

# Exhibit 8

# JEDEC STANDARD

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## DDR4 SDRAM

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**JESD79-4C**  
(Revision of JESD79-4B, June 2017)

**JANUARY 2020**

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**JEDEC SOLID STATE TECHNOLOGY ASSOCIATION**



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## DDR4 SDRAM STANDARD

(From JEDEC Board Ballot JCB-19-33, formulated under the cognizance of the JC-42.3C Subcommittee on DRAM Memories.)

---

### 1 Scope

---

This document defines the DDR4 SDRAM specification, including features, functionalities, AC and DC characteristics, packages, and ball/signal assignments. The purpose of this Standard is to define the minimum set of requirements for JEDEC compliant 2 Gb through 16 Gb for x4, x8, and x16 DDR4 SDRAM devices. This standard was created based on the DDR3 standards (JESD79-3) and some aspects of the DDR and DDR2 standards (JESD79, JESD79-2).

Each aspect of the changes for DDR4 SDRAM operation were considered and approved by committee ballot(s). The accumulation of these ballots were then incorporated to prepare this JESD79-4 specifications, replacing whole sections and incorporating the changes into Functional Description and Operation.

---

### 2 DDR4 SDRAM Package Pinout and Addressing

---

#### 2.1 DDR4 SDRAM Row for X4, X8 and X16

The DDR4 SDRAM x4/x8 component will have 13 electrical rows of balls. Electrical is defined as rows that contain signal ball or power/ground balls. There may be additional rows of inactive balls for mechanical support.

The DDR4 SDRAM x16 component will have 16 electrical rows of balls. There may be additional rows of inactive balls for mechanical support.

#### 2.2 DDR4 SDRAM Ball Pitch

The DDR4 SDRAM component will use a ball pitch of 0.8 mm by 0.8 mm.

The number of depopulated columns is 3.

#### 2.3 DDR4 SDRAM Columns for X4, X8, and X16

The DDR4 SDRAM x4/x8 and x16 component will have 6 electrical columns of balls in 2 sets of 3 columns.

There will be columns between the electrical columns where there are no balls populated. The number of these columns is 3.

Electrical is defined as columns that contain signal ball or power/ground balls. There may be additional columns of inactive balls for mechanical support.

## 2.4 DDR4 SDRAM X4/8 Ballout using MO-207

**Table 1 — DDR4 SDRAM X4/8 Ballout using MO-207**

|   | 1       | 2                                      | 3                        | 4                        | 5   | 6                        | 7   | 8    | 9   |
|---|---------|--|--------------------------|--------------------------|---|--------------------------|---|------|-----|
| A | VDD     | VSSQ                                   | TDQS_c <sup>3</sup>      |                          |   |                          | DM_n, DBI_n<br>TDQS_t <sup>2</sup> ,<br>(NC) <sup>1</sup> | VSSQ | VSS |
| B | VPP     | VDDQ                                   | DQS_c                    | DQ1                      | VDDQ                                      | ZQ                       |   |      | A   |
| C | VDDQ    | DQ0                                    | DQS_t                    | VDD                      | VSS                                       | VDDQ                     |   |      | B   |
| D | VSSQ    | DQ4<br>(NC) <sup>1</sup>               | DQ2                      | DQ3                      | DQ5<br>(NC) <sup>1</sup>                  | VSSQ                     |   |      | C   |
| E | VSS     | VDDQ                                   | DQ6<br>(NC) <sup>1</sup> | DQ7<br>(NC) <sup>1</sup> | VDDQ                                      | VSS                      |   |      | D   |
| F | VDD     | (C2) <sup>5</sup><br>ODT1 <sup>6</sup> | ODT                      | CK_t                     | CK_c                                      | VDD                      |   |      | E   |
| G | VSS     | (C0) <sup>5</sup><br>CKE1 <sup>6</sup> | CKE                      | CS_n                     | (C1) <sup>5</sup><br>(CS1_n) <sup>6</sup> | TEN<br>(NC) <sup>7</sup> |   |      | F   |
| H | VDD     | WE_n<br>A14                            | ACT_n                    | CAS_n<br>A15             | RAS_n<br>A16                              | VSS                      |   |      | G   |
| J | VREFCA  | BG0                                    | A10<br>AP                | A12<br>BC_n              | BG1                                       | VDD                      |   |      | H   |
| K | VSS     | BA0                                    | A4                       | A3                       | BA1                                       | VSS                      |   |      | J   |
| L | RESET_n | A6                                     | A0                       | A1                       | A5  | ALERT_n                  |   |      | K   |
| M | VDD     | A8                                     | A2                       | A9                       | A7  | VPP                      |   |      | L   |
| N | VSS     | A11                                    | PAR                      | A17<br>(NC) <sup>4</sup> | A13                                       | VDD                      |   |      | M   |

NOTE 1 These pins are not connected for the X4 configuration.

NOTE 2 TDQS\_t is not valid for the x4 configuration.

NOTE 3 TDQS\_c is not valid for the x4 configuration.

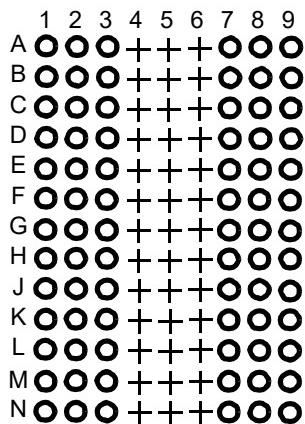
NOTE 4 A17 is only defined for the x4 configuration.

NOTE 5 These pins are for stacked component such as 3DS. For mono package, these pins are NC.

NOTE 6 ODT1 / CKE1 / CS1\_n are used together only for DDP.

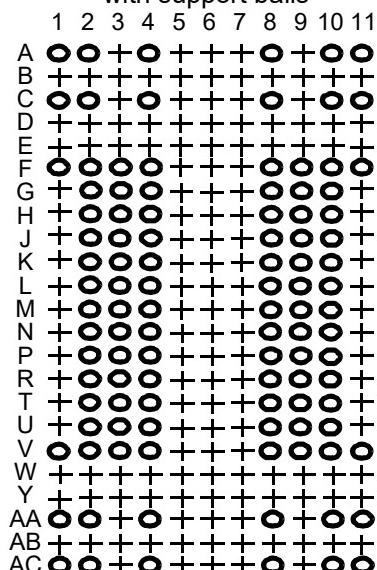
NOTE 7 TEN is optional for 8Gb and above. This pin is not connected if TEN is not supported.

MO-207 Variation DT-z (x4)



○ Populated ball  
+ Ball not populated

MO-207 Variation DW-z (x4)  
with support balls



**Figure 1 — DDR4 Ball Assignments for the x4/8 component**

## 2.5 DDR4 SDRAM X16 Ballout using MO-207

**Table 2 — DDR4 SDRAM X16 Ballout using MO-207**

|   | 1       | 2                | 3          | 4 | 5 | 6 | 7               | 8             | 9       |   |
|---|---------|------------------|------------|---|---|---|-----------------|---------------|---------|---|
| A | VDDQ    | VSSQ             | DQU0       |   |   |   | DQSU_c          | VSSQ          | VDDQ    | A |
| B | VPP     | VSS              | VDD        |   |   |   | DQSU_t          | DQU1          | VDD     | B |
| C | VDDQ    | DQU4             | DQU2       |   |   |   | DQU3            | DQU5          | VSSQ    | C |
| D | VDD     | VSSQ             | DQU6       |   |   |   | DQU7            | VSSQ          | VDDQ    | D |
| E | VSS     | DMU_n/<br>DBIU_n | VSSQ       |   |   |   | DML_n<br>DBIL_n | VSSQ          | VSS     | E |
| F | VSSQ    | VDDQ             | DQL_c      |   |   |   | DQL1            | VDDQ          | ZQ      | F |
| G | VDDQ    | DQL0             | DQL_t      |   |   |   | VDD             | VSS           | VDDQ    | G |
| H | VSSQ    | DQL4             | DQL2       |   |   |   | DQL3            | DQL5          | VSSQ    | H |
| J | VDD     | VDDQ             | DQL6       |   |   |   | DQL7            | VDDQ          | VDD     | J |
| K | VSS     | CKE              | ODT        |   |   |   | CK_t            | CK_c          | VSS     | K |
| L | VDD     | WE_n/<br>A14     | ACT_n      |   |   |   | CS_n            | RAS_n/<br>A16 | VDD     | L |
| M | VREFCA  | BG0              | A10/<br>AP |   |   |   | A12/<br>BC_n    | CAS_n/<br>A15 | VSS     | M |
| N | VSS     | BA0              | A4         |   |   |   | A3              | BA1           | TEN     | N |
| P | RESET_n | A6               | A0         |   |   |   | A1              | A5            | ALERT_n | P |
| R | VDD     | A8               | A2         |   |   |   | A9              | A7            | VPP     | R |
| T | VSS     | A11              | PAR        |   |   |   | NC              | A13           | VDD     | T |

MO - 207 Variation DU-z (x16)

|   | 1 | 2 | 3 | 4 | 5 | 6 | 7 | 8 | 9 |
|---|---|---|---|---|---|---|---|---|---|
| A | ○ | ○ | ○ | + | + | + | ○ | ○ | ○ |
| B | ○ | ○ | ○ | + | + | + | ○ | ○ | ○ |
| C | ○ | ○ | ○ | + | + | + | ○ | ○ | ○ |
| D | ○ | ○ | ○ | + | + | + | ○ | ○ | ○ |
| E | ○ | ○ | ○ | + | + | + | ○ | ○ | ○ |
| F | ○ | ○ | ○ | + | + | + | ○ | ○ | ○ |
| G | ○ | ○ | ○ | + | + | + | ○ | ○ | ○ |
| H | ○ | ○ | ○ | + | + | + | ○ | ○ | ○ |
| J | ○ | ○ | ○ | + | + | + | ○ | ○ | ○ |
| K | ○ | ○ | ○ | + | + | + | ○ | ○ | ○ |
| L | ○ | ○ | ○ | + | + | + | ○ | ○ | ○ |
| M | ○ | ○ | ○ | + | + | + | ○ | ○ | ○ |
| N | ○ | ○ | ○ | + | + | + | ○ | ○ | ○ |
| P | ○ | ○ | ○ | + | + | + | ○ | ○ | ○ |
| R | ○ | ○ | ○ | + | + | + | ○ | ○ | ○ |
| T | ○ | ○ | ○ | + | + | ○ |   |   |   |

○ Populated ball  
+ Ball not populated

MO-207 Variation DY-z (x16)

|    | 1 | 2 | 3 | 4 | 5 | 6 | 7 | 8 | 9 | 10 | 11 |
|----|---|---|---|---|---|---|---|---|---|----|----|
| A  | ○ | ○ | + | ○ | + | + | + | ○ | + | ○  | ○  |
| B  | + | + | + | + | + | + | + | + | + | +  | +  |
| C  | + | + | + | + | + | + | + | + | + | +  | +  |
| D  | ○ | ○ | ○ | + | + | + | ○ | ○ | ○ | ○  | ○  |
| E  | + | ○ | ○ | + | + | + | ○ | ○ | ○ | +  | +  |
| F  | + | ○ | ○ | + | + | + | ○ | ○ | ○ | +  | +  |
| G  | + | ○ | ○ | + | + | + | ○ | ○ | ○ | +  | +  |
| H  | + | ○ | ○ | + | + | + | ○ | ○ | ○ | +  | +  |
| J  | + | ○ | ○ | + | + | + | ○ | ○ | ○ | +  | +  |
| K  | + | ○ | ○ | + | + | + | ○ | ○ | ○ | +  | +  |
| L  | + | ○ | ○ | + | + | + | ○ | ○ | ○ | +  | +  |
| M  | + | ○ | ○ | + | + | + | ○ | ○ | ○ | +  | +  |
| N  | + | ○ | ○ | + | + | + | ○ | ○ | ○ | +  | +  |
| P  | + | ○ | ○ | + | + | + | ○ | ○ | ○ | +  | +  |
| R  | + | ○ | ○ | + | + | + | ○ | ○ | ○ | +  | +  |
| T  | + | ○ | ○ | + | + | + | ○ | ○ | ○ | +  | +  |
| U  | + | ○ | ○ | + | + | + | ○ | ○ | ○ | +  | +  |
| V  | + | ○ | ○ | + | + | + | ○ | ○ | ○ | +  | +  |
| W  | ○ | ○ | ○ | + | + | + | ○ | ○ | ○ | +  | +  |
| Y  | + | + | + | + | + | + | + | + | + | +  | +  |
| AA | + | + | + | + | + | + | + | + | + | +  | +  |
| AB | ○ | ○ | + | + | + | ○ | ○ | ○ | ○ | ○  | ○  |

**Figure 2 — DDR4 Ball Assignments for the x16 component**

## 2.6 DDR4 SDRAM X32 Ballout using MO-XXX

The DDR4 SDRAM x32 component will have the pin assignments as defined in Figure 3. Blank cells are no ball locations.

|   | 1       | 2                       | 3      | 4                       | 5    | 6 | 7    | 8                       | 9             | 10                      | 11      |    |
|---|---------|-------------------------|--------|-------------------------|------|---|------|-------------------------|---------------|-------------------------|---------|----|
| A | VPP     | VDDQ                    | DQS0_t | DQS0_c                  | VDDQ |   | VDDQ | DQS1_c                  | DQS1_t        | VDDQ                    | VDD     | 1  |
| B | VSS     | VSSQ                    | DQ0    | DM0_n,<br>DBI0_n,<br>NC | VSSQ |   | VSSQ | DQ8                     | DQ9           | VSSQ                    | VSS     | 2  |
| C | VDD     | DQ3                     | DQ2    | DQ1                     |      |   |      | DQ10                    | DQ11          | DQ12                    | VDDQ    | 3  |
| D | VDDQ    | DQ4                     | DQ5    | VSSQ                    |      |   |      | VSSQ                    | DQ13          | DQ15                    | VSSQ    | 4  |
| E | VSSQ    | DQ6                     | DQ7    | VDDQ                    |      |   |      | VDDQ                    | DQ14          | DM1_n,<br>DBI1_n,<br>NC | ZQ      | 5  |
| F | VDD     | ODT1                    | VDDQ   | ODT                     |      |   |      | CK_t                    | VDDQ          | CS1_n                   | VDD     | 6  |
| G | VDD     | CKE1                    | VSS    | CKE                     |      |   |      | CK_c                    | VSS           | TEN                     | VDD     | 7  |
| H | VREFCA  | BA0                     | ACT_n  | WE_n/<br>A14            |      |   |      | CS_n                    | RAS_n/<br>A16 | BA1                     | RFU     | 8  |
| J | VSS     | A4                      | VSS    | BG0                     |      |   |      | CAS_n/<br>A15           | VSS           | A3                      | VSS     | 9  |
| K | RESET_n | A6                      | A0     | A10/AP                  |      |   |      | A12/<br>BC_n            | RFU           | A5                      | ALERT_n | 10 |
| L | VDD     | A8                      | VSS    | A2                      |      |   |      | A1                      | VSS           | A7                      | VDD     | 11 |
| M | VDD     | A11                     | VDDQ   | PAR                     |      |   |      | A9                      | VDDQ          | A13                     | VDD     | 12 |
| N | ZQ1     | DM3_n,<br>DBI3_n,<br>NC | DQ30   | VDDQ                    |      |   |      | VDDQ                    | DQ23          | DQ22                    | VSSQ    | 13 |
| P | VSSQ    | DQ31                    | DQ29   | VSSQ                    |      |   |      | VSSQ                    | DQ21          | DQ20                    | VDDQ    | 14 |
| R | VDDQ    | DQ28                    | DQ27   | DQ26                    |      |   |      | DQ17                    | DQ18          | DQ19                    | VDD     | 15 |
| T | VSS     | VSSQ                    | DQ25   | DQ24                    | VSSQ |   | VSSQ | DM2_n,<br>DBI2_n,<br>NC | DQ16          | VSSQ                    | VSS     | 16 |
| U | VDD     | VDDQ                    | DQS3_t | DQS3_c                  | VDDQ |   | VDDQ | DQS2_c                  | DQS2_t        | VDDQ                    | VPP     | 17 |

NOTE ODT1, CKE1, CS1\_n and ZQ1 are for packages containing two x32 die stacked. These pins are NC for all other configurations.

**Figure 3 — DDR4 Ball Assignments for the x32 component**

## 2.7 Pinout Description

**Table 3 — Pinout Description**

| Symbol   | Type         | Function  |
|--|--------------|---|
| CK_t, CK_c   | Input        | Clock: CK_t and CK_c are differential clock inputs. All address and control input signals are sampled on the crossing of the positive edge of CK_t and negative edge of CK_c.   |
| CKE, (CKE1)  | Input        | Clock Enable: CKE HIGH activates, and CKE Low deactivates, internal clock signals and device input buffers and output drivers. Taking CKE Low provides Precharge Power-Down and Self-Refresh operation (all banks idle), or Active Power-Down (row Active in any bank). CKE is synchronous for Self-Refresh exit. After VREFCA and Internal DQ Vref have become stable during the power on and initialization sequence, they must be maintained during all operations (including Self-Refresh). CKE must be maintained high throughout read and write accesses. Input buffers, excluding CK_t,CK_c, ODT and CKE are disabled during power-down. Input buffers, excluding CKE, are disabled during Self-Refresh. |
| CS_n, (CS1_n)  | Input        | Chip Select: All commands are masked when CS_n is registered HIGH. CS_n provides for external Rank selection on systems with multiple Ranks. CS_n is considered part of the command code.   |
| C0,C1,C2   | Input        | Chip ID : Chip ID is only used for 3DS for 2,4,8high stack via TSV to select each slice of stacked component. Chip ID is considered part of the command code  |
| ODT, (ODT1)  | Input        | On Die Termination: ODT (registered HIGH) enables RTT_NOM termination resistance internal to the DDR4 SDRAM. When enabled, ODT is only applied to each DQ, DQS_t, DQS_c and DM_n/DBI_n/TDQS_t, NU/TDQS_c (When TDQS is enabled via Mode Register A11=1 in MR1) signal for x8 configurations. For x16 configuration ODT is applied to each DQ, DQSU_t, DQSU_c, DQL_t, DQL_c, DMU_n, and DML_n signal. The ODT pin will be ignored if MR1 is programmed to disable RTT_NOM.   |
| ACT_n  | Input        | Activation Command Input : ACT_n defines the Activation command being entered along with CS_n. The input into RAS_n/A16, CAS_n/A15 and WE_n/A14 will be considered as Row Address A16, A15 and A14  |
| RAS_n/A16. CAS_n/ A15. WE_n/A14                      | Input        | Command Inputs: RAS_n/A16, CAS_n/A15 and WE_n/A14 (along with CS_n) define the command being entered. Those pins have multi function. For example, for activation with ACT_n Low, those are Addressing like A16,A15 and A14 but for non-activation command with ACT_n High, those are Command pins for Read, Write and other command defined in command truth table   |
| DM_n/DBI_n/ TDQS_t, (DMU_n/ DBIU_n), (DML_n/ DBIL_n) | Input/Output | Input Data Mask and Data Bus Inversion: DM_n is an input mask signal for write data. Input data is masked when DM_n is sampled LOW coincident with that input data during a Write access. DM_n is sampled on both edges of DQS. DM is muxed with DBI function by Mode Register A10,A11,A12 setting in MR5. For x8 device, the function of DM or TDQS is enabled by Mode Register A11 setting in MR1. DBI_n is an input/output identifying whether to store/output the true or inverted data. If DBI_n is LOW, the data will be stored/output after inversion inside the DDR4 SDRAM and not inverted if DBI_n is HIGH. TDQS is only supported in X8  |
| BG0 - BG1  | Input        | Bank Group Inputs : BG0 - BG1 define to which bank group an Active, Read, Write or Precharge command is being applied. BG0 also determines which mode register is to be accessed during a MRS cycle. X4/8 have BG0 and BG1 but X16 has only BG0   |
| BA0 - BA1  | Input        | Bank Address Inputs: BA0 - BA1 define to which bank an Active, Read, Write or Precharge command is being applied. Bank address also determines which mode register is to be accessed during a MRS cycle.  |
| A0 - A17   | Input        | Address Inputs: Provide the row address for ACTIVATE Commands and the column address for Read/Write commands to select one location out of the memory array in the respective bank. (A10/AP, A12/BC_n, RAS_n/A16, CAS_n/A15 and WE_n/A14 have additional functions, see other rows. The address inputs also provide the op-code during Mode Register Set commands. A17 is only defined for the x4 configuration.  |
| A10 / AP   | Input        | Auto-precharge: A10 is sampled during Read/Write commands to determine whether Autoprecharge should be performed to the accessed bank after the Read/Write operation. (HIGH: Autoprecharge; LOW: no Autoprecharge).A10 is sampled during a Precharge command to determine whether the Precharge applies to one bank (A10 LOW) or all banks (A10 HIGH). If only one bank is to be precharged, the bank is selected by bank addresses.  |
| A12 / BC_n   | Input        | Burst Chop: A12 / BC_n is sampled during Read and Write commands to determine if burst chop (on-the-fly) will be performed. (HIGH, no burst chop; LOW: burst chopped). See command truth table for details.   |
| RESET_n  | Input        | Active Low Asynchronous Reset: Reset is active when RESET_n is LOW, and inactive when RESET_n is HIGH. RESET_n must be HIGH during normal operation. RESET_n is a CMOS rail to rail signal with DC high and low at 80% and 20% of V <sub>DD</sub> .   |

**Table 3 — Pinout Description (cont'd)**

| Symbol   | Type           | Function   |
|--|----------------|--|
| DQ   | Input / Output | Data Input/ Output: Bi-directional data bus. If CRC is enabled via Mode register then CRC code is added at the end of Data Burst. Any DQ from DQ0~DQ3 may indicate the internal Vref level during test via Mode Register Setting MR4 A4=High. During this mode, RTT value should be set to Hi-Z. Refer to vendor specific datasheets to determine which DQ is used.  |
| DQS_t, DQS_c,<br>DQSU_t, DQSU_c,<br>DQSL_t, DQSL_c | Input / Output | Data Strobe: output with read data, input with write data. Edge-aligned with read data, centered in write data. For the x16, DQSL corresponds to the data on DQL0-DQL7; DQSU corresponds to the data on DQU0-DQU7. The data strobe DQS_t, DQSL_t and DQSU_t are paired with differential signals DQS_c, DQSL_c, and DQSU_c, respectively, to provide differential pair signaling to the system during reads and writes. DDR4 SDRAM supports differential data strobe only and does not support single-ended.   |
| TDQS_t, TDQS_c                                     | Output         | Termination Data Strobe: TDQS_t/TDQS_c is applicable for x8 DRAMs only. When enabled via Mode Register A11 = 1 in MR1, the DRAM will enable the same termination resistance function on TDQS_t/TDQS_c that is applied to DQS_t/DQS_c. When disabled via mode register A11 = 0 in MR1, DM/DBI/TDQS will provide the data mask function or Data Bus Inversion depending on MR5; A11,12,10and TDQS_c is not used. x4/x16 DRAMs must disable the TDQS function via mode register A11 = 0 in MR1.   |
| PAR  | Input          | Command and Address Parity Input : DDR4 Supports Even Parity check in DRAM with MR setting. Once it's enabled via Register in MR5, then DRAM calculates Parity with ACT_n,RAS_n/A16,CAS_n/A15,WE_n/A14,BG0-BG1,BA0-BA1,A17-A0, and C0-C2 (3DS devices). Command and address inputs shall have parity check performed when commands are latched via the rising edge of CK_t and when CS_n is low.   |
| ALERT_n  | Input/Output   | Alert : It has multi functions such as CRC error flag, Command and Address Parity error flag as Output signal. If there is error in CRC, then Alert_n goes LOW for the period time interval and goes back HIGH. If there is error in Command Address Parity Check, then ALERT_n goes LOW for relatively long period until on going DRAM internal recovery transaction to complete. During Connectivity Test mode, this pin works as input. Using this signal or not is dependent on system. In case of not connected as Signal, ALERT_n Pin must be bounded to VDD on board. |
| TEN  | Input          | Connectivity Test Mode Enable : Required on X16 devices and optional input on x4/x8 with densities equal to or greater than 8Gb.HIGH in this pin will enable Connectivity Test Mode operation along with other pins. It is a CMOS rail to rail signal with AC high and low at 80% and 20% of VDD. Using this signal or not is dependent on System. This pin may be DRAM internally pulled low through a weak pull-down resistor to VSS.  |
| NC   |                | No Connect: No internal electrical connection is present.  |
| VDDQ   | Supply         | DQ Power Supply: 1.2 V +/- 0.06 V  |
| VSSQ   | Supply         | DQ Ground  |
| VDD  | Supply         | Power Supply: 1.2 V +/- 0.06 V   |
| VSS  | Supply         | Ground   |
| VPP  | Supply         | DRAM Activating Power Supply: 2.5V ( 2.375V min , 2.75V max)   |
| VREFCA   | Supply         | Reference voltage for CA   |
| ZQ   | Supply         | Reference Pin for ZQ calibration   |

NOTE Input only pins (BG0-BG1,BA0-BA1, A0-A17, ACT\_n, RAS\_n/A16, CAS\_n/A15, WE\_n/A14, CS\_n, CKE, ODT, and RESET\_n) do not supply termination.

## 2.8 DDR4 SDRAM Addressing

**Table 4 — 2 Gb Addressing**

| Configuration  |                      | 512 Mb x4 | 256 Mb x8 | 128 Mb x16 |
|----------------|----------------------|-----------|-----------|------------|
| Bank Address   | # of Bank Groups     | 4         | 4         | 2          |
|                | BG Address           | BG0~BG1   | BG0~BG1   | BG0        |
|                | Bank Address in a BG | BA0~BA1   | BA0~BA1   | BA0~BA1    |
| Row Address    |                      | A0~A14    | A0~A13    | A0~A13     |
| Column Address |                      | A0~A9     | A0~A9     | A0~A9      |
| Page size      |                      | 512B      | 1KB       | 2KB        |

**Table 5 — 4 Gb Addressing**

| Configuration  |                      | 1 Gb x4 | 512 Mb x8 | 256 Mb x16 |
|----------------|----------------------|---------|-----------|------------|
| Bank Address   | # of Bank Groups     | 4       | 4         | 2          |
|                | BG Address           | BG0~BG1 | BG0~BG1   | BG0        |
|                | Bank Address in a BG | BA0~BA1 | BA0~BA1   | BA0~BA1    |
| Row Address    |                      | A0~A15  | A0~A14    | A0~A14     |
| Column Address |                      | A0~A9   | A0~A9     | A0~A9      |
| Page size      |                      | 512B    | 1KB       | 2KB        |

**Table 6 — 8 Gb Addressing**

| Configuration  |                      | 2 Gb x4 | 1 Gb x8 | 512 Mb x16 |
|----------------|----------------------|---------|---------|------------|
| Bank Address   | # of Bank Groups     | 4       | 4       | 2          |
|                | BG Address           | BG0~BG1 | BG0~BG1 | BG0        |
|                | Bank Address in a BG | BA0~BA1 | BA0~BA1 | BA0~BA1    |
| Row Address    |                      | A0~A16  | A0~A15  | A0~A15     |
| Column Address |                      | A0~A9   | A0~A9   | A0~A9      |
| Page size      |                      | 512B    | 1KB     | 2KB        |

**Table 7 — 16 Gb Addressing**

| Configuration  |                      | 4 Gb x4 | 2 Gb x8 | 1 Gb x16 |
|----------------|----------------------|---------|---------|----------|
| Bank Address   | # of Bank Groups     | 4       | 4       | 2        |
|                | BG Address           | BG0~BG1 | BG0~BG1 | BG0      |
|                | Bank Address in a BG | BA0~BA1 | BA0~BA1 | BA0~BA1  |
| Row Address    |                      | A0~A17  | A0~A16  | A0~A16   |
| Column Address |                      | A0~A9   | A0~A9   | A0~A9    |
| Page size      |                      | 512B    | 1KB     | 2KB      |

## 2.9 DDP Single Rank (SR) x16 from two x8

The Single Rank (SR) x16 DDP (Dual Die Package) is comprised of two x8 devices connected in parallel. The intent is to place two x8 devices in the physical footprint space of a x16. Unless noted otherwise, the functionality, operation, and timings of the SRx16 DDP are to be the same as the mono x8 device.

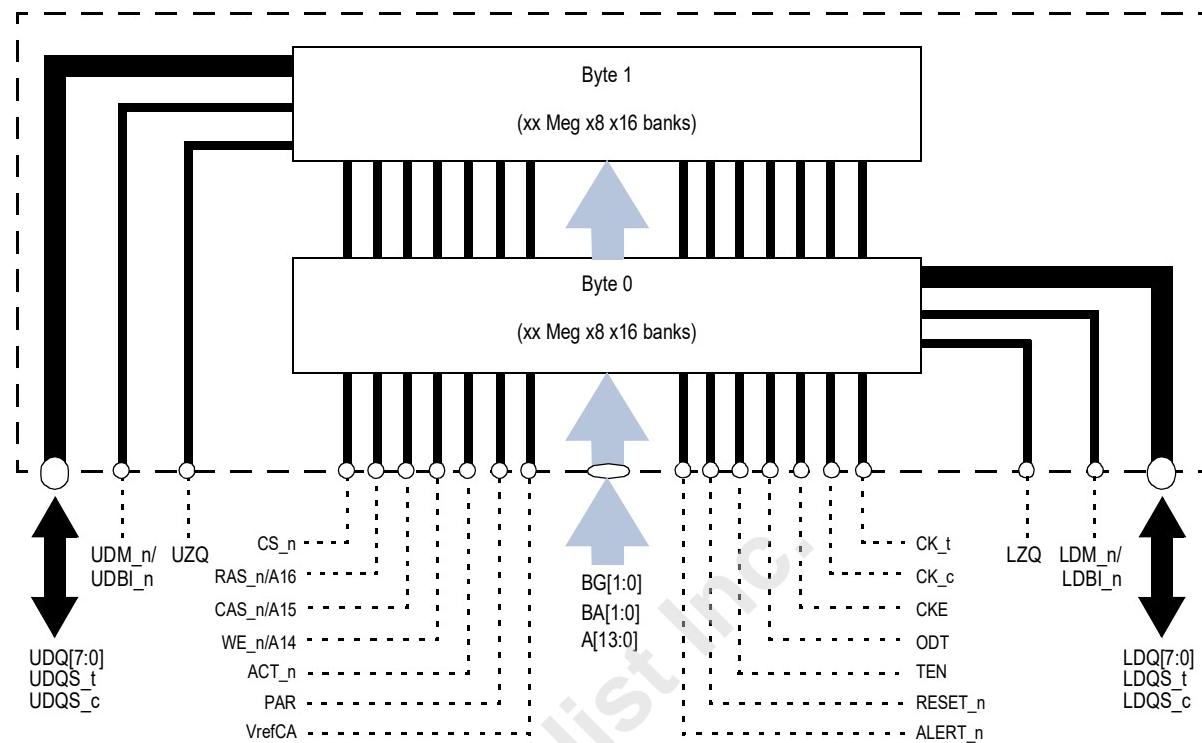


Figure 4 — Functional Block Diagram of SR x16 DDP

|   | 1       | 2                | 3          | 4 | 5 | 6 | 7               | 8             | 9       |   |
|---|---------|------------------|------------|---|---|---|-----------------|---------------|---------|---|
| A | VDDQ    | VSSQ             | DQU0       |   |   |   | DQSU_c          | VSSQ          | VDDQ    | A |
| B | VPP     | VSS              | VDD        |   |   |   | DQSU_t          | DQU1          | VDD     | B |
| C | VDDQ    | DQU4             | DQU2       |   |   |   | DQU3            | DQU5          | VSSQ    | C |
| D | VDD     | VSSQ             | DQU6       |   |   |   | DQU7            | VSSQ          | VDDQ    | D |
| E | VSS     | DMU_n/<br>DBIU_n | VSSQ       |   |   |   | DML_n<br>DBIL_n | VSSQ          | UZQ     | E |
| F | VSSQ    | VDDQ             | DQL_c      |   |   |   | DQL1            | VDDQ          | LZQ     | F |
| G | VDDQ    | DQL0             | DQL_t      |   |   |   | VDD             | VSS           | VDDQ    | G |
| H | VSSQ    | DQL4             | DQL2       |   |   |   | DQL3            | DQL5          | VSSQ    | H |
| J | VDD     | VDDQ             | DQL6       |   |   |   | DQL7            | VDDQ          | VDD     | J |
| K | VSS     | CKE              | ODT        |   |   |   | CK_t            | CK_c          | VSS     | K |
| L | VDD     | WE_n/<br>A14     | ACT_n      |   |   |   | CS_n            | RAS_n/<br>A16 | VDD     | L |
| M | VREFCA  | BG0              | A10/<br>AP |   |   |   | A12/<br>BC_n    | CAS_n/<br>A15 | BG1     | M |
| N | VSS     | BA0              | A4         |   |   |   | A3              | BA1           | TEN     | N |
| P | RESET_n | A6               | A0         |   |   |   | A1              | A5            | ALERT_n | P |
| R | VDD     | A8               | A2         |   |   |   | A9              | A7            | VPP     | R |
| T | VSS     | A11              | PAR        |   |   |   | VSS             | A13           | VDD     | T |

Figure 5 — Ballout of SR x16 DDP using MO-207

2.9 DDP Single Rank (SR) x16 from two x8 (cont'd)

**Table 8 — 8Gb Addressing (SR x16 DDP)**

| Configuration         |                      | 512Mb x 16 |
|-----------------------|----------------------|------------|
| Bank Address          | # of Bank Groups     | 4          |
|                       | BG Address           | BG0~BG1    |
|                       | Bank Address in a BG | BA0~BA1    |
| Row Address           |                      | A0~A14     |
| Column Address        |                      | A0~A9      |
| Page size - per array |                      | 1KB        |
| Page size - package   |                      | 2KB        |

**Table 9 — 16Gb Addressing (SR x16 DDP)**

| Configuration         |                      | 1Gb x 16 |
|-----------------------|----------------------|----------|
| Bank Address          | # of Bank Groups     | 4        |
|                       | BG Address           | BG0~BG1  |
|                       | Bank Address in a BG | BA0~BA1  |
| Row Address           |                      | A0~A15   |
| Column Address        |                      | A0~A9    |
| Page size - per array |                      | 1KB      |
| Page size - package   |                      | 2KB      |

**Table 10 — 32Gb Addressing (SR x16 DDP)**

| Configuration         |                      | 2Gb x 16 |
|-----------------------|----------------------|----------|
| Bank Address          | # of Bank Groups     | 4        |
|                       | BG Address           | BG0~BG1  |
|                       | Bank Address in a BG | BA0~BA1  |
| Row Address           |                      | A0~A16   |
| Column Address        |                      | A0~A9    |
| Page size - per array |                      | 1KB      |
| Page size - package   |                      | 2KB      |

### 3 Functional Description

#### 3.1 Simplified State Diagram

This simplified State Diagram is intended to provide an overview of the possible state transitions and the commands to control them. In particular, situations involving more than one bank, the enabling or disabling of on-die termination, and some other events are not captured in full detail.

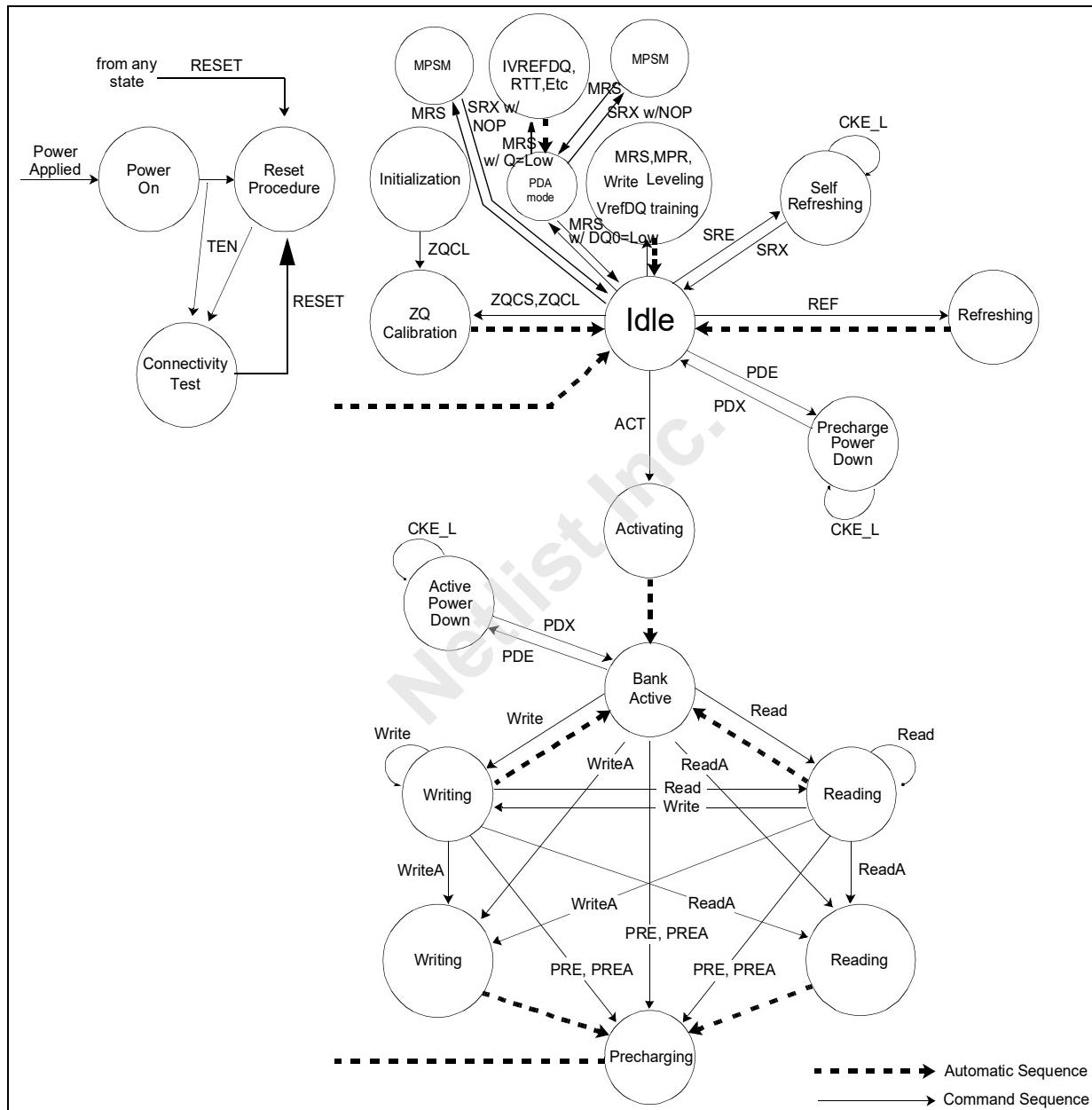


Figure 6 — Simplified State Diagram

### 3.1 Simplified State Diagram (cont'd)

**Table 11 — Simplified State Diagram Functions**

| Abbreviation | Function                          | Abbreviation | Function                          | Abbreviation | Function               |
|--------------|-----------------------------------|--------------|-----------------------------------|--------------|------------------------|
| ACT          | Activate                          | Read         | RD,RDS4, RDS8                     | PDE          | Enter Power-down       |
| PRE          | Precharge                         | Read A       | RDA, RDAS4, RDAS8                 | PDX          | Exit Power-down        |
| PREA         | PRECHARGE All                     | Write        | WR, WRS4, WRS8 with/without CRC   | SRE          | Self-Refresh entry     |
| MRS          | Mode Register Set                 | Write A      | WRA,WRAS4, WRAS8 with/without CRC | SRX          | Self-Refresh exit      |
| REF          | Refresh, Fine granularity Refresh | RESET_n      | Start RESET procedure             | MPR          | Multi Purpose Register |
| TEN          | Boundary Scan Mode Enable         |              |                                   |              |                        |

### 3.2 Basic Functionality

The DDR4 SDRAM is a high-speed dynamic random-access memory internally configured as sixteen-banks, 4 bank group with 4 banks for each bank group for x4/x8 and eight-banks, 2 bank group with 4 banks for each bankgroup for x16 DRAM.

The DDR4 SDRAM uses a 8n prefetch architecture to achieve high-speed operation. The 8n prefetch architecture is combined with an interface designed to transfer two data words per clock cycle at the I/O pins. A single read or write operation for the DDR4 SDRAM consists of a single 8n-bit wide, four clock data transfer at the internal DRAM core and eight corresponding n-bit wide, one-half clock cycle data transfers at the I/O pins.

Read and write operation to the DDR4 SDRAM are burst oriented, start at a selected location, and continue for a burst length of eight or a 'chopped' burst of four in a programmed sequence. Operation begins with the registration of an ACTIVATE Command, which is then followed by a Read or Write command. The address bits registered coincident with the ACTIVATE Command are used to select the bank and row to be activated (BG0-BG1 in x4/8 and BG0 in x16 select the bankgroup; BA0-BA1 select the bank; A0-A17 select the row; refer to "DDR4 SDRAM Addressing" on Section 2.8 for specific requirements). The address bits registered coincident with the Read or Write command are used to select the starting column location for the burst operation, determine if the auto precharge command is to be issued (via A10), and select BC4 or BL8 mode 'on the fly' (via A12) if enabled in the mode register.

Prior to normal operation, the DDR4 SDRAM must be powered up and initialized in a predefined manner.

The following sections provide detailed information covering device reset and initialization, register definition, command descriptions, and device operation.

### 3.3 RESET and Initialization Procedure

For power-up and reset initialization, in order to prevent DRAM from functioning improperly default values for the following MR settings need to be defined.

Gear down mode (MR3 A[3]) : 0 = 1/2 Rate

Per DRAM Addressability (MR3 A[4]) : 0 = Disable

Max Power Saving Mode (MR4 A[1]) : 0 = Disable

CS to Command/Address Latency (MR4 A[8:6]) : 000 = Disable

CA Parity Latency Mode (MR5 A[2:0]) : 000 = Disable

Hard Post Package Repair mode (MR4 A[13]) : 0 = Disable

Soft Post Package Repair mode (MR4 A[5]) : 0 = Disable

#### 3.3.1 Power-up Initialization Sequence

The following sequence is required for POWER UP and Initialization and is shown in Figure 7.

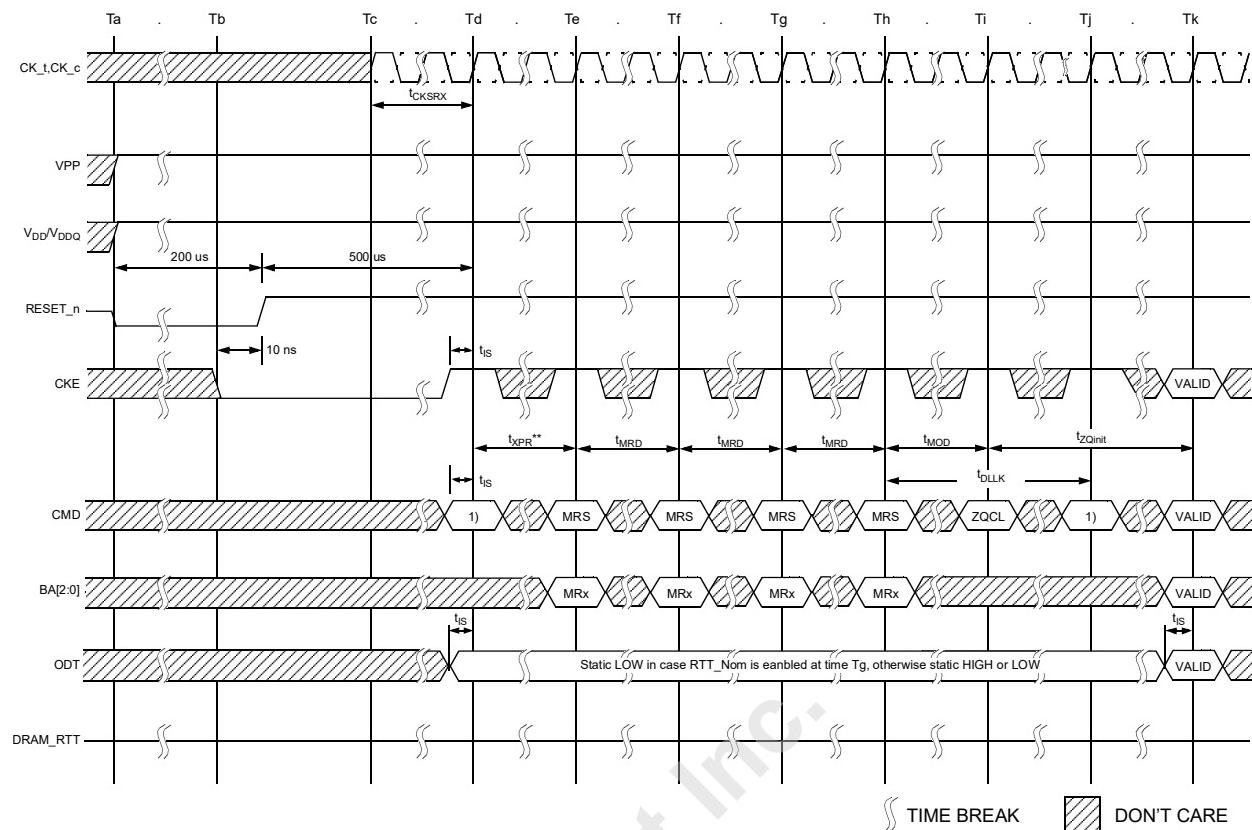
1. Apply power (RESET\_n and TEN are recommended to be maintained below 0.2 x VDD; all other inputs may be undefined). RESET\_n needs to be maintained below 0.2 x VDD for minimum 200us with stable power and TEN needs to be maintained below 0.2 x VDD for minimum 700us with stable power. CKE is pulled "Low" anytime before RESET\_n being de-asserted (min. time 10ns). The power voltage ramp time between 300mV to V<sub>DD</sub> min must be no greater than 200ms; and during the ramp, V<sub>DD</sub> ≥ V<sub>DDQ</sub> and (V<sub>DD</sub>-V<sub>DDQ</sub>) < 0.3volts. VPP must ramp at the same time or earlier than VDD and VPP must be equal to or higher than VDD at all times.

- V<sub>DD</sub> and V<sub>DDQ</sub> are driven from a single power converter output, AND
- The voltage levels on all pins other than V<sub>DD</sub>,V<sub>DDQ</sub>,V<sub>SS</sub>,V<sub>SSQ</sub> must be less than or equal to V<sub>DDQ</sub> and V<sub>DD</sub> on one side and must be larger than or equal to V<sub>SSQ</sub> and V<sub>SS</sub> on the other side. In addition, V<sub>TT</sub> is limited to 0.76V max once power ramp is finished, AND
  - VrefCA tracks VDD/2,
  - or
  - Apply V<sub>DD</sub> without any slope reversal before or at the same time as V<sub>DDQ</sub>

### 3.3.1 Power-up Initialization Sequence (cont'd)

- Apply  $V_{DDQ}$  without any slope reversal before or at the same time as  $V_{TT}$  &  $V_{refCA}$ .
  - Apply VPP without any slope reversal before or at the same time as VDD.
  - The voltage levels on all pins other than  $V_{DD}$ ,  $V_{DDQ}$ ,  $V_{SS}$ ,  $V_{SSQ}$  must be less than or equal to  $V_{DDQ}$  and  $V_{DD}$  on one side and must be larger than or equal to  $V_{SSQ}$  and  $V_{SS}$  on the other side.
2. After RESET\_n is de-asserted, wait for another 500us until CKE becomes active. During this time, the DRAM will start internal initialization; this will be done independently of external clocks.
  3. Clocks (CK\_t, CK\_c) need to be started and stabilized for at least 10ns or 5tCK (which is larger) before CKE goes active. Since CKE is a synchronous signal, the corresponding setup time to clock (tIS) must be met. Also, a Deselect command must be registered (with tIS set up time to clock) at clock edge Td. Once the CKE registered "High" after Reset, CKE needs to be continuously registered "High" until the initialization sequence is finished, including expiration of tDLLK and tZQinit.
  4. The DDR4 SDRAM keeps its on-die termination in high-impedance state as long as RESET\_n is asserted. Further, the SDRAM keeps its on-die termination in high impedance state after RESET\_n deassertion until CKE is registered HIGH. The ODT input signal may be in undefined state until tIS before CKE is registered HIGH. When CKE is registered HIGH, the ODT input signal may be statically held at either LOW or HIGH. If RTT\_NOM is to be enabled in MR1 the ODT input signal must be statically held LOW. In all cases, the ODT input signal remains static until the power up initialization sequence is finished, including the expiration of tDLLK and tZQinit.
  5. After CKE is being registered high, wait minimum of Reset CKE Exit time, tXPR, before issuing the first MRS command to load mode register. (tXPR=Max(tXS, 5nCK)]
  6. Issue MRS Command to load MR3 with all application settings( To issue MRS command to MR3, provide "Low" to BG0, "High" to BA1, BA0)
  7. Issue MRS command to load MR6 with all application settings (To issue MRS command to MR6, provide "Low" to BA0, "High" to BG0, BA1)
  8. Issue MRS command to load MR5 with all application settings (To issue MRS command to MR5, provide "Low" to BA1, "High" to BG0, BA0)
  9. Issue MRS command to load MR4 with all application settings (To issue MRS command to MR4, provide "Low" to BA1, BA0, "High" to BG0)
  10. Issue MRS command to load MR2 with all application settings (To issue MRS command to MR2, provide "Low" to BG0, BA0, "High" to BA1)
  11. Issue MRS command to load MR1 with all application settings (To issue MRS command to MR1, provide "Low" to BG0, BA1, "High" to BA0)
  12. Issue MRS command to load MR0 with all application settings (To issue MRS command to MR0, provide "Low" to BG0, BA1, BA0)
  13. Issue ZQCL command to starting ZQ calibration
  14. Wait for both tDLLK and tZQ init completed
  15. The DDR4 SDRAM is now ready for read/Write training (include Vref training and Write leveling).

### 3.3.1 Power-up Initialization Sequence (cont'd)



**NOTE 1** From time point 'Td' until 'TK', DES commands must be applied between MRS and ZQCL commands.

**NOTE 2** MRS Commands must be issued to all Mode Registers that have defined settings.

**Figure 7 — RESET\_n and Initialization Sequence at Power-on Ramping**

### 3.3.2 VDD Slew rate at Power-up Initialization Sequence

**Table 12 — VDD Slew Rate**

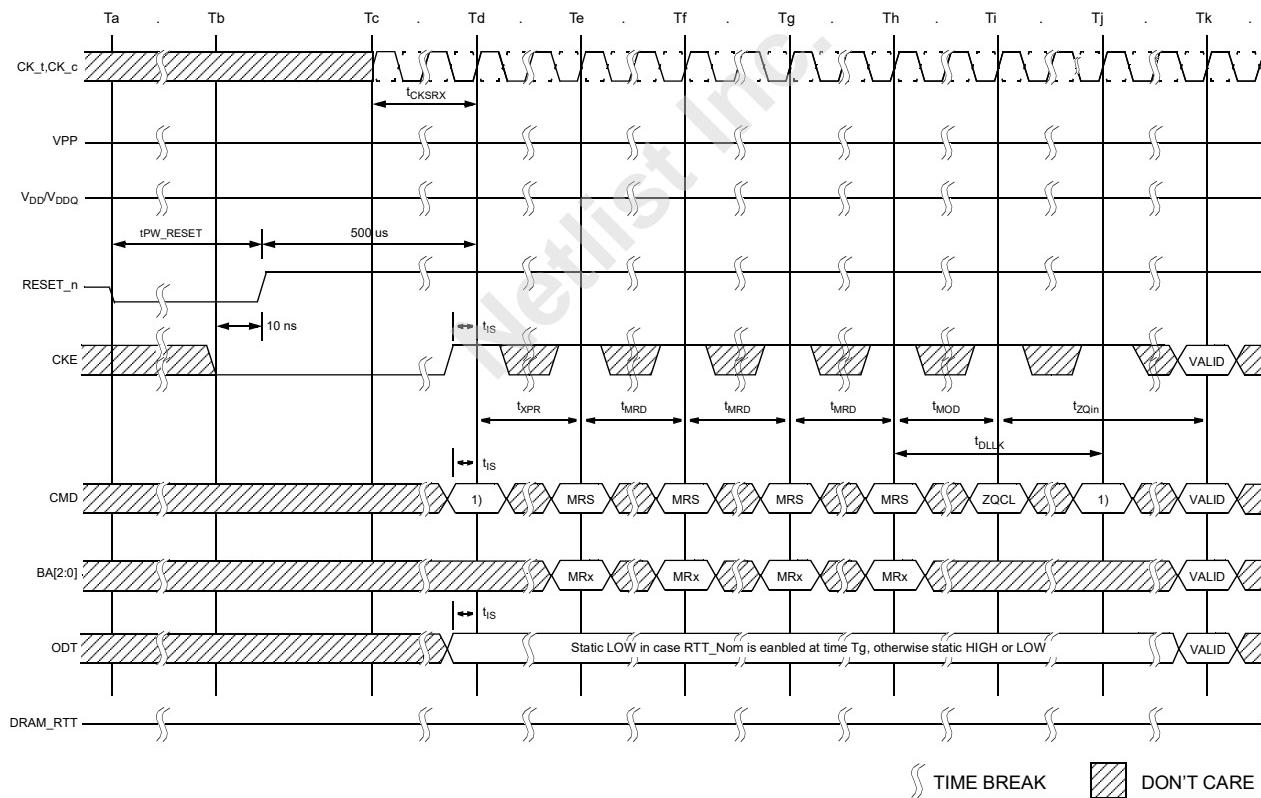
| Symbol               | Min   | Max | Units             |
|----------------------|-------|-----|-------------------|
| VDD_sla <sup>a</sup> | 0.004 | 600 | V/ms <sup>b</sup> |
| VDD_ona <sup>c</sup> |       | 200 | ms <sup>c</sup>   |

a.Measurement made between 300mv and 80% Vdd minimum.  
 b.20 MHz bandlimited measurement.  
 c.Maximum time to ramp VDD from 300 mv to VDD minimum.

### 3.3.3 Reset Initialization with Stable Power

The following sequence is required for RESET at no power interruption initialization as shown in Figure 8.

1. Asserted RESET\_n below 0.2 \* V<sub>DD</sub> anytime when reset is needed (all other inputs may be undefined). RESET\_n needs to be maintained for minimum tPW\_RESET. CKE is pulled "LOW" before RESET\_n being de-asserted (min. time 10 ns).
2. Follow steps 2 to 10 in "Power-up Initialization Sequence" on page 13.
3. The Reset sequence is now completed, DDR4 SDRAM is ready for Read/Write training (include Vref training and Write leveling)



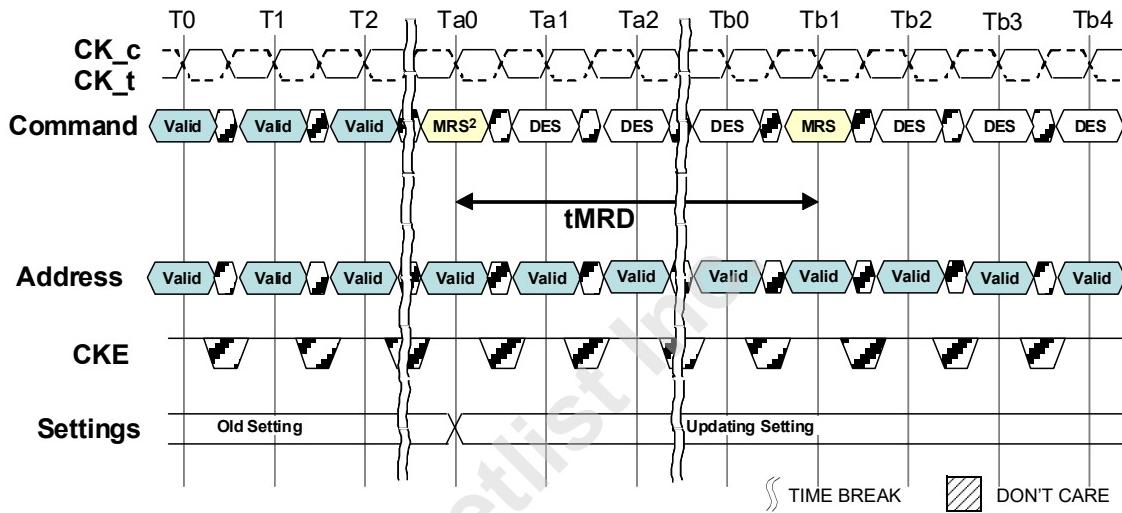
NOTE 1 From time point 'Td' until 'Tk', DES commands must be applied between MRS and ZQCL commands  
 NOTE 2 MRS Commands must be issued to all Mode Registers that have defined settings.

**Figure 8 — Reset Procedure at Power Stable**

### 3.4 Register Definition

#### 3.4.1 Programming the mode registers

For application flexibility, various functions, features, and modes are programmable in seven Mode Registers, provided by the DDR4 SDRAM, as user defined variables and they must be programmed via a Mode Register Set (MRS) command. The mode registers are divided into various fields depending on the functionality and/or modes. As not all the Mode Registers (MR#) have default values defined, contents of Mode Registers must be initialized and/or re-initialized, i.e., written, after power up and/or reset for proper operation. Also, the contents of the Mode Registers can be altered by re-executing the MRS command during normal operation. When programming the mode registers, even if the user chooses to modify only a sub-set of the MRS fields, all address fields within the accessed mode register must be redefined when the MRS command is issued. MRS command and DLL Reset do not affect array contents, which means these commands can be executed any time after power-up without affecting the array contents. MRS Commands can be issued only when DRAM is at idle state. The mode register set command cycle time, tMRD is required to complete the write operation to the mode register and is the minimum time required between two MRS commands shown in Figure 9.



NOTE 1 This timing diagram shows C/A Parity Latency mode is “Disable” case.

NOTE 2 List of MRS commands exception that do not apply to tMRD

- Gear down mode
- C/A Parity Latency mode
- CS to Command/Address Latency mode
- Per DRAM Addressability mode
- VrefDQ training Value, VrefDQ Training mode and VrefDQ training Range

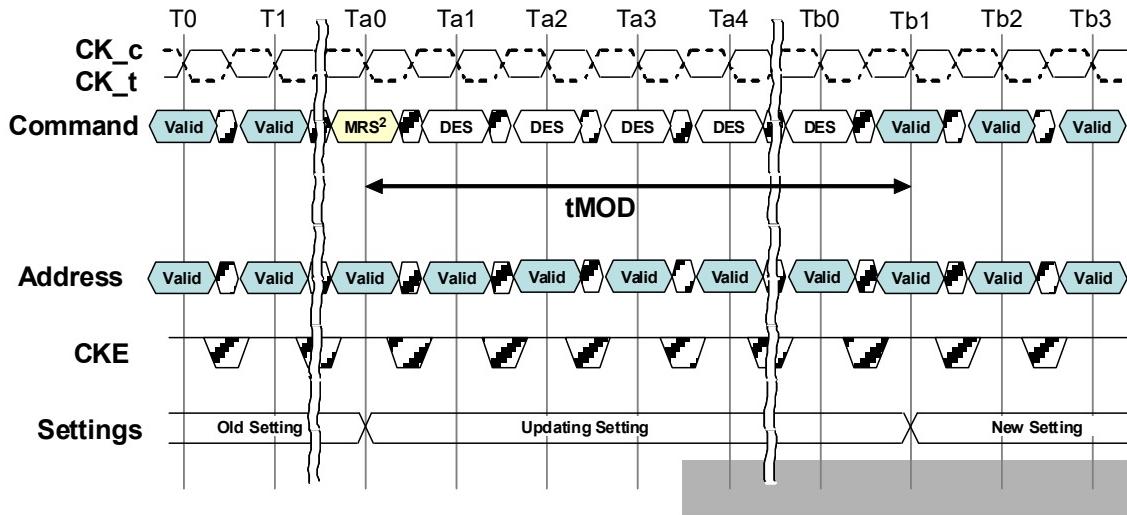
**Figure 9 — tMRD Timing**

Some of the Mode Register setting affect to address/command/control input functionality. These case, next MRS command can be allowed when the function updating by current MRS command completed.

The MRS commands which do not apply tMRD timing to next MRS command are listed in Note 2 of Figure 9. These MRS command input cases have unique MR setting procedure, so refer to individual function description.

The most MRS command to Non-MRS command delay, tMOD, is required for the DRAM to update the features, and is the minimum time required from an MRS command to a non-MRS command excluding DES shown in Figure 10.

### 3.4.1 Programming the mode registers (cont'd)



NOTE 1 This timing diagram shows CA Parity Latency mode is "Disable" case.

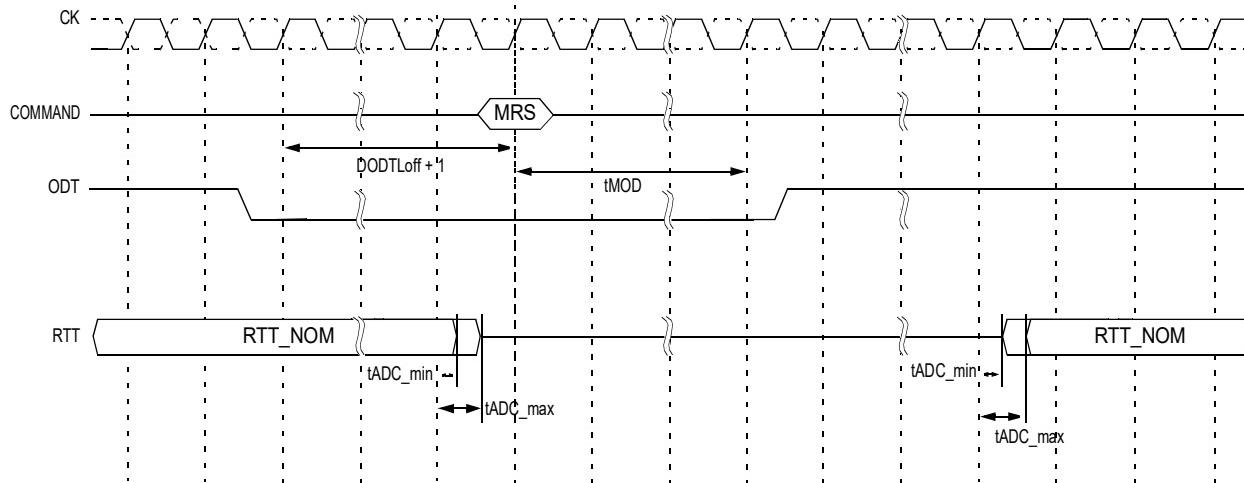
NOTE 2 List of MRS commands exception that do not apply to tMOD

- DLL Enable, DLL Reset
- VrefDQ training Value, internal Vref Monitor, VrefDQ Training mode and VrefDQ training Range
- Gear down mode
- Per DRAM addressability mode
- Maximum power saving mode
- CA Parity mode

**Figure 10 — tMOD Timing**

Some of the mode register setting cases, function updating takes longer than tMOD. The MRS commands which do not apply tMOD timing to next valid command excluding DES is listed in note 2 of Figure 10. These MRS command input cases have unique MR setting procedure, so refer to individual function description.

### 3.4.1 Programming the mode registers (cont'd)



NOTE 1 This timing diagram shows CA Parity Latency mode is "Disable" case.

NOTE 2 When an MRS command mentioned in this note affects RTT\_NOM turn off timings, RTT\_NOM turn on timings and RTT\_NOM value, this means the MR register value changes. The ODT signal should set to be low for at least  $DODT_{loff} + 1$  clock before their affecting MRS command is issued and remain low until  $tMOD$  expires. The following MR registers affects RTT\_NOM turn on timings, RTT\_NOM turn off timings and RTT\_NOM value and it requires ODT to be low when an MRS command change the MR register value. If there are no changes the MR register value that corresponds to commands mentioned in this note, then the ODT signal is not required to be low.

- DLL control for precharge power down
- Additive latency and CAS read latency
- DLL enable and disable
- CAS write latency
- CA Parity mode
- Gear Down mode
- RTT\_NOM

**Figure 11 — ODT Status at MRS affecting ODT turn-on/off timing**

The mode register contents can be changed using the same command and timing requirements during normal operation as long as the DRAM is in idle state, i.e., all banks are in the precharged state with tRP satisfied, all data bursts are completed and CKE is high prior to writing into the mode register. For MRS command, If RTT\_Nom function is intended to change (enable to disable and vice versa) or already enabled in DRAM MR, ODT signal must be registered Low, ensuring RTT\_NOM is in an off state prior to MRS command affecting RTT\_NOM turn-on and off timing. Refer to note2 of Figure 11 for this type of MRS. The ODT signal may be registered high after tMOD has expired. ODT signal is a don't care during MRS command if DRAM RTT\_Nom function is disabled in the mode register prior to and after an MRS command.

### 3.5 Mode Register

#### MR0

**Table 13 — Mode Register 0**

| Address                   | Operating Mode             | Description  |                        |
|---------------------------|----------------------------|--|------------------------|
| BG1                       | RFU                        | 0 = must be programmed to 0 during MRS   |                        |
| BG0, BA1:BA0              | MR Select                  | 000 = MR0  | 100 = MR4              |
|                           |                            | 001 = MR1  | 101 = MR5              |
|                           |                            | 010 = MR2  | 110 = MR6              |
|                           |                            | 011 = MR3  | 111 = RCW <sup>1</sup> |
| A17                       | RFU                        | 0 = must be programmed to 0 during MRS   |                        |
| A13 <sup>5</sup> , A11:A9 | WR and RTP <sup>2, 3</sup> | Write Recovery and Read to Precharge for auto precharge (see Table 14)   |                        |
| A8                        | DLL Reset                  | 0 = NO   | 1 = Yes                |
| A7                        | TM                         | 0 = Normal   | 1 = Test               |
| A12, A6:A4,A2             | CAS Latency <sup>4</sup>   | (see Table 15)   |                        |
| A3                        | Read Burst Type            | 0 = Sequential   | 1 = Interleave         |
| A1:A0                     | Burst Length               | 00 = 8 (Fixed) Abbreviated BL8MRS<br>01 = BC4 or 8 (on the fly) Abbreviated BC4OTF or BL8OTF<br>10 = BC4 (Fixed) Abbreviated BC4MRS<br>11 = Reserved |                        |

NOTE 1 Reserved for Register control word setting .DRAM ignores MR command with BG0,BA1:BA0=111 and doesn't respond. When RFU MR code setting is inputted, DRAM operation is not defined.

NOTE 2 WR (write recovery for autorecharge)min in clock cycles is calculated following rounding algorithm defined in Section 13.5. The WR value in the mode register must be programmed to be equal or larger than WRmin. The programmed WR value is used with tRP to determine tDAL.

NOTE 3 The table shows the encodings for Write Recovery and internal Read command to Precharge command delay. For actual Write recovery timing, please refer to AC timing table.

NOTE 4 The table only shows the encodings for a given Cas Latency. For actual supported Cas Latency, please refer to speedbin tables for each frequency. Cas Latency controlled by A12 is optional for 4Gb device.

NOTE 5 A13 for WR and RTP setting is optional for 4Gb.

**Table 14 — Write Recovery and Read to Precharge (cycles)**

| A13 | A11 | A10 | A9 | WR       | RTP      |
|-----|-----|-----|----|----------|----------|
| 0   | 0   | 0   | 0  | 10       | 5        |
| 0   | 0   | 0   | 1  | 12       | 6        |
| 0   | 0   | 1   | 0  | 14       | 7        |
| 0   | 0   | 1   | 1  | 16       | 8        |
| 0   | 1   | 0   | 0  | 18       | 9        |
| 0   | 1   | 0   | 1  | 20       | 10       |
| 0   | 1   | 1   | 0  | 24       | 12       |
| 0   | 1   | 1   | 1  | 22       | 11       |
| 1   | 0   | 0   | 0  | 26       | 13       |
| 1   | 0   | 0   | 1  | Reserved | Reserved |
| 1   | 0   | 1   | 0  | Reserved | Reserved |
| 1   | 0   | 1   | 1  | Reserved | Reserved |
| 1   | 1   | 0   | 0  | Reserved | Reserved |
| 1   | 1   | 0   | 1  | Reserved | Reserved |
| 1   | 1   | 1   | 0  | Reserved | Reserved |
| 1   | 1   | 1   | 1  | Reserved | Reserved |

## 3.5 Mode Register (cont'd)

**Table 15 — CAS Latency**

| A12 | A6 | A5 | A4 | A2 | CAS Latency               |
|-----|----|----|----|----|---------------------------|
| 0   | 0  | 0  | 0  | 0  | 9                         |
| 0   | 0  | 0  | 0  | 1  | 10                        |
| 0   | 0  | 0  | 1  | 0  | 11                        |
| 0   | 0  | 0  | 1  | 1  | 12                        |
| 0   | 0  | 1  | 0  | 0  | 13                        |
| 0   | 0  | 1  | 0  | 1  | 14                        |
| 0   | 0  | 1  | 1  | 0  | 15                        |
| 0   | 0  | 1  | 1  | 1  | 16                        |
| 0   | 1  | 0  | 0  | 0  | 18                        |
| 0   | 1  | 0  | 0  | 1  | 20                        |
| 0   | 1  | 0  | 1  | 0  | 22                        |
| 0   | 1  | 0  | 1  | 1  | 24                        |
| 0   | 1  | 1  | 0  | 0  | 23                        |
| 0   | 1  | 1  | 0  | 1  | 17                        |
| 0   | 1  | 1  | 1  | 0  | 19                        |
| 0   | 1  | 1  | 1  | 1  | 21                        |
| 1   | 0  | 0  | 0  | 0  | 25                        |
| 1   | 0  | 0  | 0  | 1  | 26                        |
| 1   | 0  | 0  | 1  | 0  | 27 ( only 3DS available ) |
| 1   | 0  | 0  | 1  | 1  | 28                        |
| 1   | 0  | 1  | 0  | 0  | reserved for 29           |
| 1   | 0  | 1  | 0  | 1  | 30                        |
| 1   | 0  | 1  | 1  | 0  | reserved for 31           |
| 1   | 0  | 1  | 1  | 1  | 32                        |
| 1   | 1  | 0  | 0  | 0  | reserved                  |

## 3.5 Mode Register (cont'd)

**MR1****Table 16 — Mode Register 1**

| Address      | Operating Mode                  | Description                              |                        |
|--------------|---------------------------------|--|------------------------|
| BG1          | RFU                             | 0 = must be programmed to 0 during MRS   |                        |
| BG0, BA1:BA0 | MR Select                       | 000 = MR0                                | 100 = MR4              |
|              |                                 | 001 = MR1                                | 101 = MR5              |
|              |                                 | 010 = MR2                                | 110 = MR6              |
|              |                                 | 011 = MR3                                | 111 = RCW <sup>3</sup> |
| A17          | RFU                             | 0 = must be programmed to 0 during MRS   |                        |
| A13, A6, A5  | Rx CTLE control                 | 000 = Vendor Optimized Setting (default) | 001 = vendor defined   |
|              |                                 | 010 = vendor defined                     | 011 = vendor defined   |
|              |                                 | 100 = vendor defined                     | 101 = vendor defined   |
|              |                                 | 110 = vendor defined                     | 111 = vendor defined   |
| A12          | Qoff <sup>1</sup>               | 0 = Output buffer enabled                |                        |
|              |                                 | 1 = Output buffer disabled               |                        |
| A11          | TDQS enable                     | 0 = Disable                              | 1 = Enable             |
| A10, A9, A8  | RTT_NOM                         | (see Table 17)                           |                        |
| A7           | Write Leveling Enable           | 0 = Disable                              | 1 = Enable             |
| A4, A3       | Additive Latency                | 00 = 0(AL disabled)                      | 10 = CL-2              |
|              |                                 | 01 = CL-1                                | 11 = Reserved          |
| A2, A1       | Output Driver Impedance Control | (see Table 18)                           |                        |
| A0           | DLL Enable                      | 0 = Disable <sup>2</sup>                 | 1 = Enable             |

NOTE 1 Outputs disabled - DQs, DQS\_ts, DQS\_cs.

NOTE 2 States reversed to "0 as Disable" with respect to DDR4.

NOTE 3 Reserved for Register control word setting .DRAM ignores MR command with BG0,BA1;BA0=111 and doesn't respond. When RFU MR code setting is inputted, DRAM operation is not defined.

**Table 17 — RTT\_NOM**

| A10 | A9 | A8 | RTT_NOM         |
|-----|----|----|-----------------|
| 0   | 0  | 0  | RTT_NOM Disable |
| 0   | 0  | 1  | RZQ/4           |
| 0   | 1  | 0  | RZQ/2           |
| 0   | 1  | 1  | RZQ/6           |
| 1   | 0  | 0  | RZQ/1           |
| 1   | 0  | 1  | RZQ/5           |
| 1   | 1  | 0  | RZQ/3           |
| 1   | 1  | 1  | RZQ/7           |

**Table 18 — Output Driver Impedance Control**

| A2 | A1 | Output Driver Impedance Control |
|----|----|---------------------------------|
| 0  | 0  | RZQ/7                           |
| 0  | 1  | RZQ/5                           |
| 1  | 0  | Reserved                        |
| 1  | 1  | Reserved                        |

## 3.5 Mode Register (cont'd)

**MR2****Table 19 — Mode Register 2**

| Address      | Operating Mode                       | Description   |                        |
|--------------|--------------------------------------|---|------------------------|
| BG1          | RFU                                  | 0 = must be programmed to 0 during MRS                  |                        |
| BG0, BA1:BA0 | MR Select                            | 000 = MR0   | 100 = MR4              |
|              |                                      | 001 = MR1   | 101 = MR5              |
|              |                                      | 010 = MR2   | 110 = MR6              |
|              |                                      | 011 = MR3   | 111 = RCW <sup>1</sup> |
| A17          | RFU                                  | 0 = must be programmed to 0 during MRS                  |                        |
| A13          | RFU                                  | 0 = must be programmed to 0 during MRS                  |                        |
| A12          | Write CRC                            | 0 = Disable   | 1 = Enable             |
| A11, A10:A9  | RTT_WR                               | (see Table 20)  |                        |
| A8, A2       | RFU                                  | 0 = must be programmed to 0 during MRS                  |                        |
| A7:A6        | Low Power Auto Self Refresh (LP ASR) | 00 = Manual Mode (Normal Operating Temperature Range)   |                        |
|              |                                      | 01 = Manual Mode (Reduced Operating Temperature Range)  |                        |
|              |                                      | 10 = Manual Mode (Extended Operating Temperature Range) |                        |
|              |                                      | 11 = ASR Mode (Auto Self Refresh)                       |                        |
| A5:A3        | CAS Write Latency (CWL)              | (see Table 21)  |                        |
| A1:A0        | RFU                                  | 0 = must be programmed to 0 during MRS                  |                        |

NOTE 1 Reserved for Register control word setting.DRAM ignores MR command with BG0,BA1;BA0=111 and doesn't respond. When RFU MR code setting is inputted, DRAM operation is not defined.

**Table 20 — RTT\_WR**

| A11 | A10 | A9 | RTT_WR          |
|-----|-----|----|-----------------|
| 0   | 0   | 0  | Dynamic ODT Off |
| 0   | 0   | 1  | RZQ/2           |
| 0   | 1   | 0  | RZQ/1           |
| 0   | 1   | 1  | Hi-Z            |
| 1   | 0   | 0  | RZQ/3           |
| 1   | 0   | 1  | Reserved        |
| 1   | 1   | 0  | Reserved        |
| 1   | 1   | 1  | Reserved        |

**Table 21 — CWL (CAS Write Latency)**

| A5 | A4 | A3 | CWL | Operating Data Rate in MT/s<br>for 1 tCK Write Preamble |             | Operating Data Rate in MT/s<br>for 2 tCK Write Preamble <sup>1</sup> |             |
|----|----|----|-----|---|-------------|--|-------------|
|    |    |    |     | 1st Set   | 2nd Set     | 1st Set  | 2nd Set     |
| 0  | 0  | 0  | 9   | 1600  |             |  |             |
| 0  | 0  | 1  | 10  | 1866  |             |  |             |
| 0  | 1  | 0  | 11  | 2133  | 1600        |  |             |
| 0  | 1  | 1  | 12  | 2400  | 1866        |  |             |
| 1  | 0  | 0  | 14  | 2666  | 2133        | 2400   |             |
| 1  | 0  | 1  | 16  | 2933 / 3200   | 2400        | 2666   | 2400        |
| 1  | 1  | 0  | 18  |   | 2666        | 2933 / 3200  | 2666        |
| 1  | 1  | 1  | 20  |   | 2933 / 3200 |  | 2933 / 3200 |

NOTE 1 The 2 tCK Write Preamble is valid for DDR4-2400/2666/2933/3200 Speed Grade. For the 2nd Set of 2 tCK Write Preamble, no additional CWL is needed.

## 3.5 Mode Register (cont'd)

**MR3****Table 22 — Mode Register 3**

| Address      | Operating Mode                                | Description                            |                          |
|--------------|---|--|--------------------------|
| BG1          | RFU   | 0 = must be programmed to 0 during MRS |                          |
| BG0, BA1:BA0 | MR Select                                     | 000 = MR0                              | 100 = MR4                |
|              |   | 001 = MR1                              | 101 = MR5                |
|              |   | 010 = MR2                              | 110 = MR6                |
|              |   | 011 = MR3                              | 111 = RCW <sup>1</sup>   |
| A17          | RFU   | 0 = must be programmed to 0 during MRS |                          |
| A13          | RFU   | 0 = must be programmed to 0 during MRS |                          |
| A12:A11      | MPR Read Format                               | 00 = Serial                            | 10 = Staggered           |
|              |   | 01 = Parallel                          | 11 = Reserved            |
| A10:A9       | Write CMD Latency when CRC and DM are enabled | (see Table 24)                         |                          |
| A8:A6        | Fine Granularity Refresh Mode                 | (see Table 23)                         |                          |
| A5           | Temperature sensor readout                    | 0 : disabled                           | 1: enabled               |
| A4           | Per DRAM Addressability                       | 0 = Disable                            | 1 = Enable               |
| A3           | Geardown Mode                                 | 0 = 1/2 Rate                           | 1 = 1/4 Rate             |
| A2           | MPR Operation                                 | 0 = Normal                             | 1 = Dataflow from/to MPR |
| A1:A0        | MPR page Selection                            | 00 = Page0                             | 10 = Page2               |
|              |   | 01 = Page1                             | 11 = Page3               |
|              |   | (see Table 25)                         |                          |

NOTE 1 Reserved for Register control word setting .DRAM ignores MR command with BG0,BA1:BA0=111 and doesn't respond. When RFU MR code setting is inputted, DRAM operation is not defined.

**Table 23 — Fine Granularity Refresh Mode**

| A8 | A7 | A6 | Fine Granularity Refresh |
|----|----|----|--------------------------|
| 0  | 0  | 0  | Normal (Fixed 1x)        |
| 0  | 0  | 1  | Fixed 2x                 |
| 0  | 1  | 0  | Fixed 4x                 |
| 0  | 1  | 1  | Reserved                 |
| 1  | 0  | 0  | Reserved                 |
| 1  | 0  | 1  | Enable on the fly 2x     |
| 1  | 1  | 0  | Enable on the fly 4x     |
| 1  | 1  | 1  | Reserved                 |

**Table 24 — MR3 A<10:9> Write Command Latency when CRC and DM are both enabled**

| A10 | A9 | CRC+DM Write Command Latency | Operating Data Rate |
|-----|----|------------------------------|---------------------|
| 0   | 0  | 4nCK                         | 1600                |
| 0   | 1  | 5nCK                         | 1866,2133,2400,2666 |
| 1   | 0  | 6nCK                         | 2933,3200           |
| 1   | 1  | RFU                          | RFU                 |

NOTE 1. Write Command latency when CRC and DM are both enabled:

NOTE 2. At less than or equal to 1600 then 4nCK; neither 5nCK nor 6nCK

NOTE 3. At greater than 1600 and less than or equal to 2666 then 5nCK; neither 4nCK nor 6nCK

NOTE 4. At greater than 2666 and less than or equal to 3200 then 6nCK; neither 4nCK nor 5nCK

## 3.5 Mode Register (cont'd)

**Table 25 — MPR Data Format**

MPR page0 (Training Pattern)

| Address | MPR Location | [7] | [6] | [5] | [4] | [3] | [2] | [1] | [0] | note                                 |
|---------|--------------|-----|-----|-----|-----|-----|-----|-----|-----|--------------------------------------|
| BA1:BA0 | 00 = MPR0    | 0   | 1   | 0   | 1   | 0   | 1   | 0   | 1   | Read/<br>Write<br>(default<br>value) |
|         | 01 = MPR1    | 0   | 0   | 1   | 1   | 0   | 0   | 1   | 1   |                                      |
|         | 10 = MPR2    | 0   | 0   | 0   | 0   | 1   | 1   | 1   | 1   |                                      |
|         | 11 = MPR3    | 0   | 0   | 0   | 0   | 0   | 0   | 0   | 0   |                                      |

MPR page1 (CA Parity Error Log)

| Address | MPR Location | [7]                    | [6]                            | [5]                            | [4]      | [3]      | [2]   | [1]   | [0]           | note          |
|---------|--------------|------------------------|--------------------------------|--------------------------------|----------|----------|-------|-------|---------------|---------------|
| BA1:BA0 | 00 = MPR0    | A[7]                   | A[6]                           | A[5]                           | A[4]     | A[3]     | A[2]  | A[1]  | A[0]          | Read-<br>only |
|         | 01 = MPR1    | CAS_n/<br>A15          | WE_n/<br>A14                   | A[13]                          | A[12]    | A[11]    | A[10] | A[9]  | A[8]          |               |
|         | 10 = MPR2    | PAR                    | ACT_n                          | BG[1]                          | BG[0]    | BA[1]    | BA[0] | A[17] | RAS_n/<br>A16 |               |
|         | 11 = MPR3    | CRC<br>Error<br>Status | CA Par-<br>ity Error<br>Status | CA Parity Latency <sup>4</sup> |          |          |       | C[2]  | C[1]          | C[0]          |
|         |              |                        |                                | MR5.A[2]                       | MR5.A[1] | MR5.A[0] |       |       |               |               |

NOTE 1 MPR used for C/A parity error log readout is enabled by setting A[2] in MR3

NOTE 2 For higher density of DRAM, where A[17] is not used, MPR2[1] should be treated as don't care.

NOTE 3 If a device is used in monolithic application, where C[2:0] are not used, then MPR3[2:0] should be treated as don't care.

NOTE 4 MPR3 bit 0~2 (CA parity latency) reflects the latest programmed CA parity latency values.

**Table 25 — MPR Data Format (cont'd)**

MPR page2 (MRS Readout)

| Address | MPR Location | [7]                | [6]                    | [5]    | [4]                       | [3]              | [2]               | [1]              | [0]             | note      |  |
|---------|--------------|--------------------|------------------------|--------|---------------------------|------------------|-------------------|------------------|-----------------|-----------|--|
| BA1:BA0 | 00 = MPR0    | hPPR               | sPPR                   | RTT_WR | Temperature Sensor Status | CRC Write Enable | Rtt_WR            |                  |                 | read-only |  |
|         |              | -                  | -                      | MR2    | -                         | -                | MR2               | MR2              |                 |           |  |
|         |              | -                  | -                      | A11    | -                         | -                | A12               | A10              | A9              |           |  |
|         | 01= MPR1     | Vref DQ Trng range | Vref DQ training Value |        |                           |                  |                   |                  | Geardown Enable |           |  |
|         |              | MR6                | MR6                    |        |                           |                  |                   |                  | MR3             |           |  |
|         |              | A6                 | A5                     | A4     | A3                        | A2               | A1                | A0               | A3              |           |  |
|         |              | CAS Latency        |                        |        |                           |                  | CAS Write Latency |                  |                 |           |  |
|         | 10 = MPR2    | MR0                |                        |        |                           |                  | MR2               |                  |                 |           |  |
|         |              | A6                 | A5                     | A4     | A2                        | A12              | A5                | A4               | A3              |           |  |
|         |              | Rtt_Nom            |                        |        | Rtt_Park                  |                  |                   | Driver Impedance |                 |           |  |
|         | 11 = MPR3    | MR1                |                        |        | MR5                       |                  |                   | MR1              |                 |           |  |
|         |              | A10                | A9                     | A6     | A8                        | A7               | A6                | A2               | A1              |           |  |
|         |              |                    |                        |        |                           |                  |                   |                  |                 |           |  |

MR bit for Temperature Sensor Readout

MR3 bit A5=1 : DRAM updates the temperature sensor status to MPR Page 2 (MPR0 bits A4:A3). Temperature data is guaranteed by the DRAM to be no more than 32ms old at the time of MPR Read of the Temperature Sensor Status bits.

MR3 bit A5=0: DRAM disables updates to the temperature sensor status in MPR Page 2(MPR0-bit A4:A3)

| MPR0 bit A4 | MPR0 bit A3 | Refresh Rate Range          |
|-------------|-------------|-----------------------------|
| 0           | 0           | Sub 1X refresh (> tREFI)    |
| 0           | 1           | 1X refresh rate(= tREFI)    |
| 1           | 0           | 2X refresh rate(1/2* tREFI) |
| 1           | 1           | rsvd                        |

MPR page3 (Vendor use only)<sup>1</sup>

| Address | MPR Location | [7]        | [6]        | [5]        | [4]        | [3]        | [2]        | [1]        | [0]        | note      |
|---------|--------------|------------|------------|------------|------------|------------|------------|------------|------------|-----------|
| BA1:BA0 | 00 = MPR0    | don't care | Read-only |
|         | 01 = MPR1    | don't care |           |
|         | 10 = MPR2    | don't care |           |
|         | 11 = MPR3    | don't care | don't care | don't care | don't care | MAC        | MAC        | MAC        | MAC        |           |

NOTE 1 MPR page3 is specifically assigned to DRAM. Actual encoding method is vendor specific.

### 3.5 Mode Register (cont'd)

#### MR4

**Table 26 — Mode Register 4**

| Address        | Operating Mode                       | Description                            |                        |
|----------------|--------------------------------------|--|------------------------|
| BG1            | RFU                                  | 0 = must be programmed to 0 during MRS |                        |
| BG0, BA1:BA0   | MR Select                            | 000 = MR0                              | 100 = MR4              |
|                |                                      | 001 = MR1                              | 101 = MR5              |
|                |                                      | 010 = MR2                              | 110 = MR6              |
|                |                                      | 011 = MR3                              | 111 = RCW <sup>1</sup> |
| A17            | RFU                                  | 0 = must be programmed to 0 during MRS |                        |
| A13            | hPPR                                 | 0 = Disable                            | 1 = Enable             |
| A12            | Write Preamble                       | 0 = 1 nCK                              | 1 = 2 nCK              |
| A11            | Read Preamble                        | 0 = 1 nCK                              | 1 = 2 nCK              |
| A10            | Read Preamble Training Mode          | 0 = Disable                            | 1 = Enable             |
| A9             | Self Refresh Abort                   | 0 = Disable                            | 1 = Enable             |
| A8:A6          | CS to CMD/ADDR Latency Mode (cycles) | 000 = Disable                          | 100 = 6                |
|                |                                      | 001 = 3                                | 101 = 8                |
|                |                                      | 010 = 4                                | 110 = Reserved         |
|                |                                      | 011 = 5                                | 111 = Reserved         |
| (See Table 27) |                                      |  |                        |
| A5             | sPPR                                 | 0 = Disable                            | 1 = Enable             |
| A4             | Internal Vref Monitor                | 0 = Disable                            | 1 = Enable             |
| A3             | Temperature Controlled Refresh Mode  | 0 = Disable                            | 1 = Enable             |
| A2             | Temperature Controlled Refresh Range | 0 = Normal                             | 1 = Extended           |
| A1             | Maximum Power Down Mode              | 0 = Disable                            | 1 = Enable             |
| A0             | RFU                                  | 0 = must be programmed to 0 during MRS |                        |

NOTE 1 Reserved for Register control word setting. DRAM ignores MR command with BG0,BA1:BA0=111 and doesn't respond. When RFU MR code setting is inputted, DRAM operation is not defined.

**Table 27 — CS to CMD / ADDR Latency Mode Setting**

| A8 | A7 | A6 | CAL      |
|----|----|----|----------|
| 0  | 0  | 0  | Disable  |
| 0  | 0  | 1  | 3        |
| 0  | 1  | 0  | 4        |
| 0  | 1  | 1  | 5        |
| 1  | 0  | 0  | 6        |
| 1  | 0  | 1  | 8        |
| 1  | 1  | 0  | Reserved |
| 1  | 1  | 1  | Reserved |

3.5 Mode Register (cont'd)

**MR5**

**Table 28 — Mode Register 5**

| Address      | Operating Mode                          | Description                            |                        |
|--------------|---|--|------------------------|
| BG1          | RFU                                     | 0 = must be programmed to 0 during MRS |                        |
| BG0, BA1:BA0 | MR Select                               | 000 = MR0                              | 100 = MR4              |
|              |   | 001 = MR1                              | 101 = MR5              |
|              |   | 010 = MR2                              | 110 = MR6              |
|              |   | 011 = MR3                              | 111 = RCW <sup>1</sup> |
| A17          | RFU                                     | 0 = must be programmed to 0 during MRS |                        |
| A13          | RFU                                     | 0 = must be programmed to 0 during MRS |                        |
| A12          | Read DBI                                | 0 = Disable                            | 1 = Enable             |
| A11          | Write DBI                               | 0 = Disable                            | 1 = Enable             |
| A10          | Data Mask                               | 0 = Disable                            | 1 = Enable             |
| A9           | CA parity Persistent Error              | 0 = Disable                            | 1 = Enable             |
| A8:A6        | RTT_PARK                                | (see Table 29)                         |                        |
| A5           | ODT Input Buffer during Power Down mode | 0 = ODT input buffer is activated      |                        |
|              |   | 1 = ODT input buffer is deactivated    |                        |
| A4           | C/A Parity Error Status                 | 0 = Clear                              | 1 = Error              |
| A3           | CRC Error Clear                         | 0 = Clear                              | 1 = Error              |
| A2:A0        | C/A Parity Latency Mode                 | (see Table 30)                         |                        |

NOTE 1 Reserved for Register control word setting .DRAM ignores MR command with BG0,BA1:BA0=111 and doesn't respond. When RFU MR code setting is inputted, DRAM operation is not defined.

NOTE 2 When RTT\_NOM Disable is set in MR1, A5 of MR5 will be ignored.

**Table 29 — RTT\_PARK**

| A8 | A7 | A6 | RTT_PARK         |
|----|----|----|------------------|
| 0  | 0  | 0  | RTT_PARK Disable |
| 0  | 0  | 1  | RZQ/4            |
| 0  | 1  | 0  | RZQ/2            |
| 0  | 1  | 1  | RZQ/6            |
| 1  | 0  | 0  | RZQ/1            |
| 1  | 0  | 1  | RZQ/5            |
| 1  | 1  | 0  | RZQ/3            |
| 1  | 1  | 1  | RZQ/7            |

**Table 30 — C/A Parity Latency Mode**

| A2 | A1 | A0 | PL       | Speed Bin      |
|----|----|----|----------|----------------|
| 0  | 0  | 0  | Disable  |                |
| 0  | 0  | 1  | 4        | 1600,1866,2133 |
| 0  | 1  | 0  | 5        | 2400, 2666     |
| 0  | 1  | 1  | 6        | 2933, 3200     |
| 1  | 0  | 0  | 8        | RFU            |
| 1  | 0  | 1  | Reserved |                |
| 1  | 1  | 0  | Reserved |                |
| 1  | 1  | 1  | Reserved |                |

NOTE 1 Parity latency must be programmed according to timing parameters by speed grade table

## 3.5 Mode Register (cont'd)

**MR6****Table 31 — Mode Register 6**

| Address      | Operating Mode         | Description                            |                            |
|--------------|------------------------|--|----------------------------|
| BG1          | RFU                    | 0 = must be programmed to 0 during MRS |                            |
| BG0, BA1:BA0 | MR Select              | 000 = MR0                              | 100 = MR4                  |
|              |                        | 001 = MR1                              | 101 = MR5                  |
|              |                        | 010 = MR2                              | 110 = MR6                  |
|              |                        | 011 = MR3                              | 111 = RCW <sup>1</sup>     |
| A17          | RFU                    | 0 = must be programmed to 0 during MRS |                            |
| A13, A9, A8  | RFU                    |  |                            |
| A12:A10      | tCCD_L                 | (see Table 32)                         |                            |
| A7           | VrefDQ Training Enable | 0 = Disable (Normal operation Mode)    | 1 = Enable (Training Mode) |
| A6           | VrefDQ Training Range  | (see Table 33)                         |                            |
| A5:A0        | VrefDQ Training Value  | (see Table 34)                         |                            |

NOTE 1 Reserved for Register control word setting . DRAM ignores MR command with BG0,BA1;BA0=111 and doesn't respond.

**Table 32 — tCCD\_L & tDLLK**

| A12 | A11 | A10 | tCCD_L.min (nCK) <sup>1</sup> | tDLLKmin (nCK) <sup>1</sup> | Note   |
|-----|-----|-----|-------------------------------|-----------------------------|--|
| 0   | 0   | 0   | 4                             | 597                         | Data rate ≤ 1333Mbps                               |
| 0   | 0   | 1   | 5                             |                             | 1333Mbps < Data rate ≤ 1866Mbps<br>(1600/1866Mbps) |
| 0   | 1   | 0   | 6                             | 768                         | 1866Mbps < Data rate ≤ 2400Mbps<br>(2133/2400Mbps) |
| 0   | 1   | 1   | 7                             | 1024                        | 2400Mbps < Data rate ≤ 2666Mbps<br>(2666Mbps)      |
| 1   | 0   | 0   | 8                             |                             | 2666Mbps < Data rate ≤ 3200Mbps<br>(2933/3200Mbps) |
| 1   | 0   | 1   | Reserved                      |                             |  |
| 1   | 1   | 0   |                               |                             |  |
| 1   | 1   | 1   |                               |                             |  |

NOTE 1 tCCD\_L/tDLLK should be programmed according to the value defined in AC parameter table per operating frequency

## 3.5 Mode Register (cont'd)

**Table 33 — VrefDQ Training : Range**

| A6 | VrefDQ Range |
|----|--------------|
| 0  | Range 1      |
| 1  | Range 2      |

**Table 34 — VrefDQ Training: Values**

| A5:A0   | Range1 | Range2 | A5:A0              | Range1   | Range2   |
|---------|--------|--------|--------------------|----------|----------|
| 00 0000 | 60.00% | 45.00% | 01 1010            | 76.90%   | 61.90%   |
| 00 0001 | 60.65% | 45.65% | 01 1011            | 77.55%   | 62.55%   |
| 00 0010 | 61.30% | 46.30% | 01 1100            | 78.20%   | 63.20%   |
| 00 0011 | 61.95% | 46.95% | 01 1101            | 78.85%   | 63.85%   |
| 00 0100 | 62.60% | 47.60% | 01 1110            | 79.50%   | 64.50%   |
| 00 0101 | 63.25% | 48.25% | 01 1111            | 80.15%   | 65.15%   |
| 00 0110 | 63.90% | 48.90% | 10 0000            | 80.80%   | 65.80%   |
| 00 0111 | 64.55% | 49.55% | 10 0001            | 81.45%   | 66.45%   |
| 00 1000 | 65.20% | 50.20% | 10 0010            | 82.10%   | 67.10%   |
| 00 1001 | 65.85% | 50.85% | 10 0011            | 82.75%   | 67.75%   |
| 00 1010 | 66.50% | 51.50% | 10 0100            | 83.40%   | 68.40%   |
| 00 1011 | 67.15% | 52.15% | 10 0101            | 84.05%   | 69.05%   |
| 00 1100 | 67.80% | 52.80% | 10 0110            | 84.70%   | 69.70%   |
| 00 1101 | 68.45% | 53.45% | 10 0111            | 85.35%   | 70.35%   |
| 00 1110 | 69.10% | 54.10% | 10 1000            | 86.00%   | 71.00%   |
| 00 1111 | 69.75% | 54.75% | 10 1001            | 86.65%   | 71.65%   |
| 01 0000 | 70.40% | 55.40% | 10 1010            | 87.30%   | 72.30%   |
| 01 0001 | 71.05% | 56.05% | 10 1011            | 87.95%   | 72.95%   |
| 01 0010 | 71.70% | 56.70% | 10 1100            | 88.60%   | 73.60%   |
| 01 0011 | 72.35% | 57.35% | 10 1101            | 89.25%   | 74.25%   |
| 01 0100 | 73.00% | 58.00% | 10 1110            | 89.90%   | 74.90%   |
| 01 0101 | 73.65% | 58.65% | 10 1111            | 90.55%   | 75.55%   |
| 01 0110 | 74.30% | 59.30% | 11 0000            | 91.20%   | 76.20%   |
| 01 0111 | 74.95% | 59.95% | 11 0001            | 91.85%   | 76.85%   |
| 01 1000 | 75.60% | 60.60% | 11 0010            | 92.50%   | 77.50%   |
| 01 1001 | 76.25% | 61.25% | 11 0011 to 11 1111 | Reserved | Reserved |

**DRAM MR7 Ignore**

The DDR4 SDRAM shall ignore any access to MR7 for all DDR4 SDRAM. Any bit setting within MR7 may not take any effect in the DDR4 SDRAM.

## 4 DDR4 SDRAM Command Description and Operation

### 4.1 Command Truth Table

(a) Note 1,2,3 and 4 apply to the entire Command truth table

(b) Note 5 applies to all Read/Write commands.

[BG=Bank Group Address, BA=Bank Address, RA=Row Address, CA=Column Address, BC\_n=Burst Chop, X=Don't Care, V=Valid].

**Table 35 — Command Truth Table**

| Function                                     | Abbreviation | CKE            |               | CS_n | ACT_n | RAS_n/A16        | CAS_n/A15 | WE_n/A14 | BG0-BG1 | BA0-BA1 | C2-C0 | A12/BC_n         | A17,A13,A11 | A10/AP | A0-A9 | NOTE         |
|--|--------------|----------------|---------------|------|-------|------------------|-----------|----------|---------|---------|-------|------------------|-------------|--------|-------|--------------|
|  |              | Previous Cycle | Current Cycle |      |       |                  |           |          |         |         |       |                  |             |        |       |              |
| Mode Register Set                            | MRS          | H              | H             | L    | H     | L                | L         | L        | BG      | BA      | V     | OP Code          |             |        |       | 12           |
| Refresh                                      | REF          | H              | H             | L    | H     | L                | L         | H        | V       | V       | V     | V                | V           | V      | V     |              |
| Self Refresh Entry                           | SRE          | H              | L             | L    | H     | L                | L         | H        | V       | V       | V     | V                | V           | V      | V     | 7,9          |
| Self Refresh Exit                            | SRX          | L              | H             | H    | X     | X                | X         | X        | X       | X       | X     | X                | X           | X      | X     | 7,8,9,<br>10 |
| Single Bank Precharge                        | PRE          |                |               | L    | H     | H                | H         | H        | V       | V       | V     | V                | V           | V      | V     |              |
| Precharge all Banks                          | PREA         | H              | H             | L    | H     | L                | H         | L        | V       | V       | V     | V                | V           | V      | H     | V            |
| RFU  | RFU          | H              | H             | L    | H     | L                | H         | H        | RFU     |         |       |                  |             |        |       |              |
| Bank Activate                                | ACT          | H              | H             | L    | L     | Row Address (RA) |           |          | BG      | BA      | V     | Row Address (RA) |             |        |       |              |
| Write (Fixed BL8 or BC4)                     | WR           | H              | H             | L    | H     | H                | L         | L        | BG      | BA      | V     | V                | V           | L      | CA    |              |
| Write (BC4, on the Fly)                      | WRS4         | H              | H             | L    | H     | H                | L         | L        | BG      | BA      | V     | L                | V           | L      | CA    |              |
| Write (BL8, on the Fly)                      | WRS8         | H              | H             | L    | H     | H                | L         | L        | BG      | BA      | V     | H                | V           | L      | CA    |              |
| Write with Auto Precharge (Fixed BL8 or BC4) | WRA          | H              | H             | L    | H     | H                | L         | L        | BG      | BA      | V     | V                | V           | V      | H     | CA           |
| Write with Auto Precharge (BC4, on the Fly)  | WRAS4        | H              | H             | L    | H     | H                | L         | L        | BG      | BA      | V     | L                | V           | H      | CA    |              |
| Write with Auto Precharge (BL8, on the Fly)  | WRAS8        | H              | H             | L    | H     | H                | L         | L        | BG      | BA      | V     | H                | V           | H      | CA    |              |
| Read (Fixed BL8 or BC4)                      | RD           | H              | H             | L    | H     | H                | L         | H        | BG      | BA      | V     | V                | V           | L      | CA    |              |
| Read (BC4, on the Fly)                       | RDS4         | H              | H             | L    | H     | H                | L         | H        | BG      | BA      | V     | L                | V           | L      | CA    |              |
| Read (BL8, on the Fly)                       | RDS8         | H              | H             | L    | H     | H                | L         | H        | BG      | BA      | V     | H                | V           | L      | CA    |              |
| Read with Auto Precharge (Fixed BL8 or BC4)  | RDA          | H              | H             | L    | H     | H                | L         | H        | BG      | BA      | V     | V                | V           | V      | H     | CA           |
| Read with Auto Precharge (BC4, on the Fly)   | RDAS4        | H              | H             | L    | H     | H                | L         | H        | BG      | BA      | V     | L                | V           | H      | CA    |              |
| Read with Auto Precharge (BL8, on the Fly)   | RDAS8        | H              | H             | L    | H     | H                | L         | H        | BG      | BA      | V     | H                | V           | H      | CA    |              |
| No Operation                                 | NOP          | H              | H             | L    | H     | H                | H         | H        | V       | V       | V     | V                | V           | V      | V     | 10           |
| Device Deselected                            | DES          | H              | H             | H    | X     | X                | X         | X        | X       | X       | X     | X                | X           | X      | X     |              |
| Power Down Entry                             | PDE          | H              | L             | H    | X     | X                | X         | X        | X       | X       | X     | X                | X           | X      | X     | 6            |
| Power Down Exit                              | PDX          | L              | H             | H    | X     | X                | X         | X        | X       | X       | X     | X                | X           | X      | X     | 6            |
| ZQ calibration Long                          | ZQCL         | H              | H             | L    | H     | H                | H         | L        | V       | V       | V     | V                | V           | H      | V     |              |
| ZQ calibration Short                         | ZQCS         | H              | H             | L    | H     | H                | H         | L        | V       | V       | V     | V                | V           | L      | V     |              |

NOTE 1 All DDR4 SDRAM commands are defined by states of CS\_n, ACT\_n, RAS\_n/A16, CAS\_n/A15, WE\_n/A14 and CKE at the rising edge of the clock. The MSB of BG, BA, RA and CA are device density and configuration dependent. When ACT\_n = H; pins RAS\_n/A16, CAS\_n/A15, and WE\_n/A14 are used as command pins RAS\_n, CAS\_n, and WE\_n respectively. When ACT\_n = L; pins RAS\_n/A16, CAS\_n/A15, and WE\_n/A14 are used as address pins A16, A15, and A14 respectively.

NOTE 2 RESET\_n is Low enable command which will be used only for asynchronous reset so must be maintained HIGH during any function.

NOTE 3 Bank Group addresses (BG) and Bank addresses (BA) determine which bank within a bank group to be operated upon. For MRS commands the BG and BA selects the specific Mode Register location.

NOTE 4 "V" means "H or L (but a defined logic level)" and "X" means either "defined or undefined (like floating) logic level".

NOTE 5 Burst reads or writes cannot be terminated or interrupted and Fixed/on-the-Fly BL will be defined by MRS.

NOTE 6 The Power Down Mode does not perform any refresh operation.

NOTE 7 The state of ODT does not affect the states described in this table. The ODT function is not available during Self Refresh.

NOTE 8 Controller guarantees self refresh exit to be synchronous.

NOTE 9 VPP and VREF (VrefCA) must be maintained during Self Refresh operation.

NOTE 10 The No Operation command should be used in cases when the DDR4 SDRAM is in Gear Down Mode and Max Power Saving Mode Exit

NOTE 11 Refer to the CKE Truth Table for more detail with CKE transition.

NOTE 12 During a MRS command A17 is Reserved for Future Use and is device density and configuration dependent.

## 4.2 CKE Truth Table

**Table 36 — CKE Truth Table**

| Current State <sup>2</sup>                                   | CKE                                  |                                   | Command (N) <sup>3</sup><br>RAS_n, CAS_n,<br>WE_n, CS_n | Action (N) <sup>3</sup>    | NOTE           |
|--|--------------------------------------|-----------------------------------|---|----------------------------|----------------|
|  | Previous Cycle <sup>1</sup><br>(N-1) | Current Cycle <sup>1</sup><br>(N) |   |                            |                |
| Power Down   | L                                    | L                                 | X   | Maintain Power-Down        | 14, 15         |
|  | L                                    | H                                 | DESELECT  | Power Down Exit            | 11, 14         |
| Self Refresh   | L                                    | L                                 | X   | Maintain Self Refresh      | 15, 16         |
|  | L                                    | H                                 | DESELECT  | Self Refresh Exit          | 8, 12, 16      |
| Bank(s) Active   | H                                    | L                                 | DESELECT  | Active Power Down Entry    | 11, 13, 14     |
| Reading  | H                                    | L                                 | DESELECT  | Power Down Entry           | 11, 13, 14, 17 |
| Writing  | H                                    | L                                 | DESELECT  | Power Down Entry           | 11, 13, 14, 17 |
| Precharging  | H                                    | L                                 | DESELECT  | Power Down Entry           | 11, 13, 14, 17 |
| Refreshing   | H                                    | L                                 | DESELECT  | Precharge Power Down Entry | 11             |
| All Banks Idle   | H                                    | L                                 | DESELECT  | Precharge Power Down Entry | 11, 13, 14, 18 |
|  | H                                    | L                                 | REFRESH   | Self Refresh Entry         | 9, 13, 18      |
| For more details with all signals See "Command Truth Table". |                                      |                                   |   |                            | 10             |

NOTE 1 CKE (N) is the logic state of CKE at clock edge N; CKE (N-1) was the state of CKE at the previous clock edge.

NOTE 2 Current state is defined as the state of the DDR4 SDRAM immediately prior to clock edge N.

NOTE 3 COMMAND (N) is the command registered at clock edge N, and ACTION (N) is a result of COMMAND (N), ODT is not included here.

NOTE 4 All states and sequences not shown are illegal or reserved unless explicitly described elsewhere in this document.

NOTE 5 The state of ODT does not affect the states described in this table. The ODT function is not available during Self-Refresh.

NOTE 6 During any CKE transition (registration of CKE H->L or CKE L->H), the CKE level must be maintained until 1nCK prior to tCKEmin being satisfied (at which time CKE may transition again).

NOTE 7 DESELECT and NOP are defined in the Command Truth Table.

NOTE 8 On Self-Refresh Exit DESELECT commands must be issued on every clock edge occurring during the tXS period. Read or ODT commands may be issued only after tXSDL is satisfied.

NOTE 9 Self-Refresh mode can only be entered from the All Banks Idle state.

NOTE 10 Must be a legal command as defined in the Command Truth Table.

NOTE 11 Valid commands for Power-Down Entry and Exit are DESELECT only.

NOTE 12 Valid commands for Self-Refresh Exit are DESELECT only except for Gear Down mode and Max Power Saving exit. NOP is allowed for these 2 modes.

NOTE 13 Self-Refresh can not be entered during Read or Write operations. For a detailed list of restrictions See "Self-Refresh Operation" on Section 4.27 and See "Power-Down Modes" on Section 4.28.

NOTE 14 The Power-Down does not perform any refresh operations.

NOTE 15 "X" means "don't care" (including floating around VREF) in Self-Refresh and Power-Down. It also applies to Address pins.

NOTE 16 VPP and VREF (VrefCA) -must be maintained during Self-Refresh operation.

NOTE 17 If all banks are closed at the conclusion of the read, write or precharge command, then Precharge Power-Down is entered, otherwise Active Power-Down is entered.

NOTE 18 'Idle state' is defined as all banks are closed (tRP, tDAL, etc. satisfied), no data bursts are in progress, CKE is high, and all timings from previous operations are satisfied (tMRD, tMOD, tRFC, tZQinit, tZQoper, tZQCS, etc.) as well as all Self-Refresh exit and Power-Down Exit parameters are satisfied (tXS, tXP, etc.)

### 4.3 Burst Length, Type and Order

Accesses within a given burst may be programmed to sequential or interleaved order. The burst type is selected via bit A3 of Mode Register MR0. The ordering of accesses within a burst is determined by the burst length, burst type, and the starting column address as shown in Table 37. The burst length is defined by bits A0-A1 of Mode Register MR0. Burst length options include fixed BC4, fixed BL8, and 'on the fly' which allows BC4 or BL8 to be selected coincident with the registration of a Read or Write command via A12/BC\_n.

**Table 37 — Burst Type and Burst Order**

| Burst Length | Read/Write | Starting Column Address (A2,A1,A0) | burst type = Sequential (decimal)<br>A3=0 | burst type = Interleaved (decimal)<br>A3=1 | NOTE    |
|--------------|------------|------------------------------------|---|--|---------|
| 4 Chop       | READ       | 0 0 0                              | 0,1,2,3,T,T,T,T                           | 0,1,2,3,T,T,T,T                            | 1,2,3   |
|              |            | 0 0 1                              | 1,2,3,0,T,T,T,T                           | 1,0,3,2,T,T,T,T                            | 1,2,3   |
|              |            | 0 1 0                              | 2,3,0,1,T,T,T,T                           | 2,3,0,1,T,T,T,T                            | 1,2,3   |
|              |            | 0 1 1                              | 3,0,1,2,T,T,T,T                           | 3,2,1,0,T,T,T,T                            | 1,2,3   |
|              |            | 1 0 0                              | 4,5,6,7,T,T,T,T                           | 4,5,6,7,T,T,T,T                            | 1,2,3   |
|              |            | 1 0 1                              | 5,6,7,4,T,T,T,T                           | 5,4,7,6,T,T,T,T                            | 1,2,3   |
|              |            | 1 1 0                              | 6,7,4,5,T,T,T,T                           | 6,7,4,5,T,T,T,T                            | 1,2,3   |
|              |            | 1 1 1                              | 7,4,5,6,T,T,T,T                           | 7,6,5,4,T,T,T,T                            | 1,2,3   |
|              | WRITE      | 0, V, V                            | 0,1,2,3,X,X,X,X                           | 0,1,2,3,X,X,X,X                            | 1,2,4,5 |
|              |            | 1, V, V                            | 4,5,6,7,X,X,X,X                           | 4,5,6,7,X,X,X,X                            | 1,2,4,5 |
| 8            | READ       | 0 0 0                              | 0,1,2,3,4,5,6,7                           | 0,1,2,3,4,5,6,7                            | 2       |
|              |            | 0 0 1                              | 1,2,3,0,5,6,7,4                           | 1,0,3,2,5,4,7,6                            | 2       |
|              |            | 0 1 0                              | 2,3,0,1,6,7,4,5                           | 2,3,0,1,6,7,4,5                            | 2       |
|              |            | 0 1 1                              | 3,0,1,2,7,4,5,6                           | 3,2,1,0,7,6,5,4                            | 2       |
|              |            | 1 0 0                              | 4,5,6,7,0,1,2,3                           | 4,5,6,7,0,1,2,3                            | 2       |
|              |            | 1 0 1                              | 5,6,7,4,1,2,3,0                           | 5,4,7,6,1,0,3,2                            | 2       |
|              |            | 1 1 0                              | 6,7,4,5,2,3,0,1                           | 6,7,4,5,2,3,0,1                            | 2       |
|              |            | 1 1 1                              | 7,4,5,6,3,0,1,2                           | 7,6,5,4,3,2,1,0                            | 2       |
|              | WRITE      | V, V, V                            | 0,1,2,3,4,5,6,7                           | 0,1,2,3,4,5,6,7                            | 2,4     |

NOTE 1 In case of burst length being fixed to 4 by MR0 setting, the internal write operation starts two clock cycles earlier than for the BL8 mode. This means that the starting point for tWR and tWTR will be pulled in by two clocks. In case of burst length being selected on-the-fly via A12/BC\_n, the internal write operation starts at the same point in time like a burst of 8 write operation. This means that during on-the-fly control, the starting point for tWR and tWTR will not be pulled in by two clocks.

NOTE 2 0...7 bit number is value of CA[2:0] that causes this bit to be the first read during a burst.

NOTE 3 Output driver for data and strobes are in high impedance.

NOTE 4 V : A valid logic level (0 or 1), but respective buffer input ignores level on input pins.

NOTE 5 X : Don't Care.

#### 4.3.1 BL8 Burst order with CRC Enabled

DDR4 SDRAM supports fixed write burst ordering [A2:A1:A0=0:0:0] when write CRC is enabled in BL8 (fixed).

## 4.4 DLL-off Mode & DLL on/off Switching procedure

### 4.4.1 DLL on/off switching procedure

DDR4 SDRAM DLL-off mode is entered by setting MR1 bit A0 to "0"; this will disable the DLL for subsequent operations until A0 bit is set back to "1".

### 4.4.2 DLL "on" to DLL "off" Procedure

To switch from DLL "on" to DLL "off" requires the frequency to be changed during Self-Refresh, as outlined in the following procedure:

1. Starting from Idle state (All banks pre-charged, all timings fulfilled, and DRAMs On-die Termination resistors, RTT\_NOM, must be in high impedance state before MRS to MR1 to disable the DLL.)

2. Set MR1 bit A0 to "0" to disable the DLL.

3. Wait tMOD.

4. Enter Self Refresh Mode; wait until (tCKSRE) is satisfied.

5. Change frequency, in guidance with "Input clock frequency change" on Section 4.6.

6. Wait until a stable clock is available for at least (tCKSRX) at DRAM inputs.

7. Starting with the Self Refresh Exit command, CKE must continuously be registered HIGH until all tMOD timings from any MRS command are satisfied. In addition, if any ODT features were enabled in the mode registers when Self Refresh mode was entered, the ODT signal must continuously be registered LOW until all tMOD timings from any MRS command are satisfied. If RTT\_NOM features were disabled in the mode registers when Self Refresh mode was entered, ODT signal is Don't Care.

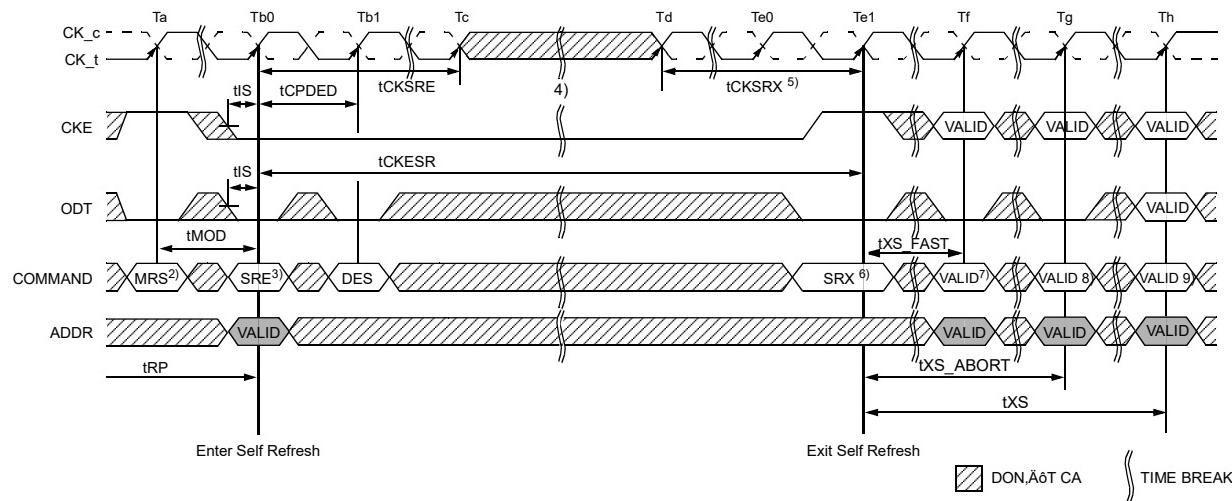
8. Wait tXS\_Fast or tXS\_Abort or tXS, then set Mode Registers with appropriate values (especially an update of CL, CWL and WR may be necessary. A ZQCL command may also be issued after tXS\_Fast).

- tXS - ACT, PRE, PREA, REF, SRE, PDE, WR, WRS4, WRS8, WRA, WRAS4, WRAS8, RD, RDS4, RDS8, RDA, RDAS4, RDAS8  
- tXS\_Fast - ZQCL, ZQCS, MRS commands. For MRS command, only DRAM CL and WR/RTP register in MR0, CWL register in MR2 and geardown mode in MR3 are allowed to be accessed provided DRAM is not in per DRAM addressability mode. Access to other DRAM mode registers must satisfy tXS timing.

- tXS\_Abort - If the MR4 bit A9 is enabled then the DRAM aborts any ongoing refresh and does not increment the refresh counter. The controller can issue a valid command after a delay of tXS\_Abort. Upon exit from Self-Refresh, the DDR4 SDRAM requires a minimum of one extra refresh command before it is put back into Self-Refresh Mode. This requirement remains the same irrespective of the setting of the MRS bit for self refresh abort.

9. Wait for tMOD, then DRAM is ready for next command.

#### 2.4.2 DLL “on” to DLL “off” Procedure (cont’d)



NOTE 1 Starting with Idle State, RTT in Stable

NOTE 2 Disable DLL by setting MR1 Bit A0 to 0

NOTE 3 Enter SR

NOTE 4 Change Frequency

NOTE 5 Clock must be stable tCKSXRX

NOTE 6 Exit SR

NOTES 7,8,9 Update Mode registers allowed with DLL off parameters setting

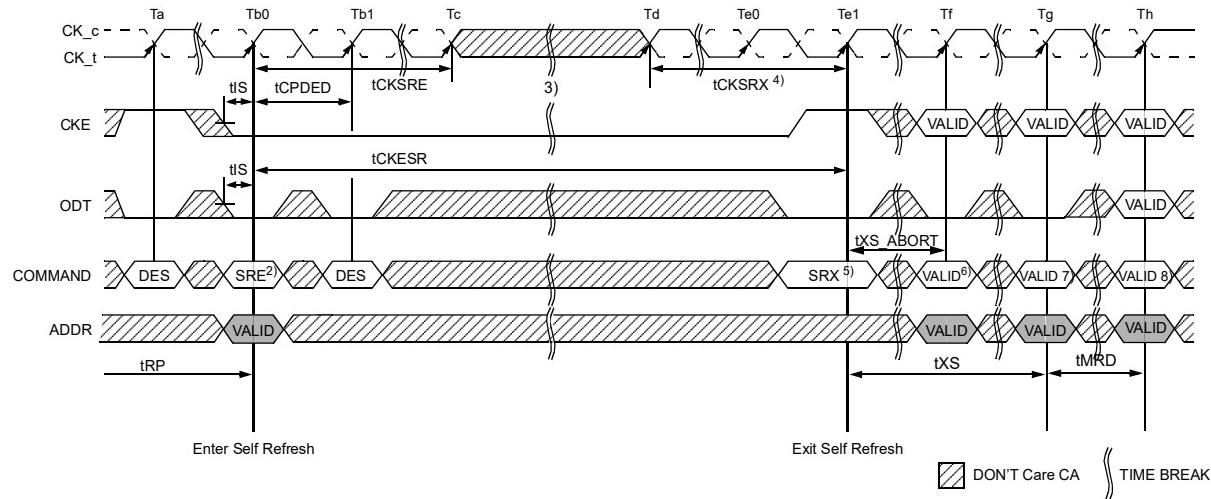
**Figure 12 — DLL Switch Sequence from DLL ON to DLL OFF**

#### 4.4.3 DLL “off” to DLL “on” Procedure

To switch from DLL “off” to DLL “on” (with required frequency change) during Self-Refresh:

1. Starting from Idle state (All banks pre-charged, all timings fulfilled and DRAMs On-die Termination resistors (RTT\_NOM) must be in high impedance state before Self-Refresh mode is entered.)
2. Enter Self Refresh Mode, wait until tCKSRE satisfied.
3. Change frequency, in guidance with "Input clock frequency change" on Section 4.6.
4. Wait until a stable clock is available for at least (tCKSXRX) at DRAM inputs.
5. Starting with the Self Refresh Exit command, CKE must continuously be registered HIGH until tDLLK timing from subsequent DLL Reset command is satisfied. In addition, if any ODT features were enabled in the mode registers when Self Refresh mode was entered, the ODT signal must continuously be registered LOW until tDLLK timings from subsequent DLL Reset command is satisfied. If RTT\_NOM were disabled in the mode registers when Self Refresh mode was entered, ODT signal is Don't care.
6. Wait tXS or tXS\_ABORT depending on Bit A9 in MR4, then set MR1 bit A0 to “1” to enable the DLL.
7. Wait tMRD, then set MRO bit A8 to “1” to start DLL Reset.
8. Wait tMRD, then set Mode Registers with appropriate values (especially an update of CL, CWL and WR may be necessary. After tMOD satisfied from any proceeding MRS command, a ZQCL command may also be issued during or after tDLLK.)
9. Wait for tMOD, then DRAM is ready for next command (Remember to wait tDLLK after DLL Reset before applying command requiring a locked DLL!). In addition, wait also for tZQoper in case a ZQCL command was issued.

#### 4.4.3 DLL “off” to DLL “on” Procedure (cont’d)



NOTE 1 Starting with Idle State

NOTE 2 Enter SR

NOTE 3 Change Frequency

NOTE 4 Clock must be stable tCKSRX

NOTE 5 Exit SR

NOTES 6,7 Set DLL-on by MR1 A0='1'

NOTE 8 Start DLLReset

NOTE 9 Update rest MR register values after tDLLK (not shown in the diagram)

NOTE 10 Ready for valid command after tDLLK (not shown in the diagram)

**Figure 13 — DLL Switch Sequence from DLL OFF to DLL ON**

#### 4.5 DLL-off Mode

DDR4 SDRAM DLL-off mode is entered by setting MR1 bit A0 to “0”; this will disable the DLL for subsequent operations until A0 bit is set back to “1”. The MR1 A0 bit for DLL control can be switched either during initialization or later. Refer to “Input clock frequency change” on Section 4.6.

The DLL-off Mode operations listed below are an optional feature for DDR4 SDRAM. The maximum clock frequency for DLL-off Mode is specified by the parameter tCKDLL\_OFF. There is no minimum frequency limit besides the need to satisfy the refresh interval, tREFI.

Due to latency counter and timing restrictions, only one value of CAS Latency (CL) in MR0 and CAS Write Latency (CWL) in MR2 are supported. The DLL-off mode is only required to support setting of both CL=10 and CWL=9. When DLL-off Mode is enabled, use of CA Parity Mode is not allowed.

DLL-off mode will affect the Read data Clock to Data Strobe relationship (tDQSK), but not the Data Strobe to Data relationship (tDQSQ, tQH). Special attention is needed to line up Read data to controller time domain.

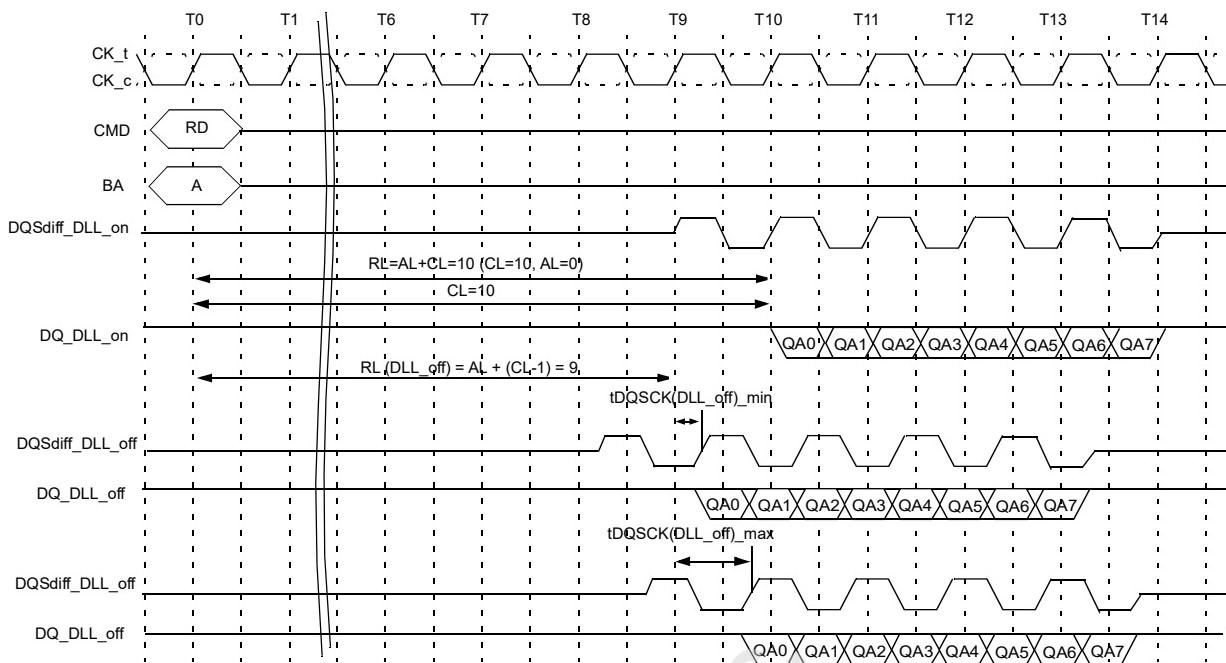
Comparing with DLL-on mode, where tDQSK starts from the rising clock edge (AL+CL) cycles after the Read command, the DLL-off mode tDQSK starts (AL+CL - 1) cycles after the read command.

Another difference is that tDQSK may not be small compared to tCK (it might even be larger than tCK) and the difference between tDQSKmin and tDQSKmax is significantly larger than in DLL-on mode.

tDQSK(DLL\_off) values are vendor specific.

The timing relations on DLL-off mode READ operation are shown in the following Timing Diagram:  
 (CL=10, BL=8, PL=0):

#### 4.5 DLL-off Mode (cont'd)



**Figure 14 — READ operation at DLL-off mode**

#### 4.6 Input Clock Frequency Change

Once the DDR4 SDRAM is initialized, the DDR4 SDRAM requires the clock to be “stable” during almost all states of normal operation. This means that, once the clock frequency has been set and is to be in the “stable state”, the clock period is not allowed to deviate except for what is allowed for by the clock jitter and SSC (spread spectrum clocking) specifications.

The input clock frequency can be changed from one stable clock rate to another stable clock rate under Self- Refresh mode. Outside Self-Refresh mode, it is illegal to change the clock frequency.

Once the DDR4 SDRAM has been successfully placed into Self-Refresh mode and tCKSRE has been satisfied, the state of the clock becomes a don’t care. Once a don’t care, changing the clock frequency is permissible, provided the new clock frequency is stable prior to tCKSRX. When entering and exiting Self-Refresh mode for the sole purpose of changing the clock frequency, the Self- Refresh entry and exit specifications must still be met as outlined in Section 4.27 “Self-Refresh Operation”.

For the new clock frequency, additional MRS commands to MR0, MR2, MR3, MR4, MR5, and MR6 may need to be issued to program appropriate CL, CWL, Gear-down mode, Read & Write Preamble, Command Address Latency (CAL Mode), Command Address Parity (CA Parity Mode), and tCCD\_L/tDLLK value.

In particular, the Command Address Parity Latency (PL) must be disabled when the clock rate changes, i.e. while in Self Refresh Mode. For example, if changing the clock rate from DDR4-2133 to DDR4-2933 with CA Parity Mode enabled, MR5[2:0] must first change from PL = 4 to PL = disable prior to PL = 6. A correct procedure would be to (1) change PL = 4 to disable via MR5 [2:0], (2) enter Self Refresh Mode, (3) change clock rate from DDR4-2133 to DDR4-2933, (4) exit Self Refresh Mode, (5) Enable CA Parity Mode setting PL = 6 via MR5 [2:0].

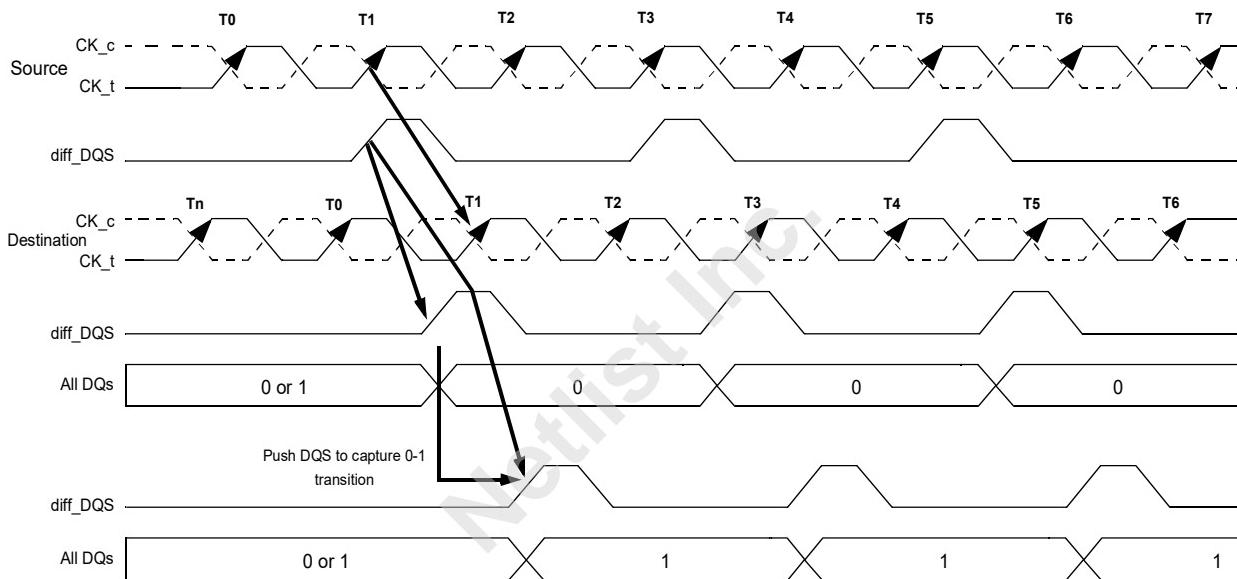
If the MR settings that require additional clocks are updated after the clock rate has been increased, i.e., after exiting self refresh mode, the required MR settings must be updated prior to removing the DRAM from the IDLE state, unless the DRAM is RESET. If the DRAM leaves the idle state to enter self refresh mode or ZQ Calibration, the updating of the required MR settings may be deferred to after the next time the DRAM enters the IDLE state.

If MR6 is issued prior to Self Refresh Entry for new tDLLK value, then DLL will relock automatically at Self Refresh Exit. However, if MR6 is issued after Self Refresh Entry, then MR0 must be issued to reset the DLL. The DDR4 SDRAM input clock frequency is allowed to change only within the minimum and maximum operating frequency specified for the particular speed grade. Any frequency change below the minimum operating frequency would require the use of DLL\_on-mode -> DLL\_off-mode transition sequence, refer to Section 4.4, DLL on/off switching procedure

## 4.7 Write Leveling

For better signal integrity, the DDR4 memory module adopted fly-by topology for the commands, addresses, control signals, and clocks. The fly-by topology has benefits from reducing number of stubs and their length, but it also causes flight time skew between clock and strobe at every DRAM on the DIMM. This makes it difficult for the Controller to maintain tDQSS, tDSS, and tDSH specification. Therefore, the DDR4 SDRAM supports a 'write leveling' feature to allow the controller to compensate for skew. This feature may not be required under some system conditions provided the host can maintain the tDQSS, tDSS and tDSH specifications.

The memory controller can use the 'write leveling' feature and feedback from the DDR4 SDRAM to adjust the DQS\_t - DQS\_c to CK\_t - CK\_c relationship. The memory controller involved in the leveling must have adjustable delay setting on DQS\_t - DQS\_c to align the rising edge of DQS\_t - DQS\_c with that of the clock at the DRAM pin. The DRAM asynchronously feeds back CK\_t - CK\_c sampled with the rising edge of DQS\_t - DQS\_c, through the DQ bus. The controller repeatedly delays DQS\_t - DQS\_c until a transition from 0 to 1 is detected. The DQS\_t - DQS\_c delay established through this exercise would ensure tDQSS specification. Besides tDQSS, tDSS and tDSH specification also needs to be fulfilled. One way to achieve this is to combine the actual tDQSS in the application with an appropriate duty cycle and jitter on the DQS\_t - DQS\_c signals. Depending on the actual tDQSS in the application, the actual values for tDQSL and tDQSH may have to be better than the absolute limits provided in the chapter "AC Timing Parameters" in order to satisfy tDSS and tDSH specification. A conceptual timing of this scheme is shown in Figure 15.



**Figure 15 — Write Leveling Concept**

DQS\_t - DQS\_c driven by the controller during leveling mode must be terminated by the DRAM based on ranks populated. Similarly, the DQ bus driven by the DRAM must also be terminated at the controller.

All data bits should carry the leveling feedback to the controller across the DRAM configurations X4, X8, and X16. On a X16 device, both byte lanes should be leveled independently. Therefore, a separate feedback mechanism should be available for each byte lane. The upper data bits should provide the feedback of the upper diff\_DQS(diff\_UDQS) to clock relationship whereas the lower data bits would indicate the lower diff\_DQS(diff\_LDQS) to clock relationship.

#### 4.7.1 DRAM setting for write leveling & DRAM termination function in that mode

DRAM enters into Write leveling mode if A7 in MR1 set 'High' and after finishing leveling, DRAM exits from write leveling mode if A7 in MR1 set 'Low' (Table 38). Note that in write leveling mode, only DQS\_t/DQS\_c terminations are activated and deactivated via ODT pin, unlike normal operation (Table 39).

**Table 38 — MR setting involved in the leveling procedure**

| Function                  | MR1 | Enable | Disable |
|---------------------------|-----|--------|---------|
| Write leveling enable     | A7  | 1      | 0       |
| Output buffer mode (Qoff) | A12 | 0      | 1       |

**Table 39 — DRAM termination function in the leveling mode**

| ODT pin @DRAM if RTT_NOM/PARK Value is set via MRS | DQS_t/DQS_c termination | DQs termination |
|--|-------------------------|-----------------|
| RTT_NOM with ODT High                              | On                      | Off             |
| RTT_PARK with ODT LOW                              | On                      | Off             |

NOTE 1 In Write Leveling Mode with its output buffer disabled (MR1[bit A7] = 1 with MR1[bit A12] = 1) all RTT\_NOM and RTT\_PARK settings are allowed; in Write Leveling Mode with its output buffer enabled (MR1[bit A7] = 1 with MR1[bit A12] = 0) all RTT\_NOM and RTT\_PARK settings are allowed.

NOTE 2 Dynamic ODT function is not available in Write Leveling Mode. DRAM MR2 bits A[11:9] must be '000' prior to entering Write Leveling Mode.

#### 4.7.2 Procedure Description

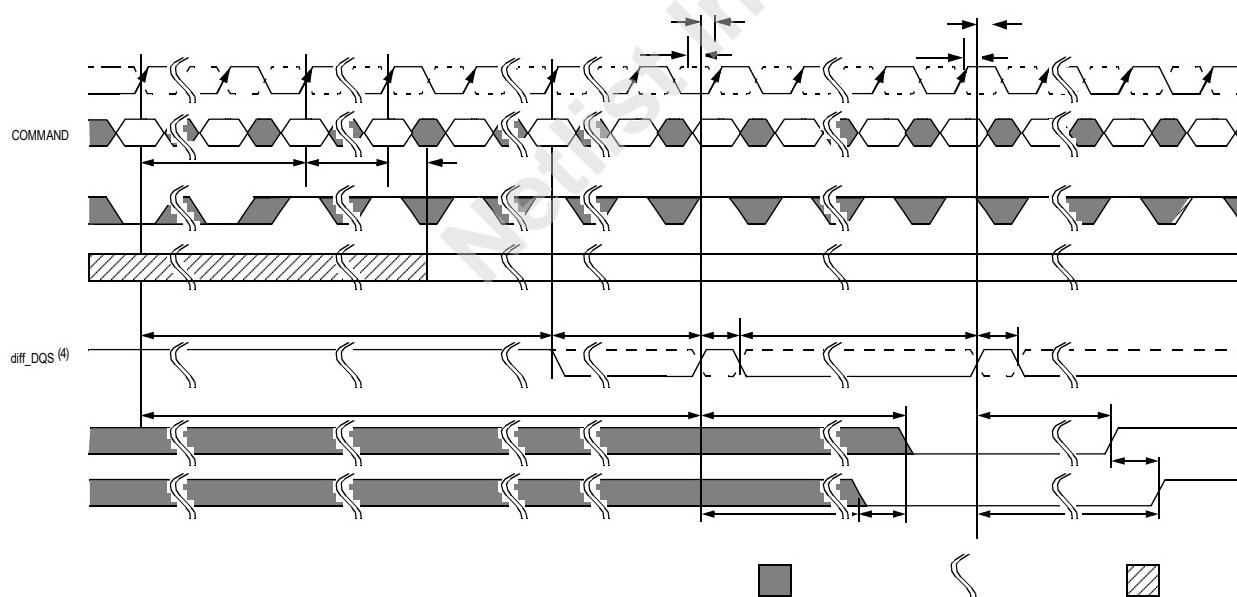
The Memory controller initiates Leveling mode of all DRAMs by setting bit A7 of MR1 to 1. When entering write leveling mode, the DQ pins are in undefined driving mode. During write leveling mode, only DESELECT commands are allowed, as well as an MRS command to change Qoff bit (MR1[A12]) and an MRS command to exit write leveling (MR1[A7]). Upon exiting write leveling mode, the MRS command performing the exit (MR1[A7]=0) may also change MR1 bits of A12-A8 ,A2-A1. Since the controller levels one rank at a time, the output of other ranks must be disabled by setting MR1 bit A12 to 1. The Controller may assert ODT after tMOD, at which time the DRAM is ready to accept the ODT signal.

The Controller may drive DQS\_t low and DQS\_c high after a delay of tWLQSEN, at which time the DRAM has applied on-die termination on these signals. After tDQSL and tWLMRD, the controller provides a single DQS\_t, DQS\_c edge which is used by the DRAM to sample CK\_t - CK\_c driven from controller. tWLMRD(max) timing is controller dependent.

DRAM samples CK\_t - CK\_c status with rising edge of DQS\_t - DQS\_c and provides feedback on all the DQ bits asynchronously after tWLOE timing. There is a DQ output uncertainty of tWLOE defined to allow mismatch on DQ bits. The tWLOE period is defined from the transition of the earliest DQ bit to the corresponding transition of the latest DQ bit. There are no read strobes (DQS\_t / DQS\_c) needed for these DQs. Controller samples incoming DQs and decides to increment or decrement DQS\_t - DQS\_c delay setting and launches the next DQS\_t/DQS\_c pulse after some time, which is controller dependent. Once a 0 to 1 transition is detected, the controller locks DQS\_t - DQS\_c delay setting and write leveling is achieved for the device. Figure 16 describes the timing diagram and parameters for the overall Write Leveling procedure.

**Table 40 — Write Leveling Mode**

| Parameter                   | Symbol | DDR4-1600,1866,2133,2400 |     | DDR4-2666,3200 |     | Units | NOTE |
|-----------------------------|--------|--------------------------|-----|----------------|-----|-------|------|
|                             |        | Min                      | Max | Min            | Max |       |      |
| Write leveling output error | tWLOE  | 0                        | 2   | 0              | 2   | ns    |      |



NOTE 1 DDR4 SDRAM drives leveling feedback on all DQs

NOTE 2 MRS : Load MR1 to enter write leveling mode

NOTE 3 DES : Deselect

NOTE 4 diff\_DQS is the differential data strobe (DQS\_t-DQS\_c). Timing reference points are the zero crossings. DQS\_t is shown with solid line, DQS\_c is shown with dotted line

NOTE 5 CK\_t/CK\_c : CK\_t is shown with solid dark line, where as CK\_c is drawn with dotted line.

NOTE 6 DQS\_t, DQS\_c needs to fulfill minimum pulse width requirements tDQSH(min) and tDQSL(min) as defined for regular Writes; the max pulse width is system dependent

NOTE 7 tMOD(Min) = max(24nCK, 15ns), WL = 9 (CWL = 9, AL = 0, PL = 0), DODTLon = WL -2 = 7

NOTE 8 tWLQSEN must be satisfied following equation when using ODT.

- tWLQSEN > tMOD(Min) + ODTLon + tADC : at DLL = Enable

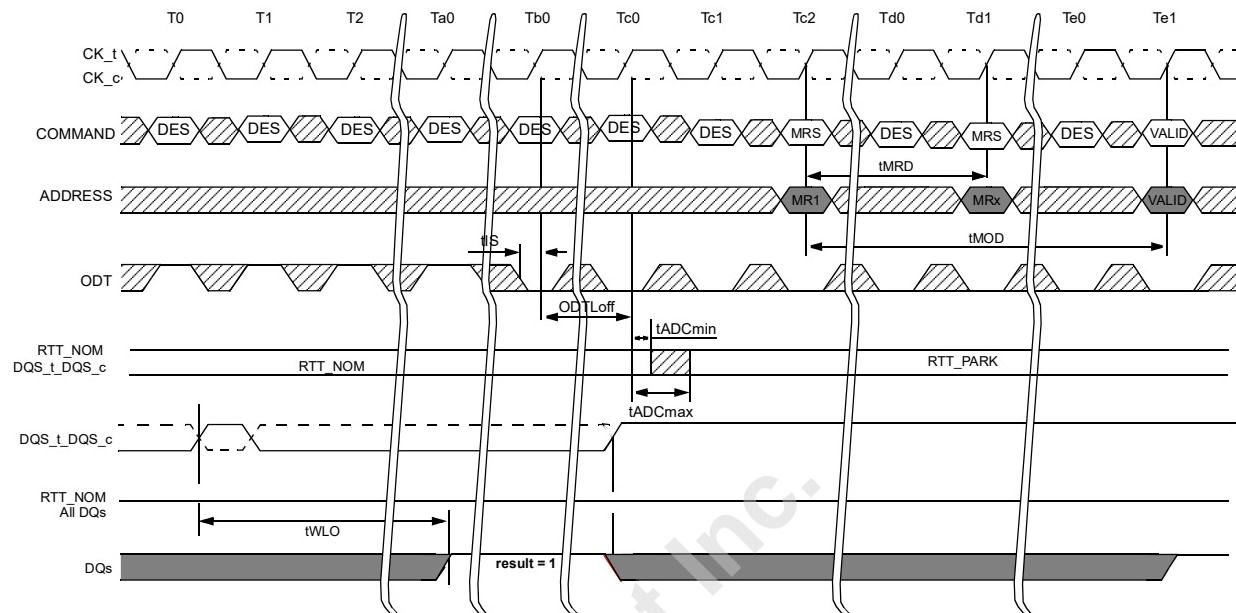
- tWLQSEN > tMOD(Min) + tAONAS : at DLL = Disable

**Figure 16 — Timing details of Write leveling sequence [DQS\_t - DQS\_c is capturing CK\_t - CK\_c low at Ta and CK\_t - CK\_c high at Tb]**

#### 4.7.3 Write Leveling Mode Exit

The following sequence describes how the Write Leveling Mode should be exited:

1. After the last rising strobe edge (see  $\sim T_0$ ), stop driving the strobe signals (see  $\sim T_{c0}$ ). Note: From now on, DQ pins are in undefined driving mode, and will remain undefined, until  $tMOD$  after the respective MRS command ( $T_{e1}$ ).
2. Drive ODT pin low ( $tIS$  must be satisfied) and continue registering low. (see  $T_{b0}$ ).
3. After the RTT is switched off, disable Write Level Mode via MRS command (see  $T_{c2}$ ).
4. After  $tMOD$  is satisfied ( $T_{e1}$ ), any valid command may be registered. (MRS commands may be issued after  $tMRD$  ( $T_{d1}$ ).



**Figure 17 — Timing details of Write leveling exit**

#### 4.8 Temperature Controlled Refresh modes

This mode is, Temperature Controlled Refresh Mode (i.e., TCR), enabled and disabled by setting bit A3 in MR4. Two modes are supported that are selected by bit A2 setting in MR4. Temperature Controlled Refresh Mode operates the same for both Commercial Temperature, "CT", Devices and the optional Industrial Temperature, "IT", Devices.

##### 4.8.1 Normal Temperature Mode (TCASE not exceed 85°C)

Commercial Temperature Device:  $0^{\circ}\text{C} \leq \text{TCASE} \leq 85^{\circ}\text{C}$

Industrial Temperature Device:  $-40^{\circ}\text{C} \leq \text{TCASE} \leq 85^{\circ}\text{C}$

Once this mode, Normal Temperature Mode, is enabled by setting bit A3=1 and A2=0 in MR4, Refresh commands should be issued to DDR4 SDRAM with the Average periodic refresh interval ( 7.8us for 2Gb, 4Gb, 8Gb, and 16Gb device ) which is tREFI of normal temperature range ( $0^{\circ}\text{C}$  to  $85^{\circ}\text{C}$  or  $-40^{\circ}\text{C}$  to  $85^{\circ}\text{C}$ ). In this mode, the system guarantees that the DRAM temperature does not exceed  $85^{\circ}\text{C}$ .

Below  $45^{\circ}\text{C}$ , DDR4 SDRAM may adjust internal Average periodic refresh interval by skipping external refresh commands with proper gear ratio. Not more than three fourths of external refresh commands are skipped at any temperature in this mode. The internal Average periodic refresh interval adjustment is automatically done inside the DRAM and user does not need to provide any additional control.

##### 4.8.2 Extended Temperature Mode (TCASE not exceed 95°C)

Commercial Temperature Device:  $0^{\circ}\text{C} \leq \text{TCASE} \leq 95^{\circ}\text{C}$

Industrial Temperature Device:  $-40^{\circ}\text{C} \leq \text{TCASE} \leq 95^{\circ}\text{C}$

Once this mode, Extended Temperature Mode, is enabled by setting bit A3=1 and A2=1 in MR4, Refresh commands should be issued to DDR4 SDRAM with the Average periodic refresh interval (3.9us for 2Gb, 4Gb, 8Gb, and 16Gb device) which is tREFI of extended temperature range ( $85^{\circ}\text{C}$  to  $95^{\circ}\text{C}$ ). In this mode, the system guarantees that the DRAM temperature does not exceed  $95^{\circ}\text{C}$ .

#### 4.8.2 Extended Temperature Mode (TCASE not exceed 95°C) (cont'd)

In the extended normal temperature range (0°C to 95°C) or extended industrial temperature range (-40°C to 95°C), DDR4 SDRAM adjusts its internal Average periodic refresh interval to tREFI of the normal temperature range by skipping external refresh commands with proper gear ratio. Below 45°C, DDR4 SDRAM may further adjust internal Average periodic refresh interval. Not more than seven eighths of external commands are skipped at any temperature in this mode. The internal Average periodic refresh interval adjustment is automatically done inside the DRAM and user does not need to provide any additional control.

### 4.9 Fine Granularity Refresh Mode

#### 4.9.1 Mode Register and Command Truth Table

The Refresh cycle time (tRFC) and the average Refresh interval (tREFI) of DDR4 SDRAM can be programmed by MRS command. The appropriate setting in the mode register will set a single set of Refresh cycle time and average Refresh interval for the DDR4 SDRAM device (fixed mode), or allow the dynamic selection of one of two sets of Refresh cycle time and average Refresh interval for the DDR4 SDRAM device (on-the-fly mode). The on-the-fly mode must be enabled by MRS as shown in Table 41 before any on-the-fly Refresh command can be issued.

**Table 41 — MR3 definition for Fine Granularity Refresh Mode**

| A8 | A7 | A6 | Fine Granularity Refresh |
|----|----|----|--------------------------|
| 0  | 0  | 0  | Normal mode (Fixed 1x)   |
| 0  | 0  | 1  | Fixed 2x                 |
| 0  | 1  | 0  | Fixed 4x                 |
| 0  | 1  | 1  | Reserved                 |
| 1  | 0  | 0  | Reserved                 |
| 1  | 0  | 1  | Enable on the fly 2x     |
| 1  | 1  | 0  | Enable on the fly 4x     |
| 1  | 1  | 1  | Reserved                 |

There are two types of on-the-fly modes (1x/2x and 1x/4x modes) that are selectable by programming the appropriate values into the mode register. When either of the two on-the-fly modes is selected ('A8=1'), DDR4 SDRAM evaluates BG0 bit when a Refresh command is issued, and depending on the status of BG0, it dynamically switches its internal Refresh configuration between 1x and 2x (or 1x and 4x) modes, and executes the corresponding Refresh operation. The command truth table is as shown in Table 42.

**Table 42 — Refresh command truth table**

| Function                | CS_n | ACT_n | RAS_n /A16 | CAS_n /A15 | WE_n /A14 | BG1 | BG0 | BA0-1 | A10/AP | A0-9, A11-12, A16-20 | MR3 Setting    |
|-------------------------|------|-------|------------|------------|-----------|-----|-----|-------|--------|----------------------|----------------|
| Refresh (Fixed rate)    | L    | H     | L          | L          | H         | V   | V   | V     | V      | V                    | A8 = '0'       |
| Refresh (on-the-fly 1x) | L    | H     | L          | L          | H         | V   | L   | V     | V      | V                    | A8 = '1'       |
| Refresh (on-the-fly 2x) | L    | H     | L          | L          | H         | V   | H   | V     | V      | V                    | A8:A7:A6='101' |
| Refresh (on-the-fly 4x) |      |       |            |            |           |     |     |       |        |                      | A8:A7:A6='110' |

#### 4.9.2 tREFI and tRFC parameters

The default Refresh rate mode is fixed 1x mode where Refresh commands should be issued with the normal rate, i.e., tREFI1 = tREFI(base) (for Tcase<=85°C), and the duration of each refresh command is the normal refresh cycle time (tRFC1). In 2x mode (either fixed 2x or on-the-fly 2x mode), Refresh commands should be issued to the DRAM at the double frequency (tREFI2 = tREFI(base)/2) of the normal Refresh rate. In 4x mode, Refresh command rate should be quadrupled (tREFI4 = tREFI(base)/4). Per each mode and command type, tRFC parameter has different values as defined in Table 43.

The refresh command that should be issued at the normal refresh rate and has the normal refresh cycle duration may be referred to as a REF1x command. The refresh command that should be issued at the double frequency (tREFI2 = tREFI(base)/2) may be referred to as a REF2x command. Finally, the refresh command that should be issued at the quadruple rate (tREFI4 = tREFI(base)/4) may be referred to as a REF4x command.

#### 4.9.2 tREFI and tRFC parameters (cont'd)

In the Fixed 1x Refresh rate mode, only REF1x commands are permitted. In the Fixed 2x Refresh rate mode, only REF2x commands are permitted. In the Fixed 4x Refresh rate mode, only REF4x commands are permitted. When the on-the-fly 1x/2x Refresh rate mode is enabled, both REF1x and REF2x commands are permitted. When the on-the-fly 1x/4x Refresh rate mode is enabled, both REF1x and REF4x commands are permitted.

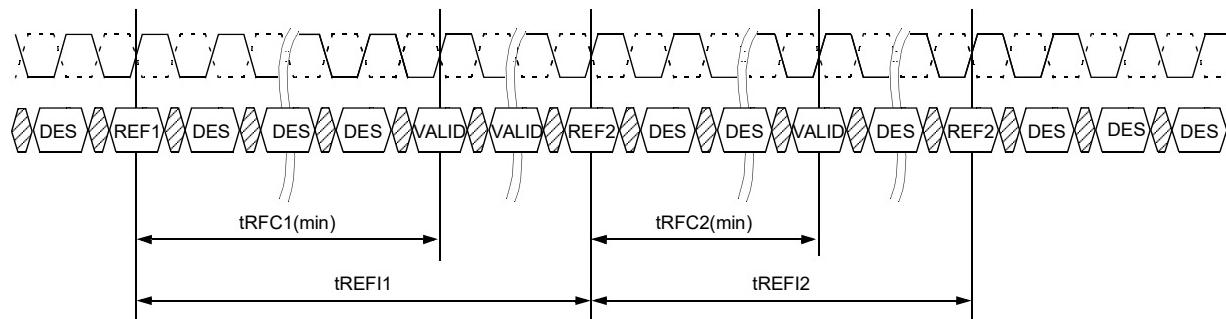
**Table 43 — tREFI and tRFC parameters**

| Refresh Mode | Parameter   |                      | 2Gb           | 4Gb           | 8Gb           | 16Gb   | Unit |
|--------------|-------------|----------------------|---------------|---------------|---------------|--|------|
|              | tREFI(base) |                      | 7.8           | 7.8           | 7.8           | 7.8  | us   |
| 1X mode      | tREFI1      | 0°C <= TCASE <= 85°C | tREFI(base)   | tREFI(base)   | tREFI(base)   | tREFI(base)  | us   |
|              |             | 85°C < TCASE <= 95°C | tREFI(base)/2 | tREFI(base)/2 | tREFI(base)/2 | tREFI(base)/2  | us   |
|              |             | tRFC1(min)           | 160           | 260           | 350           | 550(default)<br>450 (optional-1)<br>350 (optional-2) | ns   |
| 2X mode      | tREFI2      | 0°C <= TCASE <= 85°C | tREFI(base)/2 | tREFI(base)/2 | tREFI(base)/2 | tREFI(base)/2  | us   |
|              |             | 85°C < TCASE <= 95°C | tREFI(base)/4 | tREFI(base)/4 | tREFI(base)/4 | tREFI(base)/4  | us   |
|              |             | tRFC2(min)           | 110           | 160           | 260           | 350(default)<br>350 (optional-1)<br>260 (optional-2) | ns   |
| 4X mode      | tREFI4      | 0°C <= TCASE <= 85°C | tREFI(base)/4 | tREFI(base)/4 | tREFI(base)/4 | tREFI(base)/4  | us   |
|              |             | 85°C < TCASE <= 95°C | tREFI(base)/8 | tREFI(base)/8 | tREFI(base)/8 | tREFI(base)/8  | us   |
|              |             | tRFC4(min)           | 90            | 110           | 160           | 260(default)<br>260 (optional-1)<br>160 (optional-2) | ns   |

NOTE 1 'Optional' settings allow certain devices in the industry to support this setting, however, it is not a mandatory feature. tRFC2 and tRFC4 needs to be set corresponding to each setting's value (default / optional-1 / optional-2) accordingly. Refer to supplier's data sheet and/or the DIMM SPD information if and how this setting is supported.

#### 4.9.3 Changing Refresh Rate

If Refresh rate is changed by either MRS or on the fly, new tREFI and tRFC parameters would be applied from the moment of the rate change. As shown in Figure 18, when REF1x command is issued to the DRAM, then tREF1 and tRFC1 are applied from the time that the command was issued. And then, when REF2x command is issued, then tREF2 and tRFC2 should be satisfied.



**Figure 18 — On-the-fly Refresh Command Timing**

The following conditions must be satisfied before the Refresh rate can be changed. Otherwise, data retention of DDR4 SDRAM cannot be guaranteed.

1. In the fixed 2x Refresh rate mode or the on-the-fly 1x/2x Refresh mode, an even number of REF2x commands must be issued to the DDR4 SDRAM since the last change of the Refresh rate mode with an MRS command before the Refresh rate can be changed by another MRS command.
2. In the on-the-fly 1x/2x Refresh rate mode, an even number of REF2x commands must be issued between any two REF1x commands.

#### 4.9.3 Changing Refresh Rate (cont'd)

3. In the fixed 4x Refresh rate mode or the on-the-fly 1x/4x Refresh mode, a multiple-of-four number of REF4x commands must be issued to the DDR4 SDRAM since the last change of the Refresh rate with an MRS command before the Refresh rate can be changed by another MRS command.
4. In the on-the-fly 1x/4x Refresh rate mode, a multiple-of-four number of REF4x commands must be issued between any two REF1x commands.

There are no special restrictions for the fixed 1x Refresh rate mode. Switching between fixed and on-the-fly modes keeping the same rate is not regarded as a Refresh rate change.

#### 4.9.4 Usage with Temperature Controlled Refresh mode

If the Temperature Controlled Refresh mode is enabled, then only the normal mode (Fixed 1x mode; A8:A7:A6='000') is allowed. If any other Refresh mode than the normal mode is selected, then the temperature controlled Refresh mode must be disabled.

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#### 4.9.5 Self Refresh entry and exit

DDR4 SDRAM can enter Self Refresh mode anytime in 1x, 2x and 4x mode without any restriction on the number of Refresh commands that has been issued during the mode before the Self Refresh entry. However, upon Self Refresh exit, extra Refresh command(s) may be required depending on the condition of the Self Refresh entry. The conditions and requirements for the extra Refresh command(s) are defined as follows

1. There are no special restrictions on the fixed 1x Refresh rate mode.
2. In the fixed 2x Refresh rate mode or the enable-on-the-fly 1x/2x Refresh rate mode, it is recommended that there should be an even number of REF2x commands before entry into Self Refresh since the last Self Refresh exit or REF1x command or MRS command that set the refresh mode. If this condition is met, no additional refresh commands are required upon Self Refresh exit. In the case that this condition is not met, either one extra REF1x command or two extra REF2x commands are required to be issued to the DDR4 SDRAM upon Self Refresh exit. These extra Refresh commands are not counted toward the computation of the average refresh interval (tREFI).
3. In the fixed 4x Refresh rate mode or the enable-on-the-fly 1x/4x Refresh rate mode, it is recommended that there should be a multiple-of-four number of REF4x commands before entry into Self Refresh since the last Self Refresh exit or REF1x command or MRS command that set the refresh mode. If this condition is met, no additional refresh commands are required upon Self Refresh exit. In the case that this condition is not met, either one extra REF1x command or four extra REF4x commands are required to be issued to the DDR4 SDRAM upon Self Refresh exit. These extra Refresh commands are not counted toward the computation of the average refresh interval (tREFI).

#### 4.10 Multi Purpose Register

##### 4.10.1 DQ Training with MPR

The DDR4 DRAM contains four 8bit programmable MPR registers used for DQ bit pattern storage. These registers once programmed are activated with MRS read commands to drive the MPR bits on to the DQ bus during link training.

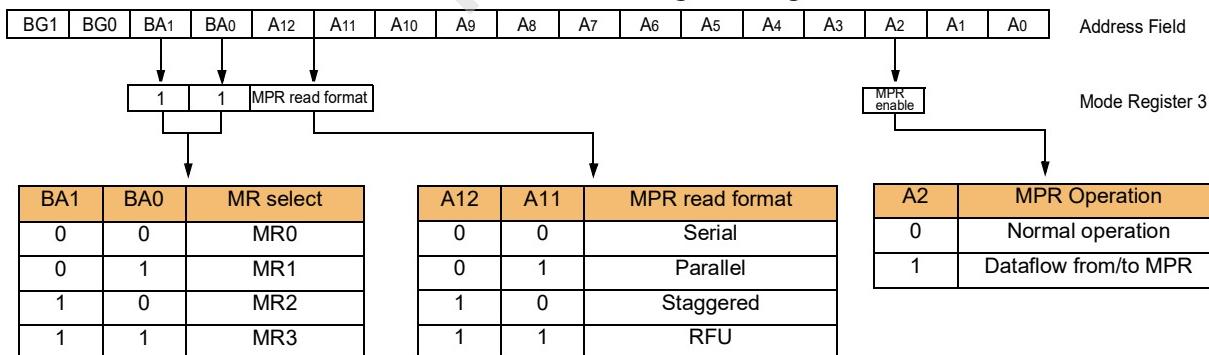
And DDR4 SDRAM only supports following command, MRS, RD, RDA WR, WRA, DES, REF and Reset during MPR enable Mode: MR3 [A2 = 1].

Note that in MPR mode RDA/WRA has the same functionality as a READ/WRITE command which means the auto precharge part of RDA/WRA is ignored. Power-Down mode and Self-Refresh command also is not allowed during MPR enable Mode. No other command can be issued within tRFC after REF command and 1x Refresh is only allowed when MPR mode is Enable. During MPR operations, MPR read or write sequence must be complete prior to a refresh command.

##### 4.10.2 MR3 definition

Mode register MR3 controls the Multi-Purpose Registers (MPR) used for training. MR3 is written by asserting CS\_n, RAS\_n/A16, CAS\_n/A15 and WE\_n/A14 low, ACT\_n, BA0 and BA1 high and BG1<sup>1</sup> and BG0 low while controlling the states of the address pins according to the table below.

**Table 44 — MR3 Programming**



##### Read or Write with MPR LOCATION :

| A1 | A0 | MPR Page Selection |
|----|----|--------------------|
| 0  | 0  | Page 0             |
| 0  | 1  | Page 1             |
| 1  | 0  | Page 2             |
| 1  | 1  | Page 3             |

Default value for MPR0 @ Page0= 01010101  
 Default value for MPR1 @ Page0 = 00110011  
 Default value for MPR2 @ Page0 = 00001111  
 Default value for MPR3 @ Page0 = 00000000

NOTE 1 x4/x8 only

#### 4.10.3 MPR Reads

MPR reads are supported using BL8 and BC4(Fixed) modes. BC4 on the fly is not supported for MPR reads.

In MPR Mode:

Reads (back-to-back) from Page 0 may use tCCD\_S or tCCD\_L timing between read commands; Reads (back-to-back) from Pages 1, 2, or 3 may not use tCCD\_S timing between read commands; tCCD\_L must be used for timing between read commands

MPR reads using BC4:

BA1 and BA0 indicate the MPR location within the selected page in MPR Mode.

A10 and other address pins are don't care including BG1 and BG0.

Read commands for BC4 are supported with starting column address of A2:A0 of '000' and '100'.

Data Bus Inversion (DBI) is not allowed during MPR Read operation. During MPR Read, DRAM ignores Read DBI Enable setting in MR5 bit A12 in MPR mode.

DDR4 MPR mode is enabled by programming bit A2=1 and then reads are done from a specific MPR location.

MPR location is specified with the Read command using Bank address bits BA1 and BA0.

Each MPR location is 8 bit wide.

STEPS:

DLL must be locked prior to MPR Reads. If DLL is Enabled : MR1[A0 = 1]

Precharge all

Wait until tRP is satisfied

MRS MR3, Opcode A2='1'b

- Redirect all subsequent read and writes to MPR locations

Wait until tMRD and tMOD satisfied.

Read command

- A[1:0] = '00'b (data burst order is fixed starting at nibble, always 00b here)

- A[2]= '0'b (For BL=8, burst order is fixed at 0,1,2,3,4,5,6,7)

- (For BC=4, burst order is fixed at 0,1,2,3,T,T,T,T)

or

- A[2]= 1 (For BL=8 : Not Support)

- (For BC=4, burst order is fixed at 4,5,6,7,T,T,T,T)

- A12/BC= 0 or 1 : Burst length supports only BL8 and BC4(Fixed), not supports BC4(OTF).

When MR0 A[1:0] is set "01", A12/BC must be always '1'b in MPR read commands (BL8 only).

- BA1 and BA0 indicate the MPR location

- A10 and other address pins are don't care including BG1and BG0

After RL= AL + CL, DRAM bursts out the data from MPR location. The format of data on return is described in a later section and controlled by MR3 bits A0,A1, A11 and A12.

Memory controller repeats these calibration reads until read data capture at memory controller is optimized. Read MPR location can be a different location as specified by the Read command

After end of last MPR read burst, wait until tMPRR is satisfied

MRS MR3, Opcode A2= '0b'

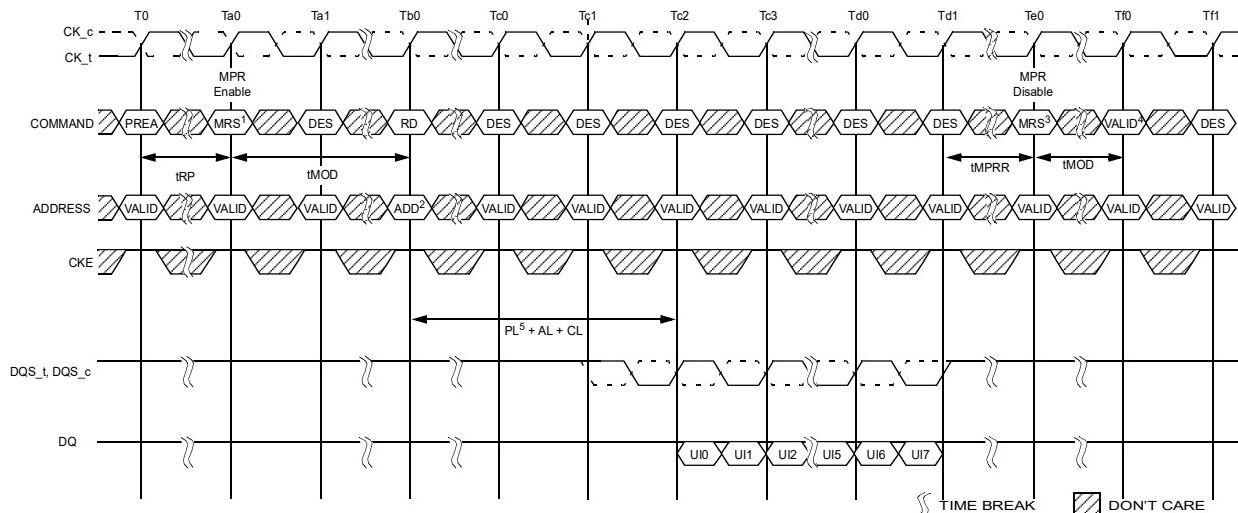
All subsequent reads and writes from DRAM array

Wait until tMRD and tMOD are satisfied

Continue with regular DRAM commands like Activate.

#### 4.10.3 MPR Reads (cont'd)

This process is depicted below(PL=0).



NOTE 1 Multi-Purpose Registers Read/Write Enable (MR3 A2 = 1)

- Redirect all subsequent read and writes to MPR locations

NOTE 2 Address setting

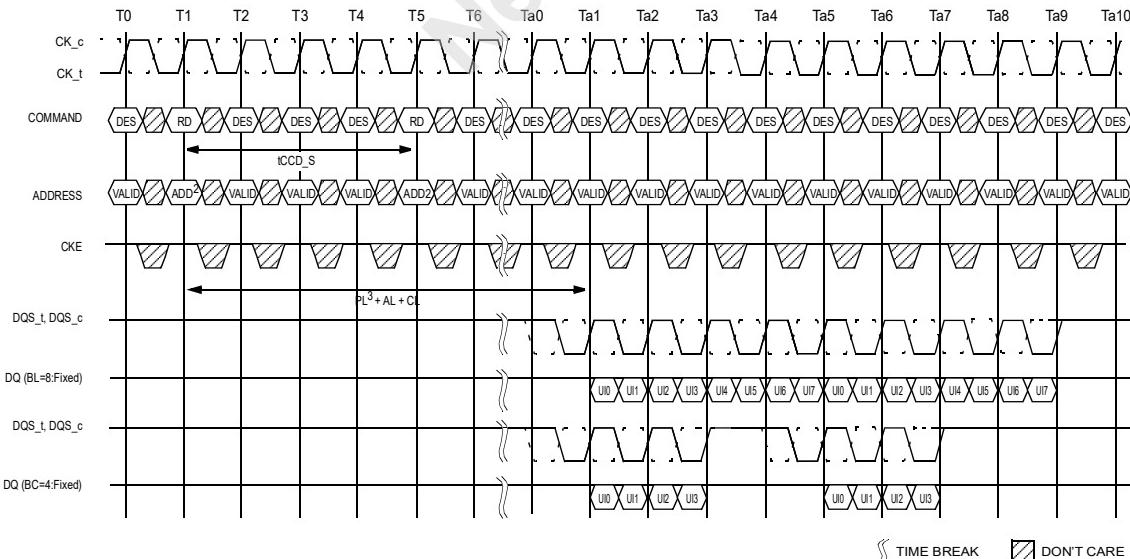
- A[1:0] = "00"b (data burst order is fixed starting at nibble, always 00b here)
- A[2]= "0"b (For BL=8, burst order is fixed at 0,1,2,3,4,5,6,7)
- BA1 and BA0 indicate the MPR location
- A10 and other address pins are don't care including BG1 and BG0. A12 is don't care when MR0 A[1:0] = "00" or "10", and must be '1'b when MR0 A[1:0] = "01"

NOTE 3 Multi-Purpose Registers Read/Write Disable (MR3 A2 = 0)

NOTE 4 Continue with regular DRAM command.

NOTE 5 PL(Parity latency) is added to Data output delay when C/A parity latency mode is enabled.

**Figure 19 — MPR Read Timing**



NOTE 1 tCCD\_S = 4, Read Preamble = 1tCK

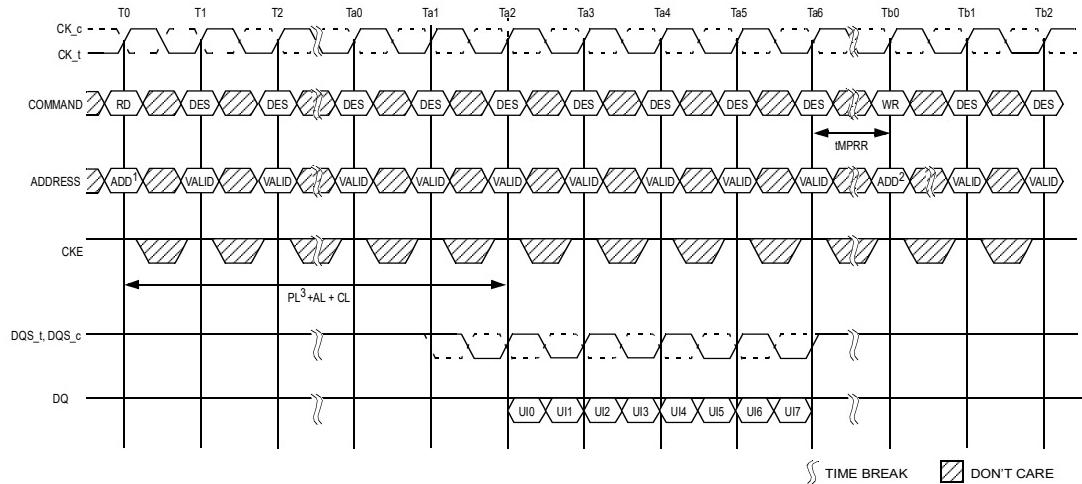
NOTE 2 Address setting

- A[1:0] = "00"b (data burst order is fixed starting at nibble, always 00b here)
- A[2]= "0"b (For BL=8, burst order is fixed at 0,1,2,3,4,5,6,7)
- (For BC=4, burst order is fixed at 0,1,2,3,T,T,T,T)
- BA1 and BA0 indicate the MPR location
- A10 and other address pins are don't care including BG1 and BG0. A12 is don't care when MR0 A[1:0] = "00" or "10", and must be '1'b when MR0 A[1:0] = "01"

NOTE 3 PL(Parity latency) is added to Data output delay when C/A parity latency mode is enabled.

**Figure 20 — MPR Back to Back Read Timing**

#### 4.10.3 MPR Reads (cont'd)



##### NOTE 1 Address setting

- A[1:0] = "00"b (data burst order is fixed starting at nibble, always 00b here)
- A[2]= "0"b (For BL=8, burst order is fixed at 0,1,2,3,4,5,6,7)
- BA1 and BA0 indicate the MPR location
- A10 and other address pins are don't care including BG1 and BG0. A12 is don't care when MR0 A[1:0] = "00", and must be '1'b when MR0 A[1:0] = "01"

##### NOTE 2 Address setting

- BA1 and BA0 indicate the MPR location
- A [7:0] = data for MPR
- A10 and other address pins are don't care.

NOTE 3 PL (Parity latency) is added to Data output delay when C/A parity latency mode is enabled.

**Figure 21 — MPR Read to Write Timing**

#### 4.10.4 MPR Writes

DDR4 allows 8 bit writes to the MPR location using the address bus A7:A0.

**Table 45 — UI and Address Mapping for MPR Location**

| MPR Location  | [7] | [6] | [5] | [4] | [3] | [2] | [1] | [0] |
|---------------|-----|-----|-----|-----|-----|-----|-----|-----|
| SDRAM Address | A7  | A6  | A5  | A4  | A3  | A2  | A1  | A0  |
| UI            | UI0 | UI1 | UI2 | UI3 | UI4 | UI5 | UI6 | UI7 |

##### STEPS:

DLL must be locked prior to MPR Writes. If DLL is Enabled : MR1[A0 = 1]

Precharge all

Wait until tRP is satisfied

MRS MR3, Opcode A2='1'b

Redirect all subsequent read and writes to MPR locations

Wait until tMRD and tMOD satisfied.

Write command

BA1 and BA0 indicate the MPR location

A [7:0] = data for MPR

Wait until tWR\_MPR satisfied, so that DRAM to complete MPR write transaction.

Memory controller repeats these calibration writes and reads until data capture at memory controller is optimized.

After end of last MPR read burst, wait until tMPRR is satisfied

MRS MR3, Opcode A2= '0'b'

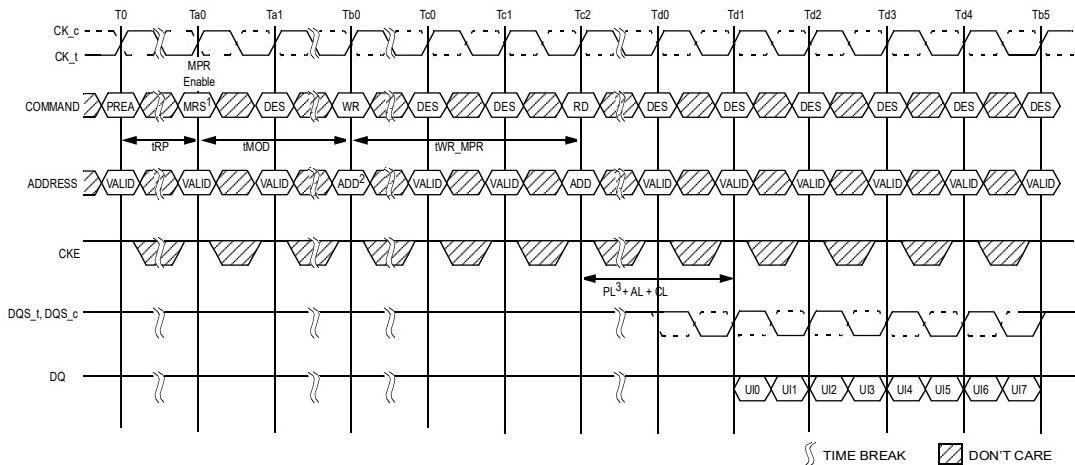
All subsequent reads and writes from DRAM array

Wait until tMRD and tMOD are satisfied

Continue with regular DRAM commands like Activate.

This process is depicted in Figure 22.

#### 4.10.4 MPR Writes (cont'd)



NOTE 1 Multi-Purpose Registers Read/Write Enable (MR3 A2 = 1)

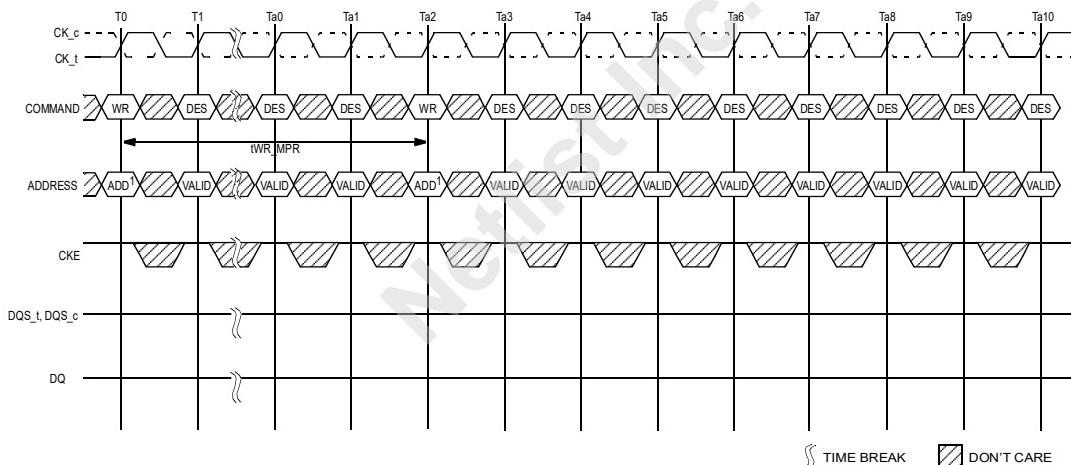
NOTE 2 Address setting - BA1 and BA0 indicate the MPR location

- A [7:0] = data for MPR

- A10 and other address pins are don't care.

NOTE 3 PL (Parity latency) is added to Data output delay when C/A parity latency mode is enabled.

**Figure 22 — MPR Write Timing and Write to Read Timing**



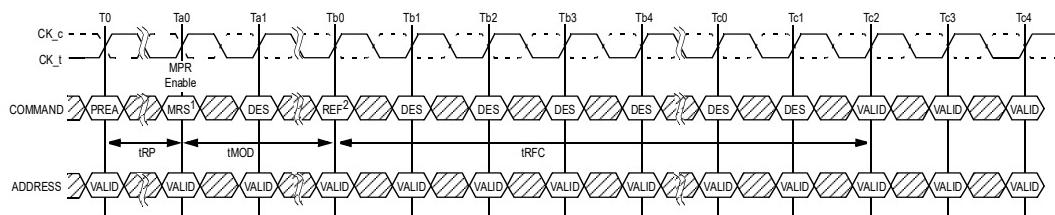
NOTE 1 Address setting

- BA1 and BA0 indicate the MPR location

- A [7:0] = data for MPR

- A10 and other address pins are don't care.

**Figure 23 — MPR Back to Back Write Timing**



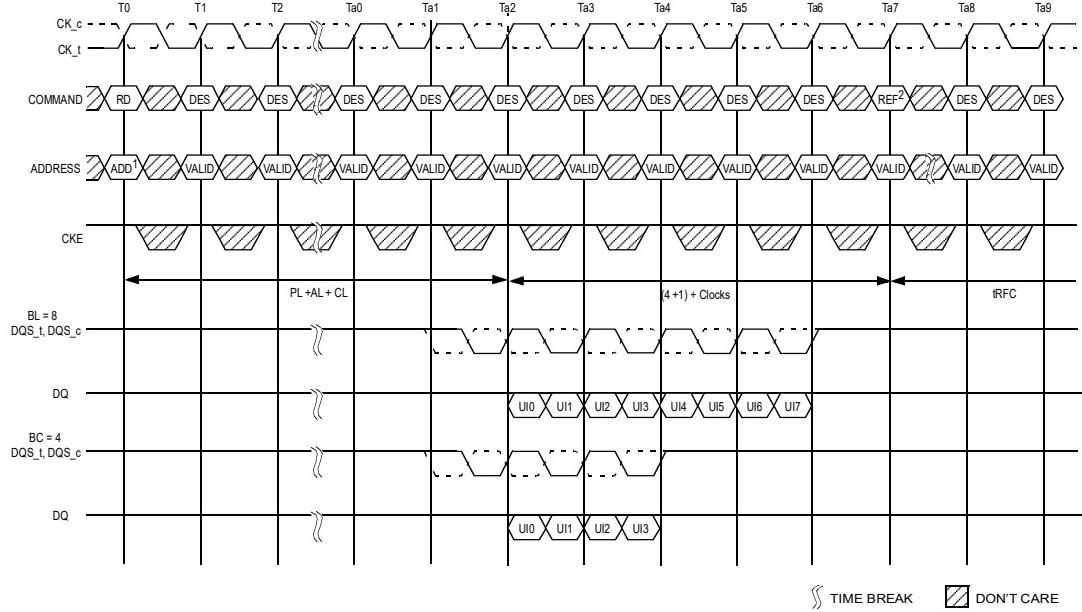
NOTE 1 Multi-Purpose Registers Read/Write Enable (MR3 A2 = 1)

- Redirect all subsequent read and writes to MPR locations

NOTE 2 1x Refresh is only allowed when MPR mode is Enable.

**Figure 24 — Refresh Command Timing**

#### 4.10.4 MPR Writes (cont'd)

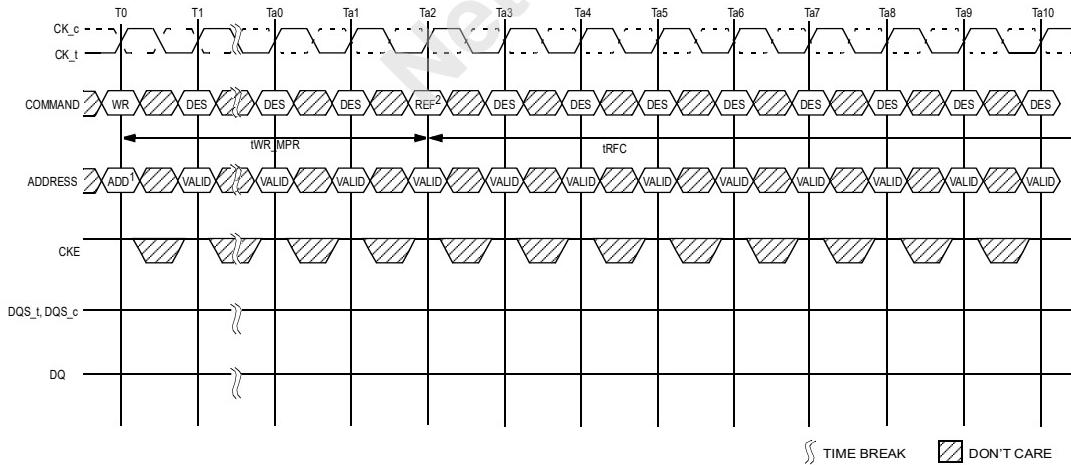


NOTE 1 Address setting

- A[1:0] = "00"b (data burst order is fixed starting at nibble, always 00b here)
- A[2]= "0"b (For BL=8, burst order is fixed at 0,1,2,3,4,5,6,7)
- BA1 and BA0 indicate the MPR location
- A10 and other address pins are don't care including BG1 and BG0. A12 is don't care when MR0 A[1:0] = "00" or "10", and must be '1'b when MR0 A[1:0] = "01"

NOTE 2 1x Refresh is only allowed when MPR mode is Enable.

**Figure 25 — Read to Refresh Command Timing**



NOTE 1 Address setting - BA1 and BA0 indicate the MPR location - A [7:0] = data for MPR

- A10 and other address pins are don't care.

NOTE 2 1x Refresh is only allowed when MPR mode is Enable.

**Figure 26 — Write to Refresh Command Timing**

#### 4.10.5 MPR Read Data format

Mode bits in MR3: (A12, A11) are used to select the data return format for MPR reads. The DRAM is required to drive associated strobes with the read data returned for all read data formats.

Serial return implies that the same pattern is returned on all DQ lanes as shown in figure below. Data from the MPR is used on all DQ lanes for the serial return case. Reads from MPR page0, MPR page1, MPR page2, and MPR page3 are allowed with serial data return mode.

In this example the pattern programmed in the MPR register is 0111 1111 in MPR Location [7:0].

**Table 46 — x4 Device**

| Serial | UI0 | UI1 | UI2 | UI3 | UI4 | UI5 | UI6 | UI7 |
|--------|-----|-----|-----|-----|-----|-----|-----|-----|
| DQ0    | 0   | 1   | 1   | 1   | 1   | 1   | 1   | 1   |
| DQ1    | 0   | 1   | 1   | 1   | 1   | 1   | 1   | 1   |
| DQ2    | 0   | 1   | 1   | 1   | 1   | 1   | 1   | 1   |
| DQ3    | 0   | 1   | 1   | 1   | 1   | 1   | 1   | 1   |

**Table 47 — x8 Device**

| Serial | UI0 | UI1 | UI2 | UI3 | UI4 | UI5 | UI6 | UI7 |
|--------|-----|-----|-----|-----|-----|-----|-----|-----|
| DQ0    | 0   | 1   | 1   | 1   | 1   | 1   | 1   | 1   |
| DQ1    | 0   | 1   | 1   | 1   | 1   | 1   | 1   | 1   |
| DQ2    | 0   | 1   | 1   | 1   | 1   | 1   | 1   | 1   |
| DQ3    | 0   | 1   | 1   | 1   | 1   | 1   | 1   | 1   |
| DQ4    | 0   | 1   | 1   | 1   | 1   | 1   | 1   | 1   |
| DQ5    | 0   | 1   | 1   | 1   | 1   | 1   | 1   | 1   |
| DQ6    | 0   | 1   | 1   | 1   | 1   | 1   | 1   | 1   |
| DQ7    | 0   | 1   | 1   | 1   | 1   | 1   | 1   | 1   |

**Table 48 — x16 Device**

| Serial | UI0 | UI1 | UI2 | UI3 | UI4 | UI5 | UI6 | UI7 |
|--------|-----|-----|-----|-----|-----|-----|-----|-----|
| DQ0    | 0   | 1   | 1   | 1   | 1   | 1   | 1   | 1   |
| DQ1    | 0   | 1   | 1   | 1   | 1   | 1   | 1   | 1   |
| DQ2    | 0   | 1   | 1   | 1   | 1   | 1   | 1   | 1   |
| DQ3    | 0   | 1   | 1   | 1   | 1   | 1   | 1   | 1   |
| DQ4    | 0   | 1   | 1   | 1   | 1   | 1   | 1   | 1   |
| DQ5    | 0   | 1   | 1   | 1   | 1   | 1   | 1   | 1   |
| DQ6    | 0   | 1   | 1   | 1   | 1   | 1   | 1   | 1   |
| DQ7    | 0   | 1   | 1   | 1   | 1   | 1   | 1   | 1   |
| DQ8    | 0   | 1   | 1   | 1   | 1   | 1   | 1   | 1   |
| DQ9    | 0   | 1   | 1   | 1   | 1   | 1   | 1   | 1   |
| DQ10   | 0   | 1   | 1   | 1   | 1   | 1   | 1   | 1   |
| DQ11   | 0   | 1   | 1   | 1   | 1   | 1   | 1   | 1   |
| DQ12   | 0   | 1   | 1   | 1   | 1   | 1   | 1   | 1   |
| DQ13   | 0   | 1   | 1   | 1   | 1   | 1   | 1   | 1   |
| DQ14   | 0   | 1   | 1   | 1   | 1   | 1   | 1   | 1   |
| DQ15   | 0   | 1   | 1   | 1   | 1   | 1   | 1   | 1   |

Parallel return implies that the MPR data is returned in the first UI and then repeated in the remaining UI's of the burst as shown in the figure below. Data from Page0 MPR registers can be used for the parallel return case as well. Read from MPR page1, MPR page2 and MPR page3 are not allowed with parallel data return mode. In this example the pattern programmed in the Page 0 MPR register is 0111 1111:MPR Location [7:0]. For the case of x4, only the first four bits are used (0111:MPR Location [7:4] in this example). For the case of x16, the same pattern is repeated on upper and lower bytes.

4.10.5 MPR Read Data format (cont'd)

**Table 49 — x4 Device**

| Parallel | UI0 | UI1 | UI2 | UI3 | UI4 | UI5 | UI6 | UI7 |
|----------|-----|-----|-----|-----|-----|-----|-----|-----|
| DQ0      | 0   | 0   | 0   | 0   | 0   | 0   | 0   | 0   |
| DQ1      | 1   | 1   | 1   | 1   | 1   | 1   | 1   | 1   |
| DQ2      | 1   | 1   | 1   | 1   | 1   | 1   | 1   | 1   |
| DQ3      | 1   | 1   | 1   | 1   | 1   | 1   | 1   | 1   |

**Table 50 — x8 Device**

| Parallel | UI0 | UI1 | UI2 | UI3 | UI4 | UI5 | UI6 | UI7 |
|----------|-----|-----|-----|-----|-----|-----|-----|-----|
| DQ0      | 0   | 0   | 0   | 0   | 0   | 0   | 0   | 0   |
| DQ1      | 1   | 1   | 1   | 1   | 1   | 1   | 1   | 1   |
| DQ2      | 1   | 1   | 1   | 1   | 1   | 1   | 1   | 1   |
| DQ3      | 1   | 1   | 1   | 1   | 1   | 1   | 1   | 1   |
| DQ4      | 1   | 1   | 1   | 1   | 1   | 1   | 1   | 1   |
| DQ5      | 1   | 1   | 1   | 1   | 1   | 1   | 1   | 1   |
| DQ6      | 1   | 1   | 1   | 1   | 1   | 1   | 1   | 1   |
| DQ7      | 1   | 1   | 1   | 1   | 1   | 1   | 1   | 1   |

**Table 51 — x16 Device**

| Parallel | UI0 | UI1 | UI2 | UI3 | UI4 | UI5 | UI6 | UI7 |
|----------|-----|-----|-----|-----|-----|-----|-----|-----|
| DQ0      | 0   | 0   | 0   | 0   | 0   | 0   | 0   | 0   |
| DQ1      | 1   | 1   | 1   | 1   | 1   | 1   | 1   | 1   |
| DQ2      | 1   | 1   | 1   | 1   | 1   | 1   | 1   | 1   |
| DQ3      | 1   | 1   | 1   | 1   | 1   | 1   | 1   | 1   |
| DQ4      | 1   | 1   | 1   | 1   | 1   | 1   | 1   | 1   |
| DQ5      | 1   | 1   | 1   | 1   | 1   | 1   | 1   | 1   |
| DQ6      | 1   | 1   | 1   | 1   | 1   | 1   | 1   | 1   |
| DQ7      | 1   | 1   | 1   | 1   | 1   | 1   | 1   | 1   |
| DQ8      | 0   | 0   | 0   | 0   | 0   | 0   | 0   | 0   |
| DQ9      | 1   | 1   | 1   | 1   | 1   | 1   | 1   | 1   |
| DQ10     | 1   | 1   | 1   | 1   | 1   | 1   | 1   | 1   |
| DQ11     | 1   | 1   | 1   | 1   | 1   | 1   | 1   | 1   |
| DQ12     | 1   | 1   | 1   | 1   | 1   | 1   | 1   | 1   |
| DQ13     | 1   | 1   | 1   | 1   | 1   | 1   | 1   | 1   |
| DQ14     | 1   | 1   | 1   | 1   | 1   | 1   | 1   | 1   |
| DQ15     | 1   | 1   | 1   | 1   | 1   | 1   | 1   | 1   |

The third mode of data return is the staggering of the MPR data across the lanes. In this mode a read command is issued to a specific MPR and then the data is returned on the DQ from different MPR registers. Read from MPR page1, MPR page2, and MPR page3 are not allowed with staggered data return mode.

#### 4.10.5 MPR Read Data format (cont'd)

For a x4 device, a read to MPR0 will result in data from MPR0 being driven on DQ0, data from MPR1 on DQ1 and so forth as shown below.

A read command to MPR1 will result in data from MPR1 being driven on DQ0, data from MPR2 on DQ1 and so forth as shown below. Reads from MPR2 and MPR3 are also shown below.

**Table 52 — Read Commands For a x4 device**

x4 (Read MPR0 command)

| Stagger | UI0-7 |
|---------|-------|
| DQ0     | MPR0  |
| DQ1     | MPR1  |
| DQ2     | MPR2  |
| DQ3     | MPR3  |

x4 (Read MPR1 command)

| Stagger | UI0-7 |
|---------|-------|
| DQ0     | MPR1  |
| DQ1     | MPR2  |
| DQ2     | MPR3  |
| DQ3     | MPR0  |

x4 (Read MPR2 command)

| Stagger | UI0-7 |
|---------|-------|
| DQ0     | MPR2  |
| DQ1     | MPR3  |
| DQ2     | MPR0  |
| DQ3     | MPR1  |

x4 (Read MPR3 command)

| Stagger | UI0-7 |
|---------|-------|
| DQ0     | MPR3  |
| DQ1     | MPR0  |
| DQ2     | MPR1  |
| DQ3     | MPR2  |

It is expected that the DRAM can respond to back to back read commands to MPR for all DDR4 frequencies so that a stream as follows can be created on the data bus with no bubbles or clocks between read data. In this case controller issues a sequence of RD MPR0, RD MPR1, RD MPR2, RD MPR3, RD MPR0, RD MPR1, RD MPR2 and RD MPR3.

**Table 53 — x4 (Back to Back read commands)**

| Stagger | UI 0-7 | UI 8-15 | UI 16-23 | UI 24-31 | UI 32-39 | UI 40-47 | UI 48-55 | UI 56-63 |
|---------|--------|---------|----------|----------|----------|----------|----------|----------|
| DQ0     | MPR0   | MPR1    | MPR2     | MPR3     | MPR0     | MPR1     | MPR2     | MPR3     |
| DQ1     | MPR1   | MPR2    | MPR3     | MPR0     | MPR1     | MPR2     | MPR3     | MPR0     |
| DQ2     | MPR2   | MPR3    | MPR0     | MPR1     | MPR2     | MPR3     | MPR0     | MPR1     |
| DQ3     | MPR3   | MPR0    | MPR1     | MPR2     | MPR3     | MPR0     | MPR1     | MPR2     |

#### 4.10.5 MPR Read Data format (cont'd)

The following figure shows a read command to MPR0 for a x8 device. The same pattern is repeated on the lower nibble as on the upper nibble. Reads to other MPR location follows the same format as for x4 case.

A read example to MPR0 for x8 and x16 device is shown below.

**Table 54 — Read Commands For x8 and x16 devices**

x8 (Read MPR0 command)

| Stagger | UI0-7 |
|---------|-------|
| DQ0     | MPR0  |
| DQ1     | MPR1  |
| DQ2     | MPR2  |
| DQ3     | MPR3  |
| DQ4     | MPR0  |
| DQ5     | MPR1  |
| DQ6     | MPR2  |
| DQ7     | MPR3  |

x16 (Read MPR0 command)

| Stagger | UI0-7 |
|---------|-------|
| DQ0     | MPR0  |
| DQ1     | MPR1  |
| DQ2     | MPR2  |
| DQ3     | MPR3  |
| DQ4     | MPR0  |
| DQ5     | MPR1  |
| DQ6     | MPR2  |
| DQ7     | MPR3  |
| DQ8     | MPR0  |
| DQ9     | MPR1  |
| DQ10    | MPR2  |
| DQ11    | MPR3  |
| DQ12    | MPR0  |
| DQ13    | MPR1  |
| DQ14    | MPR2  |
| DQ15    | MPR3  |

DDR4 MPR mode enable and page selection is done by Mode Register command as shown below.

**Table 55 — MPR MR3 Register Definition**

| Address | Operating Mode  | Description   |
|---------|-----------------|---|
| A2      | MPR operation   | 0 = Normal<br>1 = Dataflow from/to MPR                          |
| A1:A0   | MPR selection   | 00 = page0<br>01 = page1<br>10 = page2<br>11 = page3            |
| A12:A11 | MPR Read Format | 00 = Serial<br>01 = Parallel<br>10 = Staggered<br>11 = Reserved |

Four MPR pages are provided in DDR4 SDRAM. Page 0 is for both read and write, and pages 1,2 and 3 are read-only. Any MPR location (MPR0-3) in page 0 can be readable through any of three readout modes (serial, parallel or staggered), but pages 1, 2 and 3 support only the serial readout mode.

#### 4.10.5 MPR Read Data format (cont'd)

After power up, the content of MPR page 0 should have the default value as defined in the table. MPR page 0 can be writable only when MPR write command is issued by controller. Unless MPR write command is issued, DRAM must keep the default value permanently, and should never change the content on its own for any purpose. When MPR write command is issued to any of read-only pages (page 1, 2 or 3), the command is ignored by DRAM.

**Table 56 — MPR data format**

MPR page0 (Training pattern)

| Address | MPR Location | [7] | [6] | [5] | [4] | [3] | [2] | [1] | [0] | note                          |
|---------|--------------|-----|-----|-----|-----|-----|-----|-----|-----|-------------------------------|
| BA1:BA0 | 00 = MPR0    | 0   | 1   | 0   | 1   | 0   | 1   | 0   | 1   | Read/Write<br>(default value) |
|         | 01 = MPR1    | 0   | 0   | 1   | 1   | 0   | 0   | 1   | 1   |                               |
|         | 10 = MPR2    | 0   | 0   | 0   | 0   | 1   | 1   | 1   | 1   |                               |
|         | 11 = MPR3    | 0   | 0   | 0   | 0   | 0   | 0   | 0   | 0   |                               |

NOTE 1 MPRx using A7:A0 that A7 is mapped to location [7] and A0 is mapped to location [0].

MPR page1 (CA parity error log)

| Address | MPR Location | [7]                    | [6]                            | [5]                            | [4]      | [3]      | [2]   | [1]   | [0]           | note      |
|---------|--------------|------------------------|--------------------------------|--------------------------------|----------|----------|-------|-------|---------------|-----------|
| BA1:BA0 | 00 = MPR0    | A[7]                   | A[6]                           | A[5]                           | A[4]     | A[3]     | A[2]  | A[1]  | A[0]          | Read-only |
|         | 01 = MPR1    | CAS_n/<br>A15          | WE_n/<br>A14                   | A[13]                          | A[12]    | A[11]    | A[10] | A[9]  | A[8]          |           |
|         | 10 = MPR2    | PAR                    | ACT_n                          | BG[1]                          | BG[0]    | BA[1]    | BA[0] | A[17] | RAS_n/<br>A16 |           |
|         | 11 = MPR3    | CRC<br>Error<br>Status | CA Par-<br>ity Error<br>Status | CA Parity Latency <sup>4</sup> |          |          |       | C[2]  | C[1]          | C[0]      |
|         |              |                        |                                | MR5.A[2]                       | MR5.A[1] | MR5.A[0] |       |       |               |           |

NOTE 1 MPR used for C/A parity error log readout is enabled by setting A[2] in MR3

NOTE 2 For higher density of DRAM, where A[17] is not used, MPR2[1] should be treated as don't care.

NOTE 3 If a device is used in monolithic application, where C[2:0] are not used, then MPR3[2:0] should be treated as don't care.

MPR page2 (MRS Readout)

| Address | MPR Location | [7]                      | [6]                    | [5]    | [4]                            | [3] | [2]                    | [1]              | [0]                    | note      |  |
|---------|--------------|--------------------------|------------------------|--------|--------------------------------|-----|------------------------|------------------|------------------------|-----------|--|
| BA1:BA0 | 00 = MPR0    | hPPR                     | sPPR                   | RTT_WR | Temperature Sen-<br>sor Status |     | CRC<br>Write<br>Enable | Rtt_WR           |                        | read-only |  |
|         |              | -                        | -                      | MR2    | -                              | -   | MR2                    | MR2              |                        |           |  |
|         |              | -                        | -                      | A11    | -                              | -   | A12                    | A10              | A9                     |           |  |
|         | 01= MPR1     | Vref DQ<br>Trng<br>range | Vref DQ training Value |        |                                |     |                        |                  | Geardo<br>wn<br>Enable |           |  |
|         |              | MR6                      | MR6                    |        |                                |     |                        |                  | MR3                    |           |  |
|         |              | A6                       | A5                     | A4     | A3                             | A2  | A1                     | A0               | A3                     |           |  |
|         | 10 = MPR2    | CAS Latency              |                        |        |                                | RFU | CAS Write Latency      |                  |                        |           |  |
|         |              | MR0                      |                        |        |                                | -   | MR2                    |                  |                        |           |  |
|         |              | A6                       | A5                     | A4     | A2                             | -   | A5                     | A4               | A3                     |           |  |
|         | 11 = MPR3    | Rtt_Nom                  |                        |        | Rtt_Park                       |     |                        | Driver Impedance |                        |           |  |
|         |              | MR1                      |                        |        | MR5                            |     |                        | MR1              |                        |           |  |
|         |              | A10                      | A9                     | A6     | A8                             | A7  | A6                     | A2               | A1                     |           |  |

**Table 56 — MPR data format (cont'd)**

MPR page3 ( MPR0 through MPR2 in MPR page3 are for Vendor use only)

| Address | MPR Location | [7]        | [6]        | [5]        | [4]        | [3]        | [2]        | [1]        | [0]        | note      |
|---------|--------------|------------|------------|------------|------------|------------|------------|------------|------------|-----------|
| BA1:BA0 | 00 = MPR0    | don't care | read-only |
|         | 01= MPR1     | don't care |           |
|         | 10 = MPR2    | don't care |           |
|         | 11 = MPR3    | don't care | don't care | don't care | don't care | MAC        | MAC        | MAC        | MAC        |           |

**Table 57 — DDR4 MPR Page3 MAC Decode Value**

| MPR Location | A7:A4 | A2 | A1 | A0 | Note |
|--------------|-------|----|----|----|------|
| Reserved     | X     | 1  | 1  | 1  | 2    |
| Reserved     | X     | 1  | 1  | 0  | 2    |
| MAC>300K     | X     | 1  | 0  | 1  |      |
| MAC>400K     | X     | 1  | 0  | 0  |      |
| MAC>500K     | X     | 0  | 1  | 1  |      |
| MAC>600K     | X     | 0  | 1  | 0  |      |
| MAC>700K     | X     | 0  | 0  | 1  |      |
| Unknown      | X     | 0  | 0  | 0  | 1    |

NOTE 1 Unknown means that device is not tested for MAC and pass/fail value is unknown

NOTE2 Reserved for future device.

**Table 58 — Unlimited MAC**

|               | A3 | Note |
|---------------|----|------|
| Unlimited MAC | 1  | 1,2  |

NOTE 1 Unlimited MAC means that there is no restriction to the number of Activates in a refresh period provided DDR4 specifications are not violated, in particular tRCmin and refresh requirements

NOTE2 All other bits A2:A0 are set to zero

#### 4.11 Data Mask(DM), Data Bus Inversion (DBI) and TDQS

DDR4 SDRAM supports Data Mask (DM) function and Data Bus Inversion (DBI) function in x8 and x16 DRAM configuration. x4 DDR4 SDRAM does not support DM and DBI function. x8 DDR4 SDRAM supports TDQS function. x4 and x16 DDR4 SDRAM does not support TDQS function.

DM, DBI & TDQS functions are supported with dedicated one pin labeled as DM\_n/DBI\_n/TDQS\_t. The pin is bi-directional pin for DRAM. The DM\_n/DBI \_n pin is Active Low as DDR4 supports VDDQ reference termination. TDQS function does not drive actual level on the pin.

DM, DBI & TDQS functions are programmable through DRAM Mode Register (MR). The MR bit location is bit A11 in MR1 and bit A12:A10 in MR5 .

Write operation: Either DM or DBI function can be enabled but both functions cannot be enabled simultaneously. When both DM and DBI functions are disabled, DRAM turns off its input receiver and does not expect any valid logic level.

Read operation: Only DBI function applies. When DBI function is disabled, DRAM turns off its output driver and does not drive any valid logic level.

TDQS function: When TDQS function is enabled, DM & DBI functions are not supported. When TDQS function is disabled, DM and DBI functions are supported as described below in Table 59. When enabled, the same termination resistance function is applied to the TDQS\_t/TDQS\_c pins that is applied to DQS\_t/DQS\_c pins.

4.11 Data Mask(DM), Data Bus Inversion (DBI) and TDQS (cont'd)

**Table 59 — TDQS Function Matrix**

| MR1 bit A11       | DM (MR5 bit A10) | Write DBI (MR5 bit A11) | Read DBI (MR5 bit A12) |
|-------------------|------------------|-------------------------|------------------------|
| 0 (TDQS Disabled) | Enabled          | Disabled                | Enabled or Disabled    |
|                   | Disabled         | Enabled                 | Enabled or Disabled    |
|                   | Disabled         | Disabled                | Enabled or Disabled    |
| 1 (TDQS Enabled)  | Disabled         | Disabled                | Disabled               |

**Table 60 — DRAM Mode Register MR5**

| A10 | DM Enable |
|-----|-----------|
| 0   | Disabled  |
| 1   | Enabled   |

**Table 61 — DRAM Mode Register MR5**

| A11 | Write DBI Enable | A12 | Read DBI Enable |
|-----|------------------|-----|-----------------|
| 0   | Disabled         | 0   | Disabled        |
| 1   | Enabled          | 1   | Enabled         |

**Table 62 — DRAM Mode Register MR1**

| A11 | TDQS Enable |
|-----|-------------|
| 0   | Disabled    |
| 1   | Enabled     |

DM function during Write operation: DRAM masks the write data received on the DQ inputs if DM\_n was sampled Low on a given byte lane. If DM\_n was sampled High on a given byte lane, DRAM does not mask the write data and writes into the DRAM core.

DBI function during Write operation: DRAM inverts write data received on the DQ inputs if DBI\_n was sampled Low on a given byte lane. If DBI\_n was sampled High on a given byte lane, DRAM leaves the data received on the DQ inputs non-inverted.

DBI function during Read operation: DRAM inverts read data on its DQ outputs and drives DBI\_n pin Low when the number of '0' data bits within a given byte lane is greater than 4; otherwise DRAM does not invert the read data and drives DBI\_n pin High.

**Table 63 — x8 DRAM Write DQ Frame Format**

|               | Data transfer |             |             |             |             |             |             |             |
|---------------|---------------|-------------|-------------|-------------|-------------|-------------|-------------|-------------|
|               | 0             | 1           | 2           | 3           | 4           | 5           | 6           | 7           |
| DQ[7:0]       | Byte 0        | Byte 1      | Byte 2      | Byte 3      | Byte 4      | Byte 5      | Byte 6      | Byte 7      |
| DM_n or DBI_n | DM0 or DBI0   | DM1 or DBI1 | DM2 or DBI2 | DM3 or DBI3 | DM4 or DBI4 | DM5 or DBI5 | DM6 or DBI6 | DM7 or DBI7 |

**Table 64 — x8 DRAM Read DQ Frame Format**

|         | Data transfer |        |        |        |        |        |        |        |
|---------|---------------|--------|--------|--------|--------|--------|--------|--------|
|         | 0             | 1      | 2      | 3      | 4      | 5      | 6      | 7      |
| DQ[7:0] | Byte 0        | Byte 1 | Byte 2 | Byte 3 | Byte 4 | Byte 5 | Byte 6 | Byte 7 |
| DBI_n   | DBI0          | DBI1   | DBI2   | DBI3   | DBI4   | DBI5   | DBI6   | DBI7   |

**Table 65 — x16 DRAM Write DQ Frame Format**

|                 | Data transfer |               |               |               |               |               |               |               |
|-----------------|---------------|---------------|---------------|---------------|---------------|---------------|---------------|---------------|
|                 | 0             | 1             | 2             | 3             | 4             | 5             | 6             | 7             |
| DQL[7:0]        | LByte 0       | LByte 1       | LByte 2       | LByte 3       | LByte 4       | LByte 5       | LByte 6       | LByte 7       |
| DML_n or DBIL_n | DML0 or DBIL0 | DML1 or DBIL1 | DML2 or DBIL2 | DML3 or DBIL3 | DML4 or DBIL4 | DML5 or DBIL5 | DML6 or DBIL6 | DML7 or DBIL7 |
| DQU[7:0]        | UByte 0       | UByte 1       | UByte 2       | UByte 3       | UByte 4       | UByte 5       | UByte 6       | UByte 7       |
| DMU_n or DBIU_n | DMU0 or DBIU0 | DMU1 or DBIU1 | DMU2 or DBIU2 | DMU3 or DBIU3 | DMU4 or DBIU4 | DMU5 or DBIU5 | DMU6 or DBIU6 | DMU7 or DBIU7 |

#### 4.11 Data Mask(DM), Data Bus Inversion (DBI) and TDQS (cont'd)

**Table 66 — x16 DRAM Read DQ Frame Format**

|          | Data transfer |         |         |         |         |         |         |         |
|----------|---------------|---------|---------|---------|---------|---------|---------|---------|
|          | 0             | 1       | 2       | 3       | 4       | 5       | 6       | 7       |
| DQL[7:0] | LByte 0       | LByte 1 | LByte 2 | LByte 3 | LByte 4 | LByte 5 | LByte 6 | LByte 7 |
| DBIL_n   | DBIL0         | DBIL1   | DBIL2   | DBIL3   | DBIL4   | DBIL5   | DBIL6   | DBIL7   |
| DQU[7:0] | UByte 0       | UByte 1 | UByte 2 | UByte 3 | UByte 4 | UByte 5 | UByte 6 | UByte 7 |
| DBIU_n   | DBIU0         | DBIU1   | DBIU2   | DBIU3   | DBIU4   | DBIU5   | DBIU6   | DBIU7   |

#### 4.12 ZQ Calibration Commands

##### 4.12.1 ZQ Calibration Description

ZQ Calibration command is used to calibrate DRAM Ron & ODT values. DDR4 SDRAM needs longer time to calibrate output driver and on-die termination circuits at initialization and relatively smaller time to perform periodic calibrations.

ZQCL command is used to perform the initial calibration during power-up initialization sequence. This command may be issued at any time by the controller depending on the system environment. ZQCL command triggers the calibration engine inside the DRAM and, once calibration is achieved, the calibrated values are transferred from the calibration engine to DRAM IO, which gets reflected as updated output driver and on-die termination values.

The first ZQCL command issued after reset is allowed a timing period of tZQinit to perform the full calibration and the transfer of values. All other ZQCL commands except the first ZQCL command issued after RESET are allowed a timing period of tZQoper.

ZQCS command is used to perform periodic calibrations to account for voltage and temperature variations. A shorter timing window is provided to perform the calibration and transfer of values as defined by timing parameter tZQCS. One ZQCS command can effectively correct a minimum of 0.5 % (ZQ Correction) of RON and RTT impedance error within 128 nCK for all speed bins assuming the maximum sensitivities specified in the 'Output Driver Voltage and Temperature Sensitivity' and 'ODT Voltage and Temperature Sensitivity' tables. The appropriate interval between ZQCS commands can be determined from these tables and other application-specific parameters. One method for calculating the interval between ZQCS commands, given the temperature (Tdriffrate) and voltage (Vdriffrate) drift rates that the SDRAM is subject to in the application, is illustrated. The interval could be defined by the following formula:

$$\text{ZQCorrection} = \frac{(TSens \times Tdriffrate) + (VSens \times Vdriffrate)}{(TSens \times Tdriffrate) + (VSens \times Vdriffrate)}$$

Where TSens =  $\max(dRTTdT, dRONdT)$  and VSens =  $\max(dRTTdV, dRONdV)$  define the SDRAM temperature and voltage sensitivities.

For example, if TSens = 1.5% / oC, VSens = 0.15% / mV, Tdriffrate = 1 oC / sec and Vdriffrate = 15 mV / sec, then the interval between ZQCS commands is calculated as:

$$\frac{0.5}{(1.5 \times 1) + (0.15 \times 15)} = 0.133 \approx 128ms$$

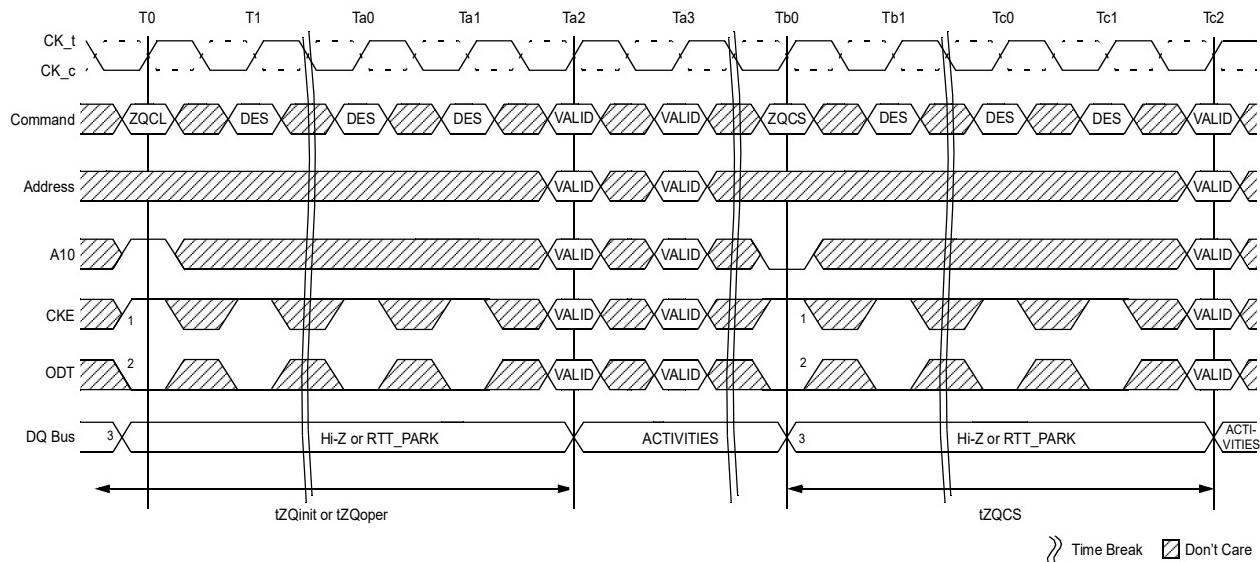
No other activities should be performed on the DRAM channel by the controller for the duration of tZQinit, tZQoper, or tZQCS. The quiet time on the DRAM channel allows accurate calibration of output driver and on-die termination values. Once DRAM calibration is achieved, the DRAM should disable ZQ current consumption path to reduce power.

All banks must be precharged and tRP met before ZQCL or ZQCS commands are issued by the controller. See "Command Truth Table" on Section 4.1 for a description of the ZQCL and ZQCS commands.

ZQ calibration commands can also be issued in parallel to DLL lock time when coming out of self refresh. Upon Self-Refresh exit, DDR4 SDRAM will not perform an IO calibration without an explicit ZQ calibration command. The earliest possible time for ZQ Calibration command (short or long) after self refresh exit is XS, XS\_Abort/ XS\_FAST depending on operation mode.

In systems that share the ZQ resistor between devices, the controller must not allow any overlap of tZQoper, tZQinit, or tZQCS between the devices.

#### 4.12.1 ZQ Calibration Description (cont'd)



NOTE 1 CKE must be continuously registered high during the calibration procedure.

NOTE 2 During ZQ Calibration, ODT signal must be held LOW and DRAM continues to provide RTT\_PARK.

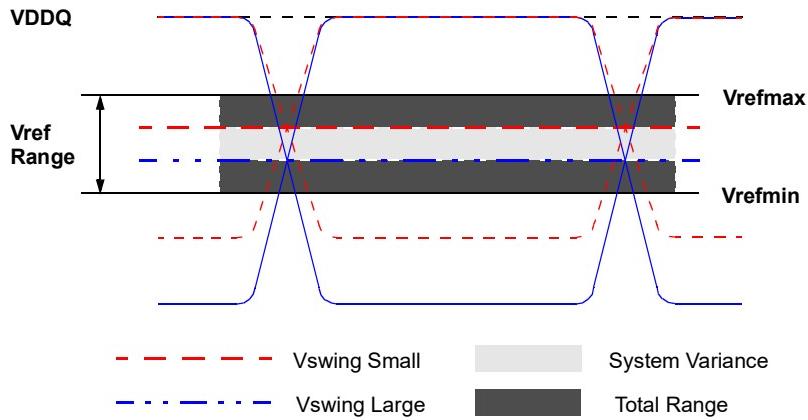
NOTE 3 All devices connected to the DQ bus should be high impedance or RTT\_PARK during the calibration procedure.

**Figure 27 — ZQ Calibration Timing**

#### 4.13 DQ Vref Training

The DRAM internal DQ Vref specification parameters are operating voltage range, stepsize, Vref step time, Vref full step time and Vref valid level.

The voltage operating range specifies the minimum required Vref setting range for DDR4 DRAM devices. The minimum range is defined by Vrefmax and Vrefmin as depicted in Figure 28 below.



**Figure 28 — Vref operating range(Vrefmin, Vrefmax)**

The Vref stepsize is defined as the stepsize between adjacent steps. Vref stepsize ranges from 0.5% VDDQ to 0.8% VDDQ. However, for a given design, DRAM has one value for Vref step size that falls within the range.

#### 4.13 DQ Vref Training (cont'd)

The Vref set tolerance is the variation in the Vref voltage from the ideal setting. This accounts for accumulated error over multiple steps. There are two ranges for Vref set tolerance uncertainty. The range of Vref set tolerance uncertainty is a function of number of steps n.

The Vref set tolerance is measured with respect to the ideal line which is based on the two endpoints. Where the endpoints are at the min and max Vref values for a specified range. An illustration depicting an example of the stepsize and Vref set tolerance is below.

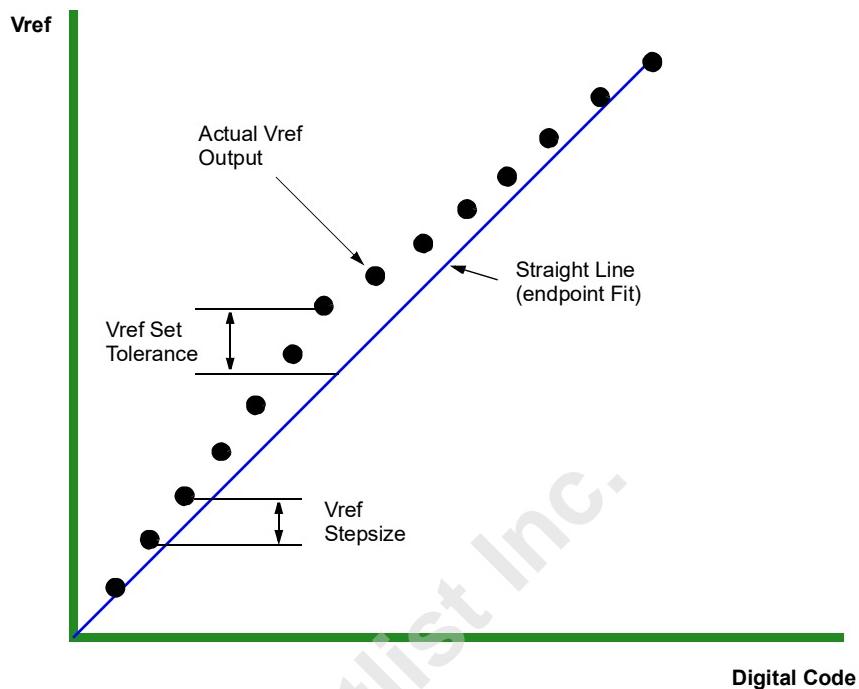


Figure 29 — Example of Vref set tolerance (max case only shown) and stepsize

#### 4.13 DQ Vref Training (cont'd)

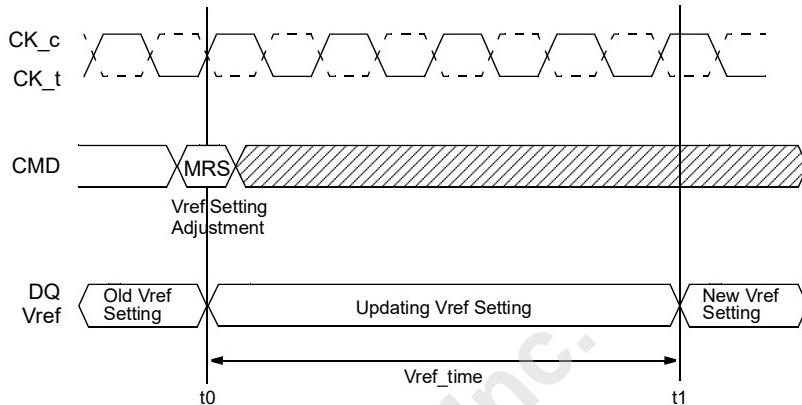
The Vref increment/decrement step times are defined by Vref\_time. The Vref\_time is defined from t0 to t1 as shown in the Figure 30 below where t1 is referenced to when the vref voltage is at the final DC level within the Vref valid tolerance (Vref\_val\_tol).

The Vref valid level is defined by Vref\_val tolerance to qualify the step time t1 as shown in Figure 32 through Figure 35. This parameter is used to insure an adequate RC time constant behavior of the voltage level change after any Vref increment/decrement adjustment. This parameter is only applicable for DRAM component level validation/characterization.

Vref\_time is the time including up to Vrefmin to Vrefmax or Vrefmax to Vrefmin change in Vref voltage

t0 - is referenced to MRS command clock

t1 - is referenced to the Vref\_val\_tol



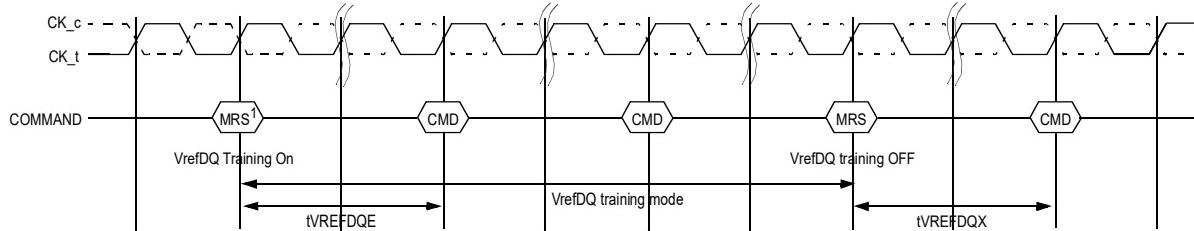
**Figure 30 — Vref\_time timing diagram**

VrefDQ Calibration Mode is entered via MRS command setting MR6 A[7] to 1 (0 disables VrefDQ Calibration Mode), setting MR6 A[6] to either 0 or 1 to select the desired range, and MR6 A[5:0] with a “don’t care” setting (there is no default initial setting; whether VrefDQ training value (MR6 A[5:0]) at training mode entry with MR6 A[7]=1 is captured by the DRAM or not is vendor specific). The next subsequent MR command is used to set the desired VrefDQ values at MR6 A[5:0]. Once VrefDQ Calibration Mode has been entered, VrefDQ Calibration Mode legal commands may be issued once tVREFDQE has been satisfied. VrefDQ Calibration Mode legal commands are ACT, WR, WRA, RD, RDA, PRE, DES, MRS to set VrefDQ values, and MRS to exit VrefDQ Calibration Mode. Once VrefDQ Calibration Mode has been entered, “dummy” write commands may be issued prior to adjusting VrefDQ value the first time VrefDQ calibration is performed after initialization. The “dummy” write commands may have bubbles between write commands provided other DRAM timings are satisfied. A possible example command sequence would be: WR1, DES, DES, DES, DES, WR2, DES, DES, DES, WR3, DES, DES, DES, WR4, DES, DES.....DES, DES, DES, WR50, DES, DES, DES. Setting VrefDQ values requires MR6 [7] set to 1, MR6 [6] unchanged from initial range selection, and MR6 A[5:0] set to desired VrefDQ value; if MR6 [7] is set to 0, MR6 [6:0] are not written. Vref\_time must be satisfied after each MR6 command to set VrefDQ value before the internal VrefDQ value is valid.

If PDA mode is used in conjunction with VrefDQ calibration, the PDA mode requirement that only MRS commands are allowed while PDA mode is enabled is not waived. That is, the only VrefDQ Calibration Mode legal commands noted above that may be used are the MRS commands, i.e., MRS to set VrefDQ values, and MRS to exit VrefDQ Calibration Mode.

The last A[6:0] setting written to MR6 prior to exiting VrefDQ Calibration Mode is the range and value used for the internal VrefDQ setting. VrefDQ Calibration Mode may be exited when the DRAM is in idle state. After the MRS command to exit VrefDQ Calibration Mode has been issued, DES must be issued till tVREFDQX has been satisfied where any legal command may then be issued.

#### 4.13 DQ Vref Training (cont'd)



NOTE 1 The MR command used to enter VrefDQ Calibration Mode treats MR6 A[5:0] as don't care while the next subsequent MR command sets VrefDQ values in MR6 A[5:0].

NOTE 2 Depending on the step size of the latest programmed VREF value, Vref\_time must be satisfied before disabling VrefDQ training mode.

**Figure 31 — VrefDQ training mode entry and exit timing diagram**

**Table 67 — AC parameters of DDR4 VrefDQ training**

| Speed   |          | DDR4-1600,1866,2133,2400,2666,3200 |     | Units | NOTE |
|---|----------|------------------------------------|-----|-------|------|
| Parameter   | Symbol   | MIN                                | MAX |       |      |
| <b>VrefDQ training</b>                                      |          |                                    |     |       |      |
| Enter VrefDQ training mode to the first valid command delay | tVREFDQE | 150                                | -   | ns    |      |
| Exit VrefDQ training mode to the first valid command delay  | tVREFDQX | 150                                | -   | ns    |      |

##### 4.13.1 Example scripts for VREFDQ Calibration Mode

When MR6 [7] = 0 then MR6 [6:0] = XXXXXXX

Entering VREFDQ Calibration if entering range 1:

- MR6 [7:6]=10 & [5:0]=XXXXXX
- All subsequent VREFDQ Calibration MR setting commands are MR6 [7:6]=10 & MR6 [5:0]=VVVVVV {VVVVVV are desired settings for VrefDQ}
- Issue ACT/WR/RD looking for pass/fail to determine Vcent(midpoint) as needed
- Just prior to exiting VREFDQ Calibration mode:
- Last two VREFDQ Calibration MR commands are
- MR6 [7:6]=10, MR6 [5:0]=VVVVVV' where VVVVVV' = desired value for VREFDQ
- MR6 [7]=0, MR6 [6:0]=XXXXXXXX to exit VREFDQ Calibration mode

Entering VREFDQ Calibration if entering range 2:

- MR6 [7:6]=11 & [5:0]=XXXXXX
- All subsequent VREFDQ Calibration MR setting commands are MR6 [7:6]=11 & MR6 [5:0]=VVVVVV {VVVVVV are desired settings for VrefDQ}
- Issue ACT/WR/RD looking for pass/fail to determine Vcent(midpoint) as needed
- Just prior to exiting VREFDQ Calibration mode:
- Last two VREFDQ Calibration MR commands are
- MR6 [7:6]=11, MR6 [5:0]=VVVVVV' where VVVVVV' = desired value for VREFDQ
- MR6 [7]=0, MR6 [6:0]=XXXXXXXX to exit VREFDQ Calibration mode

#### 4.13.1 Example scripts for VREFDQ Calibration Mode (cont'd)

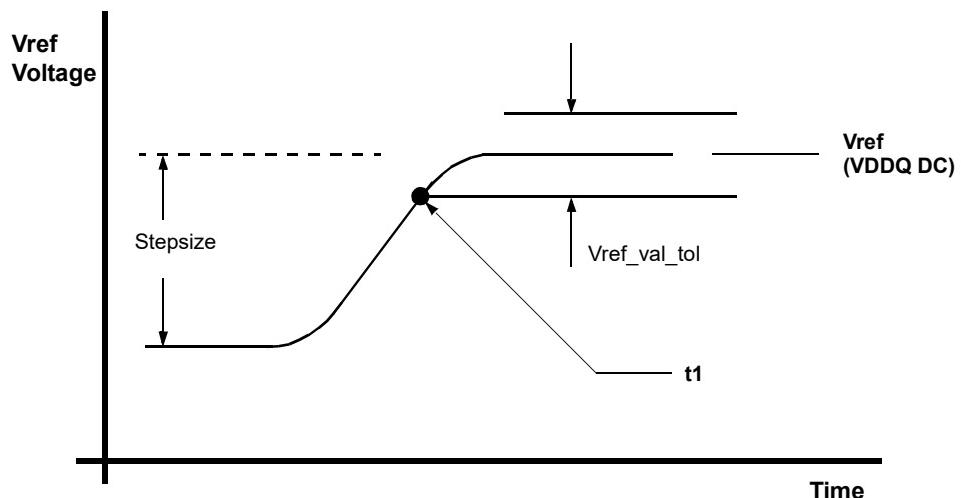


Figure 32 — Vref step single stepsize increment case

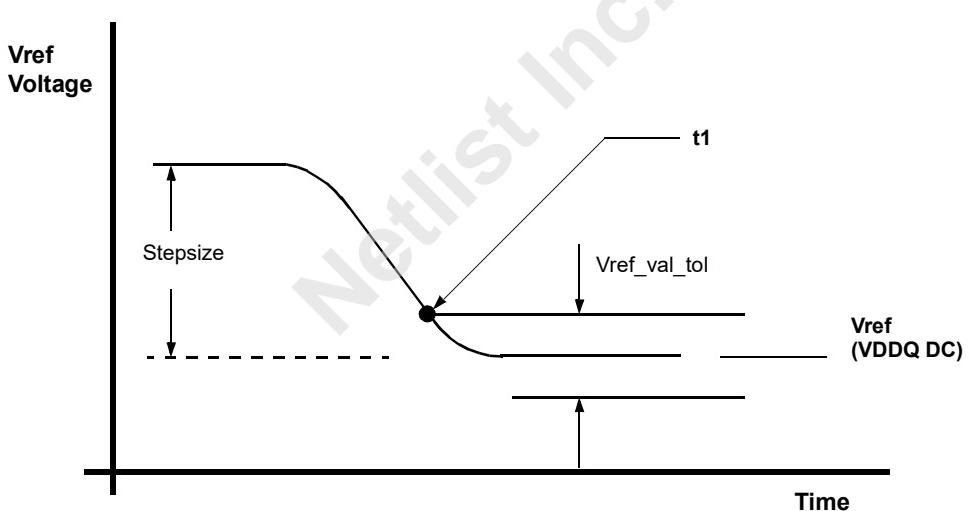


Figure 33 — Vref step single stepsize decrement case

4.13.1 Example scripts for VREFDQ Calibration Mode (cont'd)

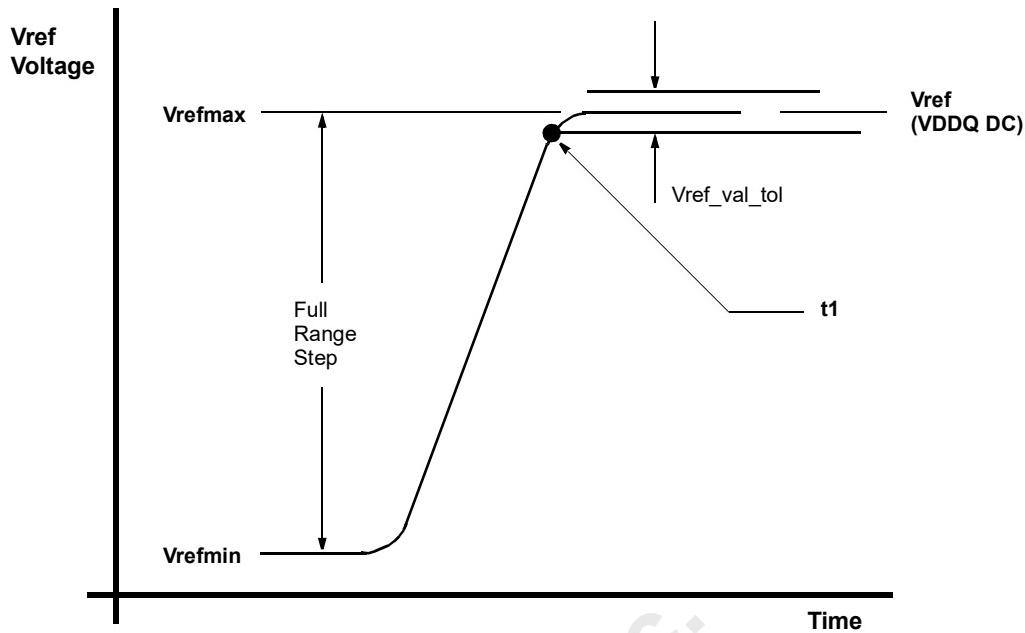


Figure 34 — Vref full step from Vrefmin to Vrefmax case

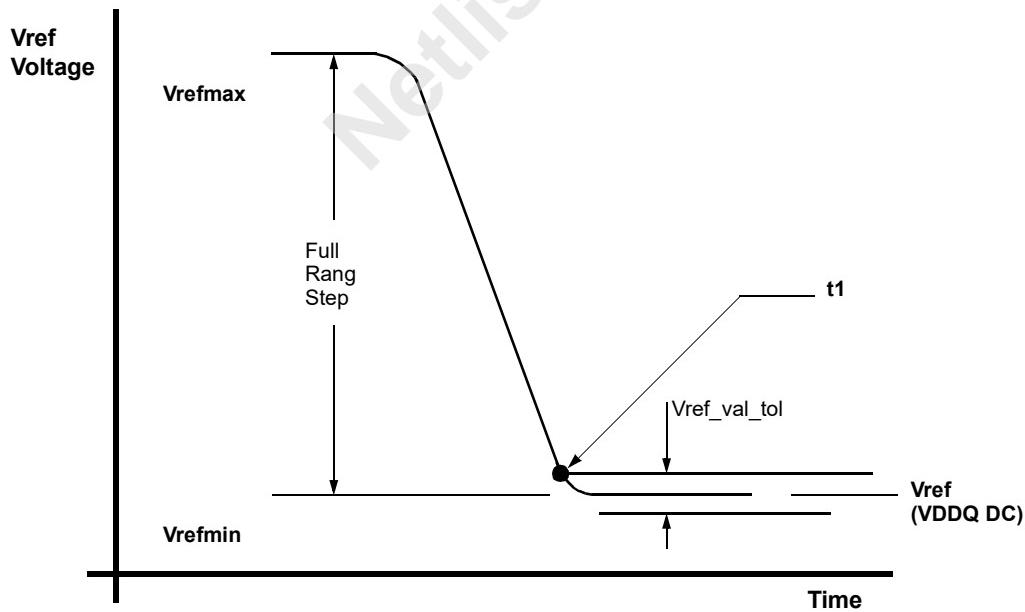


Figure 35 — Vref full step from Vrefmax to Vrefmin case

#### 4.13.1 Example scripts for VREFDQ Calibration Mode (cont'd)

**Table 68 — DQ Internal Vref Specifications**

| Parameter                       | Symbol              | Min     | Typ   | Max    | Unit | NOTE  |
|---------------------------------|---------------------|---------|-------|--------|------|-------|
| Vref Max operating point Range1 | $V_{ref\_max\_R1}$  | 92%     | -     | -      | VDDQ | 1, 10 |
| Vref Min operating point Range1 | $V_{ref\_min\_R1}$  | -       | -     | 60%    | VDDQ | 1, 10 |
| Vref Max operating point Range2 | $V_{ref\_max\_R2}$  | 77%     | -     | -      | VDDQ | 1, 10 |
| Vref Min operating point Range2 | $V_{ref\_min\_R2}$  | -       | -     | 45%    | VDDQ | 1, 10 |
| Vref Stepsize                   | $V_{ref\_step}$     | 0.50%   | 0.65% | 0.80%  | VDDQ | 2     |
| Vref Set Tolerance              | $V_{ref\_set\_tol}$ | -1.625% | 0.00% | 1.625% | VDDQ | 3,4,6 |
|                                 |                     | -0.15%  | 0.00% | 0.15%  | VDDQ | 3,5,7 |
| Vref Step Time                  | $V_{ref\_time}$     | -       | -     | 150    | ns   | 8,11  |
| Vref Valid tolerance            | $V_{ref\_val\_tol}$ | -0.15%  | 0.00% | 0.15%  | VDDQ | 9     |

NOTE 1. Vref DC voltage referenced to VDDQ\_DC. VDDQ\_DC is 1.2V

NOTE 2. Vref stepsize increment/decrement range. Vref at DC level.

NOTE 3.  $V_{ref\_new} = V_{ref\_old} + n \cdot V_{ref\_step}$ ; n=number of step; if increment use "+"; if decrement use "-".

NOTE 4. The minimum value of Vref setting tolerance= $V_{ref\_new} - 1.625\% \cdot VDDQ$ . The maximum value of Vref setting tolerance= $V_{ref\_new} + 1.625\% \cdot VDDQ$  for  $n > 4$

NOTE 5. The minimum value of Vref setting tolerance= $V_{ref\_new} - 0.15\% \cdot VDDQ$ . The maximum value of Vref setting tolerance= $V_{ref\_new} + 0.15\% \cdot VDDQ$  for  $n > 4$

NOTE 6. Measured by recording the min and max values of the Vref output over the range, drawing a straight line between those points and comparing all other Vref output settings to that line

NOTE 7. Measured by recording the min and max values of the Vref output across 4 consecutive steps( $n=4$ ), drawing a straight line between those points and comparing all other Vref output settings to that line

NOTE 8. Time from MRS command to increment or decrement one step size up to full range of Vref

NOTE 9. Only applicable for DRAM component level test/characterization purpose. Not applicable for normal mode of operation. Vref valid is to qualify the step times which will be characterized at the component level.

NOTE 10. DRAM range1 or 2 set by MRS bit MR6,A6.

NOTE 11. If the Vref monitor is enabled,  $V_{ref\_time}$  must be derated by: +10ns if DQ load is 0pF and an additional +15ns/pF of DQ loading.

#### 4.14 Per DRAM Addressability

DDR4 allows programmability of a given device on a rank. As an example, this feature can be used to program different ODT or Vref values on DRAM devices on a given rank.

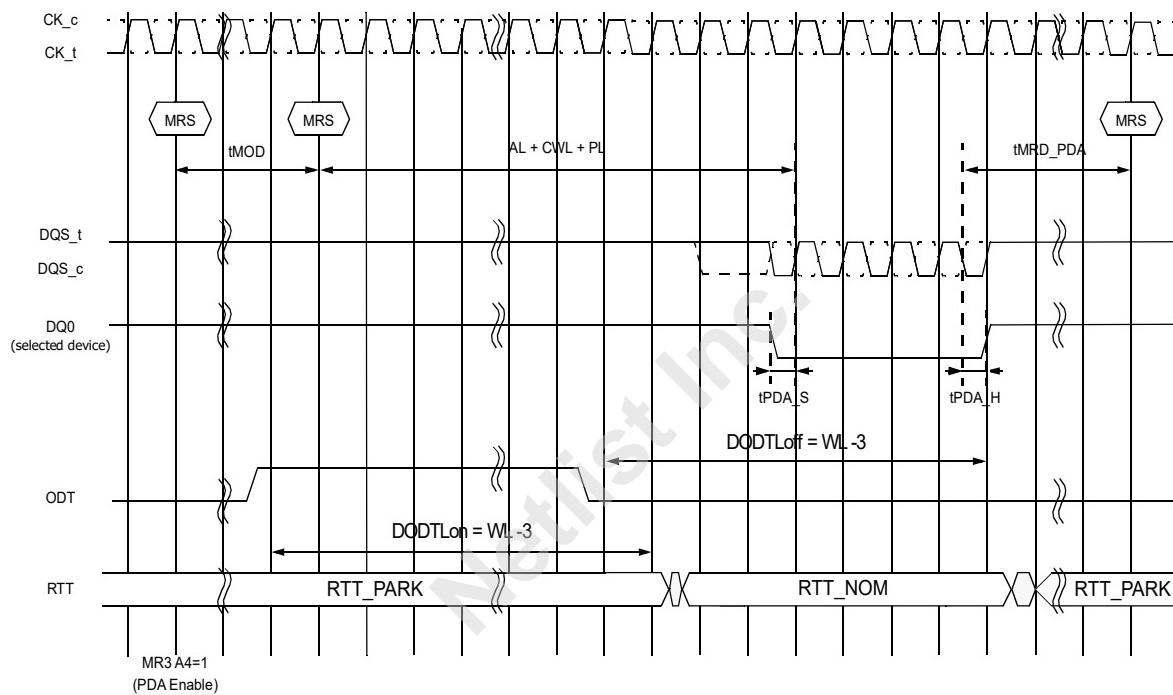
1. Before entering 'per DRAM addressability (PDA)' mode, the write leveling is required.
2. Before entering 'per DRAM addressability (PDA)' mode, the following Mode Register setting is possible.
  - RTT\_PARK MR5 {A8:A6} = Enable
  - RTT\_NOM MR1 {A10:A9:A8} = Enable
3. Enable 'per DRAM addressability (PDA)' mode using MR3 bit "A4=1".
4. In the 'per DRAM addressability' mode, all MRS command is qualified with DQ0 for x4 and x8, and DQL0 for x16. DRAM captures DQ0 for x4 and x8, and DQL0 for x16 by using DQS\_c and DQS\_t for x4 and x8, DQSL\_c and DQSL\_t for x16 signals as shown Figure 36 . If the value on DQ0 for x4 and x8, and DQL0 for x16 is 0 then the DRAM executes the MRS command. If the value on DQ0 is 1, then the DRAM ignores the MRS command. The controller can choose to drive all the DQ bits.
5. Program the desired devices and mode registers using MRS command and DQ0 for x4 and x8, and DQL0 for x16.
6. In the 'per DRAM addressability' mode, only MRS commands are allowed.
7. The mode register set command cycle time at PDA mode, AL + CWL + BL/2 - 0.5tCK + tMRD\_PDA + (PL) is required to complete the write operation to the mode register and is the minimum time required between two MRS commands shown in Figure 36.
8. Remove the DRAM from 'per DRAM addressability' mode by setting MR3 bit "A4=0". (This command will require DQ0=0 for x4 and x8, and DQL0 for x16 which shown in Figure 37).

Note: Removing a DRAM from per DRAM addressability mode will require programming the entire MR3 when the MRS command is issued. This may impact some per DRAM values programmed within a rank as the exit command is sent to the rank. In order to avoid such a case, the PDA Enable/Disable Control bit is located in a mode register that does not have any 'per DRAM addressability' mode controls). In per DRAM addressability mode, DRAM captures DQ0 for x4 and x8, and DQL0 for x16 using DQS\_t and DQS\_c for x4 and x8, DQSL\_c and DQSL\_t for x16 like normal write operation. However, Dynamic ODT is not supported. So extra care required for the ODT setting. If RTT\_NOM MR1 {A10:A9:A8} = Enable, DDR4 SDRAM data termination need to be controlled by ODT pin and apply the same timing parameters as defined in Direct ODT function that shown in Table 69. VrefDQ value must be set to either its midpoint or Vcent\_DQ(midpoint) in order to capture DQ0 or DQL0 low level for entering PDA mode.

4.14 Per DRAM Addressability (cont'd)

**Table 69 — Applied ODT Timing Parameter to PDA Mode**

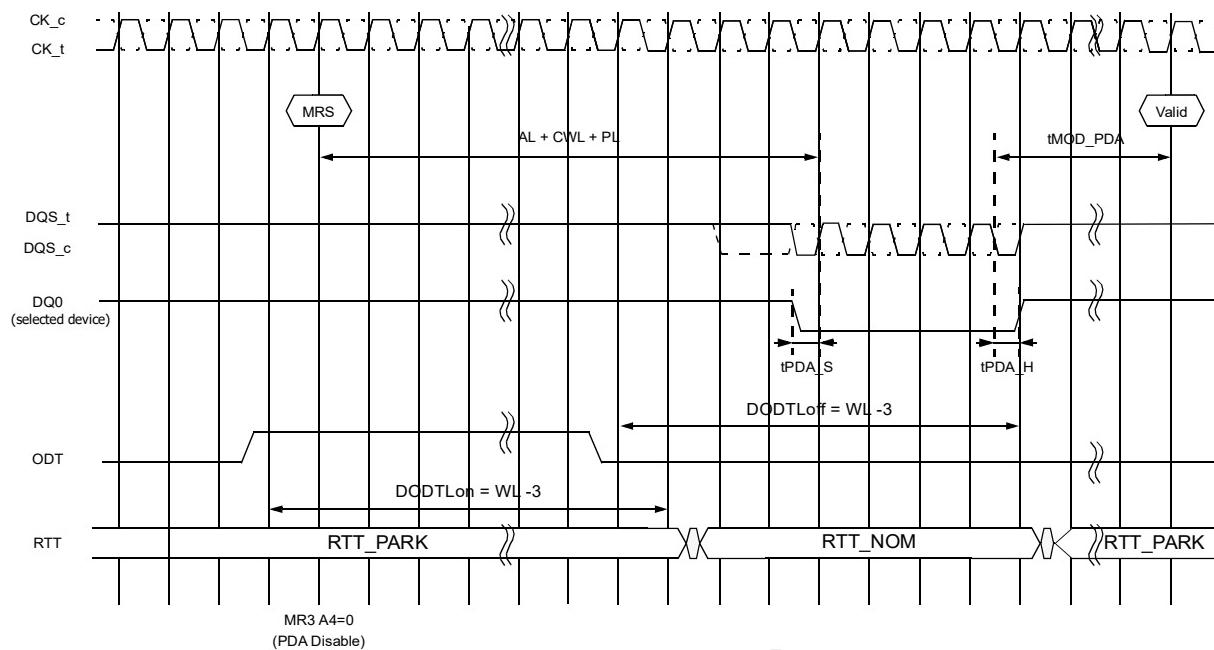
| Symbol   | Parameter                           |
|----------|-------------------------------------|
| DODTLon  | Direct ODT turn on latency          |
| DODTloff | Direct ODT turn off latency         |
| tADC     | RTT change timing skew              |
| tAONAS   | Asynchronous RTT_NOM turn-on delay  |
| tAOFAS   | Asynchronous RTT_NOM turn-off delay |



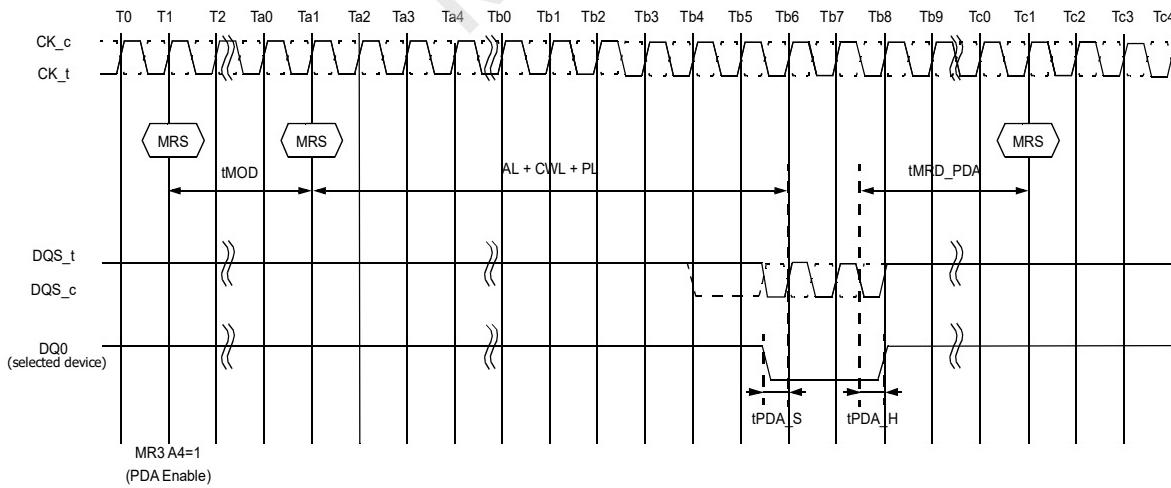
NOTE RTT\_PARK = Enable, RTT\_NOM = Enable, Write Preamble Set = 2tCK and DLL = ON, CA parity is used

**Figure 36 — MRS w/ per DRAM addressability (PDA) issuing before MRS**

#### 4.14 Per DRAM Addressability (cont'd)



**Figure 37 — MRS w/ per DRAM addressability (PDA) Exit**



NOTE CA parity is used

**Figure 38 — PDA using Burst Chop 4**

Since PDA mode may be used to program optimal Vref for the DRAM, the DRAM may incorrectly read DQ level at the first DQS edge and the last falling DQS edge. It is recommended that DRAM samples DQ0 or DQL0 on either the first falling or second rising DQS edges.

This will enable a common implementation between BC4 and BL8 modes on the DRAM. Controller is required to drive DQ0 or DQL0 to a 'Stable Low or High' during the length of the data transfer for BC4 and BL8 cases.

## 4.15 CAL Mode (CS\_n to Command Address Latency)

### 4.15.1 CAL Mode Description

DDR4 supports Command Address Latency, CAL, function as a power savings feature. CAL is the delay in clock cycles between CS\_n and CMD/ADDR defined by MR4[A8:A6] (See Figure 39).

CAL gives the DRAM time to enable the CMD/ADDR receivers before a command is issued. Once the command and the address are latched, the receivers can be disabled. For consecutive commands, the DRAM will keep the receivers enabled for the duration of the command sequence (See Figure 40).

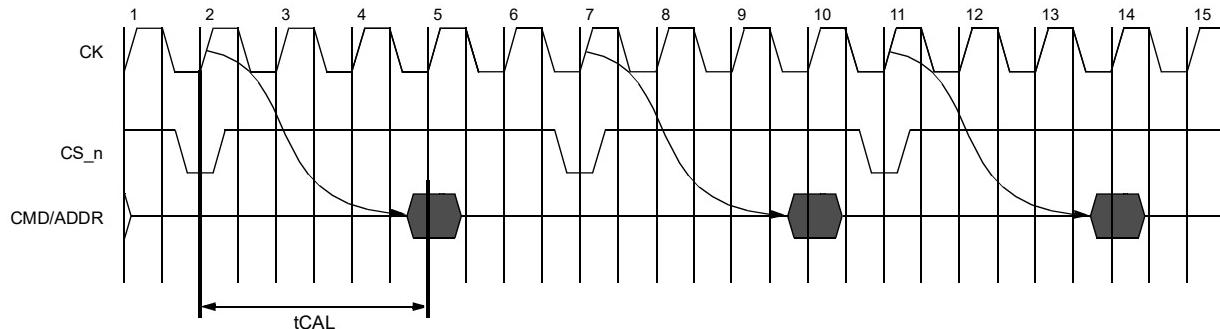


Figure 39 — Definition of CAL

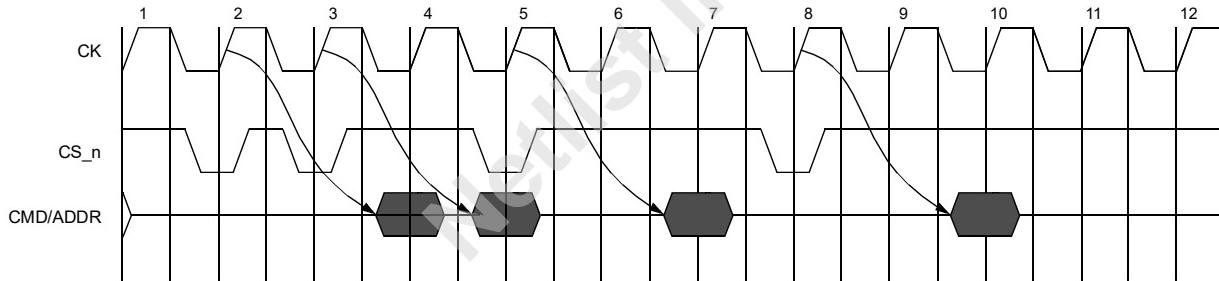


Figure 40 — CAL operational timing for consecutive command issues

The following tables show the timing requirements for tCAL (Table 70) and MRS settings (Table 42) at different data rates.

Table 70 — CS to Command Address Latency – 1600, 1866, 2133, 2400

| Parameter                       | Symbol    | DDR4-1600 | DDR4-1866            | DDR4-2133 | DDR4-2400 | Units | Note |
|---------------------------------|-----------|-----------|----------------------|-----------|-----------|-------|------|
| CS_n to Command Address Latency | tCAL(min) |           | max(3 nCK, 3.748 ns) |           |           | nCK   | 1    |

NOTE 1 Geardown mode is not supported for speed bins below DDR4-2666.

Table 71 — CS to Command Address Latency – 2666, 2933, 3200

| Parameter                       | Symbol    | DDR4-2666 | DDR4-2933            | DDR4-3200 | Units | Note |
|---------------------------------|-----------|-----------|----------------------|-----------|-------|------|
| CS_n to Command Address Latency | tCAL(min) |           | max(3 nCK, 3.748 ns) |           | nCK   | 1    |

NOTE 1 In geardown mode, odd nCK values for tCAL are not supported, and nCK values must be rounded up to the next higher even integer. For example, when operating at DDR4-2666, a minimum of 6 nCK is required for tCAL.

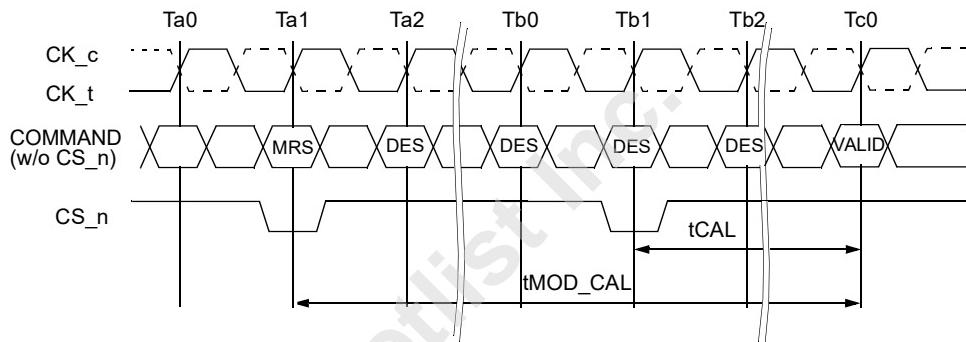
#### 4.15.1 CAL Mode Description (cont'd)

**Table 72 — MRS settings for CAL**

| A8:A6 @ MR4 | CAL(tCK cycles)   |
|-------------|-------------------|
| 000         | default (disable) |
| 001         | 3                 |
| 010         | 4                 |
| 011         | 5                 |
| 100         | 6                 |
| 101         | 8                 |
| 110         | Reserved          |
| 111         | Reserved          |

#### MRS Timings with Command/Address Latency enabled

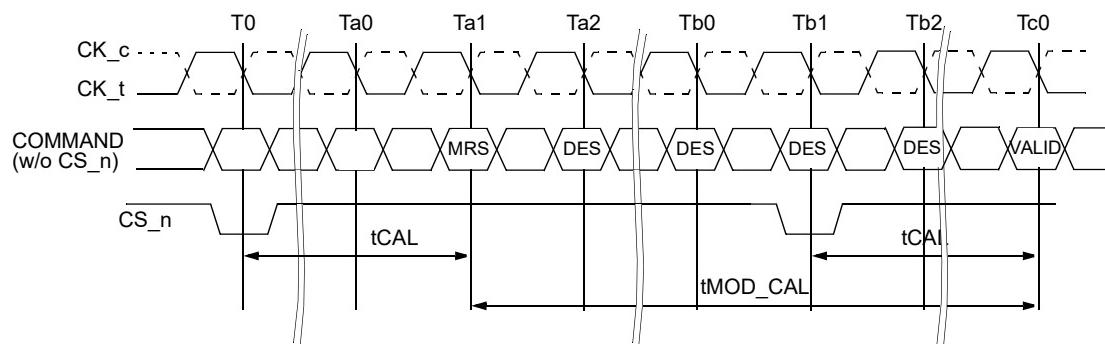
When Command/Address latency mode is enabled, users must allow more time for MRS commands to take effect. When CAL mode is enabled, or being enabled by an MRS command, the earliest the next valid command can be issued is tMOD\_CAL, where tMOD\_CAL=tMOD+tCAL.



NOTE 1 MRS command at Ta1 enables CAL mode

NOTE 2 tMOD\_CAL=tMOD+tCAL

**Figure 41 — CAL enable timing - tMOD\_CAL**



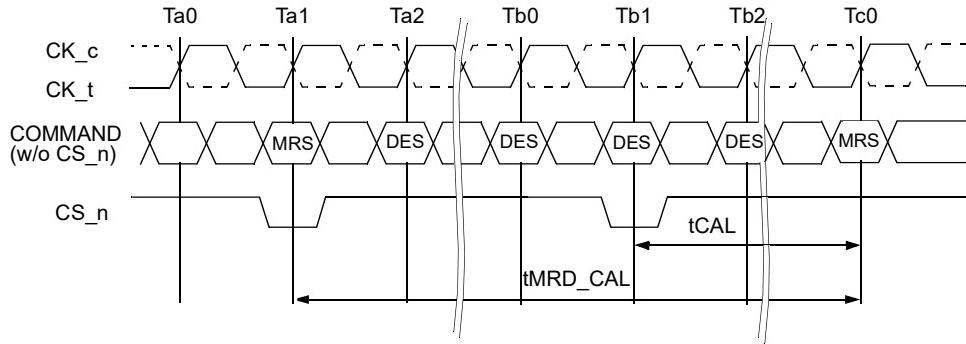
NOTE 1 MRS at Ta1 may or may not modify CAL, tMOD\_CAL is computed based on new tCAL setting.

NOTE 2 tMOD\_CAL=tMOD+tCAL

**Figure 42 — tMOD\_CAL, MRS to valid command timing with CAL enabled**

#### 4.15.1 CAL Mode Description (cont'd)

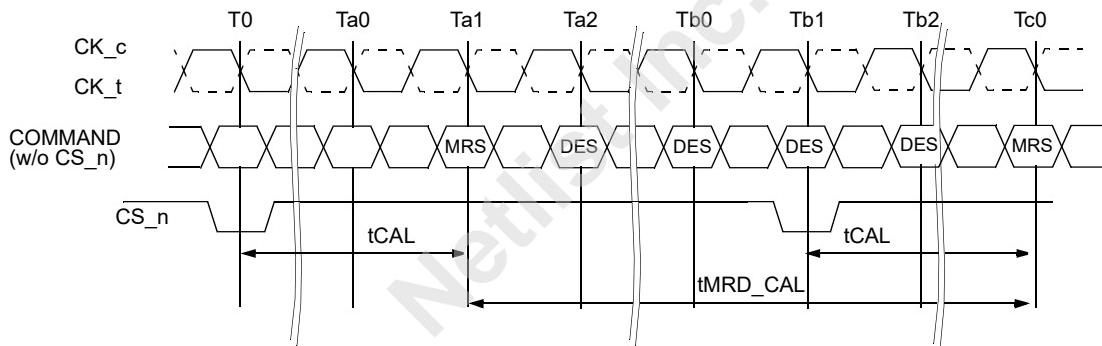
When Command/Address latency is enabled or being entered, users must wait tMRD\_CAL until the next MRS command can be issued. tMRD\_CAL=tMOD+tCAL.



NOTE 1 MRS command at Ta1 enables CAL mode

NOTE 2 tMRD\_CAL=tMOD+tCAL

**Figure 43 — CAL enabling MRS to next MRS command, tMRD\_CAL**

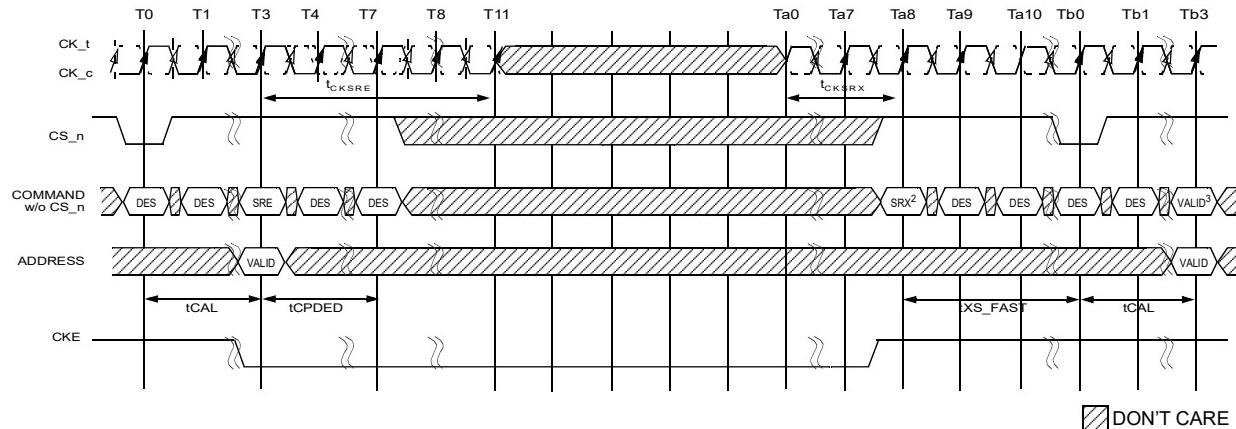


NOTE 1 MRS at Ta1 may or may not modify CAL, tMRD\_CAL is computed based on new tCAL setting.

NOTE 2 tMRD\_CAL=tMOD+tCAL.

**Figure 44 — tMRD\_CAL, mode register cycle time with CAL enabled**

#### 4.15.2 Self Refresh Entry, Exit Timing with CAL



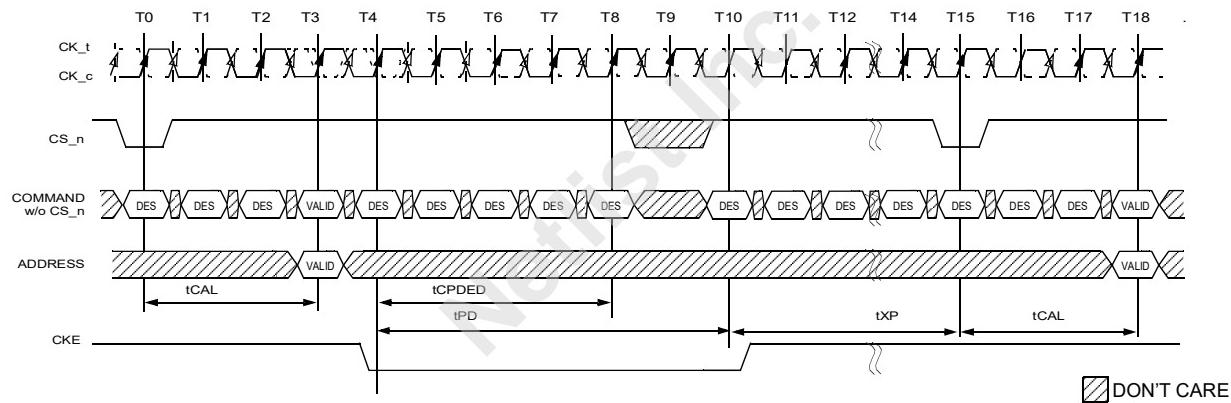
NOTE 1 tCAL = 3nCK, tCPDED = 4nCK, tKSRE = 8nCK, tCKSRX = 8nCK, tXS\_FAST = tRFC4(min) + 10ns

NOTE 2 CS<sub>n</sub> = H, ACT<sub>n</sub> = Don't Care, RAS<sub>n</sub>/A16 = Don't Care, CAS<sub>n</sub>/A15 = Don't Care, WE<sub>n</sub>/A14 = Don't Care

NOTE 3 Only MRS (limited to those described in the Self-Refresh Operation section). ZQCS or ZQCL command allowed.

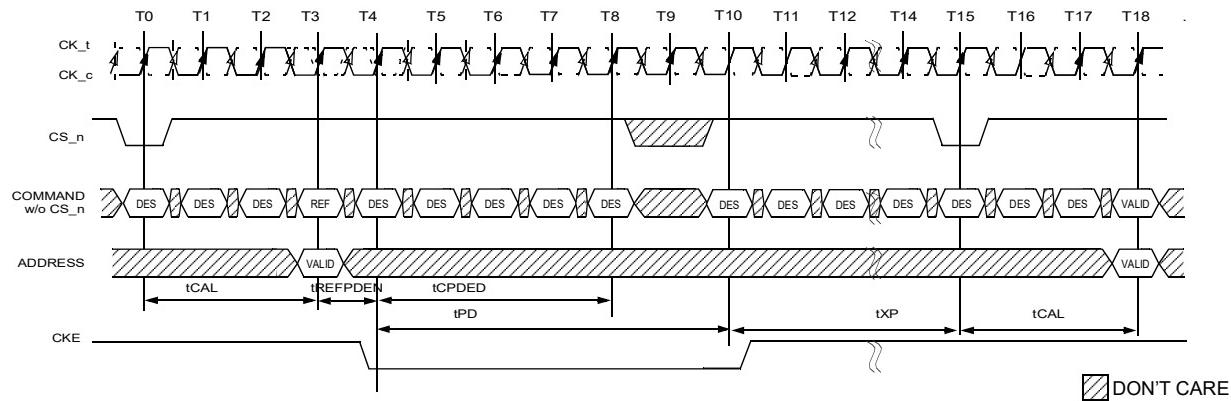
**Figure 45 — Self Refresh Entry/Exit Timing**

#### 4.15.3 Power Down Entry, Exit Timing with CAL



NOTE 1 tCAL = 3nCK, tCPDED = 4nCK, tPD = 6nCK, tXP = 5nCK

**Figure 46 — Active Power Down Entry and Exit Timing**



NOTE 1 tCAL = 3nCK, tREFPDEN = 1nCK, tCPDED = 4nCK, tPD = 6nCK, tXP = 5nCK

**Figure 47 — Refresh Command to Power Down Entry**

## 4.16 CRC

### 4.16.1 CRC Polynomial and logic equation

DDR4 supports CRC for write operation, and doesn't support CRC for read operation.

The CRC polynomial used by DDR4 is the ATM-8 HEC,  $X^8 + X^2 + X^1 + 1$

A combinatorial logic block implementation of this 8-bit CRC for 72-bits of data contains 272 two-input XOR gates contained in eight 6 XOR gate deep trees.

The CRC polynomial and combinatorial logic used by DDR4 is the same as used on GDDR5.

**Table 73 — Error Detection Details**

| ERROR TYPE   | DETECTION CAPABILITY |
|--|----------------------|
| Random Single Bit Error  | 100%                 |
| Random Double Bit Error  | 100%                 |
| Random Odd Count Error   | 100%                 |
| Random one Multi-bit UI vertical column error detection excluding DBI bits | 100%                 |

## 4.16.1 CRC Polynomial and logic equation (cont'd)

## CRC COMBINATORIAL LOGIC EQUATIONS

```
module CRC8_D72;
// polynomial: (0 1 2 8)
// data width: 72
// convention: the first serial data bit is D[71]
// initial condition all 0 implied
function [7:0]
nextCRC8_D72;
input [71:0] Data;
reg [71:0] D;
reg [7:0] NewCRC;
begin
D = Data;

NewCRC[0] = D[69] ^ D[68] ^ D[67] ^ D[66] ^ D[64] ^ D[63] ^ D[60] ^
D[56] ^ D[54] ^ D[53] ^ D[52] ^ D[50] ^ D[49] ^ D[48] ^
D[45] ^ D[43] ^ D[40] ^ D[39] ^ D[35] ^ D[34] ^ D[31] ^
D[30] ^ D[28] ^ D[23] ^ D[21] ^ D[19] ^ D[18] ^ D[16] ^
D[14] ^ D[12] ^ D[8] ^ D[7] ^ D[6] ^ D[0];
NewCRC[1] = D[70] ^ D[66] ^ D[65] ^ D[63] ^ D[61] ^ D[60] ^ D[57] ^
D[56] ^ D[55] ^ D[52] ^ D[51] ^ D[48] ^ D[46] ^ D[45] ^
D[44] ^ D[43] ^ D[41] ^ D[39] ^ D[36] ^ D[34] ^ D[32] ^
D[30] ^ D[29] ^ D[28] ^ D[24] ^ D[23] ^ D[22] ^ D[21] ^
D[20] ^ D[18] ^ D[17] ^ D[16] ^ D[15] ^ D[14] ^ D[13] ^
D[12] ^ D[9] ^ D[6] ^ D[1] ^ D[0];
NewCRC[2] = D[71] ^ D[69] ^ D[68] ^ D[63] ^ D[62] ^ D[61] ^ D[60] ^
D[58] ^ D[57] ^ D[54] ^ D[50] ^ D[48] ^ D[47] ^ D[46] ^
D[44] ^ D[43] ^ D[42] ^ D[39] ^ D[37] ^ D[34] ^ D[33] ^
D[29] ^ D[28] ^ D[25] ^ D[24] ^ D[22] ^ D[17] ^ D[15] ^
D[13] ^ D[12] ^ D[10] ^ D[8] ^ D[6] ^ D[2] ^ D[1] ^ D[0];
NewCRC[3] = D[70] ^ D[69] ^ D[64] ^ D[63] ^ D[62] ^ D[61] ^ D[59] ^
D[58] ^ D[55] ^ D[51] ^ D[49] ^ D[48] ^ D[47] ^ D[45] ^
D[44] ^ D[43] ^ D[40] ^ D[38] ^ D[35] ^ D[34] ^ D[30] ^
D[29] ^ D[26] ^ D[25] ^ D[23] ^ D[18] ^ D[16] ^ D[14] ^
D[13] ^ D[11] ^ D[9] ^ D[7] ^ D[3] ^ D[2] ^ D[1];
NewCRC[4] = D[71] ^ D[70] ^ D[65] ^ D[64] ^ D[63] ^ D[62] ^ D[60] ^
D[59] ^ D[56] ^ D[52] ^ D[50] ^ D[49] ^ D[48] ^ D[46] ^
D[45] ^ D[44] ^ D[41] ^ D[39] ^ D[36] ^ D[35] ^ D[31] ^
D[30] ^ D[27] ^ D[26] ^ D[24] ^ D[19] ^ D[17] ^ D[15] ^
D[14] ^ D[12] ^ D[10] ^ D[8] ^ D[4] ^ D[3] ^ D[2];
NewCRC[5] = D[71] ^ D[66] ^ D[65] ^ D[64] ^ D[63] ^ D[61] ^ D[60] ^
D[57] ^ D[53] ^ D[51] ^ D[50] ^ D[49] ^ D[47] ^ D[46] ^
D[45] ^ D[42] ^ D[40] ^ D[37] ^ D[36] ^ D[32] ^ D[31] ^
D[28] ^ D[27] ^ D[25] ^ D[20] ^ D[18] ^ D[16] ^ D[15] ^
D[13] ^ D[11] ^ D[9] ^ D[5] ^ D[4] ^ D[3];
NewCRC[6] = D[67] ^ D[66] ^ D[65] ^ D[64] ^ D[62] ^ D[61] ^ D[58] ^
D[54] ^ D[52] ^ D[51] ^ D[50] ^ D[48] ^ D[47] ^ D[46] ^
D[43] ^ D[41] ^ D[38] ^ D[37] ^ D[33] ^ D[32] ^ D[29] ^
D[28] ^ D[26] ^ D[21] ^ D[19] ^ D[17] ^ D[16] ^ D[14] ^
D[12] ^ D[10] ^ D[6] ^ D[5] ^ D[4];
NewCRC[7] = D[68] ^ D[67] ^ D[66] ^ D[65] ^ D[63] ^ D[62] ^ D[59] ^
D[55] ^ D[53] ^ D[52] ^ D[51] ^ D[49] ^ D[48] ^ D[47] ^
D[44] ^ D[42] ^ D[39] ^ D[38] ^ D[34] ^ D[33] ^ D[30] ^
D[29] ^ D[27] ^ D[22] ^ D[20] ^ D[18] ^ D[17] ^ D[15] ^
D[13] ^ D[11] ^ D[7] ^ D[6] ^ D[5];
```

```
nextCRC8_D72 = NewCRC;
```

#### 4.16.2 CRC data bit mapping for x8 devices

The following figure shows detailed bit mapping for a x8 device.

|                | 0   | 1   | 2   | 3   | 4   | 5   | 6   | 7   | 8    | 9 |
|----------------|-----|-----|-----|-----|-----|-----|-----|-----|------|---|
| DQ0            | d0  | d1  | d2  | d3  | d4  | d5  | d6  | d7  | CRC0 | 1 |
| DQ1            | d8  | d9  | d10 | d11 | d12 | d13 | d14 | d15 | CRC1 | 1 |
| DQ2            | d16 | d17 | d18 | d19 | d20 | d21 | d22 | d23 | CRC2 | 1 |
| DQ3            | d24 | d25 | d26 | d27 | d28 | d29 | d30 | d31 | CRC3 | 1 |
| DQ4            | d32 | d33 | d34 | d35 | d36 | d37 | d38 | d39 | CRC4 | 1 |
| DQ5            | d40 | d41 | d42 | d43 | d44 | d45 | d46 | d47 | CRC5 | 1 |
| DQ6            | d48 | d49 | d50 | d51 | d52 | d53 | d54 | d55 | CRC6 | 1 |
| DQ7            | d56 | d57 | d58 | d59 | d60 | d61 | d62 | d63 | CRC7 | 1 |
| DM_n/<br>DBI_n | d64 | d65 | d66 | d67 | d68 | d69 | d70 | d71 | 1    | 1 |

Figure 48 — CRC data bit mapping for x8 devices

#### 4.16.3 CRC data bit mapping for x4 devices

The following figure shows detailed bit mapping for a x4 device.

|     | 0   | 1   | 2   | 3   | 4   | 5   | 6   | 7   | 8    | 9    |
|-----|-----|-----|-----|-----|-----|-----|-----|-----|------|------|
| DQ0 | d0  | d1  | d2  | d3  | d4  | d5  | d6  | d7  | CRC0 | CRC4 |
| DQ1 | d8  | d9  | d10 | d11 | d12 | d13 | d14 | d15 | CRC1 | CRC5 |
| DQ2 | d16 | d17 | d18 | d19 | d20 | d21 | d22 | d23 | CRC2 | CRC6 |
| DQ3 | d24 | d25 | d26 | d27 | d28 | d29 | d30 | d31 | CRC3 | CRC7 |

Figure 49 — CRC data bit mapping for x4 devices

#### 4.16.4 CRC data bit mapping for x16 devices

A x16 device is treated as two x8 devices. x16 device will have two identical CRC trees implemented. CRC(0-7) covers data bits d(0-71). CRC(8-15) covers data bits d(72-143).

|                  | 0    | 1    | 2    | 3    | 4    | 5    | 6    | 7    | 8     | 9 |
|------------------|------|------|------|------|------|------|------|------|-------|---|
| DQ0              | d0   | d1   | d2   | d3   | d4   | d5   | d6   | d7   | CRC0  | 1 |
| DQ1              | d8   | d9   | d10  | d11  | d12  | d13  | d14  | d15  | CRC1  | 1 |
| DQ2              | d16  | d17  | d18  | d19  | d20  | d21  | d22  | d23  | CRC2  | 1 |
| DQ3              | d24  | d25  | d26  | d27  | d28  | d29  | d30  | d31  | CRC3  | 1 |
| DQ4              | d32  | d33  | d34  | d35  | d36  | d37  | d38  | d39  | CRC4  | 1 |
| DQ5              | d40  | d41  | d42  | d43  | d44  | d45  | d46  | d47  | CRC5  | 1 |
| DQ6              | d48  | d49  | d50  | d51  | d52  | d53  | d54  | d55  | CRC6  | 1 |
| DQ7              | d56  | d57  | d58  | d59  | d60  | d61  | d62  | d63  | CRC7  | 1 |
| DML_n/<br>DBIL_n | d64  | d65  | d66  | d67  | d68  | d69  | d70  | d71  | 1     | 1 |
| DQ8              | d72  | d73  | d74  | d75  | d76  | d77  | d78  | d79  | CRC8  | 1 |
| DQ9              | d80  | d81  | d82  | d83  | d84  | d85  | d86  | d87  | CRC9  | 1 |
| DQ10             | d88  | d89  | d90  | d91  | d92  | d93  | d94  | d95  | CRC10 | 1 |
| DQ11             | d96  | d97  | d98  | d99  | d100 | d101 | d102 | d103 | CRC11 | 1 |
| DQ12             | d104 | d105 | d106 | d107 | d108 | d109 | d110 | d111 | CRC12 | 1 |
| DQ13             | d112 | d113 | d114 | d115 | d116 | d117 | d118 | d119 | CRC13 | 1 |
| DQ14             | d120 | d121 | d122 | d123 | d124 | d125 | d126 | d127 | CRC14 | 1 |
| DQ15             | d128 | d129 | d130 | d131 | d132 | d133 | d134 | d135 | CRC15 | 1 |
| DMU_n/<br>DBIU_n | d136 | d137 | d138 | d139 | d140 | d141 | d142 | d143 | 1     | 1 |

Figure 50 — CRC data bit mapping for x16 devices

#### 4.16.5 Write CRC for x4, x8 and x16 devices

The Controller generates the CRC checksum and forms the write data frames as shown in Section 4.16.1 to Section 4.16.4.

For a x8 DRAM the controller must send 1's in the transfer 9 if CRC is enabled and must send 1's in transfer 8 and transfer 9 of the DBI<sub>n</sub> lane if DBI function is enabled.

For a x16 DRAM the controller must send 1's in the transfer 9 if CRC is enabled and must send 1's in transfer 8 and transfer 9 of the DBIL<sub>n</sub> and DBIU<sub>n</sub> lanes if DBI function is enabled.

The DRAM checks for an error in a received code word D[71:0] by comparing the received checksum against the computed checksum and reports errors using the ALERT<sub>n</sub> signal if there is a mis-match.

A x8 device has a CRC tree with 72 input bits. The upper 8 bits are used if either Write DBI or DM is enabled. Note that Write DBI and DM function cannot be enabled simultaneously. If both Write DBI and DM is disabled then the inputs of the upper 8 bits D[71:64] are '1's.

A x16 device has two identical CRC trees with 72 input bits each. The upper 8 bits are used if either Write DBI or DM is enabled. Note that Write DBI and DM function cannot be enabled simultaneously. If both Write DBI and DM is disabled then the inputs of the upper 8 bits [D(143:136) and D(71:64)] are '1's.

A x4 device has a CRC tree with 32 input bits. The input for the upper 40 bits D[71:32] are '1's.

DRAM can write data to the DRAM core without waiting for CRC check for full writes. If bad data is written to the DRAM core then controller will retry the transaction and overwrite the bad data. Controller is responsible for data coherency.

#### 4.16.6 CRC Error Handling

CRC Error mechanism shares the same Alert<sub>n</sub> signal for reporting errors on writes to DRAM. The controller has no way to distinguish between CRC errors and Command/Address/Parity errors other than to read the DRAM mode registers. This is a very time consuming process in a multi-rank configuration.

To speed up recovery for CRC errors, CRC errors are only sent back as a pulse. The minimum pulse-width is 6 clocks. The latency to Alert<sub>n</sub> signal is defined as tCRC\_ALERT in the figure below.

DRAM will set CRC Error Clear bit in A3 of MR5 to '1' and CRC Error Status bit in MPR3 of page1 to '1' upon detecting a CRC error. The CRC Error Clear bit remains set at '1' until the host clears it explicitly using an MRS command.

The controller upon seeing an error as a pulse width will retry the write transactions. The controller understands the worst case delay for Alert<sub>n</sub> (during init) and can backup the transactions accordingly or the controller can be made more intelligent and try to correlate the write CRC error to a specific rank or a transaction. The controller is also responsible for opening any pages and ensuring that retrying of writes is done in a coherent fashion.

The pulse width may be seen longer than six clocks at the controller if there are multiple CRC errors as the Alert<sub>n</sub> is a daisy chain bus.

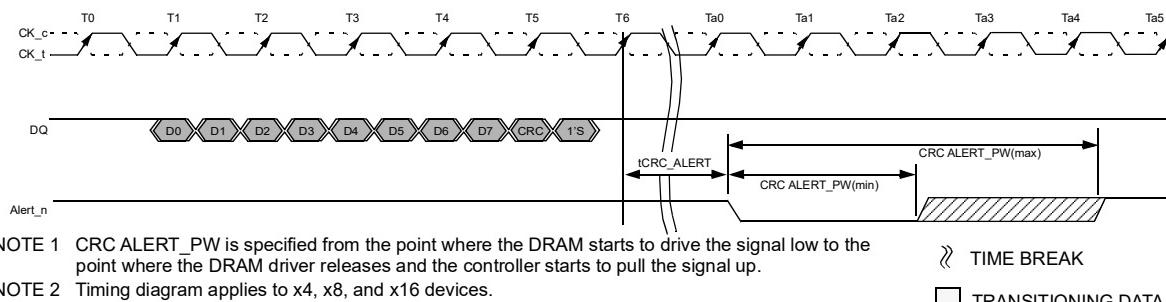


Figure 51 — CRC Error Reporting

Table 74 — CRC Error Timing Parameters

| Parameter                               | Symbol       | DDR4-1600 |     | DDR4-1866 |     | DDR4-2133 |     | DDR4-2400 |     | Unit |
|---|--------------|-----------|-----|-----------|-----|-----------|-----|-----------|-----|------|
|   |              | min       | max | min       | max | min       | max | min       | max |      |
| CRC error to ALERT <sub>n</sub> latency | tCRC_ALERT   | -         | 13  | -         | 13  | -         | 13  | -         | 13  | ns   |
| CRC ALERT <sub>n</sub> pulse width      | CRC ALERT_PW | 6         | 10  | 6         | 10  | 6         | 10  | 6         | 10  | nCK  |

#### 4.16.7 CRC Frame format with BC4

DDR4 SDRAM supports CRC function for Write operation for Burst Chop 4 (BC4). The CRC function is programmable using DRAM mode register and can be enabled for writes.

When CRC is enabled the data frame length is fixed at 10UI for both BL8 and BC4 operations. DDR4 SDRAM also supports burst length on the fly with CRC enabled. This is enabled using mode register.

##### CRC data bit mapping for x4 devices (BC4)

The following figure shows detailed bit mapping for a x4 device.

|     | Transfer |     |     |     |   |   |   |   |      |      |
|-----|----------|-----|-----|-----|---|---|---|---|------|------|
|     | 0        | 1   | 2   | 3   | 4 | 5 | 6 | 7 | 8    | 9    |
| DQ0 | d0       | d1  | d2  | d3  | 1 | 1 | 1 | 1 | CRC0 | CRC4 |
| DQ1 | d8       | d9  | d10 | d11 | 1 | 1 | 1 | 1 | CRC1 | CRC5 |
| DQ2 | d16      | d17 | d18 | d19 | 1 | 1 | 1 | 1 | CRC2 | CRC6 |
| DQ3 | d24      | d25 | d26 | d27 | 1 | 1 | 1 | 1 | CRC3 | CRC7 |

Figure 52 — CRC data bit mapping for x4 devices (BC4)

For a x4 SDRAM, the CRC tree input is 16 data bits as shown in the figure above. The input for the remaining bits are “1”.

##### CRC data bit mapping for x8 devices (BC4)

The following figure shows detailed bit mapping for a x8 device.

|       | Transfer |     |     |     |   |   |   |   |      |   |
|-------|----------|-----|-----|-----|---|---|---|---|------|---|
|       | 0        | 1   | 2   | 3   | 4 | 5 | 6 | 7 | 8    | 9 |
| DQ0   | d0       | d1  | d2  | d3  | 1 | 1 | 1 | 1 | CRC0 | 1 |
| DQ1   | d8       | d9  | d10 | d11 | 1 | 1 | 1 | 1 | CRC1 | 1 |
| DQ2   | d16      | d17 | d18 | d19 | 1 | 1 | 1 | 1 | CRC2 | 1 |
| DQ3   | d24      | d25 | d26 | d27 | 1 | 1 | 1 | 1 | CRC3 | 1 |
| DQ4   | d32      | d33 | d34 | d35 | 1 | 1 | 1 | 1 | CRC4 | 1 |
| DQ5   | d40      | d41 | d42 | d43 | 1 | 1 | 1 | 1 | CRC5 | 1 |
| DQ6   | d48      | d49 | d50 | d51 | 1 | 1 | 1 | 1 | CRC6 | 1 |
| DQ7   | d56      | d57 | d58 | d59 | 1 | 1 | 1 | 1 | CRC7 | 1 |
| DM_n  | d64      |     |     |     |   | 1 | 1 | 1 | 1    | 1 |
| DBI_n | d65      |     |     |     |   | 1 | 1 | 1 | 1    | 1 |

Figure 53 — CRC data bit mapping for x8 devices (BC4)

For a x8 SDRAM, the CRC tree inputs are 36 bits as shown in the figure above. The input bits d(64:67) are used if DBI or DM functions are enabled. If DBI and DM are disabled then d(64:67) are “1”

##### CRC data bit mapping for x16 devices (BC4)

The following figure shows detailed bit mapping for a x16 device.

|        | Transfer |      |      |      |   |   |   |   |       |   |
|--------|----------|------|------|------|---|---|---|---|-------|---|
|        | 0        | 1    | 2    | 3    | 4 | 5 | 6 | 7 | 8     | 9 |
| DQ0    | d0       | d1   | d2   | d3   | 1 | 1 | 1 | 1 | CRC0  | 1 |
| DQ1    | d8       | d9   | d10  | d11  | 1 | 1 | 1 | 1 | CRC1  | 1 |
| DQ2    | d16      | d17  | d18  | d19  | 1 | 1 | 1 | 1 | CRC2  | 1 |
| DQ3    | d24      | d25  | d26  | d27  | 1 | 1 | 1 | 1 | CRC3  | 1 |
| DQ4    | d32      | d33  | d34  | d35  | 1 | 1 | 1 | 1 | CRC4  | 1 |
| DQ5    | d40      | d41  | d42  | d43  | 1 | 1 | 1 | 1 | CRC5  | 1 |
| DQ6    | d48      | d49  | d50  | d51  | 1 | 1 | 1 | 1 | CRC6  | 1 |
| DQ7    | d56      | d57  | d58  | d59  | 1 | 1 | 1 | 1 | CRC7  | 1 |
| DML_n  | d64      |      |      |      |   | 1 | 1 | 1 | 1     | 1 |
| DBIL_n | d65      |      |      |      |   | 1 | 1 | 1 | 1     | 1 |
| DQ8    | d72      | d73  | d74  | d75  | 1 | 1 | 1 | 1 | CRC8  | 1 |
| DQ9    | d80      | d81  | d82  | d83  | 1 | 1 | 1 | 1 | CRC9  | 1 |
| DQ10   | d88      | d89  | d90  | d91  | 1 | 1 | 1 | 1 | CRC10 | 1 |
| DQ11   | d96      | d97  | d98  | d99  | 1 | 1 | 1 | 1 | CRC11 | 1 |
| DQ12   | d104     | d105 | d106 | d107 | 1 | 1 | 1 | 1 | CRC12 | 1 |
| DQ13   | d112     | d113 | d114 | d115 | 1 | 1 | 1 | 1 | CRC13 | 1 |
| DQ14   | d120     | d121 | d122 | d123 | 1 | 1 | 1 | 1 | CRC14 | 1 |
| DQ15   | d128     | d129 | d130 | d131 | 1 | 1 | 1 | 1 | CRC15 | 1 |
| DMU_n  | d136     |      |      |      |   | 1 | 1 | 1 | 1     | 1 |
| DBIU_n | d137     |      |      |      |   | 1 | 1 | 1 | 1     | 1 |

Figure 54 — CRC data bit mapping for x16 devices (BC4)

#### 4.16.7 CRC Frame format with BC4 (cont'd)

For a x16 SDRAM there are two identical CRC trees.

The lower CRC tree inputs has 36 bits as shown in the figure above. The input bits d(64:67) are used if DBI or DM functions are enabled. If DBI and DM are disabled then d(64:67) are "1".

The upper CRC tree inputs has 36 bits as shown in the figure above. The input bits d(136:139) are used if DBI or DM functions are enabled. If DBI and DM are disabled then d(136:139) are "1".

##### DBI and CRC clarification

Write operation: The SDRAM computes the CRC for received data d(71:0). Data is not inverted based on DBI before it is used for computing CRC. The data is inverted based on DBI before it is written to the DRAM core.

##### Burst Ordering with BC4 and CRC enabled

If CRC is enabled then address bit A2 is used to transfer critical data first for BC4 writes.

A x8 SDRAM is used as an example with DBI enabled.

The following figure shows data frame with A2=0.

| Transfer      |     |     |     |     |   |   |   |   |      |   |
|---------------|-----|-----|-----|-----|---|---|---|---|------|---|
|               | 0   | 1   | 2   | 3   | 4 | 5 | 6 | 7 | 8    | 9 |
| DQ0           | d0  | d1  | d2  | d3  | 1 | 1 | 1 | 1 | CRC0 | 1 |
| DQ1           | d8  | d9  | d10 | d11 | 1 | 1 | 1 | 1 | CRC1 | 1 |
| DQ2           | d16 | d17 | d18 | d19 | 1 | 1 | 1 | 1 | CRC2 | 1 |
| DQ3           | d24 | d25 | d26 | d27 | 1 | 1 | 1 | 1 | CRC3 | 1 |
| DQ4           | d32 | d33 | d34 | d35 | 1 | 1 | 1 | 1 | CRC4 | 1 |
| DQ5           | d40 | d41 | d42 | d43 | 1 | 1 | 1 | 1 | CRC5 | 1 |
| DQ6           | d48 | d49 | d50 | d51 | 1 | 1 | 1 | 1 | CRC6 | 1 |
| DQ7           | d56 | d57 | d58 | d59 | 1 | 1 | 1 | 1 | CRC7 | 1 |
| DM_n<br>DBI_n | d64 | d65 | d66 | d67 | 1 | 1 | 1 | 1 | 1    | 1 |

Figure 55 — Data Frame with A2=0

The following figure shows data frame with A2=1.

| Transfer      |     |     |     |     |   |   |   |   |      |   |
|---------------|-----|-----|-----|-----|---|---|---|---|------|---|
|               | 0   | 1   | 2   | 3   | 4 | 5 | 6 | 7 | 8    | 9 |
| DQ0           | d4  | d5  | d6  | d7  | 1 | 1 | 1 | 1 | CRC0 | 1 |
| DQ1           | d12 | d13 | d14 | d15 | 1 | 1 | 1 | 1 | CRC1 | 1 |
| DQ2           | d20 | d21 | d22 | d23 | 1 | 1 | 1 | 1 | CRC2 | 1 |
| DQ3           | d28 | d29 | d30 | d31 | 1 | 1 | 1 | 1 | CRC3 | 1 |
| DQ4           | d36 | d37 | d38 | d39 | 1 | 1 | 1 | 1 | CRC4 | 1 |
| DQ5           | d44 | d45 | d46 | d47 | 1 | 1 | 1 | 1 | CRC5 | 1 |
| DQ6           | d52 | d53 | d54 | d55 | 1 | 1 | 1 | 1 | CRC6 | 1 |
| DQ7           | d60 | d61 | d62 | d63 | 1 | 1 | 1 | 1 | CRC7 | 1 |
| DM_n<br>DBI_n | d68 | d69 | d70 | d71 | 1 | 1 | 1 | 1 | 1    | 1 |

Figure 56 — data frame with A2=1

#### 4.16.7 CRC Frame format with BC4 (cont'd)

If A2=1 then the data input to the CRC tree are 36 bits as shown above. Data bits d(4:7) are used as inputs for d(0:3), d(12:15) are used as inputs to d(8:11) and so forth for the CRC tree.

The input bits d(68:71) are used if DBI or DM functions are enabled. If DBI and DM are disabled then d(68:71) are "1"s. If A2=1 then data bits d(68:71) are used as inputs for d(64:67)

The CRC tree will treat the 36 bits in transfer's four through seven as 1's

CRC equations for x8 device in BC4 mode with A2=0 are as follows:

```

CRC[0] = D[69]=1 ^ D[68]=1 ^ D[67] ^ D[66] ^ D[64] ^ D[63]=1 ^ D[60]=1 ^ D[56] ^ D[54]=1 ^ D[53]=1 ^ D[52]=1 ^ D[50] ^ D[49] ^
D[48] ^ D[45]=1 ^ D[43] ^ D[40] ^ D[39]=1 ^ D[35] ^ D[34] ^ D[31]=1 ^
D[30]=1 ^ D[28]=1 ^ D[23]=1 ^ D[21]=1 ^ D[19] ^
D[18] ^ D[16] ^ D[14]=1 ^ D[12]=1 ^ D[8] ^ D[7]=1 ^ D[6] =1 ^ D[0];
CRC[1] = D[70]=1 ^ D[66] ^ D[65] ^ D[63]=1 ^ D[61]=1 ^ D[60]=1 ^ D[57] ^ D[56] ^ D[55]=1 ^ D[52]=1 ^ D[51] ^ D[48] ^ D[46]=1 ^
D[45]=1 ^ D[44]=1 ^ D[43] ^ D[41] ^ D[39]=1 ^ D[36]=1 ^ D[34] ^ D[32] ^
D[30]=1 ^ D[29]=1 ^ D[28]=1 ^ D[24] ^ D[23]=1 ^
D[22]=1 ^ D[21]=1 ^ D[20]=1 ^ D[18] ^ D[17] ^ D[16] ^ D[15]=1 ^ D[14]=1 ^ D[13]=1 ^ D[12]=1 ^ D[9] ^ D[6]=1 ^ D[1] ^ D[0];
CRC[2] = D[71]=1 ^ D[69]=1 ^ D[68]=1 ^ D[63]=1 ^ D[62]=1 ^ D[61]=1 ^ D[60]=1 ^ D[58] ^ D[57] ^ D[54]=1 ^ D[50] ^ D[48] ^
D[47]=1 ^ D[46]=1 ^ D[44]=1 ^ D[43] ^ D[42] ^ D[39]=1 ^ D[37]=1 ^ D[34] ^ D[33] ^
D[29]=1 ^ D[28]=1 ^ D[25] ^ D[24] ^ D[22]=1 ^ D[17] ^ D[15]=1 ^ D[13]=1 ^ D[12]=1 ^ D[10] ^ D[8] ^ D[6]=1 ^ D[2] ^ D[1] ^
D[0];
CRC[3] = D[70]=1 ^ D[69]=1 ^ D[64] ^ D[63]=1 ^ D[62]=1 ^ D[61]=1 ^ D[59] ^ D[58] ^ D[55]=1 ^ D[51] ^ D[49] ^ D[48] ^ D[47]=1 ^
D[45]=1 ^ D[44]=1 ^ D[43] ^ D[40] ^ D[38]=1 ^ D[35] ^ D[34] ^ D[30]=1 ^
D[29]=1 ^ D[26] ^ D[25] ^ D[23]=1 ^ D[18] ^
D[16] ^ D[14]=1 ^ D[13]=1 ^ D[11] ^ D[9] ^ D[7]=1 ^ D[3] ^ D[2] ^ D[1];
CRC[4] = D[71]=1 ^ D[70]=1 ^ D[65] ^ D[64] ^ D[63]=1 ^ D[62]=1 ^ D[60]=1 ^ D[59] ^ D[56] ^ D[52]=1 ^ D[50] ^ D[49] ^ D[48] ^
D[46]=1 ^ D[45]=1 ^ D[44]=1 ^ D[41] ^ D[39]=1 ^ D[36]=1 ^ D[35] ^ D[31]=1 ^
D[30]=1 ^ D[27] ^ D[26] ^ D[24] ^ D[19] ^ D[17] ^ D[15]=1 ^ D[14]=1 ^ D[12]=1 ^ D[10] ^ D[8] ^ D[4]=1 ^ D[3] ^ D[2];
CRC[5] = D[71]=1 ^ D[66] ^ D[65] ^ D[64] ^ D[63]=1 ^ D[61]=1 ^ D[60]=1 ^ D[57] ^ D[53]=1 ^ D[51] ^ D[50] ^ D[49] ^ D[47]=1 ^
D[46]=1 ^ D[45]=1 ^ D[42] ^ D[40] ^ D[37]=1 ^ D[36]=1 ^ D[32] ^ D[31]=1 ^
D[28]=1 ^ D[27] ^ D[25] ^ D[20]=1 ^ D[18] ^
D[16] ^ D[15]=1 ^ D[13]=1 ^ D[11] ^ D[9] ^ D[5]=1 ^ D[4]=1 ^ D[3];
CRC[6] = D[67] ^ D[66] ^ D[65] ^ D[64] ^ D[62]=1 ^ D[61]=1 ^ D[58] ^ D[54]=1 ^ D[52]=1 ^ D[51] ^ D[50] ^ D[48] ^ D[47]=1 ^
D[46]=1 ^ D[43] ^ D[41] ^ D[38]=1 ^ D[37]=1 ^ D[33] ^ D[32] ^ D[29]=1 ^
D[28]=1 ^ D[26] ^ D[21]=1 ^ D[19] ^ D[17] ^
D[16] ^ D[14]=1 ^ D[12]=1 ^ D[10] ^ D[6]=1 ^ D[5]=1 ^ D[4]=1;
CRC[7] = D[68]=1 ^ D[67] ^ D[66] ^ D[65] ^ D[63]=1 ^ D[62]=1 ^ D[59] ^ D[55]=1 ^ D[53]=1 ^ D[52]=1 ^ D[51] ^ D[49] ^ D[48] ^
D[47]=1 ^ D[44]=1 ^ D[42] ^ D[39]=1 ^ D[38]=1 ^ D[34] ^ D[33] ^ D[30]=1 ^
D[29]=1 ^ D[27] ^ D[22]=1 ^ D[20]=1 ^ D[18] ^
D[17] ^ D[15]=1 ^ D[13]=1 ^ D[11] ^ D[7]=1 ^ D[6]=1 ^ D[5]=1;

```

CRC equations for x8 device in BC4 mode with A2=1 are as follows:

```

CRC[0] = 1 ^ 1 ^ D[71] ^ D[70] ^ D[68] ^ 1 ^ 1 ^ D[60] ^ 1 ^ 1 ^ 1 ^ D[54] ^ D[53] ^ D[52] ^ 1 ^ D[47] ^ D[44] ^ 1 ^ D[39] ^ D[38] ^
1^ 1 ^ 1 ^ 1 ^ D[23] ^ D[22] ^ D[20] ^ 1 ^ 1 ^ D[12] ^ 1 ^ 1 ^ D[4];
CRC[1] = 1 ^ D[70] ^ D[69] ^ 1 ^ 1 ^ 1 ^ D[61] ^ D[60] ^ 1 ^ 1 ^ D[55] ^ D[52] ^ 1 ^ 1 ^ 1 ^ D[47] ^ D[45] ^ 1 ^ 1 ^ D[38] ^ D[36] ^ 1 ^
1 ^ 1 ^ D[28] ^ 1 ^ 1 ^ 1 ^ 1 ^ D[22] ^ D[21] ^ D[20] ^ 1 ^ 1 ^ 1 ^ 1 ^ D[13] ^ 1 ^ 1 ^ D[5] ^ D[4];
CRC[2] = 1 ^ 1 ^ 1 ^ 1 ^ 1 ^ 1 ^ 1 ^ D[62] ^ D[61] ^ 1 ^ D[54] ^ D[52] ^ 1 ^ 1 ^ 1 ^ D[47] ^ D[46] ^ 1 ^ 1 ^ 1 ^ D[38] ^ D[37] ^ 1 ^ 1 ^ D[29] ^
D[28] ^ 1 ^ 1 ^ D[21] ^ 1 ^ 1 ^ 1 ^ D[14] ^ D[12] ^ 1 ^ D[6] ^ D[5] ^ D[4];
CRC[3] = 1 ^ 1 ^ D[68] ^ 1 ^ 1 ^ 1 ^ D[63] ^ D[62] ^ 1 ^ D[55] ^ D[53] ^ D[52] ^ 1 ^ 1 ^ 1 ^ D[47] ^ D[44] ^ 1 ^ 1 ^ D[39] ^ D[38] ^ 1 ^ 1 ^
D[30] ^ D[29] ^ 1 ^ 1 ^ D[22] ^ D[20] ^ 1 ^ 1 ^ D[15] ^ D[13] ^ 1 ^ D[7] ^ D[6] ^ D[5];
CRC[4] = 1 ^ 1 ^ D[69] ^ D[68] ^ 1 ^ 1 ^ 1 ^ D[63] ^ D[60] ^ 1 ^ D[54] ^ D[53] ^ D[52] ^ 1 ^ 1 ^ 1 ^ D[45] ^ 1 ^ 1 ^ D[39] ^ 1 ^ 1 ^ D[31] ^
D[30] ^ D[28] ^ D[23] ^ D[21] ^ 1 ^ 1 ^ 1 ^ D[14] ^ D[12] ^ 1 ^ D[7] ^ D[6];
CRC[5] = 1 ^ D[70] ^ D[69] ^ D[68] ^ 1 ^ 1 ^ 1 ^ D[61] ^ 1 ^ D[55] ^ D[54] ^ D[53] ^ 1 ^ 1 ^ 1 ^ D[46] ^ D[44] ^ 1 ^ 1 ^ D[36] ^ 1 ^ 1 ^ 1 ^
D[31] ^ D[29] ^ 1 ^ 1 ^ D[22] ^ D[20] ^ 1 ^ 1 ^ D[15] ^ D[13] ^ 1 ^ 1 ^ D[7];
CRC[6] = D[71] ^ D[70] ^ D[69] ^ D[68] ^ 1 ^ 1 ^ 1 ^ D[62] ^ 1 ^ 1 ^ D[55] ^ D[54] ^ D[52] ^ 1 ^ 1 ^ 1 ^ D[47] ^ D[45] ^ 1 ^ 1 ^ 1 ^ D[37] ^ D[36] ^
1 ^ 1 ^ D[30] ^ 1 ^ 1 ^ D[23] ^ D[21] ^ D[20] ^ 1 ^ 1 ^ 1 ^ D[14] ^ 1 ^ 1 ^ 1 ^ 1;
CRC[7] = 1 ^ D[71] ^ D[70] ^ D[69] ^ 1 ^ 1 ^ 1 ^ D[63] ^ 1 ^ 1 ^ 1 ^ D[55] ^ D[53] ^ D[52] ^ 1 ^ 1 ^ 1 ^ D[46] ^ 1 ^ 1 ^ 1 ^ D[38] ^ D[37] ^ 1 ^ 1 ^ 1 ^
D[31] ^ 1 ^ 1 ^ 1 ^ D[22] ^ D[21] ^ 1 ^ 1 ^ D[15] ^ 1 ^ 1 ^ 1 ^ 1;

```

#### 4.16.8 Simultaneous DM and CRC Functionality

When both DM and Write CRC are enabled in the DRAM mode register, the DRAM calculates CRC before sending the write data into the array. If there is a CRC error, the DRAM blocks the write operation and discards the data. For a x16, when the DRAM detects an error in CRC tree, DDR4 DRAMs may mask all DQs or half the DQs depending upon the specific vendor implementation behavior. Both implementations are valid. For the DDR4 DRAMs that masking half the DQs, DQ0 through DQ7 will be masked if the lower byte CRC tree had the error and DQ8 through DQ15 will be masked if the upper byte CRC tree had the error.

#### 4.16.9 Simultaneous MPR Write, Per DRAM Addressability and CRC Functionality

The following combination of DDR4 features are prohibited for simultaneous operation

- 1) MPR Write and Write CRC (Note: MPR Write is via Address pins)
- 2) Per DRAM Addressability and Write CRC (Note : Only MRS are allowed during PDA and also DQ0 is used for PDA detection)

### 4.17 Command Address Parity (CA Parity)

[A2:A0] of MR5 are defined to enable or disable C/A Parity in the DRAM. The default state of the C/A Parity bits is disabled. If C/A parity is enabled by programming a non-zero value to C/A Parity Latency in the mode register (the Parity Error bit must be set to zero when enabling C/A any Parity mode), then the DRAM has to ensure that there is no parity error before executing the command. The additional delay for executing the commands versus a parity disabled mode is programmed in the mode register ( MR5, A2:A0 ) when C/A Parity is enabled (PL : Parity Latency) and is applied to commands that are latched via the rising edge of CK\_t when CS\_n is low. The command is held for the time of the Parity Latency before it is executed inside the device. This means that issuing timing of internal command is determined with PL. When C/A Parity is enabled, only DES is allowed between valid commands to prevent DRAM from any malfunctioning. CA Parity Mode is supported when DLL-on Mode is enabled, use of CA Parity Mode when DLL-off Mode is enabled is not allowed.

C/A Parity signal (PAR) covers ACT\_n, RAS\_n/A16, CAS\_n/A15, WE\_n/A14 and the address bus including bank address and bank group bits, and C0-C2 on 3DS devices. The control signals CKE, ODT and CS\_n are not included. (e.g., for a 4 Gbit x4 monolithic device, parity is computed across BG0, BG1, BA1, BA0, A16/RAS\_n, A15/CAS\_n, A14/WE\_n, A13-A0 and ACT\_n). (DRAM should internally treat any unused address pins as 0's, e.g., if a common die has stacked pins but the device is used in a monolithic application then the address pins used for stacking should internally be treated as 0's)

The convention of parity is even parity i.e., valid parity is defined as an even number of ones across the inputs used for parity computation combined with the parity signal. In other words the parity bit is chosen so that the total number of 1's in the transmitted signal, including the parity bit is even.

If a DRAM detects a C/A parity error in any command as qualified by CS\_n then it must perform the following steps:

- Ignore the erroneous command. Commands in max NnCK window (tPAR\_UNKNOWN) prior to the erroneous command are not guaranteed to be executed. When a READ command in this NnCK window is not executed, the DRAM does not activate DQS outputs.
- Log the error by storing the erroneous command and address bits in the error log. (MPR page1)
- Set the Parity Error Status bit in the mode register to '1'. The Parity Error Status bit must be set before the ALERT\_n signal is released by the DRAM (i.e., tPAR\_ALERT\_ON + tPAR\_ALERT\_PW(min)).
- Assert the ALERT\_n signal to the host (ALERT\_n is active low) within tPAR\_ALERT\_ON time.
- Wait for all in-progress commands to complete. These commands were received tPAR\_UNKNOW before the erroneous command. If a parity error occurs on a command issued between the tXS\_Fast and tXS window after self-refresh exit then the DRAM may delay the de-assertion of ALERT\_n signal as a result of any internal on going refresh. (See Figure 61)
- Wait for tRAS\_min before closing all the open pages. The DRAM is not executing any commands during the window defined by (tPAR\_ALERT\_ON + tPAR\_ALERT\_PW).
- After tPAR\_ALERT\_PW\_min has been satisfied, the DRAM may de-assert ALERT\_n.
- After the DRAM has returned to a known pre-charged state it may de-assert ALERT\_n.
- After (tPAR\_ALERT\_ON + tPAR\_ALERT\_PW), the DRAM is ready to accept commands for normal operation. Parity latency will be in effect, however, parity checking will not resume until the memory controller has cleared the Parity Error Status bit by writing a '0'(the DRAM will execute any erroneous commands until the bit is cleared).
- It is possible that the DRAM might have ignored a refresh command during the (tPAR\_ALERT\_ON + tPAR\_ALERT\_PW) window or the refresh command is the first erroneous frame so it is recommended that the controller issues extra refresh cycles as needed.

#### 4.17 Command Address Parity (CA Parity) (cont'd)

- The Parity Error Status bit may be read anytime after  $(tPAR\_ALERT\_ON + tPAR\_ALERT\_PW)$  to determine which DRAM had the error. The DRAM maintains the Error Log for the first erroneous command until the Parity Error Status bit is reset to '0'.

Mode Register for C/A Parity Error is defined as follows. C/A Parity Latency bits are write only, Parity Error Status bit is read/write and error logs are read only bits. The controller can only program the Parity Error Status bit to '0'. If the controller illegally attempts to write a '1' to the Parity Error Status bit the DRAM does not guarantee that parity will be checked. The DRAM may opt to block the controller from writing a '1' to the Parity Error Status bit.

**Table 75 — Mode Registers for C/A Parity**

| C/A Parity Latency<br>MR5[2:0]* | Speed bins     | C/A Parity Error Status<br>MR5[4] | Errant C/A Frame   |
|---------------------------------|----------------|-----------------------------------|--|
| 000 = Disabled                  | -              | 0=clear<br>1=Error                | C2-C0, ACT_n, BG1, BG0, BA0, BA1, PAR, A17, A16/RAS_n, A15/CAS_n, A14/WE_n, A13:A0 |
| 001= 4 Clocks                   | 1600,1866,2133 |                                   |  |
| 010= 5 Clocks                   | 2400           |                                   |  |
| 011= 6 Clocks                   | RFU            |                                   |  |
| 100= 8 Clocks                   | RFU            |                                   |  |

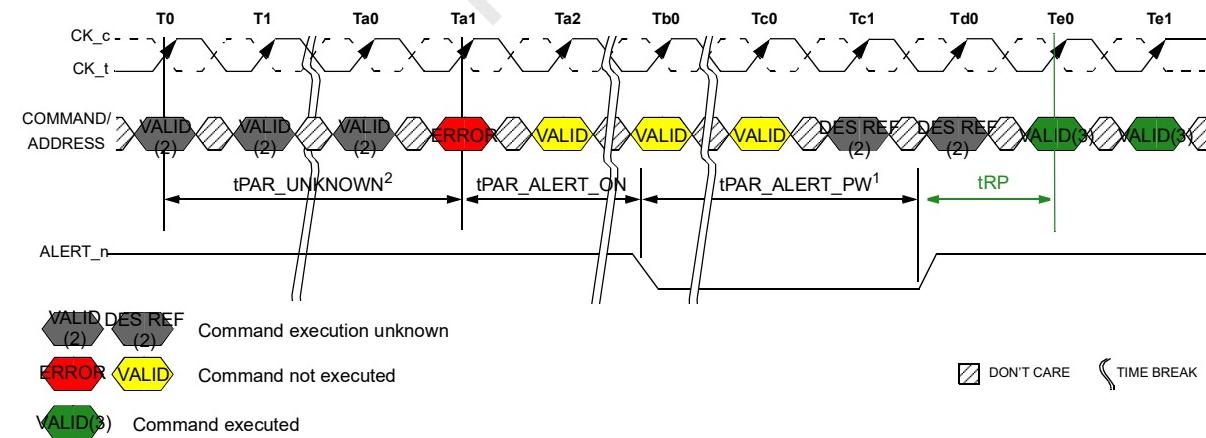
NOTE 1 Parity Latency is applied to all commands.

NOTE 2 Parity Latency can be changed only from a C/A Parity disabled state, i.e., a direct change from PL= 4 → PL= 5 is not allowed. Correct sequence is PL= 4 → Disabled → PL= 5

NOTE 3 Parity Latency is applied to write and read latency. Write Latency = AL+CWL+PL. Read Latency = AL+CL+PL.

DDR4 SDRAM supports MR bit for 'Persistent Parity Error Mode'. This mode is enabled by setting MR5 A9=High and when it is enabled, DRAM resumes checking CA Parity after the alert\_n is deasserted, even if Parity Error Status bit is set as High. If multiple errors occur before the Error Status bit is cleared the Error log in MPR page 1 should be treated as 'Don't Care'. In 'Persistent Parity Error Mode' the Alert\_n pulse will be asserted and deasserted by the DRAM as defined with the min. and max. value for tPAR\_ALERT\_PW. The controller must issue DESELECT commands once it detects the Alert\_n signal, this response time is defined as tPAR\_ALERT\_RSP

The following figure captures the flow of events on the C/A bus and the ALERT\_n signal.



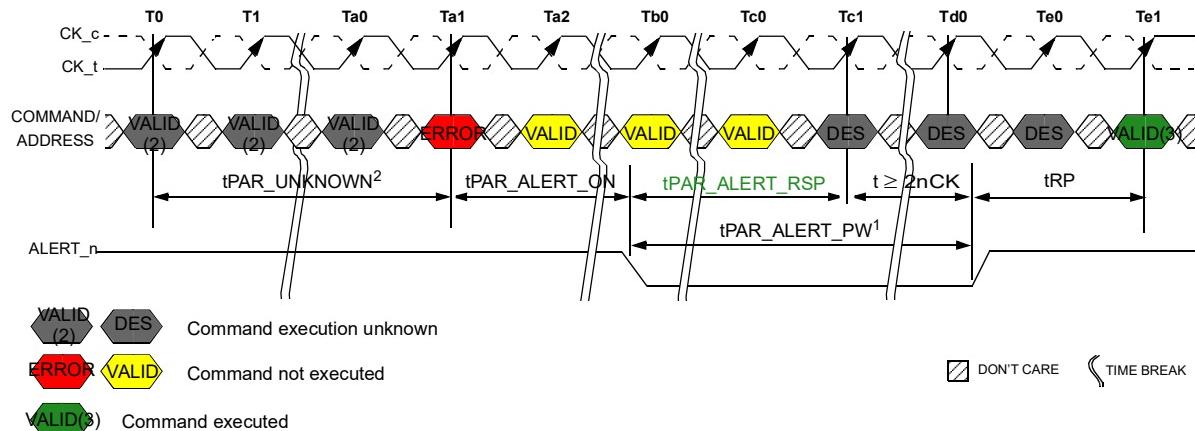
NOTE 1 DRAM is emptying queues, Precharge All and parity checking off until Parity Error Status bit cleared.

NOTE 2 Command execution is unknown the corresponding DRAM internal state change may or may not occur. The DRAM Controller should consider both cases and make sure that the command sequence meets the specifications.

NOTE 3 Normal operation with parity latency (CA Parity Persistent Error Mode disabled). Parity checking off until Parity Error Status bit cleared.

**Figure 57 — Normal CA Parity Error Checking Operation**

#### 4.17 Command Address Parity (CA Parity) (cont'd)

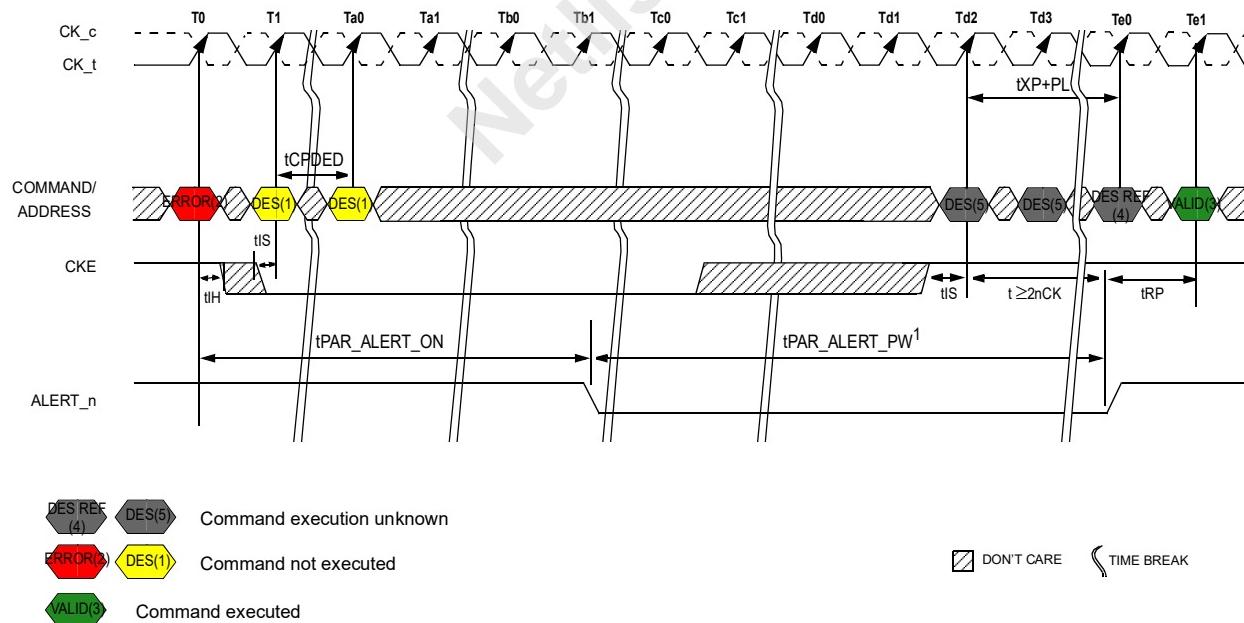


NOTE 1 DRAM is emptying queues, Precharge All and parity check re-enable finished by tPAR\_ALERT\_PW.

NOTE 2 Command execution is unknown the corresponding DRAM internal state change may or may not occur. The DRAM Controller should consider both cases and make sure that the command sequence meets the specifications.

NOTE 3 Normal operation with parity latency and parity checking (CA Parity Persistent Error Mode enabled).

**Figure 58 — Persistent CA Parity Error Checking Operation**



NOTE 1 Deselect command only allowed.

NOTE 2 Error could be Precharge or Activate.

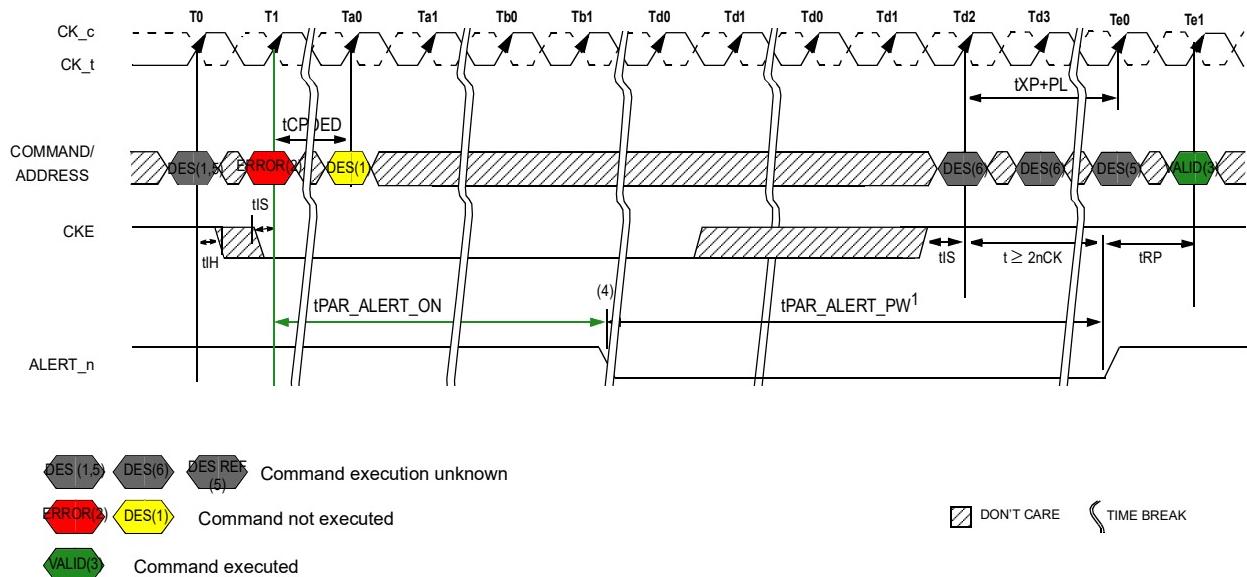
NOTE 3 Normal operation with parity latency (CA Parity Persistent Error Mode disable). Parity checking is off until Parity Error Status bit cleared.

NOTE 4 Command execution is unknown the corresponding DRAM internal state change may or may not occur. The DRAM Controller should consider both cases and make sure that the command sequence meets the specifications.

NOTE 5 Deselect command only allowed CKE may go high prior to Td2 as long as DES commands are issued.

**Figure 59 — CA Parity Error Checking - PDE/PDX**

#### 4.17 Command Address Parity (CA Parity) (cont'd)



NOTE 1 Deselect command only allowed.

NOTE 2 SelfRefresh command error. DRAM masks the intended SRE command enters Precharge Power Down.

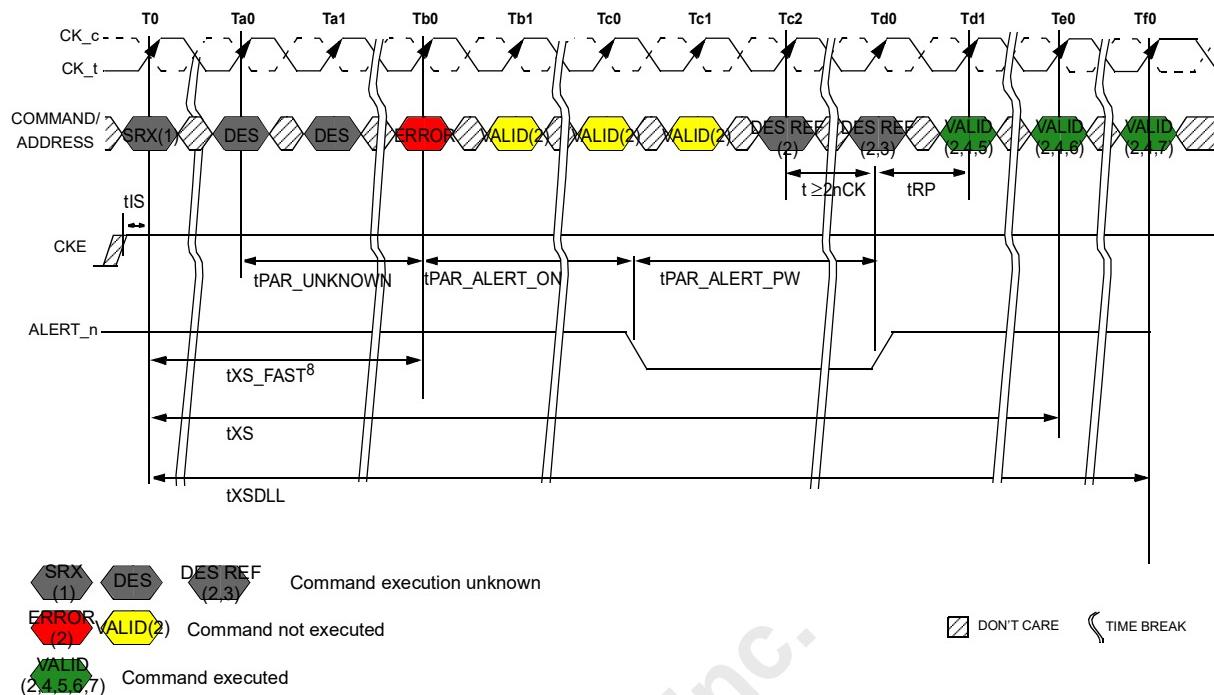
NOTE 3 Normal operation with parity latency (CA Parity Persistent Error Mode disable). Parity checking is off until Parity Error Status bit cleared.

NOTE 4 Controller can not disable clock until it has been able to have detected a possible C/A Parity error.

NOTE 5 Command execution is unknown the corresponding DRAM internal state change may or may not occur. The DRAM Controller should consider both cases and make sure that the command sequence meets the specifications.

**Figure 60 — CA Parity Error Checking - SRE Attempt**

#### 4.17 Command Address Parity (CA Parity) (cont'd)



- NOTE 1 SelfRefresh Abort = Disable : MR4 [A9=0]  
 NOTE 2 Input commands are bounded by tXSDL, tXS, tXS\_ABORT and tXS\_FAST timing.  
 NOTE 3 Command execution is unknown the corresponding DRAM internal state change may or may not occur. The DRAM Controller should consider both cases and make sure that the command sequence meets the specifications.  
 NOTE 4 Normal operation with parity latency (CA Parity Persistent Error Mode disabled). Parity checking off until Parity Error Status bit cleared.  
 NOTE 5 Only MRS (limited to those described in the Self-Refresh Operation section), ZQCS or ZQCL command allowed.  
 NOTE 6 Valid commands not requiring a locked DLL  
 NOTE 7 Valid commands requiring a locked DLL  
 NOTE 8 This figure shows the case from which the error occurred after tXS\_FAST. An error also occurs after tXS\_ABORT and tXS.

**Figure 61 — CA Parity Error Checking - SRX**

#### Command/Address parity entry and exit timings

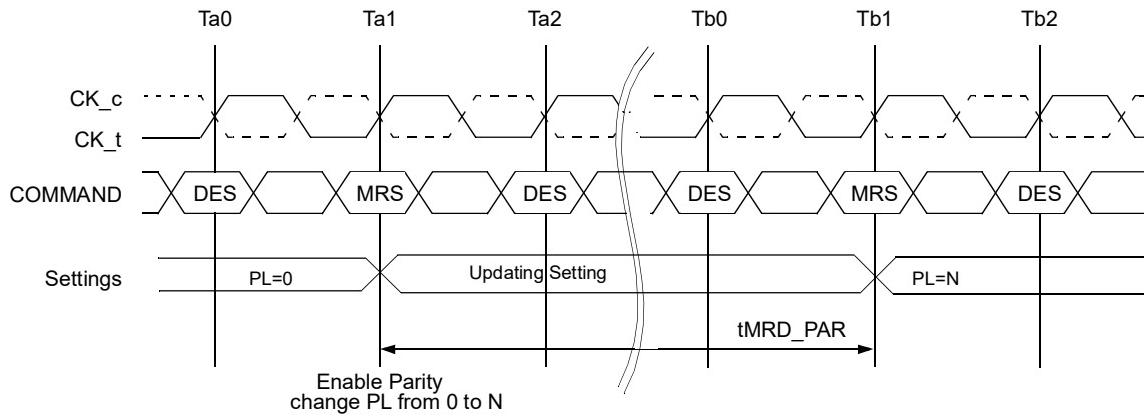
When in CA Parity mode, including entering and exiting CA Parity mode, users must wait tMRD\_PAR before issuing another MRS command, and wait tMOD\_PAR before any other commands.

$$tMOD\_PAR = tMOD + PL$$

$$tMRD\_PAR = tMOD + PL$$

For CA parity entry, PL in the equations above is the parity latency programmed with the MRS command entering CA parity mode. For CA parity exit, PL in the equations above is the programmed parity latency prior to the MRS command exiting CA parity mode.

#### 4.17 Command Address Parity (CA Parity) (cont'd)

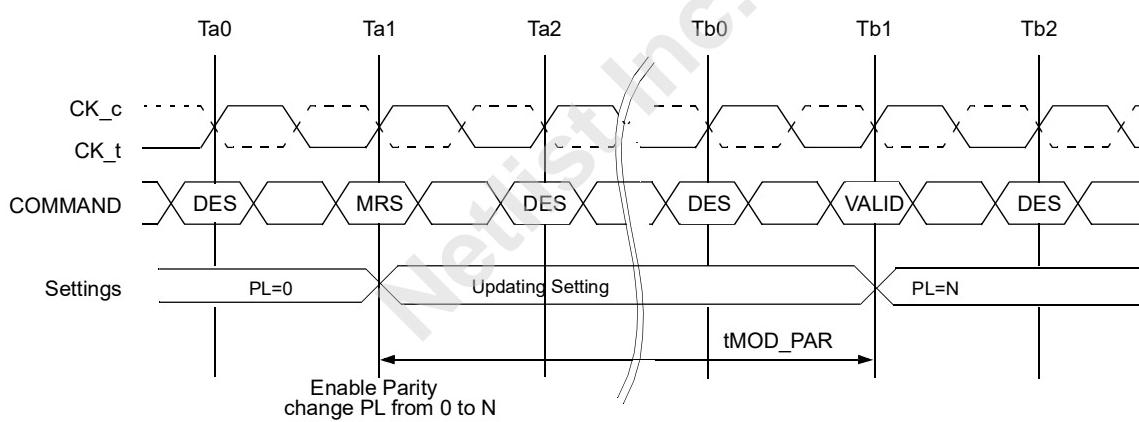


NOTE 1  $t_{MRD\_PAR} = t_{MOD} + N$ ; where  $N$  is the programmed parity latency with the MRS command entering CA parity mode.

NOTE 2 Parity check is not available at Ta1 of MRS command due to PL=0 being valid.

NOTE 3 In case parity error happens at Tb1 of MRS command,  $t_{PAR\_ALERT\_ON}$  is ' $N[nCK] + 6[ns]$ '.

**Figure 62 — Parity entry timing example - tMRD\_PAR**



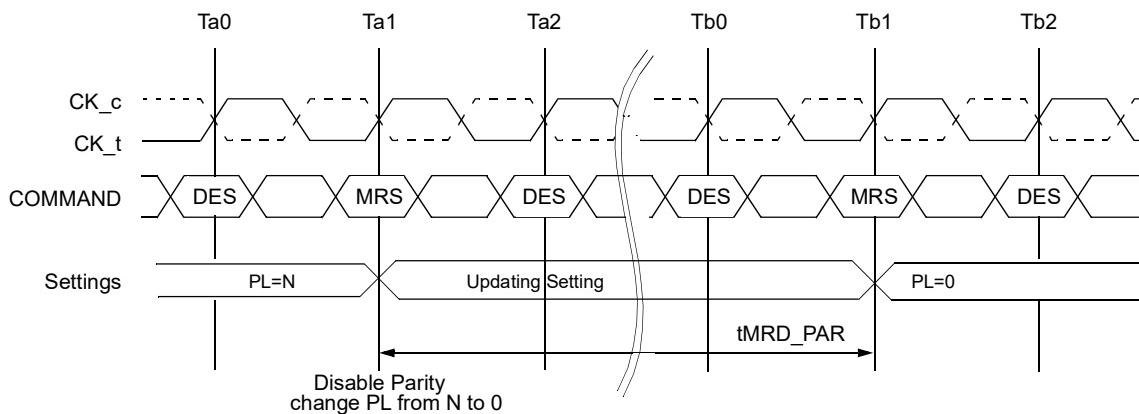
NOTE 1  $t_{MOD\_PAR} = t_{MOD} + N$ ; where  $N$  is the programmed parity latency with the MRS command entering CA parity mode.

NOTE 2 Parity check is not available at Ta1 of MRS command due to PL=0 being valid.

NOTE 3 In case parity error happens at Tb1 of VALID command,  $t_{PAR\_ALERT\_ON}$  is ' $N[nCK] + 6[ns]$ '.

**Figure 63 — Parity entry timing example - tMOD\_PAR**

#### 4.17 Command Address Parity (CA Parity) (cont'd)

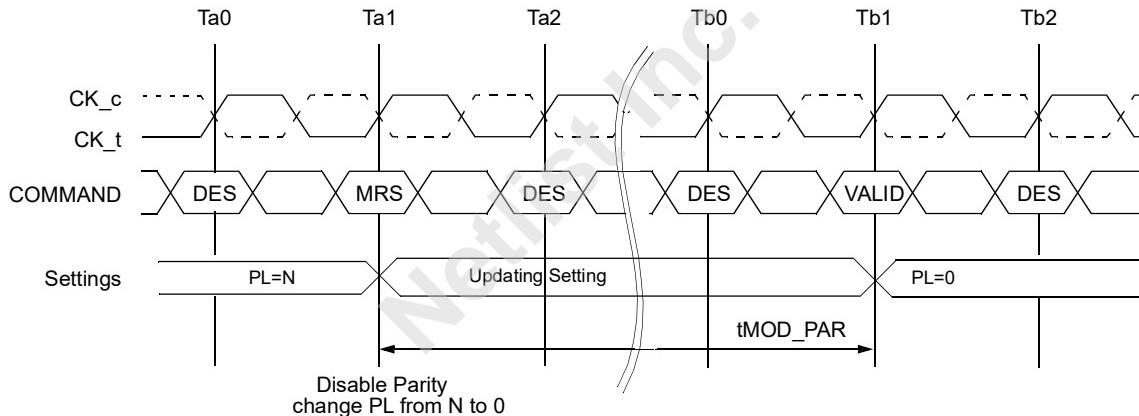


NOTE 1  $t_{MRD\_PAR} = t_{MOD} + N$ ; where  $N$  is the programmed parity latency prior to the MRS command exiting CA parity mode.

NOTE 2 In case parity error happens at Ta1 of MRS command,  $t_{PAR\_ALERT\_ON}$  is ' $N[nCK] + 6[ns]$ '.

NOTE 3 Parity check is not available at Tb1 of MRS command due to disabling parity mode.

**Figure 64 — Parity exit timing example - tMRD\_PAR**



NOTE 1  $t_{MOD\_PAR} = t_{MOD} + N$ ; where  $N$  is the programmed parity latency prior to the MRS command exiting CA parity mode.

NOTE 2 In case parity error happens at Ta1 of MRS command,  $t_{PAR\_ALERT\_ON}$  is ' $N[nCK] + 6[ns]$ '.

NOTE 3 Parity check is not available at Tb1 of VALID command due to disabling parity mode.

**Figure 65 — Parity exit timing example - tMOD\_PAR**

##### 4.17.1 CA Parity Error Log Readout

**Table 76 — MPR Mapping of CA Parity Error Log<sup>1</sup>(Page1)**

| Address       | MPR Location | [7]                 | [6]                       | [5]               | [4] | [3] | [2] | [1] | [0]           |
|---------------|--------------|---------------------|---------------------------|-------------------|-----|-----|-----|-----|---------------|
| BA1:BA0 = 0:1 | 00=MPR0      | A7                  | A6                        | A5                | A4  | A3  | A2  | A1  | A0            |
|               | 01=MPR1      | CAS_n/<br>A15       | WE_n/A14                  | A13               | A12 | A11 | A10 | A9  | A8            |
|               | 10=MPR2      | PAR                 | ACT_n                     | BG1               | BG0 | BA1 | BA0 | A17 | RAS_n/<br>A16 |
|               | 11=MPR3      | CRC Error<br>Status | CA Parity<br>Error Status | CA Parity Latency |     |     | C2  | C1  | C0            |

NOTE 1 MPR used for CA parity error log readout is enabled by setting A[2] in MR3

NOTE 2 For higher density of DRAM, where A[17] is not used, MPR2[1] should be treated as don't care.

NOTE 3 If a device is used in monolithic application, where C[2:0] are not used, then MPR3[2:0] should be treated as don't care.

## 4.18 Control Gear-down Mode

The following description represents the sequence for the gear-down mode which is specified with MR3:A3. This mode is allowed just during initialization and self refresh exit. The DRAM defaults in 1/2 rate(1N) clock mode and utilizes a low frequency MRS command followed by a sync pulse to align the proper clock edge for operating the control lines CS\_n, CKE and ODT in 1/4rate(2N) mode. For operation in 1/2 rate mode MRS command for geardown or sync pulse are not required. DRAM defaults in 1/2 rate mode.

General sequence for operation in geardown during initialization

- DRAM defaults to a 1/2 rate(1N mode) internal clock at power up/reset
- Assertion of Reset
- Assertion of CKE enables the DRAM
- MRS is accessed with a low frequency N\*tck MRS geardown CMD ( set MR3:A3 to 1 )  
Ntck static MRS command qualified by 1N CS\_n
- DRAM controller sends 1N sync pulse with a low frequency N\*tck NOP CMD  
tSYNC\_GEAR is an even number of clocks
- Sync pulse on even clock boundary from MRS CMD
- Initialization sequence, including the expiration of tDLLK and tZQinit, starts in 2N mode after tCMD\_GEAR from 1N Sync Pulse.

General sequence for operation in gear-down after self refresh exit

- DRAM reset to 1N mode during self refresh
- MRS is accessed with a low frequency N\*tck MRS gear-down CMD ( set MR3:A3 to 1 )  
Ntck static MRS command qualified by 1N CS\_n which meets tXS or tXS\_Abort
- Only Refresh command is allowed to be issued to DRAM before Ntck static MRS command
- DRAM controller sends 1N sync pulse with a low frequency N\*tck NOP CMD  
tSYNC\_GEAR is an even number of clocks
- Sync pulse is on even clock boundary from MRS CMD
- Valid command not requiring locked DLL is available in 2N mode after tCMD\_GEAR from 1N Sync Pulse.
- Valid command requiring locked DLL is available in 2N mode after tDLLK from 1N Sync Pulse

If operation is 1/2 rate(1N) mode after self refresh, no N\*tCK MRS command or sync pulse is required during self refresh exit.  
The min exit delay is tXS, or tXS\_Abort to the first valid command.

The DRAM may be changed from 1/4 rate ( 2N ) to 1/2 rate ( 1N ) by entering Self Refresh Mode, which will reset to 1N automatically. Changing from 1/4 ( 2N ) to 1/2 rate ( 1N ) by any other means, including setting MR3[A3] from 1 to 0, can result in loss of data and operation of the DRAM uncertain.

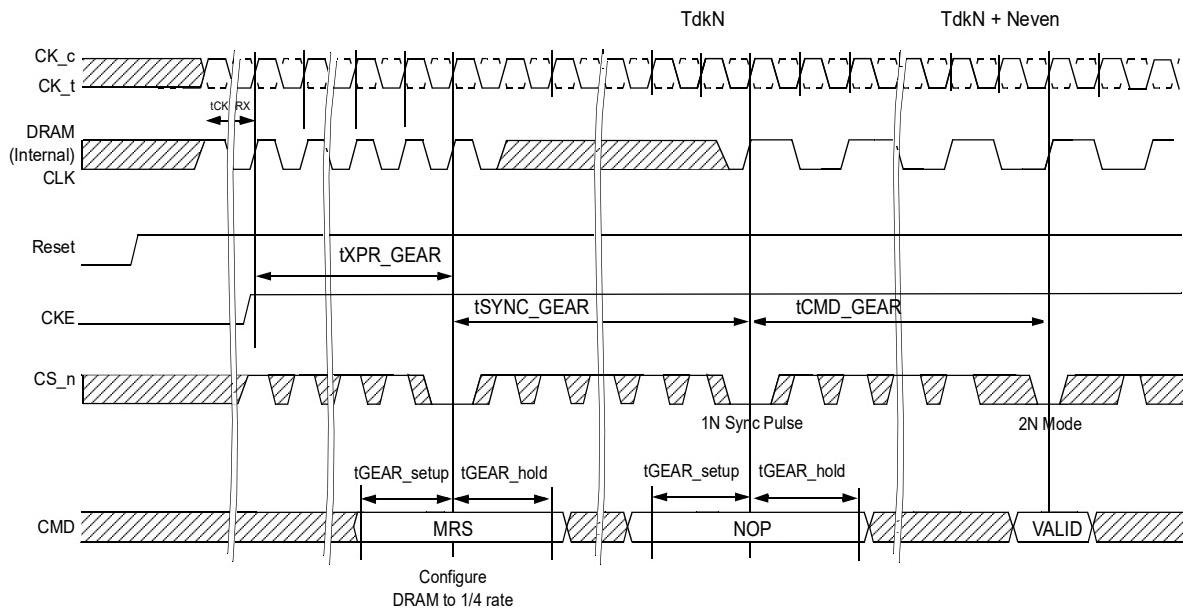
For the operation of geardown mode in 1/4 rate, the following MR settings should be applied.

- CAS Latency (MR0 A[6:4,2]) : Even number of clocks
- Write Recovery and Read to Precharge (MR0 A[11:9]) : Even number of clocks
- Additive Latency (MR1 A[4:3]) : 0, CL -2
- CAS Write Latency (MR2 A[5:3]) : Even number of clocks
- CS to Command/Address Latency Mode (MR4 A[8:6]) : Even number of clocks
- CA Parity Latency Mode (MR5 A[2:0]) : Even number of clocks

CAL or CA parity mode must be disabled prior to Gear down MRS command. They can be enabled again after tSYNC\_GEAR and tCMD\_GEAR periods are satisfied.

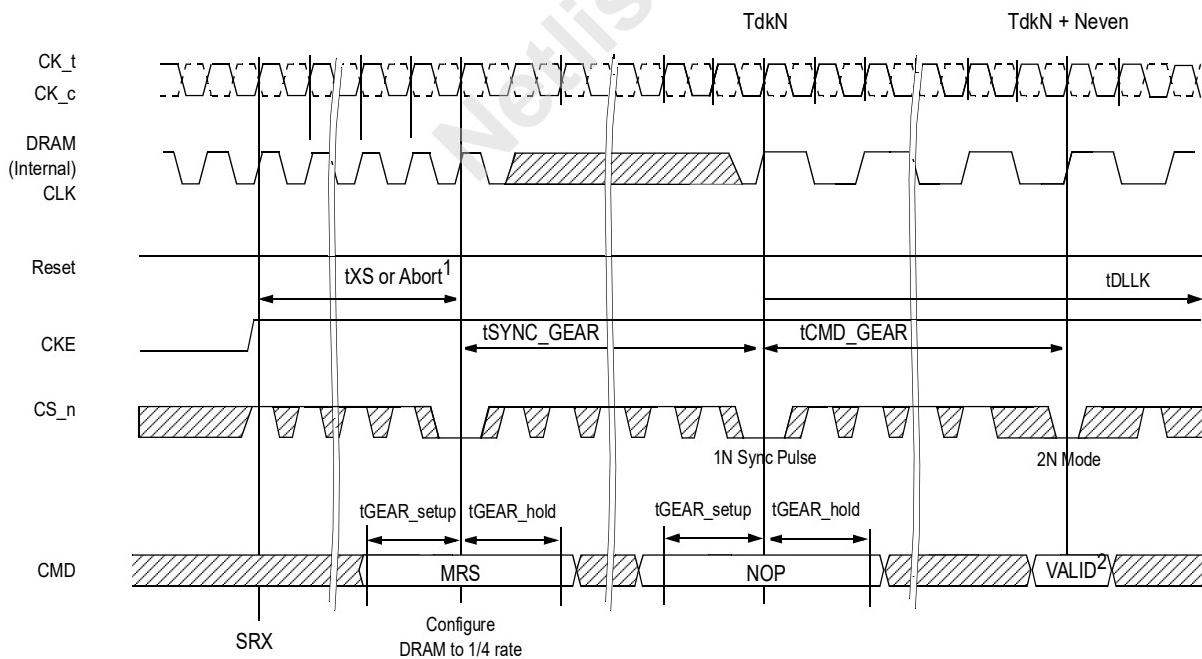
The diagram below illustrates the sequence for control operation in 2N mode during intialization.

#### 4.18 Control Gear-down Mode (cont'd)



NOTE 1 Only DES is allowed during tSYNC\_GEAR

**Figure 66 — Gear down (2N) mode entry sequence during initialization**



NOTE 1 CKE High Assert to Gear Down Enable Time (tX or tX\_Abort) depend on MR setting. A correspondence of tX/tX\_Abort and MR Setting is as follows.

- MR4[A9] = 0 : tX

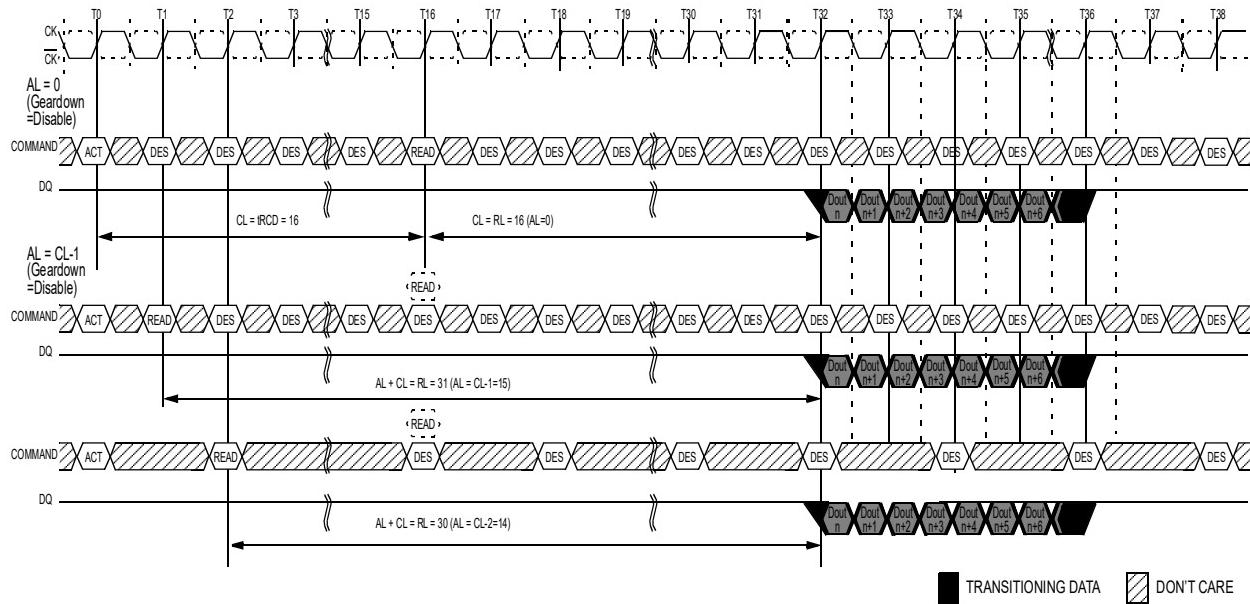
- MR4[A9] = 1 : tX\_Abort

NOTE 2 Command not requiring locked DLL

NOTE 3 Only DES is allowed during tSYNC\_GEAR

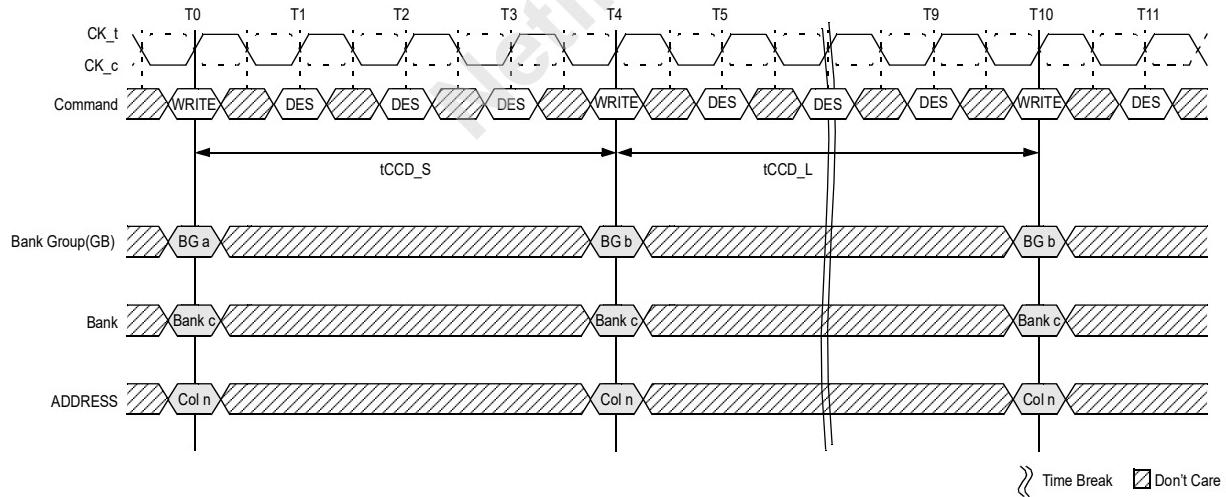
**Figure 67 — Gear down (2N) mode entry sequence after self refresh exit (SRX)**

## 4.18 Control Gear-down Mode (cont'd)

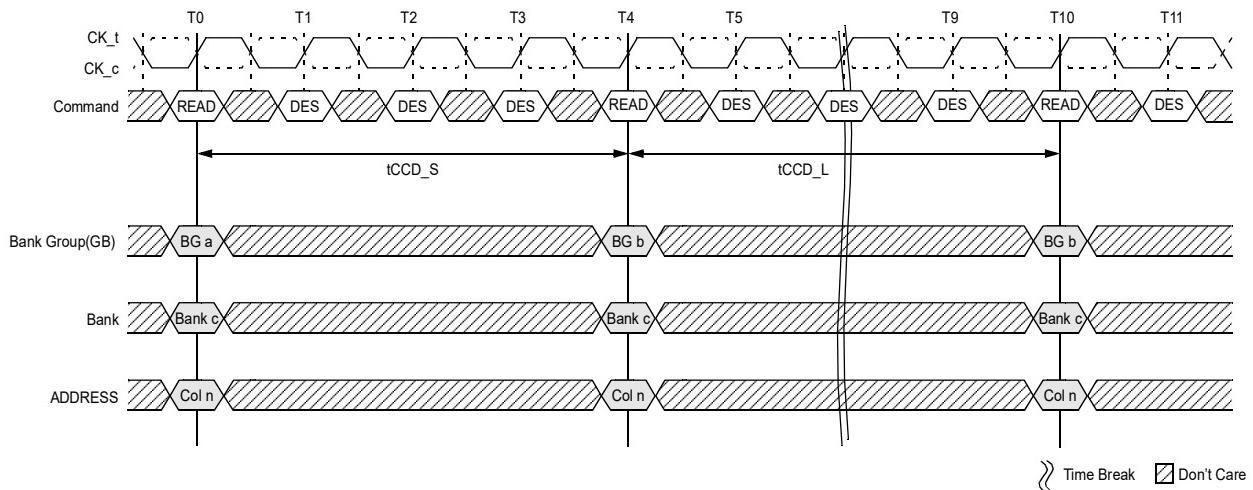
**Figure 68 — Comparison Timing Diagram Between Geardown Disable and Enable.**

## 4.19 DDR4 Key Core Timing

## DDR4, Core Timing

**Figure 69 — tCCD Timing (WRITE to WRITE Example)**

#### 4.19 DDR4 Key Core Timing (cont'd)

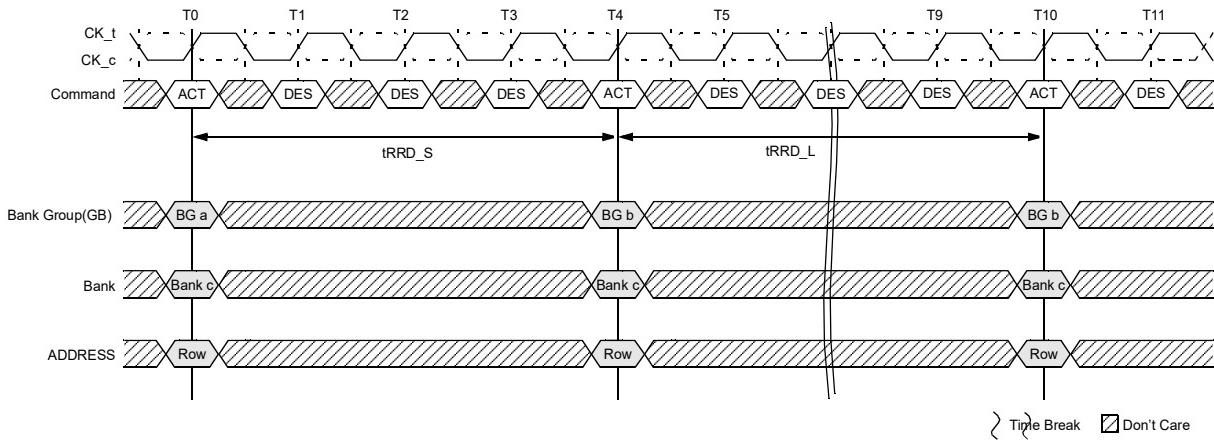


NOTE 1 tCCD\_S : CAS\_n-to-CAS\_n delay (short) : Applies to consecutive CAS\_n to different Bank Group (i.e., T0 to T4)

NOTE 2 tCCD\_L : CAS\_n-to-CAS\_n delay (long) : Applies to consecutive CAS\_n to the same Bank Group (i.e., T4 to T10)

**Figure 70 — tCCD Timing (READ to READ Example)**

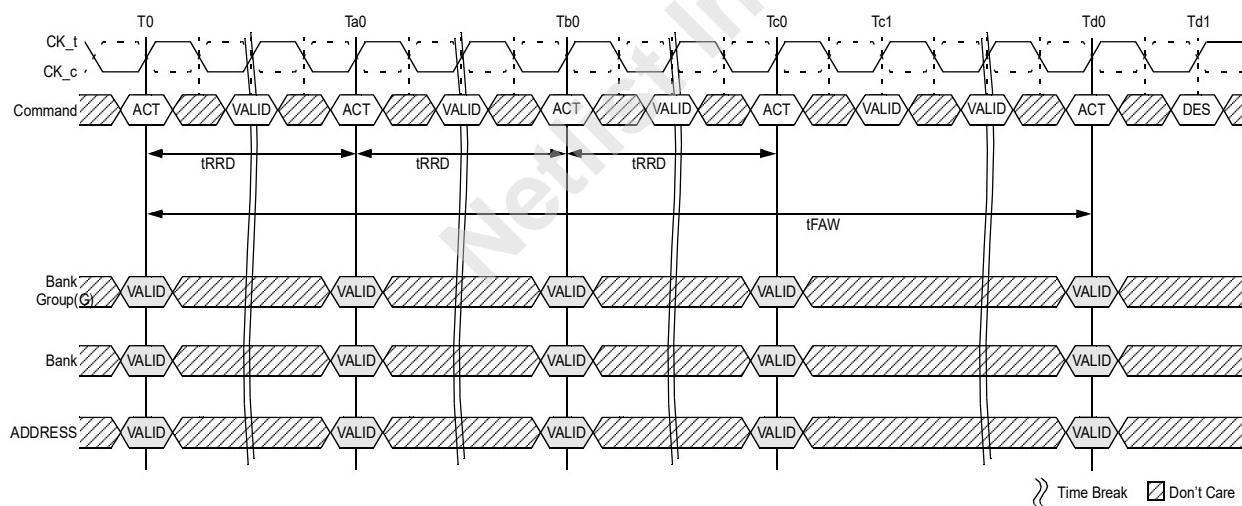
#### 4.19 DDR4 Key Core Timing (cont'd)



NOTE 1 tRRD\_S : ACTIVATE to ACTIVATE Command period (short) : Applies to consecutive ACTIVATE Commands to different Bank Group (i.e., T0 to T4)

NOTE 2 tRRD\_L : ACTIVATE to ACTIVATE Command period (long) : Applies to consecutive ACTIVATE Commands to the different Banks of the same Bank Group (i.e., T4 to T10)

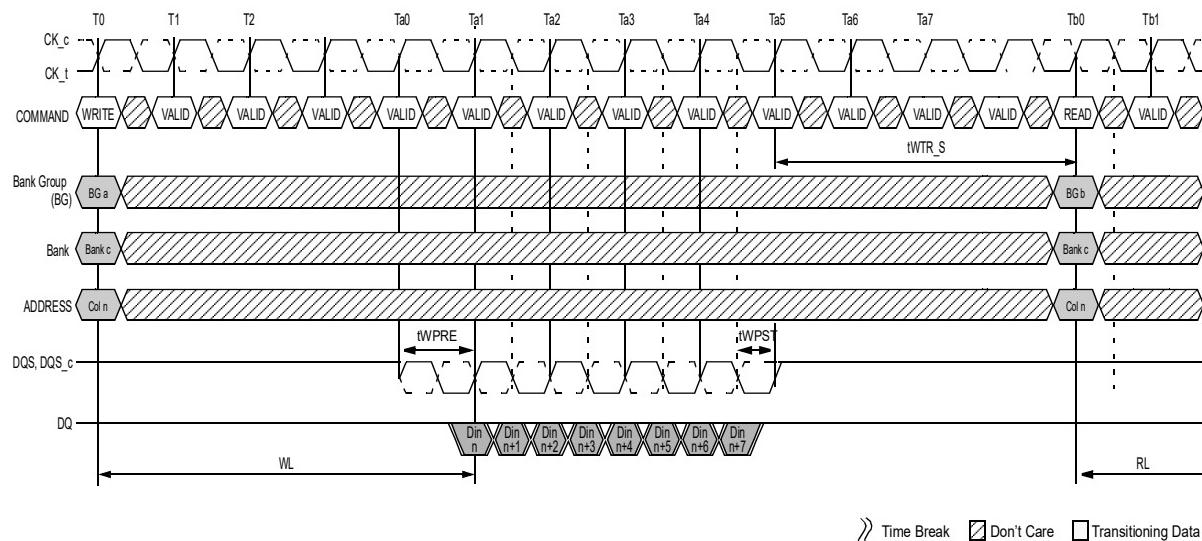
**Figure 71 — tRRD Timing**



NOTE 1 tFAW : Four activate window :

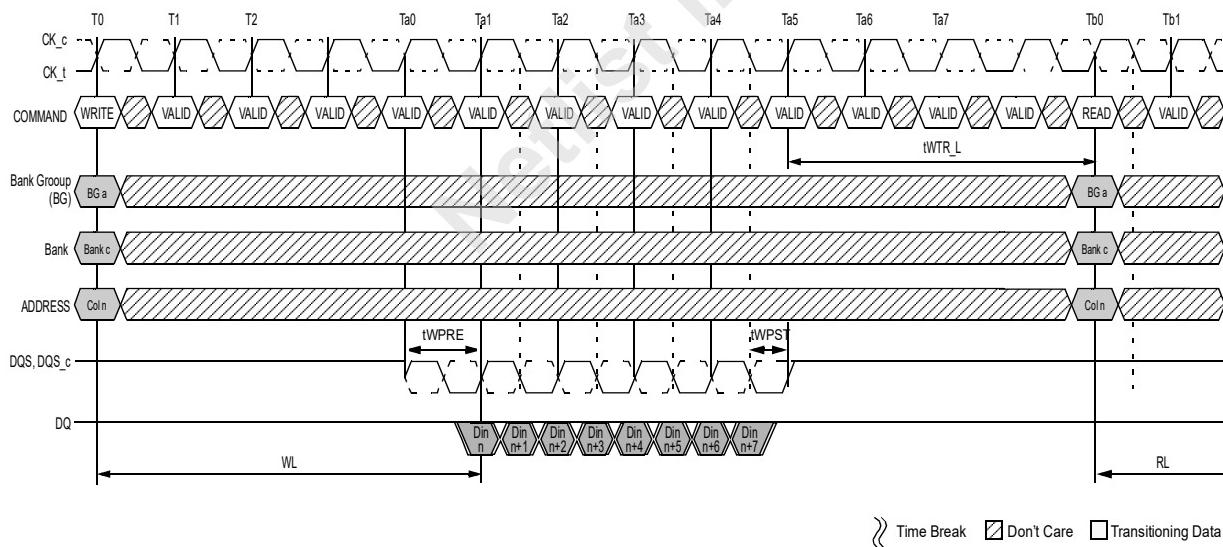
**Figure 72 — tFAW Timing**

#### 4.19 DDR4 Key Core Timing (cont'd)



NOTE 1 tWTR\_S : Delay from start of internal write transaction to internal read command to a different Bank Group.  
When AL is non-zero, the external read command at Tb0 can be pulled in by AL.

**Figure 73 — tWTR\_S Timing (WRITE to READ, Different Bank Group, CRC and DM Disabled)**



NOTE 1 tWTR\_L : Delay from start of internal write transaction to internal read command to the same Bank Group.  
When AL is non-zero, the external read command at Tb0 can be pulled in by AL.

**Figure 74 — tWTR\_L Timing (WRITE to READ, Same Bank Group, CRC and DM Disabled)**

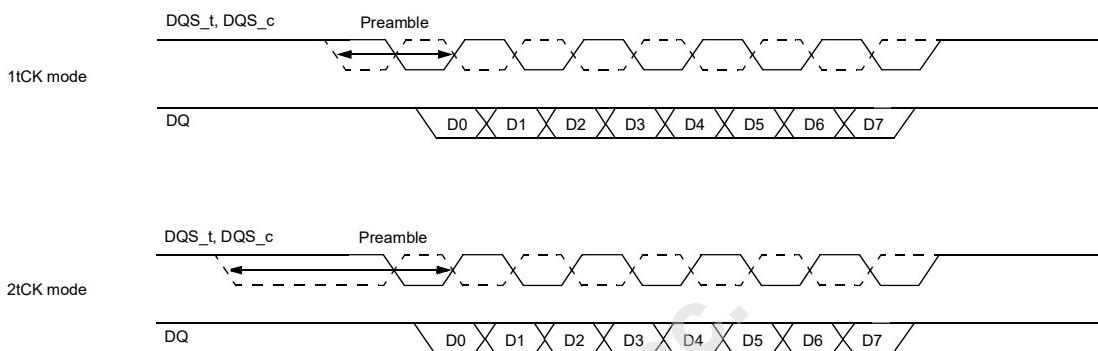
## 4.20 Programmable Preamble

The DQS preamble can be programmed to one or the other of 1 tCK and 2 tCK preamble ; selectable via MRS ( MR4 [ A12, A11] ). The 1 tCK preamble applies to all speed-Grade and The 2 tCK preamble is valid for DDR4-2400/2666/3200 Speed bin Tables.

### 4.20.1 Write Preamble

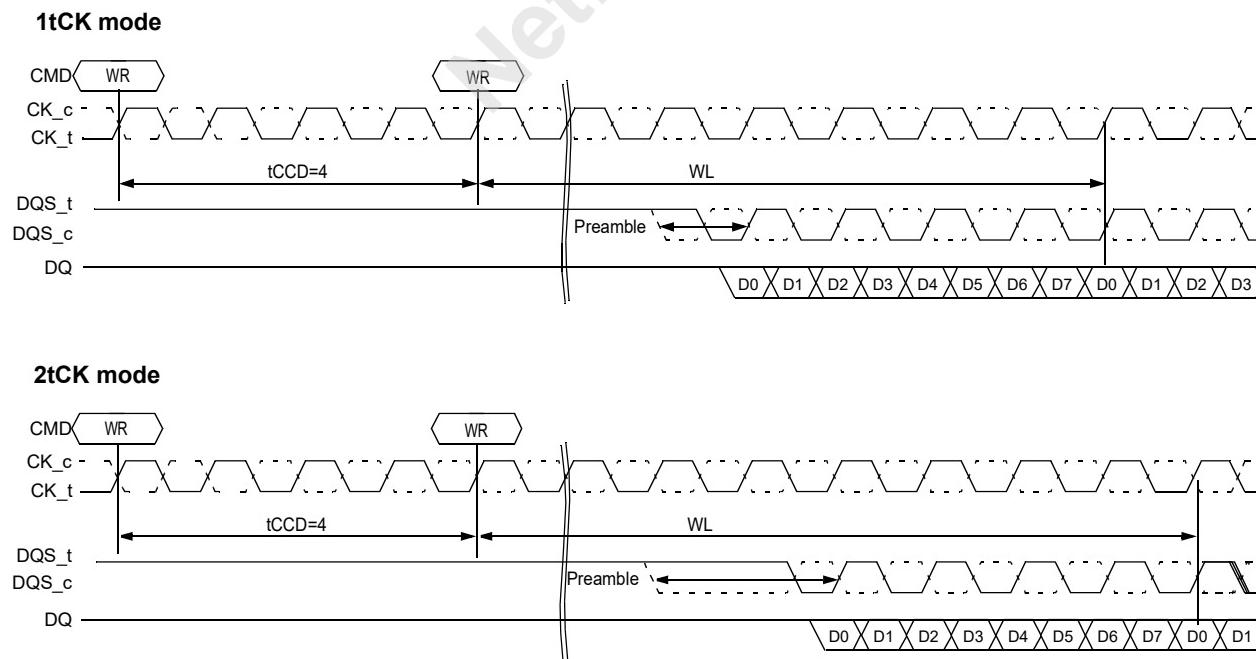
DDR4 supports a programmable write preamble. The 1 tCK or 2tCK Write Preamble is selected via MR4 [A12]. Write preamble modes of 1 tCK and 2 tCK are shown below.

When operating in 2 tCK Write preamble mode ; in MR2 Table 21, CWL of 1st Set needs to be incremented by 2 nCK and CWL of 2nd Set does not need increment of it. tWTR must be increased by one clock cycle from the tWTR required in the applicable speed bin table. WR must be programmed to a value one or two clock cycle(s), depending on available settings, greater than the WR setting required per the applicable speed bin table.



**Figure 75 — Write preamble modes of 1 tCK and 2 tCK**

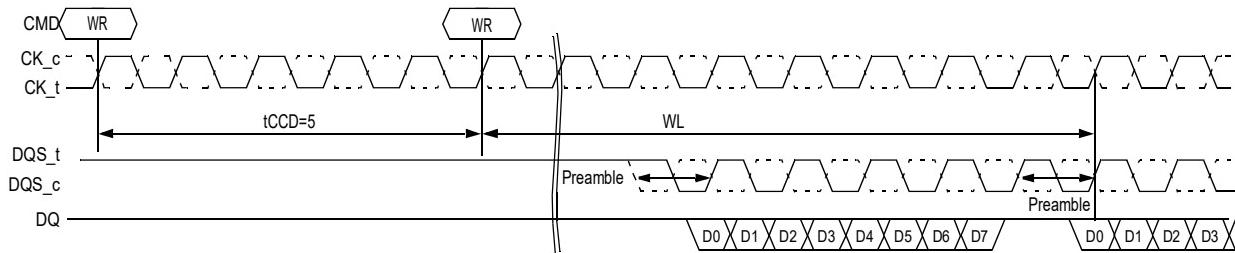
The timing diagrams contained in Figure 76, Figure 77 and Figure 78 illustrate 1 and 2 tCK preamble scenarios for consecutive write commands with tCCD timing of 4, 5 and 6 nCK, respectively. Setting tCCD to 5nCK is not allowed in 2 tCK preamble mode



**Figure 76 — tCCD=4 (AL=PL=0) of 1 tCK and 2 tCK**

#### 4.20.1 Write Preamble (cont'd)

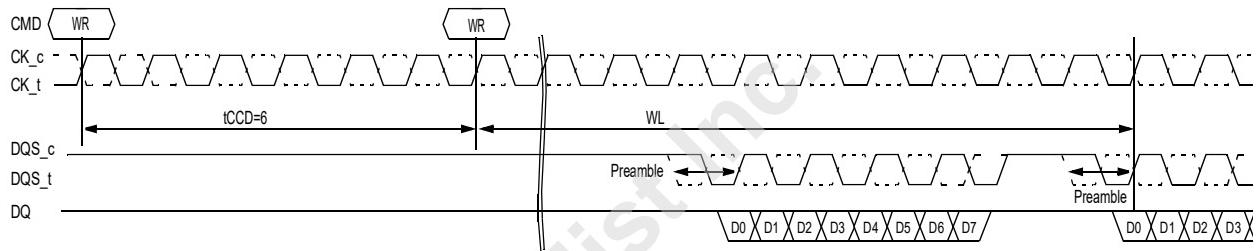
##### 1tCK mode



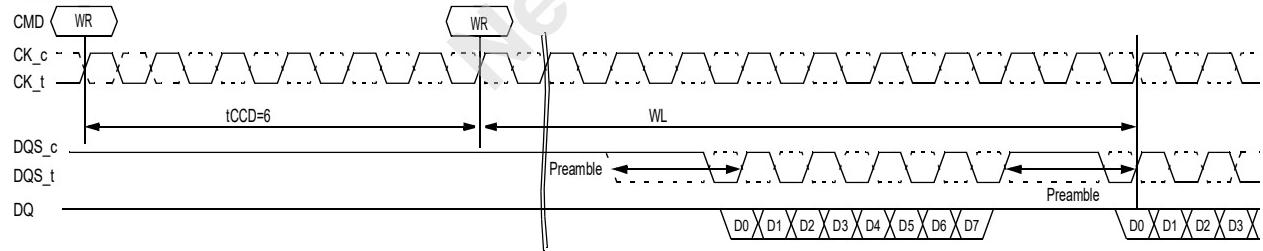
**2tCK mode:** tCCD=5 is not allowed in 2tCK mode

**Figure 77 — tCCD=5 (AL=PL=0) of 1 tCK and 2 tCK**

##### 1tCK mode



##### 2tCK mode

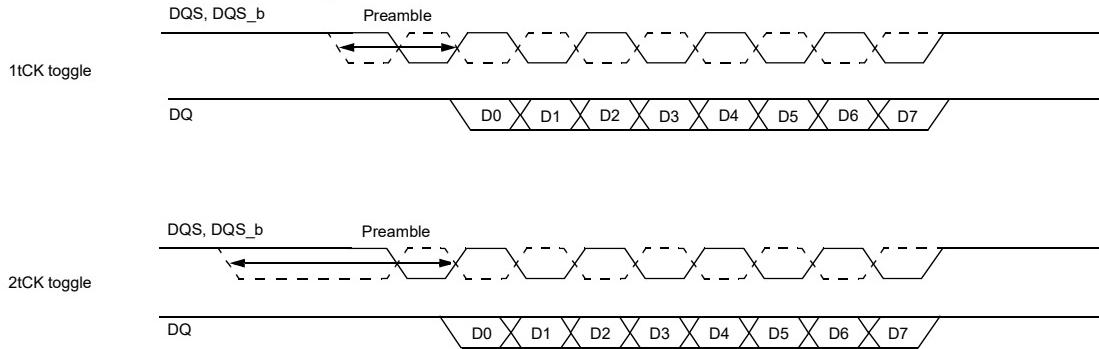


**Figure 78 — tCCD=6 (AL=PL=0) of 1 tCK and 2 tCK**

#### 4.20.2 Read Preamble

DDR4 supports a programmable read preamble. The 1 tCK and 2 tCK Read preamble is selected via MR4 [A11]. Read preamble modes of 1 tCK and 2 tCK are shown below.

#### 4.20.2 Read Preamble (cont'd)

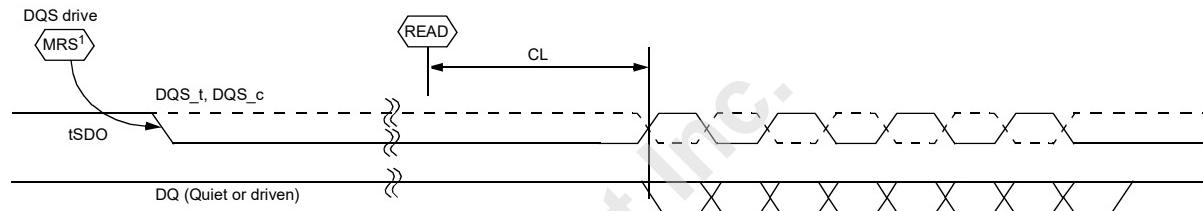


**Figure 79 — Read preamble modes of 1 tCK and 2 tCK**

#### 4.20.3 Read Preamble Training

Read Preamble Training, shown below, can be enabled via MR4 [A10] when the DRAM is in the MPR mode. Read Preamble Training is illegal if DRAM is not in the MPR mode. The Read Preamble Training can be used for read leveling.

Illegal READ commands, any command during the READ process or initiating the READS process, are not allowed during Read Preamble Training.



NOTE 1 Read Preamble Training mode is enabled by MR4 A10 = [1]

**Figure 80 — Read Preamble Training**

**Table 77 — Read Preamble Training Delay**

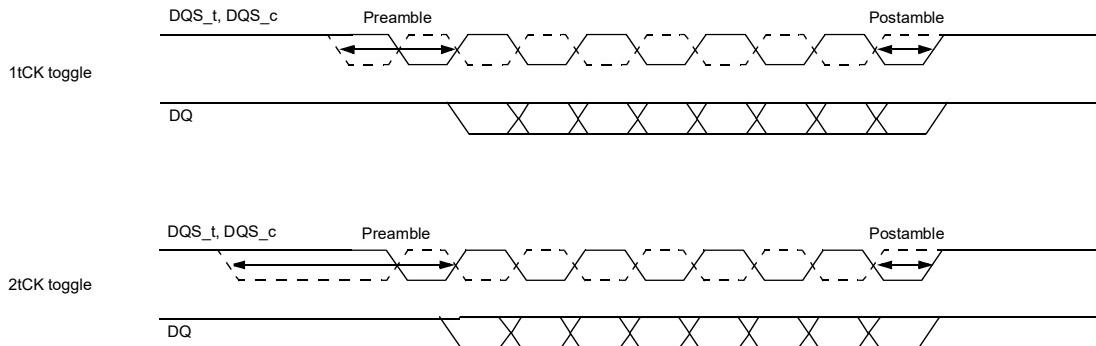
| Parameter                                       | Symbol | DDR4-1600,1866,2133,2400 |          | DDR4-2666,3200 |          | Units | NOTE |
|---|--------|--------------------------|----------|----------------|----------|-------|------|
|   |        | Min                      | Max      | Min            | Max      |       |      |
| Delay from MRS Command to Data Strobe Drive Out | tSDO   | -                        | tMOD+9ns | -              | tMOD+9ns |       |      |

#### 4.21 Postamble

##### 4.21.1 Read Postamble

DDR4 will support a fixed read postamble.

Read postamble of nominal 0.5tck for preamble modes 1,2 Tck are shown below:

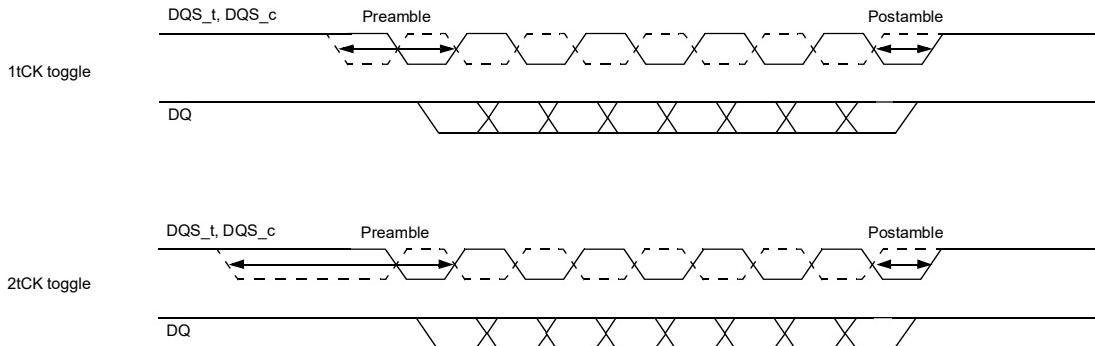


**Figure 81 — Read Postamble of 1 tCK and 2 tCK**

#### 4.21.2 Write Postamble

DDR4 will support a fixed Write postamble.

Write postamble nominal is 0.5tck for preamble modes 1,2 Tck are shown below:



**Figure 82 — Write Postamble of 1 tCK and 2 tCK**

#### 4.22 ACTIVATE Command

The ACTIVATE command is used to open (or activate) a row in a particular bank for a subsequent access. The value on the BG0-BG1 in X4/8 and BG0 in X16 select the bankgroup; BA0-BA1 inputs selects the bank within the bankgroup, and the address provided on inputs A0-A17 selects the row. This row remains active (or open) for accesses until a precharge command is issued to that bank or a precharge all command is issued. A bank must be precharged before opening a different row in the same bank.

#### 4.23 Precharge Command

The PRECHARGE command is used to deactivate the open row in a particular bank or the open row in all banks. The bank(s) will be available for a subsequent row activation a specified time (tRP) after the PRECHARGE command is issued, except in the case of concurrent auto precharge, where a READ or WRITE command to a different bank is allowed as long as it does not interrupt the data transfer in the current bank and does not violate any other timing parameters. Once a bank has been precharged, it is in the idle state and must be activated prior to any READ or WRITE commands being issued to that bank. A PRECHARGE command is allowed if there is no open row in that bank (idle state) or if the previously open row is already in the process of precharging. However, the precharge period will be determined by the last PRECHARGE command issued to the bank.

If A10 is High when Read or Write command is issued, then auto-precharge function is engaged. This feature allows the precharge operation to be partially or completely hidden during burst read cycles (dependent upon CAS latency) thus improving system performance for random data access. The RAS lockout circuit internally delays the precharge operation until the array restore operation has been completed ( tRAS satisfied ) so that the auto precharge command may be issued with any read. Auto-precharge is also implemented during Write commands. The precharge operation engaged by the Auto precharge command will not begin until the last data of the burst write sequence is properly stored in the memory array. The bank will be available for a subsequent row activation a specified time ( tRP ) after hidden PRECHARGE command ( AutoPrecharge ) is issued to that bank.

#### 4.24 Read Operation

##### 4.24.1 READ Timing Definitions

Read timing shown in this section is applied when the DLL is enabled and locked.

Rising data strobe edge parameters:

- tDQSKC min/max describes the allowed range for a rising data strobe edge relative to CK\_t, CK\_c.
- tDQSKC is the actual position of a rising strobe edge relative to CK\_t, CK\_c.
- tQSH describes the DQS\_t, DQS\_c differential output high time.
- tDQSQ describes the latest valid transition of the associated DQ pins.
- tQH describes the earliest invalid transition of the associated DQ pins.

Falling data strobe edge parameters:

- tQLL describes the DQS\_t, DQS\_c differential output low time.
- tDQSQ describes the latest valid transition of the associated DQ pins.
- tQH describes the earliest invalid transition of the associated DQ pins.

tDQSQ; both rising/falling edges of DQS, no tAC defined.

## 4.21.1 READ Timing Definitions (cont'd)

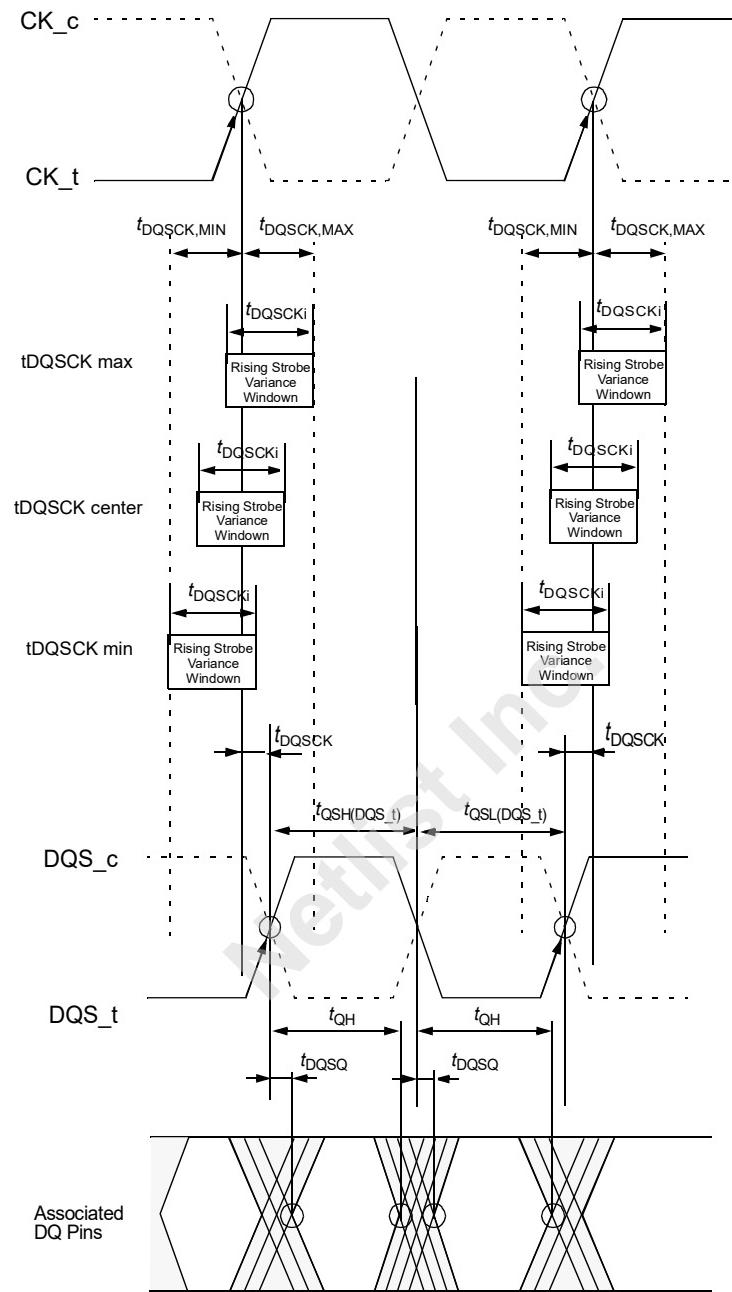


Figure 83 — READ Timing Definition

#### 4.24.1.1 READ Timing; Clock to Data Strobe relationship

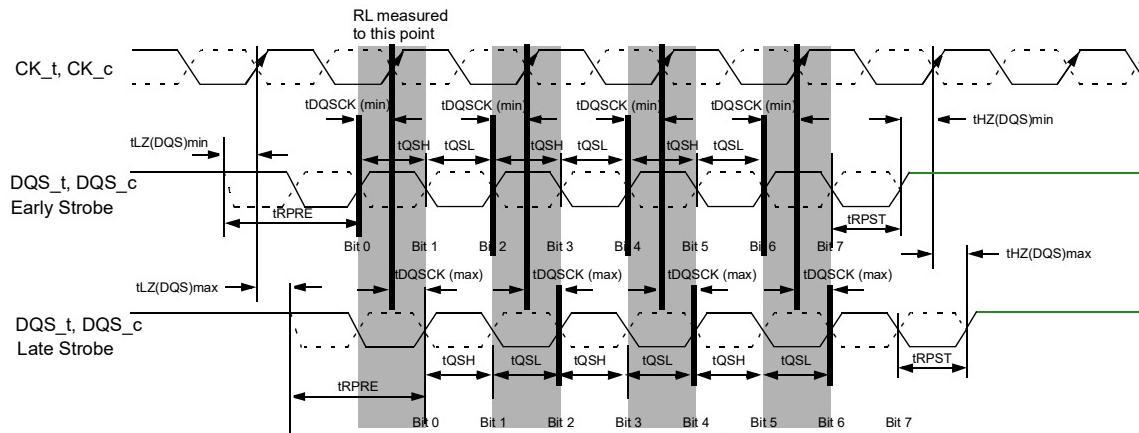
Clock to Data Strobe relationship is shown in Figure 84 and is applied when the DLL is enabled and locked.

Rising data strobe edge parameters:

- tDQSKC min/max describes the allowed range for a rising data strobe edge relative to CK\_t, CK\_c.
- tDQSKC is the actual position of a rising strobe edge relative to CK\_t, CK\_c.
- tQSH describes the data strobe high pulse width.

Falling data strobe edge parameters:

- tQLS describes the data strobe low pulse width.
- tLZ(DQS), tHZ(DQS) for preamble/postamble.



NOTE 1 Within a burst, rising strobe edge can be varied within tDQSKC<sub>i</sub> while at the same voltage and temperature.

However incorporate the device, voltage and temperature variation, rising strobe edge variance window, tDQSKC<sub>i</sub> can shift between tDQSKC(min) and tDQSKC(max). A timing of this window's right inside edge ( latest ) from rising CK\_t, CK\_c is limited by a device's actual tDQSKC(max). A timing of this window's left inside edge ( earliest ) from rising CK\_t, CK\_c is limited by tDQSKC(min).

NOTE 2 Notwithstanding note 1, a rising strobe edge with tDQSKC(max) at T(n) can not be immediately followed by a rising strobe edge with tDQSKC(min) at T(n+1). This is because other timing relationships (tQSH, tQLS) exist:

$$\text{if } tDQSKC(n+1) < 0: \\ tDQSKC(n) < 1.0 \cdot tCK - (tQSH_{min} + tQLS_{min}) - |tDQSKC(n+1)|$$

NOTE 3 The DQS\_t, DQS\_c differential output high time is defined by tQSH and the DQS\_t, DQS\_c differential output low time is defined by tQLS.

NOTE 4 Likewise, tLZ(DQS)min and tHZ(DQS)min are not tied to tDQSKCmin (early strobe case) and tLZ(DQS)max and tHZ(DQS)max are not tied to tDQSKCmax (late strobe case).

NOTE 5 The minimum pulse width of read preamble is defined by tRPRE(min).

NOTE 6 The maximum read postamble is bound by tDQSKC(min) plus tQSH(min) on the left side and tHZDQS(max) on the right side.

NOTE 7 The minimum pulse width of read postamble is defined by tRPST(min).

NOTE 8 The maximum read preamble is bound by tLZDQS(min) on the left side and tDQSKC(max) on the right side.

**Figure 84 — Clock to Data Strobe Relationship**

#### 4.24.1.2 READ Timing; Data Strobe to Data relationship

The Data Strobe to Data relationship is shown in Figure 85 and is applied when the DLL is enabled and locked.

Rising data strobe edge parameters:

- tDQSQ describes the latest valid transition of the associated DQ pins.
- tQH describes the earliest invalid transition of the associated DQ pins.

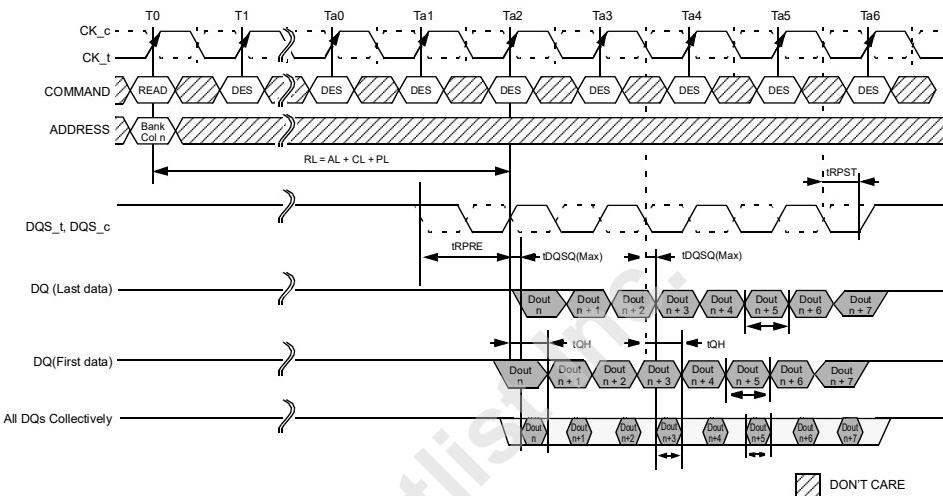
Falling data strobe edge parameters:

- tDQSQ describes the latest valid transition of the associated DQ pins.
- tQH describes the earliest invalid transition of the associated DQ pins.

tDQSQ; both rising/falling edges of DQS, no tAC defined.

Data Valid Window:

- tDVWd is the Data Valid Window per device per UI and is derived from  $(tQH - tDQSQ)$  of each UI on a given DRAM. This parameter will be characterized and guaranteed by design.
- tDVWp is Data Valid Window per pin per UI and is derived from  $(tQH - tDQSQ)$  of each UI on a pin of a given DRAM. This parameter will be characterized and guaranteed by design.



NOTE 1 BL = 8, AL = 0, CL = 11, Preamble = 1tCK

NOTE 2 DOUT n = data-out from column n.

NOTE 3 DES commands are shown for ease of illustration; other commands may be valid at these times.

NOTE 4 BL8 setting activated by either MRO[A1:0 = 00] or MRO[A1:0 = 01] and A12 = 1 during READ command at T0.

NOTE 5 Output timings are referenced to VDDQ, and DLL on for locking.

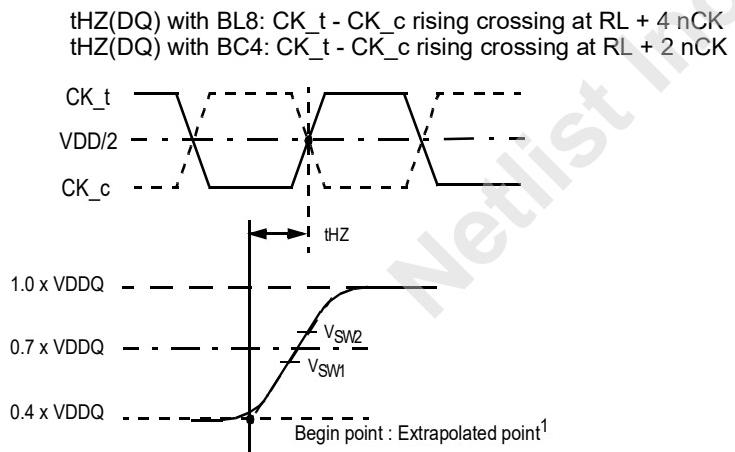
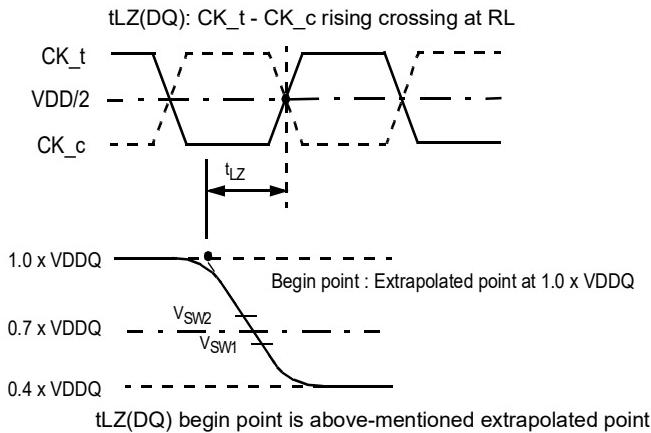
NOTE 6 tDQSQ defines the skew between DQS\_t,DQS\_c to Data and does not define DQS\_t, DQS\_c to Clock.

NOTE 7 Early Data transitions may not always happen at the same DQ. Data transitions of a DQ can vary (either early or late) within a burst

Figure 85 — Data Strobe to Data Relationship

#### 4.24.1.3 tLZ(DQS), tLZ(DQ), tHZ(DQS), tHZ(DQ) Calculation

tHZ and tLZ transitions occur in the same time window as valid data transitions. These parameters are referenced to a specific voltage level that specifies when the device output is no longer driving tHZ(DQS) and tHZ(DQ), or begins driving tLZ(DQS), tLZ(DQ). Figure 86 shows a method to calculate the point when the device is no longer driving tHZ(DQS) and tHZ(DQ), or begins driving tLZ(DQS), tLZ(DQ), by measuring the signal at two different voltages. The actual voltage measurement points are not critical as long as the calculation is consistent. The parameters tLZ(DQS), tLZ(DQ), tHZ(DQS), and tHZ(DQ) are defined as single ended.



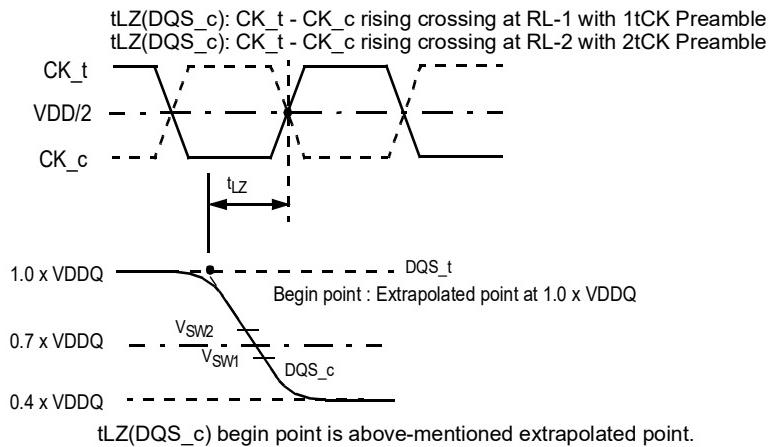
tHz(DQ) is begin point is above-mentioned extrapolated point.

**Figure 86 — tLZ(DQ) and tHZ(DQ) method for calculating transitions and begin points**

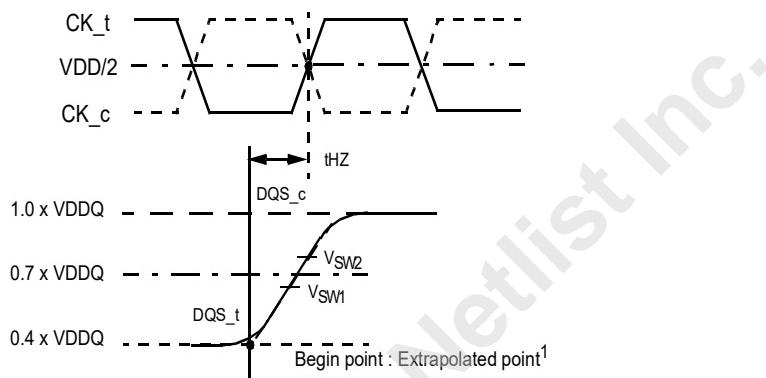
**Table 78 — Reference Voltage for tLZ(DQ), tHZ(DQ) Timing Measurements**

| Measured Parameter                    | Measured Parameter Symbol | Vsw1[V]              | Vsw2[V]              | Note |
|---------------------------------------|---------------------------|----------------------|----------------------|------|
| DQ low-impedance time from CK_t,CK_c  | tLZ(DQ)                   | (0.70 - 0.04) x VDDQ | (0.70 + 0.04) x VDDQ |      |
| DQ high impedance time from CK_t,CK_c | tHZ(DQ)                   | (0.70 - 0.04) x VDDQ | (0.70 + 0.04) x VDDQ |      |

#### 4.24.1.3 tLZ(DQS), tLZ(DQ), tHZ(DQS), tHZ(DQ) Calculation (cont'd)



tHZ(DQS\_t) with BL8: CK\_t - CK\_c rising crossing at RL + 4 nCK  
 tHZ(DQS\_t) with BC4: CK\_t - CK\_c rising crossing at RL + 2 nCK



tHZ(DQS\_t) begin point is above-mentioned extrapolated point.

**NOTE 1** Extrapolated point (Low Level) =  $VDDQ/(50+34) \times 34$   
 $= VDDQ \times 0.40$   
 - A driver impedance :  $RZQ/7(34\text{ohm})$   
 - An effective test load :  $50 \text{ ohm to VTT} = VDDQ$

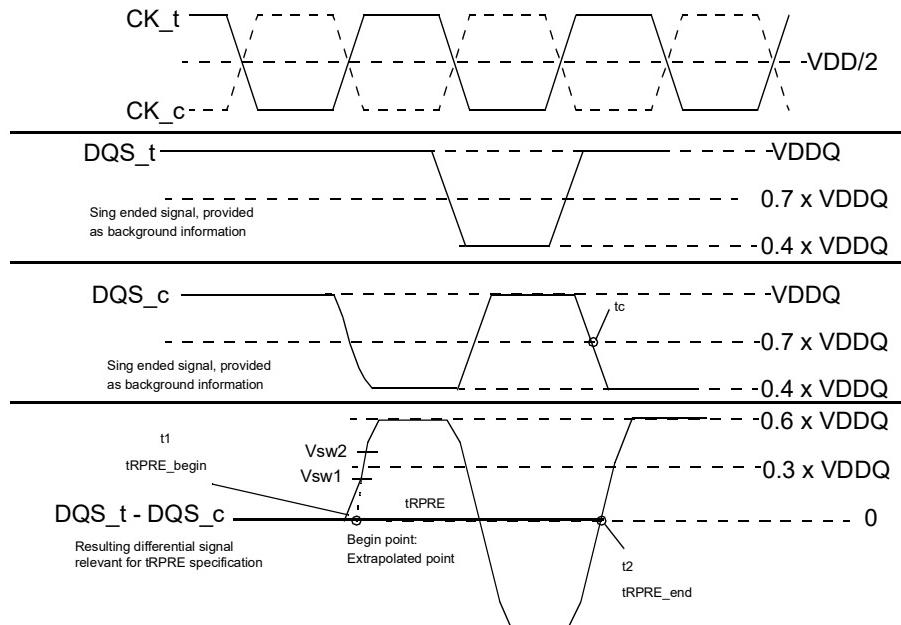
**Figure 87 — tLZ(DQS\_c) and tHZ(DQS\_t) method for calculating transitions and begin points**

**Table 79 — Reference Voltage for tLZ(DQS\_c), tHZ(DQS\_t) Timing Measurements**

| Measured Parameter                        | Measured Parameter Symbol | $V_{SW1}[\text{V}]$         | $V_{SW2}[\text{V}]$         | Note |
|---|---------------------------|-----------------------------|-----------------------------|------|
| DQS_c low-impedance time from CK_t, CK_c  | $t_{LZ}(DQS_c)$           | $(0.70 - 0.04) \times VDDQ$ | $(0.70 + 0.04) \times VDDQ$ |      |
| DQS_t high impedance time from CK_t, CK_c | $t_{HZ}(DQS_t)$           | $(0.70 - 0.04) \times VDDQ$ | $(0.70 + 0.04) \times VDDQ$ |      |

#### 4.24.1.4 tRPRE Calculation

The method for calculating differential pulse widths for tRPRE is shown in Figure 88.



**NOTE:**

1. Low Level of DQS\_t and DQS\_c =  $VDDQ/(50+34) \times 34$   
=  $VDDQ \times 0.40$

- A driver impedance : RZQ/7(34ohm)

- An effective test load : 50 ohm to VTT = VDDQ

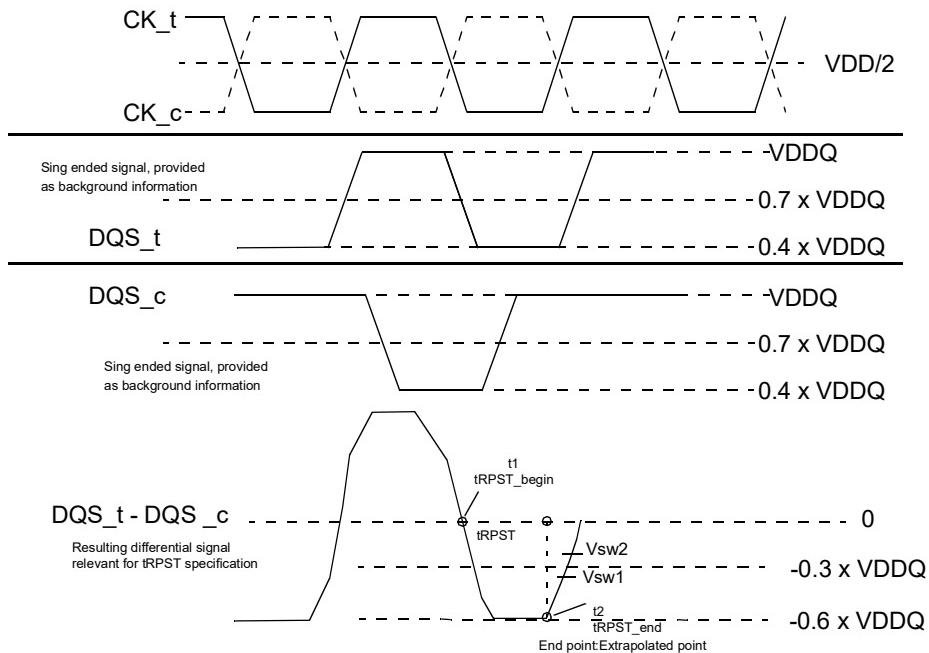
**Figure 88 — Method for calculating tRPRE transitions and endpoints**

**Table 80 — Reference Voltage for tRPRE Timing Measurements**

| Measured Parameter                      | Measured Parameter Symbol | Vsw1[V]              | Vsw2[V]              | Note |
|---|---------------------------|----------------------|----------------------|------|
| DQS_t, DQS_c differential READ Preamble | tRPRE                     | (0.30 - 0.04) x VDDQ | (0.30 + 0.04) x VDDQ |      |

#### 4.24.1.5 tRPST Calculation

The method for calculating differential pulse widths for tRPST is shown in Figure 89.



NOTE 1 Low Level of DQS\_T and DQS\_c = VDDQ/(50+34) x 34  
 $= VDDQ \times 0.40$

- A driver impedance : RZQ/7(34ohm)
- An effective test load : 50 ohm to VTT = VDDQ

**Figure 89 — Method for calculating tRPST transitions and endpoints**

**Table 81 — Reference Voltage for tRPST Timing Measurements**

| Measured Parameter                       | Measured Parameter Symbol | Vsw1[V]               | Vsw2[V]               | Note |
|--|---------------------------|-----------------------|-----------------------|------|
| DQS_t, DQS_c differential READ Postamble | tRPST                     | (-0.30 - 0.04) x VDDQ | (-0.30 + 0.04) x VDDQ |      |

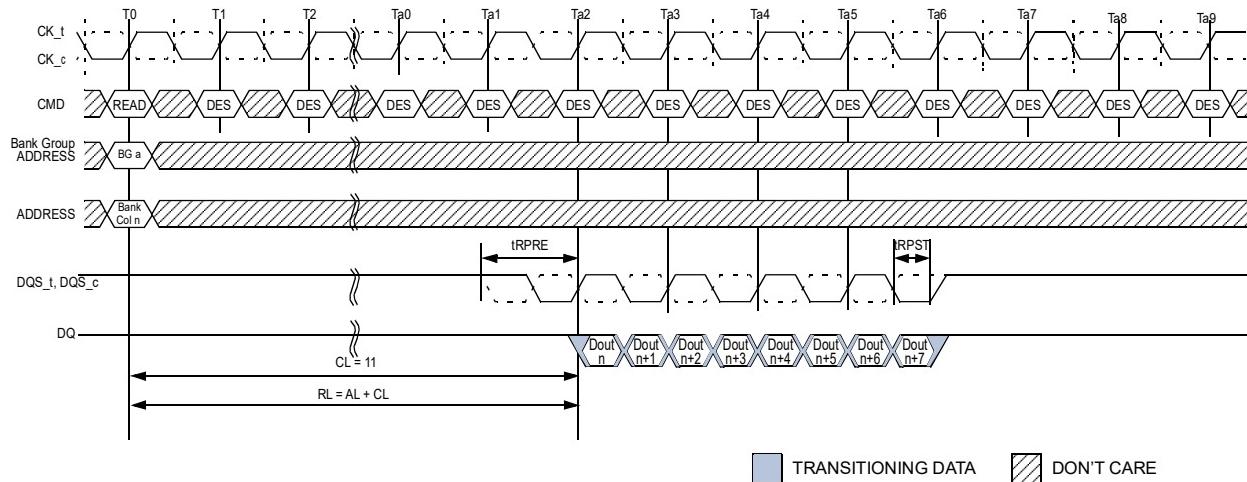
#### 4.24.2 READ Burst Operation

During a READ or WRITE command, DDR4 will support BC4 and BL8 on the fly using address A12 during the READ or WRITE (AUTO PRECHARGE can be enabled or disabled).

A12 = 0 : BC4 (BC4 = burst chop)

A12 = 1 : BL8

A12 is used only for burst length control, not as a column address.<sup>S.t.D</sup>



NOTE 1 BL = 8, AL = 0, CL = 11, Preamble = 1tCK

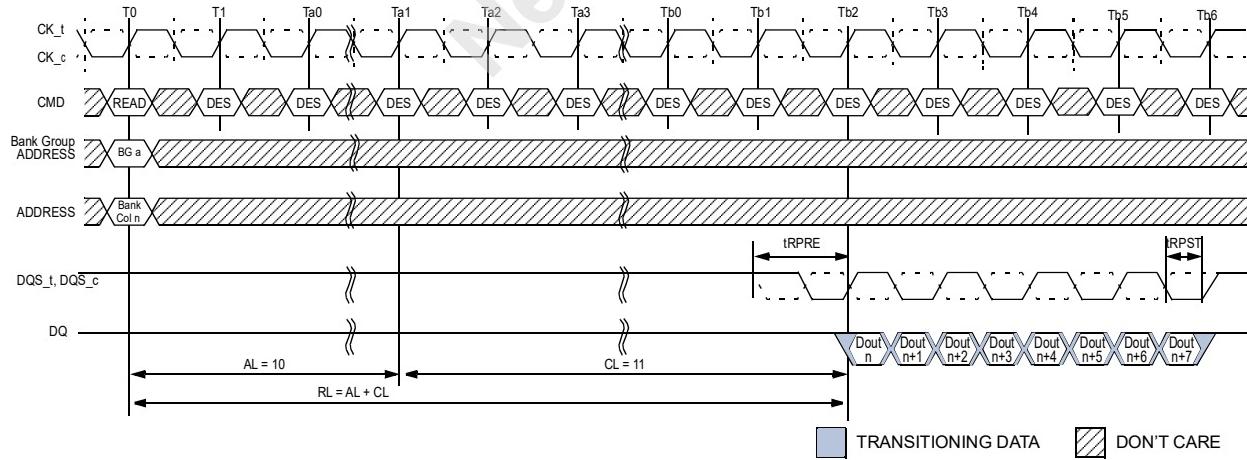
NOTE 2 DOUT n = data-out from column n.

NOTE 3 DES commands are shown for ease of illustration; other commands may be valid at these times.

NOTE 4 BL8 setting activated by either MR0[A1:0 = 00] or MR0[A1:0 = 01] and A12 = 1 during READ command at T0.

NOTE 5 CA Parity = Disable, CS to CA Latency = Disable, Read DBI = Disable

**Figure 90 — READ Burst Operation RL = 11 (AL = 0, CL = 11, BL8)**



NOTE 1 BL = 8, RL = 21, AL = (CL-1), CL = 11, Preamble = 1tCK

NOTE 2 DOUT n = data-out from column n.

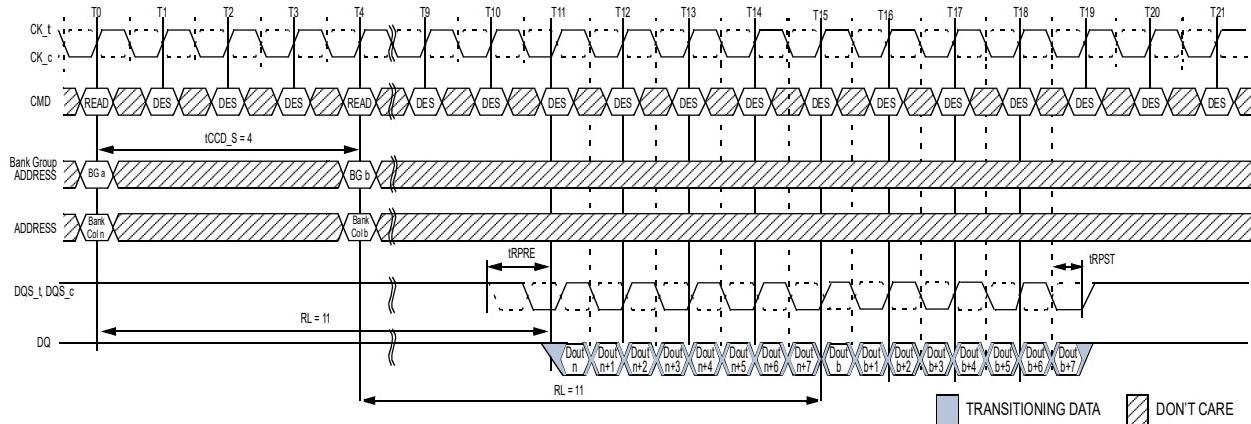
NOTE 3 DES commands are shown for ease of illustration; other commands may be valid at these times.

NOTE 4 BL8 setting activated by either MR0[A1:0 = 00] or MR0[A1:0 = 01] and A12 = 1 during READ command at T0.

NOTE 5 CA Parity = Disable, CS to CA Latency = Disable, Read DBI = Disable

**Figure 91 — READ Burst Operation RL = 21 (AL = 10, CL = 11, BL8)**

#### 4.24.2 READ Burst Operation (cont'd)



NOTE 1 BL = 8, AL = 0, CL = 11, Preamble = 1tCK

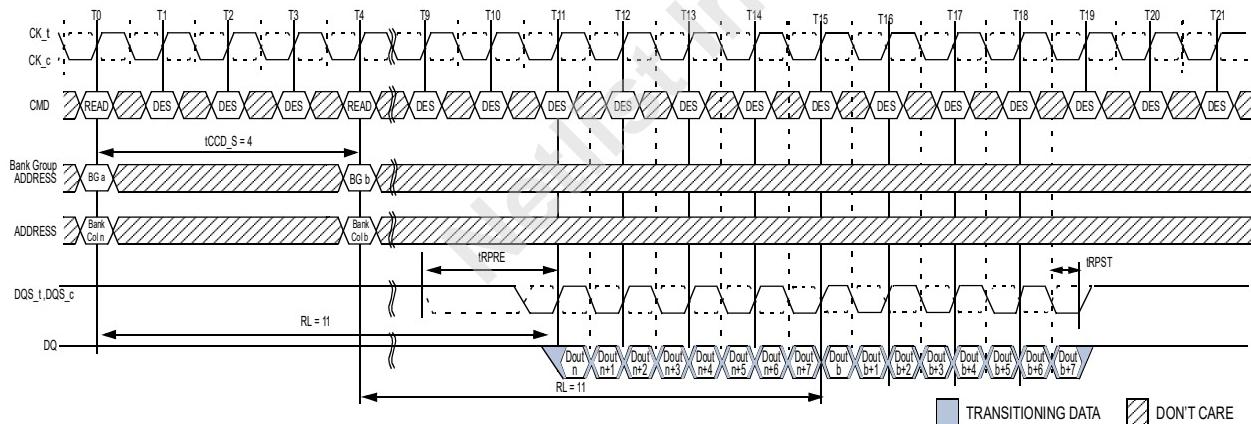
NOTE 2 DOUT n (or b) = data-out from column n (or column b).

NOTE 3 DES commands are shown for ease of illustration; other commands may be valid at these times.

NOTE 4 BL8 setting activated by either MR0[A1:A0 = 0:0] or MR0[A1:A0 = 0:1] and A12 = 1 during READ command at T0 and T4.

NOTE 5 CA Parity = Disable, CS to CA Latency = Disable, Read DBI = Disable

**Figure 92 — Consecutive READ (BL8) with 1tCK Preamble in Different Bank Group**



NOTE 1 BL = 8, AL = 0, CL = 11, Preamble = 2tCK

NOTE 2 DOUT n (or b) = data-out from column n (or column b).

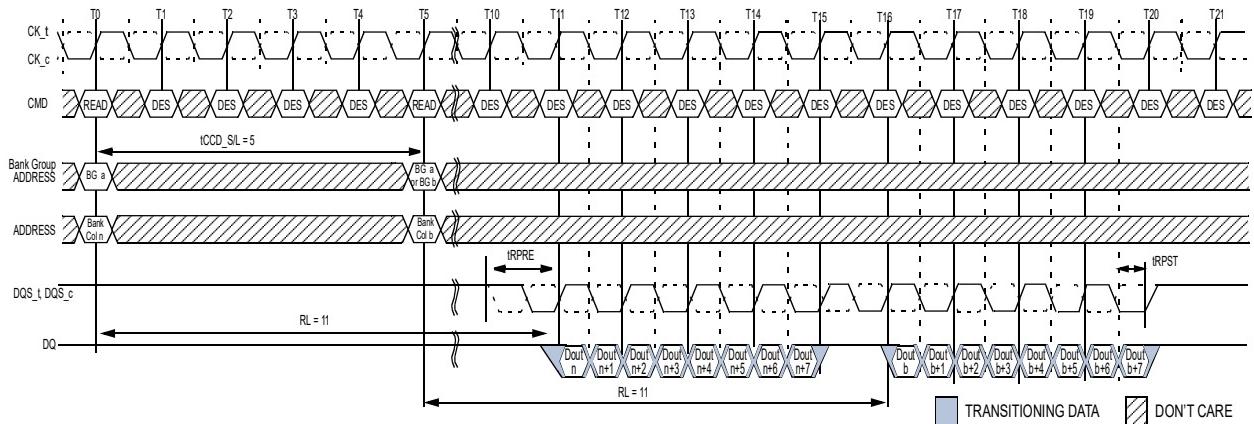
NOTE 3 DES commands are shown for ease of illustration; other commands may be valid at these times.

NOTE 4 BL8 setting activated by either MR0[A1:A0 = 0:0] or MR0[A1:A0 = 0:1] and A12 = 1 during READ command at T0 and T4.

NOTE 5 CA Parity = Disable, CS to CA Latency = Disable, Read DBI = Disable

**Figure 93 — Consecutive READ (BL8) with 2tCK Preamble in Different Bank Group**

#### 4.24.2 READ Burst Operation (cont'd)



NOTE 1 BL = 8, AL = 0, CL = 11, Preamble = 1tCK, tCCD\_S/L = 5

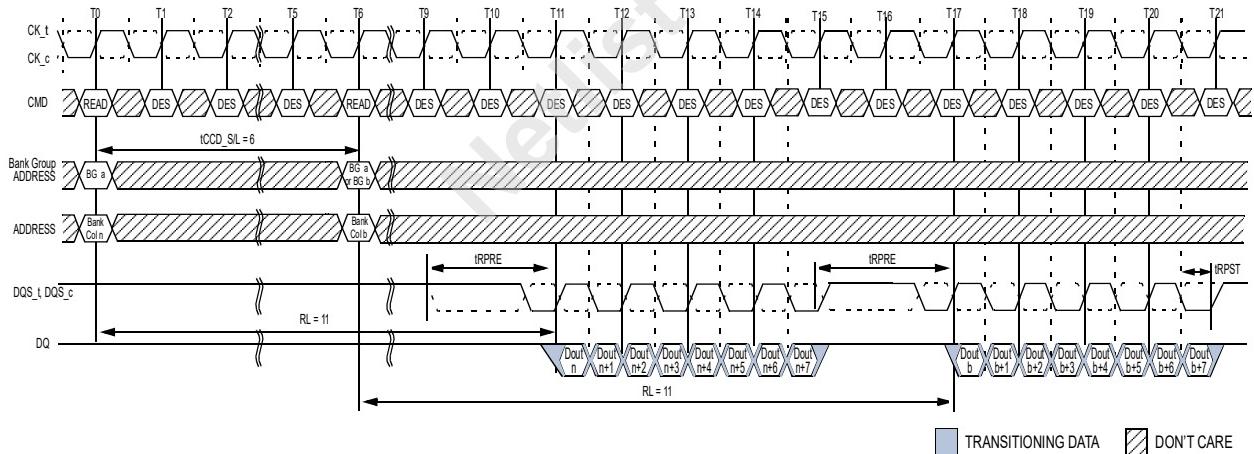
NOTE 2 DOUT n (or b) = data-out from column n (or column b).

NOTE 3 DES commands are shown for ease of illustration; other commands may be valid at these times.

NOTE 4 BL8 setting activated by either MR0[A1:A0 = 0:0] or MR0[A1:A0 = 0:1] and A12 = 1 during READ command at T0 and T5.

NOTE 5 CA Parity = Disable, CS to CA Latency = Disable, Read DBI = Disable

**Figure 94 — Nonconsecutive READ (BL8) with 1tCK Preamble in Same or Different Bank Group**



NOTE 1 BL = 8, AL = 0, CL = 11, Preamble = 2tCK, tCCD\_S/L = 6

NOTE 2 DOUT n (or b) = data-out from column n (or column b).

NOTE 3 DES commands are shown for ease of illustration; other commands may be valid at these times.

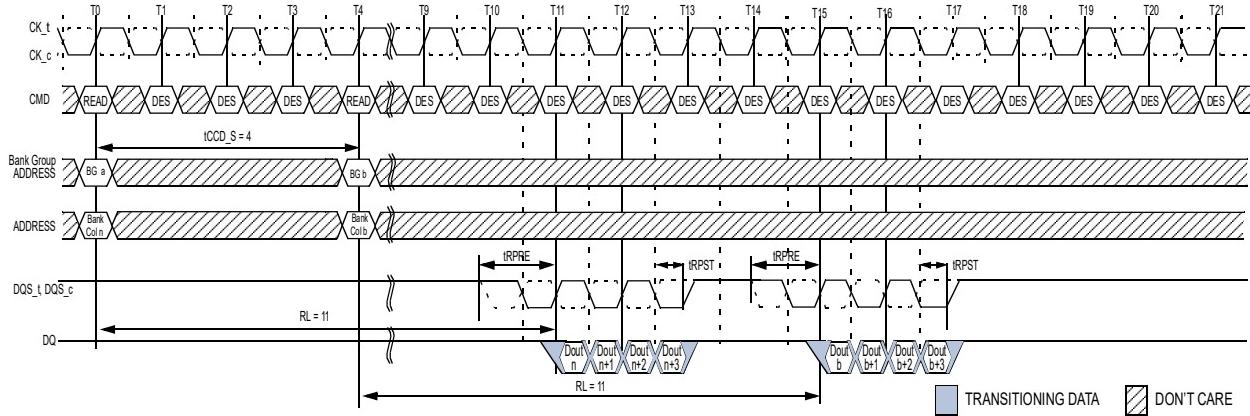
NOTE 4 BL8 setting activated by either MR0[A1:A0 = 0:0] or MR0[A1:A0 = 0:1] and A12 = 1 during READ command at T0 and T6.

NOTE 5 CA Parity = Disable, CS to CA Latency = Disable, Read DBI = Disable

NOTE 6 tCCD\_S/L=5 isn't allowed in 2tCK preamble mode.

**Figure 95 — Nonconsecutive READ (BL8) with 2tCK Preamble in Same or Different Bank Group**

#### 4.24.2 READ Burst Operation (cont'd)



NOTE 1 BL = 8, AL = 0, CL = 11, Preamble = 1tCK

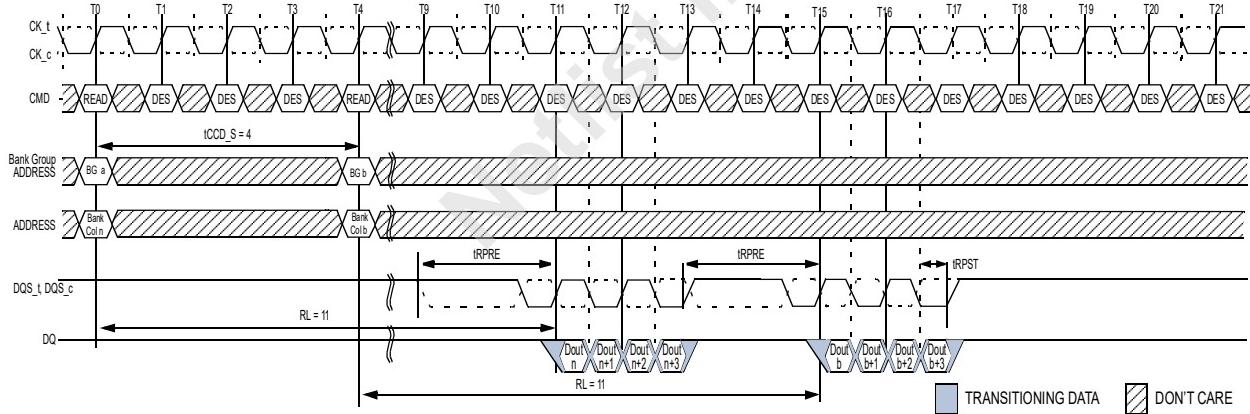
NOTE 2 DOUT n (or b) = data-out from column n (or column b).

NOTE 3 DES commands are shown for ease of illustration; other commands may be valid at these times.

NOTE 4 BC4 setting activated by either MRO[A1:A0 = 1:0] or MRO[A1:A0 = 0:1] and A12 = 0 during READ command at T0 and T4.

NOTE 5 CA Parity = Disable, CS to CA Latency = Disable, Read DBI = Disable

**Figure 96 — READ (BC4) to READ (BC4) with 1tCK Preamble in Different Bank Group**



NOTE 1 BL = 8, AL = 0, CL = 11, Preamble = 2tCK

NOTE 2 DOUT n (or b) = data-out from column n (or column b).

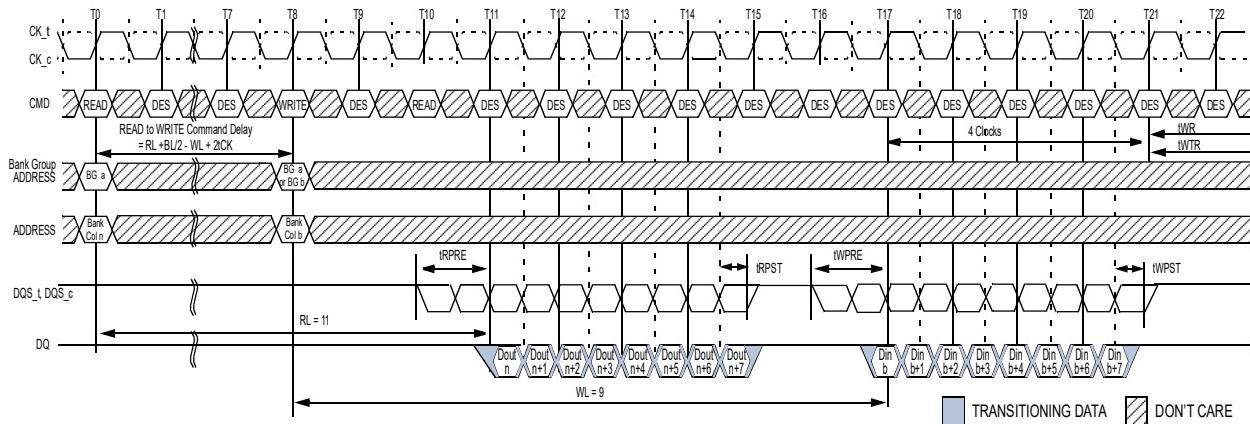
NOTE 3 DES commands are shown for ease of illustration; other commands may be valid at these times.

NOTE 4 BC4 setting activated by either MRO[A1:A0 = 1:0] or MRO[A1:A0 = 0:1] and A12 = 0 during READ command at T0 and T4.

NOTE 5 CA Parity = Disable, CS to CA Latency = Disable, Read DBI = Disable

**Figure 97 — READ (BC4) to READ (BC4) with 2tCK Preamble in Different Bank Group**

#### 4.24.2 READ Burst Operation (cont'd)



NOTE 1 BL = 8, RL = 11 (CL = 11, AL = 0), Read Preamble = 1tCK, WL = 9 (CWL = 9, AL = 0), Write Preamble = 1tCK

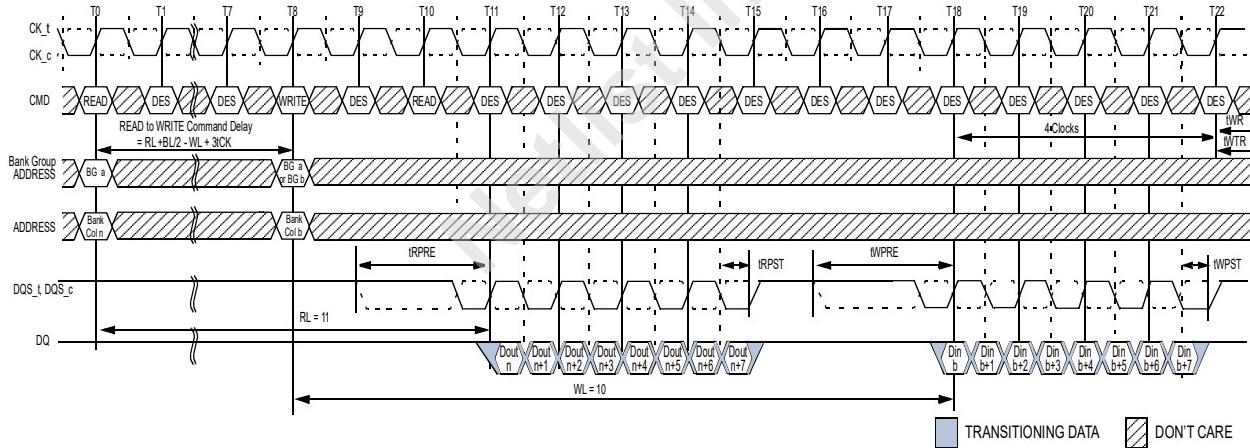
NOTE 2 DOUT n = data-out from column n, DIN b = data-in to column b.

NOTE 3 DES commands are shown for ease of illustration; other commands may be valid at these times.

NOTE 4 BL8 setting activated by either MR0[A1:A0 = 0:0] or MR0[A1:A0 = 0:1] and A12 = 1 during READ command at T0 and WRITE command at T8.

NOTE 5 CA Parity = Disable, CS to CA Latency = Disable, Read DBI = Disable, Write DBI = Disable, Write CRC = Disable.

**Figure 98 — READ (BL8) to WRITE (BL8) with 1tCK Preamble in Same or Different Bank Group**



NOTE 1 BL = 8, RL = 11 (CL = 11, AL = 0), Read Preamble = 2tCK, WL = 10 (CWL = 9+1<sup>5</sup>, AL = 0), Write Preamble = 2tCK

NOTE 2 DOUT n = data-out from column n, DIN b = data-in to column b.

NOTE 3 DES commands are shown for ease of illustration; other commands may be valid at these times.

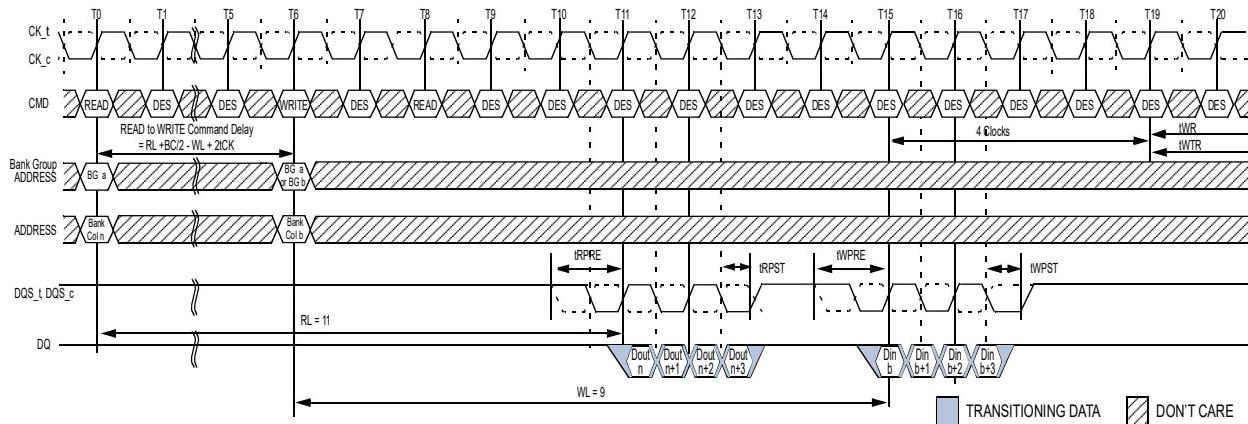
NOTE 4 BL8 setting activated by either MR0[A1:A0 = 0:0] or MR0[A1:A0 = 0:1] and A12 = 1 during READ command at T0 and WRITE command at T8.

NOTE 5 When operating in 2tCK Write Preamble Mode, CWL must be programmed to a value at least 1 clock greater than the lowest CWL setting.

NOTE 6 CA Parity = Disable, CS to CA Latency = Disable, Read DBI = Disable, Write DBI = Disable, Write CRC = Disable.

**Figure 99 — READ (BL8) to WRITE (BL8) with 2tCK Preamble in Same or Different Bank Group**

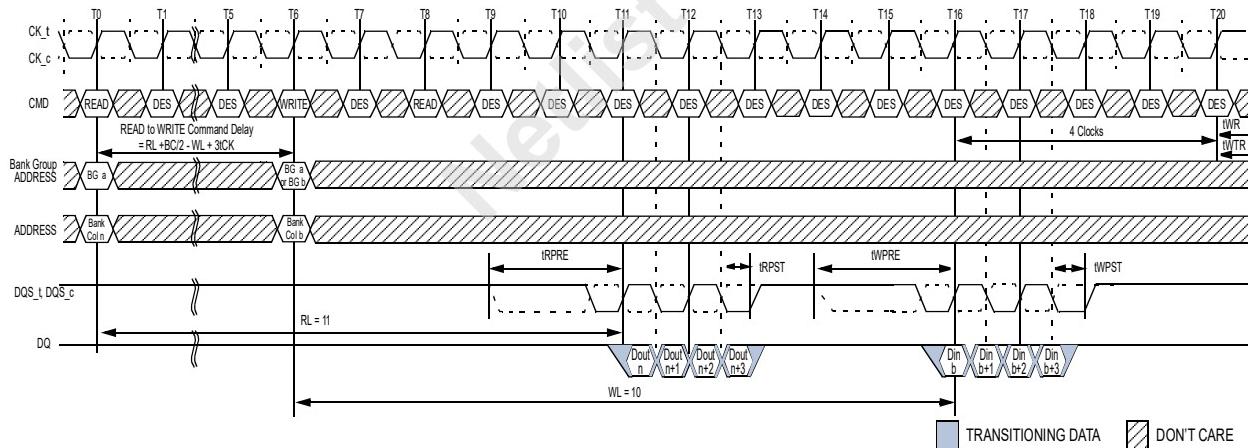
## 4.24.2 READ Burst Operation (cont'd)



NOTE 1 BC = 4, RL = 11 (CL = 11, AL = 0), Read Preamble = 1tCK, WL = 9 (CWL = 9, AL = 0), Write Preamble = 1tCK  
 NOTE 2 DOUT n = data-out from column n, DIN b = data-in to column b.  
 NOTE 3 DES commands are shown for ease of illustration; other commands may be valid at these times.

NOTE 4 BC4(OTF) setting activated by MR0[A1:A0 = 0:1] and A12 = 0 during READ command at T0 and WRITE command at T6.  
 NOTE 5 CA Parity = Disable, CS to CA Latency = Disable, Read DBI = Disable, Write DBI = Disable, Write CRC = Disable.

**Figure 100 — READ (BC4) OTF to WRITE (BC4) OTF with 1tCK Preamble in Same or Different Bank Group**



NOTE 1 BC = 4, RL = 11 (CL = 11, AL = 0), Read Preamble = 2tCK, WL = 10 (CWL =  $9+1^5$ , AL = 0), Write Preamble = 2tCK  
 NOTE 2 DOUT n = data-out from column n, DIN b = data-in to column b.

NOTE 3 DES commands are shown for ease of illustration; other commands may be valid at these times.

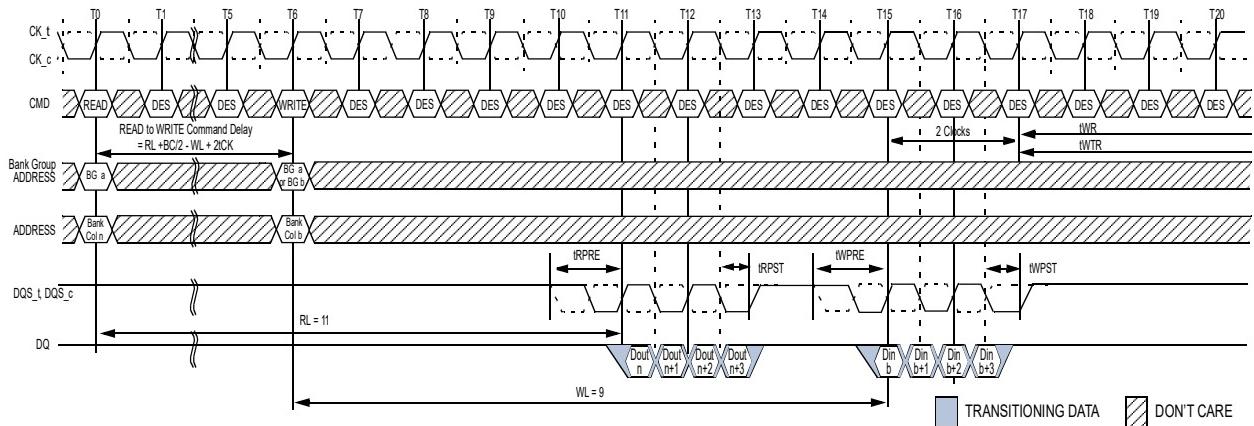
NOTE 4 BC4(OTF) setting activated by MR0[A1:A0 = 0:1] and A12 = 0 during READ command at T0 and WRITE command at T6.

NOTE 5 When operating in 2tCK Write Preamble Mode, CWL must be programmed to a value at least 1 clock greater than the lowest CWL setting.

NOTE 6 CA Parity = Disable, CS to CA Latency = Disable, Read DBI = Disable, Write DBI = Disable, Write CRC = Disable.

**Figure 101 — READ (BC4) OTF to WRITE (BC4) OTF with 2tCK Preamble in Same or Different Bank Group**

#### 4.24.2 READ Burst Operation (cont'd)



NOTE 1 BC = 4, RL = 11 (CL = 11, AL = 0), Read Preamble = 1tCK, WL = 9 (CWL = 9, AL = 0), Write Preamble = 1tCK

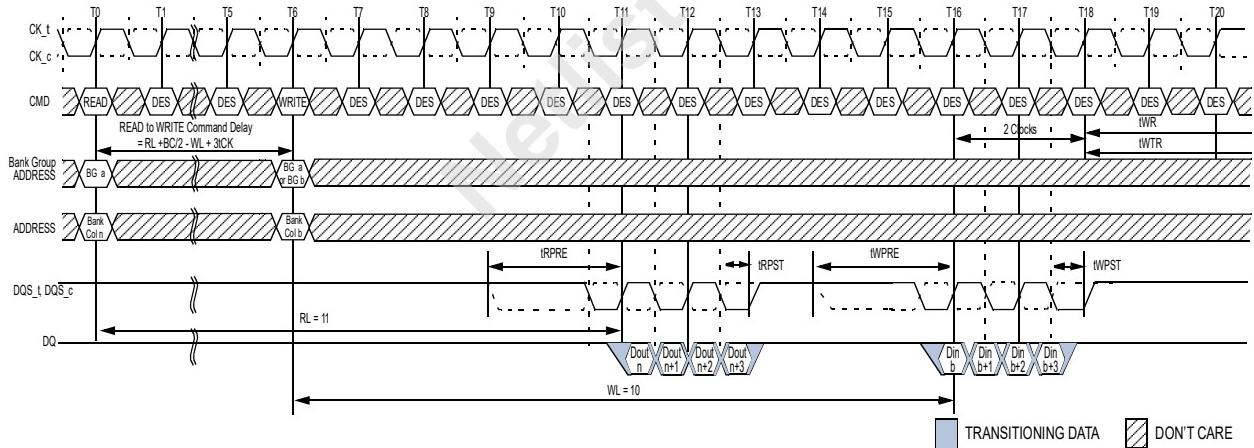
NOTE 2 DOUT n = data-out from column n, DIN b = data-in to column b.

NOTE 3 DES commands are shown for ease of illustration; other commands may be valid at these times.

NOTE 4 BC4(Fixed) setting activated by MRO[A1:A0 = 1:0].

NOTE 5 CA Parity = Disable, CS to CA Latency = Disable, Read DBI = Disable, Write DBI = Disable, Write CRC = Disable.

**Figure 102 — READ (BC4) Fixed to WRITE (BC4) Fixed with 1tCK Preamble in Same or Different Bank Group**



NOTE 1 BC = 4, RL = 11 (CL = 11, AL = 0), Read Preamble = 2tCK, WL = 10 (CWL = 9+1<sup>5</sup>, AL = 0), Write Preamble = 2tCK

NOTE 2 DOUT n = data-out from column n, DIN b = data-in to column b.

NOTE 3 DES commands are shown for ease of illustration; other commands may be valid at these times.

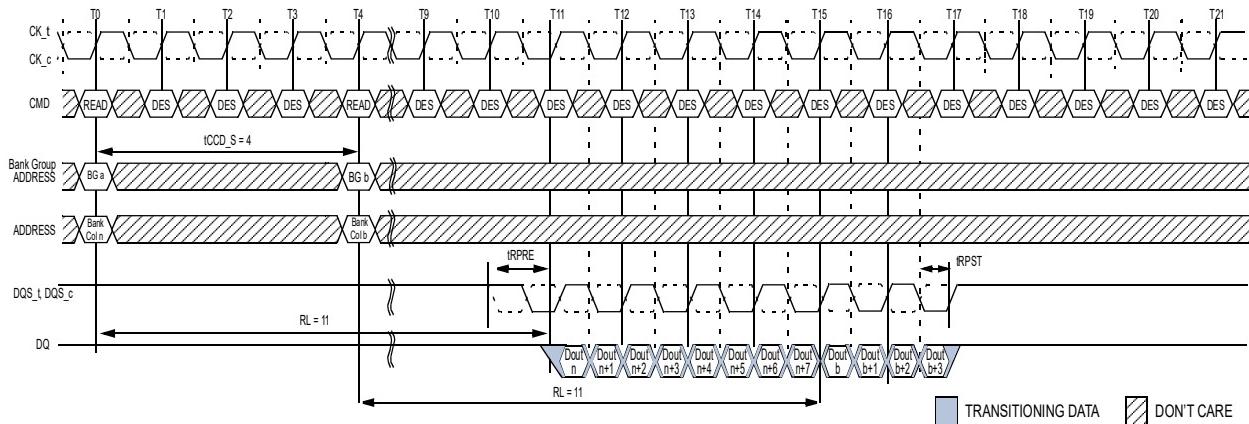
NOTE 4 BC4(Fixed) setting activated by MRO[A1:A0 = 1:0].

NOTE 5 When operating in 2tCK Write Preamble Mode, CWL must be programmed to a value at least 1 clock greater than the lowest CWL setting.

NOTE 6 CA Parity = Disable, CS to CA Latency = Disable, Read DBI = Disable, Write DBI = Disable, Write CRC = Disable.

**Figure 103 — READ (BC4) Fixed to WRITE (BC4) Fixed with 2tCK Preamble in Same or Different Bank Group**

#### 4.24.2 READ Burst Operation (cont'd)



NOTE 1 BL = 8, AL =0, CL = 11 ,Preamble = 1tCK

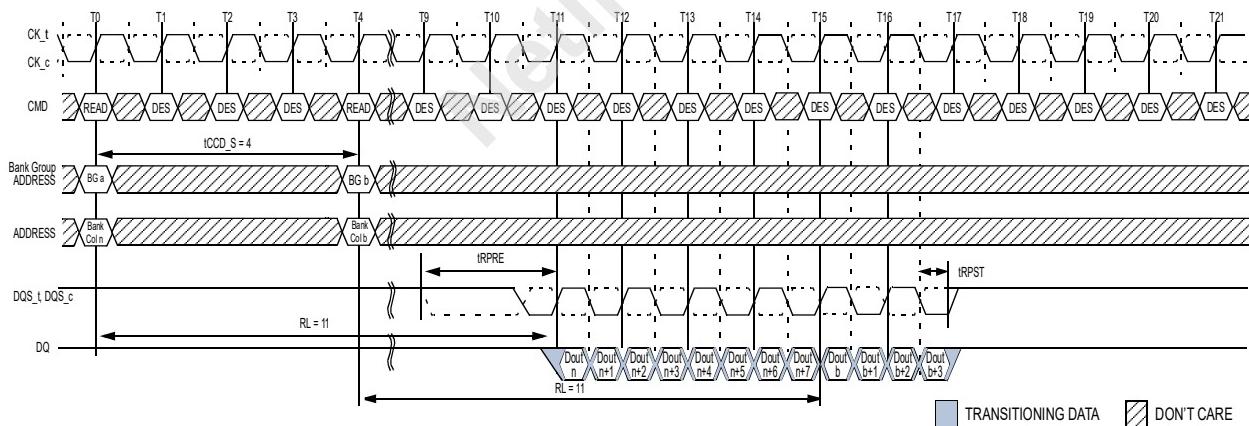
NOTE 2 DOUT n (or b) = data-out from column n (or column b).

NOTE 3 DES commands are shown for ease of illustration; other commands may be valid at these times.

NOTE 4 BL8 setting activated by MRO[A1:A0 = 0:1] and A12 = 1 during READ command at T0  
BC4 setting activated by MRO[A1:A0 = 0:1] and A12 = 0 during READ command at T4.

NOTE 5 CA Parity = Disable, CS to CA Latency = Disable, Read DBI = Disable.

**Figure 104 — READ (BL8) to READ (BC4) OTF with 1tCK Preamble in Different Bank Group**



NOTE 1 BL = 8, AL =0, CL = 11 ,Preamble = 2tCK

NOTE 2 DOUT n (or b) = data-out from column n (or column b).

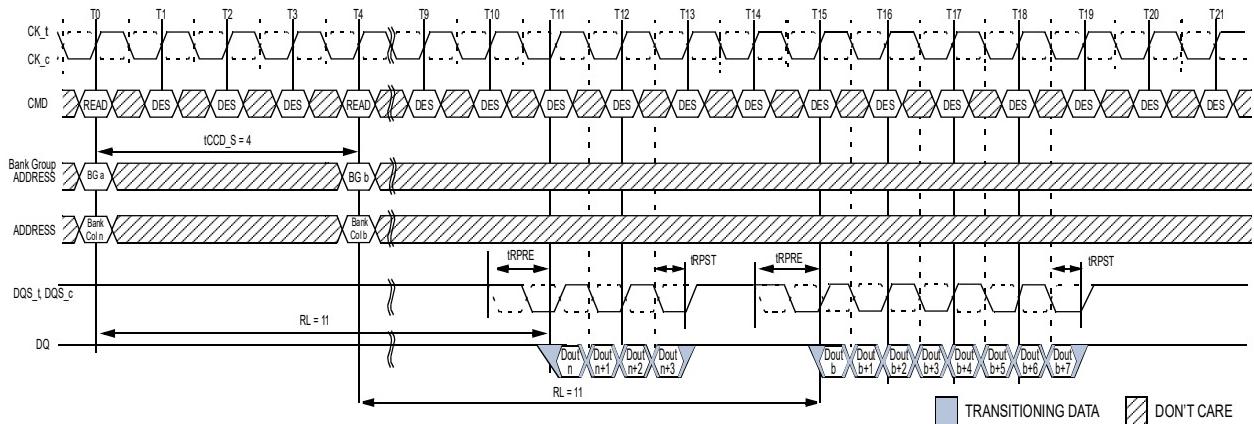
NOTE 3 DES commands are shown for ease of illustration; other commands may be valid at these times.

NOTE 4 BL8 setting activated by MRO[A1:A0 = 0:1] and A12 = 1 during READ command at T0.  
BC4 setting activated by MRO[A1:A0 = 0:1] and A12 = 0 during READ command at T4.

NOTE 5 CA Parity = Disable, CS to CA Latency = Disable, Read DBI = Disable.

**Figure 105 — READ (BL8) to READ (BC4) OTF with 2tCK Preamble in Different Bank Group**

#### 4.24.2 READ Burst Operation (cont'd)



NOTE 1 BL = 8, AL = 0, CL = 11 ,Preamble = 1tCK

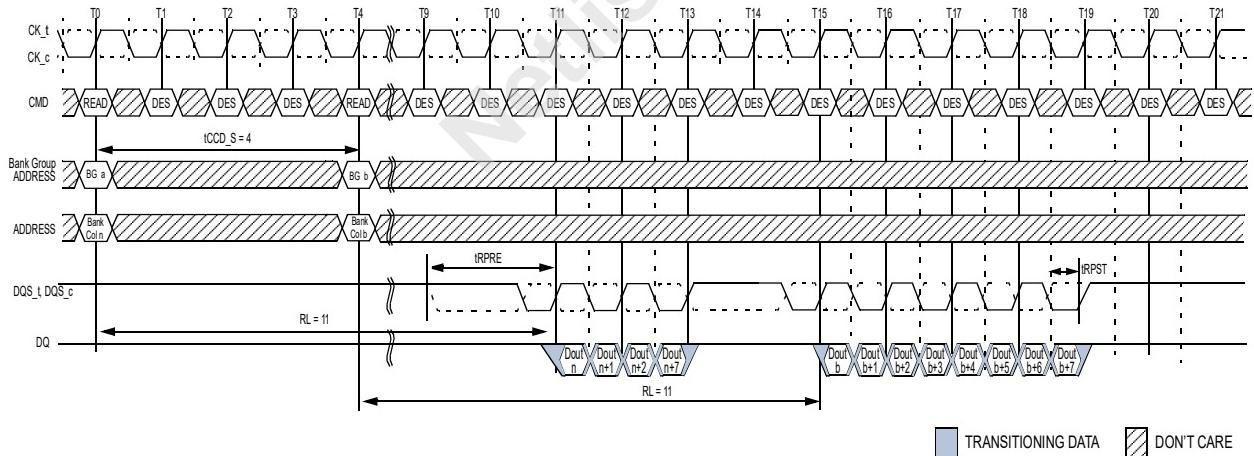
NOTE 2 DOUT n (or b) = data-out from column n (or column b).

NOTE 3 DES commands are shown for ease of illustration; other commands may be valid at these times.

NOTE 4 BC4 setting activated by MR0[A1:A0 = 0:1] and A12 = 0 during READ command at T0.  
BL8 setting activated by MR0[A1:A0 = 0:1] and A12 = 1 during READ command at T4.

NOTE 5 CA Parity = Disable, CS to CA Latency = Disable, Read DBI = Disable.

**Figure 106 — READ (BC4) to READ (BL8) OTF with 1tCK Preamble in Different Bank Group**



NOTE 1 BL = 8, AL = 0, CL = 11 ,Preamble = 2tCK

NOTE 2 DOUT n (or b) = data-out from column n (or column b).

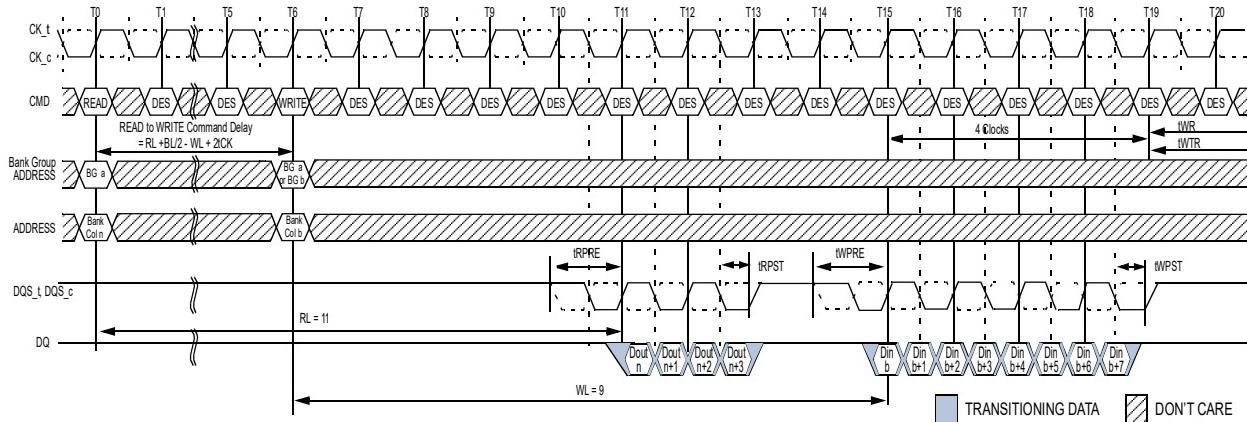
NOTE 3 DES commands are shown for ease of illustration; other commands may be valid at these times.

NOTE 4 BC4 setting activated by MR0[A1:A0 = 0:1] and A12 = 0 during READ command at T0.  
BL8 setting activated by MR0[A1:A0 = 0:1] and A12 = 1 during READ command at T4.

NOTE 5 CA Parity = Disable, CS to CA Latency = Disable, Read DBI = Disable.

**Figure 107 — READ (BC4) to READ (BL8) OTF with 2tCK Preamble in Different Bank Group**

#### 4.24.2 READ Burst Operation (cont'd)



NOTE 1 BC = 4, RL = 11(CL = 11 , AL = 0 ), Read Preamble = 1tCK, WL=9(CWL=9,AL=0), Write Preamble = 1tCK

NOTE 2 DOUT n = data-out from column n, DIN b = data-in to column b.

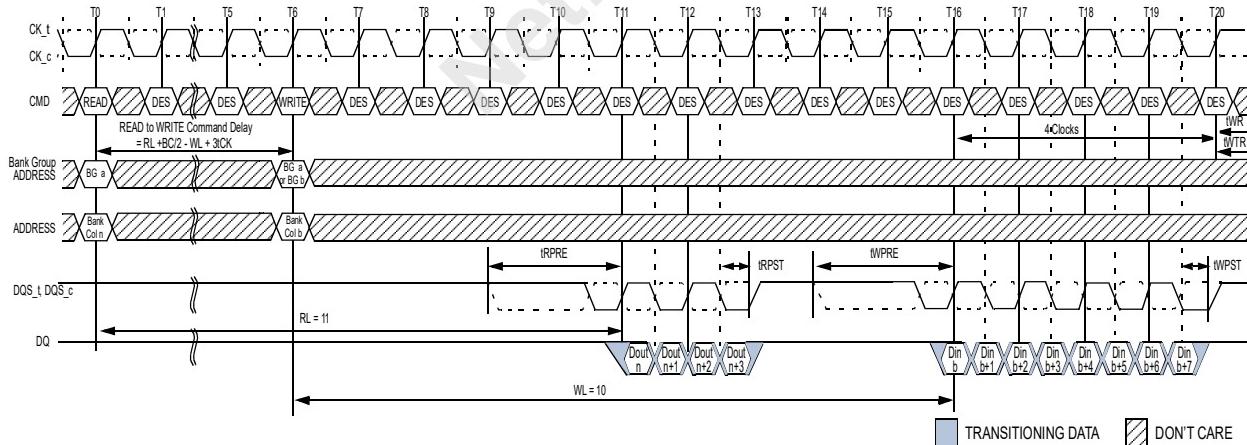
NOTE 3 DES commands are shown for ease of illustration; other commands may be valid at these times.

NOTE 4 BC4 setting activated by MRO[A1:A0 = 0:1] and A12 = 0 during READ command at T0.

BL8 setting activated by MRO[A1:A0 = 0:1] and A12 = 1 during WRITE command at T6.

NOTE 5 CA Parity = Disable, CS to CA Latency = Disable, Read DBI = Disable, Write DBI = Disable, Write CRC = Disable.

**Figure 108 — READ (BC4) to WRITE (BL8) OTF with 1tCK Preamble in Same or Different Bank Group**



NOTE 1 BC = 4, RL = 11 (CL = 11, AL = 0), Read Preamble = 2tCK, WL = 10 (CWL = 9+1<sup>5</sup>, AL = 0), Write Preamble = 2tCK

NOTE 2 DOUT n = data-out from column n, DIN b = data-in to column b.

NOTE 3 DES commands are shown for ease of illustration; other commands may be valid at these times.

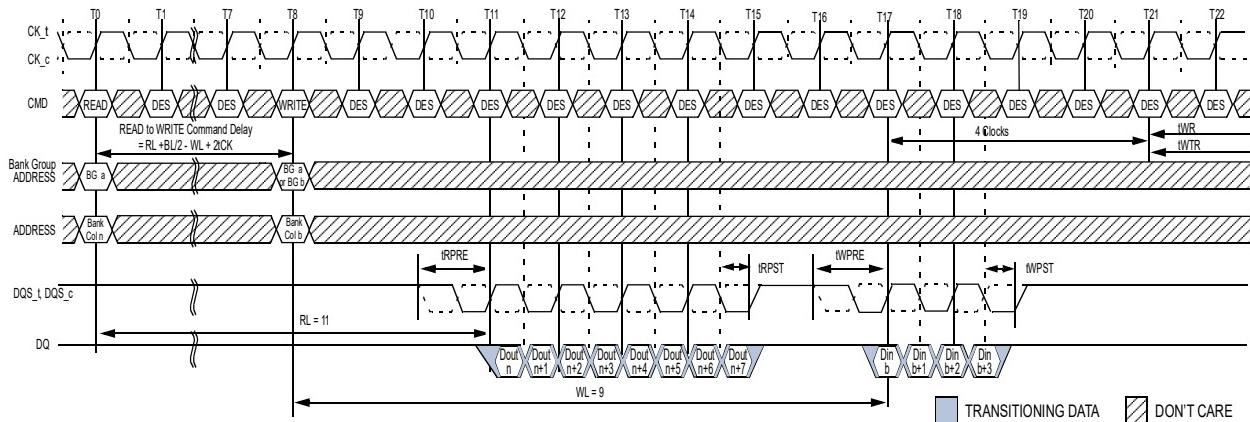
NOTE 4 BC4 setting activated by MRO[A1:A0 = 0:1] and A12 = 0 during READ command at T0.

BL8 setting activated by MRO[A1:A0 = 0:1] and A12 = 1 during WRITE command at T6.

NOTE 5 When operating in 2tCK Write Preamble Mode, CWL must be programmed to a value at least 1 clock greater than the lowest CWL setting.  
 NOTE 6 CA Parity = Disable, CS to CA Latency = Disable, Read DBI = Disable, Write DBI = Disable, Write CRC = Disable.

**Figure 109 — READ (BC4) to WRITE (BL8) OTF with 2tCK Preamble in Same or Different Bank Group**

#### 4.24.2 READ Burst Operation (cont'd)



NOTE 1 BL = 8, RL = 11 (CL = 11, AL = 0), Read Preamble = 1tCK, WL=9(CWL=9,AL=0), Write Preamble = 1tCK

NOTE 2 DOUT n = data-out from column n, DIN b = data-in to column b.

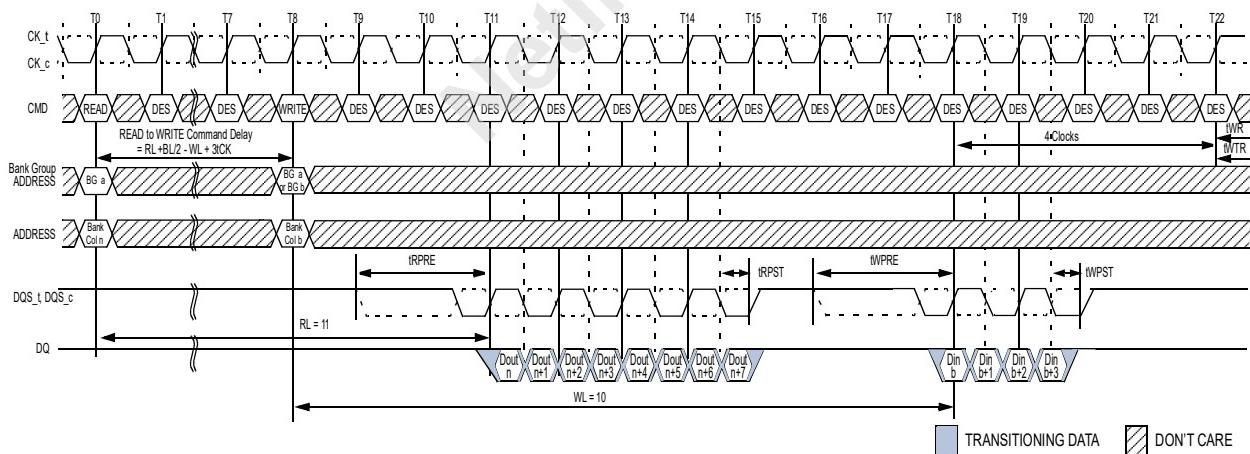
**NOTE 3** DES commands are shown for ease of illustration; other commands may be valid at these times.

**NOTE 4** BL8 setting activated by MR0|A1:A0 = 0:1 and A12 = 1 during READ command at T0.

**NOTE 4** BEG setting activated by MR0[A1:A0 = 0:1] and A12 = 1 during READ command at T8. BC4 setting activated by MR0[A1:A0 = 0:1] and A12 = 0 during WRITE command at T8.

NOTE 5: CA Parity = Disable, CS to CA Latency = Disable, Read DBI = Disable, Write DBI = Disable, Write CRC = Disable

**Figure 110 — READ (BL8) to WRITE (BC4) OTF with 1tCK Preamble in Same or Different Bank Group**



NOTE 1 BL = 8, RL = 11 (CL = 11, AL = 0), Read Preamble = 2tCK, WL = 10 (CWL = 9+1<sup>5</sup>, AL = 0), Write Preamble = 2tCK

NOTE 2 DOUT n = data-out from column n. DIN b = data-in to column b.

**NOTE 3** DES commands are shown for ease of illustration; other commands may be valid at these times.

**NOTE 3** DES commands are shown in the case of illustration; other commands may be valid at this time.

**NOTE 4** BC5 setting activated by MRO[A1:A0 = 0:1] and A12 = 1 during READ command at T<sub>8</sub>. BC4 setting activated by MRO[A1:A0 = 0:1] and A12 = 0 during WRITE command at T<sub>8</sub>.

**NOTE 5** When operating in 2tCK Write Preamble Mode, CWL must be programmed to a value at least 1 clock greater than the lowest CWL setting.

**NOTE 5** When operating in ZEN White Pageable Mode, CWD must be programmed to a value at least 1 clock greater than CA Parity = Disable, CS to CA Latency = Disable, Read DBI = Disable, Write DBI = Disable, Write CRC = Disable.

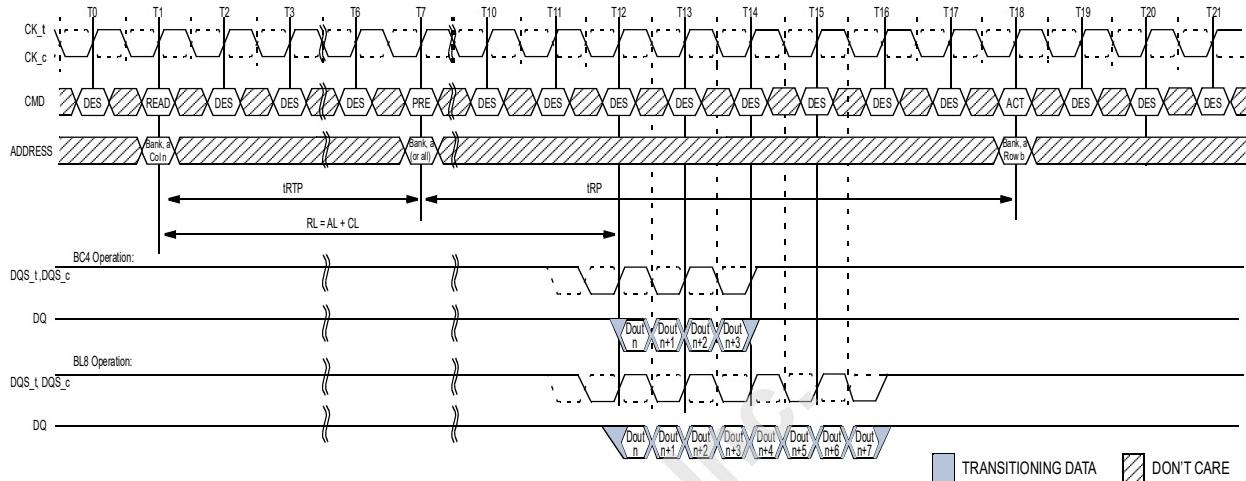
**Figure 111 — READ (BL8) to WRITE (BC4) OTF with 2tCK Preamble in Same or Different Bank Group**

#### 4.24.3 Burst Read Operation followed by a Precharge

The minimum external Read command to Precharge command spacing to the same bank is equal to AL + tRTP with tRTP being the Internal Read Command to Precharge Command Delay. Note that the minimum ACT to PRE timing, tRAS, must be satisfied as well. The minimum value for the Internal Read Command to Precharge Command Delay is given by tRTP.min. A new bank active command may be issued to the same bank if the following two conditions are satisfied simultaneously:

1. The minimum RAS precharge time (tRP.MIN) has been satisfied from the clock at which the precharge begins.
2. The minimum RAS cycle time (tRC.MIN) from the previous bank activation has been satisfied.

Examples of Read commands followed by Precharge are show in Figure 112 to Figure 114.



NOTE 1 BL = 8, RL = 11 (CL = 11, AL = 0), Preamble = 1tCK, tRTP = 6, tRP = 11

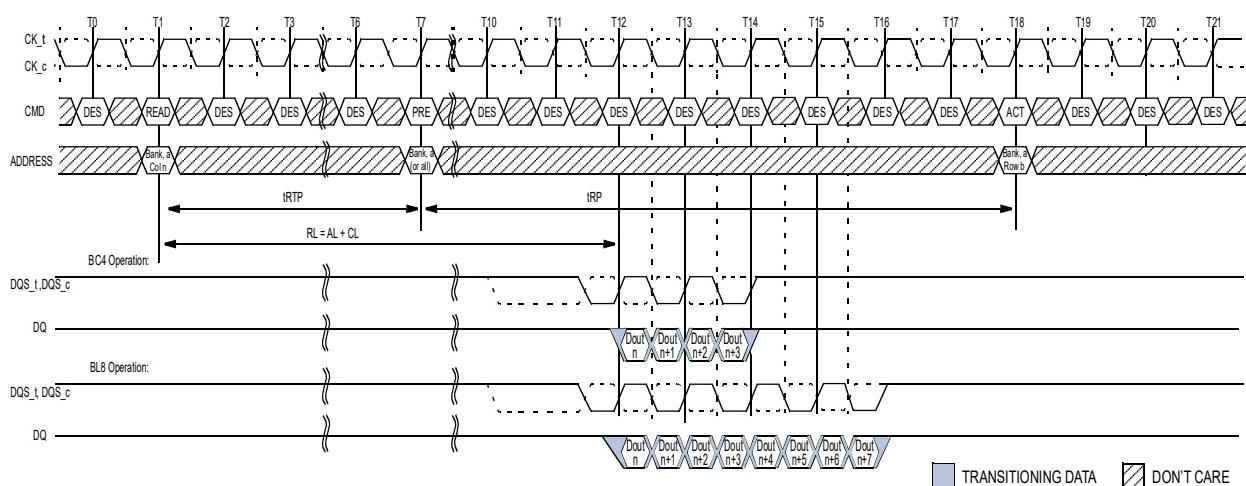
NOTE 2 DOUT n = data-out from column n.

NOTE 3 DES commands are shown for ease of illustration; other commands may be valid at these times.

NOTE 4 The example assumes tRAS. MIN is satisfied at Precharge command time(T7) and that tRC. MIN is satisfied at the next Active command time(T18).

NOTE 5 CA Parity = Disable, CS to CA Latency = Disable, Read DBI = Disable.

**Figure 112 — READ to PRECHARGE with 1tCK Preamble**



NOTE 1 BL = 8, RL = 11 (CL = 11, AL = 0), Preamble = 2tCK, tRTP = 6, tRP = 11

NOTE 2 DOUT n = data-out from column n.

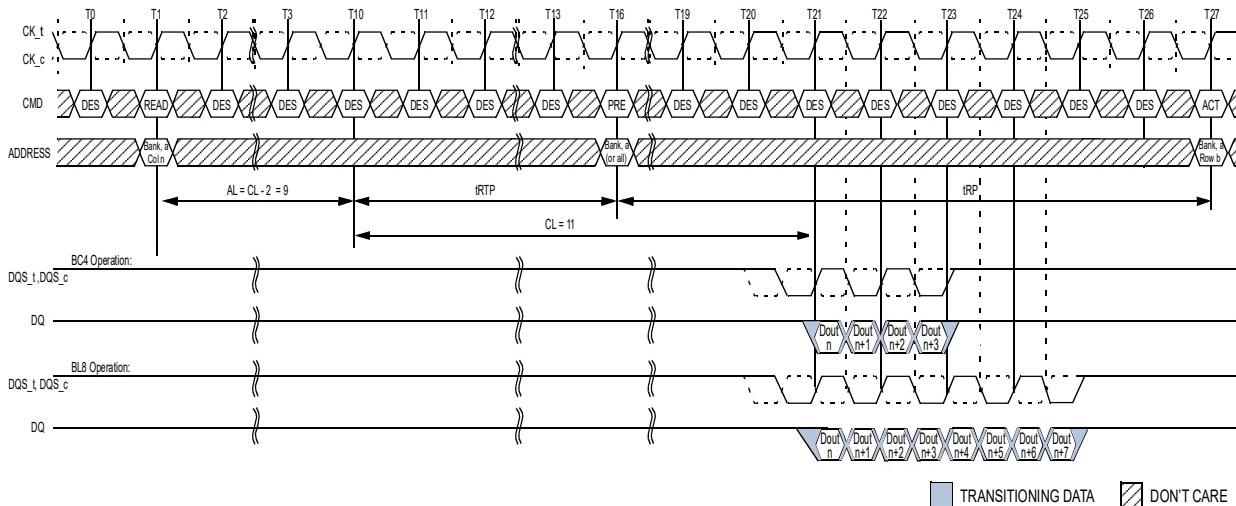
NOTE 3 DES commands are shown for ease of illustration; other commands may be valid at these times.

NOTE 4 The example assumes tRAS. MIN is satisfied at Precharge command time(T7) and that tRC. MIN is satisfied at the next Active command time(T18).

NOTE 5 CA Parity = Disable, CS to CA Latency = Disable, Read DBI = Disable.

**Figure 113 — READ to PRECHARGE with 2tCK Preamble**

#### 4.24.3 Burst Read Operation followed by a Precharge (cont'd)



NOTE 1 BL = 8, RL = 20 (CL = 11, AL = CL - 2), Preamble = 1tCK, tRTP = 6, tRP = 11

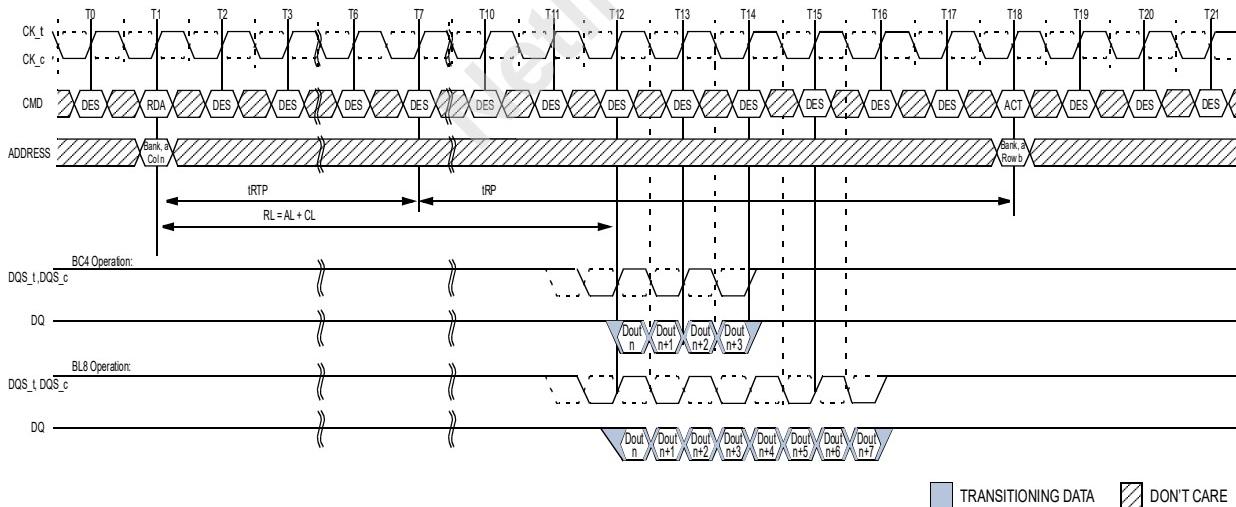
NOTE 2 DOUT n = data-out from column n.

NOTE 3 DES commands are shown for ease of illustration; other commands may be valid at these times.

NOTE 4 The example assumes tRAS. MIN is satisfied at Precharge command time(T16) and that tRC. MIN is satisfied at the next Active command time(T27).

NOTE 5 CA Parity = Disable, CS to CA Latency = Disable, Read DBI = Disable.

**Figure 114 — READ to PRECHARGE with Additive Latency and 1tCK Preamble**



NOTE 1 BL = 8, RL = 11 (CL = 11, AL = 0), Preamble = 1tCK, tRTP = 6, tRP = 11

NOTE 2 DOUT n = data-out from column n.

NOTE 3 DES commands are shown for ease of illustration; other commands may be valid at these times.

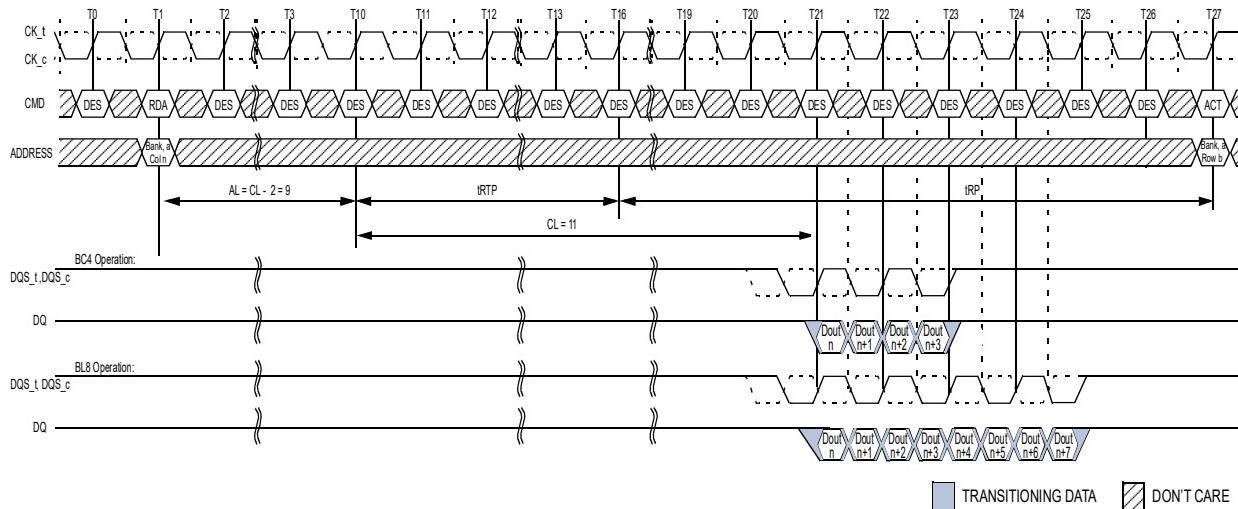
NOTE 4 tRTP = 6 setting activated by MRO[A11:9 = 001]

NOTE 5 The example assumes tRC. MIN is satisfied at the next Active command time(T18).

NOTE 6 CA Parity = Disable, CS to CA Latency = Disable, Read DBI = Disable.

**Figure 115 — READ with Auto Precharge and 1tCK Preamble**

#### 4.24.3 Burst Read Operation followed by a Precharge (cont'd)



NOTE 1 BL = 8, RL = 20 (CL = 11, AL = CL- 2), Preamble = 1tCK, tRTP = 6, tRP = 11

NOTE 2 DOUT n = data-out from column n.

NOTE 3 DES commands are shown for ease of illustration; other commands may be valid at these times.

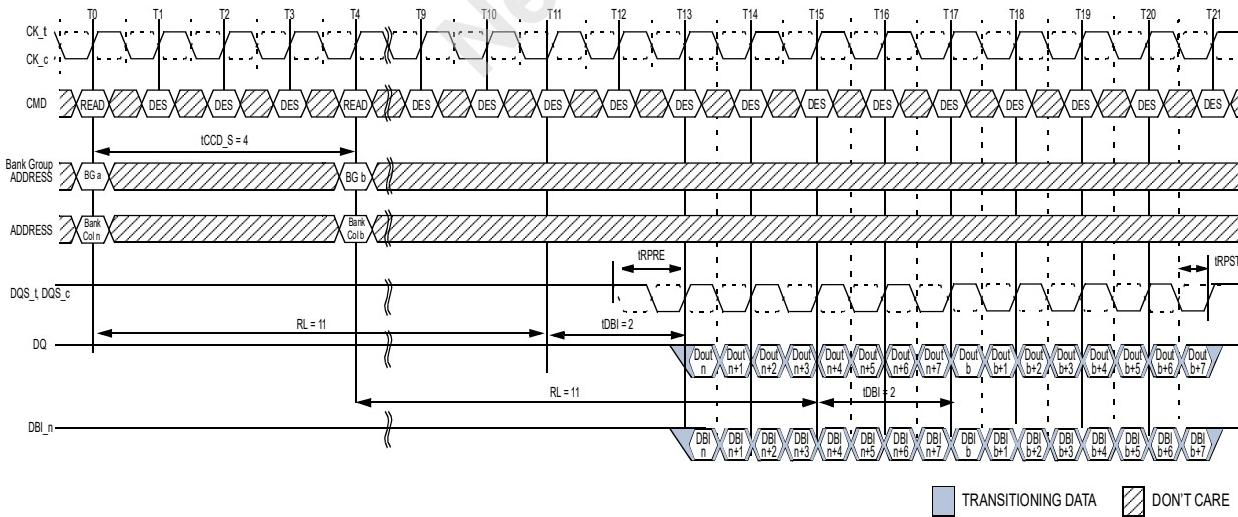
NOTE 4 tRTP = 6 setting activated by MR0[A11:9 = 001]

NOTE 5 The example assumes tRC. MIN is satisfied at the next Active command time(T27).

NOTE 6 CA Parity = Disable, CS to CA Latency = Disable, Read DBI = Disable.

**Figure 116 — READ with Auto Precharge, Additive Latency and 1tCK Preamble**

#### 4.24.4 Burst Read Operation with Read DBI (Data Bus Inversion)



NOTE 1 BL = 8, AL = 0, CL = 11, Preamble = 1tCK, tDBI = 2tCK

NOTE 2 DOUT n (or b) = data-out from column n (or column b).

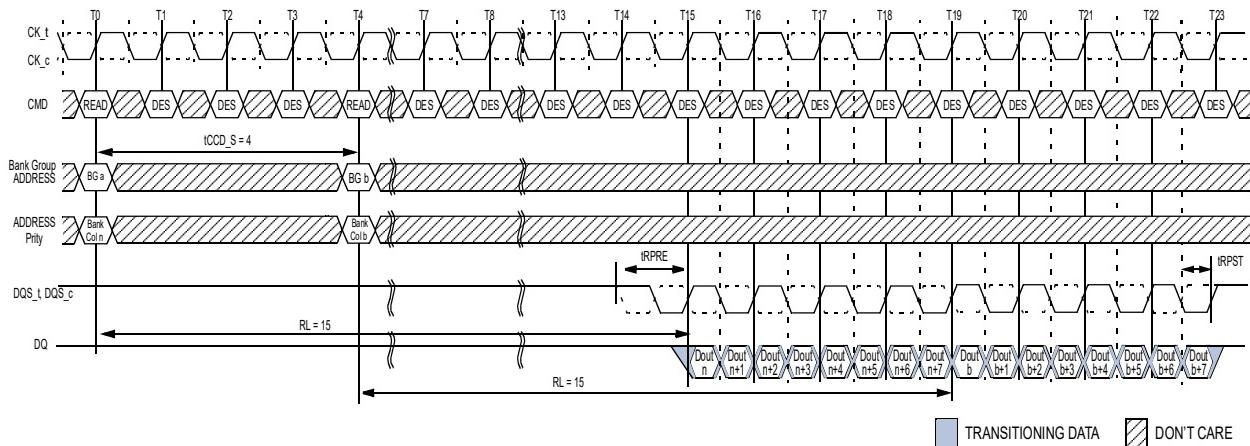
NOTE 3 DES commands are shown for ease of illustration; other commands may be valid at these times.

NOTE 4 BL8 setting activated by either MR0[A1:A0 = 00] or MR0[A1:A0 = 0:1] and A12 = 1 during READ command at T0 and T4.

NOTE 5 CA Parity = Disable, CS to CA Latency = Disable, Read DBI = Enable.

**Figure 117 — Consecutive READ (BL8) with 1tCK Preamble and DBI in Different Bank Group**

#### 4.24.5 Burst Read Operation with Command/Address Parity



NOTE 1 BL = 8, AL = 0, CL = 11, PL = 4, (RL = CL + AL + PL = 15), Preamble = 1tCK

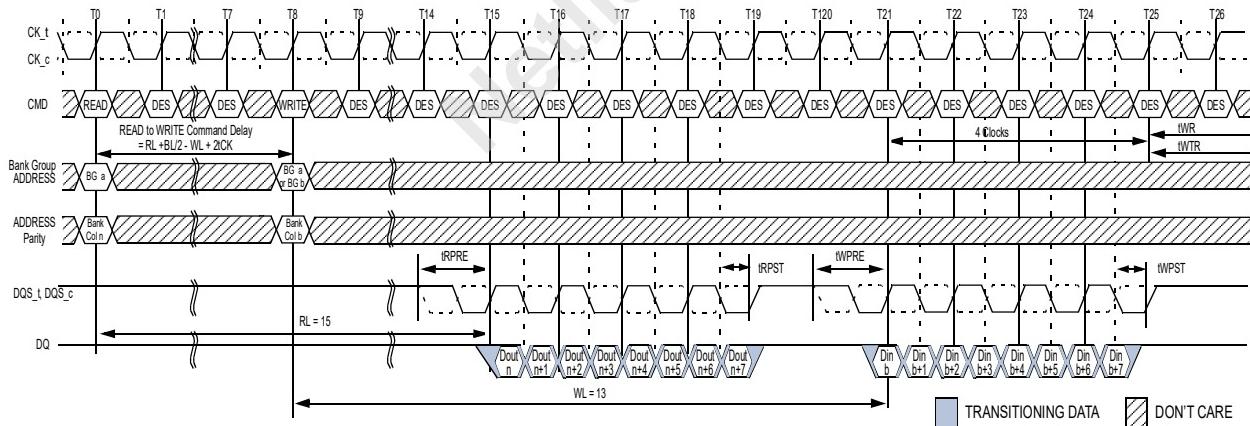
NOTE 2 DOUT n (or b) = data-out from column n (or column b).

NOTE 3 DES commands are shown for ease of illustration; other commands may be valid at these times.

NOTE 4 BL8 setting activated by either MR0[A1:A0 = 0:0] or MR0[A1:A0 = 0:1] and A12 = 1 during READ command at T0 and T4.

NOTE 5 CA Parity = Enable, CS to CA Latency = Disable, Read DBI = Disable.

**Figure 118 — Consecutive READ (BL8) with 1tCK Preamble and CA Parity in Different Bank Group**



NOTE 1 BL = 8, AL = 0, CL = 11, PL = 4, (RL = CL + AL + PL = 15), Read Preamble = 1tCK, CWL=9, AL=0, PL=4, (WL=CWL+AL+PL=13), Write Preamble = 1tCK

NOTE 2 DOUT n = data-out from column n, DIN b = data-in to column b.

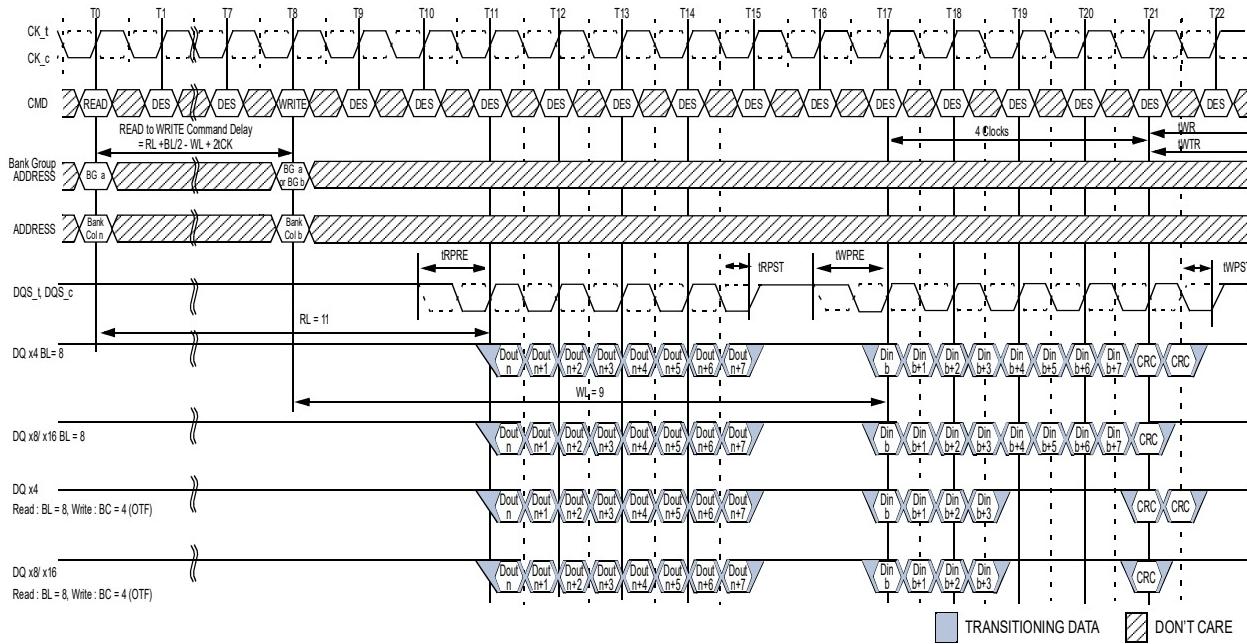
NOTE 3 DES commands are shown for ease of illustration; other commands may be valid at these times.

NOTE 4 BL8 setting activated by either MR0[A1:A0 = 0:0] or MR0[A1:A0 = 0:1] and A12 = 1 during READ command at T0 and Write command at T8.

NOTE 5 CA Parity = Enable, CS to CA Latency = Disable, Read DBI = Disable, Write DBI = Disable, Write CRC = Disable.

**Figure 119 — READ (BL8) to WRITE (BL8) with 1tCK Preamble and CA parity in Same or Different Bank Group**

#### 4.24.6 Read to Write with Write CRC



NOTE 1 BL = 8 (or BC = 4 : OTF for Write), RL = 11 (CL = 11, AL = 0), Read Preamble = 1tCK, WL=9 (CWL=9, AL=0), Write Preamble = 1tCK

NOTE 2 DOUT n = data-out from column n. DIN b = data-in to column b.

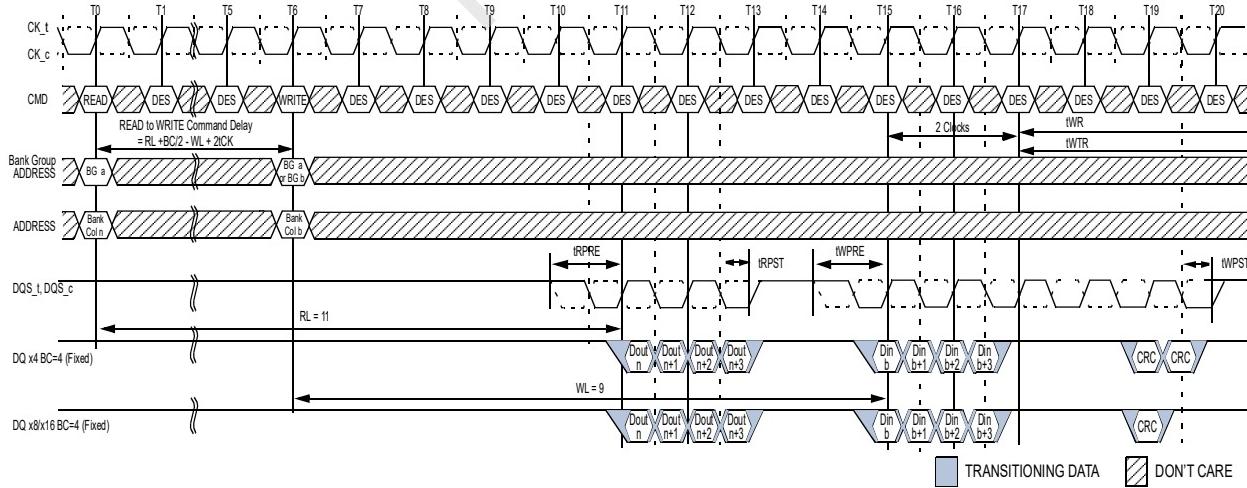
NOTE 3 DES commands are shown for ease of illustration; other commands may be valid at these times.

NOTE 4 BL8 setting activated by either MRO[A1:A0 = 0:0] or MRO[A1:A0 = 0:1] and A12 = 1 during READ command at T0 and Write command at T8.

NOTE 5 BC4 setting activated by MRO[A1:0 = 01] and A12 = 0 during Write command at T8.

NOTE 6 CA Parity = Disable, CS to CA Latency = Disable, Read DBI = Disable, Write DBI = Disable, Write CRC = Enable.

**Figure 120 — READ (BL8) to WRITE (BL8 or BC4:OTF) with 1tCK Preamble and Write CRC in Same or Different Bank Group**



NOTE 1 BC = 4 (Fixed), RL = 11 (CL = 11, AL = 0), Read Preamble = 1tCK, WL=9 (CWL=9, AL=0), Write Preamble = 1tCK

NOTE 2 DOUT n = data-out from column n. DIN b = data-in to column b.

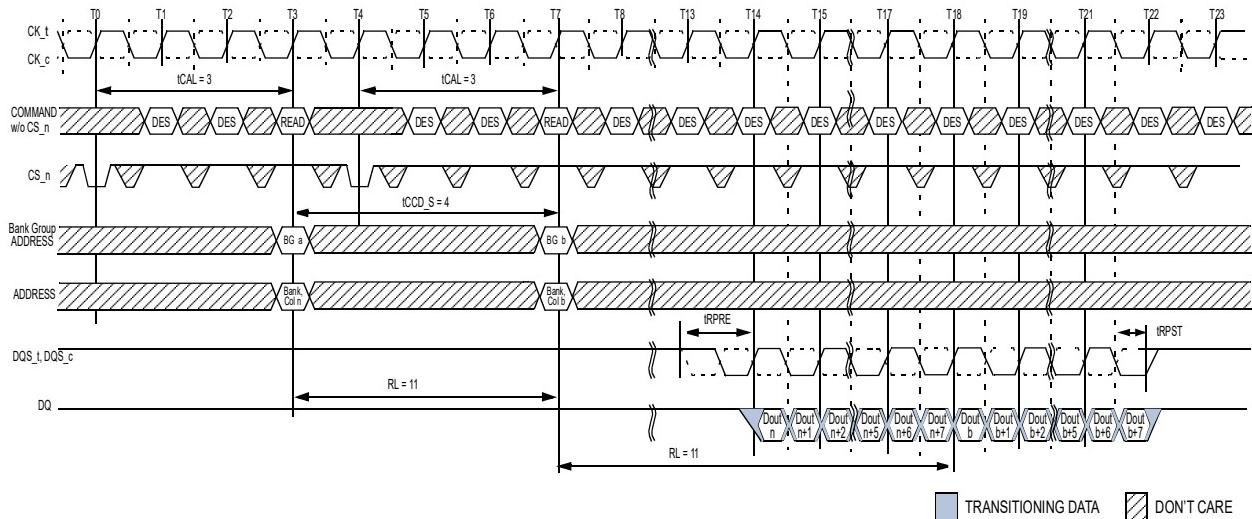
NOTE 3 DES commands are shown for ease of illustration; other commands may be valid at these times.

NOTE 4 BC4 setting activated by MRO[A1:A0 = 1:0].

NOTE 5 CA Parity = Disable, CS to CA Latency = Disable, Read DBI = Disable, Write DBI = Disable, Write CRC = Enable.

**Figure 121 — READ (BC4:Fixed) to WRITE (BC4:Fixed) with 1tCK Preamble and Write CRC in Same or Different Bank Group**

#### 4.24.7 Read to Read with CS to CA Latency



NOTE 1 BL = 8, AL = 0, CL = 11, CAL = 3, Preamble = 1tCK

NOTE 2 DOUT n (or b) = data-out from column n (or column b).

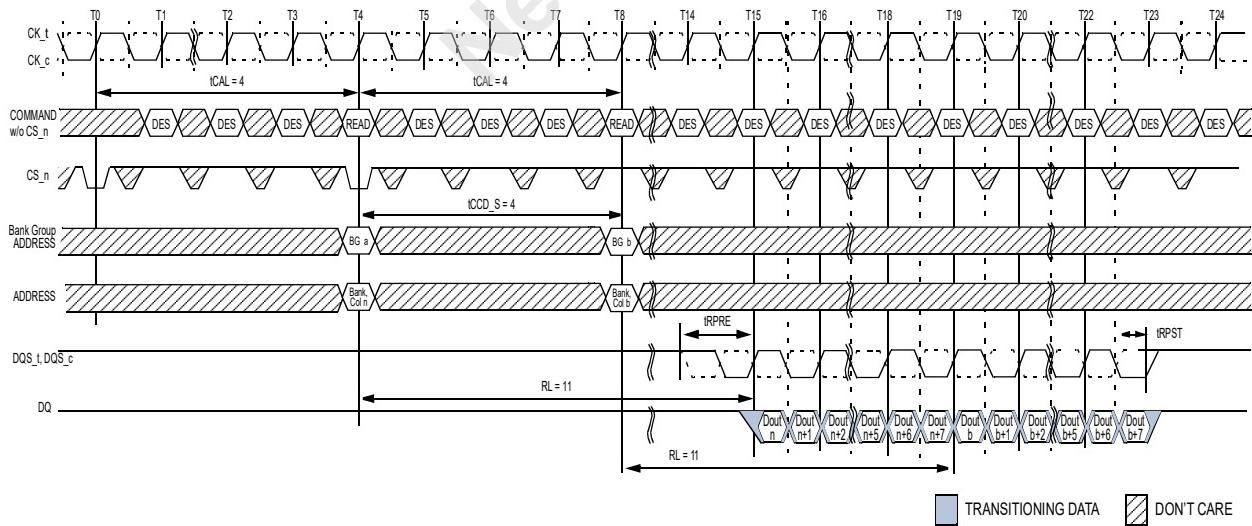
NOTE 3 DES commands are shown for ease of illustration; other commands may be valid at these times.

NOTE 4 BL8 setting activated by either MR0[A1:A0 = 0:0] or MR0[A1:A0 = 0:1] and A12 = 1 during READ command at T3 and T7.

NOTE 5 CA Parity = Disable, CS to CA Latency = Enable, Read DBI = Disable.

NOTE 6 Enabling of CAL mode does not impact ODT control timings. Users should maintain the same timing relationship relative to the command/address bus as when CAL is disabled.

**Figure 122 — Consecutive READ (BL8) with CAL(3) and 1tCK Preamble in Different Bank Group**



NOTE 1 BL = 8, AL = 0, CL = 11, CAL = 4, Preamble = 1tCK

NOTE 2 DOUT n (or b) = data-out from column n (or column b).

NOTE 3 DES commands are shown for ease of illustration; other commands may be valid at these times.

NOTE 4 BL8 setting activated by either MR0[A1:A0 = 0:0] or MR0[A1:A0 = 0:1] and A12 = 1 during READ command at T4 and T8.

NOTE 5 CA Parity = Disable, CS to CA Latency = Enable, Read DBI = Disable.

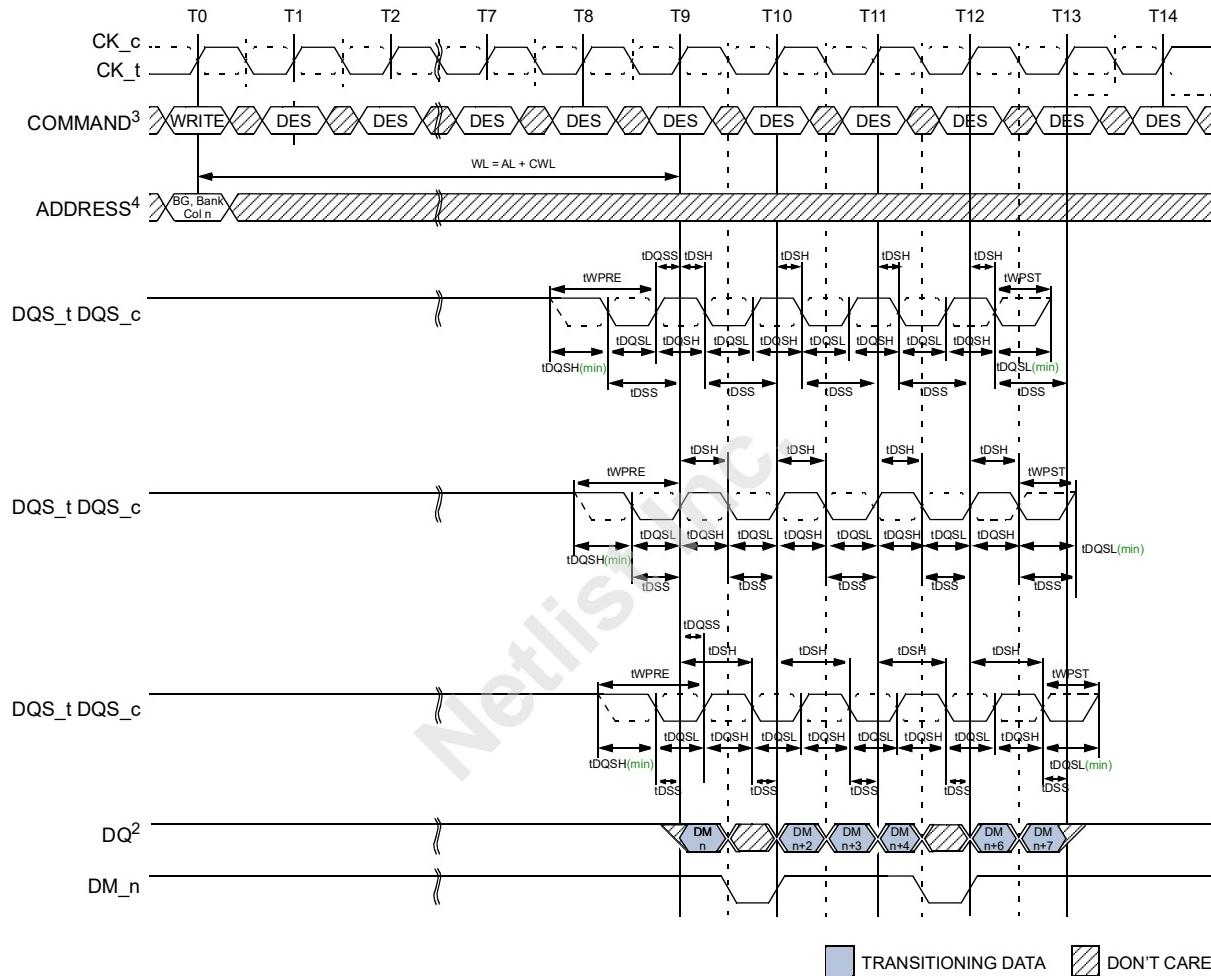
NOTE 6 Enabling of CAL mode does not impact ODT control timings. Users should maintain the same timing relationship relative to the command/address bus as when CAL is disabled.

**Figure 123 — Consecutive READ (BL8) with CAL(4) and 1tCK Preamble in Different Bank Group**

## 4.25 Write Operation

### 4.25.1 Write Timing Parameters

This drawing is for example only to enumerate the strobe edges that "belong" to a Write burst. No actual timing violations are shown here. For a valid burst all timing parameters for each edge of a burst need to be satisfied (not only for one edge - as shown).



NOTE 1 BL8, WL=9 (AL=0, CWL=9)

NOTE 2 DIN n = data-in to column n.

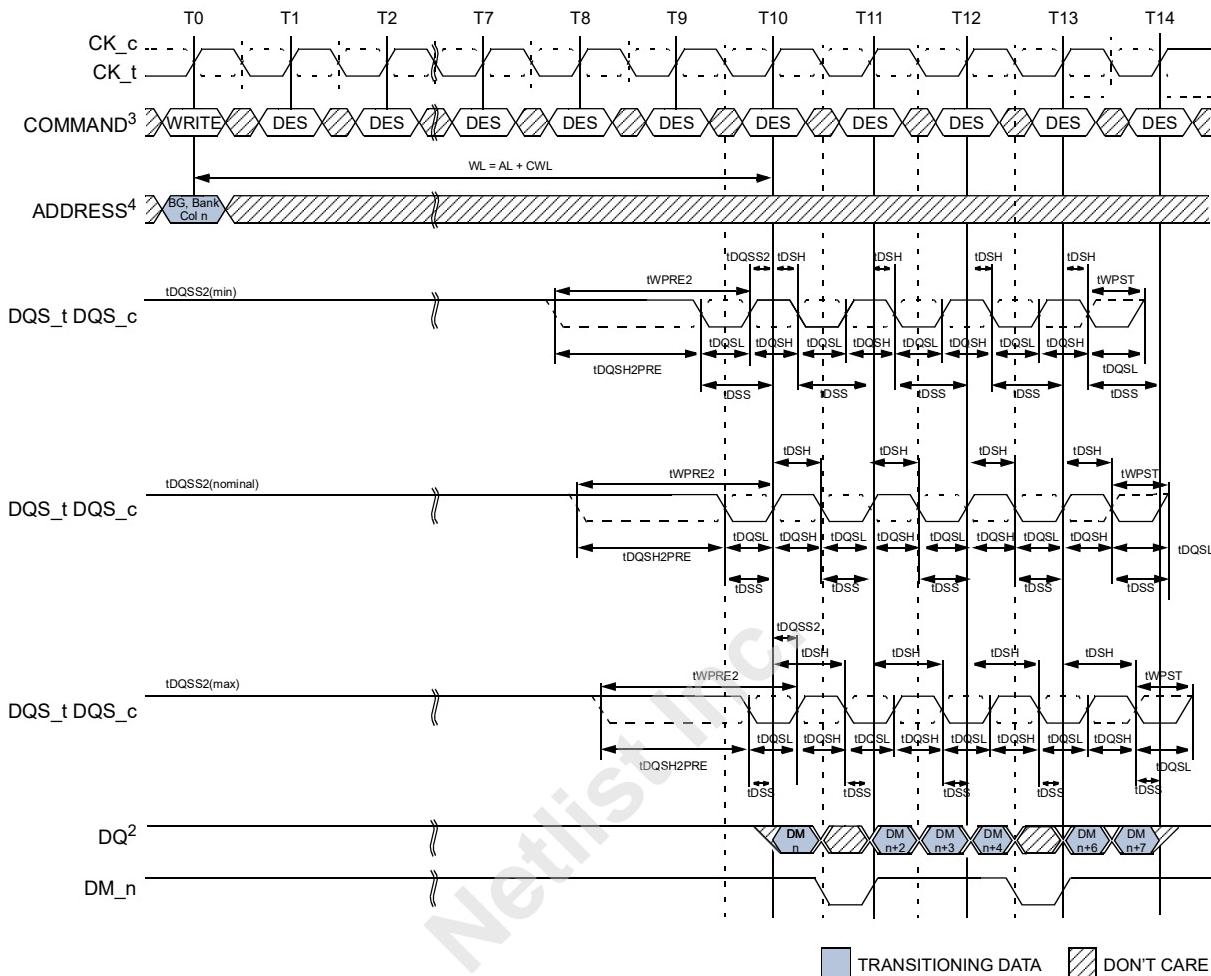
NOTE 3 DES commands are shown for ease of illustration : other commands may be valid at these times.

NOTE 4 BL8 setting activated by either MRO[A1:0=00] or MRO[A1:0=01] and A12=1 during WRITE command at T0.

NOTE 5 tDQSS must be met at each rising clock edge.

**Figure 124 — Write Timing Definition and Parameters with 1tCK Preamble**

#### 4.25.1 Write Timing Parameters (cont'd)



NOTE 1 BL8, WL=10 (AL=0, CWL=10)

NOTE 2 DIN n = data-in to column n.

NOTE 3 DES commands are shown for ease of illustration: other commands may be valid at these times.

NOTE 4 BL8 setting activated by either MR0[A1:0=00] or MR0[A1:0=01] and A12=1 during WRITE command at T0.

NOTE 5 tDQSS must be met at each rising clock edge.

**Figure 125 — Write Timing Definition and Parameters with 2tCK Preamble**

#### 4.25.2 Write Data Mask

One write data mask (DM\_n) pin for each 8 data bits (DQ) will be supported on DDR4 SDRAMs, consistent with the implementation on DDR3 SDRAMs. It has identical timings on write operations as the data bits as shown in Figure 124 and Figure 125, and though used in a unidirectional manner, is internally loaded identically to data bits to ensure matched system timing. DM\_n is not used during read cycles for any bit organizations including x4, x8, and x16, however, DM\_n of x8 bit organization can be used as TDQS\_t during write cycles if enabled by the MR1[A11] setting and x8 /x16 organization as DBI\_n during write cycles if enabled by the MR5[A11] setting. See “TDQS\_t, TDQS\_c” on page TBD for more details on TDQS vs. DM\_n operations and DBI\_n on page TBD for more detail on DBI\_n vs. DM\_n operations.

#### 4.25.3 tWPRE Calculation

The method for calculating differential pulse widths for tWPRE is shown in Figure 126.

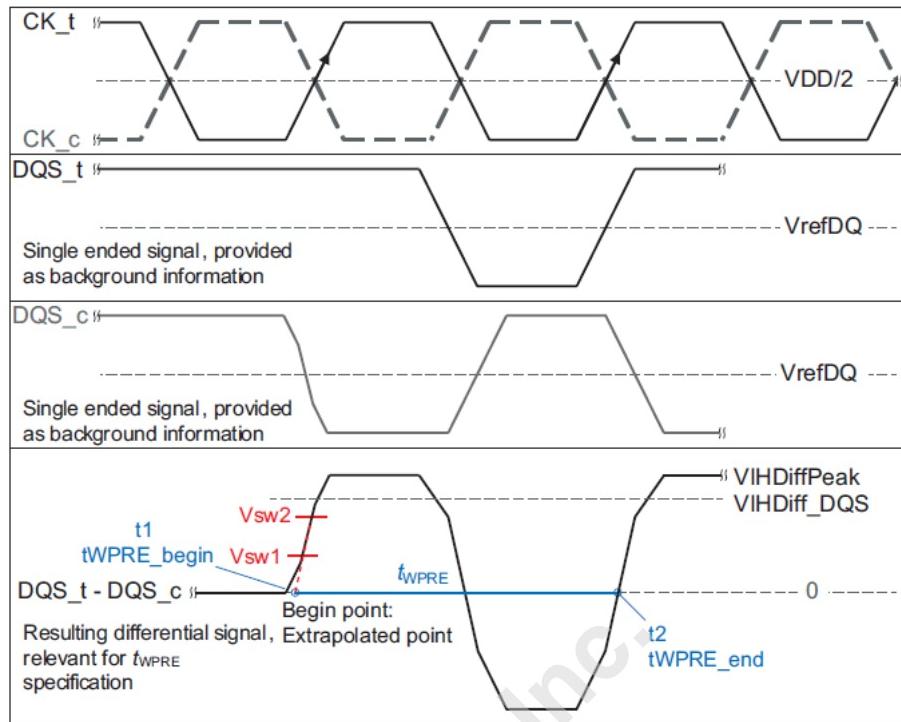


Figure 126 — Method for calculating tWPRE transitions and endpoints

Table 82 — Reference Voltage for tWPRE Timing Measurements

| Measured Parameter                       | Measured Parameter Symbol | Vsw1[V]           | Vsw2[V]           | Note |
|--|---------------------------|-------------------|-------------------|------|
| DQS_t, DQS_c differential WRITE Preamble | tWPRE                     | VIHDiff_DQS x 0.1 | VIHDiff_DQS x 0.9 |      |

The method for calculating differential pulse widths for tWPRE2 is same as tWPRE.

#### 4.25.4 tWPST Calculation

The method for calculating differential pulse widths for tWPST is shown in Figure 127.

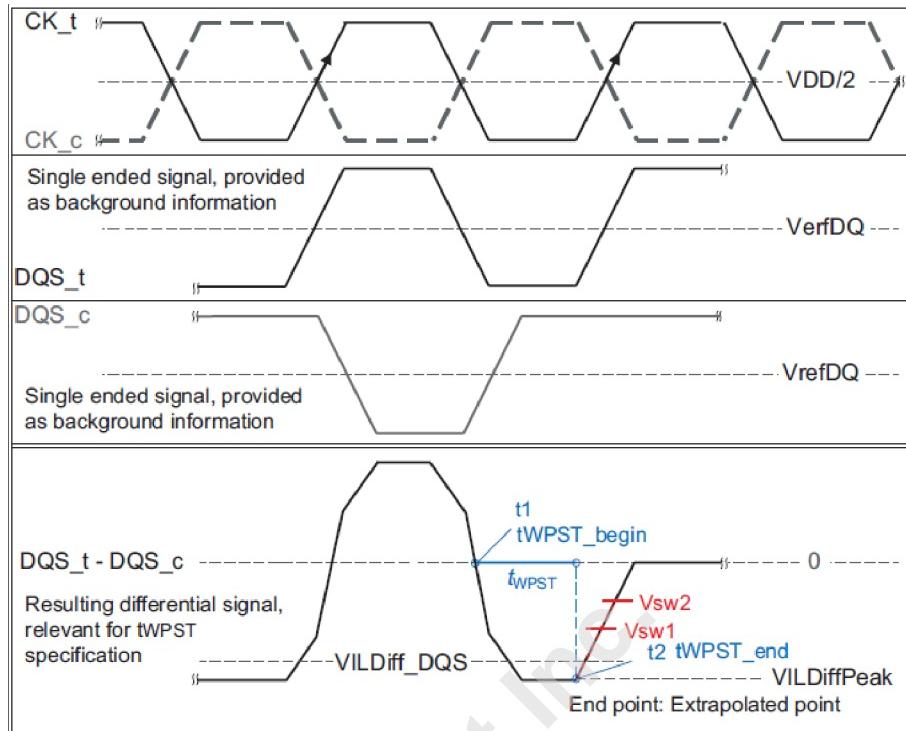


Figure 127 — Method for calculating tWPST transitions and endpoints

Table 83 — Reference Voltage for tWPST Timing Measurements

| Measured Parameter                        | Measured Parameter Symbol | $V_{sw1}[V]$               | $V_{sw2}[V]$               | Note |
|---|---------------------------|----------------------------|----------------------------|------|
| DQS_t, DQS_c differential WRITE Postamble | tWPST                     | $VILDiff_{DQS} \times 0.9$ | $VILDiff_{DQS} \times 0.1$ |      |

## 4.25.4 tWPST Calculation (cont'd)

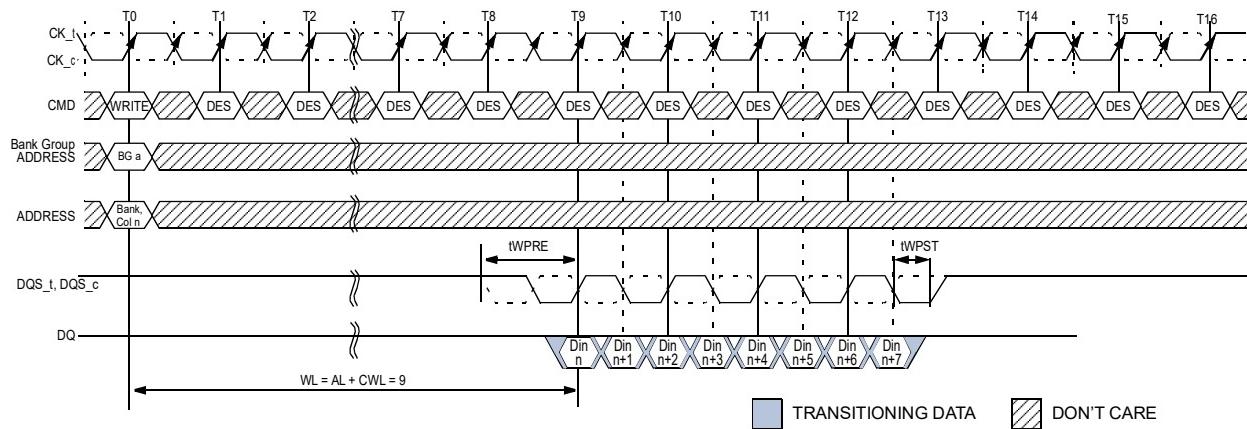
**Table 84 — Timing Parameters by Speed Grade**

| Parameter  | Symbol    | DDR4-1600 |      | DDR4-1866 |      | DDR4-2133 |      | DDR4-2400 |      | Unit     | Note |
|--|-----------|-----------|------|-----------|------|-----------|------|-----------|------|----------|------|
|  |           | Min       | Max  | Min       | Max  | Min       | Max  | Min       | Max  |          |      |
| DQS_t, DQS_c differential WRITE Preamble (1tCK Preamble)           | tWPRE     | 0.9       | -    | 0.9       | -    | 0.9       | -    | 0.9       | -    | tCK(avg) |      |
| DQS_t, DQS_c differential WRITE Preamble (2tCK Preamble)           | tWPRE2    | -         | -    | -         | -    | -         | -    | -         | -    | tCK(avg) |      |
| DQS_t, DQS_c differential WRITE Postamble                          | tWPST     | 0.33      | -    | 0.33      | -    | 0.33      | -    | 0.33      | -    | tCK(avg) |      |
| DQS_t, DQS_c differential input low pulse width                    | tDQSL     | 0.46      | 0.54 | 0.46      | 0.54 | 0.46      | 0.54 | 0.46      | 0.54 | tCK(avg) |      |
| DQS_t, DQS_c differential input high pulse width                   | tDQSH     | 0.46      | 0.54 | 0.46      | 0.54 | 0.46      | 0.54 | 0.46      | 0.54 | tCK(avg) |      |
| DQS_t, DQS_c differential input high pulse width at 2tCK Preamble  | tDQSH2PRE | -         | -    | -         | -    | -         | -    | -         | -    | tCK(avg) |      |
| DQS_t, DQS_c rising edge to CK_t, CK_c rising edge (1tCK Preamble) | tDQSS     | -0.27     | 0.27 | -0.27     | 0.27 | -0.27     | 0.27 | -0.27     | 0.27 | tCK(avg) |      |
| DQS_t, DQS_c falling edge setup time to CK_t, CK_c rising edge     | tDSS      | 0.18      | -    | 0.18      | -    | 0.18      | -    | 0.18      | -    | tCK(avg) |      |
| DQS_t, DQS_c falling edge hold time from CK_t, CK_c rising edge    | tDSH      | 0.18      | -    | 0.18      | -    | 0.18      | -    | 0.18      | -    | tCK(avg) |      |

## 4.25.5 Write Burst Operation

The following write timing diagram is to help understanding of each write parameter's meaning and just examples. The details of the definition of each parameter will be defined separately.

In these write timing diagram, CK and DQS are shown aligned and also DQS and DQ are shown center aligned for illustration purpose.



NOTE 1 BL = 8, WL = 9, AL = 0, CWL = 9, Preamble = 1tCK

NOTE 2 DIN n = data-in to column n.

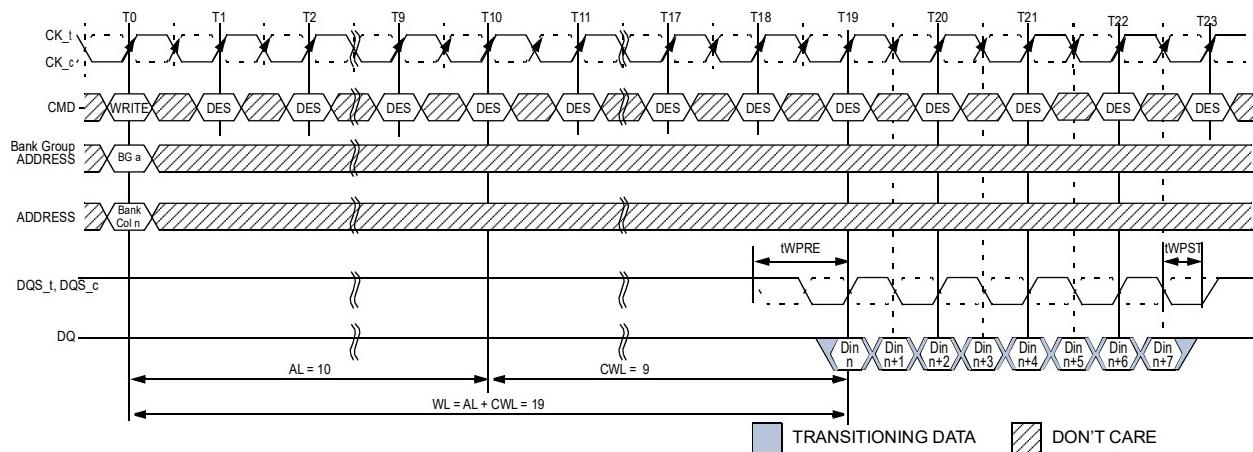
NOTE 3 DES commands are shown for ease of illustration; other commands may be valid at these times.

NOTE 4 BL8 setting activated by either MR0[A1:A0 = 0:0] or MR0[A1:A0 = 0:1] and A12 = 1 during WRITE command at T0.

NOTE 5 CA Parity = Disable, CS to CA Latency = Disable, Write DBI = Disable.

**Figure 128 — WRITE Burst Operation WL = 9 (AL = 0, CWL = 9, BL8)**

#### 4.25.5 Write Burst Operation (cont'd)



NOTE 1 BL = 8, WL = 19, AL = 10 (CL-1), CWL = 9, Preamble = 1tCK

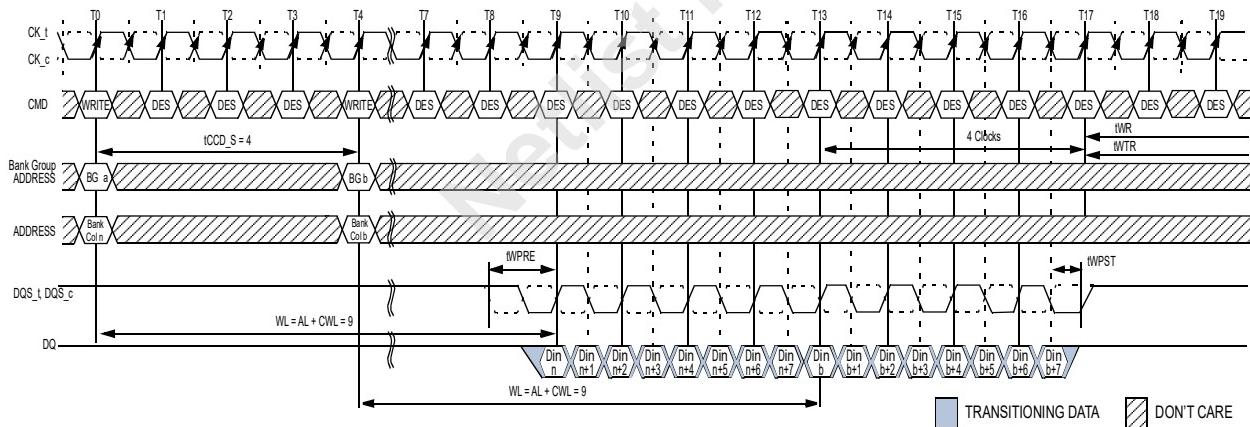
NOTE 2 DIN n = data-in to column n.

NOTE 3 DES commands are shown for ease of illustration; other commands may be valid at these times.

NOTE 4 BL8 setting activated by either MR0[A1:A0 = 0:0] or MR0[A1:A0 = 0:1] and A12 = 1 during WRITE command at T0.

NOTE 5 CA Parity = Disable, CS to CA Latency = Disable, Write DBI = Disable.

**Figure 129 — WRITE Burst Operation WL = 19 (AL = 10, CWL = 9, BL8)**



NOTE 1 BL = 8, AL = 0, CWL = 9, Preamble = 1tCK

NOTE 2 DIN n (or b) = data-in to column n (or column b).

NOTE 3 DES commands are shown for ease of illustration; other commands may be valid at these times.

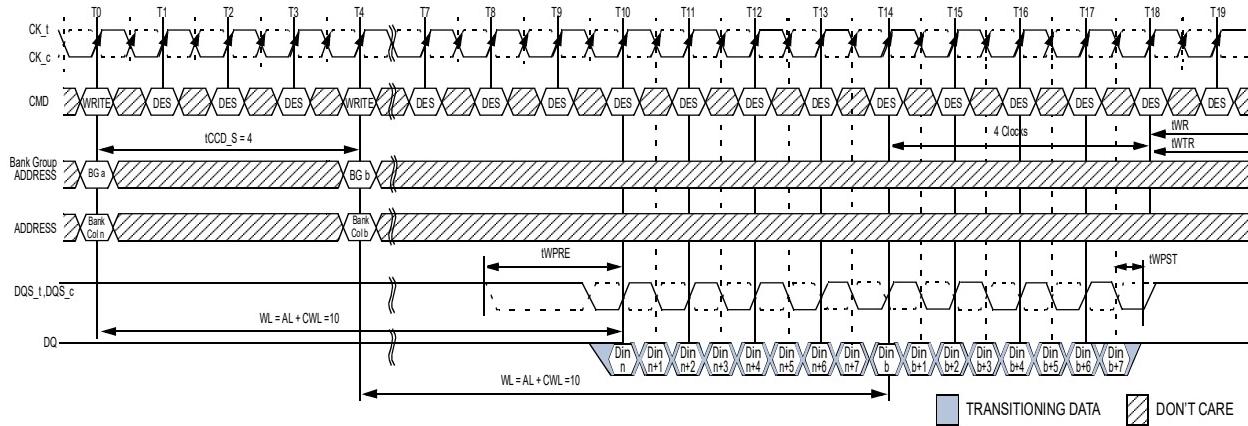
NOTE 4 BL8 setting activated by either MR0[A1:A0 = 0:0] or MR0[A1:A0 = 0:1] and A12 = 1 during WRITE command at T0 and T4.

NOTE 5 C/A Parity = Disable, CS to C/A Latency = Disable, Write DBI = Disable.

NOTE 6 The write recovery time (tWR) and write timing parameter (tWTR) are referenced from the first rising clock edge after the last write data shown at T17.

**Figure 130 — Consecutive WRITE (BL8) with 1tCK Preamble in Different Bank Group**

#### 4.25.5 Write Burst Operation (cont'd)



NOTE 1 BL = 8, AL = 0, CWL = 9 + 1 = 10<sup>7</sup>, Preamble = 2tCK

NOTE 2 DIN n (or b) = data-in to column n (or column b).

NOTE 3 DES commands are shown for ease of illustration; other commands may be valid at these times.

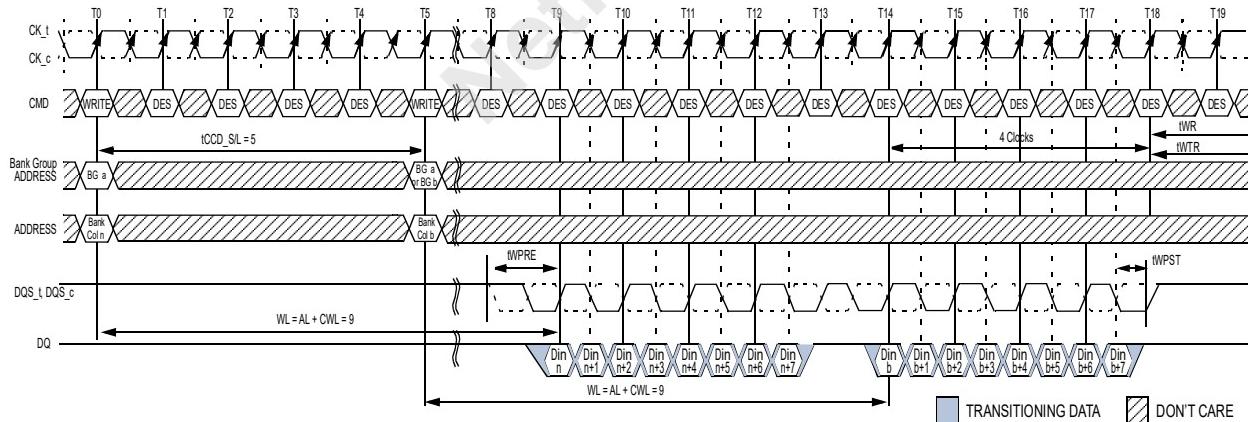
NOTE 4 BL8 setting activated by either MR0[A1:A0 = 0:0] or MR0[A1:A0 = 0:1] and A12 = 1 during WRITE command at T0 and T4.

NOTE 5 CA Parity = Disable, CS to CA Latency = Disable, Write DBI = Disable.

NOTE 6 The write recovery time(tWR) and write timing parameter(tWTR) are referenced from the first rising clock edge after the last write data shown at T18.

NOTE 7 When operating in 2tCK Write Preamble Mode, CWL must be programmed to a value at least 1 clock greater than the lowest CWL setting supported in the applicable tCK range. That means CWL = 9 is not allowed when operating in 2tCK Write Preamble Mode.

**Figure 131 — Consecutive WRITE (BL8) with 2tCK Preamble in Different Bank Group**



NOTE 1 BL = 8, AL = 0, CWL = 9, Preamble = 1tCK, tCCCD\_S/L = 5

NOTE 2 DIN n (or b) = data-in to column n (or column b).

NOTE 3 DES commands are shown for ease of illustration; other commands may be valid at these times.

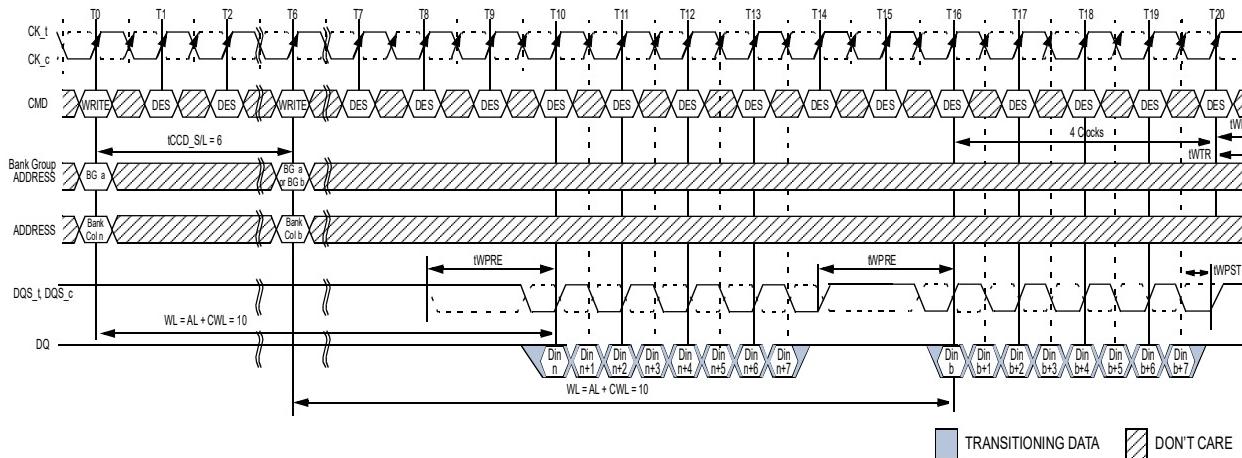
NOTE 4 BL8 setting activated by either MR0[A1:A0 = 0:0] or MR0[A1:A0 = 0:1] and A12 = 1 during WRITE command at T0 and T5.

NOTE 5 CA Parity = Disable, CS to CA Latency = Disable, Write DBI = Disable.

NOTE 6 The write recovery time (tWR) and write timing parameter (tWTR) are referenced from the first rising clock edge after the last write data shown at T18.

**Figure 132 — Nonconsecutive WRITE (BL8) with 1tCK Preamble in Same or Different Bank Group**

#### 4.25.5 Write Burst Operation (cont'd)



NOTE 1 BL = 8, AL = 0, CWL = 9 + 1 =  $10^8$ , Preamble = 2tCK, tCCD\_S/L = 6

NOTE 2 DIN n (or b) = data-in to column n (or column b).

NOTE 3 DES commands are shown for ease of illustration; other commands may be valid at these times.

NOTE 4 BL8 setting activated by either MRO[A1:A0 = 0:0] or MRO[A1:A0 = 0:1] and A12 = 1 during WRITE command at T0 and T6.

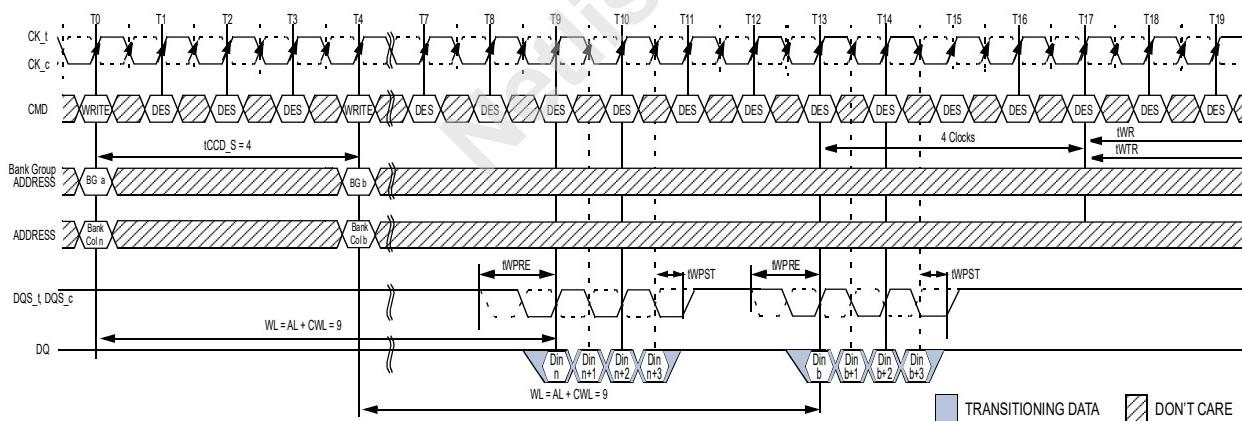
NOTE 5 CA Parity = Disable, CS to CA Latency = Disable, Write DBI = Disable.

NOTE 6 tCCD\_S/L=5 isn't allowed in 2tCK preamble mode.

NOTE 7 The write recovery time (tWR) and write timing parameter (tWTR) are referenced from the first rising clock edge after the last write data shown at T20.

NOTE 8 When operating in 2tCK Write Preamble Mode, CWL must be programmed to a value at least 1 clock greater than the lowest CWL setting supported in the applicable tCK range. That means CWL = 9 is not allowed when operating in 2tCK Write Preamble Mode.

**Figure 133 — Nonconsecutive WRITE (BL8) with 2tCK Preamble in Same or Different Bank Group**



NOTE 1 BC = 4, AL = 0, CWL = 9 , Preamble = 1tCK

NOTE 2 DIN n (or b) = data-in to column n (or column b).

NOTE 3 DES commands are shown for ease of illustration; other commands may be valid at these times.

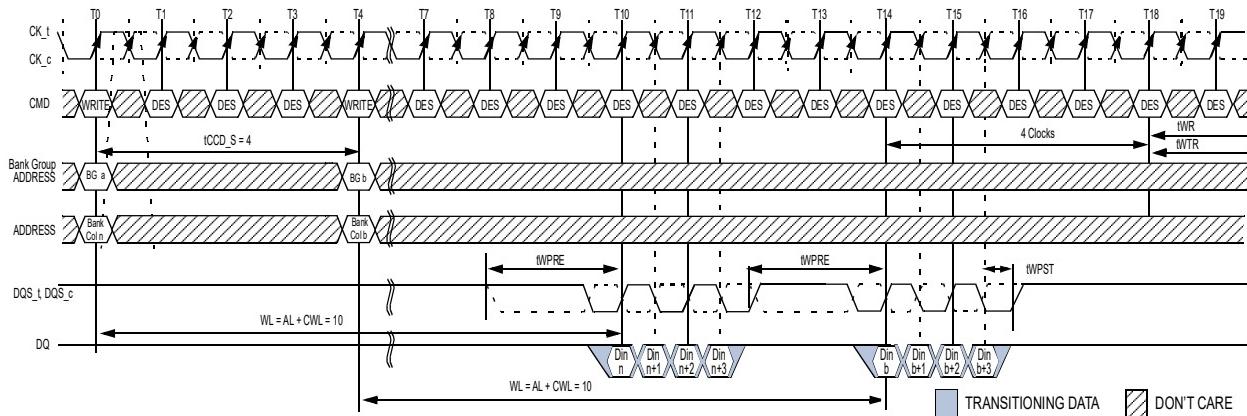
NOTE 4 BC4 setting activated by MRO[A1:A0 = 0:1] and A12 = 0 during WRITE command at T0 and T4.

NOTE 5 CA Parity = Disable, CS to CA Latency = Disable, Write DBI = Disable.

NOTE 6 The write recovery time (tWR) and write timing parameter (tWTR) are referenced from the first rising clock edge after the last write data shown at T17.

**Figure 134 — WRITE (BC4) OTF to WRITE (BC4) OTF with 1tCK Preamble in Different Bank Group**

## 4.25.5 Write Burst Operation (cont'd)



NOTE 1 BC = 4, AL = 0, CWL = 9 + 1 =  $10^7$ , Preamble = 2tCK

NOTE 2 DIN n (or b) = data-in to column n (or column b).

NOTE 3 DES commands are shown for ease of illustration; other commands may be valid at these times.

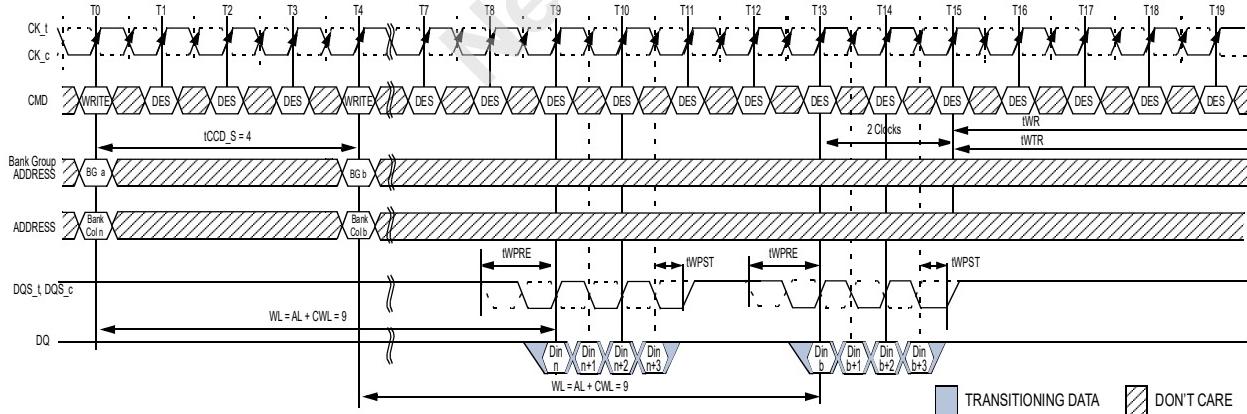
NOTE 4 BC4 setting activated by MRO[A1:A0 = 0:1] and A12 = 0 during WRITE command at T0 and T4.

NOTE 5 CA Parity = Disable, CS to CA Latency = Disable, Write DBI = Disable.

NOTE 6 The write recovery time (tWR) and write timing parameter (tWTR) are referenced from the first rising clock edge after the last write data shown at T18.

NOTE 7 When operating in 2tCK Write Preamble Mode, CWL must be programmed to a value at least 1 clock greater than the lowest CWL setting supported in the applicable tCK range. That means CWL = 9 is not allowed when operating in 2tCK Write Preamble Mode.

**Figure 135 — WRITE (BC4) OTF to WRITE (BC4) OTF with 2tCK Preamble in Different Bank Group**



NOTE 1 BC = 4, AL = 0, CWL = 9 , Preamble = 1tCK

NOTE 2 DIN n (or b) = data-in to column n (or column b).

NOTE 3 DES commands are shown for ease of illustration; other commands may be valid at these times.

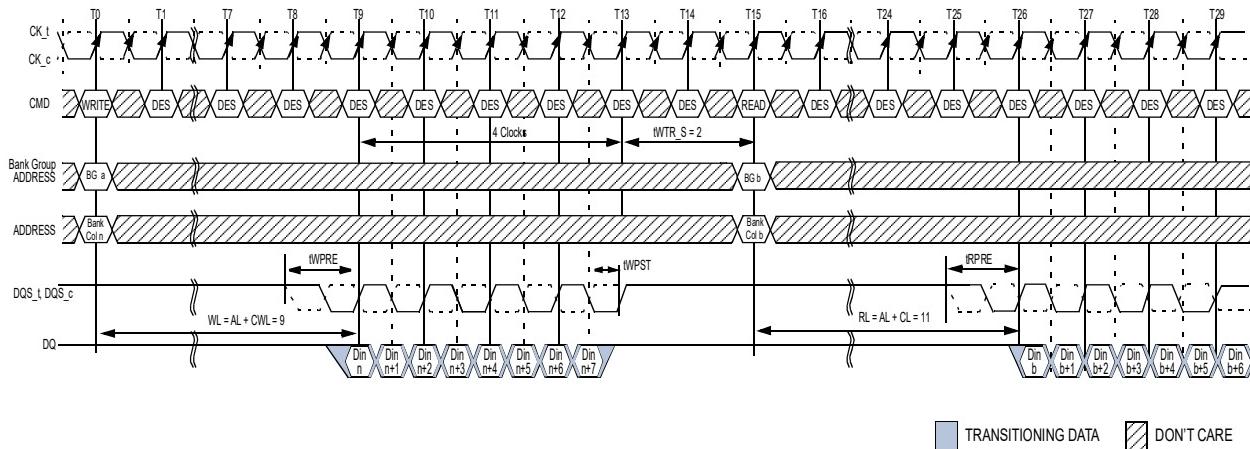
NOTE 4 BC4 setting activated by MRO[A1:A0 = 1:0].

NOTE 5 CA Parity = Disable, CS to CA Latency = Disable, Write DBI = Disable.

NOTE 6 The write recovery time (tWR) and write timing parameter (tWTR) are referenced from the first rising clock edge after the last write data shown at T15.

**Figure 136 — WRITE (BC4) Fixed to WRITE (BC4) Fixed with 1tCK Preamble in Different Bank Group**

#### 4.25.5 Write Burst Operation (cont'd)



NOTE 1 BC = 4, AL = 0, CWL = 9, CL = 11, Preamble = 1tCK

NOTE 2 DIN n = data-in to column n(or column b). DOUT b = data-out from column b.

**NOTE 3** DES commands are shown for ease of illustration; other commands may be valid at these times.

**NOTE 4** BL8 setting activated by either MRO[1:A1=0:0] or MRO[0:A1,A0=0:1] and A12 = 1 during WRITE command at T0 and READ command at T15.

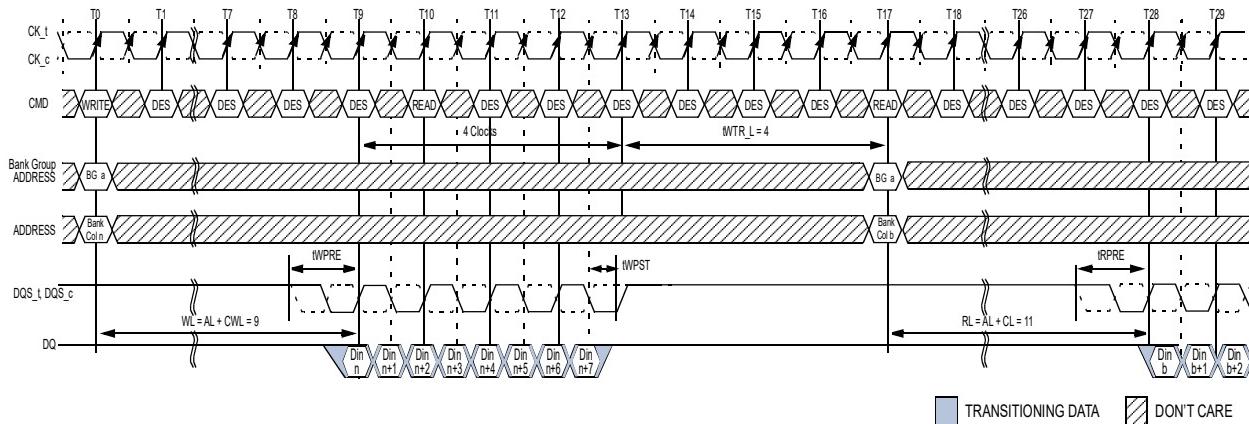
**NOTE 5** CA Parity = Disable, CS to CA Latency = Disable, Write DBI = Disable.

**NOTE 6** The write timing parameter ( $t_{WTR(S)}$ ) are referenced from the first rising clock edge after the last write data shown at T13.

When AL is non-zero, the external read command at T15 can be pulled in by AL.

**Figure 137 — WRITE (BL8) to READ (BL8) with 1tCK Preamble in Different Bank Group**

#### 4.25.5 Write Burst Operation (cont'd)



NOTE 1 BL = 8, AL = 0, CWL = 9, CL = 11, Preamble = 1tCK

NOTE 2 DIN n = data-in to column n (or column b). DOUT b = data-out from column b.

**NOTE 3** DES commands are shown for ease of illustration; other commands may be valid at these times.

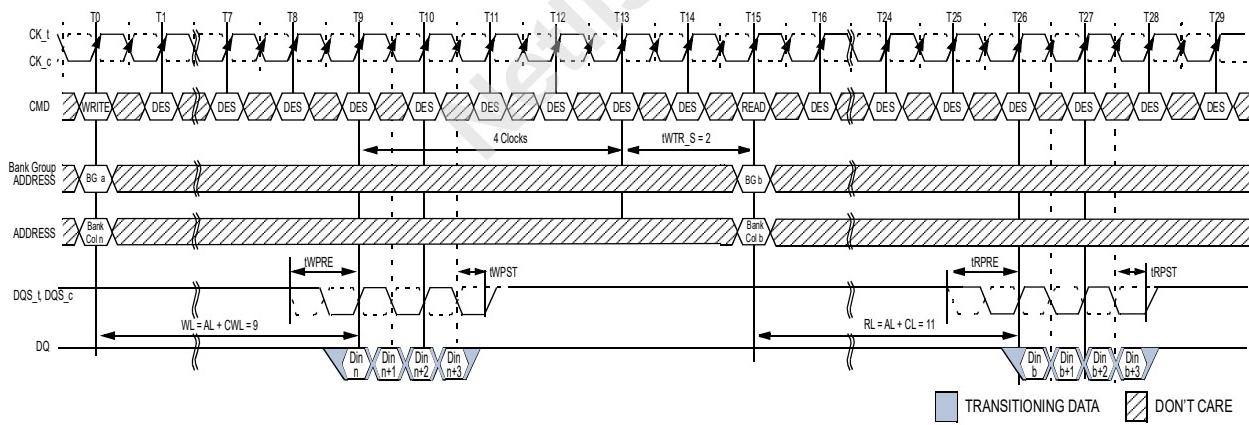
NOTE 6: DEC commands are shown for each of instruction; other commands may be valid at those times.

**NOTE 5** CA Parity = Disable, CS to CA Latency = Disable, Write DBI = Disable.

**NOTE 6** The write timing parameter ( $t_{WTR-L}$ ) are referenced from the first rising clock edge after the last write data shown at T13.

When AI<sub>1</sub> is non-zero, the external read command at T17 can be pulled in by AI<sub>1</sub>.

**Figure 138 — WRITE (BL8) to READ (BL8) with 1tCK Preamble in Same Bank Group**



NOTE 1 BC = 4, AL = 0, CWL = 9, CL = 11, Preamble = 1tCK

NOTE 2 DIN n = data-in to column n (or column b). DOUT b = data-out from column b.

NOTE 3 DES commands are shown for ease of illustration; other commands may be valid at these times.

NOTE 4 BC4 setting activated by MRO[A1:A0 = 0:1] and A12 = 0 during WRITE command at T0 and READ command at T15.

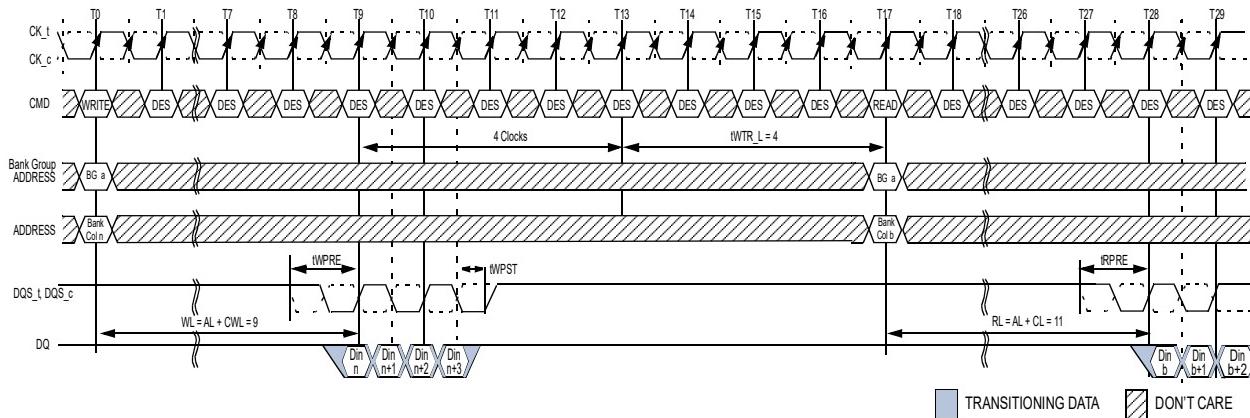
NOTE 5 CA Parity = Disable, CS to CA Latency = Disable, Write DBI = Disable.

**NOTE 6** The write timing parameter ( $t_{WTR}$ ) are referenced from the first rising clock edge after the last write data shown at T13.

When AL is non-zero, the external read command at T15 can be pulled in by AL.

**Figure 139 — WRITE (BC4)OTF to READ (BC4)OTF with 1tCK Preamble in Different Bank Group**

#### 4.25.5 Write Burst Operation (cont'd)



NOTE 1 BC = 4, AL = 0, CWL = 9, CL = 11, Preamble = 1tCK

NOTE 2 DIN n = data-in to column n (or column b). DOUT b = data-out from column b.

NOTE 3 DES commands are shown for ease of illustration; other commands may be valid at these times.

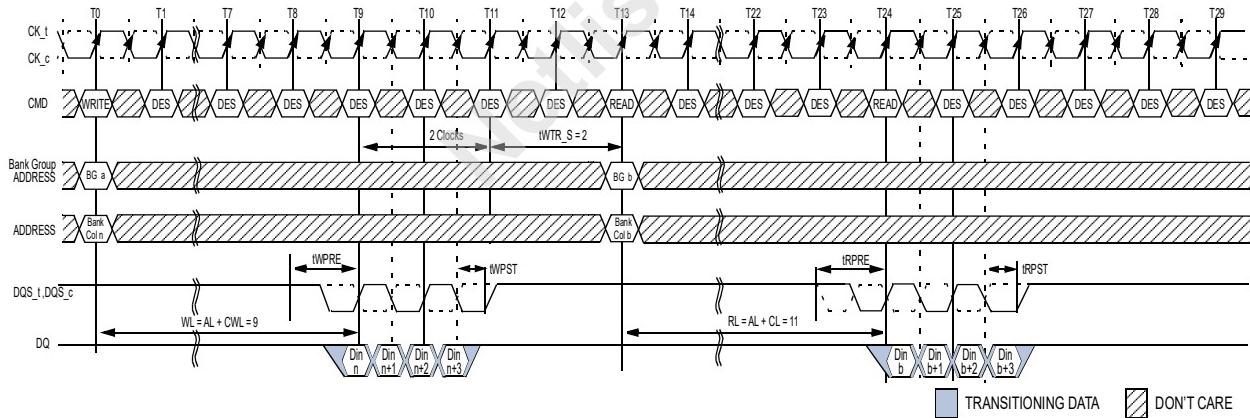
NOTE 4 BC4 setting activated by MRO[A1:A0 = 0:1] and A12 = 0 during WRITE command at T0 and READ command at T17.

NOTE 5 CA Parity = Disable, CS to CA Latency = Disable, Write DBI = Disable.

NOTE 6 The write timing parameter (tWTR\_L) are referenced from the first rising clock edge after the last write data shown at T13.

When AL is non-zero, the external read command at T17 can be pulled in by AL.

**Figure 140 — WRITE (BC4)OTF to READ (BC4)OTF with 1tCK Preamble in Same Bank Group**



NOTE 1 BC = 4, AL = 0, CWL = 9, CL = 11, Preamble = 1tCK

NOTE 2 DIN n = data-in to column n (or column b). DOUT b = data-out from column b.

NOTE 3 DES commands are shown for ease of illustration; other commands may be valid at these times.

NOTE 4 BC4 setting activated by MRO[A1:A0 = 1:0].

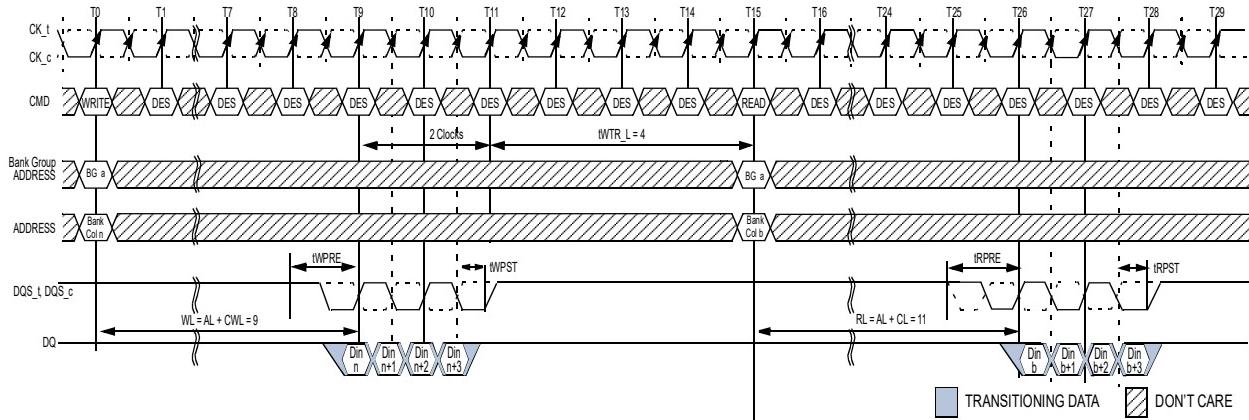
NOTE 5 CA Parity = Disable, CS to CA Latency = Disable, Write DBI = Disable.

NOTE 6 The write timing parameter (tWTR\_S) are referenced from the first rising clock edge after the last write data shown at T11.

When AL is non-zero, the external read command at T13 can be pulled in by AL.

**Figure 141 — WRITE (BC4)Fixed to READ (BC4)Fixed with 1tCK Preamble in Different Bank Group**

## 4.25.5 Write Burst Operation (cont'd)



NOTE 1. BC = 4, AL = 0, CWL = 9, CL = 11, Preamble = 1tCK

NOTE 2 DIN n = data-in to column n (or column b). DOUT b = data-out from column b.

NOTE 3 DES commands are shown for ease of illustration; other commands may be valid at these times.

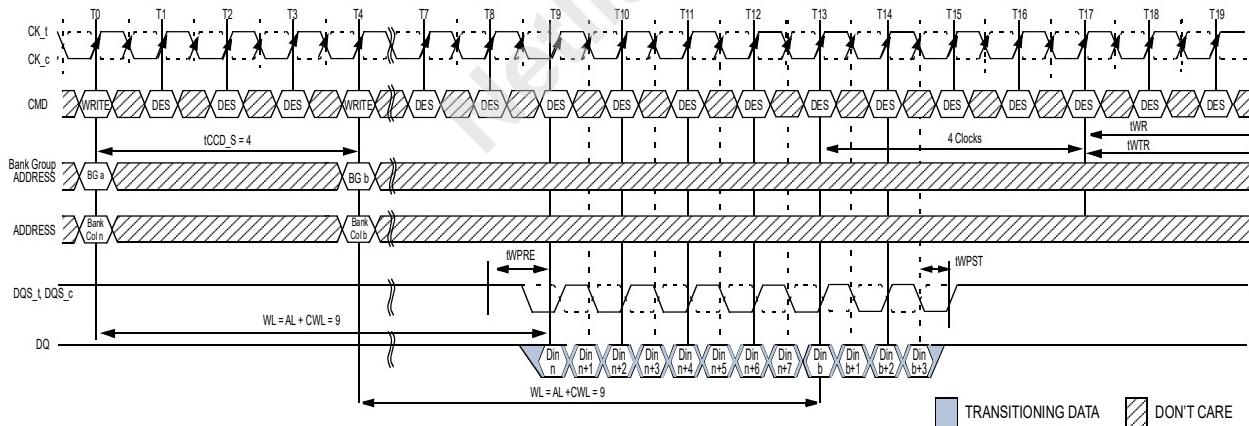
NOTE 4 BC4 setting activated by MRO[A1:A0 = 1:0].

NOTE 5 CA Parity = Disable, CS to CA Latency = Disable, Write DBI = Disable.

NOTE 6 The write timing parameter (tWTR\_L) are referenced from the first rising clock edge after the last write data shown at T11.

When AL is non-zero, the external read command at T15 can be pulled in by AL.

**Figure 142 — WRITE (BC4)Fixed to READ (BC4)Fixed with 1tCK Preamble in Same Bank Group**



NOTE 1. BL = 8 / BC = 4, AL = 0, CWL = 9, Preamble = 1tCK

NOTE 2. DIN n (or b) = data-in to column n (or column b).

NOTE 3. DES commands are shown for ease of illustration; other commands may be valid at these times.

NOTE 4. BL8 setting activated by MRO[A1:A0 = 0:1] and A12 = 1 during WRITE command at T0.

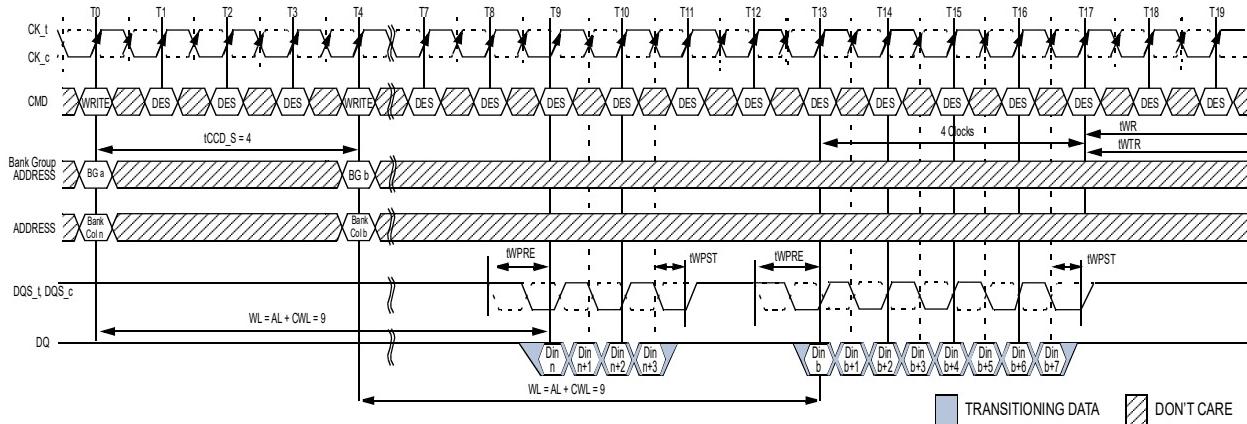
BC4 setting activated by MRO[A1:A0 = 0:1] and A12 = 0 during WRITE command at T4.

NOTE 5 CA Parity = Disable, CS to CA Latency = Disable, Write DBI = Disable.

NOTE 6 The write recovery time (tWR) and write timing parameter (tWTR) are referenced from the first rising clock edge after the last write data shown at T11.

**Figure 143 — WRITE (BL8) to WRITE (BC4) OTF with 1tCK Preamble in Different Bank Group**

#### 4.25.5 Write Burst Operation (cont'd)



NOTE 1 BL = 8 / BC = 4, AL = 0, CWL = 9, Preamble = 1tCK

NOTE 2 DIN n (or b) = data-in to column n (or column b).

NOTE 3 DES commands are shown for ease of illustration; other commands may be valid at these times.

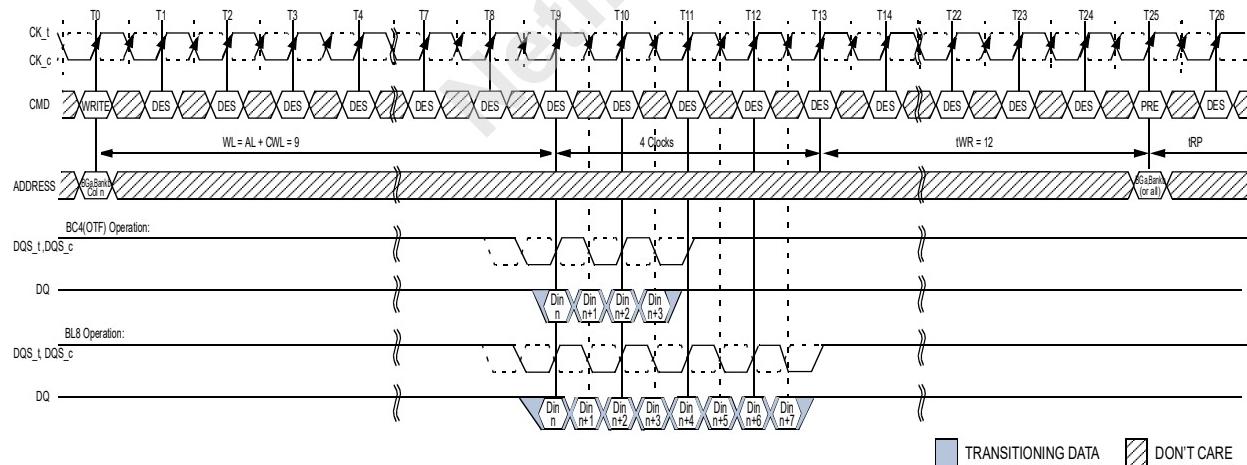
NOTE 4 BC4 setting activated by MR0[A1:A0 = 0:1] and A12 = 0 during WRITE command at T0.

BL8 setting activated by MR0[A1:A0 = 0:1] and A12 = 1 during WRITE command at T4.

NOTE 5 CA Parity = Disable, CS to CA Latency = Disable, Write DBI = Disable.

NOTE 6 The write recovery time (tWR) and write timing parameter (tWTR) are referenced from the first rising clock edge after the last write data shown at T17

**Figure 144 — WRITE (BC4)OTF to WRITE (BL8) with 1tCK Preamble in Different Bank Group**



NOTE 1. BL = 8 / BC = 4, AL = 0, CWL = 9, Preamble = 1tCK, tWR = 12

NOTE 2. DIN n = data-in to column n.

NOTE 3. DES commands are shown for ease of illustration; other commands may be valid at these times.

NOTE 4. BC4 setting activated by MR0[A1:A0 = 0:1] and A12 = 0 during WRITE command at T0.

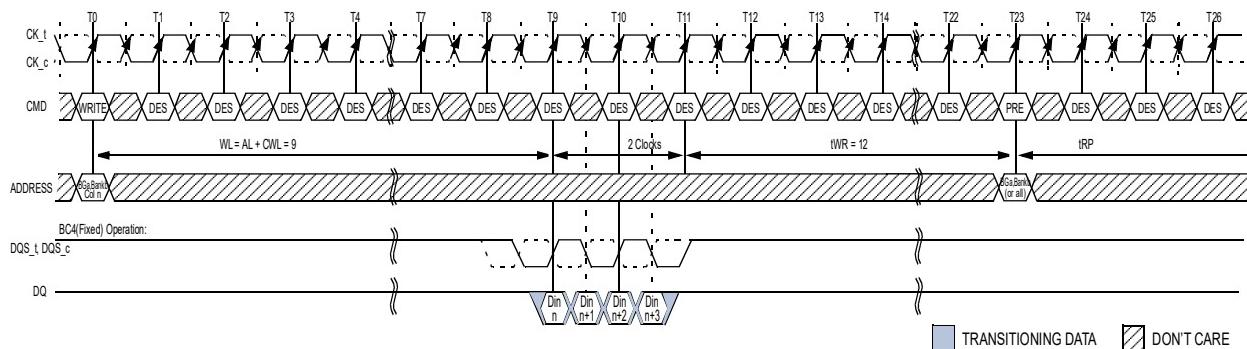
BL8 setting activated by MR0[A1:A0 = 0:0] or MR0[A1:0 = 0:1] and A12 = 1 during WRITE command at T0.

NOTE 5. CA Parity = Disable, CS to CA Latency = Disable, Write DBI = Disable.

NOTE 6. The write recovery time (tWR) is referenced from the first rising clock edge after the last write data shown at T13.  
tWR specifies the last burst write cycle until the precharge command can be issued to the same bank.

**Figure 145 — WRITE (BL8/BC4) OTF to PRECHARGE Operation with 1tCK Preamble**

## 4.25.5 Write Burst Operation (cont'd)



NOTE 1 BC = 4, AL = 0, CWL = 9, Preamble = 1tCK, tWR = 12

NOTE 2 DIN n = data-in to column n.

NOTE 3 DES commands are shown for ease of illustration; other commands may be valid at these times.

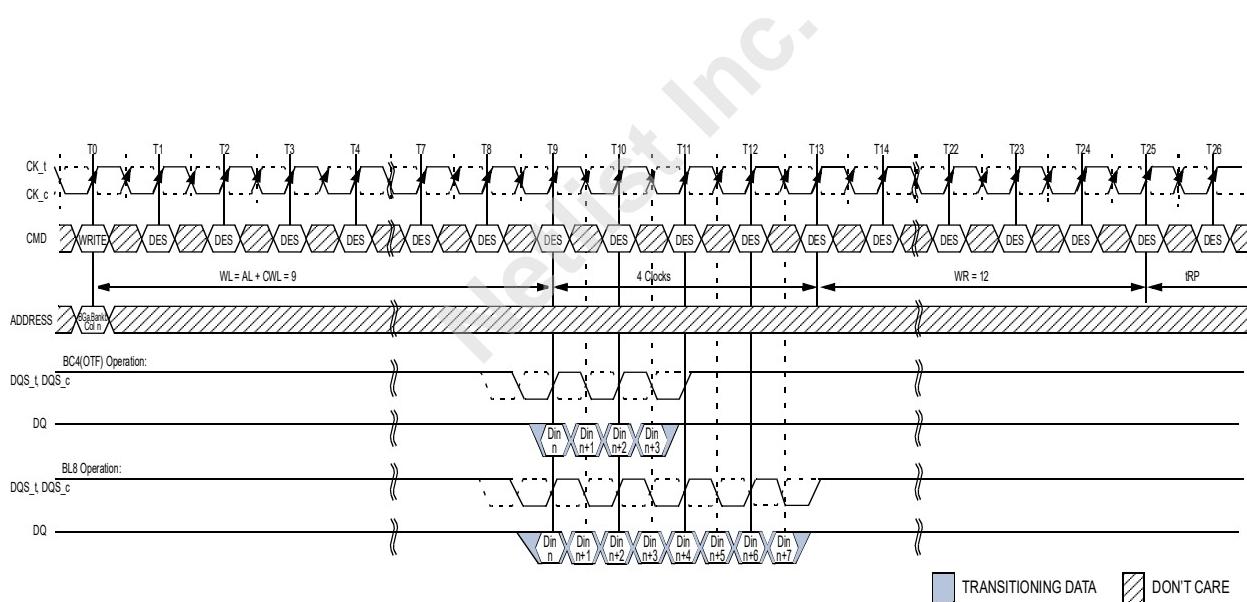
NOTE 4 BC4 setting activated by MRO[A1:A0 = 1:0].

NOTE 5 CA Parity = Disable, CS to CA Latency = Disable, Write DBI = Disable.

NOTE 6 The write recovery time (tWR) is referenced from the first rising clock edge after the last write data shown at T11.

tWR specifies the last burst write cycle until the precharge command can be issued to the same bank.

**Figure 146 — WRITE (BC4) Fixed to PRECHARGE Operation with 1tCK Preamble**



NOTE 1 BL = 8 / BC = 4, AL = 0, CWL = 9, Preamble = 1tCK, WR = 12

NOTE 2 DIN n = data-in to column n.

NOTE 3 DES commands are shown for ease of illustration; other commands may be valid at these times.

NOTE 4 BC4 setting activated by MRO[A1:A0 = 0:1] and A12 = 0 during WRITE command at T0.

BL8 setting activated by either MRO[A1:0 = 00] or MRO[A1:0 = 01] and A12 = 1 during WRITE command at T0.

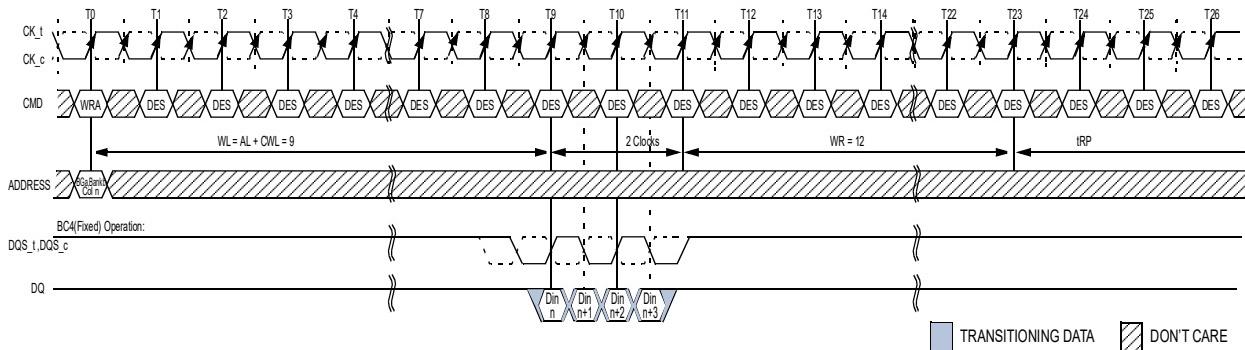
NOTE 5 CA Parity = Disable, CS to CA Latency = Disable, Write DBI = Disable.

NOTE 6 The write recovery time (WR) is referenced from the first rising clock edge after the last write data shown at T13.

WR specifies the last burst write cycle until the precharge command can be issued to the same bank.

**Figure 147 — WRITE (BL8/BC4) OTF with Auto PRECHARGE Operation and 1tCK Preamble**

#### 4.25.5 Write Burst Operation (cont'd)



NOTE 1. BC = 4, AL = 0, CWL = 9, Preamble = 1tCK, WR = 12

NOTE 2. DIN n = data-in to column n.

NOTE 3. DES commands are shown for ease of illustration; other commands may be valid at these times.

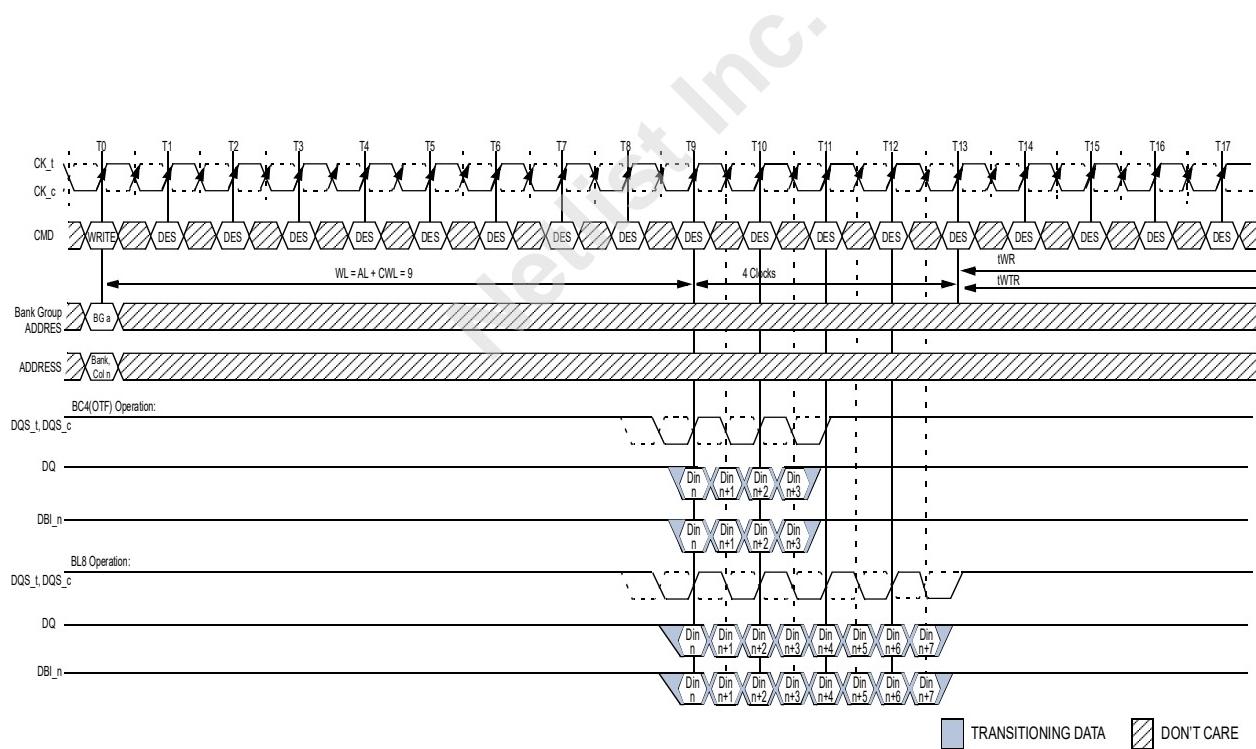
NOTE 4. BC4 setting activated by MR0[A1:A0 = 1:0].

NOTE 5. CA Parity = Disable, CS to CA Latency = Disable, Write DBI = Disable.

NOTE 6. The write recovery time (tWR) is referenced from the first rising clock edge after the last write data shown at T11.

WR specifies the last burst write cycle until the precharge command can be issued to the same bank.

**Figure 148 — WRITE (BC4) Fixed with Auto PRECHARGE Operation and 1tCK Preamble**



NOTE 1 BL = 8 / BC = 4, AL = 0, CWL = 9, Preamble = 1tCK

NOTE 2 DIN n = data-in to column n.

NOTE 3 DES commands are shown for ease of illustration; other commands may be valid at these times.

NOTE 4 BC4 setting activated by MR0[A1:A0 = 0:1] and A12 = 0 during WRITE command at T0.

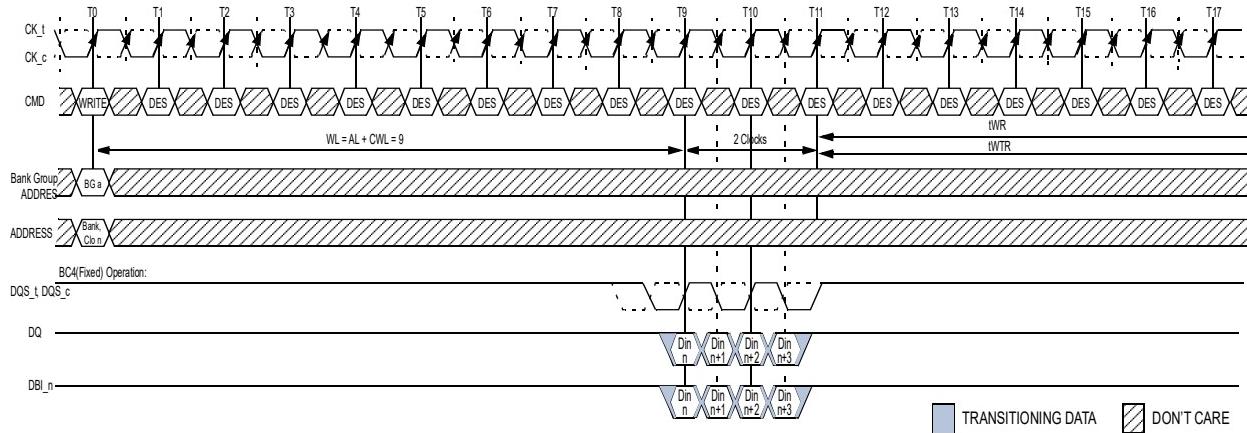
BL8 setting activated by either MR0[A1:A0 = 0:0] or MR0[A1:A0 = 0:1] and A12 = 1 during WRITE command at T0.

NOTE 5 CA Parity = Disable, CS to CA Latency = Disable, Write DBI = Enable, CRC = Disable.

NOTE 6 The write recovery time (tWR\_DB) and write timing parameter (tWTR\_DB) are referenced from the first rising clock edge after the last write data shown at T13.

**Figure 149 — WRITE (BL8/BC4) OTF with 1tCK Preamble and DBI**

#### 4.25.5 Write Burst Operation (cont'd)



NOTE 1. BC = 4, AL = 0, CWL = 9, Preamble = 1tCK

NOTE 2. DIN n = data-in to column n.

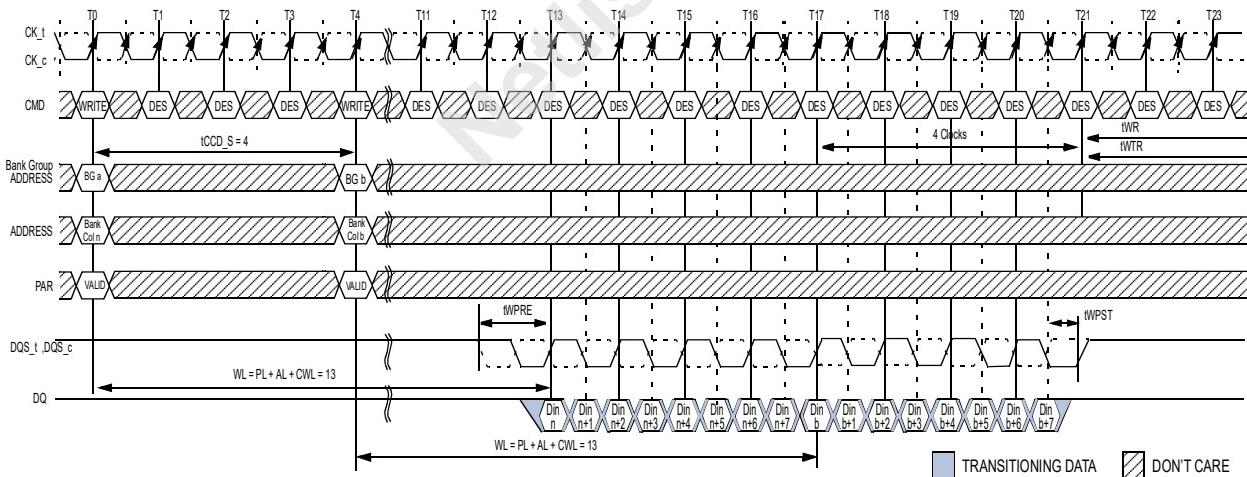
NOTE 3. DES commands are shown for ease of illustration; other commands may be valid at these times.

NOTE 4. BC4 setting activated by MRO[A1:A0 = 1:0].

NOTE 5. CA Parity = Disable, CS to CA Latency = Disable, Write DBI = Enable, CRC = Disable.

NOTE 6. The write recovery time (tWR\_DBI) and write timing parameter (tWTR\_DBI) are referenced from the first rising clock edge after the last write data shown at T11.

**Figure 150 — WRITE (BC4) Fixed with 1tCK Preamble and DBI**



NOTE 1 BL = 8, AL = 0, CWL = 9, PL = 4, Preamble = 1tCK

NOTE 2 DIN n (or b) = data-in to column n (or column b).

NOTE 3 DES commands are shown for ease of illustration; other commands may be valid at these times.

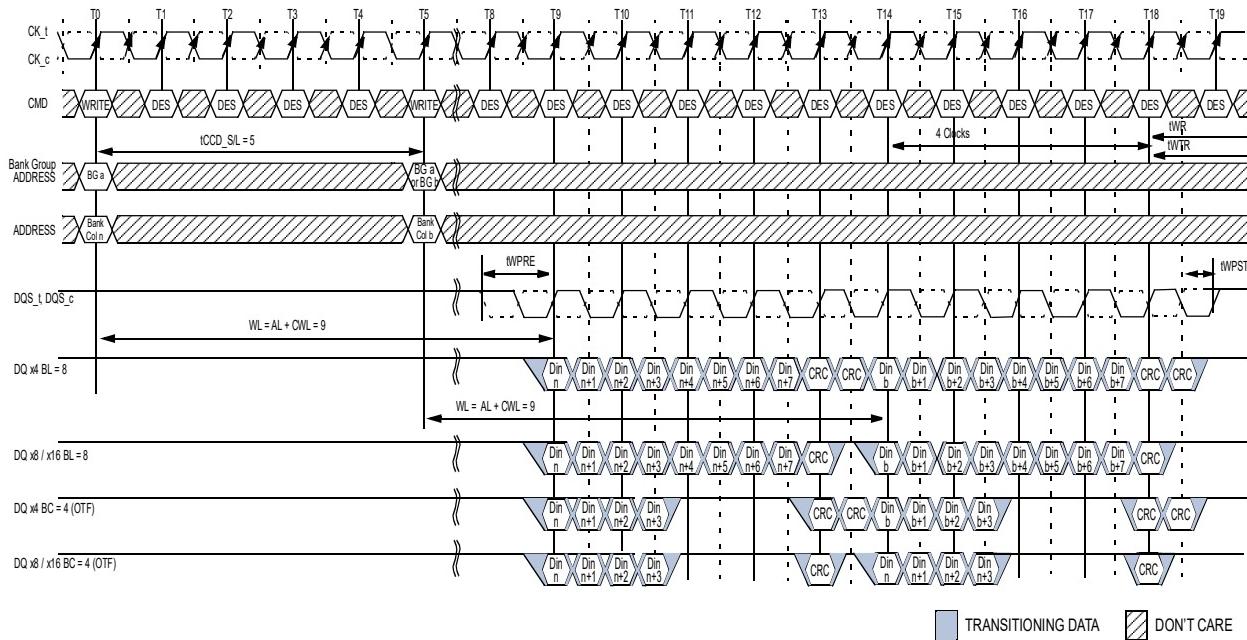
NOTE 4 BL8 setting activated by either MRO[A1:A0 = 0:0] or MRO[A1:A0 = 0:1] and A12 = 1 during WRITE command at T0 and T4.

NOTE 5 CA Parity = Enable, CS to CA Latency = Disable, Write DBI = Disable.

NOTE 6 The write recovery time (tWR) and write timing parameter (tWTR) are referenced from the first rising clock edge after the last write data shown at T21.

**Figure 151 — Consecutive WRITE (BL8) with 1tCK Preamble and CA Parity in Different Bank Group**

#### 4.25.5 Write Burst Operation (cont'd)



NOTE 1 BL = 8/BC = 4, AL = 0, CWL = 9, Preamble = 1tCK, tCCD\_S/L = 5

NOTE 2 DIN n (or b) = data-in to column n (or column b).

NOTE 3 DES commands are shown for ease of illustration; other commands may be valid at these times.

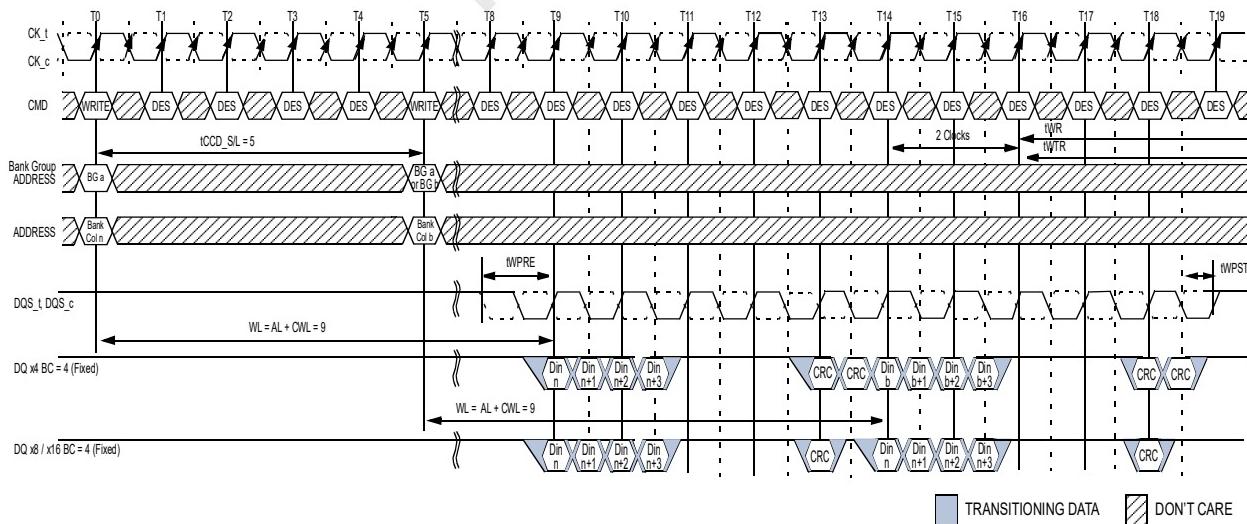
NOTE 4 BL8 setting activated by either MR0[A1:0 = 00] or MR0[A1:0 = 01] and A12 = 1 during WRITE command at T0 and T5.

NOTE 5 BC4 setting activated by MR0[A1:0 = 0:1] and A12 = 0 during WRITE command at T0 and T5.

NOTE 6 C/A Parity = Disable, CS to C/A Latency = Disable, Write DBI = Disable, Write CRC = Enable.

NOTE 7 The write recovery time (tWR) and write timing parameter (tWTR) are referenced from the first rising clock edge after the last write data shown at T18

**Figure 152 — Consecutive WRITE (BL8/BC4)OTF with 1tCK Preamble and Write CRC in Same or Different Bank Group**



NOTE 1 BL = 8, AL = 0, CWL = 9, Preamble = 1tCK, tCCD\_S/L = 5

NOTE 2 DIN n (or b) = data-in to column n (or column b).

NOTE 3 DES commands are shown for ease of illustration; other commands may be valid at these times.

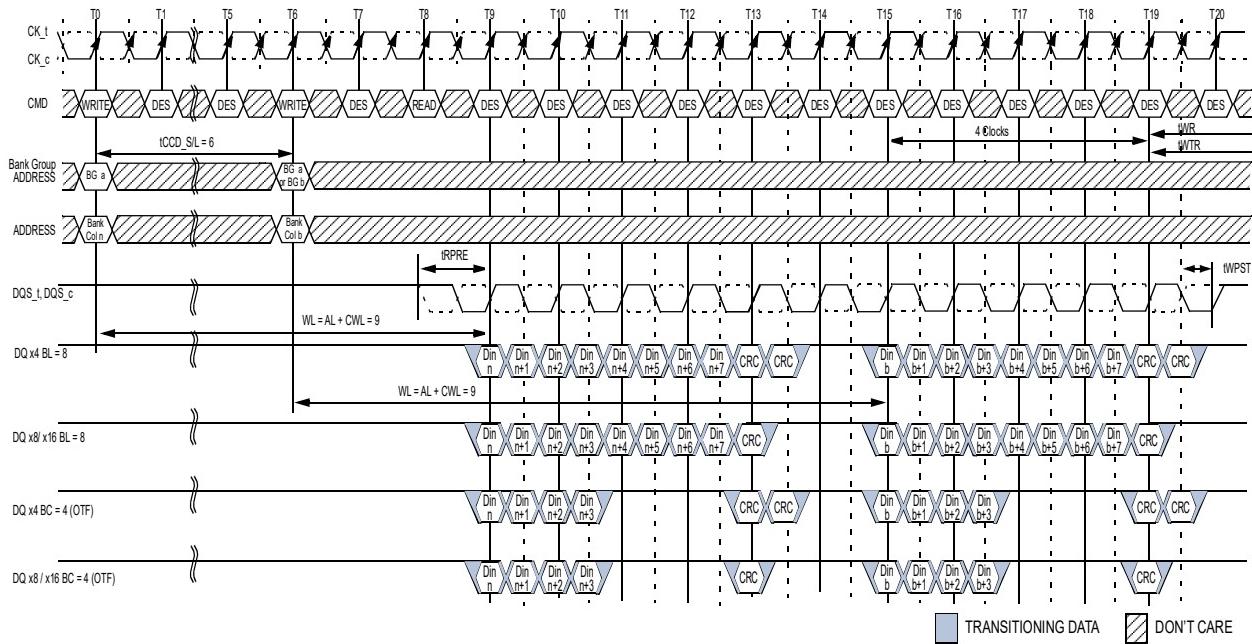
NOTE 4 BC4 setting activated by MR0[A1:0 = 1:0] at T0 and T5.

NOTE 5 CA Parity = Disable, CS to CA Latency = Disable, Write DBI = Disable, Write CRC = Enable.

NOTE 6 The write recovery time (tWR) and write timing parameter (tWTR) are referenced from the first rising clock edge after the last write data shown at T16.

**Figure 153 — Consecutive WRITE (BC4)Fixed with 1tCK Preamble and Write CRC in Same or Different Bank Group**

## 4.25.5 Write Burst Operation (cont'd)



NOTE 1 BL = 8, AL = 0, CWL = 9, Preamble = 1tCK, tCCD\_S/L = 6

NOTE 2 DIN n (or b) = data-in to column n(or column b).

NOTE 3 DES commands are shown for ease of illustration; other commands may be valid at these times.

NOTE 4 BL8 setting activated by either MR0[A1A:0 = 0:0] or MR0[A1A:0 = 0:1] and A12=1 during WRITE command at T0 and T6.

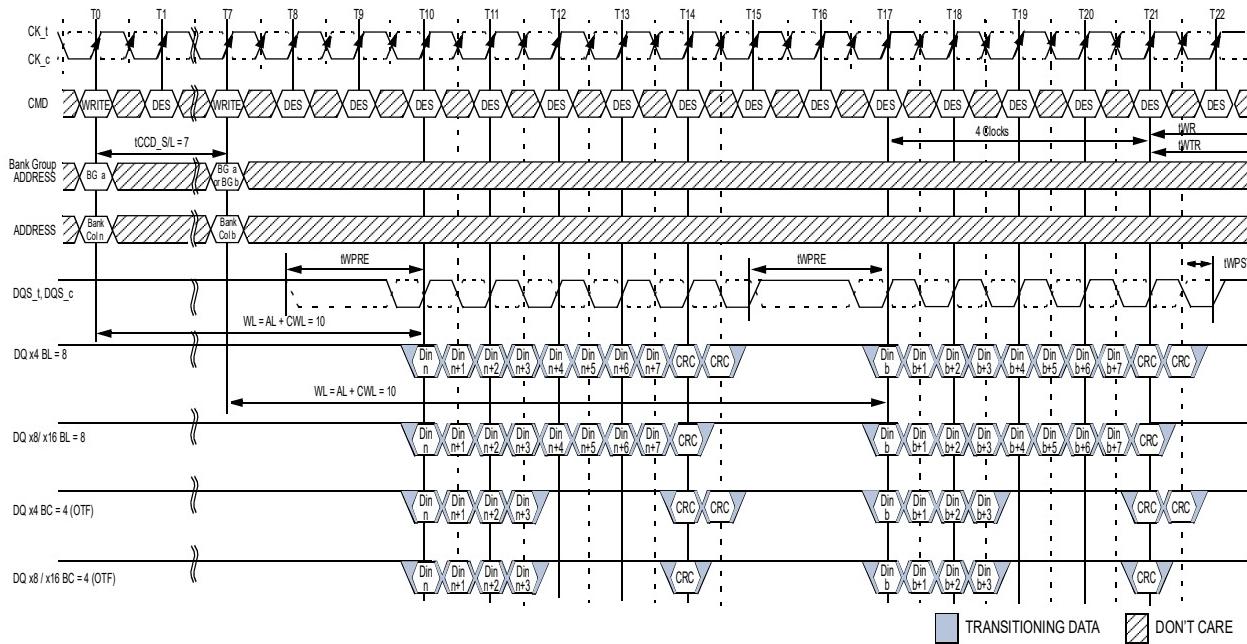
NOTE 5 BC4 setting activated by MR0[A1A:0 = 0:1] and A12=0 during WRITE command at T0 and T6.

NOTE 6 CA Parity = Disable, CS to CA Latency = Disable, Write DBI = Disable, Write CRC = Enable.

NOTE 7 The write recovery time (tWR) and write timing parameter (tWTR) are referenced from the first rising clock edge after the last write data shown at T19.

**Figure 154 — Nonconsecutive WRITE (BL8/BC4)OTF with 1tCK Preamble and Write CRC in Same or Different Bank Group**

#### 4.25.5 Write Burst Operation (cont'd)



NOTE 1 BL = 8, AL = 0, CWL = 9 + 1 =  $10^9$ , Preamble = 2tCK, tCCD\_S/L = 7

NOTE 2 DIN n (or b) = data-in to column n (or column b).

NOTE 3 DES commands are shown for ease of illustration; other commands may be valid at these times.

NOTE 4 BL8 setting activated by either MRO[A1:A0 = 0:0] or MRO[A1:A0 = 0:1] and A12=1 during WRITE command at T0 and T7.

NOTE 5 BC4 setting activated by MRO[A1:A0 = 0:1] and A12=0 during WRITE command at T0 and T7.

NOTE 6 CA Parity = Disable, CS to CA Latency = Disable, Write DBI = Disable, Write CRC = Enable.

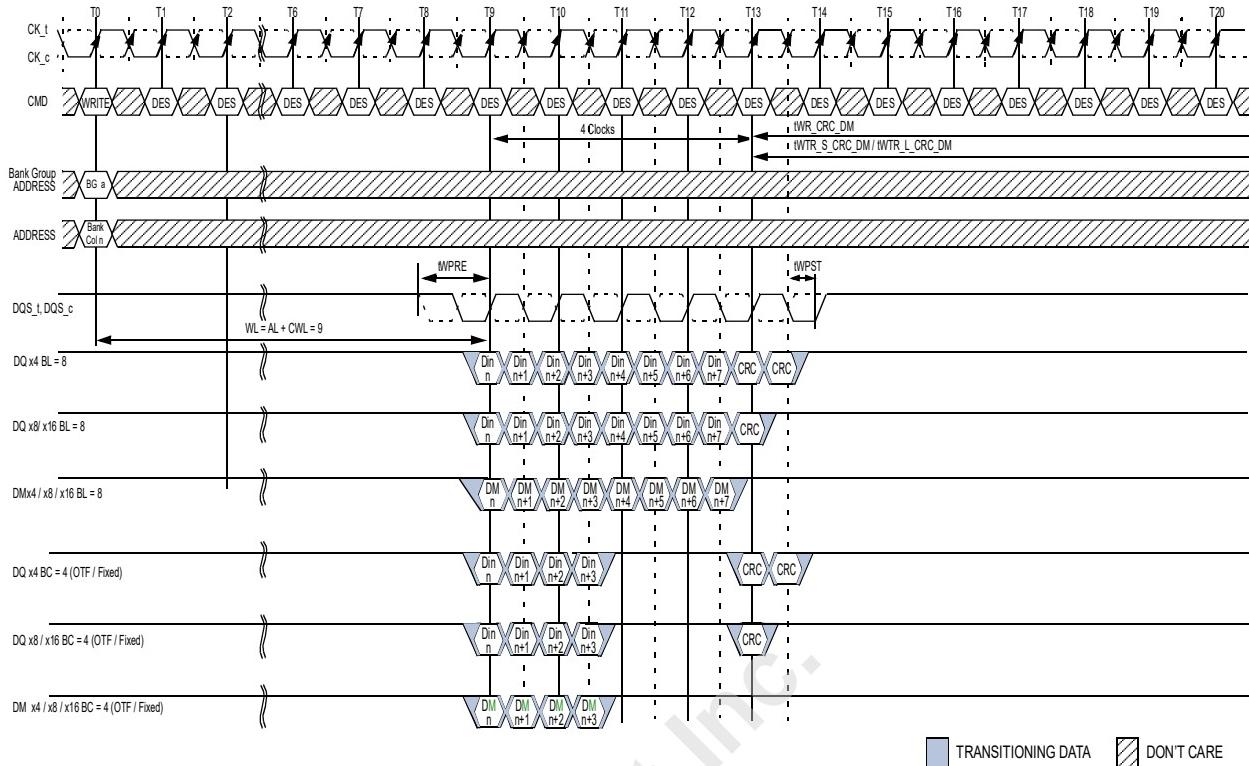
NOTE 7 tCCD\_S/L = 6 isn't allowed in 2tCK preamble mode.

NOTE 8 The write recovery time (tWR) and write timing parameter (tWTR) are referenced from the first rising clock edge after the last write data shown at T21.

NOTE 9 When operating in 2tCK Write Preamble Mode, CWL must be programmed to a value at least 1 clock greater than the lowest CWL setting supported in the applicable tCK range. That means CWL = 9 is not allowed when operating in 2tCK Write Preamble Mode

**Figure 155 — Nonconsecutive WRITE (BL8/BC4)OTF with 2tCK Preamble and Write CRC in Same or Different Bank Group**

#### 4.25.5 Write Burst Operation (cont'd)



NOTE 1 BL = 8 / BC = 4, AL = 0, CWL = 9, Preamble = 1tCK

NOTE 2 DIN n = data-in to column n.

NOTE 3 DES commands are shown for ease of illustration; other commands may be valid at these times.

NOTE 4 BL8 setting activated by either MR0[A1:A0 = 0:0] or MR0[A1:A0 = 0:1] and A12 = 1 during WRITE command at T0.

NOTE 5 BC4 setting activated by either MR0[A1:A0 = 1:0] or MR0[A1:A0 = 0:1] and A12 = 0 during READ command at T0.

NOTE 6 CA Parity = Disable, CS to CA Latency = Disable, Write DBI = Disable, Write CRC = Enable, DM = Enable.

NOTE 7 The write recovery time (tWR\_CRC\_DM) and write timing parameter (tWR\_S\_CRC\_DM/tWR\_L\_CRC\_DM) are referenced from the first rising clock edge after the last write data shown at T13.

**Figure 156 — WRITE (BL8/BC4)OTF/Fixed with 1tCK Preamble and Write CRC and DM in Same or Different Bank Group**

#### 4.25.6 Read and Write Command Interval

**Table 85 — Minimum Read and Write Command Timings**

| Bank Group | Timing Parameter         | DDR4-1600 / 1866 / 2133 / 2666 / 3200 | Units | note |
|------------|--------------------------|---------------------------------------|-------|------|
| same       | Minimum Read to Write    | CL - CWL + RBL / 2 + 1 tCK + tWPRE    |       | 1, 2 |
|            | Minimum Read after Write | CWL + WBL / 2 + tWTR_L                |       | 1, 3 |
| different  | Minimum Read to Write    | CL - CWL + RBL / 2 + 1 tCK + tWPRE    |       | 1, 2 |
|            | Minimum Read after Write | CWL + WBL / 2 + tWTR_S                |       | 1, 3 |

NOTE 1 These timings require extended calibrations times tZQinit and tZQCS.

NOTE 2 RBL : Read burst length associated with Read command

RBL = 8 for fixed 8 and on-the-fly mode 8

RBL = 4 for fixed BC4 and on-the-fly mode BC4

NOTE 3 WBL : Write burst length associated with Write command

WBL = 8 for fixed 8 and on-the-fly mode 8 or BC4

WBL = 4 for fixed BC4 only

## 4.25.7 Write Timing Violations

### 4.25.7.1 Motivation

Generally, if Write timing parameters are violated, a complete reset/initialization procedure has to be initiated to make sure that the DRAM works properly. However, it is desirable, for certain violations as specified below, the DRAM is guaranteed to not “hang up,” and that errors are limited to that particular operation.

For the following, it will be assumed that there are no timing violations with regards to the Write command itself (including ODT, etc.) and that it does satisfy all timing requirements not mentioned below.

### 4.25.7.2 Data Setup and Hold Offset Violations

Should the data to strobe timing requirements ( $T_{dq\_off}$ ,  $T_{dqh\_off}$ ,  $T_{dq\_dd\_off}$ ,  $T_{dqh\_dd\_off}$ ) be violated, for any of the strobe edges associated with a write burst, then wrong data might be written to the memory locations addressed with this WRITE command. In the example (Figure ), the relevant strobe edges for write burst A are associated with the clock edges: T9, T9.5, T10, T10.5, T11, T11.5, T12, T12.5.

Subsequent reads from that location might result in unpredictable read data, however the DRAM will work properly otherwise.

### 4.25.7.3 Strobe and Strobe to Clock Timing Violations

Should the strobe timing requirements ( $t_{DQSH}$ ,  $t_{DQL}$ ,  $t_{WPRE}$ ,  $t_{WPST}$ ) or the strobe to clock timing requirements ( $t_{DSS}$ ,  $t_{DSH}$ ,  $t_{DQSS}$ ) be violated for any of the strobe edges associated with a Write burst, then wrong data might be written to the memory location addressed with the offending WRITE command. Subsequent reads from that location might result in unpredictable read data, however the DRAM will work properly with the following constraints:

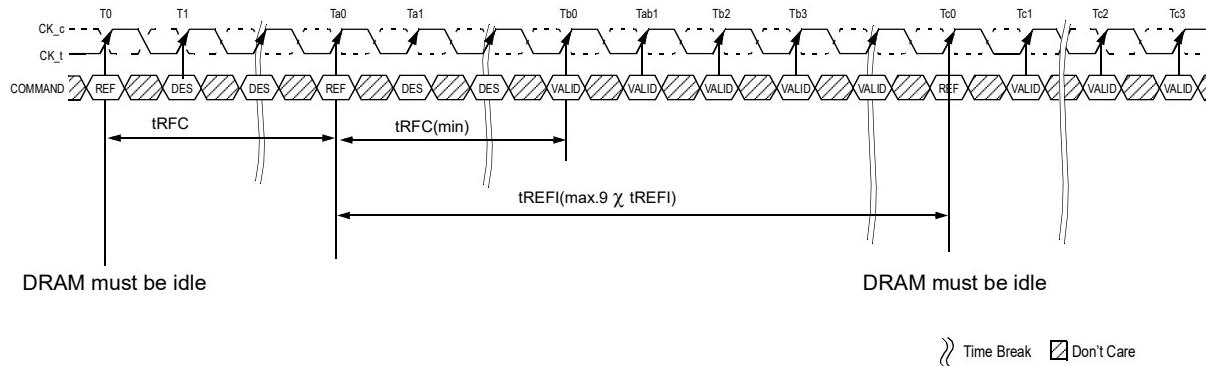
- (1) Both Write CRC and data burst OTF are disabled; timing specifications other than  $t_{DQSH}$ ,  $t_{DQL}$ ,  $t_{WPRE}$ ,  $t_{WPST}$ ,  $t_{DSS}$ ,  $t_{DSH}$ ,  $t_{DQSS}$  are not violated.
- (2) The offending write strobe (and preamble) arrive no earlier or later than six DQS transition edges from the Write-Latency position.
- (3) A Read command following an offending Write command from any open bank is allowed.
- (4) One or more subsequent WR or a subsequent WRA {to same bank as offending WR} may be issued  $t_{CCD\_L}$  later but incorrect data could be written; subsequent WR and WRA can be either offending or non-offending Writes. Reads from these Writes may provide incorrect data.
- (5) One or more subsequent WR or a subsequent WRA {to a different bank group} may be issued  $t_{CCD\_S}$  later but incorrect data could be written; subsequent WR and WRA can be either offending or non-offending Writes. Reads from these Writes may provide incorrect data.
- (6) Once one or more precharge commands (PRE or PREA) are issued to DDR4 after offending WRITE command and all banks become precharged state (idle state), a subsequent, non-offending WR or WRA to any open bank shall be able to write correct data.

## 4.26 Refresh Command

The Refresh command (REF) is used during normal operation of the DDR4 SDRAMs. This command is non persistent, so it must be issued each time a refresh is required. The DDR4 SDRAM requires Refresh cycles at an average periodic interval of  $t_{REFI}$ . When  $CS_n$ ,  $RAS_n/A16$  and  $CAS_n/A15$  are held Low and  $WE_n/A14$  and  $ACT_n$  are held High at the rising edge of the clock, the chip enters a Refresh cycle. All banks of the SDRAM must be precharged and idle for a minimum of the precharge time  $t_{RP}(\text{min})$  before the Refresh Command can be applied. The refresh addressing is generated by the internal refresh controller. This makes the address bits “Don’t Care” during a Refresh command. An internal address counter supplies the addresses during the refresh cycle. No control of the external address bus is required once this cycle has started. When the refresh cycle has completed, all banks of the SDRAM will be in the precharged (idle) state. A delay between the Refresh Command and the next valid command, except DES, must be greater than or equal to the minimum Refresh cycle time  $t_{RFC}(\text{min})$  as shown in Figure 157. Note that the  $t_{RFC}$  timing parameter depends on memory density.

In general, a Refresh command needs to be issued to the DDR4 SDRAM regularly every  $t_{REFI}$  interval. To allow for improved efficiency in scheduling and switching between tasks, some flexibility in the absolute refresh interval is provided for postponing and pulling-in refresh command. A maximum of 8 Refresh commands can be postponed when DRAM is in 1X refresh mode and for 2X/4X refresh mode, 16/32 Refresh commands can be postponed respectively during operation of the DDR4 SDRAM, meaning that at no point in time more than a total of 8,16,32 Refresh commands are allowed to be postponed for 1X,2X,4X Refresh mode respectively. In case that 8 Refresh commands are postponed in a row, the resulting maximum interval between the surrounding Refresh commands is limited to  $9 \times t_{REFI}$  (see Figure 157). In 2X and 4X Refresh mode, it’s limited to  $17 \times t_{REFI2}$  and  $33 \times t_{REFI4}$ . A maximum of 8 additional Refresh commands can be issued in advance (“pulled in”) in 1X refresh mode and for 2X/4X refresh mode, 16/32 Refresh commands can be pulled in respectively, with each one reducing the number of regular Refresh commands required later by one. Note that pulling in more than 8/16/32, depending on Refresh mode, Refresh commands in advance does not further reduce the number of regular Refresh commands required later, so that the resulting maximum interval between two surrounding Refresh commands is limited to  $9 \times t_{REFI}$ ,  $17 \times t_{REFI2}$  and  $33 \times t_{REFI4}$  respectively. At any given time, a maximum of 16 REF/32REF 2/64REF 4 commands can be issued within  $2 \times t_{REFI}$  /  $4 \times t_{REFI2}$  /  $8 \times t_{REFI4}$ .

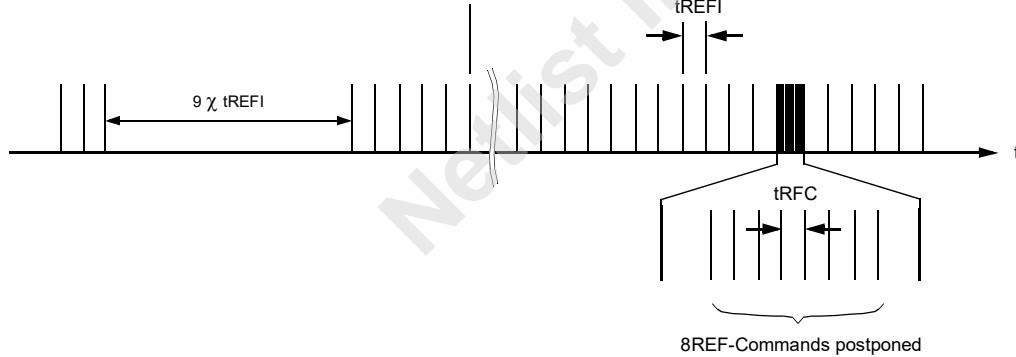
#### 4.26 Refresh Command (cont'd)



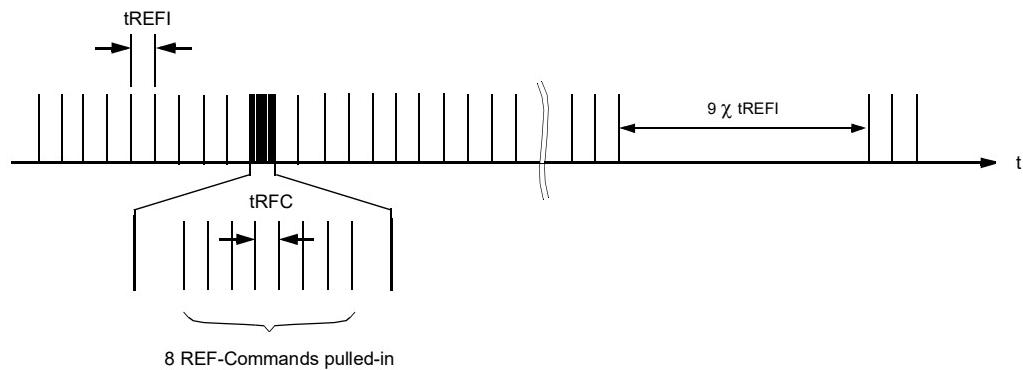
NOTE 1 Only DES commands allowed after Refresh command registered until tRFC(min) expires.

NOTE 2 Time interval between two Refresh commands may be extended to a maximum of 9 X tREFI.

**Figure 157 — Refresh Command Timing (Example of 1x Refresh mode)**



**Figure 158 — Postponing Refresh Commands (Example of 1X Refresh mode)**



**Figure 159 — Pulling-in Refresh Commands (Example of 1X Refresh mode)**

## 4.27 Self refresh Operation

The Self-Refresh command can be used to retain data in the DDR4 SDRAM, even if the rest of the system is powered down. When in the Self-Refresh mode, the DDR4 SDRAM retains data without external clocking. The DDR4 SDRAM device has a built-in timer to accommodate Self-Refresh operation. The Self-Refresh-Entry (SRE) Command is defined by having CS\_n, RAS\_n/A16, CAS\_n/A15, and CKE held low with WE\_n/A14 and ACT\_n high at the rising edge of the clock.

Before issuing the Self-Refresh-Entry command, the DDR4 SDRAM must be idle with all bank precharge state with tRP satisfied. 'Idle state' is defined as all banks are closed (tRP, tDAL, etc. satisfied), no data bursts are in progress, CKE is high, and all timings from previous operations are satisfied (tMRD, tMOD, tRFC, tZQinit, tZQoper, tZQCS, etc.). Deselect command must be registered on last positive clock edge before issuing Self Refresh Entry command. Once the Self Refresh Entry command is registered, Deselect command must also be registered at the next positive clock edge. Once the Self-Refresh Entry command is registered, CKE must be held low to keep the device in Self-Refresh mode. DRAM automatically disables ODT termination and set Hi-Z as termination state regardless of ODT pin and RTT\_PARK set when it enters in Self-Refresh mode. Upon exiting Self-Refresh, DRAM automatically enables ODT termination and set RTT\_PARK asynchronously during tXSDLL when RTT\_PARK is enabled. During normal operation (DLL on) the DLL is automatically disabled upon entering Self-Refresh and is automatically enabled (including a DLL-Reset) upon exiting Self-Refresh.

When the DDR4 SDRAM has entered Self-Refresh mode, all of the external control signals, except CKE and RESET\_n, are "don't care." For proper Self-Refresh operation, all power supply and reference pins (VDD, VDDQ, VSS, VSSQ, VPP, and VRefCA) must be at valid levels. DRAM internal VrefDQ generator circuitry may remain ON or turned OFF depending on DRAM design. If DRAM internal VrefDQ circuitry is turned OFF in self refresh, when DRAM exits from self refresh state, it ensures that VrefDQ generator circuitry is powered up and stable within tXS period. First Write operation or first Write Leveling Activity may not occur earlier than tXS after exit from Self Refresh. The DRAM initiates a minimum of one Refresh command internally within tCKE period once it enters Self-Refresh mode.

The clock is internally disabled during Self-Refresh Operation to save power. The minimum time that the DDR4 SDRAM must remain in Self-Refresh mode is tCKESR. The user may change the external clock frequency or halt the external clock tCKSRE after Self-Refresh entry is registered, however, the clock must be restarted and stable tCKSRX before the device can exit Self-Refresh operation.

The procedure for exiting Self-Refresh requires a sequence of events. First, the clock must be stable prior to CKE going back HIGH. Once a Self-Refresh Exit command (SRX, combination of CKE going high and Deselect on command bus) is registered, following timing delay must be satisfied:

### 1. Commands that do not require locked DLL:

tXS - ACT, PRE, PREA, REF, SRE, PDE, WR, WRS4, WRS8, WRA, WRAS4, WRAS8  
tXSFast - ZQCL, ZQCS, MRS commands. For MRS command, only DRAM CL and WR/RTP register and DLL Reset in MR0, RTT\_NOM register in MR1, CWL and RTT\_WR register in MR2 and geardown mode in MR3, Write and Read Preamble register in MR4, RTT\_PARK register in MR5, tCCD\_L/tDLLK and VrefDQ Training Value in MR6 are allowed to be accessed provided DRAM is not in per DRAM addressability mode. Access to other DRAM mode registers must satisfy tXS timing.

Note that synchronous ODT for write commands (WR, WRS4, WRS8, WRA, WRAS4 and WRAS8) and dynamic ODT controlled by write command require locked DLL.

### 2. Commands that require locked DLL:

tXSDLL - RD, RDS4, RDS8, RDA, RDAS4, RDAS8

Depending on the system environment and the amount of time spent in Self-Refresh, ZQ calibration commands may be required to compensate for the voltage and temperature drift as described in "ZQ Calibration Commands" on Section 4.12. To issue ZQ calibration commands, applicable timing requirements must be satisfied.

CKE must remain HIGH for the entire Self-Refresh exit period tXSDLL for proper operation except for Self-Refresh re-entry. Upon exit from Self-Refresh, the DDR4 SDRAM can be put back into Self-Refresh mode or Power down mode after waiting at least tXS period and issuing one refresh command (refresh period of tRFC). Deselect commands must be registered on each positive clock edge during the Self-Refresh exit interval tXS. Low level of ODT pin must be registered on each positive clock edge during tXSDLL when normal mode ( DLL-on ) is set. Under DLL-off mode, asynchronous ODT function might be allowed.

The use of Self-Refresh mode introduces the possibility that an internally timed refresh event can be missed when CKE is raised for exit from Self-Refresh mode. Upon exit from Self-Refresh, the DDR4 SDRAM requires a minimum of one extra refresh command before it is put back into Self-Refresh Mode.

The exit timing from self-refresh exit to first valid command not requiring a locked DLL is tXS.

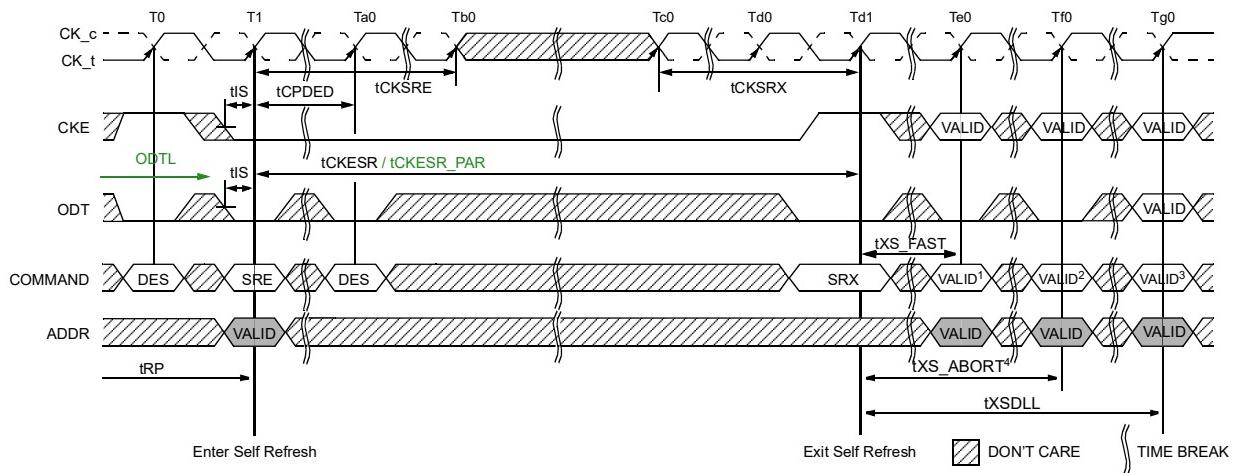
The value of tXS is (tRFC+10ns). This delay is to allow for any refreshes started by the DRAM to complete. tRFC continues to grow with higher density devices so tXS will grow as well.

A Bit A9 in MR4 is defined to enable the self refresh abort mode. If the bit is disabled then the controller uses tXS timings.

#### 4.27 Self refresh Operation (Cont'd)

If the bit is enabled then the DRAM aborts any ongoing refresh and does not increment the refresh counter. The controller can issue a valid command not requiring a locked DLL after a delay of tXS\_abort.

Upon exit from Self-Refresh, the DDR4 SDRAM requires a minimum of one extra refresh command before it is put back into Self-Refresh Mode. This requirement remains the same irrespective of the setting of the MRS bit for self refresh abort.



NOTE 1 Only MRS (limited to those described in the Self-Refresh Operation section). ZQCS or ZQCL command allowed.

NOTE 2 Valid commands not requiring a locked DLL

NOTE 3 Valid commands requiring a locked DLL

NOTE 4 Only DES is allowed during tXS\_ABORT

**Figure 160 — Self-Refresh Entry/Exit Timing**

##### 4.27.1 Low Power Auto Self Refresh

DDR4 devices support Low Power Auto Self-Refresh (LP ASR) operation at multiple temperatures ranges (See temperature table below). Mode Register MR2 – descriptions

**Table 86 — MR2 definitions for Low Power Auto Self-Refresh mode**

| A6 | A7 | Self-Refresh Operation Mode   |
|----|----|---|
| 0  | 0  | Manual Mode – Normal operating temperature range  |
| 0  | 1  | Manual Mode – Extended operating temperature range  |
| 1  | 0  | Manual Mode – Lower power mode at a reduced operating temperature range   |
| 1  | 1  | ASR Mode – automatically switching between all modes to optimize power for any of the temperature ranges listed above |

##### Auto Self Refresh (ASR)

DDR4 DRAM provides an Auto Self-Refresh mode (ASR) for application ease. ASR mode is enabled by setting the above MR2 bits A6=1 and A7=1. The DRAM will manage Self Refresh entry through the supported temperature range of the DRAM. In this mode, the DRAM will change self-refresh rate as the DRAM operating temperature changes, lower at low temperatures and higher at high temperatures.

##### Manual Modes

If ASR mode is not enabled, the LP ASR Mode Register must be manually programmed to one the three self-refresh operating modes listed above. In this mode, the user has the flexibility to select a fixed self-refresh operating mode at the entry of the self-refresh according to their system memory temperature conditions. The user is responsible to maintain the required memory temperature condition for the mode selected during the self-refresh operation. The user may change the selected mode after exiting from self refresh and before the next self-refresh entry. If the temperature condition is exceeded for the mode selected, there is risk to data retention resulting in loss of data.

#### 4.27.1 Low Power Auto Self Refresh (cont'd)

**Table 87 — Self Refresh Function table**

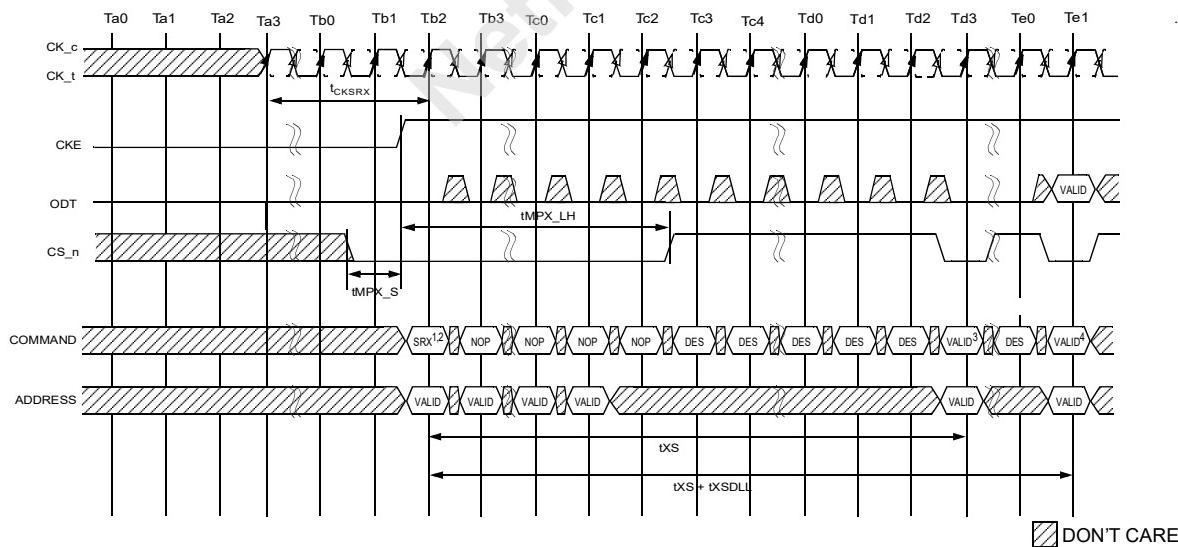
| MR2-A6 | MR2-A7 | LP ASR Mode                | Self Refresh Operation  | Allowed CT Operating Temperature Range for Self Refresh Mode (all reference to DRAM Tcase) | Allowed IT Operating Temperature Range for Self Refresh Mode (all reference to DRAM Tcase) |
|--------|--------|----------------------------|---|--|--|
| 0      | 0      | Normal                     | Fixed normal self-Refresh rate to maintain data retention for the normal operating temperature. User is required to ensure 85°C DRAM Tcasemax is not exceeded to avoid any risk of data loss.                               | (0°C to 85°C)  | (-40°C to 85°C)  |
| 0      | 1      | Extended Temperature range | Fixed high self-Refresh rate to optimize data retention to support the extended temperature range   | (0°C to 95°C)  | (-40°C to 95°C)  |
| 1      | 0      | Reduced Temperature range  | Variable or fixed self-Refresh rate or any other DRAM power consumption reduction control for the reduced temperature range. User is required to ensure 45°C DRAM Tcasemax is not exceeded to avoid any risk of data loss . | (0°C to 45°C)  | (-40°C to 45°C)  |
| 1      | 1      | Auto Self Refresh          | ASR Mode Enabled. Self-Refresh power consumption and data retention are optimized for any given operating temperature conditions  | All of the above   | All of the above   |

#### 4.27.2 Self Refresh Exit with No Operation command

Self Refresh Exit with No Operation command (NOP) allows for a common command/address bus between active DRAM and DRAM in Max Power Saving Mode. Self Refresh Mode may exit with No Operation commands (NOP) provided:

- (1) The DRAM entered Self Refresh Mode with CA Parity and CAL disabled.
- (2) tMPX\_S and tMPX\_LH are satisfied.
- (3) NOP commands are only issued during tMPX\_LH window.

No other command is allowed during tMPX\_LH window after SRX command is issued. (See Figure 161)



NOTE 1 CS\_n = L, ACT\_n = H, RAS\_n/A16 = H, CAS\_n/A15 = H, WE\_n/A14 = H at Tb2 (No Operation command )

NOTE 2 SRX at Tb2 is only allowed when DRAM shared Command/Address bus is under exiting Max Power Saving Mode.

NOTE 3 Valid commands not requiring a locked DLL

NOTE 4 Valid commands requiring a locked DLL

NOTE 5 IXS\_FAST and IXS\_ABORT are not allowed this case.

NOTE 6 Duration of CS\_n Low around CKE rising edge must satisfy tMPX\_S and tMPX\_LH as defined by Max Power Saving Mode AC parameters.

**Figure 161 — Self Refresh Exit with No Operation command**

## 4.28 Power down Mode

### 4.28.1 Power-Down Entry and Exit

Power-down is synchronously entered when CKE is registered low (along with Deselect command). CKE is not allowed to go low while mode register set command, MPR operations, ZQCAL operations, DLL locking or read / write operation are in progress. CKE is allowed to go low while any of other operations such as row activation, precharge or auto-precharge and refresh are in progress, but power-down IDD spec will not be applied until finishing those operations. Timing diagrams are shown in Figure 163 through Figure 171 with details for entry and exit of Power-Down.

The DLL should be in a locked state when power-down is entered for fastest power-down exit timing. DRAM design provides all AC and DC timing and voltage specification as well as proper DLL operation with any CKE intensive operations as long as DRAM controller complies with DRAM specifications.

During Power-Down, if all banks are closed after any in-progress commands are completed, the device will be in precharge Power-Down mode; if any bank is open after in-progress commands are completed, the device will be in active Power-Down mode.

Entering power-down deactivates the input and output buffers, excluding CK\_t, CK\_c, CKE and RESET\_n. In power-down mode, DRAM ODT input buffer deactivation is based on MR5 bit A5. If it is configured to 0b, ODT input buffer remains on and ODT input signal must be at valid logic level. If it is configured to 1b, ODT input buffer is deactivated and DRAM ODT input signal may be floating and DRAM does not provide Rtt\_Nom termination. Note that DRAM continues to provide Rtt\_Park termination if it is enabled in DRAM mode register MR5 bit A8:A6. To protect DRAM internal delay on CKE line to block the input signals, multiple Deselect commands are needed during the CKE switch off and cycle(s) after, this timing period are defined as tCPDED. CKE\_low will result in deactivation of command and address receivers after tCPDED has expired.

**Table 88 — Power-Down Entry Definitions**

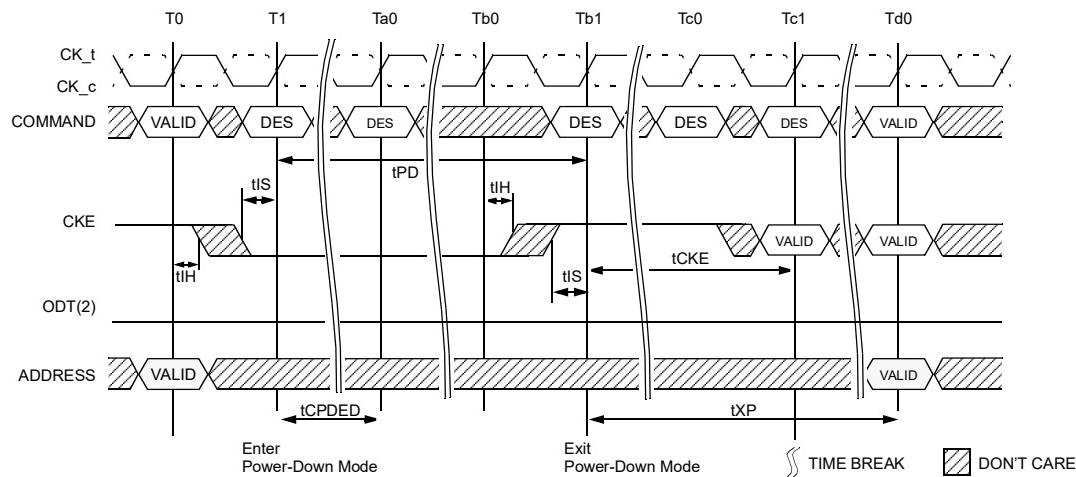
| Status of DRAM                       | DLL | PD Exit | Relevant Parameters       |
|--------------------------------------|-----|---------|---------------------------|
| Active<br>(A bank or more Open)      | On  | Fast    | tXP to any valid command  |
| Precharged<br>(All banks Precharged) | On  | Fast    | tXP to any valid command. |

Also, the DLL is kept enabled during precharge power-down or active power-down. In power-down mode, CKE low, RESET\_n high, and a stable clock signal must be maintained at the inputs of the DDR4 SDRAM, and ODT should be in a valid state, but all other input signals are “Don’t Care.” (If RESET\_n goes low during Power-Down, the DRAM will be out of PD mode and into reset state.) CKE low must be maintained until tCKE has been satisfied. Power-down duration is limited by 9 times tREFI of the device.

The power-down state is synchronously exited when CKE is registered high (along with a Deselect command). CKE high must be maintained until tCKE has been satisfied. DRAM ODT input signal must be at valid level when DRAM exits from power-down mode independent of MR5 bit A5 if Rtt\_Nom is enabled in DRAM mode register. If DRAM Rtt\_Nom is disabled then ODT input signal may remain floating. A valid, executable command can be applied with power-down exit latency, tXP after CKE goes high. Power-down exit latency is defined in the AC specifications Table in Section 12.3.

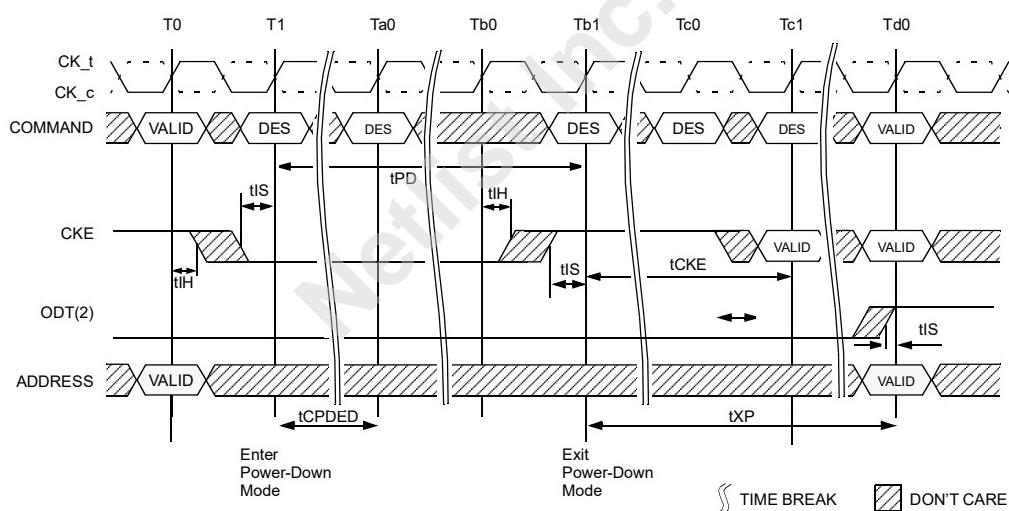
Active Power Down Entry and Exit timing diagram example is shown in Figure 163. Timing Diagrams for CKE with PD Entry, PD Exit with Read and Read with Auto Precharge, Write, Write with Auto Precharge, Activate, Precharge, Refresh, and MRS are shown in Figure 164 through Figure 171. Additional clarification is shown in Figure 172.

#### 4.28.1 Power-Down Entry and Exit (cont'd)



NOTE 1 VALID command at T0 is ACT, DES or Precharge with still one bank remaining open after completion of the precharge command.  
 NOTE 2 ODT pin driven to a valid state. MR5 bit A5=0 (default setting) is shown.

**Figure 162 — Active Power-Down Entry and Exit Timing Diagram MR5 bit A5 =0**



NOTE 1 VALID command at T0 is ACT, DES or Precharge with still one bank remaining open after completion of the precharge command.  
 NOTE 2 ODT pin driven to a valid state. MR5 bit A5=1 is shown.

**Figure 163 — Active Power-Down Entry and Exit Timing Diagram MR5 bit A5=1**

#### 4.28.1 Power-Down Entry and Exit (cont'd)

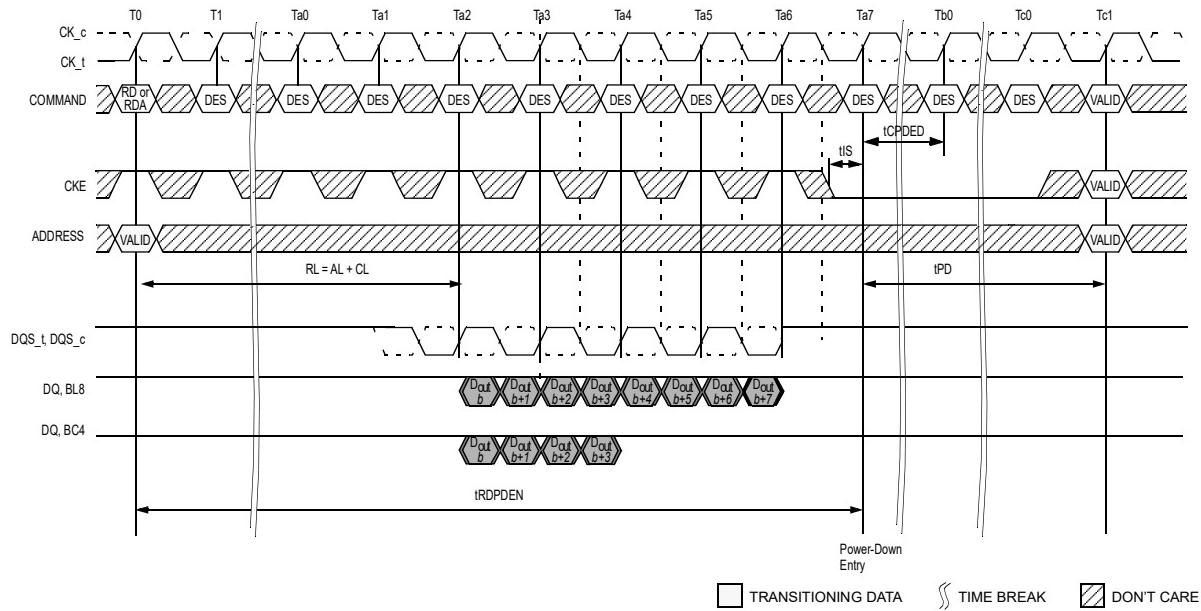
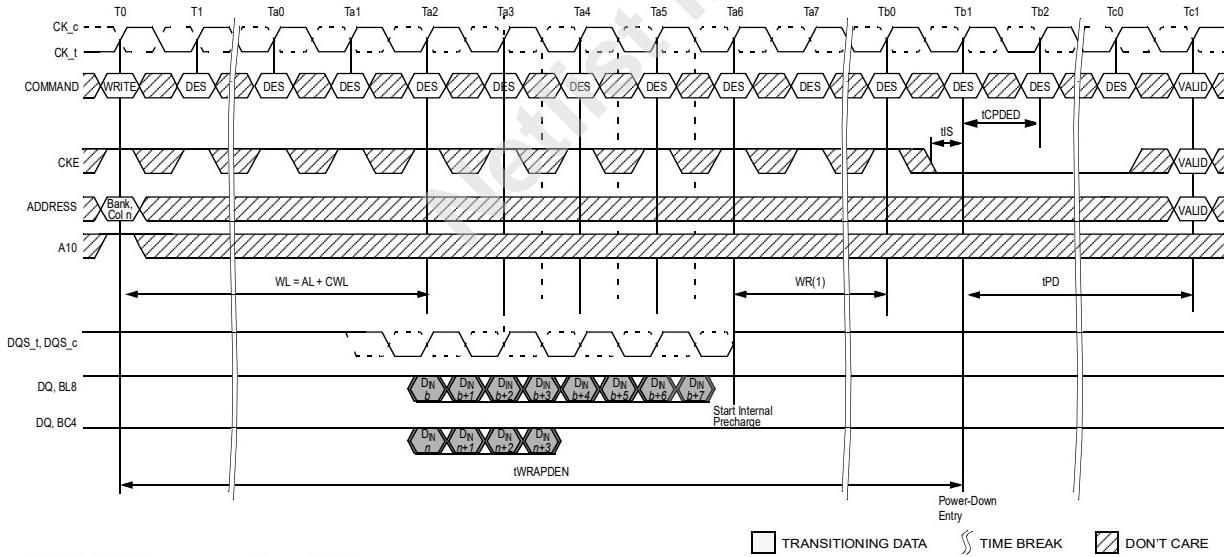


Figure 164 — Power-Down Entry after Read and Read with Auto Precharge



NOTE 1 tWR is programmed through MRO.

Figure 165 — Power-Down Entry After Write with Auto Precharge

#### 4.28.1 Power-Down Entry and Exit (cont'd)

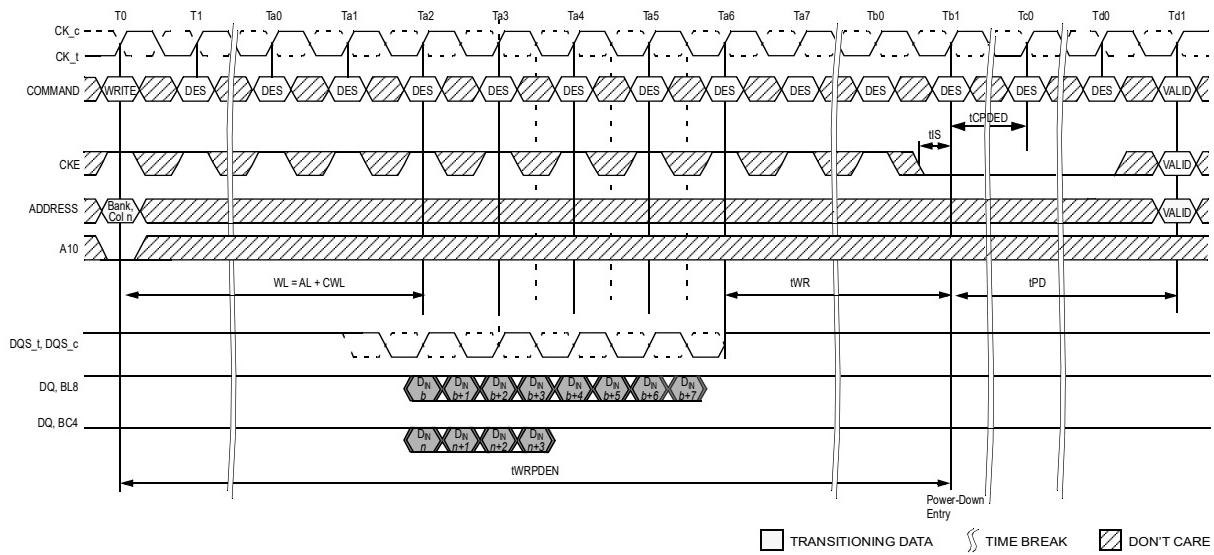


Figure 166 — Power-Down Entry after Write

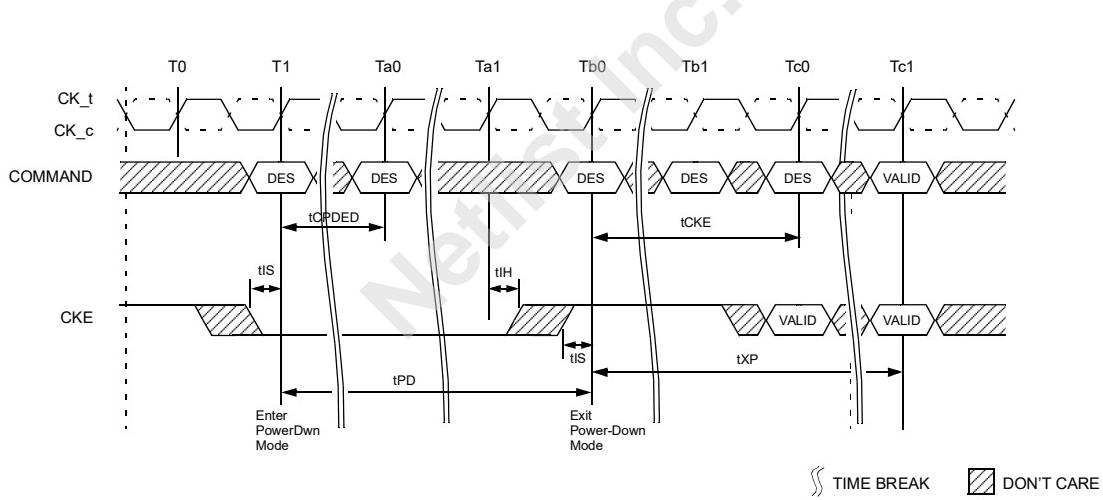


Figure 167 — Precharge Power-Down Entry and Exit

## 4.28.1 Power-Down Entry and Exit (cont'd)

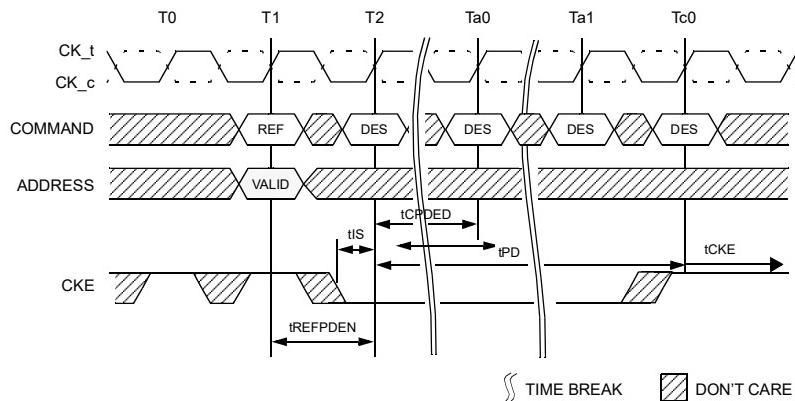


Figure 168 — Refresh Command to Power-Down Entry

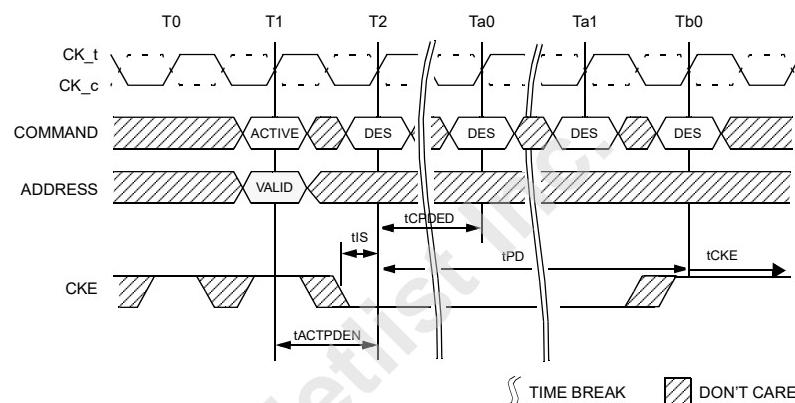


Figure 169 — Activate Command to Power-Down Entry

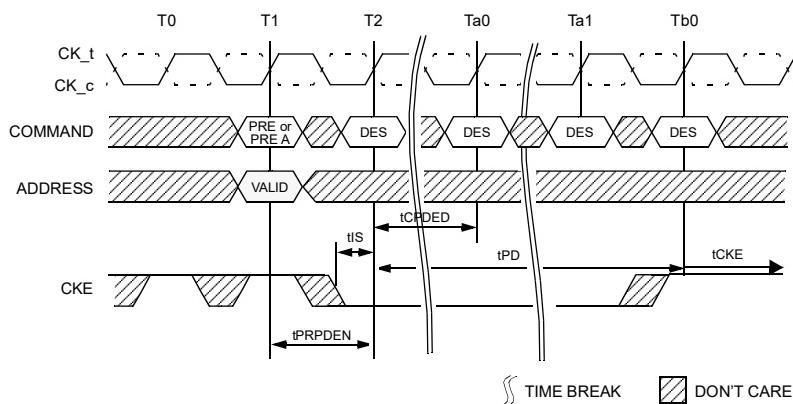


Figure 170 — Precharge/Precharge all Command to Power-Down Entry

#### 4.28.1 Power-Down Entry and Exit (cont'd)

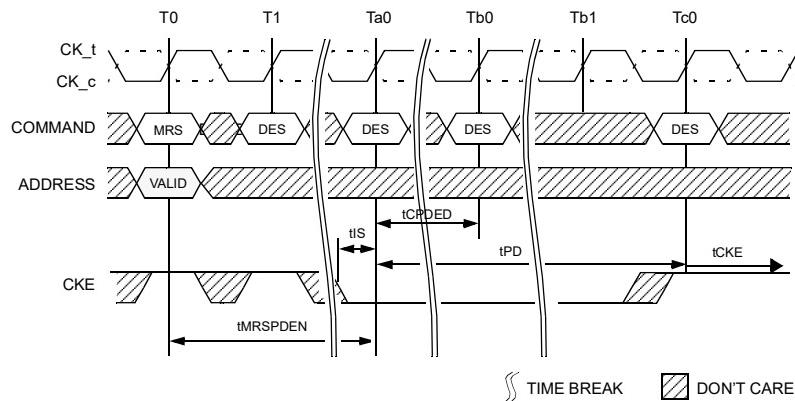


Figure 171 — MRS Command to Power-Down Entry

#### 4.28.2 Power-Down clarifications

When CKE is registered low for power-down entry, tPD(min) must be satisfied before CKE can be registered high for power-down exit. The minimum value of parameter tPD(min) is equal to the minimum value of parameter tCKE(min) as shown in Table, "Timing Parameters by Speed Bin". A detailed example of Case1 is shown in Figure 172.

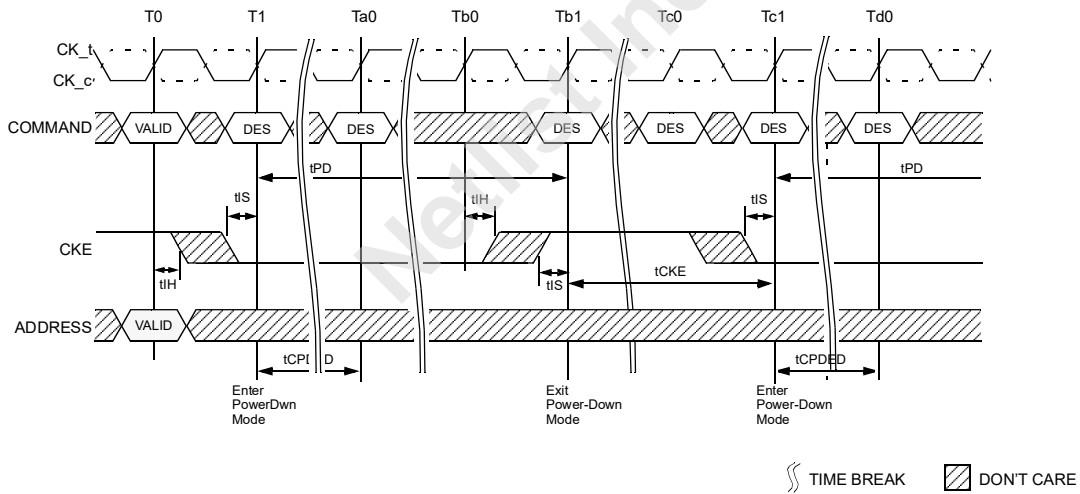
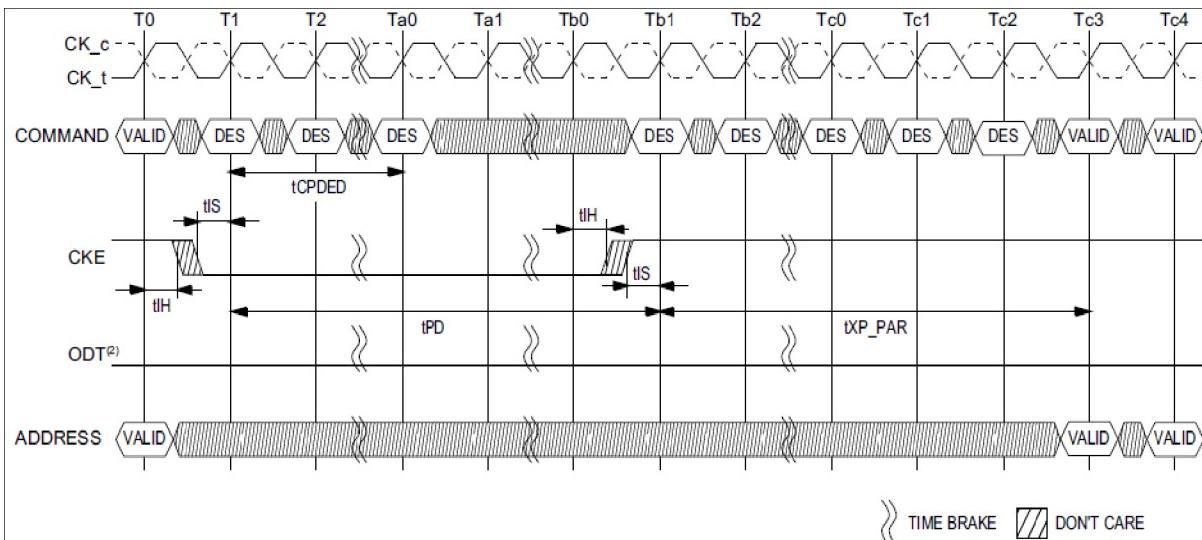


Figure 172 — Power-Down Entry/Exit Clarification

#### 4.28.3 Power Down Entry and Exit timing during Command/Address Parity Mode is Enable

Power Down entry and exit timing during Command/Address Parity mode is Enable are shown in Figure 173.



##### NOTE

1. VALID command at T0 is ACT, DES or Precharge with still one bank remaining open after completion of the precharge command.
2. ODT pin driven to a valid state. MR5[A5 = 0] (default setting) is shown.
3. CA Parity = Enable

**Figure 173 — Power Down Entry and Exit Timing with C/A Parity**

**Table 89 — AC Timing Table**

| Speed   |         | DDR4-1600              |     | DDR4-1866              |     | DDR4-2133              |     | DDR4-2400              |     | Unit |
|---|---------|------------------------|-----|------------------------|-----|------------------------|-----|------------------------|-----|------|
| Parameter   | Symbol  | MIN                    | MAX | MIN                    | MAX | MIN                    | MAX | MIN                    | MAX | Unit |
| Exit Power Down with DLL on to any valid command;<br>Exit Precharge Power Down with DLL frozen to commands not requiring a locked DLL when CA Parity is enabled | tXP_PAR | max (4nCK,6ns)<br>+ PL | -   |      |

#### 4.29 Maximum Power Saving Mode

##### 4.29.1 Maximum power saving mode

This mode provides lowest power consuming mode which could be similar to the Self-Refresh status with no internal refresh activity. When DDR4 SDRAM is in the maximum power saving mode, it does not need to guarantee data retention nor respond to any external command (except maximum power saving mode exit and asserting RESET\_n signal LOW) to minimize the power consumption.

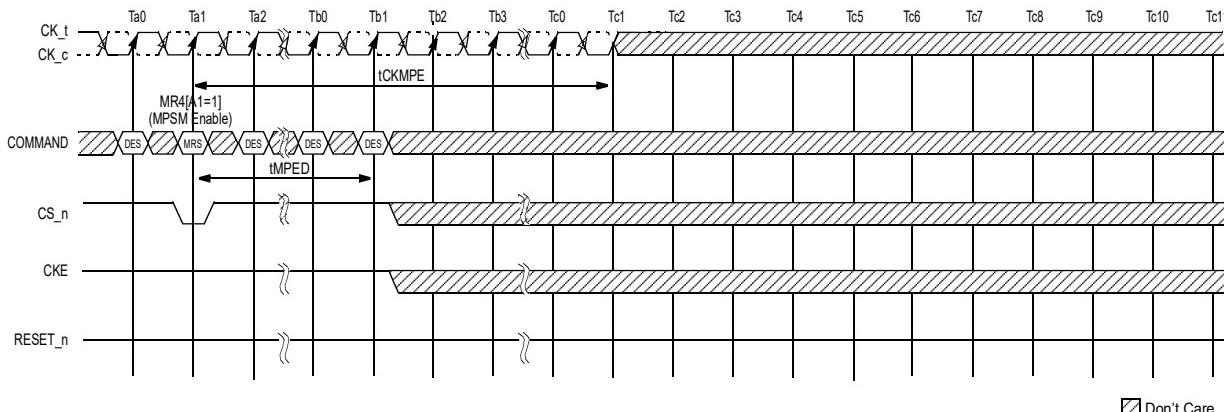
##### 4.29.2 Mode entry

Max power saving mode is entered through an MRS command. For devices with shared control/address signals, a single DRAM device can be entered into the max power saving mode using the per DRAM Addressability MRS command.

Note that large CS\_n hold time to CKE upon the mode exit may cause DRAM malfunction, thus it is required that the CA parity,

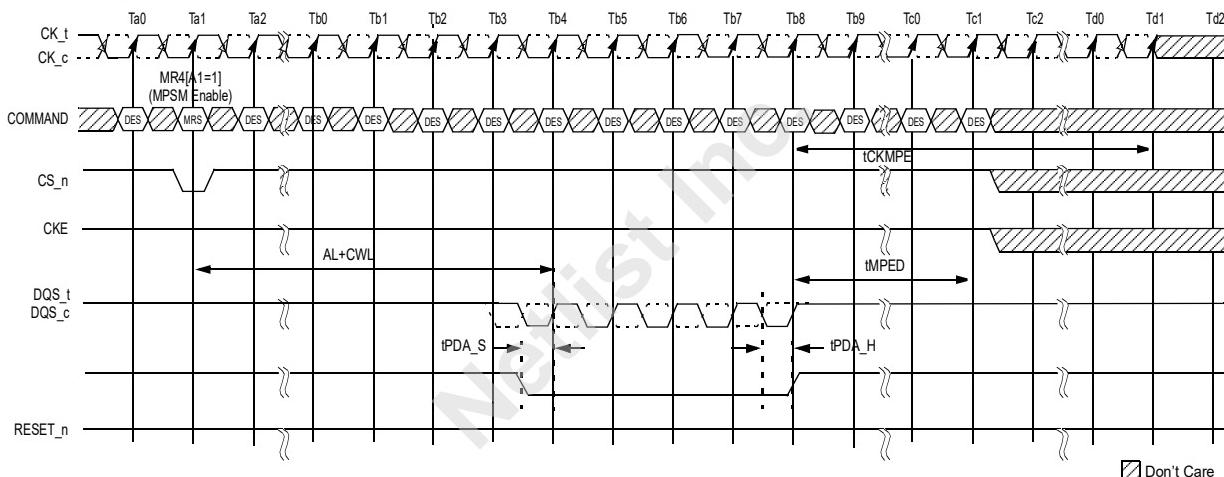
#### 4.29.2 Mode entry (Cont'd)

CAL and Gear Down modes are disabled prior to the max power saving mode entry MRS command.



**Figure 174 — Maximum Power Saving mode Entry**

Figure 175 below illustrates the sequence and timing parameters required for the maximum power saving mode with the per DRAM addressability (PDA).

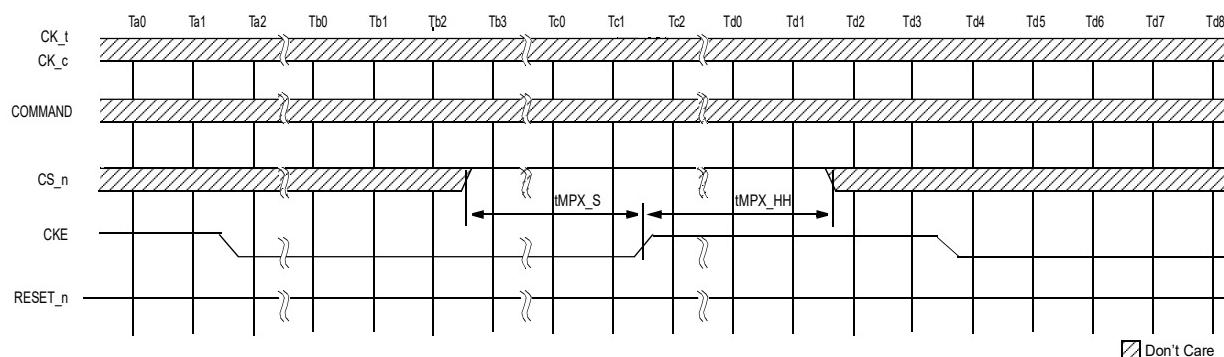


**Figure 175 — Maximum Power Saving mode Entry with PDA**

When entering Maximum Power Saving mode, only DES commands are allowed until tMPED is satisfied. After tMPED period from the mode entry command, DRAM is not responsive to any input signals except CS\_n, CKE and RESET\_n signals, and all other input signals can be High-Z. CLK should be valid for tCKMPE period and then can be High-Z.

#### 4.29.3 CKE transition during the mode

CKE toggle is allowed when DRAM is in the maximum power saving mode. To prevent the device from exiting the mode, CS\_n should be issued 'High' at CKE 'L' to 'H' edge with appropriate setup tMPX\_S and hold tMPX\_HH timings.



**Figure 176 — CKE Transition Limitation to hold Maximum Power Saving Mode**

#### 4.29.4 Mode exit

DRAM monitors CS\_n signal level and when it detects CKE 'L' to 'H' transition, and either exits from the power saving mode or stay in the mode depending on the CS\_n signal level at the CKE transition. Because CK receivers are shut down during this mode, CS\_n = 'L' is captured by rising edge of the CKE signal. If CS\_n signal level is detected 'L', then the DRAM initiates internal exit procedure from the power saving mode. CK must be restarted and stable tCKMPX period before the device can exit the maximum power saving mode. During the exit time tXMP, any valid commands except DES command is not allowed to DDR4 SDRAM and also tXMP\_DLL, any valid commands requiring a locked DLL is not allowed to DDR4 SDRAM.

When recovering from this mode, the DRAM clears the MRS bits of this mode. It means that the setting of MR4 [A1] is move to '0' automatically.

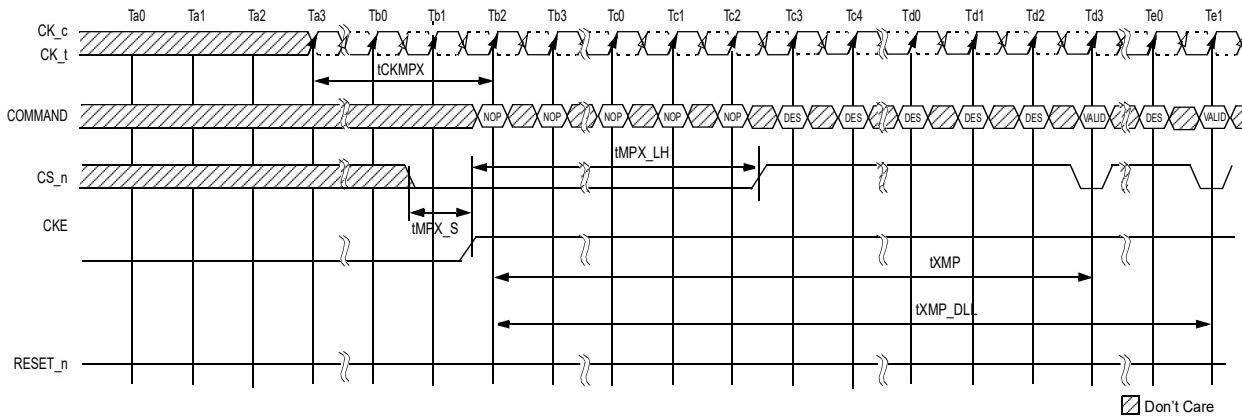


Figure 177 — Maximum Power Saving Mode Exit Sequence

#### 4.29.5 Timing parameter bin of Maximum Power Saving Mode for DDR4-1600/1866/2133/2400/2666/2933/3200

Table 90 — Timing parameter bin of Maximum Power Saving Mode

| Description                                      | symbol  | DDR4-1600/1866/2133/2400 |           | DDR4-2666/2933/3200     |           | Unit | Note |
|--|---------|--------------------------|-----------|-------------------------|-----------|------|------|
|  |         | Min                      | Max       | Min                     | Max       |      |      |
| Command path disable delay upon MPSM entry       | tMPED   | tMOD(min) + tCPDED(min)  | -         | tMOD(min) + tCPDED(min) | -         |      |      |
| Valid clock requirement after MPSM entry         | tCKMPE  | tMOD(min) + tCPDED(min)  | -         | tMOD(min) + tCPDED(min) | -         |      |      |
| Valid clock requirement before MPSM exit         | tCKMPX  | tCKSRX(min)              | -         | tCKSRX(min)             | -         |      |      |
| Exit MPSM to commands not requiring a locked DLL | tXMP    | tXS(min)                 | -         | tXS(min)                | -         |      |      |
| Exit MPSM to commands requiring a locked DLL     | tXMPDLL | tXMP(min) + tXSDLL(min)  | -         | tXMP(min) + tXSDLL(min) | -         |      |      |
| CS setup time to CKE                             | tMPX_S  | tISmin + tIHmin          | -         | tISmin + tIHmin         | -         |      |      |
| CS_n High hold time to CKE rising edge           | tMPX_HH | tXP(min)                 |           | tXP(min)                |           |      |      |
| CS_n Low hold time to CKE rising edge            | tMPX_LH | 12                       | tXMP-10ns | 12                      | tXMP-10ns | ns   | 1    |

NOTE 1 tMPX\_LH(max) is defined with respect to actual tXMP in system as opposed to tXMP(min).

## 4.30 Connectivity Test Mode

### 4.30.1 Introduction

The DDR4 memory device supports a connectivity test (CT) mode, which is designed to greatly speed up testing of electrical continuity of pin interconnection on the PC boards between the DDR4 memory devices and the memory controller on the SoC. Designed to work seamlessly with any boundary scan devices, the CT mode is required for all x16 width devices independent of density and optional for all x8 and x4 width devices with densities greater than or equal to 8Gb.

Contrary to other conventional shift register based test mode, where test patterns are shifted in and out of the memory devices serially in each clock, DDR4's CT mode allows test patterns to be entered in parallel into the test input pins and the test results extracted in parallel from the test output pins of the DDR4 memory device at the same time, significantly enhancing the speed of the connectivity check. RESET\_n is registered to High and VrefCA must be stable prior to entering CT mode. Once put in the CT mode, the DDR4 memory device effectively appears as an asynchronous device to the external controlling agent; after the input test pattern is applied, the connectivity check test results are available for extraction in parallel at the test output pins after a fixed propagation delay. During CT mode, any ODT is turned off.

A reset of the DDR4 memory device is required after exiting the CT mode.

### 4.30.2 Pin Mapping

Only digital pins can be tested via the CT mode. For the purpose of connectivity check, all pins that are used for the digital logic in the DDR4 memory device are classified as one of the following types:

1. Test Enable (TEN) pin: when asserted high, this pin causes the DDR4 memory device to enter the CT mode. In this mode, the normal memory function inside the DDR4 memory device is bypassed and the IO pins appear as a set of test input and output pins to the external controlling agent; additionally, the DRAM will set the internal VrefDQ to VDDQ\*0.5 during CT mode (this is the only time the DRAM takes direct control over setting the internal VrefDQ). The TEN pin is dedicated to the connectivity check function and will not be used during normal memory operation.
2. Chip Select (CS\_n) pin: when asserted low, this pin enables the test output pins in the DDR4 memory device. When de-asserted, the output pins in the DDR4 memory device will be tri-stated. The CS\_n pin in the DDR4 memory device serves as the CS\_n pin when in CT mode.
3. Test Input: a group of pins that are used during normal DDR4 DRAM operation are designated test input pins. These pins are used to enter the test pattern in CT mode.
4. Test Output: a group of pins that are used during normal DDR4 DRAM operation are designated test output pins. These pins are used for extraction of the connectivity test results in CT mode.
5. RESET\_n : Fixed high level is required during CT mode same as normal function.

Table 91 below shows the pin classification of the DDR4 memory device.

**Table 91 — Pin Classification of DDR4 Memory Device in Connectivity Test(CT) Mode**

| Pin Type in CT Mode |   | Pin Names during Normal Memory Operation   |
|---------------------|---|--|
| Test Enable         |   | TEN  |
| Chip Select         |   | CS_n   |
| Test Input          | A | BA0-1, BG0-1, A0-A9, A10/AP, A12/BC_n, A13, WE_n/A14, CAS_n/A15, RAS_n/A16, CKE, ACT_n, ODT, CK_t, CK_c, PAR |
|                     | B | DML_n/DBIL_n, DMU_n/DBIU_n, DM_n/DBI_n   |
|                     | C | ALERT_n  |
|                     | D | RESET_n  |
| Test Output         |   | DQ0 – DQ15, DQSU_t, DQSU_c, DQLS_t, DQLS_c, DQS_t, DQS_c   |

**Table 92 — Signal Description**

| Symbol | Type  | Function   |
|--------|-------|--|
| TEN    | Input | Connectivity Test Mode is active when TEN is HIGH and inactive when TEN is LOW. TEN must be LOW during normal operation. TEN is a CMOS rail-to-rail signal with DC high and low at 80% and 20% of VDD, i.e., 960mV for DC high and 240mV for DC low. |

**Table 93 — TEN Pin Weak Pull Down Strength Range**

| Symbol | Description  | Min  | Max | Unit |
|--------|--|------|-----|------|
| TEN    | TEN pin should be internally pulled low to prevent DDR4 SDRAM from conducting Connectivity Test mode in case that TEN is not used. | 0.05 | 10  | uA   |

NOTE 1 The host controller should use good enough strength when activating Connectivity Test mode to avoid current fighting at TEN signal and inability of Connectivity Test mode.

### 4.30.3 Logic Equations

#### 4.30.3.1 Min Term Equations

MTx is an internal signal to be used to generate the signal to drive the output signals.

x16 and x8 signals are internal signal indicating the density of the device.

MT0 = XOR (A1, A6, PAR)

MT1 = XOR (A8, ALERT\_n, A9)

MT2 = XOR (A2, A5, A13) or XOR (A2, A5, A13, A17)

MT3 = XOR (A0 A7, A11)

MT4 = XOR (CK\_c, ODT, CAS\_n/A15)

MT5 = XOR (CKE, RAS\_n/A16, A10/AP)

MT6 = XOR (ACT\_n, A4, BA1)

MT7 = XOR ((x16 and DMU\_n / DBIU\_n) or (!x16 and BG1)), ((x8 or x16) and DML\_n / DBIL\_n), CK\_t))

MT8 = XOR (WE\_n / A14, A12 / BC, BA0)

MT9 = XOR (BG0, A3, (RESET\_n and TEN))

Note that A17 is used for only 16Gb x4 configuration. When A17 is not used, MT2 = XOR (A2, A5, A13). When A17 is used, MT2 = XOR (A2, A5, A13, A17)

#### 4.30.3.2 Output equations for x16 devices

DQ0 = MT0

DQ1 = MT1

DQ2 = MT2

DQ3 = MT3

DQ4 = MT4

DQ5 = MT5

DQ6 = MT6

DQ7 = MT7

DQ8 = !DQ0

DQ9 = !DQ1

DQ10 = !DQ2

DQ11 = !DQ3

DQ12 = !DQ4

DQ13 = !DQ5

DQ14 = !DQ6

DQ15 = !DQ7

DQSL\_t = MT8

DQSL\_c = MT9

DQSU\_t = !DQSL\_t

DQSU\_c = !DQSL\_c

#### 4.30.3.3 Output equations for x8 devices

DQ0 = MT0

DQ1 = MT1

DQ2 = MT2

DQ3 = MT3

DQ4 = MT4

DQ5 = MT5

DQ6 = MT6

DQ7 = MT7

DQS\_t = MT8

DQS\_c = MT9

#### 4.30.3.4 Output equations for x4 devices

DQ0 = XOR(MT0, MT1)

DQ1 = XOR(MT2, MT3)

DQ2 = XOR(MT4, MT5)

DQ3 = XOR(MT6, MT7)

DQS\_t = MT8

DQS\_c = MT9

#### 4.30.4 Input level and Timing Requirement

During CT Mode, input levels are defined below.

TEN pin : CMOS rail-to-rail with DC high and low at 80% and 20% of VDD.

CS\_n : Pseudo differential signal referring to VrefCA

Test Input pin A : Pseudo differential signal referring to VrefCA

Test Input pin B : Pseudo differential signal referring to internal Vref 0.5\*VDD

RESET\_n : CMOS DC high above 70 % VDD

ALERT\_n : Terminated to VDD. Swing level is TBD.

Prior to the assertion of the TEN pin, all voltage supplies must be valid and stable.

Upon the assertion of the TEN pin, the CK\_t and CK\_c signals will be ignored and the DDR4 memory device enter into the CT mode after tCT\_Enable. In the CT mode, no refresh activities in the memory arrays, initiated either externally (i.e., auto-refresh) or internally (i.e., self-refresh), will be maintained.

The TEN pin may be asserted after the DRAM has completed power-on; once the DRAM is initialized and VREFdq is calibrated, CT Mode may no longer be used.

The TEN pin may be de-asserted at any time in the CT mode. Upon exiting the CT mode, the states of the DDR4 memory device are unknown and the integrity of the original content of the memory array is not guaranteed and therefore the reset initialization sequence is required.

All output signals at the test output pins will be stable within tCT\_Valid after the test inputs have been applied to the test input pins with TEN input and CS\_n input maintained High and Low respectively.

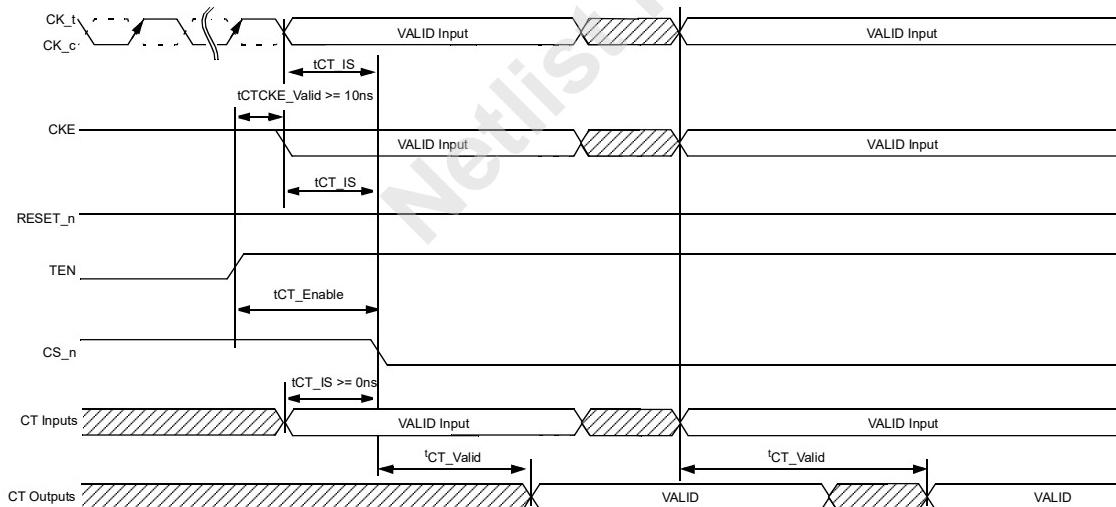


Figure 178 — Timing Diagram for Connectivity Test(CT) Mode

Table 94 — AC parameters for Connectivity Test (CT) Mode

| Symbol     | Min | Max | Unit |
|------------|-----|-----|------|
| tCT_IS     | 0   | -   | ns   |
| tCT_Enable | 200 | -   | ns   |
| tCT_Valid  | -   | 200 | ns   |

#### 4.30.5 Connectivity Test (CT) Mode Input Levels

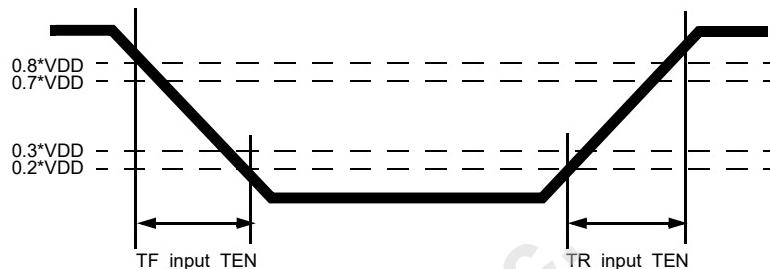
Following input parameters will be applied for DDR4 SDRAM Input Signal during Connectivity Test Mode.

**Table 95 — CMOS rail to rail Input Levels for TEN**

| Parameter                     | Symbol       | Min       | Max       | Unit | Notes |
|-------------------------------|--------------|-----------|-----------|------|-------|
| TEN AC Input High Voltage     | VIH(AC)_TEN  | 0.8 * VDD | VDD       | V    | 1     |
| TEN DC Input High Voltage     | VIH(DC)_TEN  | 0.7 * VDD | VDD       | V    |       |
| TEN DC Input Low Voltage      | VIL(DC)_TEN  | VSS       | 0.3 * VDD | V    |       |
| TEN AC Input Low Voltage      | VIL(AC)_TEN  | VSS       | 0.2 * VDD | V    | 2     |
| TEN Input signal Falling time | TF_input_TEN | -         | 10        | ns   |       |
| TEN Input signal Rising time  | TR_input_TEN | -         | 10        | ns   |       |

NOTE 1 Overshoot might occur. It should be limited by the Absolute Maximum DC Ratings.

NOTE 2 Undershoot might occur. It should be limited by Absolute Maximum DC Ratings.

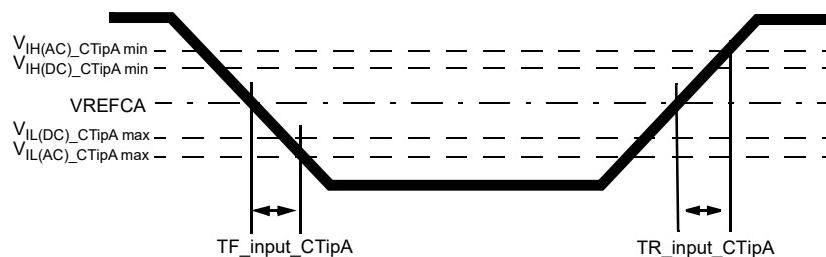


**Figure 179 — TEN Input Slew Rate Definition**

**Table 96 — Single-Ended AC and DC Input levels for CS\_n, BA0-1, BG0-1,A0-A9, A10/AP, A12/BC\_n, A13, WE\_n/A14, CAS\_n/A15, RAS\_n/A16, A17, CKE, ACT\_n, ODT, CK\_t, CK\_c, and PAR**

| Parameter                       | Symbol         | Min           | Max           | Unit | Notes |
|---------------------------------|----------------|---------------|---------------|------|-------|
| CTipA AC Input High Voltage     | VIH(AC)_CTipA  | VREFCA + 0.2  | Note 1        | V    |       |
| CTipA DC Input High Voltage     | VIH(DC)_CTipA  | VREFCA + 0.15 | VDD           | V    |       |
| CTipA DC Input Low Voltage      | VIL(DC)_CTipA  | VSS           | VREFCA - 0.15 | V    |       |
| CTipA AC Input Low Voltage      | VIL(AC)_CTipA  | Note 1        | VREFCA - 0.2  | V    |       |
| CTipA Input signal Falling time | TF_input_CTipA | -             | 5             | ns   |       |
| CTipA Input signal Rising time  | TR_input_CTipA | -             | 5             | ns   |       |

NOTE 1 See 8.3.4 and 8.3.5 "Overshoot and Undershoot Specifications".



**Figure 180 — CS\_n and Input A Slew Rate Definition**

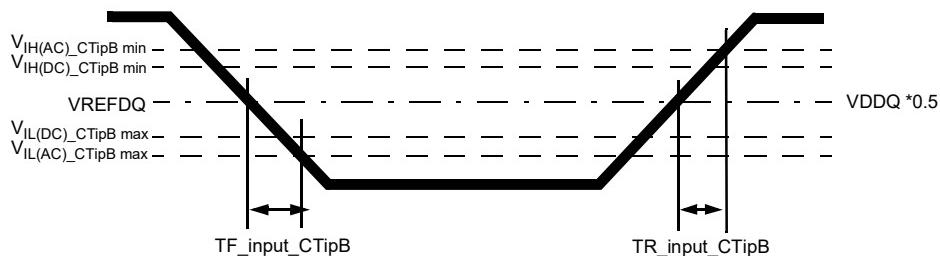
#### 4.30.5 Connectivity Test (CT) Mode Input Levels (cont'd)

**Table 97 — Single-Ended AC and DC Input levels for DML\_n/DBIL\_n, DMU\_n/DBIU\_n and DM\_n/DBI\_n**

| Parameter                       | Symbol         | Min          | Max          | Unit | Notes |
|---------------------------------|----------------|--------------|--------------|------|-------|
| CTipB AC Input High Voltage     | VIH(AC)_CTipB  | VREFDQ + 0.3 | Note 2       | V    | 1     |
| CTipB DC Input High Voltage     | VIH(DC)_CTipB  | VREFDQ + 0.2 | VDDQ         | V    | 1     |
| CTipB DC Input Low Voltage      | VIL(DC)_CTipB  | VSSQ         | VREFDQ - 0.2 | V    | 1     |
| CTipB AC Input Low Voltage      | VIL(AC)_CTipB  | Note 2       | VREFDQ - 0.3 | V    | 1     |
| CTipB Input signal Falling time | TF_input_CTipB | -            | 5            | ns   |       |
| CTipB Input signal Rising time  | TR_input_CTipB | -            | 5            | ns   |       |

NOTE 1 VREFDQ is VDDQ\*0.5

NOTE 2 See 8.3.6 "Overshoot and Undershoot Specifications"



**Figure 181 — Input B Slew Rate Definition**

##### 4.30.5.1 Input Levels for RESET\_n

RESET\_n input condition is the same as normal operation.

##### 4.30.5.2 Input Levels for ALERT\_n

TBD

<Following table is just reference. >

**Table 98 — Pin Classification of DDR4 Memory Device in Connectivity Test(CT) Mode**

| Pin Type in CT Mode |   | Pin Names during Normal Memory Operation  |  |
|---------------------|---|---|--|
| Test Enable         |   | TEN   |  |
| Chip Select         |   | CS_n  |  |
| Test Input          | A | BA0-1, BG0-1, A0-A9, A10/AP, A12/BC_n, A13, WE_n/A14, CAS_n/A15, RAS_n/A16, A17, CKE, ACT_n, ODT, CK_t, CK_c, PAR |  |
|                     | B | DML_n/DBIL_n, DMU_n/DBIU_n, DM_n/DBI_n  |  |
|                     | C | Alert_n   |  |
|                     | D | RESET_n   |  |
| Test Output         |   | DQ0 – DQ15, DQSU_t, DQSU_c, DQLS_t, DQLS_c, DQS_t, DQS_c  |  |

#### 4.31 CLK to Read DQS timing parameters

DDR4 supports DLLOFF mode. Following parameters will be defined for CK to read DQS timings.

**Table 99 — CLK to Read DQS Timing Parameters**

| Speed  |                  | DDR4-1600/1866/2133/2400/2666/3200 |                              |                  |            |
|--|------------------|------------------------------------|------------------------------|------------------|------------|
| Parameter  | Symbol           | Min                                | Max                          | Units            | NOTE       |
| DQS_t, DQS_c rising edge output timing location from rising CK_t, CK_c | tDQSCK (DLL On)  | refer to AC parameter tables       | refer to AC parameter tables | ps               | 1, 3, 8, 9 |
|  | tDQSCK (DLL Off) | vendor specific                    | vendor specific              | ps               | 2, 3, 8    |
| DQS_t, DQS_c rising edge output variance window                        | tDQSCKi(DLL On)  | -                                  | refer to AC parameter tables | ps               | 1,5,6,8,9  |
|  | tDQSCKi(DLL Off) | -                                  | vendor specific              | ps               | 2,4,5,6,8  |
| VDD sensitivity of tDQSCK (DLL Off)                                    | dTDQSCKdV        | -                                  | vendor specific              | ps/mV            | 2, 6       |
| Temperature sensitivity of tDQSCK (DLL Off)                            | dTDQSCKdT        | -                                  | vendor specific              | ps/ $^{\circ}$ C | 2, 6       |

NOTE 1 These parameters are applied when DRAM is in DLLON mode.

NOTE 2 These parameters are applied when DRAM is in DLLOFF mode.

NOTE 3 Measured over full VDD and Temperature spec ranges.

NOTE 4 Measured at fixed and constant VDD and Temperature condition.

NOTE 5 Measured for a given DRAM part, and for each DQS\_t/DQS\_c pair in case of x16 (part variation is excluded).

NOTE 6 These parameters are verified by design and characterization, and may not be subject to production test.

NOTE 7 deleted

NOTE 8 Assume no jitter on input clock signals to the DRAM.

NOTE 9 Refer to Section 4.24.1 READ Timing Definitions.

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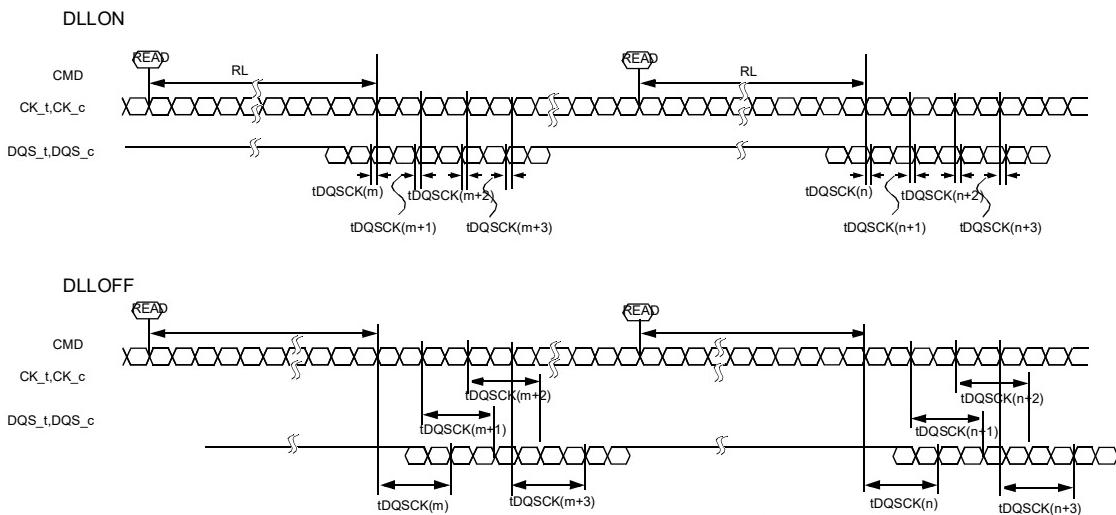
#### 4.31 CLK to Read DQS timing parameters (cont'd)

tDQSK(DLL On), Min limit = Earliest of {tDQSK(m)(DLL On), at any valid VDD and Temperature, all DQS pairs and parts}

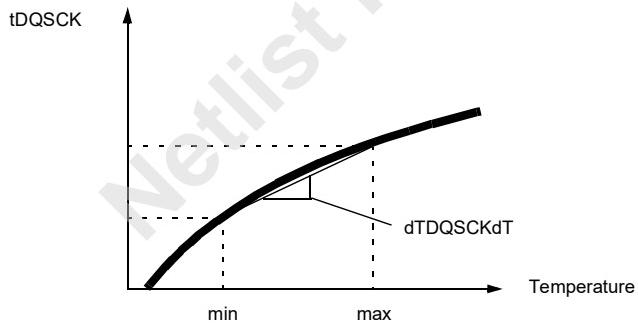
tDQSK(DLL On), Max limit = Latest of {tDQSK(m)(DLL On), at any valid VDD and Temperature, all DQS pairs and parts}

tDQSK(DLL Off), Min limit = Earliest of {tDQSK(m)(DLL Off), at any valid VDD and Temperature, all DQS pairs and parts}

tDQSK(DLL Off), Max limit = Latest of {tDQSK(m)(DLL Off), at any valid VDD and Temperature, all DQS pairs and parts}

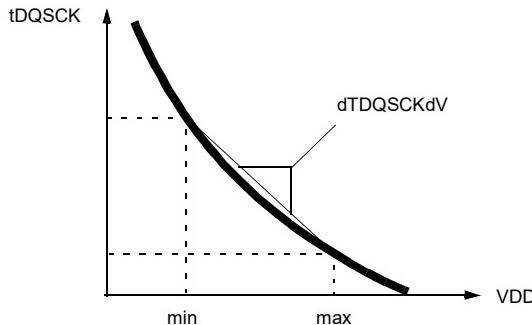


**Figure 182 — tDQSK Definition Difference between DLL ON and DLL OFF**



$$dTQSKdT = |tDQSK(Toper,max) - tDQSK(Toper,min)| / Toper,max - Toper,min$$

**Figure 183 — dTQSKdT Definition**



$$dTQSKdV = |tDQSK(VDD,max) - tDQSK(VDD,min)| / VDD,max - VDD,min$$

**Figure 184 — TDQSKdT Definition**

## 4.32 Post Package Repair (hPPR)

DDR4 supports Fail Row address repair as optional feature for 4Gb and required for 8Gb and above. Supporting hPPR is identified via Datasheet and SPD in Module so should refer to DRAM manufacturer's Datasheet. PPR provides simple and easy repair method in the system and Fail Row address can be repaired by the electrical programming of Electrical-fuse scheme.

With hPPR, DDR4 can correct 1Row per Bank Group

Electrical-fuse cannot be switched back to un-fused states once it is programmed. The controller should prevent unintended hPPR mode entry and repair. (i.e., Command/Address training period)

DDR4 defines two hard fail row address repair sequences and users can choose to use among those 2 command sequences. The first command sequence uses a WRA command and ensures data retention with Refresh operations except for the 2banks containing the rows being repaired, with BA[0] a don't care. Second command sequence is to use WR command and Refresh operation can't be performed in the sequence. So, the second command sequence doesn't ensure data retention for target DRAM.

When hard PPR Mode is supported, entry into hPPR Mode is to be protected through a sequential MRS guard key to prevent unintentional hPPR programming. When soft PPR Mode, i.e., sPPR, is supported, entry into sPPR Mode is to be protected through a sequential MRS guard key to prevent unintentional sPPR programming. The sequential MRS guard key for hPPR mode and sPPR is the same Guard Key, i.e., hPPR/sPPR Guard Key.

The hPPR/sPPR Guard Key requires a sequence of four MR0 commands to be executed immediately after entering hPPR mode (setting MR4 bit 13 to a "1") or immediately after entering sPPR mode (setting MR4 bit 5 to a "1"). The hPPR/sPPR Guard Key's sequence must be entered in the specified order as stated and shown in the spec below. Any interruption of the hPPR/sPPR Guard Key sequence from other MR commands or non-MR commands such as ACT, WR, RD, PRE, REF, ZQ, NOP, RFU is not allowed. Although interruption of the hPPR/sPPR Guard Key entry is not allowed, if the hPPR/sPPR Guard Key is not entering in the required order or is interrupted by other commands, the hPPR Mode or sPPR Mode will not execute and the offending command terminating hPPR/sPPR Mode may or may not execute correctly; however, the offending command will not cause the DRAM to "lock up". Additionally, when the hPPR or sPPR entry sequence is interrupted, subsequent ACT and WR commands will be conducted as normal DRAM commands. If a hPPR operation was prematurely terminated, the MR4 bit 13 must be re-set "0" prior to performing another hPPR or sPPR operation. If a sPPR operation was prematurely terminated, the MR4 bit 5 must be reset to "0" prior to performing another sPPR or hPPR operation. The DRAM does not provide an error indication if an incorrect hPPR/sPPR Guard Key sequence is entered.

**Table 100 — hPPR & sPPR MR0 Guard Key Sequences**

| Guard Keys          | BG1:0 <sup>1</sup> | BA1:0 | A17:A12 | A11 | A10 | A9 | A8 | A7 | A6:A0   |
|---------------------|--------------------|-------|---------|-----|-----|----|----|----|---------|
| 1 <sup>st</sup> MR0 | 00                 | 00    | X       | 1   | 1   | 0  | 0  | 1  | 1111111 |
| 2 <sup>nd</sup> MR0 | 00                 | 00    | X       | 0   | 1   | 1  | 1  | 1  | 1111111 |
| 3 <sup>rd</sup> MR0 | 00                 | 00    | X       | 1   | 0   | 1  | 1  | 1  | 1111111 |
| 4 <sup>th</sup> MR0 | 00                 | 00    | X       | 0   | 0   | 1  | 1  | 1  | 1111111 |

NOTE 1 BG1 is 'Don't Care' in X16

NOTE 2 A6:A0 can be either '111111' or 'Don't Care'. And, it depends on vendor's implementation. '111111' is allowed in all DDR4 density but 'Don't Care' in A6:A0 is only allowed in 4Gb & 8Gb die DDR4 product.

NOTE 3 After completing hPPR & sPPR mode, MR0 must be re-programmed to pre-PPR mode state if the DRAM is to be accessed.

### 4.32.1 Hard Fail Row Address Repair (WRA Case)

The following is a procedure of hPPR with the WRA command.

1. Before entering 'hPPR' mode, all banks must be Precharged; DBI and CRC Modes must be disabled
2. Enable hPPR using MR4 bit "A13=1" and wait tMOD
3. Issue guard Key as four consecutive MR0 commands each with a unique address field A[17:0]. Each MR0 command should space by tMOD
4. Issue ACT command with Fail Row address
5. After tRCD, Issue WRA with VALID address. DRAM will consider Valid address with WRA command as 'Don't Care'
6. After WL(WL=CWL+AL+PL), All DQs of Target DRAM should be LOW for 4tCK. If HIGH is driven to All DQs of a DRAM consecutively for equal to or longer than 2tCK, then DRAM does not conduct hPPR and retains data if REF command is properly issued; if all DQs are neither LOW for 4tCK nor HIGH for equal to or longer than 2tCK , then hPPR mode execution is unknown.
7. Wait tPGM to allow DRAM repair target Row Address internally and issue PRE
8. Wait tPGM\_Exit after PRE which allow DRAM to recognize repaired Row address
9. Exit hPPR with setting MR4 bit "A13=0"
10. DDR4 will accept any valid command after tPGMPST
11. In More than one fail address repair case, Repeat Step 2 to 9

#### 4.32.1 Hard Fail Row Address Repair (WRA Case) (cont'd)

In addition to that, hPPR mode allows REF commands from PL+WL+BL/2+tWR+tRP after WRA command during tPGM and tPGMPST for proper repair; provided multiple REF commands are issued at a rate of tREFI or tREFI/2, however back-to-back REF commands must be separated by at least tREFI/4 when the DRAM is in hPPR mode. Upon receiving REF command, DRAM performs normal Refresh operation and ensure data retention with Refresh operations except for the 2banks containing the rows being repaired, with BA[0] don't care. Other command except REF during tPGM can cause incomplete repair so no other command except REF is allowed during tPGM

Once hPPR mode is exited, to confirm if target row is repaired correctly, host can verify by writing data into the target row and reading it back after hPPR exit with MR4 [A13=0] and tPGMPST

#### 4.32.2 Hard Fail Row Address Repair (WR Case)

The following is procedure of hPPR PPR with WR command.

1. Before entering hPPR mode, all banks must be precharged; DBI and CRC modes must be disabled
2. Enable hPPR using MR4 bit "A13=1" and wait tMOD
3. Issue guard Key as four consecutive MR0 commands each with a unique address field A[17:0]. Each MR0 command should space by tMOD
4. Issue ACT command with row address
5. After tRCD, issue WR with valid address. DRAM consider the valid address with WR command as 'Don't Care'
6. After WL(WL=CWL+AL+PL), All DQs of target DRAM should be LOW for 4tCK. If HIGH is driven to All DQs of a DRAM consecutively for equal to or longer than first 2tCK, then DRAM does not conduct hPPR and retains data if REF command is properly issued; if all DQs are neither LOW for 4tCK nor HIGH for equal to or longer than first 2tCK, then hPPR mode execution is unknown.
7. Wait tPGM to allow DRAM repair target Row Address internally and issue PRE
8. Wait tPGM\_Exit after PRE which allow DRAM to recognize repaired Row address
9. Exit hPPR with setting MR4 bit "A13=0"
10. DDR4 will accept any valid command after tPGMPST
11. In More than one fail address repair case, Repeat Step 2 to10

In this sequence, Refresh command is not allowed between hPPR MRS entry and exit.

Once hPPR mode is exited, to confirm if target row is repaired correctly, host can verify by writing data into the target row and reading it back after hPPR exit with MR4 [A13=0] and tPGMPST

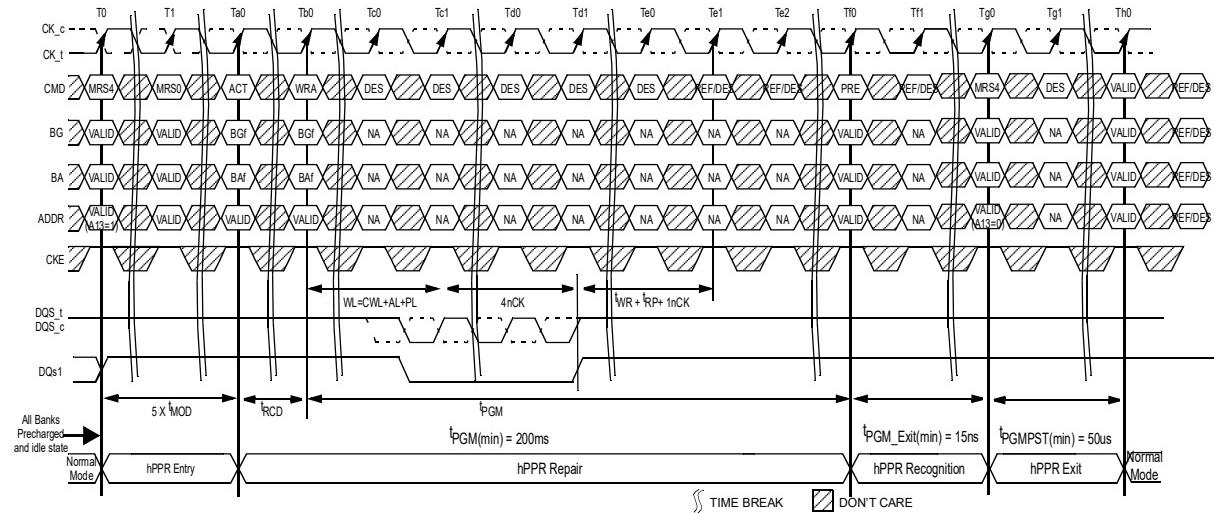
#### 4.32.3 Hard Fail Row Address Repair MR bits and timing diagram

The following table and Timing diagram show hPPR related MR bits and its operation

**Table 101 — hPPR Setting**

| MR4 [A13] | Description   |
|-----------|---------------|
| 0         | hPPR Disabled |
| 1         | hPPR Enabled  |

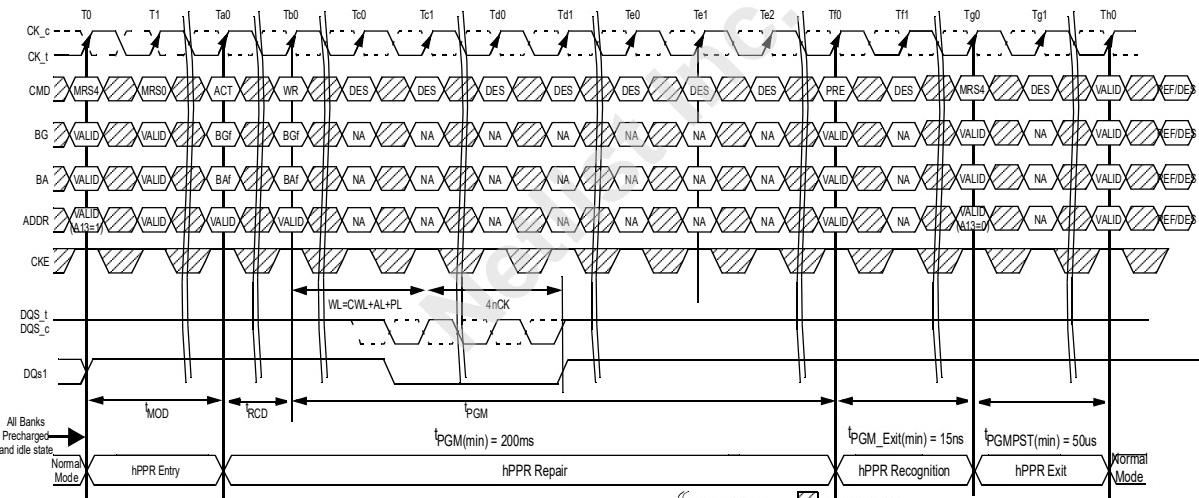
#### 4.32.3 Hard Fail Row Address Repair MR bits and timing diagram (cont'd)



NOTE 1 Allow REF(1X) from PL+WL+BL/2+tWR+tRP after WR

NOTE 2 Timing diagram shows possible commands but not all shown can be issued at same time; for example if REF is issued at Te1, DES must be issued at Te2 as REF would be illegal at Te2. Likewise, DES must be issued tRFC prior to PRE at Tf0. All regular timings must still be satisfied.

**Figure 185 — Hard Fail Row Repair (WRA Case)**



**Figure 186 — Hard Fail Row Repair (WR Case)**

#### 4.32.4 Programming hPPR & sPPR support in MPR0 page?

hPPR & sPPR is optional feature of DDR4 4Gb so Host can recognize if DRAM is supporting hPPR & sPPR or not by reading out MPR0 Page2

MPR page?

hard PPR is supported : [7]=1

hard PPP is supported : [7]=1

soft PPP is supported : [6]=1

soft PPP is supported : [6]=1

#### 4.32.5 Required Timing Parameters

Repair requires additional time period to repair Hard Fail Row Address into spare Row address and the followings are requirement timing parameters for HFRP.

#### 4.32.5 Required Timing Parameters (cont'd)

**Table 102 — hPPR Timing Parameters**

| Parameter                        | Symbol    | DDR4-1600/1866/2133/2400 |     | DDR4-2666/3200 |     | Unit | Note |
|----------------------------------|-----------|--------------------------|-----|----------------|-----|------|------|
|                                  |           | min                      | max | min            | max |      |      |
| hPPR Programming Time: x4/<br>x8 | tPGMa     | 1,000                    | -   | 1,000          | -   | ms   |      |
| hPPR Programming Time: x16       | tPGMb     | 2,000                    | -   | 2,000          | -   | ms   |      |
| hPPR Exit Time                   | tPGM_Exit | 15                       | -   | 15             | -   | ns   |      |
| New Address Setting time         | tPGMPST   | 50                       | -   | 50             | -   | us   |      |

#### 4.33 Soft Post Package Repair (sPPR)

Soft Post Package Repair (sPPR) is a way to quickly, but temporarily, repair a row element in a Bank Group on a DDR4 DRAM device, contrasted to hard Post Package Repair which takes longer but is permanent repair of a row element. There are some limitations and differences between sPPR and hPPR

**Table 103 — Description and Comparison of hPPR & sPPR**

| Topic  | Soft Repair  | Hard Repair  | Note   |
|--|--|--|--|
| <b>Persistence of Repair</b>                                     | Volatile – repair persists while power is within operating range | Non-Volatile – repair is permanent after the repair cycle. | sPPR cleared after power off or device reset   |
| <b>tPGM (hPPR &amp; sPPR programming Time)</b>                   | WL+ 4tCK+tWR   | >1000ms(tPGMa) or 2000ms(tPGMb)                            |  |
| <b># of Repair elements</b>                                      | 1 per BG   | 1 per BG   | Once hPPR is used within a BG, sPPR is no longer supported in that BG  |
| <b>Simultaneous use of soft and hard repair within a BG</b>      | Previous hPPR are allowed before soft repair to a different BG   | Any outstanding sPPR must be cleared before a hard repair  | Clearing sPPR occurs by either:<br>(a) powerdown and power-up sequence<br>or<br>(b) Reset and re-initialize. |
| <b>Repair Sequence</b>   | 1 method – WR cmd.   | 2 methods WRA and WR                                       |  |
| <b>Bank<sup>1</sup> not having row repair retains array data</b> | Yes  | Yes, if WRA sequence;<br>No, if WR sequence                | WRA sequence requires use of REF commands  |
| <b>Bank<sup>1</sup> having row repair retain array data</b>      | Yes, except for seed and associated rows                         | No   | sPPR must be performed outside of REF window (tRFC)  |

NOTE 1 If a BA pin is defined to be an "sPPR associated row" to the seed row, both states of the BA address input are affected. For example, if BA0 is selected as an "sPPR associated row" to the seed row, addresses in both BA0 = 0 and BA0 = 1 are equally affected.

sPPR mode is entered in a similar fashion as hPPR, sPPR uses MR4 bit A5 while hPPR uses MR4 bit A13; sPPR requires the same guard key sequence as hPPR to qualify the MR4 PPR entry. Prior to sPPR entry, either an hPPR exit command or an sPPR exit command should be performed, which ever was the last PPR entry. After sPPR entry, an ACT command will capture the target bank and target row, herein seed row, where the row repair will be made. After tRCD time, a WR command is used to select the individual DRAM, through the DQ bits, to transfer the repair address into an internal register in the DRAM. After a write recovery time and PRE command, the sPPR mode can be exited and normal operation can resume. The DRAM will retain the sPPR change as long as VDD remains within the operating region. If the DRAM power is removed or the DRAM is RESET, all sPPR changes will revert to the unrepairs state. sPPR changes must be cleared by either a power-up sequence or re-initialization by RESET signal before hPPR mode is enabled.

DDR4 sPPR can repair one row per Bank Group, however when the hPPR resources for a bank group have been used, sPPR resources are no longer available for that bank group. If an sPPR or hPPR repair sequence is issued to a bank group with PPR resource un-available, the DRAM will ignore the programming sequence. sPPR mode is optional for 4Gb & 8Gb density DDR4 devices and required for densities which are larger than 8Gb.

#### 4.33 Soft Post Package Repair (sPPR) (cont'd)

The bank receiving sPPR change is expected to retain array data in all other rows except for the seed row and its associated row addresses on all densities larger than 8Gb; and is optional for 8Gb devices and smaller. If the user does not require the data in the array in the bank under sPPR repair to be retained, then the handling of the seed row's associated row addresses is not of interest and can be ignored. If the user requires the data in the array to be retained in the bank under sPPR mode, then prior to executing the sPPR mode, the seed row and its associated row addresses should be backed up and restored after sPPR has been completed. sPPR associated seed row addresses are specified in the Table below.

**Table 104 — sPPR associated row address**

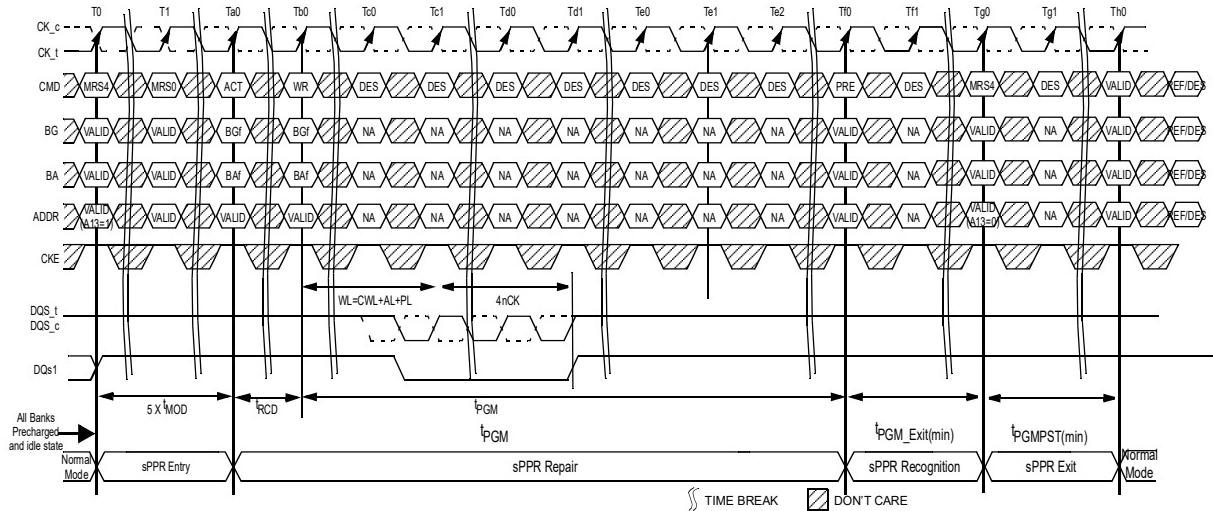
| sPPR Associated Row Addresses |     |     |     |     |     |    |    |
|-------------------------------|-----|-----|-----|-----|-----|----|----|
| BA0                           | A17 | A16 | A15 | A14 | A13 | A1 | A0 |

##### 4.33.1 Soft Repair of a Fail Row Address

The following is the procedure of sPPR with WR command. Note that during the soft repair sequence, no refresh is allowed.

1. Before entering 'sPPR' mode, all banks must be Precharged; DBI and CRC Modes must be disabled
2. Enable sPPR using MR4 bit "A5=1" and wait tMOD
3. Issue Guard Key as four consecutive MR0 commands each with a unique address field A[17:0]. Each MR0 command should space by tMOD. MR0 Guard Key sequence is same as hPPR in Table 100 on page 160
4. Issue ACT command with the Bank and Row Fail address, Write data is used to select the individual DRAM in the Rank for repair.
5. A WR command is issued after tRCD, with VALID column address. The DRAM will ignore the column address given with the WR command.
6. After WL(WL=CWL+AL+PL), All DQs of Target DRAM should be LOW for 4tCK. If HIGH is driven to All DQs of a DRAM consecutively for equal to or longer than first 2tCK, then DRAM does not conduct sPPR. If all DQs are neither LOW for 4tCK nor HIGH for equal to or longer than first 2tCK , then sPPR mode execution is unknown.
7. Wait tWR for the internal repair register to be written and then issue PRE to the Bank.
8. Wait 20ns after PRE which allow DRAM to recognize repaired Row address
9. Exit PPR with setting MR4 bit "A5=0" and wait tMOD
10. One soft repair address per Bank Group is allowed before a hard repair is required. When more than one sPPR request is made to the same BG, the most recently issued sPPR address would replace the early issued one. In the case of conducting soft repair address in a different Bank Group, Repeat Step 2 to 9 . During a soft Repair, Refresh command is not allowed between sPPR MRS entry and exit.

Once sPPR mode is exited, to confirm if target row is repaired correctly, the host can verify the repair by writing data into the target row and reading it back after sPPR exit with MR4 [A5=0].



**Figure 187 — Fail Row Soft PPR (WR Case)**

#### 4.34 Equalization Configuration Mode Registers

Rx CTLE is an optional feature on DDR4. The Mode Register for Rx CTLE Control (MR1) shown in Table 105 is vendor specific, refer to the supplier data sheets for more information regarding the details on the Mode Register definition. The host can step through all possible combinations of MR1[A13,A6,A5] and choose the settings that is best optimized for the system based on the performance metric of interest.

**Table 105 — DDR4 MR Bit Allocation for Rx EQ Control (MR1)**

| Address     | Operating Mode  | Description  |
|-------------|-----------------|--|
| A13, A6, A5 | Rx CTLE control | 000 = Vendor Optimized Setting (default)<br>001 = vendor defined<br>010 = vendor defined<br>011 = vendor defined<br>100 = vendor defined<br>101 = vendor defined<br>110 = vendor defined<br>111 = vendor defined |

NOTE 1 Refer to the vendor data sheets for more information regarding Rx CTLE Control settings.

NOTE 2 Since CTLE circuits can not be typically bypassed, a disable option is not provided. Instead, a vendor optimized setting is given. It should be noted that the settings are not specifically linear in relationship to the vendor optimized setting, so the host may opt to instead walk through all the provided options and use the setting that works best in their environment.

---

## 5 On-Die Termination

ODT (On-Die Termination) is a feature of the DDR4 SDRAM that allows the DRAM to change termination resistance for each DQ, DQS\_t, DQS\_c and DM\_n for x4 and x8 configuration (and TDQS\_t, TDQS\_c for X8 configuration, when enabled via A11=1 in MR1) via the ODT control pin or Write Command or Default Parking value with MR setting. For x16 configuration, ODT is applied to each DQU, DQL, DQSU\_t, DQSU\_c, DQLS\_t, DQLS\_c, DMU\_n and DML\_n signal. The ODT feature is designed to improve signal integrity of the memory channel by allowing the DRAM controller to independently change termination resistance for any or all DRAM devices. More details about ODT control modes and ODT timing modes can be found further down in this document.

- The ODT control modes are described in Section 5.1.
- The ODT synchronous mode is described in Section 5.2
- The Dynamic ODT feature is described in Section 5.3
- The ODT asynchronous mode is described in Section 5.4
- The ODT buffer disable mode is described in "ODT buffer disabled mode for Power down" in Section 5.5

The ODT feature is turned off and not supported in Self-Refresh mode. A simple functional representation of the DRAM ODT feature is shown in Figure 188.

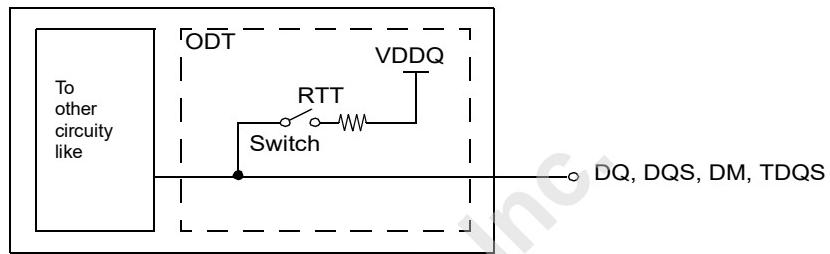


Figure 188 — Functional Representation of ODT

The switch is enabled by the internal ODT control logic, which uses the external ODT pin and Mode Register Setting and other control information, see below. The value of RTT is determined by the settings of Mode Register bits (see Section 3.5). The ODT pin will be ignored if the Mode Registers MR1 is programmed to disable RTT\_NOM(MR1{A10,A9,A8}={0,0,0}) and in self-refresh mode.

### 5.1 ODT Mode Register and ODT State Table

The ODT Mode of DDR4 SDRAM has 4 states, Data Termination Disable, RTT\_WR, RTT\_NOM and RTT\_PARK. And the ODT Mode is enabled if any of MR1{A10,A9,A8} or MR2 {A10:A9} or MR5 {A8:A6} are non zero. In this case, the value of RTT is determined by the settings of those bits.

After entering Self-Refresh mode, DRAM automatically disables ODT termination and set Hi-Z as termination state regardless of these setting.

Application: Controller can control each RTT condition with WR/RD command and ODT pin

- RTT\_WR: The rank that is being written to provide termination regardless of ODT pin status (either HIGH or LOW)
- RTT\_NOM: DRAM turns ON RTT\_NOM if it sees ODT asserted (except ODT is disabled by MR1).
- RTT\_PARK: Default parked value set via MR5 to be enabled and ODT pin is driven LOW.
- Data Termination Disable: DRAM driving data upon receiving READ command disables the termination after RL-X and stays off for a duration of BL/2 + X clock cycles.

X is 2 for 1tCK and 3 for 2tCK preamble mode.

- The Termination State Table is shown in Table 106.

Those RTT values have priority as following.

1. Data Termination Disable
2. RTT\_WR
3. RTT\_NOM
4. RTT\_PARK

which means if there is WRITE command along with ODT pin HIGH, then DRAM turns on RTT\_WR not RTT\_NOM, and also if there is READ command, then DRAM disables data termination regardless of ODT pin and goes into Driving mode.

## 5.1 ODT Mode Register and ODT State Table (cont'd)

**Table 106 — Termination State Table**

| RTT_PARK MR5{A8:A6} | RTT_NOM MR1 {A10:A9:A8} | ODT pin                 | DRAM termination state | Note |
|---------------------|-------------------------|-------------------------|------------------------|------|
| Enabled             | Enabled                 | HIGH                    | RTT_NOM                | 1,2  |
|                     |                         | LOW                     | RTT_PARK               | 1,2  |
|                     | Disabled                | Don't care <sup>3</sup> | RTT_PARK               | 1,2  |
| Disabled            | Enabled                 | HIGH                    | RTT_NOM                | 1,2  |
|                     |                         | LOW                     | Hi-Z                   | 1,2  |
|                     | Disabled                | Don't care <sup>3</sup> | Hi-Z                   | 1,2  |

NOTE 1 When read command is executed, DRAM termination state will be Hi-Z for defined period independent of ODT pin and MR setting of RTT\_PARK/RTT\_NOM. This is described in section 1.2.3 ODT During Read.

NOTE 2 If RTT\_WR is enabled, RTT\_WR will be activated by Write command for defined period time independent of ODT pin and MR setting of RTT\_PARK /RTT\_NOM. This is described in section 1.3 Dynamic ODT.

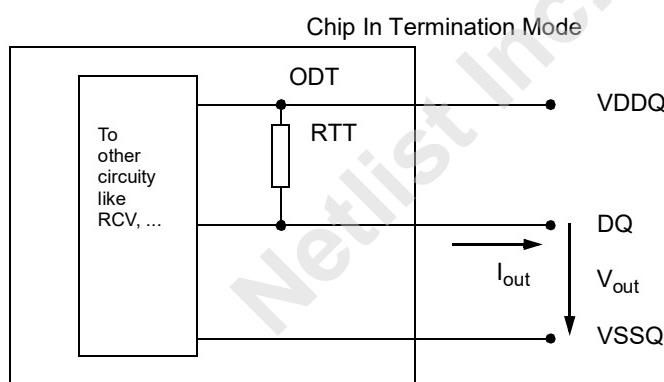
NOTE 3 If RTT\_NOM MRS is disabled, ODT receiver power will be turned off to save power.

On-Die Termination effective resistance RTT is defined by MRS bits.

RTT is applied to the DQ, DM, DQS\_T/DQS\_C and TDQS\_T/TDQS\_C (x8 devices only) pins.

A functional representation of the on-die termination is shown in the figure below.

$$RTT = \frac{VDDQ - V_{out}}{|I_{out}|}$$



**Figure 189 — On Die Termination**

### 5.1 ODT Mode Register and ODT State Table (cont'd)

On die termination effective Rtt values supported are 240, 120, 80, 60, 48, 40, 34 ohms.

**Table 107 — ODT Electrical Characteristics RZQ=240Ω +/-1% entire temperature operation range; after proper ZQ calibration**

| RTT                        | Vout              | Min | Nom | Max  | Unit  | NOTE      |
|----------------------------|-------------------|-----|-----|------|-------|-----------|
| 240Ω                       | VOLDc= 0.5* VDDQ  | 0.9 | 1   | 1.25 | RZQ   | 1,2,3,7   |
|                            | VOMdc= 0.8* VDDQ  | 0.9 | 1   | 1.1  | RZQ   | 1,2,3,7   |
|                            | VOHdc= 1.1* VDDQ  | 0.8 | 1   | 1.1  | RZQ   | 1,2,3,7   |
| 120Ω                       | VOLDc= 0.5* VDDQ  | 0.9 | 1   | 1.25 | RZQ/2 | 1,2,3,7   |
|                            | VOMdc= 0.8* VDDQ  | 0.9 | 1   | 1.1  | RZQ/2 | 1,2,3,7   |
|                            | VOHdc= 1.1* VDDQ  | 0.8 | 1   | 1.1  | RZQ/2 | 1,2,3,7   |
| 80Ω                        | VOLDc= 0.5* VDDQ  | 0.9 | 1   | 1.25 | RZQ/3 | 1,2,3,7   |
|                            | VOMdc= 0.8* VDDQ  | 0.9 | 1   | 1.1  | RZQ/3 | 1,2,3,7   |
|                            | VOHdc= 1.1* VDDQ  | 0.8 | 1   | 1.1  | RZQ/3 | 1,2,3,7   |
| 60Ω                        | VOLDc= 0.5* VDDQ  | 0.9 | 1   | 1.25 | RZQ/4 | 1,2,3,7   |
|                            | VOMdc= 0.8* VDDQ  | 0.9 | 1   | 1.1  | RZQ/4 | 1,2,3,7   |
|                            | VOHdc= 1.1* VDDQ  | 0.8 | 1   | 1.1  | RZQ/4 | 1,2,3,7   |
| 48Ω                        | VOLDc= 0.5* VDDQ  | 0.9 | 1   | 1.25 | RZQ/5 | 1,2,3,7   |
|                            | VOMdc= 0.8* VDDQ  | 0.9 | 1   | 1.1  | RZQ/5 | 1,2,3,7   |
|                            | VOHdc= 1.1* VDDQ  | 0.8 | 1   | 1.1  | RZQ/5 | 1,2,3,7   |
| 40Ω                        | VOLDc= 0.5* VDDQ  | 0.9 | 1   | 1.25 | RZQ/6 | 1,2,3,7   |
|                            | VOMdc= 0.8* VDDQ  | 0.9 | 1   | 1.1  | RZQ/6 | 1,2,3,7   |
|                            | VOHdc= 1.1* VDDQ  | 0.8 | 1   | 1.1  | RZQ/6 | 1,2,3,7   |
| 34Ω                        | VOLDc= 0.5* VDDQ  | 0.9 | 1   | 1.25 | RZQ/7 | 1,2,3,7   |
|                            | VOMdc= 0.8* VDDQ  | 0.9 | 1   | 1.1  | RZQ/7 | 1,2,3,7   |
|                            | VOHdc= 1.1* VDDQ  | 0.8 | 1   | 1.1  | RZQ/7 | 1,2,3,7   |
| DQ-DQ Mismatch within byte | VOMdc = 0.8* VDDQ | 0   | -   | 10   | %     | 1,2,4,5,6 |

NOTE 1 The tolerance limits are specified after calibration with stable voltage and temperature. For the behavior of the tolerance limits if temperature or voltage changes after calibration, see following section on voltage and temperature sensitivity.

NOTE 2 Pull-up ODT resistors are recommended to be calibrated at 0.8\*VDDQ. Other calibration schemes may be used to achieve the linearity spec shown above, e.g., calibration at 0.5\*VDDQ and 1.1\*VDDQ.

NOTE 3 The tolerance limits are specified under the condition that VDDQ=VDD and VSSQ=VSS

NOTE 4 DQ to DQ mismatch within byte variation for a given component including DQS\_T and DQS\_C (characterized)

NOTE 5 RTT variance range ratio to RTT Nominal value in a given component, including DQS\_t and DQS\_c.

$$\text{DQ-DQ Mismatch in a Device} = \frac{\text{RTTMax} - \text{RTTMin}}{\text{RTTNOM}} * 100$$

NOTE 6 This parameter of x16 device is specified for Upper byte and Lower byte.

NOTE 7 For IT device, the minimum values are reduced by tbd%.

### 5.2 Synchronous ODT Mode

Synchronous ODT mode is selected whenever the DLL is turned on and locked. Based on the power-down definition, these modes are:

- Any bank active with CKE high
- Refresh with CKE high
- Idle mode with CKE high
- Active power down mode
- Precharge power down mode

In synchronous ODT mode, RTT\_NOM will be turned on DODTLon clock cycles after ODT is sampled HIGH by a rising clock edge and turned off DODTLooff clock cycles after ODT is registered LOW by a rising clock edge. The ODT latency is tied to the Write Latency (WL = CWL + AL + PL) by: DODTLon = WL - 2; DODTLooff = WL - 2.

When operating in 2tCK Preamble Mode, The ODT latency must be 1 clock smaller than in 1tCK Preamble Mode; DODTLon =WL - 3; DODTLooff = WL - 3."(WL = CWL+AL+PL)

### 5.2.1 ODT Latency and Posted ODT

In Synchronous ODT Mode, the Additive Latency (AL) and the Parity Latency (PL) programmed into the Mode Register (MR1) applies to ODT Latencies as shown in Table 108 and Table 109. For details, refer to DDR4 SDRAM latency definitions.

**Table 108 — ODT Latency**

| Symbol    | Parameter   | DDR4-1600/1866/2133/2400/2666/3200 | Unit |
|-----------|---|------------------------------------|------|
| DODTLon   | Direct ODT turn on Latency                          | CWL + AL + PL - 2.0                | tCK  |
| DODTLooff | Direct ODT turn off Latency                         | CWL + AL + PL - 2.0                |      |
| RODTLooff | Read command to internal ODT turn off Latency       | See detail in Table 109            |      |
| RODTLon4  | Read command to RTT_PARK turn on Latency in BC4     | See detail in Table 109            |      |
| RODTLon8  | Read command to RTT_PARK turn on Latency in BC8/BL8 | See detail in Table 109            |      |

**Table 109 — Read command to ODT off/on Latency variation by Preamble**

| Symbol    | 1tck Preamble | 2tck Preamble | Unit |
|-----------|---------------|---------------|------|
|           |               |               |      |
| RODTLooff | CL+AL+PL-2.0  | CL+AL+PL-3.0  | tCK  |
| RODTLon4  | RODTLooff +4  | RODTLooff +5  |      |
| RODTLon8  | RODTLooff +6  | RODTLooff +7  |      |
| ODTH4     | 4             | 5             |      |
| ODTH8     | 6             | 7             |      |

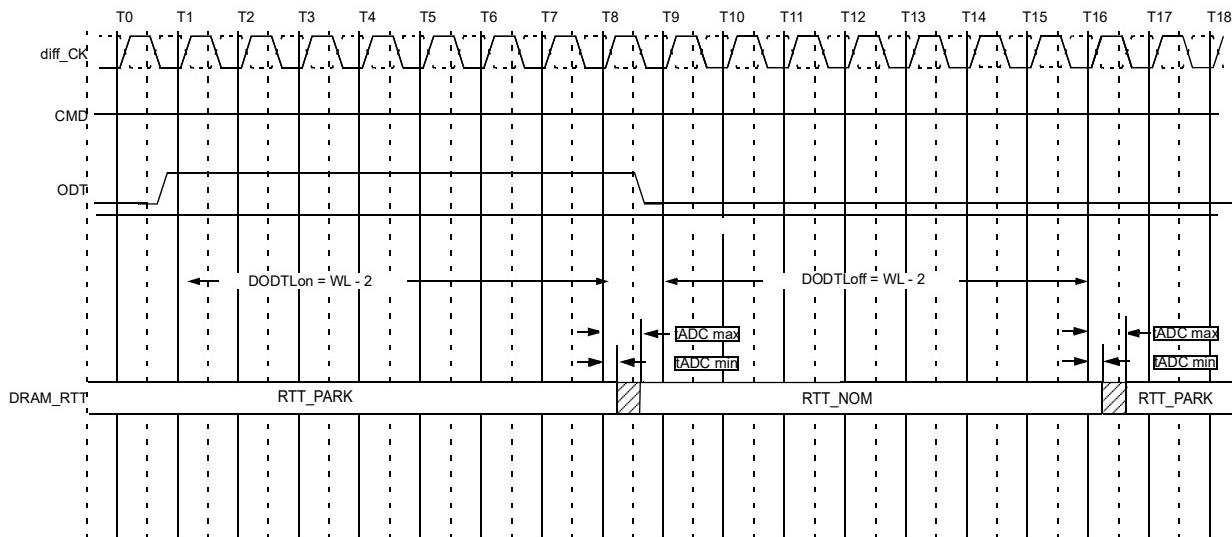
### 5.2.2 Timing Parameters

In synchronous ODT mode, the following timing parameters apply:

DODTLon, DODTLooff, RODTLooff, RODTLon4, RODTLon8, tADC,min,max.

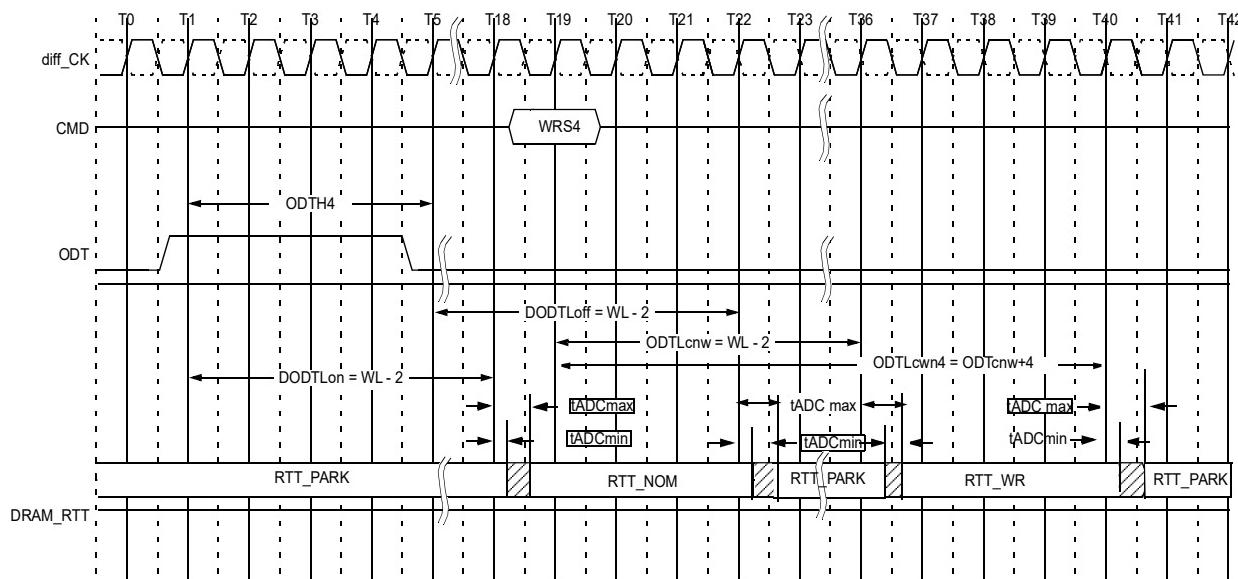
tADC,min and tADC,max are minimum and maximum RTT change timing skew between different termination values. Those timing parameters apply to both the Synchronous ODT mode and the Data Termination Disable mode.

When ODT is asserted, it must remain HIGH until minimum ODTH4 (BL=4) or ODTH8 (BL=8) is satisfied. Additionally, depending on CRC or 2tCK preamble setting in MRS, ODTH should be adjusted.



**Figure 190 — Synchronous ODT Timing Example for CWL=9, AL=0, PL=0; DODTLon=WL-2=7; DODTLooff=WL-2=7**

### 5.2.2 Timing Parameters (cont'd)

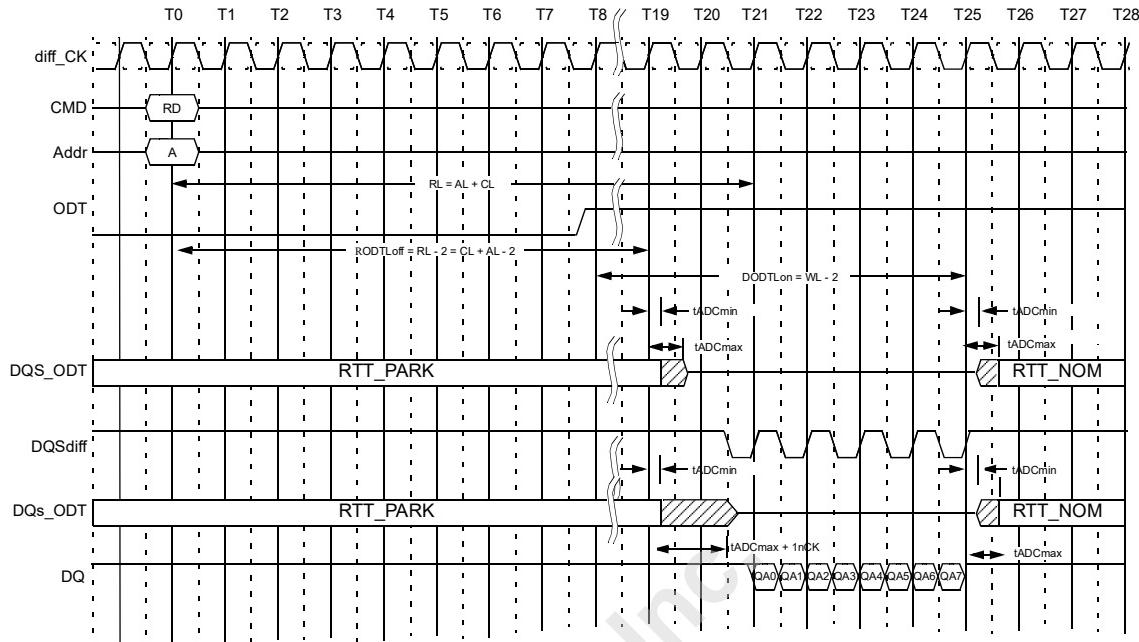


**Figure 191 — Synchronous ODT example with BL=4, CWL=9, AL=10, PL=0; DODTLon/off=WL-2=17, ODTcnw=WL-2=17**

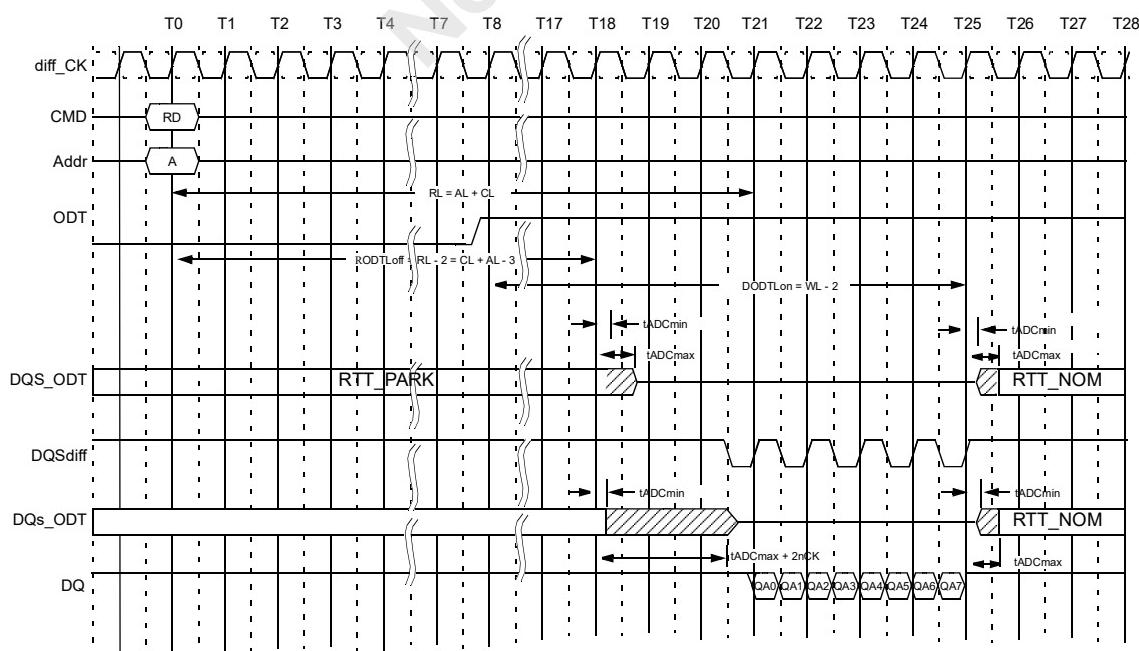
ODT must be held HIGH for at least ODTH4 after assertion (T1). ODTH is measured from ODT first registered HIGH to ODT first registered LOW, or from registration of Write command. Note that ODTH4 should be adjusted depending on CRC or 2tCK preamble setting

### 5.2.3 ODT during Reads

As the DDR4 SDRAM can not terminate and drive at the same time. RTT may nominally not be enabled until the end of the postamble as shown in the example below. As shown in Figure 192 below at cycle T25, DRAM turns on the termination when it stops driving which is determined by tHZ. If DRAM stops driving early (i.e., tHZ is early) then tADC,min timing may apply. If DRAM stops driving late (i.e., tHZ is late) then DRAM complies with tADC,max timing.



**Figure 192 — Example: CL=11, PL=0; AL=CL-1=10; RL=AL+PL+CL=21; CWL=9; DODTLon=AL+CWL-2=17; DODTLoft=AL+CWL-2=17; 1tCK preamble)**



**Figure 193 — Example: CL=11, PL=0; AL=CL-1=10; RL=AL+PL+CL=21; CWL=9; DODTLon=AL+CWL-2=17; DODTLoft=AL+CWL-2=17; 2tCK preamble)**

### 5.3 Dynamic ODT

In certain application cases and to further enhance signal integrity on the data bus, it is desirable that the termination strength of the DDR4 SDRAM can be changed without issuing an MRS command. This requirement is supported by the “Dynamic ODT” feature as described as follows:

#### 5.3.1 Functional Description

The Dynamic ODT Mode is enabled if bit A[9] or A[10] of MR2 is set to '1'. The function is described as follows:

- Three RTT values are available: RTT\_NOM, RTT\_PARK and RTT\_WR.
  - The value for RTT\_NOM is preselected via bits A[10:8] in MR1
  - The value for RTT\_PARK is preselected via bits A[8:6] in MR5
  - The value for RTT\_WR is preselected via bits A[10:9] in MR2
- During operation without commands, the termination is controlled as follows;
  - Nominal termination strength RTT\_NOM or RTT\_PARK is selected.
  - RTT\_NOM on/off timing is controlled via ODT pin and latencies DODTLon and DODTLooff and RTT\_PARK is on when ODT is LOW.
- When a write command (WR, WRA, WRS4, WRS8, WRAS4, WRAS8) is registered, and if Dynamic ODT is enabled, the termination is controlled as follows:
  - A latency ODTLcnw after the write command, termination strength RTT\_WR is selected.
  - A latency ODTLcwn8 (for BL8, fixed by MRS or selected OTF) or ODTLcwn4 (for BC4, fixed by MRS or selected OTF) after the write command, termination strength RTT\_WR is de-selected.
  - 1 or 2 clocks will be added or subtracted into/from ODTLcwn8 and ODTLcwn4 depending on CRC and/or 2tCK preamble setting.

Table 110 shows latencies and timing parameters which are relevant for the on-die termination control in Dynamic ODT mode.

The Dynamic ODT feature is not supported at DLL-off mode. User must use MRS command to set Rtt\_WR, MR2{A10,A9}={0,0} externally.

### 5.3.1 Functional Description

**Table 110 — Latencies and timing parameters relevant for Dynamic ODT with 1tCK preamble mode and CRC disabled**

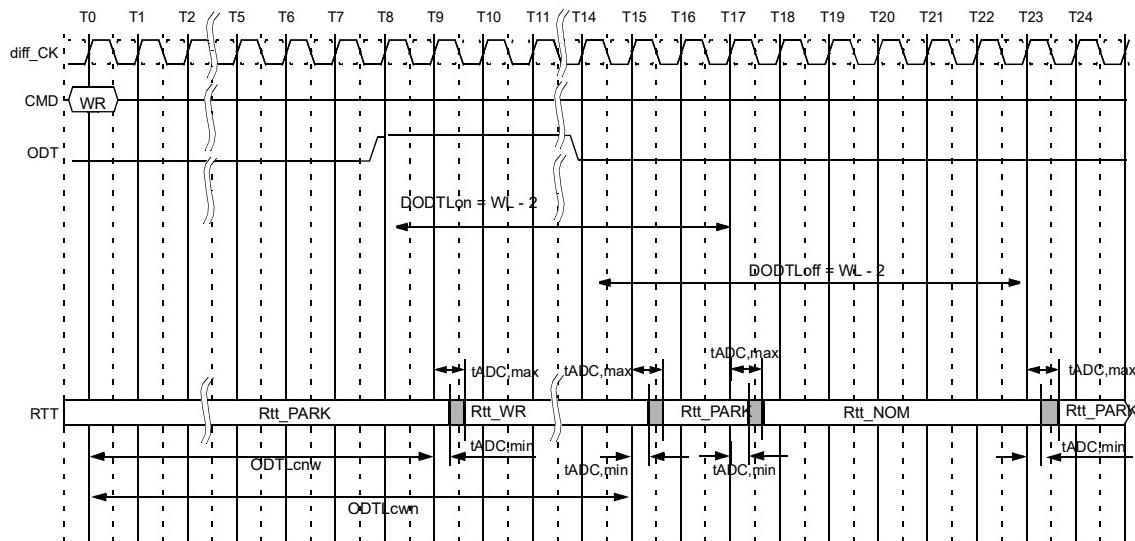
| Name and Description  | Abbr.    | Defined from                       | Define to   | 1600/1866/2133/<br>2400            | 2666                                 | 2933/3200                            | Unit     |
|---|----------|------------------------------------|---|------------------------------------|--------------------------------------|--------------------------------------|----------|
| ODT Latency for changing from RTT_PARK/RTT_NOM to RTT_WR        | ODTLcnw  | Registering external write command | Change RTT strength from RTT_PARK/RTT_Nom to RTT_WR |                                    | ODTLcnw = WL - 2                     |                                      | tCK      |
| ODT Latency for change from RTT_WR to RTT_PARK/RTT_Nom (BL = 4) | ODTLcwn4 | Registering external write command | Change RTT strength from RTT_WR to RTT_PARK/RTT_Nom |                                    | ODTLcwn4 = 4 + ODTLcnw               |                                      | tCK      |
| ODT Latency for change from RTT_WR to RTT_PARK/RTT_Nom (BL = 8) | ODTLcwn8 | registering external write command | Change RTT strength from RTT_WR to RTT_PARK/RTT_Nom |                                    | ODTLcwn8 = 6 + ODTLcnw               |                                      | tCK(avg) |
| RTT change skew   | tADC     | ODTLcnw<br>ODTLcwn                 | RTT valid   | tADC(min) = 0.3<br>tADC(max) = 0.7 | tADC(min) = 0.28<br>tADC(max) = 0.72 | tADC(min) = 0.26<br>tADC(max) = 0.74 | tCK(avg) |

**Table 111 — Latencies and timing parameters relevant for Dynamic ODT with 1 and 2tCK preamble mode and CRC en/disabled**

| Symbol   | 1tck Preamble |            | 2tck Preamble |            | Unit |
|----------|---------------|------------|---------------|------------|------|
|          | CRC off       | CRC on     | CRC off       | CRC on     |      |
| ODTLcnw  | WL - 2        | WL - 2     | WL - 3        | WL - 3     | tCK  |
| ODTLcwn4 | ODTLcnw +4    | ODTLcnw +7 | ODTLcnw +5    | ODTLcnw +8 |      |
| ODTLcwn8 | ODTLcnw +6    | ODTLcnw +7 | ODTLcnw +7    | ODTLcnw +8 |      |

### 5.3.2 ODT Timing Diagrams

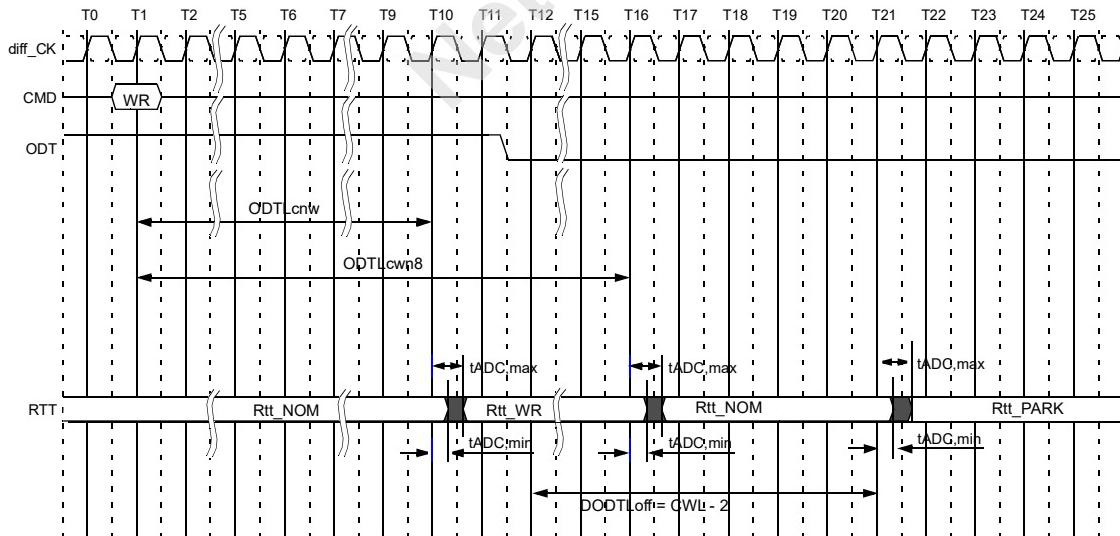
The following figures provide example timing diagrams



$ODTLcnw = WL-2$  (1tCK preamble),  $WL-3$  (2tCK preamble)

$ODTLcwn = WL+2$  (BC4),  $WL+4$ (BL8) w/o CRC or  $WL+5,5$  (BC4, BL8 respectively) when CRC is enabled.

**Figure 194 — ODT timing (Dynamic ODT, 1tCK preamble, CL=14, CWL=11, BL=8, AL=0, CRC Disabled)**



Behavior with WR command is issued while ODT being registered high.

**Figure 195 — Dynamic ODT overlapped with Rtt\_NOM (CL=14, CWL=11, BL=8, AL=0, CRC Disabled)**

## 5.4 Asynchronous ODT mode

Asynchronous ODT mode is selected when DLL is disabled by MR1 bit A0='0'b.

In asynchronous ODT timing mode, internal ODT command is not delayed by either the Additive latency (AL) or relative to the external ODT signal (RTT\_NOM).

In asynchronous ODT mode, the following timing parameters apply tAONAS,min, max, tAOFAS,min,max.

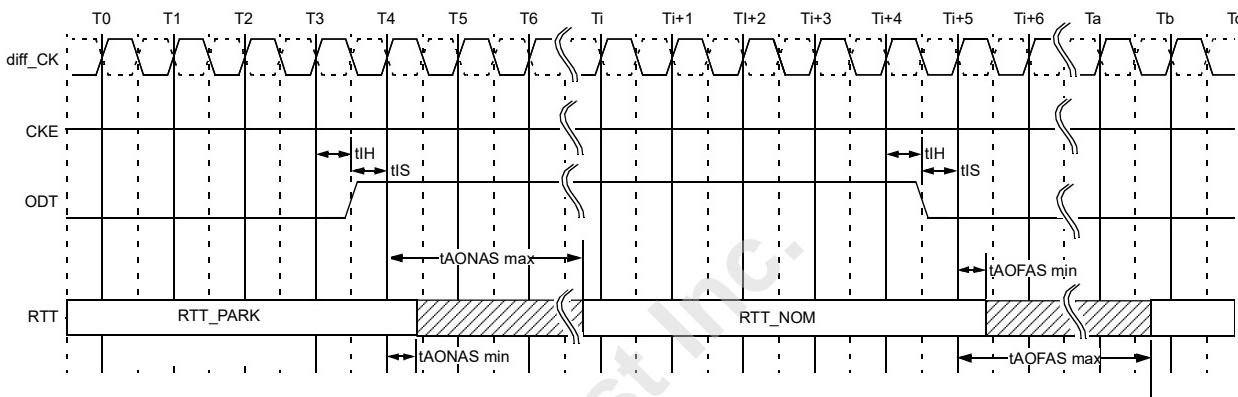
Minimum RTT\_NOM turn-on time (tAONASmin) is the point in time when the device termination circuit leaves RTT\_PARK and ODT resistance begins to change. Maximum RTT\_NOM turn on time(tAONASmax) is the point in time when the ODT resistance is reached RTT\_NOM.

tAONASmin and tAONASmax are measured from ODT being sampled high.

Minimum RTT\_NOM turn-off time (tAOFASmin) is the point in time when the devices termination circuit starts to leave RTT\_NOM.

Maximum RTT\_NOM turn-off time (tAOFASmax) is the point in time when the on-die termination has reached RTT\_PARK.

tAOFASmin and tAOFASmax are measured from ODT being sampled low.



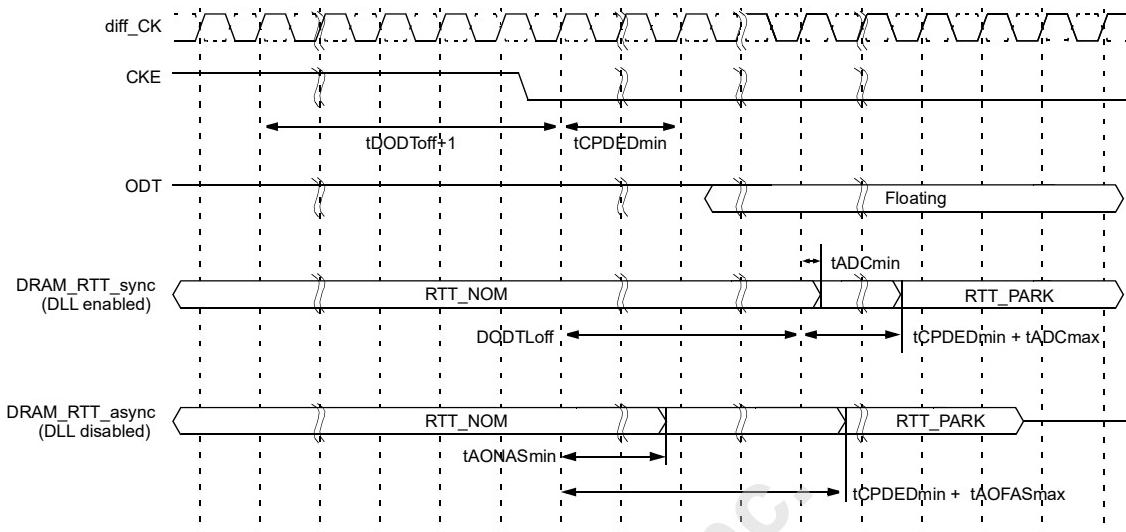
**Figure 196 — Asynchronous ODT Timing on DDR4 SDRAM with DLL-off**

**Table 112 — Asynchronous ODT Timing Parameters for all Speed Bins**

| Description                     | Symbol      | min | max | Unit |
|---------------------------------|-------------|-----|-----|------|
| Asynchronous RTT turn-on delay  | $t_{AONAS}$ | 1.0 | 9.0 | ns   |
| Asynchronous RTT turn-off delay | $t_{AOFAS}$ | 1.0 | 9.0 | ns   |

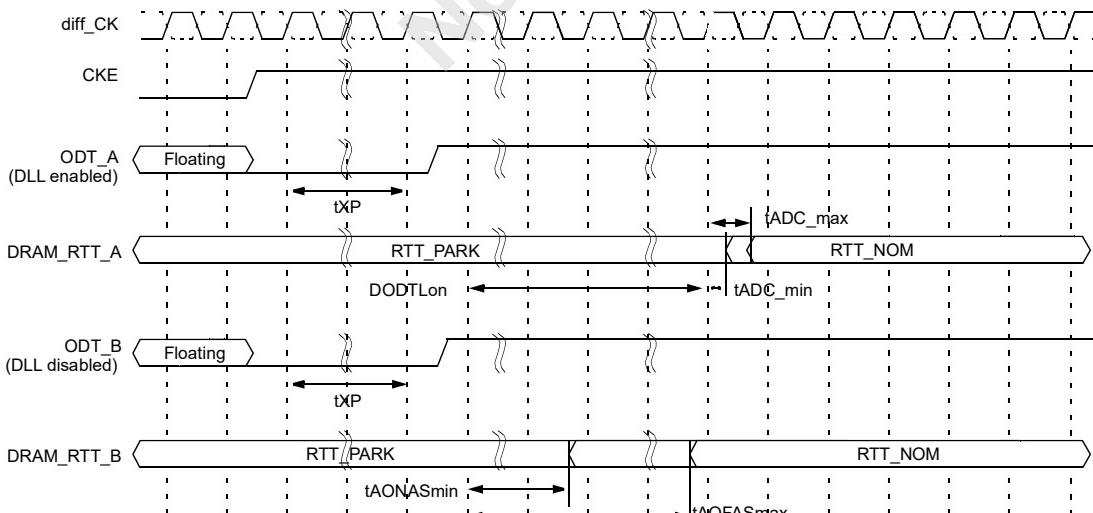
## 5.5 ODT buffer disabled mode for Power down

DRAM does not provide RTT\_NOM termination during power down when ODT input buffer deactivation mode is enabled in MR5 bit A5. To account for DRAM internal delay on CKE line to disable the ODT buffer and block the sampled output, the host controller must continuously drive ODT to either low or high when entering power down (from tDODToff+1 prior to CKE low till tCPDED after CKE low). The ODT signal is allowed to float after tCPDEDmin has expired. In this mode, RTT\_NOM termination corresponding to sampled ODT at the input when CKE is registered low (and tANPD before that) may be either RTT\_NOM or RTT\_PARK . tANPD is equal to (WL-1) and is counted backwards from PDE.



**Figure 197 — ODT timing for power down entry with ODT buffer disable mode**

When exit from power down, along with CKE being registered high, ODT input signal must be re-driven and maintained low until tXP is met.

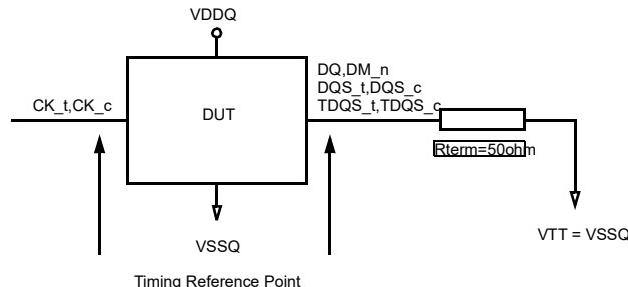


**Figure 198 — ODT timing for power down exit with ODT buffer disable mode**

## 5.6 ODT Timing Definitions

### 5.6.1 Test Load for ODT Timings

Different than for timing measurements, the reference load for ODT timings is defined in Figure 199.



**Figure 199 — ODT Timing Reference Load**

### 5.6.2 ODT Timing Definitions

Definitions for tADC, tAONAS and tAOFAS are provided in Table 113 and subsequent figures. Measurement reference settings are provided in Table 114. tADC of Dynamic ODT case and Read Disable ODT case are represented by tADC of Direct ODT Control case.

**Table 113 — ODT Timing Definitions**

| Symbol | Begin Point Definition  | End Point Definition           | Figure     | Note |  |
|--------|---|--------------------------------|------------|------|--|
| tADC   | Rising edge of CK_t,CK_c defined by the end point of DODTLoff               | Extrapolated point at VRTT_NOM | Figure 200 |      |  |
|        | Rising edge of CK_t,CK_c defined by the end point of DODTLon                | Extrapolated point at VSSQ     |            |      |  |
|        | Rising edge of CK_t - CK_c defined by the end point of ODTLcnw              | Extrapolated point at VRTT_NOM | Figure 201 |      |  |
|        | Rising edge of CK_t - CK_c defined by the end point of ODTLcwn4 or ODTLcwn8 | Extrapolated point at VSSQ     |            |      |  |
| tAONAS | Rising edge of CK_t,CK_c with ODT being first registered high               | Extrapolated point at VSSQ     | Figure 202 |      |  |
| tAOFAS | Rising edge of CK_t,CK_c with ODT being first registered low                | Extrapolated point at VRTT_NOM |            |      |  |

**Table 114 — Reference Settings for ODT Timing Measurements**

| Measured Parameter | RTT_PARK | RTT_NOM | RTT_WR | Vsw1  | Vsw2  | Figure     | Note |
|--------------------|----------|---------|--------|-------|-------|------------|------|
| tADC               | Disable  | RZQ/7   | -      | 0.20V | 0.40V | Figure 200 | 1,2  |
|                    | -        | RZQ/7   | Hi-Z   | 0.20V | 0.40V | Figure 201 | 1,3  |
| tAONAS             | Disable  | RZQ/7   | -      | 0.20V | 0.40V | Figure 202 | 1,2  |
| tAOFAS             | Disable  | RZQ/7   | -      | 0.20V | 0.40V |            |      |

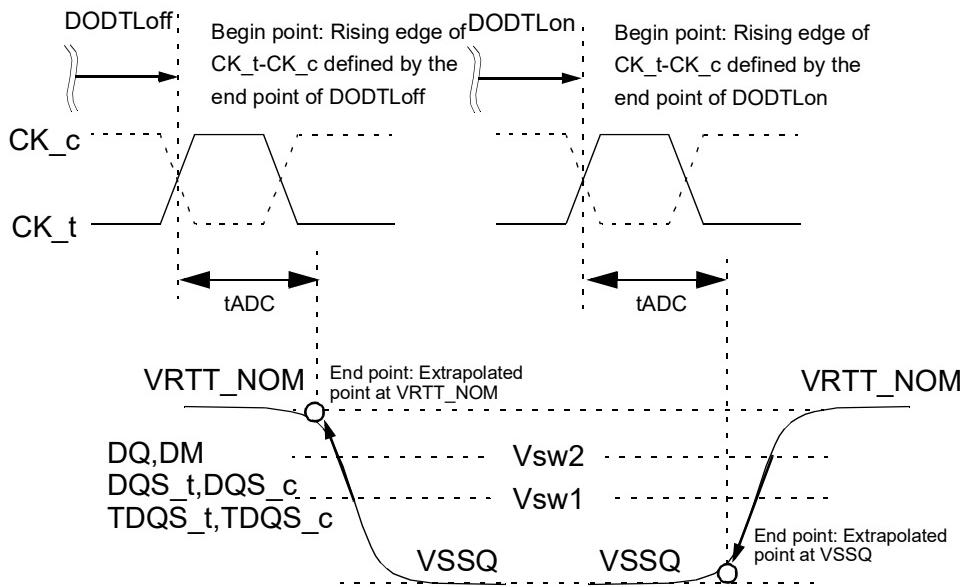
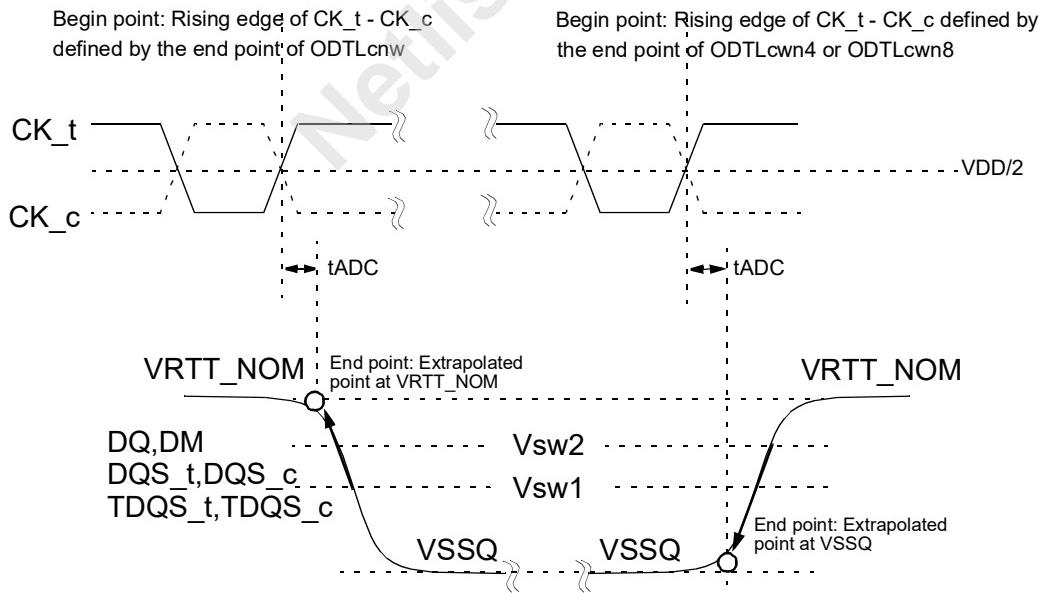
NOTE 1 MR setting is as follows.

- MR1 A10=1, A9=1, A8=1 (RTT\_NOM\_Setting)
- MR5 A8=0 , A7=0, A6=0 (RTT\_PARK Setting)
- MR2 A11=0, A10=1, A9=1 (RTT\_WR Setting)

NOTE 2 ODT state change is controlled by ODT pin.

NOTE 3 ODT state change is controlled by Write Command.

## 5.6.2 ODT Timing Definitions (cont'd)

Figure 200 — Definition of  $t_{ADC}$  at Direct ODT ControlFigure 201 — Definition of  $t_{ADC}$  at Dynamic ODT Control

## 5.6.2 ODT Timing Definitions (cont'd)

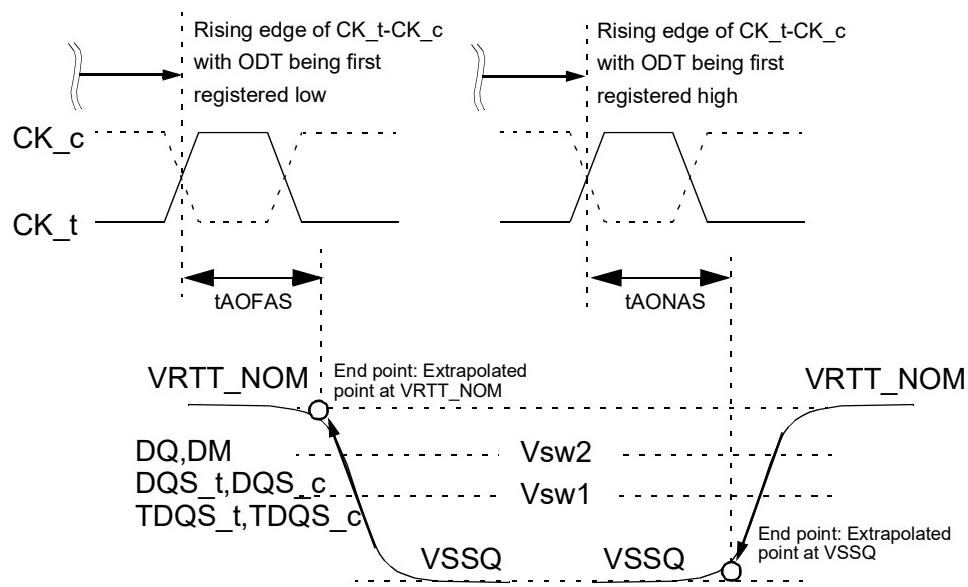


Figure 202 — Definition of tAOFAS and tAONAS

## 6 Absolute Maximum Ratings

**Table 115 — Absolute Maximum DC Ratings**

| Symbol                             | Parameter  | Rating      | Units | NOTE  |
|------------------------------------|--|-------------|-------|-------|
| VDD                                | Voltage on VDD pin relative to Vss               | -0.3 ~ 1.5  | V     | 1,3   |
| VDDQ                               | Voltage on VDDQ pin relative to Vss              | -0.3 ~ 1.5  | V     | 1,3   |
| VPP                                | Voltage on VPP pin relative to Vss               | -0.3 ~ 3.0  | V     | 4     |
| V <sub>IN</sub> , V <sub>OUT</sub> | Voltage on any pin except VREFCA relative to Vss | -0.3 ~ 1.5  | V     | 1,3,5 |
| T <sub>STG</sub>                   | Storage Temperature                              | -55 to +100 | °C    | 1,2   |

NOTE 1 Stresses greater than those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. This is a stress rating only and functional operation of the device at these or any other conditions above those indicated in the operational sections of this specification is not implied. Exposure to absolute maximum rating conditions for extended periods may affect reliability

NOTE 2 Storage Temperature is the case surface temperature on the center/top side of the DRAM. For the measurement conditions, please refer to JESD51-2 standard.

NOTE 3 VDD and VDDQ must be within 300 mV of each other at all times; and VREFCA must be not greater than 0.6 x VDDQ, When VDD and VDDQ are less than 500 mV; VREFCA may be equal to or less than 300 mV

NOTE 4 VPP must be equal or greater than VDD/VDDQ at all times.

NOTE 5 Overshoot area above 1.5 V is specified in Section 8.3.4, Section 8.3.5, and Section 8.3.6.

## 7 AC & DC Operating Conditions

**Table 116 — Recommended DC Operating Conditions**

| Symbol | Parameter                 | Rating |      |      | Unit | NOTE  |
|--------|---------------------------|--------|------|------|------|-------|
|        |                           | Min.   | Typ. | Max. |      |       |
| VDD    | Supply Voltage            | 1.14   | 1.2  | 1.26 | V    | 1,2,3 |
| VDDQ   | Supply Voltage for Output | 1.14   | 1.2  | 1.26 | V    | 1,2,3 |
| VPP    |                           | 2.375  | 2.5  | 2.75 | V    | 3     |

NOTE 1 Under all conditions VDDQ must be less than or equal to VDD.

NOTE 2 VDDQ tracks with VDD. AC parameters are measured with VDD and VDDQ tied together.

NOTE 3 DC bandwidth is limited to 20MHz.

**Table 117 — Recommended Operating Temperature Ranges**

| Parameter/Condition    | Device Rating | Symbol               | Min   | Max-Normal | Max-Extended |
|------------------------|---------------|----------------------|-------|------------|--------------|
| Commercial Temperature | CT            | T <sub>OPER-CT</sub> | 0°C   | 85°C       | 95°C         |
| Industrial Temperature | IT            | T <sub>OPER-IT</sub> | -40°C | 85°C       | 95°C         |

NOTE 1 The operating temperature is the case surface temperature on the center-top side of the DDR4 device. For measurements conditions, refer to JESD51-2.

NOTE 2 Max-Normal is the maximum limit when device is operating in the Normal Temperature Mode.

NOTE 3 Max-Extended is the maximum limit when device is operating in the Extended Temperature Mode.

NOTE 4 Support for the Industrial Temperature device rating by suppliers is optional. Refer to suppliers device specifications for information regarding Industrial Temperature support.

## 8 AC & DC Input Measurement Levels

### 8.1 AC & DC Logic input levels for single-ended signals

**Table 118 — Single-ended AC & DC input levels for Command and Address**

| Symbol        | Parameter                             | DDR4-1600/1866/2133/2400 |              | DDR4-2666/2933/3200 |              | Unit | NOTE |
|---------------|---------------------------------------|--------------------------|--------------|---------------------|--------------|------|------|
|               |                                       | Min.                     | Max.         | Min.                | Max.         |      |      |
| VIH.CA(DC75)  | DC input logic high                   | VREFCA+ 0.075            | VDD          | -                   | -            | V    |      |
| VIL.CA(DC75)  | DC input logic low                    | Vss                      | VREFCA-0.075 | -                   | -            | V    |      |
| VIH.CA(DC65)  | DC input logic high                   | -                        | -            | VREFCA+ 0.065       | VDD          | V    |      |
| VIL.CA(DC65)  | DC input logic low                    | -                        | -            | Vss                 | VREFCA-0.065 | V    |      |
| VIH.CA(AC100) | AC input logic high                   | VREF + 0.1               | Note 2       | -                   | -            | V    | 1    |
| VIL.CA(AC100) | AC input logic low                    | Note 2                   | VREF - 0.1   | -                   | -            | V    | 1    |
| VIH.CA(AC90)  | AC input logic high                   | -                        | -            | VREF + 0.09         | Note 2       | V    | 1    |
| VIL.CA(AC90)  | AC input logic low                    | -                        | -            | Note 2              | VREF - 0.09  | V    | 1    |
| VREFCA(DC)    | Reference Voltage for ADD, CMD inputs | 0.49*VDD                 | 0.51*VDD     | 0.49*VDD            | 0.51*VDD     | V    | 2,3  |

NOTE 1 See "Overshoot and Undershoot Specifications" on section 8.3.

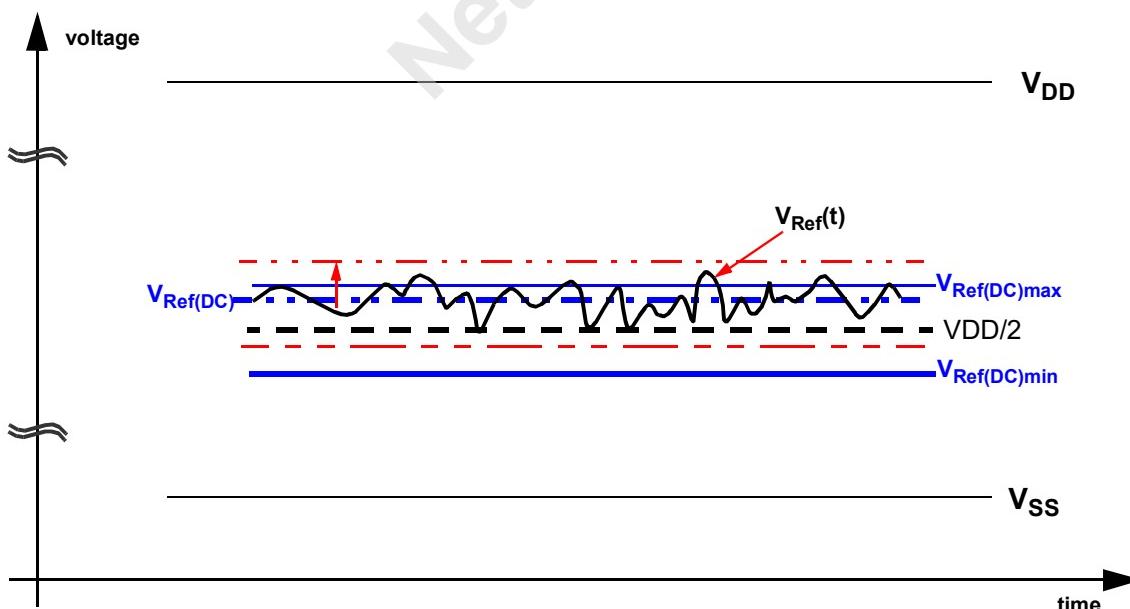
NOTE 2 The AC peak noise on VREFCA may not allow VREFCA to deviate from VREFCA(DC) by more than  $\pm 1\%$  VDD (for reference : approx.  $\pm 12\text{mV}$ )

NOTE 3 For reference : approx.  $\text{VDD}/2 \pm 12\text{mV}$

### 8.2 AC and DC Input Measurement Levels: $V_{\text{REF}}$ Tolerances

The DC-tolerance limits and ac-noise limits for the reference voltages  $V_{\text{REFCA}}$  is illustrated in Figure 203. It shows a valid reference voltage  $V_{\text{REF}}(t)$  as a function of time. ( $V_{\text{REF}}$  stands for  $V_{\text{REFCA}}$ ).

$V_{\text{REF}}(\text{DC})$  is the linear average of  $V_{\text{REF}}(t)$  over a very long period of time (e.g., 1 sec). This average has to meet the min/max requirement in Table 118. Furthermore  $V_{\text{REF}}(t)$  may temporarily deviate from  $V_{\text{REF}}(\text{DC})$  by no more than  $\pm 1\% \text{ VDD}$ .



**Figure 203 — Illustration of  $V_{\text{REF}}(\text{DC})$  tolerance and  $V_{\text{REF}}$  AC-noise limits**

The voltage levels for setup and hold time measurements  $V_{\text{IH}}(\text{AC})$ ,  $V_{\text{IH}}(\text{DC})$ ,  $V_{\text{IL}}(\text{AC})$  and  $V_{\text{IL}}(\text{DC})$  are dependent on  $V_{\text{REF}}$ .

" $V_{\text{REF}}$ " shall be understood as  $V_{\text{REF}}(\text{DC})$ , as defined in Figure 203.

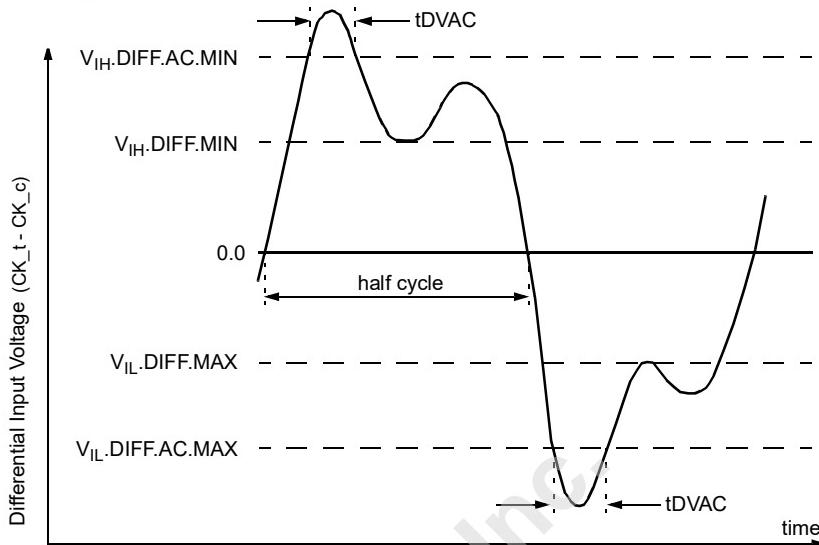
This clarifies, that DC-variations of  $V_{\text{REF}}$  affect the absolute voltage a signal has to reach to achieve a valid high or low level and therefore the time to which setup and hold is measured. System timing and voltage budgets need to account for  $V_{\text{REF}}(\text{DC})$  deviations from the optimum position within the data-eye of the input signals.

## 8.2 AC and DC Input Measurement Levels: $V_{REF}$ Tolerances (cont'd)

This also clarifies that the DRAM setup/hold specification and derating values need to include time and voltage associated with  $V_{REF}$  AC-noise. Timing and voltage effects due to AC-noise on  $V_{REF}$  up to the specified limit ( $\pm 1\%$  of  $V_{DD}$ ) are included in DRAM timings and their associated deratings.

## 8.3 AC and DC Logic Input Levels for Differential Signals

### 8.3.1 Differential signal definition



NOTE 1 Differential signal rising edge from  $V_{IL}$ .DIFF.MAX to  $V_{IH}$ .DIFF.MIN must be monotonic slope.

NOTE 2 Differential signal falling edge from  $V_{IH}$ .DIFF.MIN to  $V_{IL}$ .DIFF.MAX must be monotonic slope.

**Figure 204 — Definition of differential ac-swing and “time above ac-level”  $t_{DVAC}$**

### 8.3.2 Differential swing requirements for clock ( $CK_t - CK_c$ )

**Table 119 — Differential AC and DC Input Levels**

| Symbol           | Parameter                  | DDR4 -1600,1866,2133              |                                   | DDR4 -2400                        |                                   | unit | NOTE |
|------------------|----------------------------|-----------------------------------|-----------------------------------|-----------------------------------|-----------------------------------|------|------|
|                  |                            | min                               | max                               | min                               | max                               |      |      |
| $V_{IHdiff}$     | differential input high    | 150                               | NOTE 3                            | 135                               | NOTE 3                            | mV   | 1    |
| $V_{ILdiff}$     | differential input low     | NOTE 3                            | -150                              | NOTE 3                            | -135                              | mV   | 1    |
| $V_{IHdiff(AC)}$ | differential input high ac | $2 \times (V_{IH}(AC) - V_{REF})$ | NOTE 3                            | $2 \times (V_{IH}(AC) - V_{REF})$ | NOTE 3                            | V    | 2    |
| $V_{ILdiff(AC)}$ | differential input low ac  | NOTE 3                            | $2 \times (V_{IL}(AC) - V_{REF})$ | NOTE 3                            | $2 \times (V_{IL}(AC) - V_{REF})$ | V    | 2    |

| Symbol           | Parameter                  | DDR4 -2666                        |                                   | DDR4 -2933                        |                                   | DDR4 -3200                        |                                   | unit | NOTE |
|------------------|----------------------------|-----------------------------------|-----------------------------------|-----------------------------------|-----------------------------------|-----------------------------------|-----------------------------------|------|------|
|                  |                            | min                               | max                               | min                               | max                               | min                               | max                               |      |      |
| $V_{IHdiff}$     | differential input high    | 135                               | NOTE 3                            | 125                               | NOTE 3                            | 110                               | NOTE 3                            | mV   | 1    |
| $V_{ILdiff}$     | differential input low     | NOTE 3                            | -135                              | NOTE 3                            | -125                              | NOTE 3                            | -110                              | mV   | 1    |
| $V_{IHdiff(AC)}$ | differential input high ac | $2 \times (V_{IH}(AC) - V_{REF})$ | NOTE 3                            | $2 \times (V_{IH}(AC) - V_{REF})$ | NOTE 3                            | $2 \times (V_{IH}(AC) - V_{REF})$ | NOTE 3                            | V    | 2    |
| $V_{ILdiff(AC)}$ | differential input low ac  | NOTE 3                            | $2 \times (V_{IL}(AC) - V_{REF})$ | NOTE 3                            | $2 \times (V_{IL}(AC) - V_{REF})$ | NOTE 3                            | $2 \times (V_{IL}(AC) - V_{REF})$ | V    | 2    |

NOTE 1 Used to define a differential signal slew-rate.

NOTE 2 for  $CK_t - CK_c$  use  $V_{IH,CA}/V_{IL,CA}(AC)$  of ADD/CMD and  $V_{REFCA}$ .

NOTE 3 These values are not defined; however, the differential signals  $CK_t - CK_c$ , need to be within the respective limits ( $V_{IH,CA}(DC)$  max,  $V_{IL,CA}(DC)$  min) for single-ended signals as well as the limitations for overshoot and undershoot.

### 8.3.2 Differential swing requirements for clock (CK\_t - CK\_c) (cont'd)

**Table 120 — Allowed time before ringback (tDVAC) for CK\_t - CK\_c**

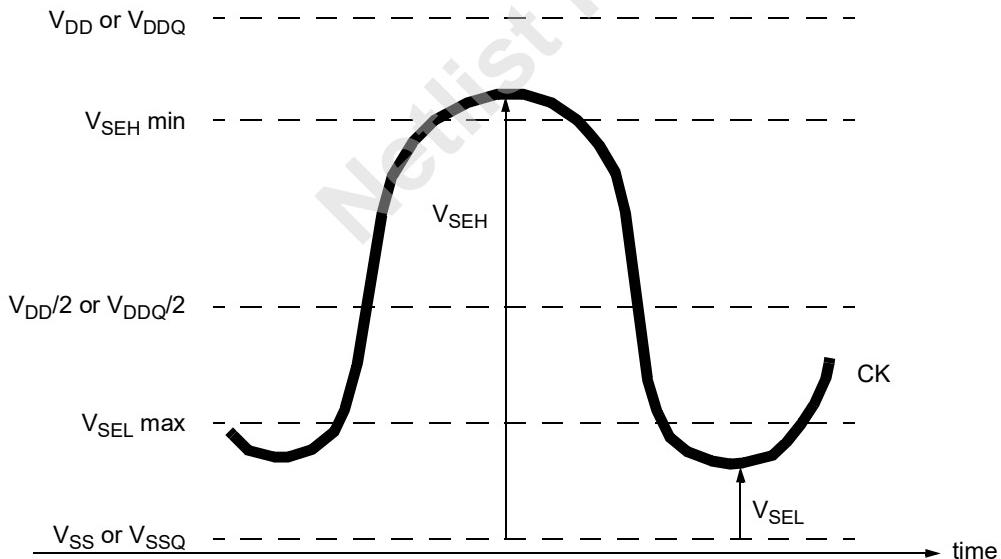
| Slew Rate [V/ns] | tDVAC [ps] @ $ V_{IH/L} - V_{L/H}  = 200\text{mV}$ |     | tDVAC [ps] @ $ V_{IH/L} - V_{L/H}  = \text{TBDmV}$ |     |
|------------------|--|-----|--|-----|
|                  | min  | max | min  | max |
| > 4.0            | 120  | -   | TBD  | -   |
| 4.0              | 115  | -   | TBD  | -   |
| 3.0              | 110  | -   | TBD  | -   |
| 2.0              | 105  | -   | TBD  | -   |
| 1.8              | 100  | -   | TBD  | -   |
| 1.6              | 95   | -   | TBD  | -   |
| 1.4              | 90   | -   | TBD  | -   |
| 1.2              | 85   | -   | TBD  | -   |
| 1.0              | 80   | -   | TBD  | -   |
| < 1.0            | 80   | -   | TBD  | -   |

### 8.3.3 Single-ended requirements for differential signals

Each individual component of a differential signal (CK\_t, CK\_c) has also to comply with certain requirements for single-ended signals.

CK\_t and CK\_c have to approximately reach VSEHmin / VSELmax (approximately equal to the ac-levels (VIH.CA(AC) / VIL.CA(AC)) for ADD/CMD signals) in every half-cycle.

Note that the applicable ac-levels for ADD/CMD might be different per speed-bin etc. E.g., if Different value than VIH.CA(AC100)/ VIL.CA(AC100) is used for ADD/CMD signals, then these ac-levels apply also for the single-ended signals CK\_t and CK\_c



**Figure 205 — Single-ended requirement for differential signals.**

Note that, while ADD/CMD signal requirements are with respect to VrefCA, the single-ended components of differential signals have a requirement with respect to VDD / 2; this is nominally the same. The transition of single-ended signals through the ac-levels is used to measure setup time. For single-ended components of differential signals the requirement to reach VSELmax, VSEHmin has no bearing on timing, but adds a restriction on the common mode characteristics of these signals.

### 8.3.3 Single-ended requirements for differential signals (cont'd)

**Table 121 — Single-ended levels for CK\_t, CK\_c**

| Symbol           | Parameter                              | DDR4-1600/1866/2133 |               | DDR4-2400/2666 |               | DDR4-2933     |               | DDR4-3200     |               | Unit | NOTE |
|------------------|--|---------------------|---------------|----------------|---------------|---------------|---------------|---------------|---------------|------|------|
|                  |  | Min                 | Max           | Min            | Max           | Min           | Max           | Min           | Max           |      |      |
| V <sub>SEH</sub> | Single-ended high-level for CK_t, CK_c | (VDD/2)+0.100       | NOTE3         | (VDD/2)+0.095  | NOTE3         | (VDD/2)+0.085 | NOTE3         | (VDD/2)+0.085 | NOTE3         | V    | 1, 2 |
| V <sub>SEL</sub> | Single-ended low-level for CK_t, CK_c  | NOTE3               | (VDD/2)-0.100 | NOTE3          | (VDD/2)-0.095 | NOTE3         | (VDD/2)-0.085 | NOTE3         | (VDD/2)-0.085 | V    | 1, 2 |

NOTE 1 For CK\_t - CK\_c use V<sub>IH,CA</sub>/V<sub>IL,CA</sub>(AC) of ADD/CMD;

NOTE 2 V<sub>IH</sub>(AC)/V<sub>IL</sub>(AC) for ADD/CMD is based on V<sub>REFCA</sub>:

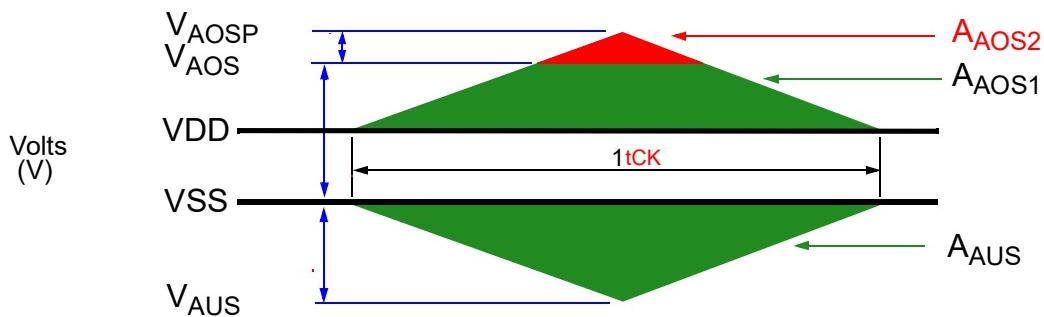
NOTE 3 These values are not defined, however the single-ended signals CK\_t - CK\_c need to be within the respective limits (V<sub>IH,CA</sub>(DC) max, V<sub>IL,CA</sub>(DC)min) for single-ended signals as well as the limitations for overshoot and undershoot.

### 8.3.4 Address, Command and Control Overshoot and Undershoot specifications

**Table 122 — AC overshoot/undershoot specification for Address, Command and Control pins**

| Parameter  | Symbol            | DDR4-1600  | DDR4-1866 | DDR4-2133 | DDR4-2400 | DDR4-2666 | DDR4-2933 | DDR4-3200 | unit | note |
|--|-------------------|------------|-----------|-----------|-----------|-----------|-----------|-----------|------|------|
| Maximum peak amplitude above V <sub>AOS</sub>                                      | V <sub>AOSP</sub> | 0.06       |           |           |           |           | V         |           |      |      |
| Upper boundary of overshoot area A <sub>AOS1</sub>                                 | V <sub>AOS</sub>  | VDD + 0.24 |           |           |           |           | V         |           | 1    |      |
| Maximum peak amplitude allowed for undershoot                                      | V <sub>AUS</sub>  | 0.30       |           |           |           |           | V         |           |      |      |
| Maximum overshoot area per 1 tCK above VAOS  | A <sub>AOS2</sub> | 0.0083     | 0.0071    | 0.0062    | 0.0055    | 0.0055    |           | V-ns      |      |      |
| Maximum overshoot area per 1 tCK between VDD and V <sub>AOS</sub>                  | A <sub>AOS1</sub> | 0.2550     | 0.2185    | 0.1914    | 0.1699    | 0.1699    |           | V-ns      |      |      |
| Maximum undershoot area per 1 tCK below VSS  | A <sub>AUS</sub>  | 0.2644     | 0.2265    | 0.1984    | 0.1762    | 0.1762    |           | V-ns      |      |      |
| (A0-A13,A17,BG0-BG1,BA0-BA1,ACT_n,RAS_n/A16,CAS_n/A15,WE_n/A14,CS_n,CKE,ODT,C2-C0) |                   |            |           |           |           |           |           |           |      |      |

NOTE 1 The value of VAOS matches VDD absolute max as defined in Table 115 Absolute Maximum DC Ratings if VDD equals VDD max as defined in Table 116 Recommended DC Operating Conditions. If VDD is above the recommended operating conditions, VAOS remains at VDD absolute max as defined in Table 115.



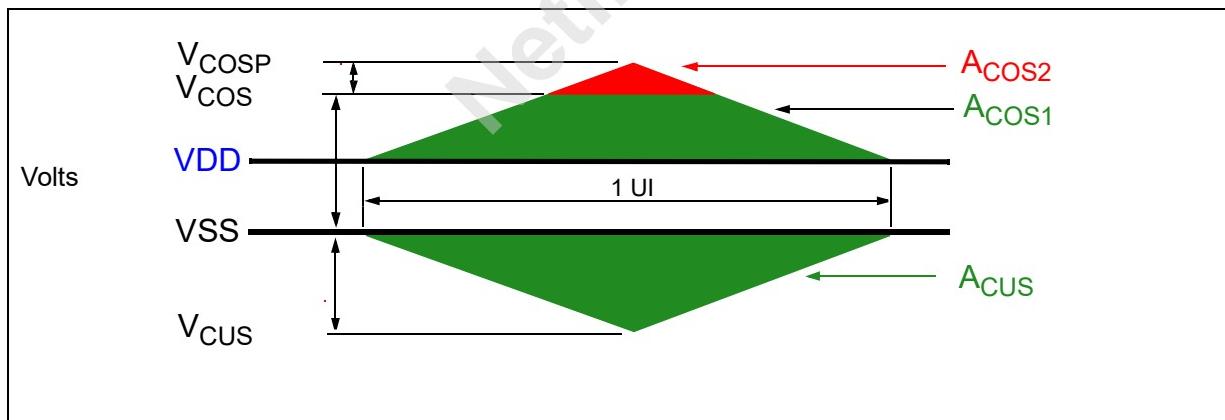
**Figure 206 — Address, Command and Control Overshoot and Undershoot Definition**

### 8.3.5 Clock Overshoot and Undershoot Specifications

**Table 123 — AC overshoot/undershoot specification for Clock**

| Parameter   | Symbol     | DDR4-1600    | DDR4-1866 | DDR4-2133 | DDR4-2400 | DDR4-2666 | DDR4-2933 | DDR4-3200 | unit | note |  |
|---|------------|--------------|-----------|-----------|-----------|-----------|-----------|-----------|------|------|--|
| Maximum peak amplitude above $V_{COS}$                    | $V_{COSP}$ | 0.06         |           |           |           |           | V         |           |      |      |  |
| Upper boundary of overshoot area $A_{DOS1}$               | $V_{COS}$  | $VDD + 0.24$ |           |           |           |           | V         |           | 1    |      |  |
| Maximum peak amplitude allowed for undershoot             | $V_{CUS}$  | 0.30         |           |           |           |           | V         |           |      |      |  |
| Maximum overshoot area per 1 UI above VCOS                | $A_{COS2}$ | 0.0038       | 0.0032    | 0.0028    | 0.0025    | 0.0025    |           | V-ns      |      |      |  |
| Maximum overshoot area per 1 UI between VDD and $V_{DOS}$ | $A_{COS1}$ | 0.1125       | 0.0964    | 0.0844    | 0.0750    | 0.0750    |           | V-ns      |      |      |  |
| Maximum undershoot area per 1 UI below VSS                | $A_{CUS}$  | 0.1144       | 0.0980    | 0.0858    | 0.0762    | 0.0762    |           | V-ns      |      |      |  |
| (CK_t, Ck_c)  |            |              |           |           |           |           |           |           |      |      |  |

NOTE 1 The value of VCOS matches VDD absolute max as defined in Table 115 Absolute Maximum DC Ratings if VDD equals VDD max as defined in Table 116 Recommended DC Operating Conditions. If VDD is above the recommended operating conditions, VCOS remains at VDD absolute max as defined in Table 115.



**Figure 207 — Clock Overshoot and Undershoot Definition**

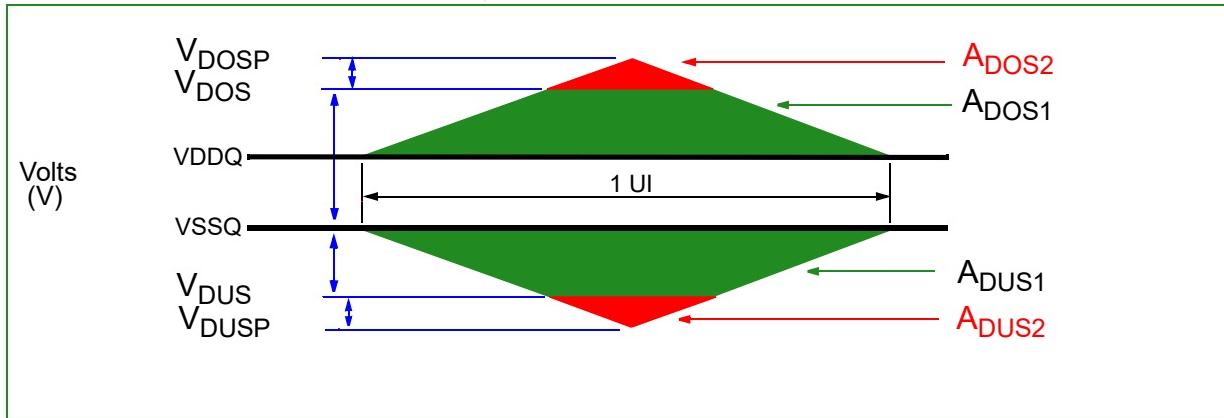
### 8.3.6 Data, Strobe and Mask Overshoot and Undershoot Specifications

**Table 124 — AC overshoot/undershoot specification for Data, Strobe and Mask**

| Parameter  | Symbol     | DDR4-1600 | DDR4-1866 | DDR4-2133 | DDR4-2400   | DDR4-2666 | DDR4-2933 | DDR4-3200 | unit | note |
|--|------------|-----------|-----------|-----------|-------------|-----------|-----------|-----------|------|------|
| Maximum peak amplitude above $V_{DOS}$                       | $V_{DOSP}$ |           |           |           | 0.16        |           |           |           | V    |      |
| Upper boundary of overshoot area $A_{DOS1}$                  | $V_{DOS}$  |           |           |           | VDDQ + 0.24 |           |           |           | V    | 1    |
| Lower boundary of undershoot area $A_{DUS1}$                 | $V_{DUS}$  |           |           |           | 0.30        |           |           |           | V    | 2    |
| Maximum peak amplitude below $V_{DUS}$                       | $V_{DUSP}$ |           |           |           | 0.10        |           |           |           | V    |      |
| Maximum overshoot area per 1 UI above VDOS                   | $A_{DOS2}$ | 0.0150    | 0.0129    | 0.0113    | 0.0100      |           | 0.0100    |           | V-ns |      |
| Maximum overshoot area per 1 UI between VDDQ and $V_{DOS}$   | $A_{DOS1}$ | 0.1050    | 0.0900    | 0.0788    | 0.0700      |           | 0.0700    |           | V-ns |      |
| Maximum undershoot area per 1 UI between VSSQ and $V_{DUS1}$ | $A_{DUS1}$ | 0.1050    | 0.0900    | 0.0788    | 0.0700      |           | 0.0700    |           | V-ns |      |
| Maximum undershoot area per 1 UI below $V_{DUS}$             | $A_{DUS2}$ | 0.0150    | 0.0129    | 0.0113    | 0.0100      |           | 0.0100    |           | V-ns |      |
| (DQ, DQS_t, DQS_c, DM_n, DBI_n, TDQS_t, TDQS_c)              |            |           |           |           |             |           |           |           |      |      |

NOTE 1 The value of VDOS matches (VIN, VOUT) max as defined in Table 115 Absolute Maximum DC Ratings if VDDQ equals VDDQ max as defined in Table 116 Recommended DC Operating Conditions. If VDDQ is above the recommended operating conditions, VDOS remains at (VIN, VOUT) max as defined in Table 115.

NOTE 2 The value of VDUS matches (VIN, VOUT) min as defined in Table 115 Absolute Maximum DC Ratings.



**Figure 208 — Data, Strobe and Mask Overshoot and Undershoot Definition**

## 8.4 Slew Rate Definitions

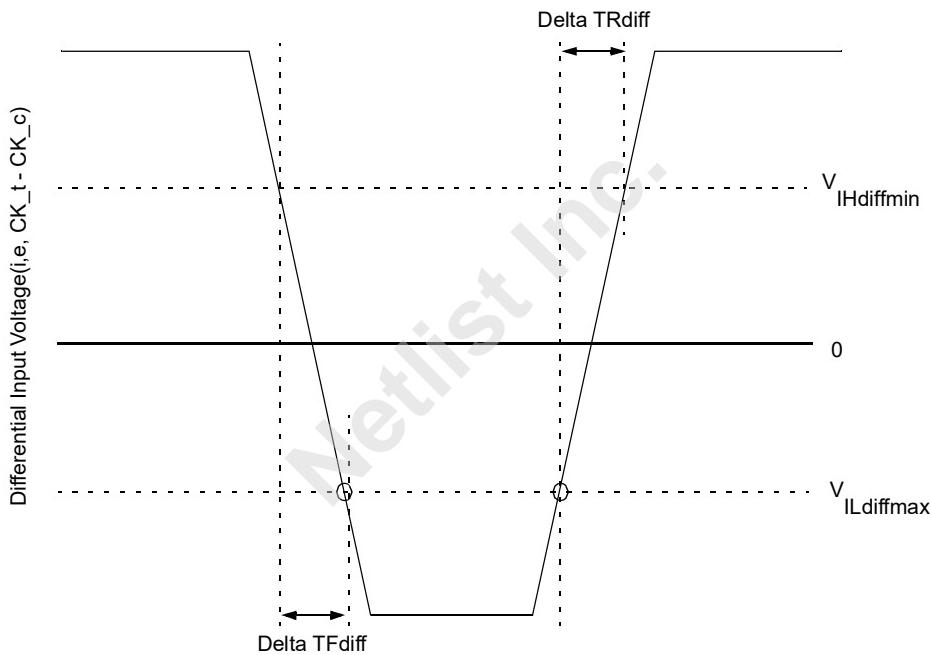
### 8.4.1 Slew Rate Definitions for Differential Input Signals (CK)

Input slew rate for differential signals (CK\_t, CK\_c) are defined and measured as shown in Table 125 and Figure 209.

**Table 125 — Differential Input Slew Rate Definition**

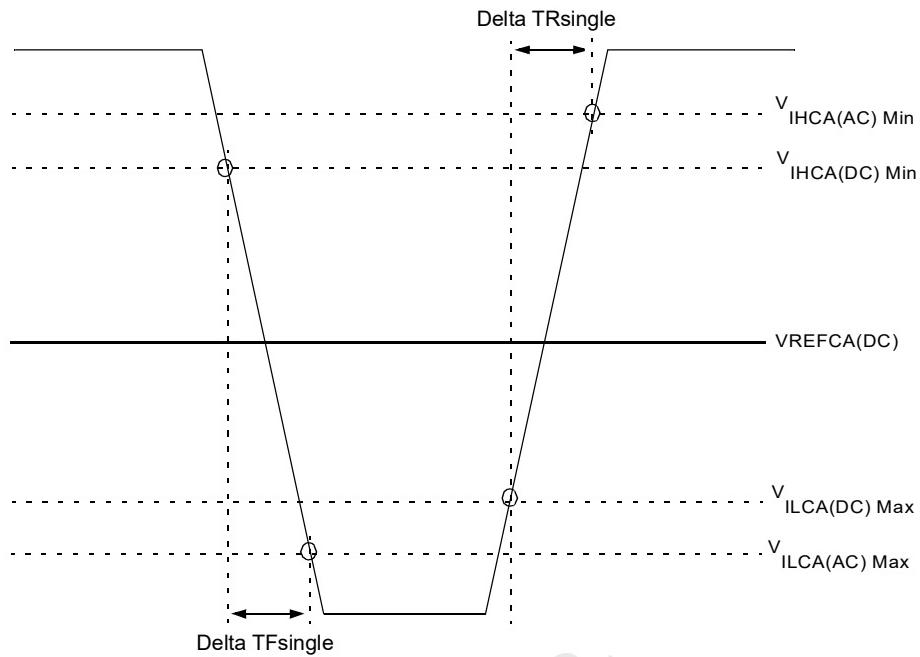
| Description  | from            | to              | Defined by  |
|--|-----------------|-----------------|---|
|  |                 |                 |   |
| Differential input slew rate for rising edge(CK_t - CK_c)  | $V_{ILdiffmax}$ | $V_{IHdiffmin}$ | $[ V_{IHdiffmin} - V_{ILdiffmax} ] / \Delta TRdiff$ |
| Differential input slew rate for falling edge(CK_t - CK_c) | $V_{IHdiffmin}$ | $V_{ILdiffmax}$ | $[ V_{IHdiffmin} - V_{ILdiffmax} ] / \Delta TFdiff$ |

NOTE The differential signal (i.e.,CK\_t - CK\_c) must be linear between these thresholds.



**Figure 209 — Differential Input Slew Rate Definition for CK\_t, CK\_c**

#### 8.4.2 Slew Rate Definition for Single-ended Input Signals (CMD/ADD)



NOTE 1 Single-ended input slew rate for rising edge = {  $V_{IHCA(AC) \text{ Min}} - V_{ILCA(DC) \text{ Max}}$  } /  $\Delta T_{Rsingle}$

NOTE 2 Single-ended input slew rate for falling edge = {  $V_{IHCA(DC) \text{ Min}} - V_{ILCA(AC) \text{ Max}}$  } /  $\Delta T_{Fsingle}$

NOTE 3 Single-ended signal rising edge from  $V_{ILCA(DC) \text{ Max}}$  to  $V_{IHCA(DC) \text{ Min}}$  must be monotonic slope.

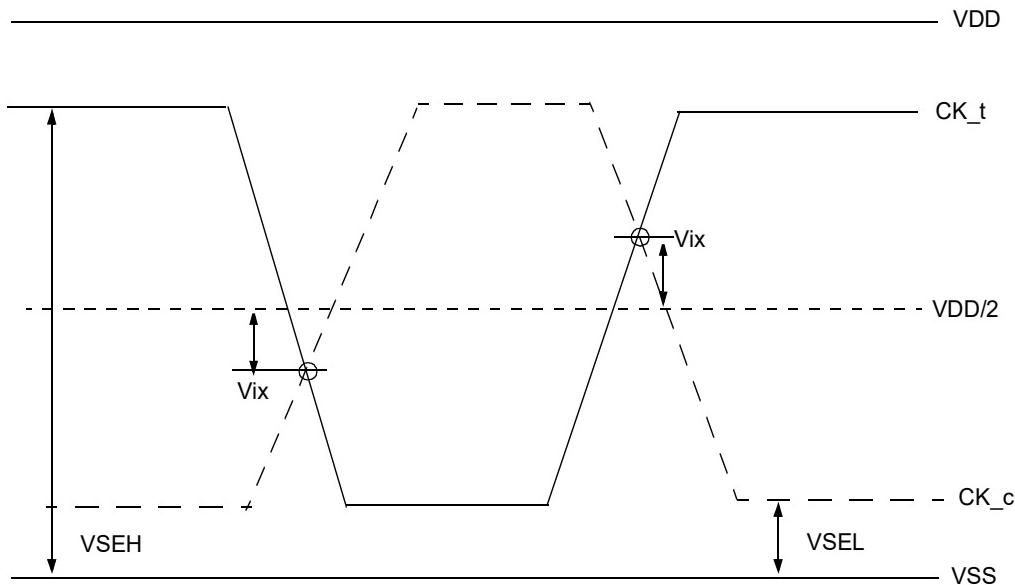
NOTE 4 Single-ended signal falling edge from  $V_{IHCA(DC) \text{ Min}}$  to  $V_{ILCA(DC) \text{ Max}}$  must be monotonic slope.

**Figure 210 — Single-ended Input Slew Rate definition for CMD and ADD**

#### 8.5 Differential Input Cross Point Voltage

To guarantee tight setup and hold times as well as output skew parameters with respect to clock, each cross point voltage of differential input signals ( $CK_t$ ,  $CK_c$ ) must meet the requirements in Table 126. The differential input cross point voltage  $V_{IX}$  is measured from the actual cross point of true and complement signals to the midlevel between  $VDD$  and  $VSS$ .

### 8.5 Single-ended requirements for differential signals (cont'd)



**Figure 211 — Vix Definition (CK)**

**Table 126 — Cross point voltage for differential input signals (CK)**

| Symbol  | Parameter   | DDR4-1600/1866/2133/2400                           |  |   |                          |
|---------|---|--|--|---|--------------------------|
|         |   | min  |  | max   |                          |
| -       | Area of VSEH, VSEL  | VSEL < VDD/2 - 145 mV<br>=< VSEL =< VDD/2 - 100 mV | VDD/2 - 145 mV<br>=< VSEL =< VDD/2 + 100 mV<br>=< VSEH =< VDD/2 + 145 mV | VDD/2 + 100 mV<br>=< VSEH =< VDD/2 + 145 mV | VDD/2 + 145 mV<br>< VSEH |
| VIX(CK) | Differential Input Cross Point Voltage relative to VDD/2 for CK_t, CK_c | -120 mV  | -( VDD/2 - VSEL )<br>+ 25 mV   | ( VSEH - VDD/2 )<br>- 25 mV                 | 120 mV                   |

| Symbol  | Parameter   | DDR4-2666/2933/3200                                |  |   |                          |
|---------|---|--|--|---|--------------------------|
|         |   | min  |  | max   |                          |
| -       | Area of VSEH, VSEL  | VSEL < VDD/2 - 145 mV<br>=< VSEL =< VDD/2 - 100 mV | VDD/2 - 145 mV<br>=< VSEL =< VDD/2 + 100 mV<br>=< VSEH =< VDD/2 + 145 mV | VDD/2 + 100 mV<br>=< VSEH =< VDD/2 + 145 mV | VDD/2 + 145 mV<br>< VSEH |
| VIX(CK) | Differential Input Cross Point Voltage relative to VDD/2 for CK_t, CK_c | -110 mV  | -( VDD/2 - VSEL )<br>+ 30 mV   | ( VSEH - VDD/2 )<br>- 30 mV                 | 110 mV                   |

## 8.6 CMOS rail to rail Input Levels

### 8.6.1 CMOS rail to rail Input Levels for RESET\_n

**Table 127 — CMOS rail to rail Input Levels for RESET\_n**

| Parameter             | Symbol        | Min     | Max     | Unit | NOTE |
|-----------------------|---------------|---------|---------|------|------|
| AC Input High Voltage | VIH(AC)_RESET | 0.8*VDD | VDD     | V    | 6    |
| DC Input High Voltage | VIH(DC)_RESET | 0.7*VDD | VDD     | V    | 2    |
| DC Input Low Voltage  | VIL(DC)_RESET | VSS     | 0.3*VDD | V    | 1    |
| AC Input Low Voltage  | VIL(AC)_RESET | VSS     | 0.2*VDD | V    | 7    |
| Rising time           | TR_RESET      | -       | 1.0     | us   | 4    |
| RESET pulse width     | tPW_RESET     | 1.0     | -       | us   | 3,5  |

NOTE 1 After RESET\_n is registered LOW, RESET\_n level shall be maintained below VIL(DC)\_RESET during tPW\_RESET, otherwise, SDRAM may not be reset.

NOTE 2 Once RESET\_n is registered HIGH, RESET\_n level must be maintained above VIH(DC)\_RESET, otherwise, SDRAM operation will not be guaranteed until it is reset asserting RESET\_n signal LOW.

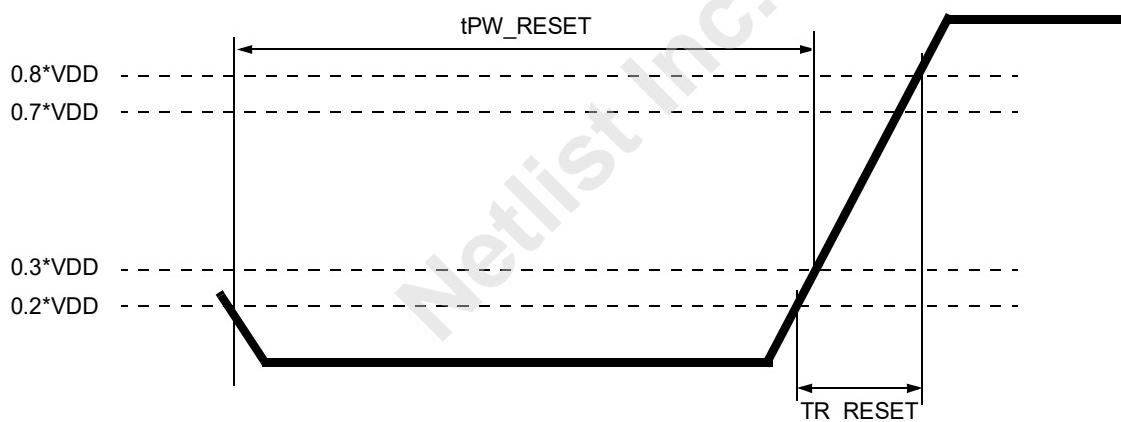
NOTE 3 RESET is destructive to data contents.

NOTE 4 No slope reversal (ringback) requirement during its level transition from Low to High.

NOTE 5 This definition is applied only "Reset Procedure at Power Stable".

NOTE 6 Overshoot might occur. It should be limited by the Absolute Maximum DC Ratings.

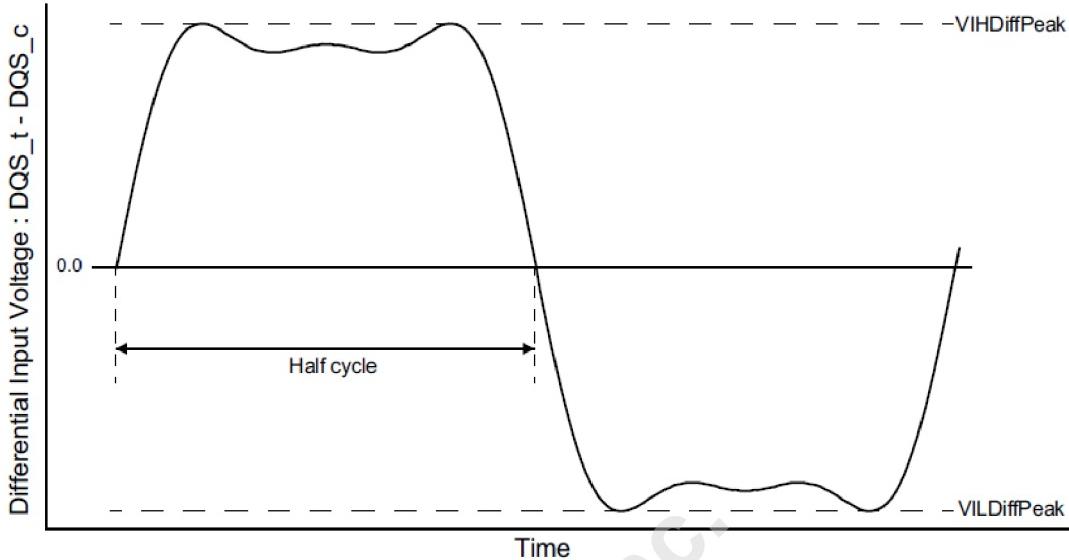
NOTE 7 Undershoot might occur. It should be limited by Absolute Maximum DC Ratings



**Figure 212 — RESET\_n Input Slew Rate Definition**

## 8.7 AC and DC Logic Input Levels for DQS Signals

### 8.7.1 Differential signal definition



**Figure 213 — Definition of differential DQS Signal AC-swing Level**

### 8.7.2 Differential swing requirements for DQS (DQS\_t - DQS\_c)

**Table 128 — Differential AC and DC Input Levels for DQS**

| Symbol      | Parameter             | DDR4-1600, 1866, 2133 |       | DDR4-2400 |       | DDR4-2666 |       | Unit | Note |
|-------------|-----------------------|-----------------------|-------|-----------|-------|-----------|-------|------|------|
|             |                       | Min                   | Max   | Min       | Max   | Min       | Max   |      |      |
| VIHDiffPeak | VIH.DIFF.Peak Voltage | 186                   | Note2 | 160       | Note2 | 150       | Note2 | mV   | 1    |
| VILDiffPeak | VIL.DIFF.Peak Voltage | Note2                 | -186  | Note2     | -160  | Note2     | -150  | mV   | 1    |

| Symbol      | Parameter             | DDR4-2933 |       | DDR4-3200 |       | Unit | Note |
|-------------|-----------------------|-----------|-------|-----------|-------|------|------|
|             |                       | Min       | Max   | Min       | Max   |      |      |
| VIHDiffPeak | VIH.DIFF.Peak Voltage | 145       | Note2 | 140       | Note2 | mV   | 1    |
| VILDiffPeak | VIL.DIFF.Peak Voltage | Note2     | -145  | Note2     | -140  | mV   | 1    |

NOTE 1 Used to define a differential signal slew-rate.

NOTE 2 These values are not defined; however, the differential signals DQS\_t - DQS\_c, need to be within the respective limits Overshoot, Undershoot Specification for single-ended signals.

### 8.7.3 Peak voltage calculation method

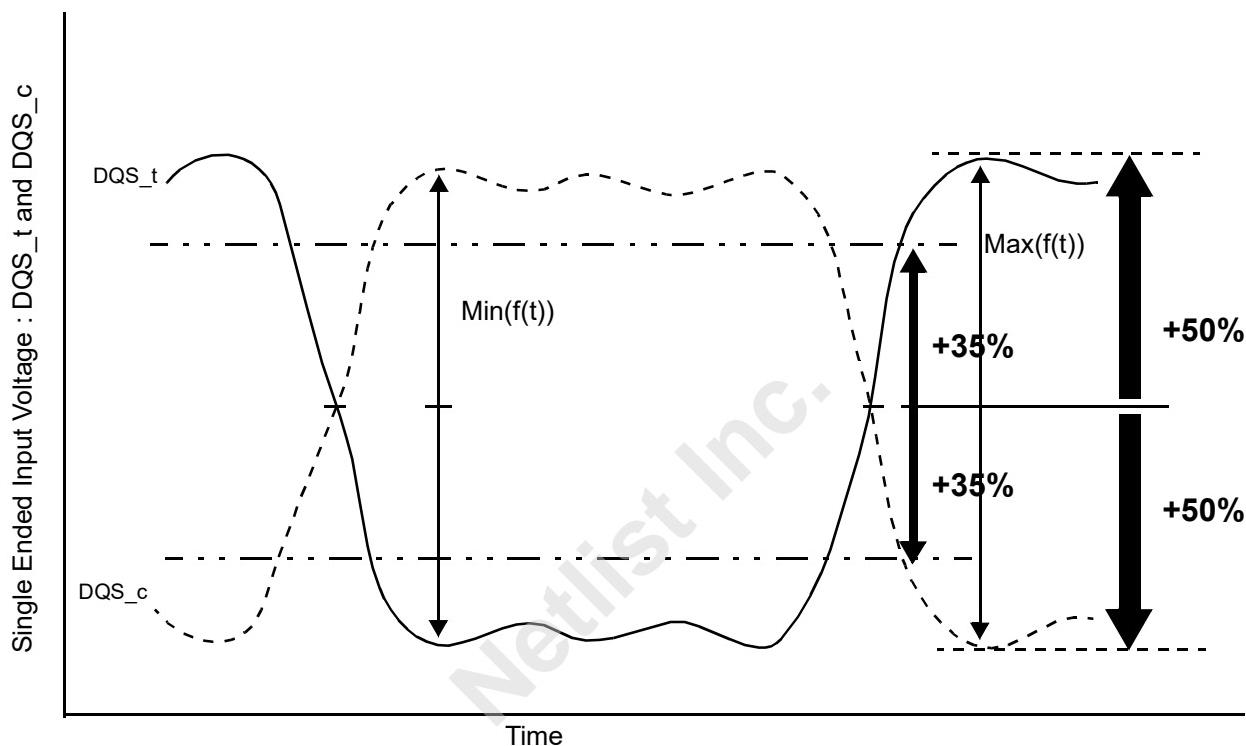
The peak voltage of Differential DQS signals are calculated in a following equation.

$$\text{VIH.DIFF.Peak Voltage} = \text{Max}(f(t))$$

$$\text{VIL.DIFF.Peak Voltage} = \text{Min}(f(t))$$

$$f(t) = \text{VDQS}_t - \text{VDQS}_c$$

The Max(f(t)) or Min(f(t)) used to determine the midpoint which to reference the +/-35% window of the exempt non-monotonic signaling shall be the smallest peak voltage observed in all UIs.



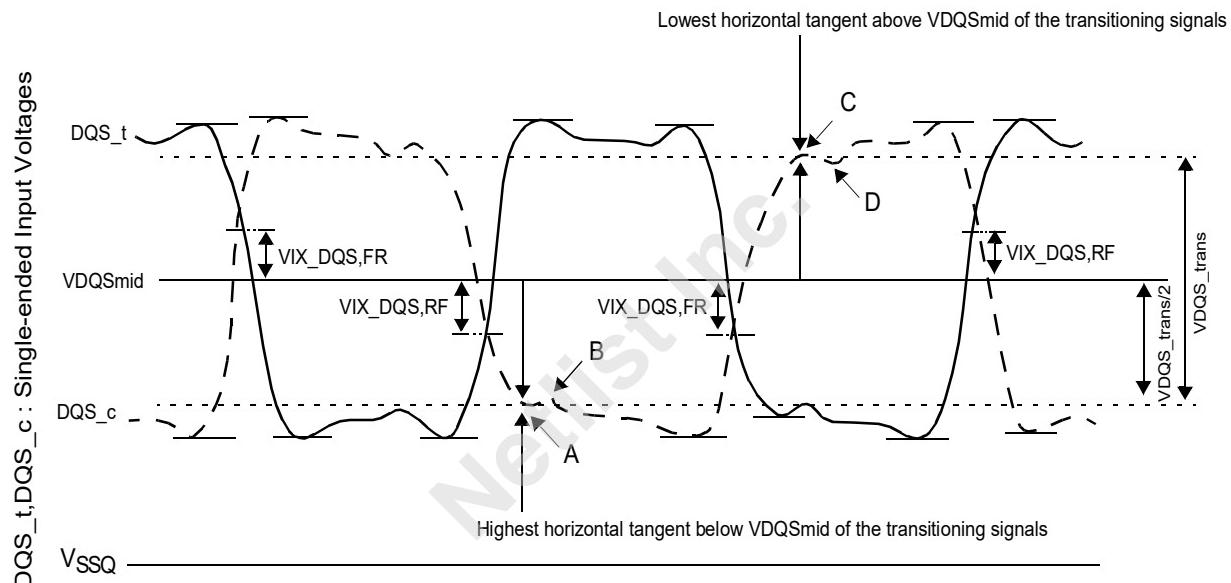
**Figure 214 — Definition of differential DQS Peak Voltage and range of exempt non-monotonic signaling**

## 8.7.4 Differential Input Cross Point Voltage

To achieve tight RxMask input requirements as well as output skew parameters with respect to strobe, the cross point voltage of differential input signals (DQS\_t, DQS\_c) must meet the requirements in Table 129. The differential input cross point voltage VIX\_DQS (VIX\_DQS\_FR and VIX\_DQS\_RF) is measured from the actual cross point of DQS\_t, DQS\_c relative to the VDQSmid of the DQS\_t and DQS\_c signals.

VDQSmid is the midpoint of the minimum levels achieved by the transitioning DQS\_t and DQS\_c signals, and noted by VDQS\_trans. VDQS\_trans is the difference between the lowest horizontal tangent above VDQSmid of the transitioning DQS signals and the highest horizontal tangent below VDQSmid of the transitioning DQS signals.

A non-monotonic transitioning signal's ledge is exempt or not used in determination of a horizontal tangent provided the said ledge occurs within +/- 35% of the midpoint of either VIH.DIFF.Peak Voltage (DQS\_t rising) or VIL.DIFF.Peak Voltage (DQS\_c rising), refer to Figure 214. A secondary horizontal tangent resulting from a ring-back transition is also exempt in determination of a horizontal tangent. That is, a falling transition's horizontal tangent is derived from its negative slope to zero slope transition (point A in Figure 215) and a ring-back's horizontal tangent derived from its positive slope to zero slope transition (point B in Figure 215) is not a valid horizontal tangent; and a rising transition's horizontal tangent is derived from its positive slope to zero slope transition (point C in Figure 215) and a ring-back's horizontal tangent derived from its negative slope to zero slope transition (point D in Figure 215) is not a valid horizontal tangent.



**Figure 215 — Vix Definition (DQS)**

**Table 129 — Cross point voltage for DQS differential input signals**

| Symbol           | Parameter  | DDR4-1600, 1866, 2133, |                 | DDR4-2666, 2933, 3200 |                 | Unit | Note    |
|------------------|--|------------------------|-----------------|-----------------------|-----------------|------|---------|
|                  |  | Min                    | Max             | Min                   | Max             |      |         |
| Vix_DQS_ratio    | DQS_t and DQS_c crossing relative to the midpoint of the DQS_t and DQS_c signal swings | -                      | 25              | -                     | 25              | %    | 1, 2,   |
| VDQSmid_to_Vcent | VDQSmid offset relative to Vcent_DQ(midpoint)  | -                      | min(VIHdiff,50) | -                     | min(VIHdiff,50) | mV   | 3, 4, 5 |

NOTE 1 Vix\_DQS\_Ratio is DQS VIX crossing (Vix\_DQS\_FR or Vix\_DQS\_RF) divided by VDQS\_trans. VDQS\_trans is the difference between the lowest horizontal tangent above VDQSmid of the transitioning DQS signals and the highest horizontal tangent below VDQSmid of the transitioning DQS signals.

NOTE 2 VDQSmid will be similar to the VREFDQ internal setting value obtained during Vref Training if the DQS and DQs drivers and paths are matched.

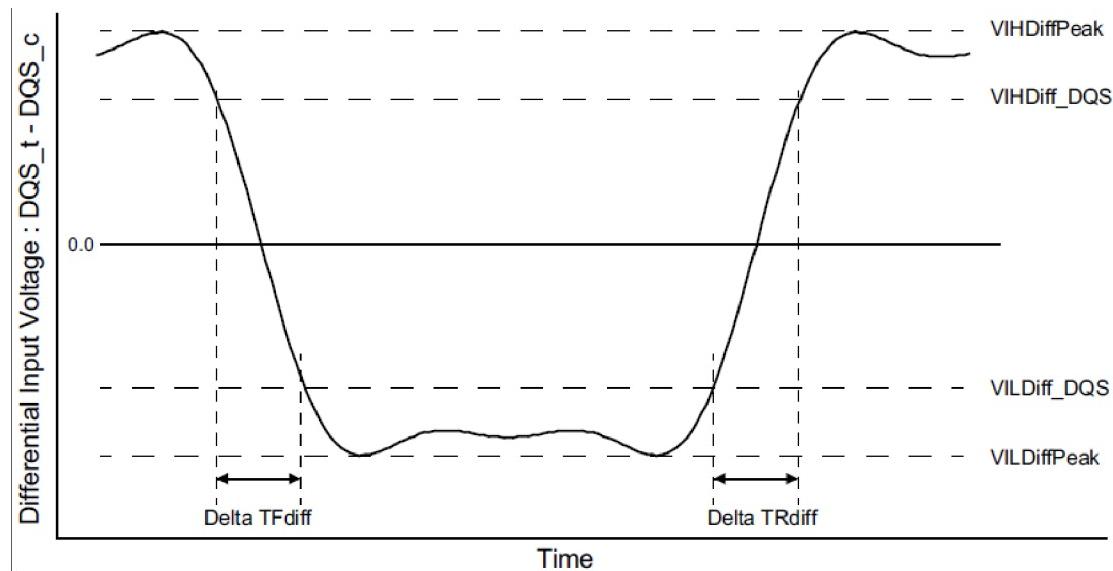
NOTE 3 The maximum limit shall not exceed the smaller of VIHdiff minimum limit or 50mV.

NOTE 4 VIX measurements are only applicable for transitioning DQS\_t and DQS\_c signals when toggling data, preamble and high-z states are not applicable conditions.

NOTE 5 The parameter VDQSmid is defined for simulation and ATE testing purposes, it is not expected to be tested in a system.

### 8.7.5 Differential Input Slew Rate Definition

Input slew rate for differential signals (DQS\_t, DQS\_c) are defined and measured as shown in Figure 215 & Figure 216.



NOTE 1 Differential signal rising edge from VILDiff\_DQS to VIHDiff\_DQS must be monotonic slope.

NOTE 2 Differential signal falling edge from VIHDiff\_DQS to VILDiff\_DQS must be monotonic slope.

**Figure 216 — Differential Input Slew Rate Definition for DQS\_t, DQS\_c**

**Table 130 — Differential Input Slew Rate Definition for DQS\_t, DQS\_c**

| Description   |             |             | Defined by                                  |  |
|---|-------------|-------------|---|--|
|   | From        | To          |   |  |
| Differential input slew rate for rising edge (DQS_t - DQS_c)  | VILDiff_DQS | VIHDiff_DQS | $ VILDiff_DQS - VIHDiff_DQS /\Delta TRdiff$ |  |
| Differential input slew rate for falling edge (DQS_t - DQS_c) | VIHDiff_DQS | VILDiff_DQS | $ VILDiff_DQS - VIHDiff_DQS /\Delta TFdiff$ |  |

**Table 131 — Differential Input Level for DQS\_t, DQS\_c**

| Symbol      | Parameter               | DDR4-1600, 1866, 2133 |      | DDR4-2400, 2666 |      | DDR4-2933 |      | DDR4-3200 |      | Unit | Note |
|-------------|-------------------------|-----------------------|------|-----------------|------|-----------|------|-----------|------|------|------|
|             |                         | Min                   | Max  | Min             | Max  | Min       | Max  | Min       | Max  |      |      |
| VIHDiff_DQS | Differential Input High | 136                   | -    | 130             | -    | 115       | -    | 110       | -    | mV   |      |
| VILDiff_DQS | Differential Input Low  | -                     | -136 | -               | -130 | -         | -115 | -         | -110 | mV   |      |

**Table 132 — Differential Input Slew Rate for DQS\_t, DQS\_c**

| Symbol  | Parameter                    | DDR4-1600, 1866, 2133 |     | DDR4-2400 |     | DDR4-2666, 2933, 3200 |     | Unit | Note |
|---------|------------------------------|-----------------------|-----|-----------|-----|-----------------------|-----|------|------|
|         |                              | Min                   | Max | Min       | Max | Min                   | Max |      |      |
| SRIdiff | Differential Input Slew Rate | 3                     | 18  | 3         | 18  | 2.5                   | 18  | V/ns |      |

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## 9 AC and DC output Measurement levels

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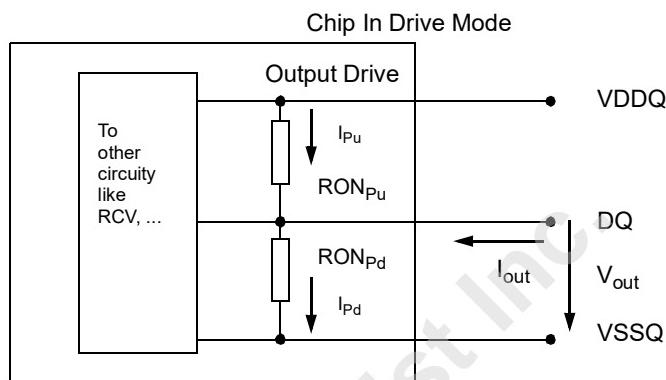
### 9.1 Output Driver DC Electrical Characteristics

The DDR4 driver supports two different Ron values. These Ron values are referred as strong(low Ron) and weak mode(high Ron). A functional representation of the output buffer is shown in the figure below. Output driver impedance RON is defined as follows:

The individual pull-up and pull-down resistors ( $RON_{Pu}$  and  $RON_{Pd}$ ) are defined as follows:

$$RON_{Pu} = \frac{VDDQ - Vout}{|I_{out}|} \quad \text{under the condition that } RON_{Pd} \text{ is off}$$

$$RON_{Pd} = \frac{Vout}{|I_{out}|} \quad \text{under the condition that } RON_{Pu} \text{ is off}$$



**Figure 217 — Output driver**

### 9.1 Output Driver DC Electrical Characteristics (cont'd)

**Table 133 — Output Driver DC Electrical Characteristics, assuming RZQ = 240ohm; entire operating temperature range; after proper ZQ calibration**

| RON <sub>NOM</sub>                                   | Resistor | Vout             | Min  | Nom | Max  | Unit  | NOTE    |
|--|----------|------------------|------|-----|------|-------|---------|
| 34Ω  | RON34Pd  | VOLdc= 0.5*VDDQ  | 0.73 | 1   | 1.1  | RZQ/7 | 1,2,6   |
|  |          | VOMdc= 0.8* VDDQ | 0.83 | 1   | 1.1  | RZQ/7 | 1,2,6   |
|  |          | VOHdc= 1.1* VDDQ | 0.83 | 1   | 1.25 | RZQ/7 | 1,2,6   |
|  | RON34Pu  | VOLdc= 0.5* VDDQ | 0.9  | 1   | 1.25 | RZQ/7 | 1,2,6   |
|  |          | VOMdc= 0.8* VDDQ | 0.9  | 1   | 1.1  | RZQ/7 | 1,2,6   |
|  |          | VOHdc= 1.1* VDDQ | 0.8  | 1   | 1.1  | RZQ/7 | 1,2,6   |
| 48Ω  | RON48Pd  | VOLdc= 0.5*VDDQ  | 0.73 | 1   | 1.1  | RZQ/5 | 1,2,6   |
|  |          | VOMdc= 0.8* VDDQ | 0.83 | 1   | 1.1  | RZQ/5 | 1,2,6   |
|  |          | VOHdc= 1.1* VDDQ | 0.83 | 1   | 1.25 | RZQ/5 | 1,2,6   |
|  | RON48Pu  | VOLdc= 0.5* VDDQ | 0.9  | 1   | 1.25 | RZQ/5 | 1,2,6   |
|  |          | VOMdc= 0.8* VDDQ | 0.9  | 1   | 1.1  | RZQ/5 | 1,2,6   |
|  |          | VOHdc= 1.1* VDDQ | 0.8  | 1   | 1.1  | RZQ/5 | 1,2,6   |
| Mismatch between pull-up and pull-down, MMPuPd       |          | VOMdc= 0.8* VDDQ | -10  |     | 17   | %     | 1,2,4,3 |
| Mismatch DQ-DQ within byte variation pull-up, MMPudd |          | VOMdc= 0.8* VDDQ |      |     | 10   | %     | 1,2,4   |
| Mismatch DQ-DQ within byte variation pull-dn, MMPddd |          | VOMdc= 0.8* VDDQ |      |     | 10   | %     | 1,2,4   |

NOTE 1 The tolerance limits are specified after calibration with stable voltage and temperature. For the behavior of the tolerance limits if temperature or voltage changes after calibration, see following section on voltage and temperature sensitivity(TBD).

NOTE 2 Pull-up and pull-dn output driver impedances are recommended to be calibrated at 0.8 \* VDDQ. Other calibration schemes may be used to achieve the linearity spec shown above, e.g., calibration at 0.5 \* VDDQ and 1.1 \* VDDQ.

NOTE 3 Measurement definition for mismatch between pull-up and pull-down, MMPuPd : Measure RONPu and RONPD both at 0.8\*VDD separately; RONnom is the nominal Ron value

$$MMPuPd = \frac{RONPu - RONPd}{RONNOM} *100$$

NOTE 4 RON variance range ratio to RON Nominal value in a given component, including DQS\_t and DQS\_c.

$$MMPudd = \frac{RONPuMax - RONPuMin}{RONNOM} *100$$

$$MMPddd = \frac{RONPdMax - RONPdMin}{RONNOM} *100$$

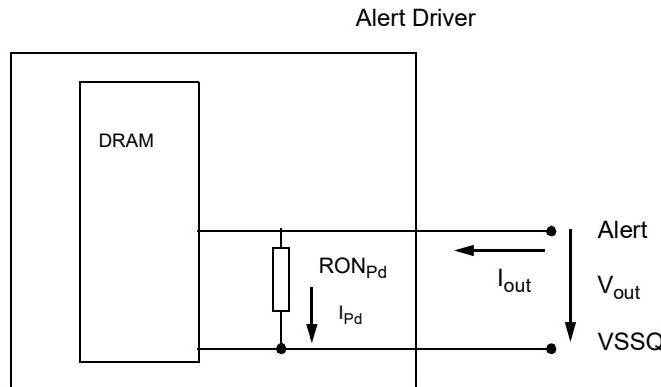
NOTE 5 This parameter of x16 device is specified for Upper byte and Lower byte.

NOTE 6 For IT device, the minimum values are reduced by tbd%

### 9.1.1 Alert\_n output Drive Characteristic

A functional representation of the output buffer is shown in the figure below. Output driver impedance  $RON_{Pd}$  is defined as follows:

$$RON_{Pd} = \frac{V_{out}}{|I_{out}|} \text{ under the condition that } RON_{Pu} \text{ is off}$$



**Figure 218 — Functional Representation of the Output Buffer**

**Table 134 — Output Driver Impedance**

|  | Resistor   | Vout                    | Min |  | Max | Unit       | NOTE |
|--|------------|-------------------------|-----|--|-----|------------|------|
|  | $RON_{Pd}$ | $V_{OLdc} = 0.1 * VDDQ$ | 0.3 |  | 1.2 | $34\Omega$ | 1    |
|  |            | $V_{OMdc} = 0.8 * VDDQ$ | 0.4 |  | 1.2 | $34\Omega$ | 1    |
|  |            | $V_{OHdc} = 1.1 * VDDQ$ | 0.4 |  | 1.4 | $34\Omega$ | 1    |

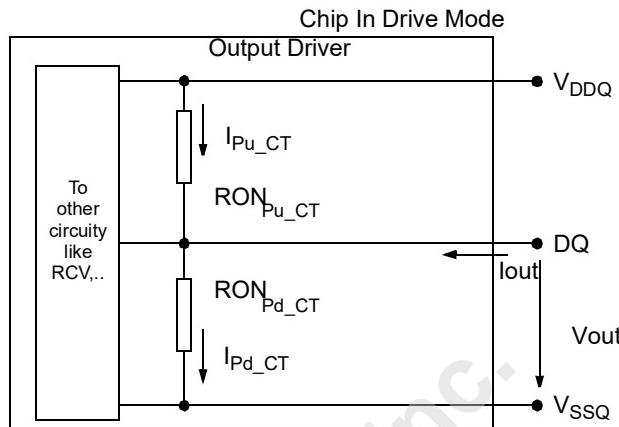
NOTE 1 VDDQ voltage is at VDDQ DC. VDDQ DC definition is tbd.

### 9.1.2 Output Driver Characteristic of Connectivity Test (CT) Mode

Following Output driver impedance RON will be applied Test Output Pin during Connectivity Test (CT) Mode.  
 The individual pull-up and pull-down resistors (RONPu\_CT and RONPd\_CT) are defined as follows:

$$RON_{Pu\_CT} = \frac{V_{DDQ} - V_{OUT}}{|I_{out}|}$$

$$RON_{Pd\_CT} = \frac{V_{OUT}}{|I_{out}|}$$



**Figure 219 — Output Driver**

**Table 135 — RONPu\_CT and RONPd\_CT**

| RON_NOM_CT | Resistor  | Vout                               | Max | Units | NOTE |
|------------|-----------|------------------------------------|-----|-------|------|
| 34Ω        | RON_Pd_CT | $V_{OB_{dc}} = 0.2 \times V_{DDQ}$ | 1.9 | 34Ω   | 1    |
|            |           | $V_{OL_{dc}} = 0.5 \times V_{DDQ}$ | 2.0 | 34Ω   | 1    |
|            |           | $V_{OM_{dc}} = 0.8 \times V_{DDQ}$ | 2.2 | 34Ω   | 1    |
|            |           | $V_{OH_{dc}} = 1.1 \times V_{DDQ}$ | 2.5 | 34Ω   | 1    |
|            | RON_Pu_CT | $V_{OB_{dc}} = 0.2 \times V_{DDQ}$ | 2.5 | 34Ω   | 1    |
|            |           | $V_{OL_{dc}} = 0.5 \times V_{DDQ}$ | 2.2 | 34Ω   | 1    |
|            |           | $V_{OM_{dc}} = 0.8 \times V_{DDQ}$ | 2.0 | 34Ω   | 1    |
|            |           | $V_{OH_{dc}} = 1.1 \times V_{DDQ}$ | 1.9 | 34Ω   | 1    |

NOTE 1 Connectivity test mode uses un-calibrated drivers, showing the full range over PVT. No mismatch between pull up and pull down is defined.

### 9.2 Single-ended AC & DC Output Levels

**Table 136 — Single-ended AC & DC output levels**

| Symbol       | Parameter   | DDR4-1600/1866/2133/2400/2666/3200 | Units | NOTE |
|--------------|---|------------------------------------|-------|------|
| $V_{OH}(DC)$ | DC output high measurement level (for IV curve linearity) | $1.1 \times V_{DDQ}$               | V     |      |
| $V_{OM}(DC)$ | DC output mid measurement level (for IV curve linearity)  | $0.8 \times V_{DDQ}$               | V     |      |
| $V_{OL}(DC)$ | DC output low measurement level (for IV curve linearity)  | $0.5 \times V_{DDQ}$               | V     |      |
| $V_{OH}(AC)$ | AC output high measurement level (for output SR)          | $(0.7 + 0.15) \times V_{DDQ}$      | V     | 1    |
| $V_{OL}(AC)$ | AC output low measurement level (for output SR)           | $(0.7 - 0.15) \times V_{DDQ}$      | V     | 1    |

NOTE 1 The swing of  $\pm 0.15 \times V_{DDQ}$  is based on approximately 50% of the static single-ended output peak-to-peak swing with a driver impedance of  $R_{ZQ}/7\Omega$  and an effective test load of  $50\Omega$  to  $V_{TT} = V_{DDQ}$ .

### 9.3 Differential AC & DC Output Levels

**Table 137 — Differential AC & DC output levels**

| Symbol           | Parameter   | DDR4-1600/1866/2133/2400/<br>2666/3200 | Units | NOTE |
|------------------|---|--|-------|------|
| $V_{OHdiff}(AC)$ | AC differential output high measurement level (for output SR) | +0.3 x $V_{DDQ}$                       | V     | 1    |
| $V_{OLdiff}(AC)$ | AC differential output low measurement level (for output SR)  | -0.3 x $V_{DDQ}$                       | V     | 1    |

NOTE 1 The swing of  $\pm 0.3 \times V_{DDQ}$  is based on approximately 50% of the static differential output peak-to-peak swing with a driver impedance of  $RZQ/7$  and an effective test load of  $50\Omega$  to  $V_{TT} = V_{DDQ}$  at each of the differential outputs.

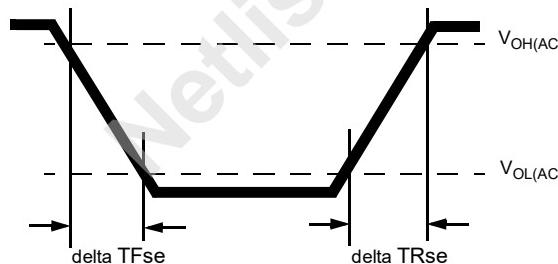
### 9.4 Single-ended Output Slew Rate

With the reference load for timing measurements, output slew rate for falling and rising edges is defined and measured between  $V_{OL(AC)}$  and  $V_{OH(AC)}$  for single ended signals as shown in Table 138 and Figure 220.

**Table 138 — Single-ended output slew rate definition**

| Description                                    | Measured     |              | Defined by                                   |
|--|--------------|--------------|--|
|  | From         | To           |  |
| Single ended output slew rate for rising edge  | $V_{OL(AC)}$ | $V_{OH(AC)}$ | $[V_{OH(AC)} - V_{OL(AC)}] / \Delta T_{Rse}$ |
| Single ended output slew rate for falling edge | $V_{OH(AC)}$ | $V_{OL(AC)}$ | $[V_{OH(AC)} - V_{OL(AC)}] / \Delta T_{Fse}$ |

NOTE 1 Output slew rate is verified by design and characterization, and may not be subject to production test.



**Figure 220 — Single-ended Output Slew Rate Definition**

**Table 139 — Single-ended output slew rate**

| Parameter                     | Symbol | DDR4-1600 |     | DDR4-1866 |     | DDR4-2133 |     | DDR4-2400 |     | DDR4-2666 |     | DDR4-2933 |     | DDR4-3200 |     | Units |
|-------------------------------|--------|-----------|-----|-----------|-----|-----------|-----|-----------|-----|-----------|-----|-----------|-----|-----------|-----|-------|
|                               |        | Min       | Max |       |
| Single ended output slew rate | SRQse  | 4         | 9   | 4         | 9   | 4         | 9   | 4         | 9   | 4         | 9   | 4         | 9   | 4         | 9   | V/ns  |

Description: SR: Slew Rate

Q: Query Output (like in DQ, which stands for Data-in, Query-Output)

se: Single-ended Signals

For Ron = RZQ/7 setting

NOTE 1 In two cases, a maximum slew rate of 12 V/ns applies for a single DQ signal within a byte lane.

-Case 1 is defined for a single DQ signal within a byte lane which is switching into a certain direction (either from high to low or low to high) while all remaining DQ signals in the same byte lane are static (i.e., they stay at either high or low).

-Case 2 is defined for a single DQ signal within a byte lane which is switching into a certain direction (either from high to low or low to high) while all remaining DQ signals in the same byte lane are switching into the opposite direction (i.e., from low to high or high to low respectively). For the remaining DQ signal switching into the opposite direction, the regular maximum limit of 9 V/ns applies

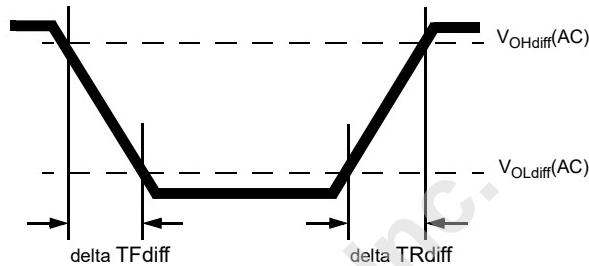
## 9.5 Differential Output Slew Rate

With the reference load for timing measurements, output slew rate for falling and rising edges is defined and measured between VOLdiff(AC) and VOHdiff(AC) for differential signals as shown in Table 140 and Figure 221.

**Table 140 — Differential output slew rate definition**

| Description                                    | Measured                 |                          | Defined by   |
|--|--------------------------|--------------------------|--|
|  | From                     | To                       |  |
| Differential output slew rate for rising edge  | V <sub>OLdiff</sub> (AC) | V <sub>OHdiff</sub> (AC) | [V <sub>OHdiff</sub> (AC)-V <sub>OLdiff</sub> (AC)] / Delta TRdiff |
| Differential output slew rate for falling edge | V <sub>OHdiff</sub> (AC) | V <sub>OLdiff</sub> (AC) | [V <sub>OHdiff</sub> (AC)-V <sub>OLdiff</sub> (AC)] / Delta TFdiff |

NOTE 1 Output slew rate is verified by design and characterization, and may not be subject to production test.



**Figure 221 — Differential Output Slew Rate Definition**

**Table 141 — Differential output slew rate**

| Parameter                     | Symbol  | DDR4-1600 |     | DDR4-1866 |     | DDR4-2133 |     | DDR4-2400 |     | DDR4-2666 |     | DDR4-2933 |     | DDR4-3200 |     | Unit s |
|-------------------------------|---------|-----------|-----|-----------|-----|-----------|-----|-----------|-----|-----------|-----|-----------|-----|-----------|-----|--------|
|                               |         | Min       | Max |        |
| Differential output slew rate | SRQdiff | 8         | 18  | 8         | 18  | 8         | 18  | 8         | 18  | 8         | 18  | 8         | 18  | 8         | 18  | V/ns   |

Description:

SR: Slew Rate

Q: Query Output (like in DQ, which stands for Data-in, Query-Output)

diff: Differential Signals

For Ron = RZQ/7 setting

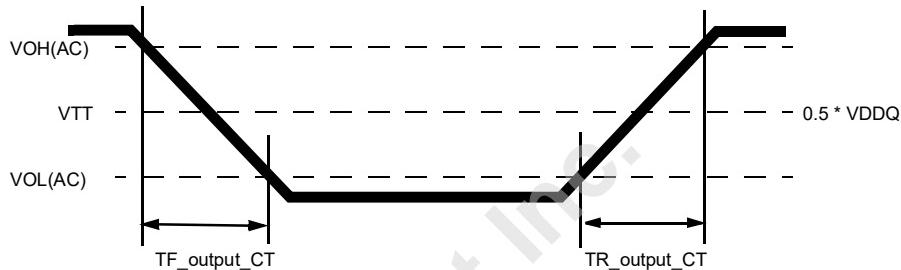
## 9.6 Single-ended AC & DC Output Levels of Connectivity Test Mode

Following output parameters will be applied for DDR4 SDRAM Output Signal during Connectivity Test Mode.

**Table 142 — Single-ended AC & DC output levels of Connectivity Test Mode**

| Symbol       | Parameter  | DDR4-1600/1866/<br>2133/ 2400/2666/3200 | Unit | Notes |
|--------------|--|---|------|-------|
| $V_{OH(DC)}$ | DC output high measurement level (for IV curve linearity)  | $1.1 \times VDDQ$                       | V    |       |
| $V_{OM(DC)}$ | DC output mid measurement level (for IV curve linearity)   | $0.8 \times VDDQ$                       | V    |       |
| $V_{OL(DC)}$ | DC output low measurement level (for IV curve linearity)   | $0.5 \times VDDQ$                       | V    |       |
| $V_{OB(DC)}$ | DC output below measurement level (for IV curve linearity) | $0.2 \times VDDQ$                       | V    |       |
| $V_{OH(AC)}$ | AC output high measurement level (for output SR)           | $VTT + (0.1 \times VDDQ)$               | V    | 1     |
| $V_{OL(AC)}$ | AC output below measurement level (for output SR)          | $VTT - (0.1 \times VDDQ)$               | V    | 1     |

NOTE 1 The effective test load is  $50\Omega$  terminated by  $VTT = 0.5 \times VDDQ$ .



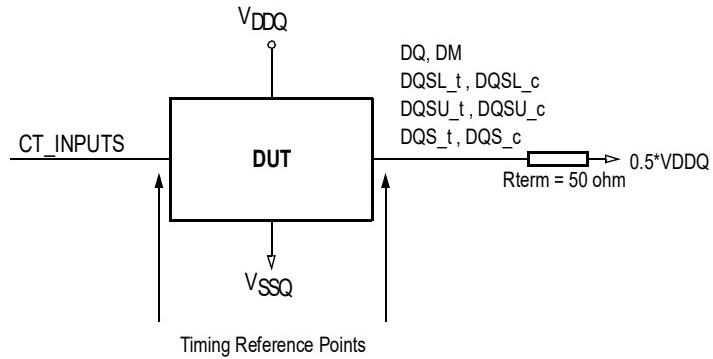
**Figure 222 — Output Slew Rate Definition of Connectivity Test Mode**

**Table 143 — Single-ended output slew rate of Connectivity Test Mode**

| Parameter                  | Symbol       | DDR4-1600/1866/2133/ 2400/2666/3200 |     | Unit | Notes |
|----------------------------|--------------|-------------------------------------|-----|------|-------|
|                            |              | Min                                 | Max |      |       |
| Output signal Falling time | TF_output_CT | -                                   | 10  | ns/V |       |
| Output signal Rising time  | TR_output_CT | -                                   | 10  | ns/V |       |

## 9.7 Test Load for Connectivity Test Mode Timing

The reference load for ODT timings is defined in Figure 223.



**Figure 223 — Connectivity Test Mode Timing Reference Load**

## 10 Speed Bin

The notes for Tables 140 through 146 are in Section 10.1.

**Table 144 — DDR4-1600 Speed Bins and Operations**

| Speed Bin   |         |                                       | DDR4-1600J      |                            | DDR4-1600K                                     |                               | DDR4-1600L      |                 | Unit | NOTE                 |  |
|---|---------|---------------------------------------|-----------------|----------------------------|--|-------------------------------|-----------------|-----------------|------|----------------------|--|
| CL-nRCD-nRP   |         |                                       | 10-10-10        |                            | 11-11-11                                       |                               | 12-12-12        |                 |      |                      |  |
| Parameter   |         | Symbol                                | min             | max                        | min  | max                           | min             | max             |      |                      |  |
| Internal read command to first data                       |         | tAA                                   | 12.50           | 18.00                      | 13.75 <sup>14</sup><br>(13.50) <sup>5,12</sup> | 18.00                         | 15.00           | 18.00           | ns   | 12                   |  |
| Internal read command to first data with read DBI enabled |         | tAA_DBI                               | tAA(min) + 2nCK | tAA(max) + 2nCK            | tAA(min) + 2nCK                                | tAA(max) + 2nCK               | tAA(min) + 2nCK | tAA(max) + 2nCK | ns   | 12                   |  |
| ACT to internal read or write delay time                  |         | tRCD                                  | 12.50           | -                          | 13.75 <sup>14</sup><br>(13.50) <sup>5,12</sup> | -                             | 15.00           | -               | ns   | 12                   |  |
| PRE command period  |         | tRP                                   | 12.50           | -                          | 13.75 <sup>14</sup><br>(13.50) <sup>5,12</sup> | -                             | 15.00           | -               | ns   | 12                   |  |
| ACT to PRE command period                                 |         | tRAS                                  | 35              | 9 x tREFI                  | 35   | 9 x tREFI                     | 35              | 9 x tREFI       | ns   | 12                   |  |
| ACT to ACT or REF command period                          |         | tRC                                   | 47.5            | -                          | 48.75 <sup>14</sup><br>(48.50) <sup>5,12</sup> | -                             | 50              | -               | ns   | 12                   |  |
|   | Normal  | Read DBI                              |                 |                            |  |                               |                 |                 |      |                      |  |
| CWL = 9   | CL = 9  | CL = 11<br>(Optional) <sup>5,12</sup> | tCK(AVG)        | 1.5                        | 1.6  | 1.5                           | 1.6             | Reserved        |      | 1,2,3,4<br>,11,17    |  |
|   |         |                                       |                 | (Optional) <sup>5,12</sup> |  | (Optional) <sup>5,12,14</sup> |                 |                 |      |                      |  |
|   | CL = 10 | CL = 12                               | tCK(AVG)        | 1.5                        | 1.6  | Reserved                      |                 | 1.5             | 1.6  | ns 1,2,3,4<br>,11,17 |  |
| CWL = 9,11  | CL = 10 | CL = 12                               | tCK(AVG)        | 1.25                       | <1.5   | Reserved                      |                 | Reserved        |      | ns 1,2,3,4           |  |
|   | CL = 11 | CL = 13                               | tCK(AVG)        | 1.25                       | <1.5   | 1.25                          | <1.5            | Reserved        |      | ns 1,2,3,4           |  |
|   | CL = 12 | CL = 14                               | tCK(AVG)        | 1.25                       | <1.5   | 1.25                          | <1.5            | 1.25            | <1.5 | ns 1,2,3             |  |
| Supported CL Settings                                     |         |                                       | (9),10,11,12    |                            | (9),11,12                                      |                               | 10,12           |                 | nCK  | 13,14                |  |
| Supported CL Settings with read DBI                       |         |                                       | (11),12,13,14   |                            | (11),13,14                                     |                               | 11,14           |                 | nCK  | 13                   |  |
| Supported CWL Settings                                    |         |                                       | 9,11            |                            | 9,11   |                               | 9,11            |                 | nCK  |                      |  |

## 10 Speed Bin (cont'd)

**Table 145 — DDR4-1866 Speed Bins and Operations**

| Speed Bin   |         |                                       | DDR4-1866L           |  | DDR4-1866M                                     |                               | DDR4-1866N      |                 | Unit  | NOTE             |                  |  |
|---|---------|---------------------------------------|----------------------|--|--|-------------------------------|-----------------|-----------------|-------|------------------|------------------|--|
| CL-nRCD-nRP   |         |                                       | 12-12-12             |  | 13-13-13                                       |                               | 14-14-14        |                 |       |                  |                  |  |
| Parameter   |         | Symbol                                | min                  | max  | min  | max                           | min             | max             |       |                  |                  |  |
| Internal read command to first data                       | tAA     |                                       | 12.85                | 18.00  | 13.92 <sup>14</sup><br>(13.50) <sup>5,12</sup> | 18.00                         | 15.00           | 18.00           | ns    | 12               |                  |  |
| Internal read command to first data with read DBI enabled | tAA_DBI | tAA(min) + 2nCK                       | tAA(max) + 2nCK      | tAA(min) + 2nCK                                | tAA(max) + 2nCK                                | tAA(min) + 2nCK               | tAA(max) + 2nCK | tAA(max) + 2nCK | ns    | 12               |                  |  |
| ACT to internal read or write delay time                  | tRCD    | 12.85                                 | -                    | 13.92 <sup>14</sup><br>(13.50) <sup>5,12</sup> | -  | 15.00                         | -               | ns              | 12    |                  |                  |  |
| PRE command period  | tRP     | 12.85                                 | -                    | 13.92 <sup>14</sup><br>(13.50) <sup>5,12</sup> | -  | 15.00                         | -               | ns              | 12    |                  |                  |  |
| ACT to PRE command period                                 | tRAS    | 34                                    | 9 x tREFI            | 34   | 9 x tREFI                                      | 34                            | 9 x tREFI       | ns              | 12    |                  |                  |  |
| ACT to ACT or REF command period                          | tRC     | 46.85                                 | -                    | 47.92 <sup>14</sup><br>(47.50) <sup>5,12</sup> | -  | 49.00                         | -               | ns              | 12    |                  |                  |  |
|   | Normal  | Read DBI                              |                      |  |  |                               |                 |                 |       |                  |                  |  |
| CWL = 9   | CL = 9  | CL = 11<br>(Optional) <sup>5,12</sup> | tCK(AVG)             | 1.5  | 1.6  | 1.5                           | 1.6             | Reserved        | ns    | 1,2,3,4,<br>6,11 |                  |  |
|   |         |                                       | tCK(AVG)             | (Optional) <sup>5,12</sup>                     |  | (Optional) <sup>5,12,14</sup> |                 |                 |       |                  |                  |  |
|   | CL = 10 | CL = 12                               | tCK(AVG)             | 1.5  | 1.6  | Reserved                      |                 | 1.5             | 1.6   | ns               | 1,2,3,4,<br>6,11 |  |
| CWL = 9,11  | CL = 10 | CL = 12                               | tCK(AVG)             | Reserved                                       |  | Reserved                      |                 | Reserved        |       | ns               | 4                |  |
|   | CL = 11 | CL = 13                               | tCK(AVG)             | Reserved                                       |  | 1.25                          | <1.5            | Reserved        |       | ns               | 1,2,3,4,<br>6    |  |
|   | CL = 12 | CL = 14                               | tCK(AVG)             | 1.25   | <1.5   | 1.25                          | <1.5            | 1.25            | <1.5  | ns               | 1,2,3,6          |  |
| CWL = 10,12   | CL = 12 | CL = 14                               | tCK(AVG)             | 1.071  | <1.25  | Reserved                      |                 | Reserved        |       | ns               | 1,2,3,4          |  |
|   | CL = 13 | CL = 15                               | tCK(AVG)             | 1.071  | <1.25  | 1.071                         | <1.25           | Reserved        |       | ns               | 1,2,3,4          |  |
|   | CL = 14 | CL = 16                               | tCK(AVG)             | 1.071  | <1.25  | 1.071                         | <1.25           | 1.071           | <1.25 | ns               | 1,2,3            |  |
| Supported CL Settings                                     |         |                                       | (9),10,12 ,13,14     |  | (9),(11),12,13,14                              |                               | 10,12,14        |                 | nCK   | 13,14            |                  |  |
| Supported CL Settings with read DBI                       |         |                                       | (11),12,13,14 ,14,16 |  | (11),(13),14 ,15,16                            |                               | 12,14,16        |                 | nCK   | 13               |                  |  |
| Supported CWL Settings                                    |         |                                       | 9,10,11,12           |  | 9,10,11,12                                     |                               | 9,10,11,12      |                 | nCK   |                  |                  |  |

## 10 Speed Bin (cont'd)

**Table 146 — DDR4-2133 Speed Bins and Operations**

| Speed Bin   |         |                                       | DDR4-2133N                 |  | DDR4-2133P                                     |                               | DDR4-2133R      |          | Unit  | NOTE             |  |  |
|---|---------|---------------------------------------|----------------------------|--|--|-------------------------------|-----------------|----------|-------|------------------|--|--|
| CL-nRCD-nRP   |         |                                       | 14-14-14                   |  | 15-15-15                                       |                               | 16-16-16        |          |       |                  |  |  |
| Parameter   |         | Symbol                                | min                        | max  | min  | max                           | min             | max      |       |                  |  |  |
| Internal read command to first data                       | tAA     |                                       | 13.13                      | 18.00  | 14.06 <sup>14</sup><br>(13.50) <sup>5,12</sup> | 18.00                         | 15.00           | 18.00    | ns    | 12               |  |  |
| Internal read command to first data with read DBI enabled | tAA_DBI | tAA(min) + 3nCK                       | tAA(max) + 3nCK            | tAA(min) + 3nCK                                | tAA(max) + 3nCK                                | tAA(min) + 3nCK               | tAA(max) + 3nCK | ns       | 12    |                  |  |  |
| ACT to internal read or write delay time                  | tRCD    | 13.13                                 | -                          | 14.06 <sup>14</sup><br>(13.50) <sup>5,12</sup> | -  | 15.00                         | -               | ns       | 12    |                  |  |  |
| PRE command period  | tRP     | 13.13                                 | -                          | 14.06 <sup>14</sup><br>(13.50) <sup>5,12</sup> | -  | 15.00                         | -               | ns       | 12    |                  |  |  |
| ACT to PRE command period                                 | tRAS    | 33                                    | 9 x tREFI                  | 33   | 9 x tREFI                                      | 33                            | 9 x tREFI       | ns       | 12    |                  |  |  |
| ACT to ACT or REF command period                          | tRC     | 46.13                                 | -                          | 47.06 <sup>14</sup><br>(46.50) <sup>5,12</sup> | -  | 48.00                         | -               | ns       | 12    |                  |  |  |
|   | Normal  | Read DBI                              |                            |  |  |                               |                 |          |       |                  |  |  |
| CWL = 9   | CL = 9  | CL = 11<br>(Optional) <sup>5,12</sup> | tCK(AVG)                   | 1.5  | 1.6  | 1.5                           | 1.6             | Reserved |       | 1,2,3,4<br>,7,11 |  |  |
|   |         |                                       | tCK(AVG)                   | (Optional) <sup>5,12</sup>                     |  | (Optional) <sup>5,12,14</sup> |                 | Reserved |       |                  |  |  |
| CWL = 9,11  | CL = 10 | CL = 12                               | tCK(AVG)                   | 1.5  | 1.6  | Reserved                      |                 | 1.5      | 1.6   | 1,2,3,4<br>,7,11 |  |  |
|   |         |                                       | tCK(AVG)                   | Reserved                                       |  | 1.25                          | <1.5            | Reserved |       |                  |  |  |
| CWL = 10,12   | CL = 12 | CL = 14                               | tCK(AVG)                   | 1.25   | <1.5   | 1.25                          | <1.5            | 1.25     | <1.5  | 1,2,3,7          |  |  |
|   |         |                                       | tCK(AVG)                   | Reserved                                       |  | 1.071                         | <1.25           | Reserved |       |                  |  |  |
| CWL = 11,14   | CL = 14 | CL = 16                               | tCK(AVG)                   | 1.071  | <1.25  | 1.071                         | <1.25           | 1.071    | <1.25 | 1,2,3,7          |  |  |
|   |         |                                       | tCK(AVG)                   | Reserved                                       |  | (Optional) <sup>5,12</sup>    | Reserved        |          |       |                  |  |  |
| Supported CL Settings                                     |         |                                       | (9),10,12,14,15,16         |  | (9),(11),12,(13),14,15,16                      |                               | 10,12,14,16     |          | nCK   | 13,14            |  |  |
| Supported CL Settings with read DBI                       |         |                                       | (11),12,14,16,17,18,<br>19 |  | (11),(13),14,(15),16,18,19                     |                               | 12,14,16,19     |          | nCK   | 13               |  |  |
| Supported CWL Settings                                    |         |                                       | 9,10,11,12,14              |  | 9,10,11,12,14                                  |                               | 9,10,11,12,14   |          | nCK   |                  |  |  |

## 10 Speed Bin (cont'd)

Table 147 — DDR4-2400 Speed Bins and Operations

| Speed Bin   |         | DDR4-2400P                               |                                | DDR4-2400R                 |                                    | DDR4-2400T                       |                                      | DDR4-2400U      |                  | Unit     | NOTE             |                        |
|---|---------|--|--------------------------------|----------------------------|------------------------------------|----------------------------------|--------------------------------------|-----------------|------------------|----------|------------------|------------------------|
| CL-nRCD-nRP   |         | 15-15-15                                 |                                | 16-16-16                   |                                    | 17-17-17                         |                                      | 18-18-18        |                  |          |                  |                        |
| Parameter   | Symbol  | min                                      | max                            | min                        | max                                | min                              | max                                  | min             | max              |          |                  |                        |
| Internal read command to first data                       | tAA     | 12.50                                    | 18.00                          | 13.32                      | 18.00                              | 14.16<br>(13.75) <sup>5,12</sup> | 18.00                                | 15.00           | 18.00            | ns       | 12               |                        |
| Internal read command to first data with read DBI enabled | tAA_DBI | tAA(min) + 3nCK                          | tAA(max) + 3nCK                | tAA(min) + 3nCK            | tAA(max) + 3nCK                    | tAA(min) + 3nCK                  | tAA(max) + 3nCK                      | tAA(min) + 3nCK | tAA(max) + 3nCK  | ns       | 12               |                        |
| ACT to internal read or write delay time                  | tRCD    | 12.50                                    | -                              | 13.32                      | -                                  | 14.16<br>(13.75) <sup>5,12</sup> | -                                    | 15.00           | -                | ns       | 12               |                        |
| PRE command period  | tRP     | 12.50                                    | -                              | 13.32                      | -                                  | 14.16<br>(13.75) <sup>5,12</sup> | -                                    | 15.00           | -                | ns       | 12               |                        |
| ACT to PRE command period                                 | tRAS    | 32                                       | 9 x tREFI                      | 32                         | 9 x tREFI                          | 32                               | 9 x tREFI                            | 32              | 9 x tREFI        | ns       | 12               |                        |
| ACT to ACT or REF command period                          | tRC     | 44.50                                    | -                              | 45.32                      | -                                  | 46.16<br>(45.75) <sup>5,12</sup> | -                                    | 47.00           | -                | ns       | 12               |                        |
|   | Normal  | Read DBI                                 |                                |                            |                                    |                                  |                                      |                 |                  |          |                  |                        |
| CWL = 9   | CL = 9  | CL = 11<br>(Optional)<br><sup>5,12</sup> | tCK(AVG)                       | 1.5                        | 1.6                                | 1.5                              | 1.6                                  | Reserved        |                  | Reserved | 1,2,3,4,<br>8,11 |                        |
|   |         |  |                                | (Optional) <sup>5,12</sup> |                                    | (Optional) <sup>5,12</sup>       |                                      |                 |                  |          |                  |                        |
|   | CL = 10 | CL = 12                                  |                                | 1.5                        | 1.6                                | Reserved                         |                                      | 1.5             | 1.6              | 1.5      | 1.6              | ns<br>1,2,3,4,<br>8,11 |
| CWL = 9,11  | CL = 10 | CL = 12                                  | tCK(AVG)                       | Reserved                   |                                    | Reserved                         |                                      | Reserved        |                  | ns       | 4                |                        |
|   | CL = 11 | CL = 13                                  | tCK(AVG)                       | Reserved                   |                                    | 1.25                             | <1.5                                 | 1.25            | <1.5             | Reserved |                  | ns<br>1,2,3,4,<br>8    |
|   | CL = 12 | CL = 14                                  | tCK(AVG)                       | 1.25                       | <1.5                               | 1.25                             | <1.5                                 | 1.25            | <1.5             | 1.25     | <1.5             | ns<br>1,2,3,8          |
| CWL = 10,12   | CL = 12 | CL = 14                                  | tCK(AVG)                       | Reserved                   |                                    | Reserved                         |                                      | Reserved        |                  | ns       | 4                |                        |
|   | CL = 13 | CL = 15                                  | tCK(AVG)                       | Reserved                   |                                    | 1.071                            | <1.25                                | 1.071           | <1.25            | Reserved |                  | ns<br>1,2,3,4,<br>8    |
|   | CL = 14 | CL = 16                                  | tCK(AVG)                       | 1.071                      | <1.25                              | 1.071                            | <1.25                                | 1.071           | <1.25            | 1.071    | <1.25            | ns<br>1,2,3,8          |
| CWL = 11,14   | CL = 14 | CL = 17                                  | tCK(AVG)                       | Reserved                   |                                    | Reserved                         |                                      | Reserved        |                  | ns       | 4                |                        |
|   | CL = 15 | CL = 18                                  | tCK(AVG)                       | Reserved                   |                                    | 0.937                            | <1.071                               | 0.937           | <1.071           | Reserved |                  | ns<br>1,2,3,4,<br>8    |
|   | CL = 16 | CL = 19                                  | tCK(AVG)                       | 0.937                      | <1.071                             | 0.937                            | <1.071                               | 0.937           | <1.071           | 0.937    | <1.071           | ns<br>1,2,3,8          |
| CWL = 12,16   | CL = 15 | CL = 18                                  | tCK(AVG)                       | 0.833                      | <0.937                             | Reserved                         |                                      | Reserved        |                  | Reserved |                  | ns<br>1,2,3,4          |
|   | CL = 16 | CL = 19                                  | tCK(AVG)                       | 0.833                      | <0.937                             | 0.833                            | <0.937                               | Reserved        |                  | Reserved |                  | ns<br>1,2,3,4          |
|   | CL = 17 | CL = 20                                  | tCK(AVG)                       | 0.833                      | <0.937                             | 0.833                            | <0.937                               | 0.833           | <0.937           | Reserved |                  | ns<br>1,2,3,4          |
|   | CL = 18 | CL = 21                                  | tCK(AVG)                       | 0.833                      | <0.937                             | 0.833                            | <0.937                               | 0.833           | <0.937           | 0.833    | <0.937           | ns<br>1,2,3            |
| Supported CL Settings                                     |         |  | (9),10,12,14,15,16,17,<br>18   |                            | (9),11,12,13,14,15,16<br>,17,18    |                                  | 10,(11),12,(13),14,(15),<br>16,17,18 |                 | 10,12,14,16,18   |          | nCK              | 13                     |
| Supported CL Settings with read DBI                       |         |  | (11),12,14,16,18,19,<br>,20,21 |                            | (11),13,14,15,16,18,1<br>,9,,20,21 |                                  | 12,(13),14,(15),16,(18),<br>19,20,21 |                 | 12,14,16,19,21   |          | nCK              | 13                     |
| Supported CWL Settings                                    |         |  | 9,10,11,12,14,16               |                            | 9,10,11,12,14,16                   |                                  | 9,10,11,12,14,16                     |                 | 9,10,11,12,14,16 |          | nCK              |                        |

10 Speed Bin (cont'd)

**Table 148 — DDR4-2666 Speed Bins and Operations**

| Speed Bin   |         |          | DDR4-2666T                             |                 | DDR4-2666U                             |                 | DDR4-2666V                               |                 | DDR4-2666W          |                            | Unit   | NOTE |              |  |
|---|---------|----------|--|-----------------|--|-----------------|--|-----------------|---------------------|----------------------------|--------|------|--------------|--|
| CL-nRCD-nRP   |         |          | 17-17-17                               |                 | 18-18-18                               |                 | 19-19-19                                 |                 | 20-20-20            |                            |        |      |              |  |
| Parameter   |         | Symbol   | min                                    | max             | min                                    | max             | min                                      | max             | min                 | max                        |        |      |              |  |
| Internal read command to first data                       |         | tAA      | 12.75                                  | 18.00           | 13.50                                  | 18.00           | 14.25 (13.75) <sup>5,12</sup>            | 18.00           | 15.00               | 18.00                      | ns     | 12   |              |  |
| Internal read command to first data with read DBI enabled |         | tAA_DBI  | tAA(min) + 3nCK                        | tAA(max) + 3nCK | tAA(min) + 3nCK                        | tAA(max) + 3nCK | tAA(min) + 3nCK                          | tAA(max) + 3nCK | tAA(min) + 3nCK     | tAA(max) + 3nCK            | ns     | 12   |              |  |
| ACT to internal read or write delay time                  |         | tRCD     | 12.75                                  | -               | 13.50                                  | -               | 14.25 (13.75) <sup>5,12</sup>            | -               | 15.00               | -                          | ns     | 12   |              |  |
| PRE command period  |         | tRP      | 12.75                                  | -               | 13.50                                  | -               | 14.25 (13.75) <sup>5,12</sup>            | -               | 15.00               | -                          | ns     | 12   |              |  |
| ACT to PRE command period                                 |         | tRAS     | 32                                     | 9 x tREFI       | 32                                     | 9 x tREFI       | 32                                       | 9 x tREFI       | 32                  | 9 x tREFI                  | ns     | 12   |              |  |
| ACT to ACT or REF command period                          |         | tRC      | 44.75                                  | -               | 45.5                                   | -               | 46.25 (45.75) <sup>5,12</sup>            | -               | 47.00               | -                          | ns     | 12   |              |  |
|   | Normal  | Read DBI |  |                 |  |                 |  |                 |                     |                            |        |      |              |  |
| CWL = 9   | CL = 9  | CL = 11  | tCK(AVG)                               | 1.5             | 1.6                                    | 1.5             | 1.6                                      | Reserved        |                     | Reserved                   |        | ns   | 1,2,3,4,9,11 |  |
|   | CL = 10 | CL = 12  | tCK(AVG)                               | 1.5             | 1.6                                    | 1.5             | 1.6                                      | 1.5             | 1.6                 | 1.5                        | 1.6    | ns   | 1,2,3,9,11   |  |
| CWL = 9,11  | CL = 10 | CL = 12  | tCK(AVG)                               | Reserved        |  | Reserved        |  | Reserved        |                     | Reserved                   |        | ns   | 4            |  |
|   | CL = 11 | CL = 13  | tCK(AVG)                               | 1.25            | <1.5                                   | 1.25            | <1.5                                     | 1.25            | <1.5                | (Optional) <sup>5,12</sup> |        | ns   | 1,2,3,4,9    |  |
|   | CL = 12 | CL = 14  | tCK(AVG)                               | 1.25            | <1.5                                   | 1.25            | <1.5                                     | 1.25            | <1.5                | 1.25                       | <1.5   |      | 1,2,3,9      |  |
| CWL = 10,12   | CL = 12 | CL = 14  | tCK(AVG)                               | Reserved        |  | Reserved        |  | Reserved        |                     | Reserved                   |        | ns   | 4            |  |
|   | CL = 13 | CL = 15  | tCK(AVG)                               | 1.071           | <1.25                                  | 1.071           | <1.25                                    | 1.071           | <1.25               | (Optional) <sup>5,12</sup> |        | ns   | 1,2,3,4,9    |  |
|   | CL = 14 | CL = 16  | tCK(AVG)                               | 1.071           | <1.25                                  | 1.071           | <1.25                                    | 1.071           | <1.25               | 1.071                      | <1.25  |      | 1,2,3,9      |  |
| CWL = 11,14   | CL = 14 | CL = 17  | tCK(AVG)                               | Reserved        |  | Reserved        |  | Reserved        |                     | Reserved                   |        | ns   | 4            |  |
|   | CL = 15 | CL = 18  | tCK(AVG)                               | 0.937           | <1.071                                 | 0.937           | <1.071                                   | 0.937           | <1.071              | (Optional) <sup>5,12</sup> |        | ns   | 1,2,3,4,9    |  |
|   | CL = 16 | CL = 19  | tCK(AVG)                               |                 |  |                 |  | 0.937           | <1.071              | 0.937                      | <1.071 |      | 1,2,3,9      |  |
| CWL = 12,16   | CL = 15 | CL = 18  | tCK(AVG)                               | Reserved        |  | Reserved        |  | Reserved        |                     | Reserved                   |        | ns   | 4            |  |
|   | CL = 16 | CL = 19  | tCK(AVG)                               | 0.833           | <0.937                                 | Reserved        |  | Reserved        |                     | Reserved                   |        | ns   | 1,2,3,4,9    |  |
|   | CL = 17 | CL = 20  | tCK(AVG)                               | 0.833           | <0.937                                 | 0.833           | <0.937                                   | 0.833           | <0.937              | (Optional) <sup>5,12</sup> |        | ns   | 1,2,3,4,9    |  |
|   | CL = 18 | CL = 21  | tCK(AVG)                               | 0.833           | <0.937                                 | 0.833           | <0.937                                   | 0.833           | <0.937              | 0.833                      | <0.937 |      | 1,2,3,9      |  |
| CWL = 14,18   | CL = 17 | CL = 20  | tCK(AVG)                               | 0.75            | <0.833                                 | Reserved        |  | Reserved        |                     | Reserved                   |        | ns   | 1,2,3,4      |  |
|   | CL = 18 | CL = 21  | tCK(AVG)                               | 0.75            | <0.833                                 | 0.75            | <0.833                                   | Reserved        |                     | Reserved                   |        | ns   | 1,2,3,4      |  |
|   | CL = 19 | CL = 22  | tCK(AVG)                               | 0.75            | <0.833                                 | 0.75            | <0.833                                   | 0.75            | <0.833              | Reserved                   |        | ns   | 1,2,3,4      |  |
|   | CL = 20 | CL = 23  | tCK(AVG)                               | 0.75            | <0.833                                 | 0.75            | <0.833                                   | 0.75            | <0.833              | 0.75                       | <0.833 | ns   | 1,2,3        |  |
| Supported CL Settings                                     |         |          | 9,10,11,12,13,14,15,16,17,18,19,20     |                 | 9,10,11,12,13,14,15,16,17,18,19,20     |                 | 10,(11),12,(13),14,(15),16,(17),18,19,20 |                 | 10,12,14,16,18,20   |                            | nCK    | 13   |              |  |
| Supported CL Settings with read DBI                       |         |          | 11,12,13,14,15,16,17,18,19,20,21,22,23 |                 | 11,12,13,14,15,16,17,18,19,20,21,22,23 |                 | 12,(13),14,(15),17,(18),19,(20),21,22,23 |                 | 12,14,16,19,21,23   |                            | nCK    | 13   |              |  |
| Supported CWL Settings                                    |         |          | 9,10,11,12,14,16,18                    |                 | 9,10,11,12,14,16,18                    |                 | 9,10,11,12,14,16,18                      |                 | 9,10,11,12,14,16,18 |                            | nCK    |      |              |  |

## 10 Speed Bin (cont'd)

Table 149 — DDR4-2933 Speed Bins and Operations

| Speed Bin   |         |          | DDR4-2933V                                   |   | DDR4-2933W  |                        | DDR4-2933Y                       |                 | DDR4-2933AA     |                            | Unit   | NOTE     |               |    |            |
|---|---------|----------|--|---|---|------------------------|----------------------------------|-----------------|-----------------|----------------------------|--------|----------|---------------|----|------------|
| CL-nRCD-nRP   |         |          | 19-19-19                                     |   | 20-20-20  |                        | 21-21-21                         |                 | 22-22-22        |                            |        |          |               |    |            |
| Parameter   |         | Symbol   | min  | max                                       | min   | max                    | min                              | max             | min             | max                        |        |          |               |    |            |
| Internal read command to first data                       |         | tAA      | 12.96  | 18.00                                     | 13.64   | 18.00                  | 14.32<br>(13.75) <sup>5,12</sup> | 18.00           | 15.00           | 18.00                      | ns     | 12       |               |    |            |
| Internal read command to first data with read DBI enabled |         | tAA_DBI  | tAA(min) + 4nCK                              | tAA(max) + 4nCK                           | tAA(min) + 4nCK                                   | tAA(max) + 4nCK        | tAA(min) + 4nCK                  | tAA(max) + 4nCK | tAA(min) + 4nCK | tAA(max) + 4nCK            | ns     | 12       |               |    |            |
| ACT to internal read or write delay time                  |         | tRCD     | 12.96  | -   | 13.64   | -                      | 14.32<br>(13.75) <sup>5,12</sup> | -               | 15.00           | -                          | ns     | 12       |               |    |            |
| PRE command period  |         | tRP      | 12.96  | -   | 13.64   | -                      | 14.32<br>(13.75) <sup>5,12</sup> | -               | 15.00           | -                          | ns     | 12       |               |    |            |
| ACT to PRE command period                                 |         | tRAS     | 32   | 9 x tREFI                                 | 32  | 9 x tREFI              | 32                               | 9 x tREFI       | 32              | 9 x tREFI                  | ns     | 12       |               |    |            |
| ACT to ACT or REF command period                          |         | tRC      | 44.96  | -   | 45.64   | -                      | 46.32<br>(45.75) <sup>5,12</sup> | -               | 47.00           | -                          | ns     | 12       |               |    |            |
|   | Normal  | Read DBI |  |   |   |                        |                                  |                 |                 |                            |        |          |               |    |            |
| CWL = 9   | CL = 9  | CL = 11  | tCK(AVG)                                     | 1.5                                       | 1.6   | Reserved               |                                  | Reserved        |                 | Reserved                   |        | ns       | 1,2,3,4,11,15 |    |            |
|   | CL = 10 | CL = 12  | tCK(AVG)                                     | 1.5                                       | 1.6   | 1.5                    | 1.6                              | 1.5             | 1.6             | 1.5                        | 1.6    | ns       | 1,2,3,11,15   |    |            |
| CWL = 9,11  | CL = 10 | CL = 12  | tCK(AVG)                                     | Reserved                                  |   | Reserved               |                                  | Reserved        |                 | Reserved                   |        | ns       | 4             |    |            |
|   | CL = 11 | CL = 13  | tCK(AVG)                                     | 1.25                                      | <1.5  | 1.25                   | <1.5                             | 1.25            | <1.5            | (Optional) <sup>5,12</sup> |        | Reserved |               | ns | 15         |
|   | CL = 12 | CL = 14  | tCK(AVG)                                     | 1.25                                      | <1.5  | 1.25                   | <1.5                             | 1.25            | <1.5            |                            |        | 1.25     | <1.5          | ns | 1,2,3,15   |
| CWL = 10,12   | CL = 12 | CL = 14  | tCK(AVG)                                     | Reserved                                  |   | Reserved               |                                  | Reserved        |                 | Reserved                   |        | ns       | 4             |    |            |
|   | CL = 13 | CL = 15  | tCK(AVG)                                     | 1.071                                     | <1.25   | 1.071                  | <1.25                            | 1.071           | <1.25           | (Optional) <sup>5,12</sup> |        | Reserved |               | ns | 1,2,3,4,15 |
|   | CL = 14 | CL = 16  | tCK(AVG)                                     | 1.071                                     | <1.25   | 1.071                  | <1.25                            | 1.071           | <1.25           | 1.071                      | <1.25  | ns       | 1,2,3,15      |    |            |
| CWL = 11,14   | CL = 14 | CL = 17  | tCK(AVG)                                     | Reserved                                  |   | Reserved               |                                  | Reserved        |                 | Reserved                   |        | ns       | 4             |    |            |
|   | CL = 15 | CL = 18  | tCK(AVG)                                     | 0.937                                     | <1.071  | 0.937                  | <1.071                           | 0.937           | <1.071          | (Optional) <sup>5,12</sup> |        | Reserved |               | ns | 1,2,3,4,15 |
|   | CL = 16 | CL = 19  | tCK(AVG)                                     | 0.937                                     | <1.071  | 0.937                  | <1.071                           | 0.937           | <1.071          | 0.937                      | <1.071 | ns       | 1,2,3,15      |    |            |
| CWL = 12,16   | CL = 15 | CL = 18  | tCK(AVG)                                     | Reserved                                  |   | Reserved               |                                  | Reserved        |                 | Reserved                   |        | ns       | 4             |    |            |
|   | CL = 16 | CL = 19  | tCK(AVG)                                     | 0.833                                     | <0.937  | Reserved               |                                  | Reserved        |                 | Reserved                   |        | ns       | 1,2,3,4,15    |    |            |
|   | CL = 17 | CL = 20  | tCK(AVG)                                     | 0.833                                     | <0.937  | 0.833                  | <0.937                           | 0.833           | <0.937          | (Optional) <sup>5,12</sup> |        | Reserved |               | ns | 1,2,3,4,15 |
|   | CL = 18 | CL = 21  | tCK(AVG)                                     | 0.833                                     | <0.937  | 0.833                  | <0.937                           | 0.833           | <0.937          | 0.833                      | <0.937 | ns       | 1,2,3,15      |    |            |
| CWL = 14,18   | CL = 17 | CL = 20  | tCK(AVG)                                     | Reserved                                  |   | Reserved               |                                  | Reserved        |                 | Reserved                   |        | ns       | 4             |    |            |
|   | CL = 18 | CL = 21  | tCK(AVG)                                     | 0.75                                      | <0.833  | Reserved               |                                  | Reserved        |                 | Reserved                   |        | ns       | 1,2,3,4,15    |    |            |
|   | CL = 19 | CL = 22  | tCK(AVG)                                     | 0.75                                      | <0.833  | 0.75                   | <0.833                           | 0.75            | <0.833          | (Optional) <sup>5,12</sup> |        | Reserved |               | ns | 1,2,3,4,15 |
|   | CL = 20 | CL = 23  | tCK(AVG)                                     | 0.75                                      | <0.833  | 0.75                   | <0.833                           | 0.75            | <0.833          | 0.75                       | <0.833 | ns       | 1,2,3,15      |    |            |
| CWL = 16,20   | CL = 19 | CL = 23  | tCK(AVG)                                     | 0.682                                     | <0.75   | Reserved               |                                  | Reserved        |                 | Reserved                   |        | ns       | 1,2,3,4       |    |            |
|   | CL = 20 | CL = 24  | tCK(AVG)                                     | 0.682                                     | <0.75   | 0.682                  | <0.75                            | 0.682           | <0.75           | Reserved                   |        | Reserved |               | ns | 1,2,3,4    |
|   | CL = 21 | CL = 25  | tCK(AVG)                                     | 0.682                                     | <0.75   | 0.682                  | <0.75                            | 0.682           | <0.75           | 0.682                      | <0.75  | ns       | 1,2,3,4       |    |            |
|   | CL = 22 | CL = 26  | tCK(AVG)                                     | 0.682                                     | <0.75   | 0.682                  | <0.75                            | 0.682           | <0.75           | 0.682                      | <0.75  | ns       | 1,2,3         |    |            |
| Supported CL Settings                                     |         |          | 9,10,11,12,13,14,1,5,16,17,18,19,20,2,1,22   | 10,11,12,13,14,15,16,17,18,19,20,21,22    | 10,(11),12,(13),14,(1,5),16,(17),18,(19),20,21,22 | 10,12,14,16,18,20,22   | nCK                              | 13              |                 |                            |        |          |               |    |            |
| Supported CL Settings with read DBI                       |         |          | 11,12,13,14,15,16,18,19,20,21,22,23,24,25,26 | 12,13,14,15,16,18,19,20,21,22,23,24,25,26 | 12,(13),14,(15),16,(1,8),19,(20),21,(22),23,25,26 | 12,14,16,19,21,23,26   | nCK                              | 13              |                 |                            |        |          |               |    |            |
| Supported CWL Settings                                    |         |          | 9,10,11,12,14,16,18,20                       | 9,10,11,12,14,16,18,20                    | 9,10,11,12,14,16,18,20                            | 9,10,11,12,14,16,18,20 | nCK                              |                 |                 |                            |        |          |               |    |            |

## 10 Speed Bin (cont'd)

Table 150 — DDR4-3200 Speed Bins and Operations

| Speed Bin   |         |          | DDR4-3200W                                      |                 | DDR4-3200AA                               |                 | DDR4-3200AC             |                 | Unit   | NOTE             |
|---|---------|----------|---|-----------------|---|-----------------|-------------------------|-----------------|--------|------------------|
| CL-nRCD-nRP   |         |          | 20-20-20  |                 | 22-22-22                                  |                 | 24-24-24                |                 |        |                  |
| Parameter   | Symbol  |          | min   | max             | min                                       | max             | min                     | max             |        |                  |
| Internal read command to first data                       | tAA     |          | 12.50   | 18.00           | 13.75                                     | 18.00           | 15.00                   | 18.00           | ns     | 12               |
| Internal read command to first data with read DBI enabled | tAA_DB1 |          | tAA(min) + 4nCK                                 | tAA(max) + 4nCK | tAA(min) + 4nCK                           | tAA(max) + 4nCK | tAA(min) + 4nCK         | tAA(max) + 4nCK | ns     | 12               |
| ACT to internal read or write delay time                  | tRCD    |          | 12.50   | -               | 13.75                                     | -               | 15.00                   | -               | ns     | 12               |
| PRE command period  | tRP     |          | 12.50   | -               | 13.75                                     | -               | 15.00                   | -               | ns     | 12               |
| ACT to PRE command period                                 | tRAS    |          | 32  | 9 x tREFI       | 32  | 9 x tREFI       | 32                      | 9 x tREFI       | ns     | 12               |
| ACT to ACT or REF command period                          | tRC     |          | 44.50   | -               | 45.75                                     | -               | 47.00                   | -               | ns     | 12               |
|   | Normal  | Read DBI |   |                 |   |                 |                         |                 |        |                  |
| CWL = 9   | CL = 9  | CL = 11  | tCK(AVG)  | 1.5             | 1.6                                       | Reserved        |                         | Reserved        |        | ns 1,2,3,4,10,11 |
|   | CL = 10 | CL = 12  | tCK(AVG)  | 1.5             | 1.6                                       | 1.5             | 1.6                     | 1.5             | 1.6    | ns 1,2,3,10,11   |
| CWL = 9,11  | CL = 10 | CL = 12  | tCK(AVG)  | Reserved        |   | Reserved        |                         | Reserved        |        | ns 4             |
|   | CL = 11 | CL = 13  | tCK(AVG)  | 1.25            | <1.5                                      | 1.25            | <1.5                    | Reserved        |        | ns 1,2,3,4,10    |
|   | CL = 12 | CL = 14  | tCK(AVG)  | 1.25            | <1.5                                      | 1.25            | <1.5                    | 1.25            | <1.5   | ns 1,2,3,10      |
| CWL = 10,12   | CL = 12 | CL = 14  | tCK(AVG)  | Reserved        |   | Reserved        |                         | Reserved        |        | ns 4             |
|   | CL = 13 | CL = 15  | tCK(AVG)  | 1.071           | <1.25                                     | 1.071           | <1.25                   | Reserved        |        | ns 1,2,3,4,10    |
|   | CL = 14 | CL = 16  | tCK(AVG)  | 1.071           | <1.25                                     | 1.071           | <1.25                   | 1.071           | <1.25  | ns 1,2,3,10      |
| CWL = 11,14   | CL = 14 | CL = 17  | tCK(AVG)  | Reserved        |   | Reserved        |                         | Reserved        |        | ns 4             |
|   | CL = 15 | CL = 18  | tCK(AVG)  | 0.937           | <1.071                                    | 0.937           | <1.071                  | Reserved        |        | ns 1,2,3,4,10    |
|   | CL = 16 | CL = 19  | tCK(AVG)  | 0.937           | <1.071                                    | 0.937           | <1.071                  | 0.937           | <1.071 | ns 1,2,3,10      |
| CWL = 12,16   | CL = 15 | CL = 18  | tCK(AVG)  | Reserved        |   | Reserved        |                         | Reserved        |        | ns 4             |
|   | CL = 16 | CL = 19  | tCK(AVG)  | 0.833           | <0.937                                    | Reserved        |                         | Reserved        |        | ns 1,2,3,4,10    |
|   | CL = 17 | CL = 20  | tCK(AVG)  | 0.833           | <0.937                                    | 0.833           | <0.937                  | Reserved        |        | ns 1,2,3,4,10    |
|   | CL = 18 | CL = 21  | tCK(AVG)  | 0.833           | <0.937                                    | 0.833           | <0.937                  | 0.833           | <0.937 | ns 1,2,3,10      |
| CWL = 14,18   | CL = 17 | CL = 20  | tCK(AVG)  | Reserved        |   | Reserved        |                         | Reserved        |        | ns 4             |
|   | CL = 18 | CL = 21  | tCK(AVG)  | 0.75            | <0.833                                    | Reserved        |                         | Reserved        |        | ns 1,2,3,4,10    |
|   | CL = 19 | CL = 22  | tCK(AVG)  | 0.75            | <0.833                                    | 0.75            | <0.833                  | Reserved        |        | ns 1,2,3,4,10    |
|   | CL = 20 | CL = 23  | tCK(AVG)  | 0.75            | <0.833                                    | 0.75            | <0.833                  | 0.75            | <0.833 | ns 1,2,3,10      |
| CWL = 16,20   | CL=20   | CL=24    | tCK(AVG)  | 0.682           | <0.75                                     | Reserved        |                         | Reserved        |        | ns 1,2,3,4,10    |
|   | CL=21   | CL=25    | tCK(AVG)  | 0.682           | <0.75                                     | 0.682           | <0.75                   | Reserved        |        | ns 1,2,3,4,10    |
|   | CL=22   | CL=26    | tCK(AVG)  | 0.682           | <0.75                                     | 0.682           | <0.75                   | 0.682           | <0.75  | ns 1,2,3,10      |
|   | CL=24   | CL=28    | tCK(AVG)  | 0.682           | <0.75                                     | 0.682           | <0.75                   | 0.682           | <0.75  | ns 1,2,3,10      |
| CWL = 16,20   | CL = 20 | CL = 24  | tCK(AVG)  | 0.625           | <0.682                                    | Reserved        |                         | Reserved        |        | ns 1,2,3,4       |
|   | CL = 22 | CL = 26  | tCK(AVG)  | 0.625           | <0.682                                    | 0.625           | <0.682                  | Reserved        |        | ns 1,2,3,4       |
|   | CL = 24 | CL = 28  | tCK(AVG)  | 0.625           | <0.682                                    | 0.625           | <0.682                  | 0.625           | <0.682 | ns 1,2,3         |
| Supported CL Settings                                     |         |          | 9,10,11,12,13,14,15,16,17,18,19,20,21,22,24     |                 | 10,11,12,13,14,15,16,17,18,19,20,21,22,24 |                 | 10,12,14,16,18,20,22,24 |                 | nCK    |                  |
| Supported CL Settings with read DBI                       |         |          | 11,12,13,14,15,16,18,19,20,21,22,23,24,25,26,28 |                 | 12,13,14,15,16,18,19,20,21,22,23,25,26,28 |                 | 12,14,16,19,21,23,26,28 |                 | nCK    |                  |
| Supported CWL Settings                                    |         |          | 9,10,11,12,14,16,18,20                          |                 | 9,10,11,12,14,16,18,20                    |                 | 9,10,11,12,14,16,18,20  |                 | nCK    |                  |

## 10.1 Speed Bin Table Notes

### Absolute Specification

- VDDQ = VDD = 1.20V +/- 0.06 V
- VPP = 2.5V +0.25/-0.125 V
- The values defined with above-mentioned table are DLL ON case.
- DDR4-1600, 1866, 2133 and 2400 Speed Bin Tables are valid only when Geardown Mode is disabled.

NOTE 1 The CL setting and CWL setting result in tCK(avg).MIN and tCK(avg).MAX requirements. When making a selection of tCK(avg), both need to be fulfilled: Requirements from CL setting as well as requirements from CWL setting.

NOTE 2 tCK(avg).MIN limits: Since CAS Latency is not purely analog - data and strobe output are synchronized by the DLL - all possible intermediate frequencies may not be guaranteed. CL in clock cycle is calculated from tAA following rounding algorithm defined in Section 13.5.

NOTE 3 tCK(avg).MAX limits: Calculate  $tCK(\text{avg}) = tAA.\text{MAX} / \text{CL SELECTED}$  and round the resulting tCK(avg) down to the next valid speed bin (i.e., 1.5ns or 1.25ns or 1.071 ns or 0.937 ns or 0.833 ns). This result is tCK(avg).MAX corresponding to CL SELECTED.

NOTE 4 'Reserved' settings are not allowed. User must program a different value.

NOTE 5 'Optional' settings allow certain devices in the industry to support this setting, however, it is not a mandatory feature. Any combination of the 'optional' CL's is supported. The associated 'optional' tAA, tRCD, tRP, and tRC values must be adjusted based upon the CL combination supported. Refer to supplier's data sheet and/or the DIMM SPD information if and how this setting is supported.

NOTE 6 Any DDR4-1866 speed bin also supports functional operation at lower frequencies as shown in the table which are not subject to Production Tests but verified by Design/Characterization.

NOTE 7 Any DDR4-2133 speed bin also supports functional operation at lower frequencies as shown in the table which are not subject to Production Tests but verified by Design/Characterization.

NOTE 8 Any DDR4-2400 speed bin also supports functional operation at lower frequencies as shown in the table which are not subject to Production Tests but verified by Design/Characterization.

NOTE 9 Any DDR4-2666 speed bin also supports functional operation at lower frequencies as shown in the table which are not subject to Production Tests but verified by Design/Characterization.

NOTE 10 Any DDR4-3200 speed bin also supports functional operation at lower frequencies as shown in the table which are not subject to Production Tests but verified by Design/Characterization.

NOTE 11 DDR4-1600 AC timing apply if DRAM operates at lower than 1600 MT/s data rate.

NOTE 12 Parameters apply from tCK(avg)min to tCK(avg)max at all standard JEDEC clock period values as stated in the Speed Bin Tables.

NOTE 13 CL number in parentheses, it means that these numbers are optional.

NOTE 14 DDR4 SDRAM supports CL=9 as long as a system meets tAA(min), tRCD(min), tRP(min), and tRC(min).

NOTE 15 Any DDR4-2933 speed bin also supports functional operation at lower frequencies as shown in the table which are not subject to Production Tests but verified by Design/Characterization.

NOTE 16 Each speed bin lists the timing requirements that need to be supported in order for a given DRAM to be JEDEC compliant. JEDEC compliance does not require support for all speed bins within a given speed. JEDEC compliance requires meeting the parameters for at least one of the listed speed bins.

NOTE 17 Any DDR4-1600 speed bin also supports functional operation at lower frequencies as shown in the table which are not subject to Production Tests but verified by Design/Characterization.

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## 11 IDD and IDDQ Specification Parameters and Test conditions

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### 11.1 IDD, IPP and IDDQ Measurement Conditions

In this chapter, IDD, IPP and IDDQ measurement conditions such as test load and patterns are defined. Figure 224 shows the setup and test load for IDD, IPP and IDDQ measurements.

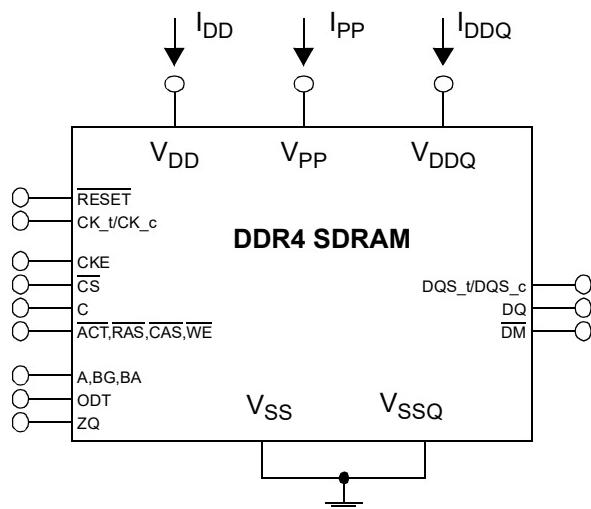
- IDD currents (such as IDD0, IDD0A, IDD1, IDD1A, IDD2N, IDD2NA, IDD2NL, IDD2NT, IDD2P, IDD2Q, IDD3N, IDD3NA, IDD3P, IDD4R, IDD4RA, IDD4W, IDD4WA, IDD5B, IDD5F2, IDD5F4, IDD6N, IDD6E, IDD6R, IDD6A, IDD7 and IDD8) are measured as time-averaged currents with all VDD balls of the DDR4 SDRAM under test tied together. Any IPP or IDDQ current is not included in IDD currents.
- IPP currents have the same definition as IDD except that the current on the VPP supply is measured.
- IDDQ currents (such as IDDQ2NT and IDDQ4R) are measured as time-averaged currents with all VDDQ balls of the DDR4 SDRAM under test tied together. Any IDD current is not included in IDDQ currents.

Attention: IDDQ values cannot be directly used to calculate IO power of the DDR4 SDRAM. They can be used to support correlation of simulated IO power to actual IO power as outlined in Figure 225. In DRAM module application, IDDQ cannot be measured separately since VDD and VDDQ are using one merged-power layer in Module PCB.

For IDD, IPP and IDDQ measurements, the following definitions apply:

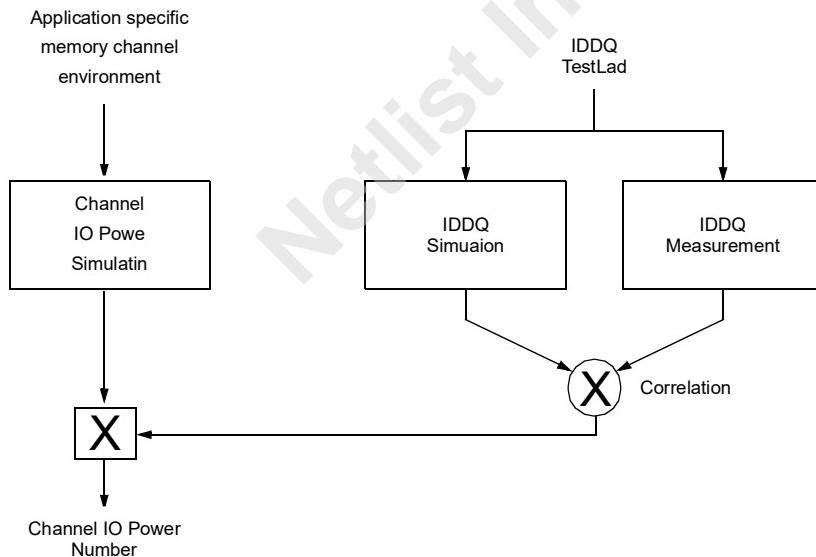
- "0" and "LOW" is defined as  $VIN \leq VILAC(\max)$ .
- "1" and "HIGH" is defined as  $VIN \geq VIHAC(\min)$ .
- "MID-LEVEL" is defined as inputs are  $VREF = VDD / 2$ .
- Timings used for IDD, IPP and IDDQ Measurement-Loop Patterns are provided in Table 151.
- Basic IDD, IPP and IDDQ Measurement Conditions are described in Table .
- Detailed IDD, IPP and IDDQ Measurement-Loop Patterns are described in Table 153 through Table 161.
- IDD Measurements are done after properly initializing the DDR4 SDRAM. This includes but is not limited to setting  $RON = RZQ/7$  (34 Ohm in MR1);  
 $RTT\_NOM = RZQ/6$  (40 Ohm in MR1);  
 $RTT\_WR = RZQ/2$  (120 Ohm in MR2);  
 $RTT\_PARK = \text{Disable}$ ;  
 $Qoff = 0_B$  (Output Buffer enabled) in MR1;  
 $TDQS_t$  disabled in MR1;  
 $CRC$  disabled in MR2;  
 $CA$  parity feature disabled in MR5;  
 $Gear down mode$  disabled in MR3  
 $Read/Write DBI$  disabled in MR5;  
 $DM$  disabled in MR5
- Attention: The IDD, IPP and IDDQ Measurement-Loop Patterns need to be executed at least one time before actual IDD or IDDQ measurement is started.
- Define  $D = \{CS_n, ACT_n, RAS_n, CAS_n, WE_n\} := \{\text{HIGH}, \text{LOW}, \text{LOW}, \text{LOW}, \text{LOW}\}$ ; apply BG/BA changes when directed.
- Define  $D\# = \{CS_n, ACT_n, RAS_n, CAS_n, WE_n\} := \{\text{HIGH}, \text{HIGH}, \text{HIGH}, \text{HIGH}, \text{HIGH}\}$ ; apply invert of BG/BA changes when directed above.

## 11.1 IDD, IPP and IDDQ Measurement Conditions (cont'd)



NOTE 1 DIMM level Output test load condition may be different from above

**Figure 224 — Measurement Setup and Test Load for IDD, IPP and IDDQ Measurements**



**Figure 225 — Correlation from simulated Channel IO Power to actual Channel IO Power supported by IDDQ Measurement.**

11.1 IDD, IPP and IDDQ Measurement Conditions (cont'd)

**Table 151 — Timings used for IDD, IPP and IDDQ Measurement-Loop Patterns**

| Symbol    | DDR4-1600 |          |          | DDR4-1866 |          |          | DDR4-2133 |          |          | DDR4-2400 |          |          | Unit     |     |
|-----------|-----------|----------|----------|-----------|----------|----------|-----------|----------|----------|-----------|----------|----------|----------|-----|
|           | 10-10-10  | 11-11-11 | 12-12-12 | 12-12-12  | 13-13-13 | 14-14-14 | 14-14-14  | 15-15-15 | 16-16-16 | 15-15-15  | 16-16-16 | 17-17-17 | 18-18-18 |     |
| tCK       | 1.25      |          |          | 1.071     |          |          | 0.937     |          |          | 0.833     |          |          | ns       |     |
| CL        | 10        | 11       | 12       | 12        | 13       | 14       | 14        | 15       | 16       | 15        | 16       | 17       | 18       | nCK |
| CWL       | 9         | 11       | 11       | 10        | 12       | 12       | 11        | 14       | 14       | 12        | 16       | 16       | 16       | nCK |
| nRCD      | 10        | 11       | 12       | 12        | 13       | 14       | 14        | 15       | 16       | 15        | 16       | 17       | 18       | nCK |
| nRC       | 38        | 39       | 40       | 44        | 45       | 46       | 50        | 51       | 52       | 54        | 55       | 56       | 57       | nCK |
| nRAS      | 28        |          |          | 32        |          |          | 36        |          |          | 39        |          |          | nCK      |     |
| nRP       | 10        | 11       | 12       | 12        | 13       | 14       | 14        | 15       | 16       | 15        | 16       | 17       | 18       | nCK |
| nFAW      | x4        | 16       |          |           | 16       |          |           | 16       |          |           | 16       |          |          | nCK |
|           | x8        | 20       |          |           | 22       |          |           | 23       |          |           | 26       |          |          | nCK |
|           | x16       | 28       |          |           | 28       |          |           | 32       |          |           | 36       |          |          | nCK |
| nRRDS     | x4        | 4        |          |           | 4        |          |           | 4        |          |           | 4        |          |          | nCK |
|           | x8        | 4        |          |           | 4        |          |           | 4        |          |           | 4        |          |          | nCK |
|           | x16       | 5        |          |           | 6        |          |           | 6        |          |           | 7        |          |          | nCK |
| nRRDL     | x4        | 5        |          |           | 5        |          |           | 6        |          |           | 6        |          |          | nCK |
|           | x8        | 5        |          |           | 5        |          |           | 6        |          |           | 6        |          |          | nCK |
|           | x16       | 6        |          |           | 6        |          |           | 7        |          |           | 8        |          |          | nCK |
| tCCD_S    | 4         |          |          | 4         |          |          | 4         |          |          | 4         |          |          | nCK      |     |
| tCCD_L    | 5         |          |          | 5         |          |          | 6         |          |          | 6         |          |          | nCK      |     |
| tWTR_S    | 2         |          |          | 3         |          |          | 3         |          |          | 3         |          |          | nCK      |     |
| tWTR_L    | 6         |          |          | 7         |          |          | 8         |          |          | 9         |          |          | nCK      |     |
| nRFC 2Gb  | 128       |          |          | 150       |          |          | 171       |          |          | 193       |          |          | nCK      |     |
| nRFC 4Gb  | 208       |          |          | 243       |          |          | 278       |          |          | 313       |          |          | nCK      |     |
| nRFC 8Gb  | 280       |          |          | 327       |          |          | 374       |          |          | 421       |          |          | nCK      |     |
| nRFC 16Gb | 440       |          |          | 514       |          |          | 587       |          |          | 661       |          |          | nCK      |     |
| TBD       |           |          |          |           |          |          |           |          |          |           |          |          | nCK      |     |

11.1 IDD, IPP and IDDQ Measurement Conditions (cont'd)

**Table 151 — Timings used for IDD, IPP and IDDQ Measurement-Loop Patterns (cont'd)**

| Symbol    | DDR4-2666 |          |          |          | DDR4-2933 |          |          |          | DDR4-3200 |          |          |  | Unit |     |
|-----------|-----------|----------|----------|----------|-----------|----------|----------|----------|-----------|----------|----------|--|------|-----|
|           | 17-17-17  | 18-18-18 | 19-19-19 | 20-20-20 | 19-19-19  | 20-20-20 | 21-21-21 | 22-22-22 | 20-20-20  | 22-22-22 | 24-24-24 |  |      |     |
| tCK       | 0.75      |          |          |          | 0.682     |          |          |          | 0.625     |          |          |  | ns   |     |
| CL        | 17        | 18       | 19       | 20       | 19        | 20       | 21       | 22       | 20        | 22       | 24       |  | nCK  |     |
| CWL       | 16        | 16       | 18       | 18       | 18        | 18       | 20       | 20       | 18        | 20       | 20       |  | nCK  |     |
| nRCD      | 17        | 18       | 19       | 20       | 19        | 20       | 21       | 22       | 20        | 22       | 24       |  | nCK  |     |
| nRC       | 60        | 61       | 62       | 63       | 66        | 67       | 68       | 69       | 72        | 74       | 76       |  | nCK  |     |
| nRAS      | 43        |          |          |          | 47        |          |          |          | 52        |          |          |  | nCK  |     |
| nRP       | 17        | 18       | 19       | 20       | 19        | 20       | 21       | 22       | 20        | 22       | 24       |  | nCK  |     |
| nFAW      | x4        | 16       |          |          |           | 16       |          |          |           | 16       |          |  |      | nCK |
|           | x8        | 28       |          |          |           | 31       |          |          |           | 34       |          |  |      | nCK |
|           | x16       | 40       |          |          |           | 44       |          |          |           | 48       |          |  |      | nCK |
| nRRDS     | x4        | 4        |          |          |           | 4        |          |          |           | 4        |          |  |      | nCK |
|           | x8        | 4        |          |          |           | 4        |          |          |           | 4        |          |  |      | nCK |
|           | x16       | 8        |          |          |           | 8        |          |          |           | 9        |          |  |      | nCK |
| nRRDL     | x4        | 7        |          |          |           | 8        |          |          |           | 8        |          |  |      | nCK |
|           | x8        | 7        |          |          |           | 8        |          |          |           | 8        |          |  |      | nCK |
|           | x16       | 9        |          |          |           | 10       |          |          |           | 11       |          |  |      | nCK |
| tCCD_S    | 4         |          |          |          | 4         |          |          |          | 4         |          |          |  | nCK  |     |
| tCCD_L    | 7         |          |          |          | 8         |          |          |          | 8         |          |          |  | nCK  |     |
| tWTR_S    | 4         |          |          |          | 4         |          |          |          | 4         |          |          |  | nCK  |     |
| tWTR_L    | 10        |          |          |          | 11        |          |          |          | 12        |          |          |  | nCK  |     |
| nRFC 2Gb  | 214       |          |          |          | 235       |          |          |          | 256       |          |          |  | nCK  |     |
| nRFC 4Gb  | 347       |          |          |          | 382       |          |          |          | 416       |          |          |  | nCK  |     |
| nRFC 8Gb  | 467       |          |          |          | 514       |          |          |          | 560       |          |          |  | nCK  |     |
| nRFC 16Gb | 734       |          |          |          | 807       |          |          |          | 880       |          |          |  | nCK  |     |
| TBD       |           |          |          |          |           |          |          |          |           |          |          |  |      |     |

11.1 IDD, IPP and IDDQ Measurement Conditions (cont'd)

**Table 152 — Basic IDD, IPP and IDDQ Measurement Conditions**

| Symbol                | Description   |
|-----------------------|---|
| IDD0                  | <b>Operating One Bank Active-Precharge Current (AL=0)</b><br><b>CKE:</b> High; <b>External clock:</b> On; <b>tCK, nRC, nRAS, CL:</b> see Table 151; <b>BL:</b> 8 <sup>1</sup> ; <b>AL:</b> 0; <b>CS_n:</b> High between ACT and PRE; <b>Command, Address, Bank Group Address, Bank Address Inputs:</b> partially toggling according to Table 153; <b>Data IO:</b> VDDQ; <b>DM_n:</b> stable at 1; <b>Bank Activity:</b> Cycling with one bank active at a time: 0,0,1,1,2,2,... (see Table 153); <b>Output Buffer and RTT:</b> Enabled in Mode Registers <sup>2</sup> ; <b>ODT Signal:</b> stable at 0; <b>Pattern Details:</b> see Table 153   |
| IDD0A                 | <b>Operating One Bank Active-Precharge Current (AL=CL-1)</b><br><b>AL = CL-1, Other conditions:</b> see IDD0  |
| IPP0                  | <b>Operating One Bank Active-Precharge IPP Current</b><br><b>Same condition with IDD0</b>   |
| IDD1                  | <b>Operating One Bank Active-Read-Precharge Current (AL=0)</b><br><b>CKE:</b> High; <b>External clock:</b> On; <b>tCK, nRC, nRAS, nRCD, CL:</b> see Table 151; <b>BL:</b> 8 <sup>1</sup> ; <b>AL:</b> 0; <b>CS_n:</b> High between ACT, RD and PRE; <b>Command, Address, Bank Group Address, Bank Address Inputs, Data IO:</b> partially toggling according to Table 154; <b>DM_n:</b> stable at 1; <b>Bank Activity:</b> Cycling with one bank active at a time: 0,0,1,1,2,2,... (see Table 154); <b>Output Buffer and RTT:</b> Enabled in Mode Registers <sup>2</sup> ; <b>ODT Signal:</b> stable at 0; <b>Pattern Details:</b> see Table 154 |
| IDD1A                 | <b>Operating One Bank Active-Read-Precharge Current (AL=CL-1)</b><br><b>AL = CL-1, Other conditions:</b> see IDD1   |
| IPP1                  | <b>Operating One Bank Active-Read-Precharge IPP Current</b><br><b>Same condition with IDD1</b>  |
| IDD2N                 | <b>Precharge Standby Current (AL=0)</b><br><b>CKE:</b> High; <b>External clock:</b> On; <b>tCK, CL:</b> see Table 151; <b>BL:</b> 8 <sup>1</sup> ; <b>AL:</b> 0; <b>CS_n:</b> stable at 1; <b>Command, Address, Bank Group Address, Bank Address Inputs:</b> partially toggling according to Table 155; <b>Data IO:</b> VDDQ; <b>DM_n:</b> stable at 1; <b>Bank Activity:</b> all banks closed; <b>Output Buffer and RTT:</b> Enabled in Mode Registers <sup>2</sup> ; <b>ODT Signal:</b> stable at 0; <b>Pattern Details:</b> see Table 155  |
| IDD2NA                | <b>Precharge Standby Current (AL=CL-1)</b><br><b>AL = CL-1, Other conditions:</b> see IDD2N   |
| IPP2N                 | <b>Precharge Standby IPP Current</b><br><b>Same condition with IDD2N</b>  |
| IDD2NT                | <b>Precharge Standby ODT Current</b><br><b>CKE:</b> High; <b>External clock:</b> On; <b>tCK, CL:</b> see Table 151; <b>BL:</b> 8 <sup>1</sup> ; <b>AL:</b> 0; <b>CS_n:</b> stable at 1; <b>Command, Address, Bank Group Address, Bank Address Inputs:</b> partially toggling according to Table 156; <b>Data IO:</b> VSSQ; <b>DM_n:</b> stable at 1; <b>Bank Activity:</b> all banks closed; <b>Output Buffer and RTT:</b> Enabled in Mode Registers <sup>2</sup> ; <b>ODT Signal:</b> toggling according to Table 156; <b>Pattern Details:</b> see Table 156   |
| IDDQ2NT<br>(Optional) | <b>Precharge Standby ODT IDDQ Current</b><br>Same definition like for IDD2NT, however measuring IDDQ current instead of IDD current   |
| IDD2NL                | <b>Precharge Standby Current with CAL enabled</b><br>Same definition like for IDD2N, CAL enabled <sup>3</sup>   |
| IDD2NG                | <b>Precharge Standby Current with Gear Down mode enabled</b><br>Same definition like for IDD2N, Gear Down mode enabled <sup>3,5</sup>   |
| IDD2ND                | <b>Precharge Standby Current with DLL disabled</b><br>Same definition like for IDD2N, DLL disabled <sup>3</sup>   |
| IDD2N_p<br>ar         | <b>Precharge Standby Current with CA parity enabled</b><br>Same definition like for IDD2N, CA parity enabled <sup>3</sup>   |
| IDD2P                 | <b>Precharge Power-Down Current</b> <b>CKE:</b> Low; <b>External clock:</b> On; <b>tCK, CL:</b> see Table 151; <b>BL:</b> 8 <sup>1</sup> ; <b>AL:</b> 0; <b>CS_n:</b> stable at 1; <b>Command, Address, Bank Group Address, Bank Address Inputs:</b> stable at 0; <b>Data IO:</b> VDDQ; <b>DM_n:</b> stable at 1; <b>Bank Activity:</b> all banks closed; <b>Output Buffer and RTT:</b> Enabled in Mode Registers <sup>2</sup> ; <b>ODT Signal:</b> stable at 0   |
| IPP2P                 | <b>Precharge Power-Down IPP Current</b><br><b>Same condition with IDD2P</b>   |
| IDD2Q                 | <b>Precharge Quiet Standby Current</b><br><b>CKE:</b> High; <b>External clock:</b> On; <b>tCK, CL:</b> see Table 151; <b>BL:</b> 8 <sup>1</sup> ; <b>AL:</b> 0; <b>CS_n:</b> stable at 1; <b>Command, Address, Bank Group Address, Bank Address Inputs:</b> stable at 0; <b>Data IO:</b> VDDQ; <b>DM_n:</b> stable at 1; <b>Bank Activity:</b> all banks closed; <b>Output Buffer and RTT:</b> Enabled in Mode Registers <sup>2</sup> ; <b>ODT Signal:</b> stable at 0  |

**Table 152 — Basic IDD, IPP and IDDQ Measurement Conditions (cont'd)**

| Symbol             | Description   |
|--------------------|---|
| IDD3N              | <b>Active Standby Current</b><br><b>CKE:</b> High; <b>External clock:</b> On; <b>tCK, CL:</b> see Table 151; <b>BL:</b> 8 <sup>1</sup> ; <b>AL:</b> 0; <b>CS_n:</b> stable at 1; <b>Command, Address, Bank Group Address, Bank Address Inputs:</b> partially toggling according to Table 155; <b>Data IO:</b> VDDQ; <b>DM_n:</b> stable at 1; <b>Bank Activity:</b> all banks open; <b>Output Buffer and RTT:</b> Enabled in Mode Registers <sup>2</sup> ; <b>ODT Signal:</b> stable at 0; <b>Pattern Details:</b> see Table 155  |
| IDD3NA             | <b>Active Standby Current (AL=CL-1)</b><br><b>AL = CL-1, Other conditions:</b> see IDD3N  |
| IPP3N              | <b>Active Standby IPP Current</b><br><b>Same condition with IDD3N</b>   |
| IDD3P              | <b>Active Power-Down Current</b><br><b>CKE:</b> Low; <b>External clock:</b> On; <b>tCK, CL:</b> see Table 151; <b>BL:</b> 8 <sup>1</sup> ; <b>AL:</b> 0; <b>CS_n:</b> stable at 1; <b>Command, Address, Bank Group Address, Bank Address Inputs:</b> stable at 0; <b>Data IO:</b> VDDQ; <b>DM_n:</b> stable at 1; <b>Bank Activity:</b> all banks open; <b>Output Buffer and RTT:</b> Enabled in Mode Registers <sup>2</sup> ; <b>ODT Signal:</b> stable at 0   |
| IPP3P              | <b>Active Power-Down IPP Current</b><br><b>Same condition with IDD3P</b>  |
| IDD4R              | <b>Operating Burst Read Current</b><br><b>CKE:</b> High; <b>External clock:</b> On; <b>tCK, CL:</b> see Table 151; <b>BL:</b> 8 <sup>2</sup> ; <b>AL:</b> 0; <b>CS_n:</b> High between RD; <b>Command, Address, Bank Group Address, Bank Address Inputs:</b> partially toggling according to Table 157; <b>Data IO:</b> seamless read data burst with different data between one burst and the next one according to Table 157; <b>DM_n:</b> stable at 1; <b>Bank Activity:</b> all banks open, RD commands cycling through banks: 0,0,1,1,2,2,... (see Table 157); <b>Output Buffer and RTT:</b> Enabled in Mode Registers <sup>2</sup> ; <b>ODT Signal:</b> stable at 0; <b>Pattern Details:</b> see Table 157      |
| IDD4RA             | <b>Operating Burst Read Current (AL=CL-1)</b><br><b>AL = CL-1, Other conditions:</b> see IDD4R  |
| IDD4RB             | <b>Operating Burst Read Current with Read DBI</b><br><b>Read DBI enabled<sup>3</sup>, Other conditions:</b> see IDD4R   |
| IPP4R              | <b>Operating Burst Read IPP Current</b><br><b>Same condition with IDD4R</b>   |
| IDDQ4R (Optional)  | <b>Operating Burst Read IDDQ Current</b><br><b>Same definition like for IDD4R, however measuring IDDQ current instead of IDD current</b>  |
| IDDQ4RB (Optional) | <b>Operating Burst Read IDDQ Current with Read DBI</b><br><b>Same definition like for IDD4RB, however measuring IDDQ current instead of IDD current</b>   |
| IDD4W              | <b>Operating Burst Write Current</b><br><b>CKE:</b> High; <b>External clock:</b> On; <b>tCK, CL:</b> see Table 151; <b>BL:</b> 8 <sup>1</sup> ; <b>AL:</b> 0; <b>CS_n:</b> High between WR; <b>Command, Address, Bank Group Address, Bank Address Inputs:</b> partially toggling according to Table 158; <b>Data IO:</b> seamless write data burst with different data between one burst and the next one according to Table 158; <b>DM_n:</b> stable at 1; <b>Bank Activity:</b> all banks open, WR commands cycling through banks: 0,0,1,1,2,2,... (see Table 158); <b>Output Buffer and RTT:</b> Enabled in Mode Registers <sup>2</sup> ; <b>ODT Signal:</b> stable at HIGH; <b>Pattern Details:</b> see Table 158 |
| IDD4WA             | <b>Operating Burst Write Current (AL=CL-1)</b><br><b>AL = CL-1, Other conditions:</b> see IDD4W   |
| IDD4WB             | <b>Operating Burst Write Current with Write DBI</b><br><b>Write DBI enabled<sup>3</sup>, Other conditions:</b> see IDD4W  |
| IDD4WC             | <b>Operating Burst Write Current with Write CRC</b><br><b>Write CRC enabled<sup>3</sup>, Other conditions:</b> see IDD4W  |
| IDD4W_p_ar         | <b>Operating Burst Write Current with CA Parity</b><br><b>CA Parity enabled<sup>3</sup>, Other conditions:</b> see IDD4W  |
| IPP4W              | <b>Operating Burst Write IPP Current</b><br><b>Same condition with IDD4W</b>  |
| IDD5B              | <b>Burst Refresh Current (1X REF)</b><br><b>CKE:</b> High; <b>External clock:</b> On; <b>tCK, CL, nRFC:</b> see Table 151; <b>BL:</b> 8 <sup>1</sup> ; <b>AL:</b> 0; <b>CS_n:</b> High between REF; <b>Command, Address, Bank Group Address, Bank Address Inputs:</b> partially toggling according to Table 160; <b>Data IO:</b> VDDQ; <b>DM_n:</b> stable at 1; <b>Bank Activity:</b> REF command every nRFC (see Table 160); <b>Output Buffer and RTT:</b> Enabled in Mode Registers <sup>2</sup> ; <b>ODT Signal:</b> stable at 0; <b>Pattern Details:</b> see Table 160   |
| IPP5B              | <b>Burst Refresh Write IPP Current (1X REF)</b><br><b>Same condition with IDD5B</b>   |
| IDD5F2             | <b>Burst Refresh Current (2X REF)</b><br><b>tRFC=tRFC_x2, Other conditions:</b> see IDD5B   |

**Table 152 — Basic IDD, IPP and IDDQ Measurement Conditions (cont'd)**

| Symbol | Description   |
|--------|---|
| IPP5F2 | Burst Refresh Write IPP Current (2X REF)<br>Same condition with IDD5F2  |
| IDD5F4 | Burst Refresh Current (4X REF)<br>$t_{RFC}=t_{RFC\_x4}$ , Other conditions: see IDD5B   |
| IPP5F4 | Burst Refresh Write IPP Current (4X REF)<br>Same condition with IDD5F4  |
| IDD6N  | Self Refresh Current: Normal Temperature Range<br>$T_{CASE}$ for CT devices: 0 to 85°C, $T_{CASE}$ for IT devices: -40 to 85°C; <b>Low Power Auto Self Refresh (LP ASR)</b> : Normal <sup>4</sup> ; <b>CKE</b> : Low; <b>External clock</b> : Off; CK_t and CK_c#: LOW; CL: see Table 151; BL: 8 <sup>1</sup> ; AL: 0; CS_n#, Command, Address, Bank Group Address, Bank Address, Data IO: High; DM_n: stable at 1; <b>Bank Activity</b> : Self-Refresh operation; <b>Output Buffer and RTT</b> : Enabled in Mode Registers <sup>2</sup> ; <b>ODT Signal</b> : MID-LEVEL                          |
| IPP6N  | Self Refresh IPP Current: Normal Temperature Range<br>Same condition with IDD6N   |
| IDD6E  | Self-Refresh Current: Extended Temperature Range<br>$T_{CASE}$ for CT devices: 0 to 95°C, $T_{CASE}$ for IT devices: -40 to 95°C; <b>Low Power Auto Self Refresh (LP ASR)</b> : Extended <sup>4</sup> ; <b>CKE</b> : Low; <b>External clock</b> : Off; CK_t and CK_c#: LOW; CL: see Table 151; BL: 8 <sup>1</sup> ; AL: 0; CS_n#, Command, Address, Bank Group Address, Bank Address, Data IO: High; DM_n: stable at 1; <b>Bank Activity</b> : Extended Temperature Self-Refresh operation; <b>Output Buffer and RTT</b> : Enabled in Mode Registers <sup>2</sup> ; <b>ODT Signal</b> : MID-LEVEL |
| IPP6E  | Self Refresh IPP Current: Extended Temperature Range<br>Same condition with IDD6E   |
| IDD6R  | Self-Refresh Current: Reduced Temperature Range<br>$T_{CASE}$ for CT devices: 0 to 45°C, $T_{CASE}$ for IT devices: -40 to 45°C; <b>Low Power Auto Self Refresh (LP ASR)</b> : Reduced <sup>4</sup> ; <b>CKE</b> : Low; <b>External clock</b> : Off; CK_t and CK_c#: LOW; CL: see Table 151; BL: 8 <sup>1</sup> ; AL: 0; CS_n#, Command, Address, Bank Group Address, Bank Address, Data IO: High; DM_n: stable at 1; <b>Bank Activity</b> : Extended Temperature Self-Refresh operation; <b>Output Buffer and RTT</b> : Enabled in Mode Registers <sup>2</sup> ; <b>ODT Signal</b> : MID-LEVEL   |
| IPP6R  | Self Refresh IPP Current: Reduced Temperature Range<br>Same condition with IDD6R  |
| IDD6A  | Auto Self-Refresh Current<br>$T_{CASE}$ for CT devices: 0 to 95°C, $T_{CASE}$ for IT devices: -40 to 95°C; <b>Low Power Auto Self Refresh (LP ASR)</b> : Auto <sup>4</sup> ; <b>CKE</b> : Low; <b>External clock</b> : Off; CK_t and CK_c#: LOW; CL: see Table 151; BL: 8 <sup>1</sup> ; AL: 0; CS_n#, Command, Address, Bank Group Address, Bank Address, Data IO: High; DM_n: stable at 1; <b>Bank Activity</b> : Auto Self-Refresh operation; <b>Output Buffer and RTT</b> : Enabled in Mode Registers <sup>2</sup> ; <b>ODT Signal</b> : MID-LEVEL  |
| IPP6A  | Auto Self-Refresh IPP Current<br>Same condition with IDD6A  |

**Table 152 — Basic IDD, IPP and IDDQ Measurement Conditions (cont'd)**

| Symbol | Description  |
|--------|--|
| IDD7   | <b>Operating Bank Interleave Read Current</b><br><b>CKE:</b> High; <b>External clock:</b> On; <b>tCK, nRC, nRAS, nRCD, nRRD, nFAW, CL:</b> see Table 151; <b>BL:</b> 8 <sup>1</sup> ; <b>AL:</b> CL-1; <b>CS_n:</b> High between ACT and RDA; <b>Command, Address, Bank Group Address, Bank Address Inputs:</b> partially toggling according to Table 161; <b>Data IO:</b> read data bursts with different data between one burst and the next one according to Table 161; <b>DM_n:</b> stable at 1; <b>Bank Activity:</b> two times interleaved cycling through banks (0, 1, ...7) with different addressing, see Table 161; <b>Output Buffer and RTT:</b> Enabled in Mode Registers <sup>2</sup> ; <b>ODT Signal:</b> stable at 0; <b>Pattern Details:</b> see Table 161 |
| IPP7   | <b>Operating Bank Interleave Read IPP Current</b><br><b>Same condition with IDD7</b>   |
| IDD8   | <b>Maximum Power Down Current</b><br><b>TBD</b>  |
| IPP8   | <b>Maximum Power Down IPP Current</b><br><b>Same condition with IDD8</b>   |

NOTE 1 Burst Length: BL8 fixed by MRS: set MR0 [A1:0=00].

NOTE 2 Output Buffer Enable

- set MR1 [A12 = 0] : Qoff = Output buffer enabled
- set MR1 [A2:1 = 00] : Output Driver Impedance Control = RZQ/7
- RTT\_Nom enable
- set MR1 [A10:8 = 011] : RTT\_NOM = RZQ/6
- RTT\_WR enable
- set MR2 [A10:9 = 01] : RTT\_WR = RZQ/2
- RTT\_PARK disable
- set MR5 [A8:6 = 000]

NOTE 3 CAL enabled : set MR4 [A8:6 = 001] : 1600MT/s  
 010] : 1866MT/s, 2133MT/s  
 011] : 2400MT/s

Gear Down mode enabled : set MR3 [A3 = 1] : 1/4 Rate

DLL disabled : set MR1 [A0 = 0]

CA parity enabled : set MR5 [A2:0 = 001] : 1600MT/s, 1866MT/s, 2133MT/s  
 010] : 2400MT/s

Read DBI enabled : set MR5 [A12 = 1]

Write DBI enabled : set MR5 [A11 = 1]

NOTE 4 Low Power Auto Self Refresh (LP ASR) : set MR2 [A7:6 = 00] : Normal

- 01] : Reduced Temperature range
- 10] : Extended Temperature range
- 11] : Auto Self Refresh

NOTE 5 IDD2NG should be measured after sync pulse (NOP) input.

## 11.1 IDD, IPP and IDDQ Measurement Conditions (cont'd)

Table 153 — IDD0, IDD0A and IPP0 Measurement-Loop Pattern<sup>1</sup>

| CK_t / CK_c             | CKE | Sub-Loop | Cycle Number   | Command | CS_n | ACT_n | RAS_n/A16 | CAS_n/A15 | WE_n/A14 | CDT | C[2:0] <sup>3</sup> | BG[1:0] <sup>2</sup> | BA[1:0] | A12/BC_n | A[17,13,11] | A[10]/AP | A[9:7] | A[6:3] | A[2:0] | Data <sup>4</sup> |
|-------------------------|-----|----------|--|---------|------|-------|-----------|-----------|----------|-----|---------------------|----------------------|---------|----------|-------------|----------|--------|--------|--------|-------------------|
| toggling<br>Static High | 0   | 0        | ACT  | 0       | 0    | 0     | 0         | 0         | 0        | 0   | 0                   | 0                    | 0       | 0        | 0           | 0        | 0      | 0      | 0      | -                 |
|                         |     | 1,2      | D, D   | 1       | 0    | 0     | 0         | 0         | 0        | 0   | 0                   | 0                    | 0       | 0        | 0           | 0        | 0      | 0      | 0      | -                 |
|                         |     | 3,4      | D_#,<br>D_#  | 1       | 1    | 1     | 1         | 1         | 1        | 0   | 0                   | 3 <sup>2</sup>       | 3       | 0        | 0           | 0        | 7      | F      | 0      | -                 |
|                         |     | ...      | repeat pattern 1...4 until nRAS - 1, truncate if necessary                 |         |      |       |           |           |          |     |                     |                      |         |          |             |          |        |        |        |                   |
|                         |     | nRAS     | PRE  | 0       | 1    | 0     | 1         | 0         | 0        | 0   | 0                   | 0                    | 0       | 0        | 0           | 0        | 0      | 0      | 0      | -                 |
|                         |     | ...      | repeat pattern 1...4 until nRC - 1, truncate if necessary                  |         |      |       |           |           |          |     |                     |                      |         |          |             |          |        |        |        |                   |
|                         | 1   | 1*nRC    | repeat Sub-Loop 0, use <b>BG[1:0]<sup>2</sup> = 1, BA[1:0] = 1 instead</b> |         |      |       |           |           |          |     |                     |                      |         |          |             |          |        |        |        |                   |
|                         |     | 2*nRC    | repeat Sub-Loop 0, use <b>BG[1:0]<sup>2</sup> = 0, BA[1:0] = 2 instead</b> |         |      |       |           |           |          |     |                     |                      |         |          |             |          |        |        |        |                   |
|                         |     | 3*nRC    | repeat Sub-Loop 0, use <b>BG[1:0]<sup>2</sup> = 1, BA[1:0] = 3 instead</b> |         |      |       |           |           |          |     |                     |                      |         |          |             |          |        |        |        |                   |
|                         |     | 4*nRC    | repeat Sub-Loop 0, use <b>BG[1:0]<sup>2</sup> = 0, BA[1:0] = 1 instead</b> |         |      |       |           |           |          |     |                     |                      |         |          |             |          |        |        |        |                   |
|                         |     | 5*nRC    | repeat Sub-Loop 0, use <b>BG[1:0]<sup>2</sup> = 1, BA[1:0] = 2 instead</b> |         |      |       |           |           |          |     |                     |                      |         |          |             |          |        |        |        |                   |
|                         |     | 6*nRC    | repeat Sub-Loop 0, use <b>BG[1:0]<sup>2</sup> = 0, BA[1:0] = 3 instead</b> |         |      |       |           |           |          |     |                     |                      |         |          |             |          |        |        |        |                   |
|                         |     | 7*nRC    | repeat Sub-Loop 0, use <b>BG[1:0]<sup>2</sup> = 1, BA[1:0] = 0 instead</b> |         |      |       |           |           |          |     |                     |                      |         |          |             |          |        |        |        |                   |
|                         |     | 8*nRC    | repeat Sub-Loop 0, use <b>BG[1:0]<sup>2</sup> = 2, BA[1:0] = 0 instead</b> |         |      |       |           |           |          |     |                     |                      |         |          |             |          |        |        |        |                   |
|                         |     | 9*nRC    | repeat Sub-Loop 0, use <b>BG[1:0]<sup>2</sup> = 3, BA[1:0] = 1 instead</b> |         |      |       |           |           |          |     |                     |                      |         |          |             |          |        |        |        |                   |
|                         |     | 10*nRC   | repeat Sub-Loop 0, use <b>BG[1:0]<sup>2</sup> = 2, BA[1:0] = 2 instead</b> |         |      |       |           |           |          |     |                     |                      |         |          |             |          |        |        |        |                   |
|                         |     | 11*nRC   | repeat Sub-Loop 0, use <b>BG[1:0]<sup>2</sup> = 3, BA[1:0] = 3 instead</b> |         |      |       |           |           |          |     |                     |                      |         |          |             |          |        |        |        |                   |
|                         |     | 12*nRC   | repeat Sub-Loop 0, use <b>BG[1:0]<sup>2</sup> = 2, BA[1:0] = 1 instead</b> |         |      |       |           |           |          |     |                     |                      |         |          |             |          |        |        |        |                   |
|                         |     | 13*nRC   | repeat Sub-Loop 0, use <b>BG[1:0]<sup>2</sup> = 3, BA[1:0] = 2 instead</b> |         |      |       |           |           |          |     |                     |                      |         |          |             |          |        |        |        |                   |
|                         |     | 14*nRC   | repeat Sub-Loop 0, use <b>BG[1:0]<sup>2</sup> = 2, BA[1:0] = 3 instead</b> |         |      |       |           |           |          |     |                     |                      |         |          |             |          |        |        |        |                   |
|                         |     | 15*nRC   | repeat Sub-Loop 0, use <b>BG[1:0]<sup>2</sup> = 3, BA[1:0] = 0 instead</b> |         |      |       |           |           |          |     |                     |                      |         |          |             |          |        |        |        |                   |

NOTE 1 DQS\_t, DQS\_c are VDDQ.

NOTE 2 BG1 is don't care for x16 device

NOTE 3 C[2:0] are used only for 3DS device

NOTE 4 DQ signals are VDDQ.

For x4 and  
x8 only

11.1 IDD, IPP and IDDQ Measurement Conditions (cont'd)

**Table 154 — IDD1, IDD1A and IPP1 Measurement-Loop Pattern<sup>1</sup>**

| CK_t, CK_c | CKE         | Sub-Loop | Cycle Number      | Command  | CS_n | ACT_n | RAS_n/A16 | CAS_n/A15 | WE_n/A14 | ODT | C[2:0] <sup>3</sup> | BG[1:0] <sup>2</sup> | BA[1:0] | A12BC_n | A[17,13,11] | A[10]AP | A[9:7] | A[6:3] | A[2:0] | Data <sup>4</sup>  |  |
|------------|-------------|----------|-------------------|--|------|-------|-----------|-----------|----------|-----|---------------------|----------------------|---------|---------|-------------|---------|--------|--------|--------|--|--|
| toggling   | Static High | 0        | 0                 | ACT  | 0    | 0     | 0         | 0         | 0        | 0   | 0                   | 0                    | 0       | 0       | 0           | 0       | 0      | 0      | -      |  |  |
|            |             |          | 1, 2              | D, D   | 1    | 0     | 0         | 0         | 0        | 0   | 0                   | 0                    | 0       | 0       | 0           | 0       | 0      | 0      | 0      | -  |  |
|            |             |          | 3, 4              | D#, D#   | 1    | 1     | 1         | 1         | 1        | 0   | 0                   | 3 <sup>b</sup>       | 3       | 0       | 0           | 0       | 7      | F      | 0      | -  |  |
|            |             |          | ...               | repeat pattern 1...4 until nRCD - AL - 1, truncate if necessary          |      |       |           |           |          |     |                     |                      |         |         |             |         |        |        |        |  |  |
|            |             |          | nRCD - AL         | RD   | 0    | 1     | 1         | 0         | 1        | 0   | 0                   | 0                    | 0       | 0       | 0           | 0       | 0      | 0      | 0      | D0=00, D1=FF<br>D2=FF, D3=00<br>D4=FF, D5=00<br>D6=00, D7=FF |  |
|            |             | 1        | ...               | repeat pattern 1...4 until nRAS - 1, truncate if necessary               |      |       |           |           |          |     |                     |                      |         |         |             |         |        |        |        |  |  |
|            |             |          | nRAS              | PRE  | 0    | 1     | 0         | 1         | 0        | 0   | 0                   | 0                    | 0       | 0       | 0           | 0       | 0      | 0      | 0      | -  |  |
|            |             |          | ...               | repeat pattern 1...4 until nRC - 1, truncate if necessary                |      |       |           |           |          |     |                     |                      |         |         |             |         |        |        |        |  |  |
|            |             |          | 1*nRC + 0         | ACT  | 0    | 0     | 0         | 1         | 1        | 0   | 0                   | 1                    | 1       | 0       | 0           | 0       | 0      | 0      | 0      | -  |  |
|            |             | 2        | 1*nRC + 1, 2      | D, D   | 1    | 0     | 0         | 0         | 0        | 0   | 0                   | 0                    | 0       | 0       | 0           | 0       | 0      | 0      | 0      | -  |  |
|            |             |          | 1*nRC + 3, 4      | D#, D#   | 1    | 1     | 1         | 1         | 1        | 0   | 0                   | 3 <sup>b</sup>       | 3       | 0       | 0           | 0       | 7      | F      | 0      | -  |  |
|            |             |          | ...               | repeat pattern nRC + 1...4 until 1*nRC + nRAS - 1, truncate if necessary |      |       |           |           |          |     |                     |                      |         |         |             |         |        |        |        |  |  |
|            |             |          | 1*nRC + nRCD - AL | RD   | 0    | 1     | 1         | 0         | 1        | 0   | 0                   | 1                    | 1       | 0       | 0           | 0       | 0      | 0      | 0      | D0=FF, D1=00<br>D2=00, D3=FF<br>D4=00, D5=FF<br>D6=FF, D7=00 |  |
|            |             |          | ...               | repeat pattern 1...4 until nRAS - 1, truncate if necessary               |      |       |           |           |          |     |                     |                      |         |         |             |         |        |        |        |  |  |
|            |             |          | 1*nRC + nRAS      | PRE  | 0    | 1     | 0         | 1         | 0        | 0   | 0                   | 1                    | 1       | 0       | 0           | 0       | 0      | 0      | 0      | -  |  |
|            |             |          | ...               | repeat nRC + 1...4 until 2*nRC - 1, truncate if necessary                |      |       |           |           |          |     |                     |                      |         |         |             |         |        |        |        |  |  |
|            |             |          | 2 2*nRC           | repeat Sub-Loop 0, use BG[1:0] <sup>2</sup> = 0, BA[1:0] = 2 instead     |      |       |           |           |          |     |                     |                      |         |         |             |         |        |        |        |  |  |
|            |             |          | 3 3*nRC           | repeat Sub-Loop 1, use BG[1:0] <sup>2</sup> = 1, BA[1:0] = 3 instead     |      |       |           |           |          |     |                     |                      |         |         |             |         |        |        |        |  |  |
|            |             |          | 4 4*nRC           | repeat Sub-Loop 0, use BG[1:0] <sup>2</sup> = 0, BA[1:0] = 1 instead     |      |       |           |           |          |     |                     |                      |         |         |             |         |        |        |        |  |  |
|            |             |          | 5 5*nRC           | repeat Sub-Loop 1, use BG[1:0] <sup>2</sup> = 1, BA[1:0] = 2 instead     |      |       |           |           |          |     |                     |                      |         |         |             |         |        |        |        |  |  |
|            |             |          | 6 6*nRC           | repeat Sub-Loop 0, use BG[1:0] <sup>2</sup> = 0, BA[1:0] = 3 instead     |      |       |           |           |          |     |                     |                      |         |         |             |         |        |        |        |  |  |
|            |             |          | 8 7*nRC           | repeat Sub-Loop 1, use BG[1:0] <sup>2</sup> = 1, BA[1:0] = 0 instead     |      |       |           |           |          |     |                     |                      |         |         |             |         |        |        |        |  |  |
|            |             |          | 9 9*nRC           | repeat Sub-Loop 1, use BG[1:0] <sup>2</sup> = 2, BA[1:0] = 0 instead     |      |       |           |           |          |     |                     |                      |         |         |             |         |        |        |        |  |  |
|            |             |          | 10 10*nRC         | repeat Sub-Loop 0, use BG[1:0] <sup>2</sup> = 3, BA[1:0] = 1 instead     |      |       |           |           |          |     |                     |                      |         |         |             |         |        |        |        |  |  |
|            |             |          | 11 11*nRC         | repeat Sub-Loop 1, use BG[1:0] <sup>2</sup> = 2, BA[1:0] = 2 instead     |      |       |           |           |          |     |                     |                      |         |         |             |         |        |        |        |  |  |
|            |             |          | 12 12*nRC         | repeat Sub-Loop 0, use BG[1:0] <sup>2</sup> = 3, BA[1:0] = 3 instead     |      |       |           |           |          |     |                     |                      |         |         |             |         |        |        |        |  |  |
|            |             |          | 13 13*nRC         | repeat Sub-Loop 1, use BG[1:0] <sup>2</sup> = 2, BA[1:0] = 1 instead     |      |       |           |           |          |     |                     |                      |         |         |             |         |        |        |        |  |  |
|            |             |          | 14 14*nRC         | repeat Sub-Loop 0, use BG[1:0] <sup>2</sup> = 3, BA[1:0] = 2 instead     |      |       |           |           |          |     |                     |                      |         |         |             |         |        |        |        |  |  |
|            |             |          | 15 15*nRC         | repeat Sub-Loop 1, use BG[1:0] <sup>2</sup> = 2, BA[1:0] = 3 instead     |      |       |           |           |          |     |                     |                      |         |         |             |         |        |        |        |  |  |
|            |             |          | 16 16*nRC         | repeat Sub-Loop 0, use BG[1:0] <sup>2</sup> = 3, BA[1:0] = 0 instead     |      |       |           |           |          |     |                     |                      |         |         |             |         |        |        |        |  |  |

NOTE 1 DQS\_t, DQS\_c are used according to RD Commands, otherwise VDDQ

NOTE 2 BG1 is don't care for x16 device

NOTE 3 C[2:0] are used only for 3DS device

NOTE 4 Burst Sequence driven on each DQ signal by Read Command. Outside burst operation, DQ signals are VDDQ.

For x4 and x8  
only

11.1 IDD, IPP and IDDQ Measurement Conditions (cont'd)

**Table 155 — IDD2N, IDD2NA, IDD2NL, IDD2NG, IDD2ND, IDD2N\_par, IPP2, IDD3N, IDD3NA and IDD3P**

**Measurement-Loop Pattern<sup>1</sup>**

| CK_t, CK_c              | CKE  | Sub-Loop | Cycle Number   | Command  | CS_n | ACT_n | RAS_n/A16 | CAS_n/A15 | WE_n/A14 | ODT | C[2:0] <sup>3</sup> | BG[1:0] <sup>2</sup> | BA[1:0] | A12/BC_n | A[17,13,11] | A[10]/AP | A[9:7] | A[6:3] | A[2:0] | Data <sup>4</sup> |   |
|-------------------------|--|----------|--|--|------|-------|-----------|-----------|----------|-----|---------------------|----------------------|---------|----------|-------------|----------|--------|--------|--------|-------------------|---|
| toggling<br>Static High | 0  | 0        | D, D   | 1 0            |      |       |           |           |          |     |                     |                      |         |          |             |          |        |        |        |                   | 0 |
|                         |  | 1        | D, D   | 1 0            |      |       |           |           |          |     |                     |                      |         |          |             |          |        |        |        |                   | 0 |
|                         |  | 2        | D#, D#   | 1 1 1 1 1 1 0 0 0 3 <sup>2</sup> 3 0 0 0 0 0 7 F 0 0 |      |       |           |           |          |     |                     |                      |         |          |             |          |        |        |        |                   | 0 |
|                         |  | 3        | D#, D#   | 1 1 1 1 1 1 0 0 0 3 <sup>2</sup> 3 0 0 0 0 0 7 F 0 0 |      |       |           |           |          |     |                     |                      |         |          |             |          |        |        |        |                   | 0 |
|                         | 1 4-7<br>2 8-11<br>3 12-15<br>4 16-19<br>5 20-23<br>6 24-27<br>7 28-31<br>8 32-35<br>9 36-39<br>10 40-43<br>11 44-47<br>12 48-51<br>13 52-55<br>14 56-59<br>15 60-63 | 4-7      | repeat Sub-Loop 0, use BG[1:0] <sup>2</sup> = 1, BA[1:0] = 1 instead |  |      |       |           |           |          |     |                     |                      |         |          |             |          |        |        |        |                   |   |
|                         |  | 8-11     | repeat Sub-Loop 0, use BG[1:0] <sup>2</sup> = 0, BA[1:0] = 2 instead |  |      |       |           |           |          |     |                     |                      |         |          |             |          |        |        |        |                   |   |
|                         |  | 12-15    | repeat Sub-Loop 0, use BG[1:0] <sup>2</sup> = 1, BA[1:0] = 3 instead |  |      |       |           |           |          |     |                     |                      |         |          |             |          |        |        |        |                   |   |
|                         |  | 16-19    | repeat Sub-Loop 0, use BG[1:0] <sup>2</sup> = 0, BA[1:0] = 1 instead |  |      |       |           |           |          |     |                     |                      |         |          |             |          |        |        |        |                   |   |
|                         |  | 20-23    | repeat Sub-Loop 0, use BG[1:0] <sup>2</sup> = 1, BA[1:0] = 2 instead |  |      |       |           |           |          |     |                     |                      |         |          |             |          |        |        |        |                   |   |
|                         |  | 24-27    | repeat Sub-Loop 0, use BG[1:0] <sup>2</sup> = 0, BA[1:0] = 3 instead |  |      |       |           |           |          |     |                     |                      |         |          |             |          |        |        |        |                   |   |
|                         |  | 28-31    | repeat Sub-Loop 0, use BG[1:0] <sup>2</sup> = 1, BA[1:0] = 0 instead |  |      |       |           |           |          |     |                     |                      |         |          |             |          |        |        |        |                   |   |
|                         |  | 32-35    | repeat Sub-Loop 0, use BG[1:0] <sup>2</sup> = 2, BA[1:0] = 0 instead |  |      |       |           |           |          |     |                     |                      |         |          |             |          |        |        |        |                   |   |
|                         |  | 36-39    | repeat Sub-Loop 0, use BG[1:0] <sup>2</sup> = 3, BA[1:0] = 1 instead |  |      |       |           |           |          |     |                     |                      |         |          |             |          |        |        |        |                   |   |
|                         |  | 40-43    | repeat Sub-Loop 0, use BG[1:0] <sup>2</sup> = 2, BA[1:0] = 2 instead |  |      |       |           |           |          |     |                     |                      |         |          |             |          |        |        |        |                   |   |
|                         |  | 44-47    | repeat Sub-Loop 0, use BG[1:0] <sup>2</sup> = 3, BA[1:0] = 3 instead |  |      |       |           |           |          |     |                     |                      |         |          |             |          |        |        |        |                   |   |
|                         |  | 48-51    | repeat Sub-Loop 0, use BG[1:0] <sup>2</sup> = 2, BA[1:0] = 1 instead |  |      |       |           |           |          |     |                     |                      |         |          |             |          |        |        |        |                   |   |
|                         |  | 52-55    | repeat Sub-Loop 0, use BG[1:0] <sup>2</sup> = 3, BA[1:0] = 2 instead |  |      |       |           |           |          |     |                     |                      |         |          |             |          |        |        |        |                   |   |
|                         |  | 56-59    | repeat Sub-Loop 0, use BG[1:0] <sup>2</sup> = 2, BA[1:0] = 3 instead |  |      |       |           |           |          |     |                     |                      |         |          |             |          |        |        |        |                   |   |
|                         |  | 60-63    | repeat Sub-Loop 0, use BG[1:0] <sup>2</sup> = 3, BA[1:0] = 0 instead |  |      |       |           |           |          |     |                     |                      |         |          |             |          |        |        |        |                   |   |

NOTE 1 DQS\_t, DQS\_c are VDDQ.

NOTE 2 BG1 is don't care for x16 device

NOTE 3 C[2:0] are used only for 3DS device

NOTE 4 DQ signals are VDDQ.

11.1 IDD, IPP and IDDQ Measurement Conditions (cont'd)

**Table 156 — IDD2NT and IDDQ2NT Measurement-Loop Pattern<sup>1</sup>**

| CK_t, CK_c              | CKE | Sub-Loop | Cycle Number | Command  | CS_n | ACT_n | RAS_n/A16 | CAS_n/A15 | WE_n/A14 | ODT | C[2:0] <sup>3</sup> | BG[1:0] <sup>2</sup> | BA[1:0] | A12/BC_n | A[17,13,11] | A[10]/AP | A[9:7] | A[6:3] | A[2:0] | Data <sup>4</sup> |
|-------------------------|-----|----------|--------------|--|------|-------|-----------|-----------|----------|-----|---------------------|----------------------|---------|----------|-------------|----------|--------|--------|--------|-------------------|
| toggling<br>Static High |     | 0        | 0            | D, D   | 1    | 0     | 0         | 0         | 0        | 0   | 0                   | 0                    | 0       | 0        | 0           | 0        | 0      | 0      | 0      | -                 |
|                         |     | 1        |              | D, D   | 1    | 0     | 0         | 0         | 0        | 0   | 0                   | 0                    | 0       | 0        | 0           | 0        | 0      | 0      | 0      | -                 |
|                         |     | 2        |              | D#, D#   | 1    | 1     | 1         | 1         | 1        | 0   | 0                   | 3 <sup>2</sup>       | 3       | 0        | 0           | 0        | 7      | F      | 0      | -                 |
|                         |     | 3        |              | D#, D#   | 1    | 1     | 1         | 1         | 1        | 0   | 0                   | 3 <sup>2</sup>       | 3       | 0        | 0           | 0        | 7      | F      | 0      | -                 |
|                         |     | 1        | 4-7          | repeat Sub-Loop 0, but ODT = 1 and BG[1:0] <sup>2</sup> = 1, BA[1:0] = 1 instead |      |       |           |           |          |     |                     |                      |         |          |             |          |        |        |        |                   |
|                         |     | 2        | 8-11         | repeat Sub-Loop 0, but ODT = 0 and BG[1:0] <sup>2</sup> = 0, BA[1:0] = 2 instead |      |       |           |           |          |     |                     |                      |         |          |             |          |        |        |        |                   |
|                         |     | 3        | 12-15        | repeat Sub-Loop 0, but ODT = 1 and BG[1:0] <sup>2</sup> = 1, BA[1:0] = 3 instead |      |       |           |           |          |     |                     |                      |         |          |             |          |        |        |        |                   |
|                         |     | 4        | 16-19        | repeat Sub-Loop 0, but ODT = 0 and BG[1:0] <sup>2</sup> = 0, BA[1:0] = 1 instead |      |       |           |           |          |     |                     |                      |         |          |             |          |        |        |        |                   |
|                         |     | 5        | 20-23        | repeat Sub-Loop 0, but ODT = 1 and BG[1:0] <sup>2</sup> = 1, BA[1:0] = 2 instead |      |       |           |           |          |     |                     |                      |         |          |             |          |        |        |        |                   |
|                         |     | 6        | 24-27        | repeat Sub-Loop 0, but ODT = 0 and BG[1:0] <sup>2</sup> = 0, BA[1:0] = 3 instead |      |       |           |           |          |     |                     |                      |         |          |             |          |        |        |        |                   |
|                         |     | 7        | 28-31        | repeat Sub-Loop 0, but ODT = 1 and BG[1:0] <sup>2</sup> = 1, BA[1:0] = 0 instead |      |       |           |           |          |     |                     |                      |         |          |             |          |        |        |        |                   |
|                         |     | 8        | 32-35        | repeat Sub-Loop 0, but ODT = 0 and BG[1:0] <sup>2</sup> = 2, BA[1:0] = 0 instead |      |       |           |           |          |     |                     |                      |         |          |             |          |        |        |        |                   |
|                         |     | 9        | 36-39        | repeat Sub-Loop 0, but ODT = 1 and BG[1:0] <sup>2</sup> = 3, BA[1:0] = 1 instead |      |       |           |           |          |     |                     |                      |         |          |             |          |        |        |        |                   |
|                         |     | 10       | 40-43        | repeat Sub-Loop 0, but ODT = 0 and BG[1:0] <sup>2</sup> = 2, BA[1:0] = 2 instead |      |       |           |           |          |     |                     |                      |         |          |             |          |        |        |        |                   |
|                         |     | 11       | 44-47        | repeat Sub-Loop 0, but ODT = 1 and BG[1:0] <sup>2</sup> = 3, BA[1:0] = 3 instead |      |       |           |           |          |     |                     |                      |         |          |             |          |        |        |        |                   |
|                         |     | 12       | 48-51        | repeat Sub-Loop 0, but ODT = 0 and BG[1:0] <sup>2</sup> = 2, BA[1:0] = 1 instead |      |       |           |           |          |     |                     |                      |         |          |             |          |        |        |        |                   |
|                         |     | 13       | 52-55        | repeat Sub-Loop 0, but ODT = 1 and BG[1:0] <sup>2</sup> = 3, BA[1:0] = 2 instead |      |       |           |           |          |     |                     |                      |         |          |             |          |        |        |        |                   |
|                         |     | 14       | 56-59        | repeat Sub-Loop 0, but ODT = 0 and BG[1:0] <sup>2</sup> = 2, BA[1:0] = 3 instead |      |       |           |           |          |     |                     |                      |         |          |             |          |        |        |        |                   |
|                         |     | 15       | 60-63        | repeat Sub-Loop 0, but ODT = 1 and BG[1:0] <sup>2</sup> = 3, BA[1:0] = 0 instead |      |       |           |           |          |     |                     |                      |         |          |             |          |        |        |        |                   |

NOTE 1 DQS\_t, DQS\_c are VDDQ.

NOTE 2 BG1 is don't care for x16 device

NOTE 3 C[2:0] are used only for 3DS device

NOTE 4 DQ signals are VDDQ.

For x4  
and  
x8  
only

11.1 IDD, IPP and IDDQ Measurement Conditions (cont'd)

**Table 157 — IDD4R, IDR4RA, IDR4RB and IDDQ4R Measurement-Loop Pattern<sup>1</sup>**

| CK_t, CK_c | CKE         | Sub-Loop | Cycle Number | Command  | CS_n | ACT_n | RAS_n/A16 | CAS_n/A15 | WE_n/A14 | ODT | C[2:0] <sup>3</sup> | BG[1:0] <sup>2</sup>  | BA[1:0]  | A12/BC_n | A[17,13,11] | A[10]/AP | A[9:7]   | A[6:3]   | A[2:0]   | Data <sup>4</sup>  |  |
|------------|-------------|----------|--------------|--|------|-------|-----------|-----------|----------|-----|---------------------|-----------------------|----------|----------|-------------|----------|----------|----------|----------|--|--|
| toggling   | Static High | 0        | 0            | <b>RD</b>  | 0    | 1     | 1         | 0         | 1        | 0   | 0                   | <b>0</b>              | <b>0</b> | <b>0</b> | 0           | 0        | <b>0</b> | <b>0</b> | <b>0</b> | D0=00, D1=FF<br>D2=FF, D3=00<br>D4=FF, D5=00<br>D6=00, D7=FF |  |
|            |             |          | 1            | D  | 1    | 0     | 0         | 0         | 0        | 0   | 0                   | <b>0</b>              | <b>0</b> | <b>0</b> | 0           | 0        | <b>0</b> | <b>0</b> | <b>0</b> | -  |  |
|            |             |          | 2,3          | D#, D#   | 1    | 1     | 1         | 1         | 1        | 0   | 0                   | <b>3</b> <sup>2</sup> | <b>3</b> | 0        | 0           | 0        | <b>0</b> | <b>7</b> | <b>F</b> | 0  | -  |
|            |             | 1        | 4            | <b>RD</b>  | 0    | 1     | 1         | 0         | 1        | 0   | 0                   | <b>1</b>              | <b>1</b> | 0        | 0           | 0        | <b>0</b> | <b>7</b> | <b>F</b> | 0  | D0=FF, D1=00<br>D2=00, D3=FF<br>D4=00, D5=FF<br>D6=FF, D7=00 |
|            |             |          | 5            | D  | 1    | 0     | 0         | 0         | 0        | 0   | 0                   | <b>0</b>              | <b>0</b> | <b>0</b> | 0           | 0        | <b>0</b> | <b>0</b> | <b>0</b> | 0  | -  |
|            |             |          | 6,7          | D#, D#   | 1    | 1     | 1         | 1         | 1        | 0   | 0                   | <b>3</b> <sup>2</sup> | <b>3</b> | 0        | 0           | 0        | <b>0</b> | <b>7</b> | <b>F</b> | 0  | -  |
|            |             | 2        | 8-11         | repeat Sub-Loop 0, use BG[1:0] <sup>2</sup> = 0, BA[1:0] = 2 instead |      |       |           |           |          |     |                     |                       |          |          |             |          |          |          |          |  |  |
|            |             |          | 12-15        | repeat Sub-Loop 1, use BG[1:0] <sup>2</sup> = 1, BA[1:0] = 3 instead |      |       |           |           |          |     |                     |                       |          |          |             |          |          |          |          |  |  |
|            |             |          | 16-19        | repeat Sub-Loop 0, use BG[1:0] <sup>2</sup> = 0, BA[1:0] = 1 instead |      |       |           |           |          |     |                     |                       |          |          |             |          |          |          |          |  |  |
|            |             |          | 20-23        | repeat Sub-Loop 1, use BG[1:0] <sup>2</sup> = 1, BA[1:0] = 2 instead |      |       |           |           |          |     |                     |                       |          |          |             |          |          |          |          |  |  |
|            |             |          | 24-27        | repeat Sub-Loop 0, use BG[1:0] <sup>2</sup> = 0, BA[1:0] = 3 instead |      |       |           |           |          |     |                     |                       |          |          |             |          |          |          |          |  |  |
|            |             |          | 28-31        | repeat Sub-Loop 1, use BG[1:0] <sup>2</sup> = 1, BA[1:0] = 0 instead |      |       |           |           |          |     |                     |                       |          |          |             |          |          |          |          |  |  |
|            |             |          | 32-35        | repeat Sub-Loop 0, use BG[1:0] <sup>2</sup> = 2, BA[1:0] = 0 instead |      |       |           |           |          |     |                     |                       |          |          |             |          |          |          |          |  |  |
|            |             |          | 36-39        | repeat Sub-Loop 1, use BG[1:0] <sup>2</sup> = 3, BA[1:0] = 1 instead |      |       |           |           |          |     |                     |                       |          |          |             |          |          |          |          |  |  |
|            |             |          | 40-43        | repeat Sub-Loop 0, use BG[1:0] <sup>2</sup> = 2, BA[1:0] = 2 instead |      |       |           |           |          |     |                     |                       |          |          |             |          |          |          |          |  |  |
|            |             |          | 44-47        | repeat Sub-Loop 1, use BG[1:0] <sup>2</sup> = 3, BA[1:0] = 3 instead |      |       |           |           |          |     |                     |                       |          |          |             |          |          |          |          |  |  |
|            |             |          | 48-51        | repeat Sub-Loop 0, use BG[1:0] <sup>2</sup> = 2, BA[1:0] = 1 instead |      |       |           |           |          |     |                     |                       |          |          |             |          |          |          |          |  |  |
|            |             |          | 52-55        | repeat Sub-Loop 1, use BG[1:0] <sup>2</sup> = 3, BA[1:0] = 2 instead |      |       |           |           |          |     |                     |                       |          |          |             |          |          |          |          |  |  |
|            |             |          | 56-59        | repeat Sub-Loop 0, use BG[1:0] <sup>2</sup> = 2, BA[1:0] = 3 instead |      |       |           |           |          |     |                     |                       |          |          |             |          |          |          |          |  |  |
|            |             |          | 60-63        | repeat Sub-Loop 1, use BG[1:0] <sup>2</sup> = 3, BA[1:0] = 0 instead |      |       |           |           |          |     |                     |                       |          |          |             |          |          |          |          |  |  |

NOTE 1 DQS\_t, DQS\_c are used according to RD Commands, otherwise VDDQ.

NOTE 2 BG1 is don't care for x16 device

NOTE 3 C[2:0] are used only for 3DS device

NOTE 4 Burst Sequence driven on each DQ signal by Read Command.

For x4 and x8 only

11.1 IDD, IPP and IDDQ Measurement Conditions (cont'd)

**Table 158 — IDD4W, IDD4WA, IDD4WB and IDD4W\_par Measurement-Loop Pattern<sup>1</sup>**

| CK_t, CK_c              | CKE | Sub-Loop | Cycle Number | Command  | CS_n | ACT_n | RAS_n/A16 | CAS_n/A15 | WE_n/A14 | ODT | C[2:0] <sup>3</sup> | BG[1:0] <sup>2</sup> | BA[1:0]  | A12/BC_n | A[17,13,11] | A[10]/AP | A[9:7] | A[6:3] | A[2:0] | Data <sup>4</sup>  |  |
|-------------------------|-----|----------|--------------|--|------|-------|-----------|-----------|----------|-----|---------------------|----------------------|----------|----------|-------------|----------|--------|--------|--------|--|--|
| toggling<br>Static High |     | 0        | 0            | <b>WR</b>  | 0    | 1     | 1         | 0         | 0        | 1   | 0                   | <b>0</b>             | <b>0</b> | 0        | 0           | 0        | 0      | 0      | 0      | D0=00, D1=FF<br>D2=FF, D3=00<br>D4=FF, D5=00<br>D6=00, D7=FF |  |
|                         |     | 1        | D            | 1  | 0    | 0     | 0         | 0         | 0        | 1   | 0                   | <b>0</b>             | <b>0</b> | 0        | 0           | 0        | 0      | 0      | 0      | -  |  |
|                         |     | 2,3      | D#, D#       | 1  | 1    | 1     | 1         | 1         | 1        | 1   | 0                   | <b>3<sup>2</sup></b> | <b>3</b> | 0        | 0           | 0        | 0      | 7      | F      | 0  | -  |
|                         |     | 1        | 4            | <b>WR</b>  | 0    | 1     | 1         | 0         | 0        | 1   | 0                   | <b>1</b>             | <b>1</b> | 0        | 0           | 0        | 0      | 7      | F      | 0  | D0=FF, D1=00<br>D2=00, D3=FF<br>D4=00, D5=FF<br>D6=FF, D7=00 |
|                         |     | 5        | D            | 1  | 0    | 0     | 0         | 0         | 0        | 1   | 0                   | <b>0</b>             | <b>0</b> | 0        | 0           | 0        | 0      | 0      | 0      | -  |  |
|                         |     | 6,7      | D#, D#       | 1  | 1    | 1     | 1         | 1         | 1        | 1   | 0                   | <b>3<sup>2</sup></b> | <b>3</b> | 0        | 0           | 0        | 0      | 7      | F      | 0  | -  |
|                         |     | 2        | 8-11         | repeat Sub-Loop 0, use BG[1:0] <sup>2</sup> = 0, BA[1:0] = 2 instead |      |       |           |           |          |     |                     |                      |          |          |             |          |        |        |        |  |  |
|                         |     | 3        | 12-15        | repeat Sub-Loop 1, use BG[1:0] <sup>2</sup> = 1, BA[1:0] = 3 instead |      |       |           |           |          |     |                     |                      |          |          |             |          |        |        |        |  |  |
|                         |     | 4        | 16-19        | repeat Sub-Loop 0, use BG[1:0] <sup>2</sup> = 0, BA[1:0] = 1 instead |      |       |           |           |          |     |                     |                      |          |          |             |          |        |        |        |  |  |
|                         |     | 5        | 20-23        | repeat Sub-Loop 1, use BG[1:0] <sup>2</sup> = 1, BA[1:0] = 2 instead |      |       |           |           |          |     |                     |                      |          |          |             |          |        |        |        |  |  |
|                         |     | 6        | 24-27        | repeat Sub-Loop 0, use BG[1:0] <sup>2</sup> = 0, BA[1:0] = 3 instead |      |       |           |           |          |     |                     |                      |          |          |             |          |        |        |        |  |  |
|                         |     | 7        | 28-31        | repeat Sub-Loop 1, use BG[1:0] <sup>2</sup> = 1, BA[1:0] = 0 instead |      |       |           |           |          |     |                     |                      |          |          |             |          |        |        |        |  |  |
|                         |     | 8        | 32-35        | repeat Sub-Loop 0, use BG[1:0] <sup>2</sup> = 2, BA[1:0] = 0 instead |      |       |           |           |          |     |                     |                      |          |          |             |          |        |        |        |  |  |
|                         |     | 9        | 36-39        | repeat Sub-Loop 1, use BG[1:0] <sup>2</sup> = 3, BA[1:0] = 1 instead |      |       |           |           |          |     |                     |                      |          |          |             |          |        |        |        |  |  |
|                         |     | 10       | 40-43        | repeat Sub-Loop 0, use BG[1:0] <sup>2</sup> = 2, BA[1:0] = 2 instead |      |       |           |           |          |     |                     |                      |          |          |             |          |        |        |        |  |  |
|                         |     | 11       | 44-47        | repeat Sub-Loop 1, use BG[1:0] <sup>2</sup> = 3, BA[1:0] = 3 instead |      |       |           |           |          |     |                     |                      |          |          |             |          |        |        |        |  |  |
|                         |     | 12       | 48-51        | repeat Sub-Loop 0, use BG[1:0] <sup>2</sup> = 2, BA[1:0] = 1 instead |      |       |           |           |          |     |                     |                      |          |          |             |          |        |        |        |  |  |
|                         |     | 13       | 52-55        | repeat Sub-Loop 1, use BG[1:0] <sup>2</sup> = 3, BA[1:0] = 2 instead |      |       |           |           |          |     |                     |                      |          |          |             |          |        |        |        |  |  |
|                         |     | 14       | 56-59        | repeat Sub-Loop 0, use BG[1:0] <sup>2</sup> = 2, BA[1:0] = 3 instead |      |       |           |           |          |     |                     |                      |          |          |             |          |        |        |        |  |  |
|                         |     | 15       | 60-63        | repeat Sub-Loop 1, use BG[1:0] <sup>2</sup> = 3, BA[1:0] = 0 instead |      |       |           |           |          |     |                     |                      |          |          |             |          |        |        |        |  |  |

NOTE 1 DQS\_t, DQS\_c are used according to WR Commands, otherwise VDDQ.

NOTE 2 BG1 is don't care for x16 device

NOTE 3 C[2:0] are used only for 3DS device

NOTE 4 Burst Sequence driven on each DQ signal by Write Command.

For x4 and x8 only

## 11.1 IDD, IPP and IDDQ Measurement Conditions (cont'd)

**Table 159 — IDD4WC Measurement-Loop Pattern<sup>1</sup>**

| CK_t, CK_c              | CKE  | Sub-Loop | Cycle Number   | Command | CS_n | ACT_n | RAS_n/A16 | CAS_n/A15 | WE_n/A14 | ODT | C[2:0] <sup>c</sup> | BG[1:0] <sup>b</sup> | BA[1:0] | A12/BC_n | A[17,13,11] | A[10]/AP | A[9:7] | A[6:3] | A[2:0] | Data <sup>d</sup>  |
|-------------------------|--|----------|--|---------|------|-------|-----------|-----------|----------|-----|---------------------|----------------------|---------|----------|-------------|----------|--------|--------|--------|--|
| Static High<br>toggling | 0  | 0        | WR   | 0       | 1    | 1     | 0         | 0         | 0        | 1   | 0                   | 0                    | 0       | 0        | 0           | 0        | 0      | 0      | 0      | D0=00, D1=FF<br>D2=FF, D3=00<br>D4=FF, D5=00<br>D6=00, D7=FF<br>D8=CRC |
|                         |  | 1,2      | D, D   | 1       | 0    | 0     | 0         | 0         | 0        | 1   | 0                   | 0                    | 0       | 0        | 0           | 0        | 0      | 0      | 0      | -  |
|                         |  | 3,4      | D#, D#   | 1       | 1    | 1     | 1         | 1         | 1        | 0   | 3 <sup>2</sup>      | 3                    | 0       | 0        | 0           | 0        | 7      | F      | 0      | -  |
|                         |  | 5        | WR   | 0       | 1    | 1     | 0         | 0         | 0        | 1   | 0                   | 1                    | 1       | 0        | 0           | 0        | 0      | 7      | F      | 0  |
|                         |  | 6,7      | D, D   | 1       | 0    | 0     | 0         | 0         | 0        | 1   | 0                   | 0                    | 0       | 0        | 0           | 0        | 0      | 0      | 0      | -  |
|                         |  | 8,9      | D#, D#   | 1       | 1    | 1     | 1         | 1         | 1        | 0   | 3 <sup>2</sup>      | 3                    | 0       | 0        | 0           | 0        | 0      | 7      | F      | 0  |
|                         | 2 10-14<br>3 15-19<br>4 20-24<br>5 25-29<br>6 30-34<br>7 35-39<br>8 40-44<br>9 45-49<br>10 50-54<br>11 55-59<br>12 60-64<br>13 65-69<br>14 70-74<br>15 75-79 | 10-14    | repeat Sub-Loop 0, use <b>BG[1:0]<sup>2</sup> = 0, BA[1:0] = 2 instead</b> |         |      |       |           |           |          |     |                     |                      |         |          |             |          |        |        |        |  |
|                         |  | 15-19    | repeat Sub-Loop 1, use <b>BG[1:0]<sup>2</sup> = 1, BA[1:0] = 3 instead</b> |         |      |       |           |           |          |     |                     |                      |         |          |             |          |        |        |        |  |
|                         |  | 20-24    | repeat Sub-Loop 0, use <b>BG[1:0]<sup>2</sup> = 0, BA[1:0] = 1 instead</b> |         |      |       |           |           |          |     |                     |                      |         |          |             |          |        |        |        |  |
|                         |  | 25-29    | repeat Sub-Loop 1, use <b>BG[1:0]<sup>2</sup> = 1, BA[1:0] = 2 instead</b> |         |      |       |           |           |          |     |                     |                      |         |          |             |          |        |        |        |  |
|                         |  | 30-34    | repeat Sub-Loop 0, use <b>BG[1:0]<sup>2</sup> = 0, BA[1:0] = 3 instead</b> |         |      |       |           |           |          |     |                     |                      |         |          |             |          |        |        |        |  |
|                         |  | 35-39    | repeat Sub-Loop 1, use <b>BG[1:0]<sup>2</sup> = 1, BA[1:0] = 0 instead</b> |         |      |       |           |           |          |     |                     |                      |         |          |             |          |        |        |        |  |
|                         |  | 40-44    | repeat Sub-Loop 0, use <b>BG[1:0]<sup>2</sup> = 2, BA[1:0] = 0 instead</b> |         |      |       |           |           |          |     |                     |                      |         |          |             |          |        |        |        |  |
|                         |  | 45-49    | repeat Sub-Loop 1, use <b>BG[1:0]<sup>2</sup> = 3, BA[1:0] = 1 instead</b> |         |      |       |           |           |          |     |                     |                      |         |          |             |          |        |        |        |  |
|                         |  | 50-54    | repeat Sub-Loop 0, use <b>BG[1:0]<sup>2</sup> = 2, BA[1:0] = 2 instead</b> |         |      |       |           |           |          |     |                     |                      |         |          |             |          |        |        |        |  |
|                         |  | 55-59    | repeat Sub-Loop 1, use <b>BG[1:0]<sup>2</sup> = 3, BA[1:0] = 3 instead</b> |         |      |       |           |           |          |     |                     |                      |         |          |             |          |        |        |        |  |
|                         |  | 60-64    | repeat Sub-Loop 0, use <b>BG[1:0]<sup>2</sup> = 2, BA[1:0] = 1 instead</b> |         |      |       |           |           |          |     |                     |                      |         |          |             |          |        |        |        |  |
|                         |  | 65-69    | repeat Sub-Loop 1, use <b>BG[1:0]<sup>2</sup> = 3, BA[1:0] = 2 instead</b> |         |      |       |           |           |          |     |                     |                      |         |          |             |          |        |        |        |  |
|                         |  | 70-74    | repeat Sub-Loop 0, use <b>BG[1:0]<sup>2</sup> = 2, BA[1:0] = 3 instead</b> |         |      |       |           |           |          |     |                     |                      |         |          |             |          |        |        |        |  |
|                         |  | 75-79    | repeat Sub-Loop 1, use <b>BG[1:0]<sup>2</sup> = 3, BA[1:0] = 0 instead</b> |         |      |       |           |           |          |     |                     |                      |         |          |             |          |        |        |        |  |

NOTE 1 DQS\_t, DQS\_c are VDDQ.

NOTE 2 BG1 is don't care for x16 device.

NOTE 3 C[2:0] are used only for 3DS device.

NOTE 4 Burst Sequence driven on each DQ signal by Write Command.

For x4 and x8 only

11.1 IDD, IPP and IDDQ Measurement Conditions (cont'd)

**Table 160 — IDD5B Measurement-Loop Pattern<sup>1</sup>**

| CK_t, CK_c              | CKE | Sub-Loop | Cycle Number    | Command   | CS_n | ACT_n | RAS_n/A16 | CAS_n/A15 | WE_n/A14 | ODT | C[2:0] <sup>3</sup> | BG[1:0] <sup>2</sup> | BA[1:0] | A12/BC_n | A[17,13,11] | A[10]/AP | A[9:7] | A[6:3] | A[2:0] | Data <sup>4</sup> |  |
|-------------------------|-----|----------|-----------------|---|------|-------|-----------|-----------|----------|-----|---------------------|----------------------|---------|----------|-------------|----------|--------|--------|--------|-------------------|--|
| toggling<br>Static High | 1   | 0        | 0               | REF   | 1    | 0     | 0         | 0         | 0        | 0   | 0                   | 0                    | 0       | 0        | 0           | 0        | 0      | 0      | 0      | -                 |  |
|                         |     | 1        | 1               | D   | 1    | 0     | 0         | 0         | 0        | 0   | 0                   | 0                    | 0       | 0        | 0           | 0        | 0      | 0      | 0      | -                 |  |
|                         |     | 2        |                 | D   | 1    | 0     | 0         | 0         | 0        | 0   | 0                   | 0                    | 0       | 0        | 0           | 0        | 0      | 0      | 0      | -                 |  |
|                         |     | 3        |                 | D#, D#  | 1    | 1     | 1         | 1         | 1        | 0   | 0                   | 3 <sup>2</sup>       | 3       | 0        | 0           | 0        | 7      | F      | 0      | -                 |  |
|                         |     | 4        |                 | D#, D#  | 1    | 1     | 1         | 1         | 1        | 0   | 0                   | 3 <sup>2</sup>       | 3       | 0        | 0           | 0        | 7      | F      | 0      | -                 |  |
|                         |     | 4-7      |                 | repeat pattern 1...4, use <b>BG[1:0]<sup>2</sup> = 1, BA[1:0] = 1 instead</b> |      |       |           |           |          |     |                     |                      |         |          |             |          |        |        |        |                   |  |
|                         |     | 8-11     |                 | repeat pattern 1...4, use <b>BG[1:0]<sup>2</sup> = 0, BA[1:0] = 2 instead</b> |      |       |           |           |          |     |                     |                      |         |          |             |          |        |        |        |                   |  |
|                         |     | 12-15    |                 | repeat pattern 1...4, use <b>BG[1:0]<sup>2</sup> = 1, BA[1:0] = 3 instead</b> |      |       |           |           |          |     |                     |                      |         |          |             |          |        |        |        |                   |  |
|                         |     | 16-19    |                 | repeat pattern 1...4, use <b>BG[1:0]<sup>2</sup> = 0, BA[1:0] = 1 instead</b> |      |       |           |           |          |     |                     |                      |         |          |             |          |        |        |        |                   |  |
|                         |     | 20-23    |                 | repeat pattern 1...4, use <b>BG[1:0]<sup>2</sup> = 1, BA[1:0] = 2 instead</b> |      |       |           |           |          |     |                     |                      |         |          |             |          |        |        |        |                   |  |
|                         |     | 24-27    |                 | repeat pattern 1...4, use <b>BG[1:0]<sup>2</sup> = 0, BA[1:0] = 3 instead</b> |      |       |           |           |          |     |                     |                      |         |          |             |          |        |        |        |                   |  |
|                         |     | 28-31    |                 | repeat pattern 1...4, use <b>BG[1:0]<sup>2</sup> = 1, BA[1:0] = 0 instead</b> |      |       |           |           |          |     |                     |                      |         |          |             |          |        |        |        |                   |  |
|                         |     | 32-35    |                 | repeat pattern 1...4, use <b>BG[1:0]<sup>2</sup> = 2, BA[1:0] = 0 instead</b> |      |       |           |           |          |     |                     |                      |         |          |             |          |        |        |        |                   |  |
|                         |     | 36-39    |                 | repeat pattern 1...4, use <b>BG[1:0]<sup>2</sup> = 3, BA[1:0] = 1 instead</b> |      |       |           |           |          |     |                     |                      |         |          |             |          |        |        |        |                   |  |
|                         |     | 40-43    |                 | repeat pattern 1...4, use <b>BG[1:0]<sup>2</sup> = 2, BA[1:0] = 2 instead</b> |      |       |           |           |          |     |                     |                      |         |          |             |          |        |        |        |                   |  |
|                         |     | 44-47    |                 | repeat pattern 1...4, use <b>BG[1:0]<sup>2</sup> = 3, BA[1:0] = 3 instead</b> |      |       |           |           |          |     |                     |                      |         |          |             |          |        |        |        |                   |  |
|                         |     | 48-51    |                 | repeat pattern 1...4, use <b>BG[1:0]<sup>2</sup> = 2, BA[1:0] = 1 instead</b> |      |       |           |           |          |     |                     |                      |         |          |             |          |        |        |        |                   |  |
|                         |     | 52-55    |                 | repeat pattern 1...4, use <b>BG[1:0]<sup>2</sup> = 3, BA[1:0] = 2 instead</b> |      |       |           |           |          |     |                     |                      |         |          |             |          |        |        |        |                   |  |
|                         |     | 56-59    |                 | repeat pattern 1...4, use <b>BG[1:0]<sup>2</sup> = 2, BA[1:0] = 3 instead</b> |      |       |           |           |          |     |                     |                      |         |          |             |          |        |        |        |                   |  |
|                         |     | 60-63    |                 | repeat pattern 1...4, use <b>BG[1:0]<sup>2</sup> = 3, BA[1:0] = 0 instead</b> |      |       |           |           |          |     |                     |                      |         |          |             |          |        |        |        |                   |  |
|                         |     | 2        | 64 ... nRFC - 1 | repeat Sub-Loop 1, Truncate, if necessary                                     |      |       |           |           |          |     |                     |                      |         |          |             |          |        |        |        |                   |  |

NOTE 1 DQS\_t, DQS\_c are VDDQ.

NOTE 2 BG1 is don't care for x16 device.

NOTE 3 C[2:0] are used only for 3DS device.

NOTE 4 DQ signals are VDDQ.

For x4 and x8  
only

11.1 IDD, IPP and IDDQ Measurement Conditions (cont'd)

Table 161 — IDD7 Measurement-Loop Pattern<sup>1</sup>

| CK_t, CK_c              | CKE | Sub-Loop | Cycle Number  | Command  | CS_n | ACT_n | RAS_n/A16 | CAS_n/A15 | WE_n/A14 | ODT            | C[2:0] <sup>3</sup> | BG[1:0] <sup>2</sup> | BA[1:0] | A12/BC_n | A[17,13,11] | A[10]/AP | A[9:7] | A[6:3] | A[2:0] | Data <sup>4</sup> |  |  |
|-------------------------|-----|----------|---|--|------|-------|-----------|-----------|----------|----------------|---------------------|----------------------|---------|----------|-------------|----------|--------|--------|--------|-------------------|--|--|
| toggling<br>Static High | 0   | 0        | ACT   | 0 0  | 0 0  | 0 0   | 0 0       | 0 0       | 0 0      | 0 0            | 0 0                 | 0 0                  | 0 0     | 0 0      | 0 0         | 0 0      | 0 0    | 0 0    | 0 0    | -                 |  |  |
|                         |     | 1        | RDA   | 0 1  | 1 1  | 0 0   | 1 0       | 0 1       | 0 0      | 0 0            | 0 0                 | 0 0                  | 0 0     | 0 0      | 0 0         | 1 1      | 0 0    | 0 0    | 0 0    | 0 0               | D0=00, D1=FF<br>D2=FF, D3=00<br>D4=FF, D5=00<br>D6=00, D7=FF |  |
|                         |     | 2        | D   | 1 0  | 0 0  | 0 0   | 0 0       | 0 0       | 0 0      | 0 0            | 0 0                 | 0 0                  | 0 0     | 0 0      | 0 0         | 0 0      | 0 0    | 0 0    | 0 0    | 0 0               | -  |  |
|                         |     | 3        | D#  | 1 1  | 1 1  | 1 1   | 1 1       | 1 0       | 0 0      | 3 <sup>2</sup> | 3 3                 | 0 0                  | 0 0     | 0 0      | 0 0         | 7 F      | 0 0    | 0 0    | 0 0    | 0 0               | -  |  |
|                         |     | ...      | repeat pattern 2...3 until nRRD - 1, if nRRD > 4. Truncate if necessary     |  |      |       |           |           |          |                |                     |                      |         |          |             |          |        |        |        |                   |  |  |
|                         |     | 1        | nRRD  | ACT  | 0 0  | 0 0   | 0 0       | 0 0       | 0 0      | 0 1            | 1 1                 | 0 0                  | 0 0     | 0 0      | 0 0         | 0 0      | 0 0    | 0 0    | 0 0    | 0 0               | -  |  |
|                         |     | nRRD + 1 | RDA   | 0 1  | 1 1  | 0 0   | 1 0       | 0 1       | 0 0      | 1 1            | 1 1                 | 0 0                  | 0 0     | 1 1      | 0 0         | 0 0      | 0 0    | 0 0    | 0 0    | 0 0               | D0=FF, D1=00<br>D2=00, D3=FF<br>D4=00, D5=FF<br>D6=FF, D7=00 |  |
|                         |     | ...      | repeat pattern 2 ... 3 until 2*nRRD - 1, if nRRD > 4. Truncate if necessary |  |      |       |           |           |          |                |                     |                      |         |          |             |          |        |        |        |                   |  |  |
|                         |     | 2        | 2*nRRD  | repeat Sub-Loop 0, use BG[1:0] <sup>2</sup> = 0, BA[1:0] = 2 instead           |      |       |           |           |          |                |                     |                      |         |          |             |          |        |        |        |                   |  |  |
|                         |     | 3        | 3*nRRD  | repeat Sub-Loop 1, use BG[1:0] <sup>2</sup> = 1, BA[1:0] = 3 instead           |      |       |           |           |          |                |                     |                      |         |          |             |          |        |        |        |                   |  |  |
|                         |     | 4        | 4*nRRD  | repeat pattern 2 ... 3 until nFAW - 1, if nFAW > 4*nRRD. Truncate if necessary |      |       |           |           |          |                |                     |                      |         |          |             |          |        |        |        |                   |  |  |
|                         |     | 5        | nFAW  | repeat Sub-Loop 0, use BG[1:0] <sup>2</sup> = 0, BA[1:0] = 1 instead           |      |       |           |           |          |                |                     |                      |         |          |             |          |        |        |        |                   |  |  |
|                         |     | 6        | nFAW + nRRD   | repeat Sub-Loop 1, use BG[1:0] <sup>2</sup> = 1, BA[1:0] = 2 instead           |      |       |           |           |          |                |                     |                      |         |          |             |          |        |        |        |                   |  |  |
|                         |     | 7        | nFAW + 2*nRRD   | repeat Sub-Loop 0, use BG[1:0] <sup>2</sup> = 0, BA[1:0] = 3 instead           |      |       |           |           |          |                |                     |                      |         |          |             |          |        |        |        |                   |  |  |
|                         |     | 8        | nFAW + 3*nRRD   | repeat Sub-Loop 1, use BG[1:0] <sup>2</sup> = 1, BA[1:0] = 0 instead           |      |       |           |           |          |                |                     |                      |         |          |             |          |        |        |        |                   |  |  |
|                         |     | 9        | nFAW + 4*nRRD   | repeat Sub-Loop 4  |      |       |           |           |          |                |                     |                      |         |          |             |          |        |        |        |                   |  |  |
|                         |     | 10       | 2*nFAW  | repeat Sub-Loop 0, use BG[1:0] <sup>2</sup> = 2, BA[1:0] = 0 instead           |      |       |           |           |          |                |                     |                      |         |          |             |          |        |        |        |                   |  |  |
|                         |     | 11       | 2*nFAW + nRRD   | repeat Sub-Loop 1, use BG[1:0] <sup>2</sup> = 3, BA[1:0] = 1 instead           |      |       |           |           |          |                |                     |                      |         |          |             |          |        |        |        |                   |  |  |
|                         |     | 12       | 2*nFAW + 2*nRRD   | repeat Sub-Loop 0, use BG[1:0] <sup>2</sup> = 2, BA[1:0] = 2 instead           |      |       |           |           |          |                |                     |                      |         |          |             |          |        |        |        |                   |  |  |
|                         |     | 13       | 2*nFAW + 3*nRRD   | repeat Sub-Loop 1, use BG[1:0] <sup>2</sup> = 3, BA[1:0] = 3 instead           |      |       |           |           |          |                |                     |                      |         |          |             |          |        |        |        |                   |  |  |
|                         |     | 14       | 2*nFAW + 4*nRRD   | repeat Sub-Loop 4  |      |       |           |           |          |                |                     |                      |         |          |             |          |        |        |        |                   |  |  |
|                         |     | 15       | 3*nFAW  | repeat Sub-Loop 0, use BG[1:0] <sup>2</sup> = 2, BA[1:0] = 1 instead           |      |       |           |           |          |                |                     |                      |         |          |             |          |        |        |        |                   |  |  |
|                         |     | 16       | 3*nFAW + nRRD   | repeat Sub-Loop 1, use BG[1:0] <sup>2</sup> = 3, BA[1:0] = 2 instead           |      |       |           |           |          |                |                     |                      |         |          |             |          |        |        |        |                   |  |  |
|                         |     | 17       | 3*nFAW + 2*nRRD   | repeat Sub-Loop 0, use BG[1:0] <sup>2</sup> = 2, BA[1:0] = 3 instead           |      |       |           |           |          |                |                     |                      |         |          |             |          |        |        |        |                   |  |  |
|                         |     | 18       | 3*nFAW + 3*nRRD   | repeat Sub-Loop 1, use BG[1:0] <sup>2</sup> = 3, BA[1:0] = 0 instead           |      |       |           |           |          |                |                     |                      |         |          |             |          |        |        |        |                   |  |  |
|                         |     | 19       | 3*nFAW + 4*nRRD   | repeat Sub-Loop 4  |      |       |           |           |          |                |                     |                      |         |          |             |          |        |        |        |                   |  |  |
|                         |     | 20       | 4*nFAW  | repeat pattern 2 ... 3 until nRC - 1, if nRC > 4*nFAW. Truncate if necessary   |      |       |           |           |          |                |                     |                      |         |          |             |          |        |        |        |                   |  |  |

For x4 and x8  
only

NOTE 1 DQS\_t, DQS\_c are VDDQ.

NOTE 2 BG1 is don't care for x16 device.

NOTE 3 C[2:0] are used only for 3DS device.

NOTE 4 Burst Sequence driven on each DQ signal by Read Command. Outside burst operation, DQ signals are VDDQ.

## 11.2 IDD Specifications

IDD and IPP values are for full operating range of voltage and temperature unless otherwise noted. IDD and IPP values are for full operating range of voltage and temperature unless otherwise noted.

**Table 162 —  $I_{DD}$  and  $I_{DDQ}$  Specification Example**

| Speed Grade Bin |          |          | Unit | NOTE |
|-----------------|----------|----------|------|------|
| Symbol          | IDD Max. | IPP Max. |      |      |
| $I_{DD0}$       |          |          | mA   |      |
| $I_{DD0A}$      |          |          | mA   |      |
| $I_{DD1}$       |          |          | mA   |      |
| $I_{DD1A}$      |          |          | mA   |      |
| $I_{DD2N}$      |          |          | mA   |      |
| $I_{DD2NA}$     |          |          | mA   |      |
| $I_{DD2NT}$     |          |          | mA   |      |
| $I_{DD2QNT}$    |          |          | mA   |      |
| $I_{DD2NL}$     |          |          | mA   |      |
| $I_{DD2NG}$     |          |          | mA   |      |
| $I_{DD2ND}$     |          |          | mA   |      |
| $I_{DD2N\_par}$ |          |          | mA   |      |
| $I_{DD2P}$      |          |          | mA   |      |
| $I_{DD2Q}$      |          |          | mA   |      |
| $I_{DD3N}$      |          |          | mA   |      |
| $I_{DD3NA}$     |          |          | mA   |      |
| $I_{DD3P}$      |          |          | mA   |      |
| $I_{DD4R}$      |          |          | mA   |      |
| $I_{DD4RA}$     |          |          | mA   |      |
| $I_{DD4RB}$     |          |          | mA   |      |
| $I_{DDQ4R}$     |          |          | mA   |      |
| $I_{DDQ4RB}$    |          |          | mA   |      |
| $I_{DD4W}$      |          |          | mA   |      |
| $I_{DD4WA}$     |          |          | mA   |      |
| $I_{DD4WB}$     |          |          | mA   |      |
| $I_{DD4WC}$     |          |          | mA   |      |
| $I_{DD4W\_par}$ |          |          | mA   |      |
| $I_{DD5B}$      |          |          | mA   |      |
| $I_{DD5F2}$     |          |          | mA   |      |
| $I_{DD5F4}$     |          |          | mA   |      |
| $I_{DD6N}$      |          |          | mA   |      |
| $I_{DD6E}$      |          |          | mA   |      |
| $I_{DD6N}$      |          |          | mA   |      |
| $I_{DD6E}^1$    |          |          | mA   |      |
| $I_{DD6R}$      |          |          | mA   |      |
| $I_{DD6A}$      |          |          | mA   |      |
| $I_{DD7}$       |          |          | mA   |      |
| $I_{DD8}$       |          |          | mA   |      |

NOTE 1 Users should refer to the DRAM supplier data sheet and/or the DIMM SPD to determine if DDR4 SDRAM devices support the following options or requirements referred to in this material.

## 11.2 IDD Specifications (cont'd)

**Table 163 —  $I_{PP}$  Specification Example**

| Speed Grade Bin |          |          | Unit | NOTE |
|-----------------|----------|----------|------|------|
| Symbol          | IDD Max. | IPP Max. |      |      |
| $I_{PP0}$       |          |          | mA   |      |
| $I_{PP1}$       |          |          | mA   |      |
| $I_{PP2N}$      |          |          | mA   |      |
| $I_{PP2P}$      |          |          | mA   |      |
| $I_{PP3N}$      |          |          | mA   |      |
| $I_{PP3P}$      |          |          | mA   |      |
| $I_{PP4R}$      |          |          | mA   |      |
| $I_{PP4W}$      |          |          | mA   |      |
| $I_{PP5B}$      |          |          | mA   |      |
| $I_{PP5F2}$     |          |          | mA   |      |
| $I_{PP5F4}$     |          |          | mA   |      |
| $I_{PP5TC}$     |          |          | mA   |      |
| $I_{PP6N}$      |          |          | mA   |      |
| $I_{PP6E}$      |          |          | mA   |      |
| $I_{PP6N}$      |          |          | mA   |      |
| $I_{PP6E}^1$    |          |          | mA   |      |
| $I_{PP6R}$      |          |          | mA   |      |
| $I_{PP6A}$      |          |          | mA   |      |
| $I_{PP7}$       |          |          | mA   |      |
| $I_{PP8}$       |          |          | mA   |      |

NOTE 1 Users should refer to the DRAM supplier data sheet and/or the DIMM SPD to determine if DDR4 SDRAM devices support the following options or requirements referred to in this material.

**Table 164 —  $I_{DD6}$  Specification**

| Symbol     | CT Temperature Range  | IT Temperature Range  | Value | Unit | NOTE    |
|------------|-----------------------|-----------------------|-------|------|---------|
| $I_{DD6N}$ | 0 to 85 °C            | -40 to 85 °C          |       | mA   | 3,4     |
| $I_{DD6E}$ | 0 to 95 °C            | -40 to 95 °C          |       | mA   | 4,5,6   |
| $I_{DD6R}$ | 0 to 45°C             | -40 to 45°C           |       | mA   | 4,6,9   |
| $I_{DD6A}$ | 0 °C ~ $T_a$          | 0 °C ~ $T_a$          |       | mA   | 4,6,7,8 |
|            | $T_b$ ~ $T_y$         | $T_b$ ~ $T_y$         |       | mA   | 4,6,7,8 |
|            | $T_z$ ~ $T_{OPERmax}$ | $T_z$ ~ $T_{OPERmax}$ |       | mA   | 4,6,7,8 |

NOTE 1 Some  $I_{DD}$  currents are higher for x16 organization due to larger page-size architecture.

NOTE 2 Max. values for  $I_{DD}$  currents considering worst case conditions of process, temperature and voltage.

NOTE 3 Applicable for MR2 settings A6=0 and A7=0.

NOTE 4 Supplier data sheets include a max value for  $I_{DD6}$ .

NOTE 5 Applicable for MR2 settings A6=0 and A7=1.  $I_{DD6E}$  is only specified for devices which support the Extended Temperature Range feature.

NOTE 6 Refer to the supplier data sheet for the value specification method (e.g., max, typical) for  $I_{DD6E}$  and  $I_{DD6A}$ .

NOTE 7 Applicable for MR2 settings A6=1 and A7=0.  $I_{DD6A}$  is only specified for devices which support the Auto Self Refresh feature.

NOTE 8 The number of discrete temperature ranges supported and the associated  $T_a$  -  $T_z$  values are supplier/design specific. Temperature ranges are specified for all supported values of  $T_{OPER}$ . Refer to supplier data sheet for more information.

NOTE 9 Applicable for MR2 settings MR2 [A7:A6 = 01] : Reduced Temperature range.  $I_{DD6R}$  is verified by design and characterization, and may not be subject to production test

## 12 Input/Output Capacitance

**Table 165 — Silicon pad I/O Capacitance**

| Symbol             | Parameter                                      | DDR4-1600,1866,2133 |      | DDR4-2400,2666 |      | DDR4-2933 |      | DDR4-3200 |      | Unit | NOTE     |
|--------------------|--|---------------------|------|----------------|------|-----------|------|-----------|------|------|----------|
|                    |  | min                 | max  | min            | max  | min       | max  | min       | max  |      |          |
| $C_{IO}$           | Input/output capacitance                       | 0.55                | 1.4  | 0.55           | 1.15 | 0.55      | 1.00 | 0.55      | 1.00 | pF   | 1,2,3    |
| $C_{DIO}$          | Input/output capacitance delta                 | -0.1                | 0.1  | -0.1           | 0.1  | -0.1      | 0.1  | -0.1      | 0.1  | pF   | 1,2,3,11 |
| $C_{DDQS}$         | Input/output capacitance delta DQS_t and DQS_c | -                   | 0.05 | -              | 0.05 | -         | 0.05 | -         | 0.05 | pF   | 1,2,3,5  |
| $C_{CK}$           | Input capacitance, CK_t and CK_c               | 0.2                 | 0.8  | 0.2            | 0.7  | 0.2       | 0.7  | 0.2       | 0.7  | pF   | 1,3      |
| $C_{DCK}$          | Input capacitance delta CK_t and CK_c          | -                   | 0.05 | -              | 0.05 | -         | 0.05 | -         | 0.05 | pF   | 1,3,4    |
| $C_I$              | Input capacitance(CTRL, ADD, CMD pins only)    | 0.2                 | 0.8  | 0.2            | 0.7  | 0.2       | 0.6  | 0.2       | 0.55 | pF   | 1,3,6    |
| $C_{DI\_CTRL}$     | Input capacitance delta(All CTRL pins only)    | -0.1                | 0.1  | -0.1           | 0.1  | -0.1      | 0.1  | -0.1      | 0.1  | pF   | 1,3,7,8  |
| $C_{DI\_ADD\_CMD}$ | Input capacitance delta(All ADD/CMD pins only) | -0.1                | 0.1  | -0.1           | 0.1  | -0.1      | 0.1  | -0.1      | 0.1  | pF   | 1,2,9,10 |
| $C_{ALERT}$        | Input/output capacitance of ALERT              | 0.5                 | 1.5  | 0.5            | 1.5  | 0.5       | 1.5  | 0.5       | 1.5  | pF   | 1,3      |
| $C_{ZQ}$           | Input/output capacitance of ZQ                 | -                   | 2.3  | -              | 2.3  | -         | 2.3  | -         | 2.3  | pF   | 1,3,12   |
| $C_{TEN}$          | Input capacitance of TEN                       | 0.2                 | 2.3  | 0.2            | 2.3  | 0.2       | 2.3  | 0.2       | 2.3  | pF   | 1,3,13   |

NOTE 1 This parameter is not subject to production test. It is verified by design and characterization. The silicon only capacitance is validated by de-embedding the package L & C parasitic. The capacitance is measured with VDD, VDDQ, VSS, VSSQ applied with all other signal pins floating. Measurement procedure tbd.

NOTE 2 DQ, DM\_n, DQS\_T, DQS\_C, TDQS\_T, TDQS\_C. Although the DM, TDQS\_T and TDQS\_C pins have different functions, the loading matches DQ and DQS

NOTE 3. This parameter applies to monolithic devices only; stacked/dual-die devices are not covered here

NOTE 4 Absolute value CK\_T-CK\_C

NOTE 5 Absolute value of CIO(DQS\_T)-CIO(DQS\_C)

NOTE 6 CI applies to ODT, CS\_n, CKE, A0-A17, BA0-BA1, BG0-BG1, RAS\_n/A16, CAS\_n/A15, WE\_n/A14, ACT\_n and PAR.

NOTE 7 CDI CTRL applies to ODT, CS\_n and CKE

NOTE 8 CDI\_CTRL = CI(CTRL)-0.5\*(CI(CK\_t)+CI(CK\_c))

NOTE 9 CDI\_ADD\_CMD applies to, A0-A17, BA0-BA1, BG0-BG1,RAS\_n/A16, CAS\_n/A15, WE\_n/A14, ACT\_n and PAR.

NOTE 10 CDI\_ADD\_CMD = CI(ADD\_CMD)-0.5\*(CI(CK\_t)+CI(CK\_c))

NOTE 11 CDIO = CIO(DQ,DM)-0.5\*(CIO(DQS\_T)+CIO(DQS\_C))

NOTE 12 Maximum external load capacitance on ZQ pin: tbd pF.

NOTE 13 TEN pin may be DRAM internally pulled low through a weak pull-down resistor to VSS. In this case CTEN might not be valid and system shall verify TEN signal with Vendor specific information.

12 Input/Output Capacitance (cont'd)

**Table 166 — DRAM package electrical specifications (X4/X8)**

| Symbol                 | Parameter                     | DDR4-<br>1600,1866,2133,<br>2400,2666 |      | DDR4-2933 |      | DDR4-3200 |      | Unit | NOTE              |
|------------------------|-------------------------------|---------------------------------------|------|-----------|------|-----------|------|------|-------------------|
|                        |                               | min                                   | max  | min       | max  | min       | max  |      |                   |
| Z <sub>IO</sub>        | Input/output Zpkg             | 45                                    | 85   | 48        | 85   | 48        | 85   | Ω    | 1,2,4,5,10,<br>11 |
| T <sub>dIO</sub>       | Input/output Pkg Delay        | 14                                    | 42   | 14        | 40   | 14        | 40   | ps   | 1,3,4,5,11        |
| L <sub>io</sub>        | Input/Output Lpkg             | -                                     | 3.3  | -         | 3.3  | -         | 3.3  | nH   | 11, 12            |
| C <sub>io</sub>        | Input/Output Cpkg             | -                                     | 0.78 | -         | 0.78 | -         | 0.78 | pF   | 11, 13            |
| Z <sub>IO DQS</sub>    | DQS_t, DQS_c Zpkg             | 45                                    | 85   | 48        | 85   | 48        | 85   | Ω    | 1,2,5,10,11       |
| T <sub>dIO DQS</sub>   | DQS_t, DQS_c Pkg Delay        | 14                                    | 42   | 14        | 40   | 14        | 40   | ps   | 1,3,5,10,11       |
| L <sub>io DQS</sub>    | DQS Lpkg                      | -                                     | 3.3  | -         | 3.3  | -         | 3.3  | nH   | 11, 12            |
| C <sub>io DQS</sub>    | DQS Cpkg                      | -                                     | 0.78 | -         | 0.78 | -         | 0.78 | pF   | 11, 13            |
| DZ <sub>DIO DQS</sub>  | Delta Zpkg DQS_t, DQS_c       | -                                     | 10   | -         | 10   | -         | 10   | Ω    | 1,2,5,7,10        |
| D <sub>TdDIO DQS</sub> | Delta Delay DQS_t, DQS_c      | -                                     | 5    | -         | 5    | -         | 5    | ps   | 1,3,5,7,10        |
| Z <sub>I CTRL</sub>    | Input- CTRL pins Zpkg         | 50                                    | 90   | 50        | 90   | 50        | 90   | Ω    | 1,2,5,9,10,<br>11 |
| T <sub>dI_CTRL</sub>   | Input- CTRL pins Pkg Delay    | 14                                    | 42   | 14        | 40   | 14        | 40   | ps   | 1,3,5,9,10,<br>11 |
| L <sub>i CTRL</sub>    | Input CTRL Lpkg               | -                                     | 3.4  | -         | 3.4  | -         | 3.4  | nH   | 11, 12            |
| C <sub>i CTRL</sub>    | Input CTRL Cpkg               | -                                     | 0.7  | -         | 0.7  | -         | 0.7  | pF   | 11, 13            |
| Z <sub>IADD CMD</sub>  | Input- CMD ADD pins Zpkg      | 50                                    | 90   | 50        | 90   | 50        | 90   | Ω    | 1,2,5,8,10,<br>11 |
| T <sub>dIADD_CMD</sub> | Input- CMD ADD pins Pkg Delay | 14                                    | 45   | 14        | 40   | 14        | 40   | ps   | 1,3,5,8,10,<br>11 |
| L <sub>i ADD CMD</sub> | Input CMD ADD Lpkg            | -                                     | 3.6  | -         | 3.6  | -         | 3.6  | nH   | 11, 12            |
| C <sub>i ADD CMD</sub> | Input CMD ADD Cpkg            | -                                     | 0.74 | -         | 0.74 | -         | 0.74 | pF   | 11, 13            |
| Z <sub>CK</sub>        | CK_t & CK_c Zpkg              | 50                                    | 90   | 50        | 90   | 50        | 90   | Ω    | 1,2,5,10,11       |
| T <sub>dCK</sub>       | CK_t & CK_c Pkg Delay         | 14                                    | 42   | 14        | 42   | 14        | 42   | ps   | 1,3,5,10,11       |
| L <sub>i CLK</sub>     | Input CK Lpkg                 | -                                     | 3.4  | -         | 3.4  | -         | 3.4  | nH   | 11, 12            |
| C <sub>i CLK</sub>     | Input CK Cpkg                 | -                                     | 0.7  | -         | 0.7  | -         | 0.7  | pF   | 11, 13            |
| DZ <sub>DCK</sub>      | Delta Zpkg CK_t & CK_c        | -                                     | 10   | -         | 10   | -         | 10   | Ω    | 1,2,5,6,10        |
| D <sub>TdCK</sub>      | Delta Delay CK_t & CK_c       | -                                     | 5    | -         | 5    | -         | 5    | ps   | 1,3,5,6,10        |
| Z <sub>OZQ</sub>       | ZQ Zpkg                       | -                                     | 100  | -         | 100  | -         | 100  | Ω    | 1,2,5,10,11       |
| T <sub>dO ZQ</sub>     | ZQ Delay                      | 20                                    | 90   | 20        | 90   | 20        | 90   | ps   | 1,3,5,10,11       |
| Z <sub>O ALERT</sub>   | ALERT Zpkg                    | 40                                    | 100  | 40        | 100  | 40        | 100  | Ω    | 1,2,5,10,11       |
| T <sub>dO ALERT</sub>  | ALERT Delay                   | 20                                    | 55   | 20        | 55   | 20        | 55   | ps   | 1,3,5,10,11       |

NOTE 1 This parameter is not subject to production test. It is verified by design and characterization. The package parasitic (L & C) are validated using package only samples. The capacitance is measured with VDD, VDDQ, VSS, VSSQ shorted with all other signal pins floating. The inductance is measured with VDD, VDDQ, VSS and VSSQ shorted and all other signal pins shorted at the die side(not pin). Measurement procedure tbd

NOTE 2 Package only impedance (Zpkg) is calculated based on the Lpkg and Cpkg total for a given pin where:

$$Z_{\text{pkg}} (\text{total per pin}) = \sqrt{L_{\text{pkg}}/C_{\text{pkg}}}$$

NOTE 3 Package only delay(Tpkg) is calculated based on Lpkg and Cpkg total for a given pin where:

$$T_{\text{pkg}} (\text{total per pin}) = \sqrt{L_{\text{pkg}} * C_{\text{pkg}}}$$

NOTE 4 Z & Td IO applies to DQ, DM, TDQS\_T and TDQS\_C

**Table 131 — DRAM package electrical specifications (X4/X8) (cont'd)**

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NOTE 5 This parameter applies to monolithic devices only; stacked/dual-die devices are not covered here.  
 NOTE 6 Absolute value of ZCK\_t-ZCK\_c for impedance(Z) or absolute value of TdCK\_t-TdCK\_c for delay(Td).  
 NOTE 7 Absolute value of ZIO(DQS\_t)-ZIO(DQS\_c) for impedance(Z) or absolute value of TdIO(DQS\_t)-TdIO(DQS\_c) for delay(Td).  
 NOTE 8 ZI & Td ADD CMD applies to A0-A13,A17, ACT\_n BA0-BA1, BG0-BG1, RAS\_n/A16 CAS\_n/A15, WE\_n/A14 and PAR  
 NOTE 9 ZI & Td CTRL applies to ODT, CS\_n and CKE  
 NOTE 10 This table applies to monolithic X4 and X8 devices.  
 NOTE 11 Package implementations shall meet spec if the Zpkg and Pkg Delay fall within the ranges shown, and the maximum Lpkg and Cpkg do not exceed the maximum values shown.  
 NOTE 12 It is assumed that Lpkg can be approximated as Lpkg = Zo\*Td.  
 NOTE 13 It is assumed that Cpkg can be approximated as Cpkg = Td/Zo.

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**Table 167 — DRAM package electrical specifications (X16)**

| Symbol                 | Parameter                     | DDR4-1600,1866,2133,2400,2666,2933,3200 |      | Unit | NOTE |
|------------------------|-------------------------------|---|------|------|------|
|                        |                               | min                                     | max  |      |      |
| Z <sub>IO</sub>        | Input/output Zpkg             | 45                                      | 85   | Ω    | 1    |
| T <sub>dIO</sub>       | Input/output Pkg Delay        | 14                                      | 45   | ps   | 1    |
| L <sub>io</sub>        | Input/Output Lpkg             | -                                       | 3.4  | nH   | 1, 2 |
| C <sub>io</sub>        | Input/Output Cpkg             | -                                       | 0.82 | pF   | 1, 3 |
| Z <sub>IO DQS</sub>    | DQS_t, DQS_c Zpkg             | 45                                      | 85   | Ω    | 1    |
| T <sub>dIO DQS</sub>   | DQS_t, DQS_c Pkg Delay        | 14                                      | 45   | ps   | 1    |
| L <sub>io DQS</sub>    | DQS Lpkg                      | -                                       | 3.4  | nH   | 1, 2 |
| C <sub>io DQS</sub>    | DQS Cpkg                      | -                                       | 0.82 | pF   | 1, 3 |
| DZ <sub>DIO DQS</sub>  | Delta Zpkg DQSU_t, DQSU_c     | -                                       | 10   | Ω    | -    |
|                        | Delta Zpkg DQSL_t, DQSL_c     | -                                       | 10   | Ω    | -    |
| D <sub>TdDIO DQS</sub> | Delta Delay DQSU_t, DQSU_c    | -                                       | 5    | ps   | -    |
|                        | Delta Delay DQSL_t, DQSL_c    | -                                       | 5    | ps   | -    |
| Z <sub>I CTRL</sub>    | Input CTRL pins Zpkg          | 50                                      | 90   | Ω    | 1    |
| T <sub>dI_CTRL</sub>   | Input CTRL pins Pkg Delay     | 14                                      | 42   | ps   | 1    |
| L <sub>i CTRL</sub>    | Input CTRL Lpkg               | -                                       | 3.4  | nH   | 1, 2 |
| C <sub>i CTRL</sub>    | Input CTRL Cpkg               | -                                       | 0.7  | pF   | 1, 3 |
| Z <sub>IADD CMD</sub>  | Input- CMD ADD pins Zpkg      | 50                                      | 90   | Ω    | 1    |
| T <sub>dIADD_CMD</sub> | Input- CMD ADD pins Pkg Delay | 14                                      | 52   | ps   | 1    |
| L <sub>i ADD CMD</sub> | Input CMD ADD Lpkg            | -                                       | 3.9  | nH   | 1, 2 |
| C <sub>i ADD CMD</sub> | Input CMD ADD Cpkg            | -                                       | 0.86 | pF   | 1, 3 |
| Z <sub>CK</sub>        | CK_c Zpkg                     | 50                                      | 90   | Ω    | 1    |
| T <sub>dCK</sub>       | CK_c Pkg Delay                | 14                                      | 42   | ps   | 1    |
| L <sub>i CLK</sub>     | Input CK Lpkg                 | -                                       | 3.4  | nH   | 1, 2 |
| C <sub>i CLK</sub>     | Input CK Cpkg                 | -                                       | 0.7  | pF   | 1, 3 |
| DZ <sub>DCK</sub>      | Delta Zpkg CK_c               | -                                       | 10   | Ω    | -    |
| D <sub>TdCK</sub>      | Delta Delay CK_c              | -                                       | 5    | ps   | -    |
| Z <sub>OZQ</sub>       | ZQ Zpkg                       | -                                       | 100  | Ω    | -    |
| T <sub>dO ZQ</sub>     | ZQ Delay                      | 20                                      | 90   | ps   | -    |
| Z <sub>O ALERT</sub>   | ALERT Zpkg                    | 40                                      | 100  | Ω    | -    |
| T <sub>dO ALERT</sub>  | ALERT Delay                   | 20                                      | 55   | ps   | -    |

NOTE 1 Package implementations shall meet spec if the Zpkg and Pkg Delay fall within the ranges shown, and the maximum Lpkg and Cpkg do not exceed the maximum value shown

NOTE 2 It is assumed that Lpkg can be approximated as Lpkg = Zo\*Td

NOTE 3 It is assumed that Cpkg can be approximated as Cpkg = Td/Zo

## 13 Electrical Characteristics & AC Timing

### 13.1 Reference Load for AC Timing and Output Slew Rate

Figure 226 represents the effective reference load of 50 ohms used in defining the relevant AC timing parameters of the device as well as output slew rate measurements.

Ron nominal of DQ, DQS\_t and DQS\_c drivers uses 34 ohms to specify the relevant AC timing parameter values of the device.

The maximum DC High level of Output signal =  $1.0 * VDDQ$ ,

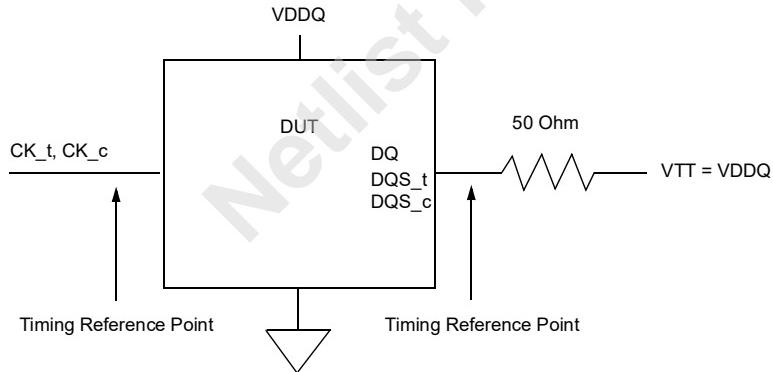
The minimum DC Low level of Output signal =  $\{ 34 / (34 + 50) \} * VDDQ = 0.4 * VDDQ$

The nominal reference level of an Output signal can be approximated by the following:

The center of maximum DC High and minimum DC Low =  $\{ (1 + 0.4) / 2 \} * VDDQ = 0.7 * VDDQ$

The actual reference level of Output signal might vary with driver Ron and reference load tolerances. Thus, the actual reference level or midpoint of an output signal is at the widest part of the output signal's eye. Prior to measuring AC parameters, the reference level of the verification tool should be set to an appropriate level.

It is not intended as a precise representation of any particular system environment or a depiction of the actual load presented by a production tester. System designers should use IBIS or other simulation tools to correlate the timing reference load to a system environment. Manufacturers correlate to their production test conditions, generally one or more coaxial transmission lines terminated at the tester electronics.



**Figure 226 — Reference Load for AC Timing and Output Slew Rate**

### 13.2 tREFI

Average periodic Refresh interval (tREFI) of DDR4 SDRAM is defined as shown in the table.

**Table 168 — tREFI by device density**

| Parameter                         | Symbol |   | 2Gb | 4Gb | 8Gb | 16Gb | Units         |
|-----------------------------------|--------|---|-----|-----|-----|------|---------------|
| Average periodic refresh interval | tREFI  | $0^{\circ}\text{C} \leq \text{TCASE} \leq 85^{\circ}\text{C}$ | 7.8 | 7.8 | 7.8 | 7.8  | $\mu\text{s}$ |
|                                   |        | $85^{\circ}\text{C} < \text{TCASE} \leq 95^{\circ}\text{C}$   | 3.9 | 3.9 | 3.9 | 3.9  | $\mu\text{s}$ |

### 13.3 Clock Specification

The jitter specified is a random jitter meeting a Gaussian distribution. Input clocks violating the min/max values may result in malfunction of the DDR4 SDRAM device.

### 13.3.1 Definition for tCK(abs)

tCK(abs) is defined as the absolute clock period, as measured from one rising edge to the next consecutive rising edge. tCK(abs) is not subject to production test.

### 13.3.2 Definition for tCK(avg)

tCK(avg) is calculated as the average clock period across any consecutive 200 cycle window, where each clock period is calculated from rising edge to rising edge.

$$tCK(\text{avg}) = \left( \sum_{j=1}^N tCK(\text{abs})_j \right) / N \quad N = 200$$

### 13.3.3 Definition for tCH(avg) and tCL(avg)

tCH(avg) is defined as the average high pulse width, as calculated across any consecutive 200 high pulses.

$$tCH(\text{avg}) = \left( \sum_{j=1}^N tCH_j \right) / \{ N \times tCK(\text{avg}) \} \quad N = 200$$

tCL(avg) is defined as the average low pulse width, as calculated across any consecutive 200 low pulses.

$$tCL(\text{avg}) = \left( \sum_{j=1}^N tCL_j \right) / \{ N \times tCK(\text{avg}) \} \quad N = 200$$

### 13.3.4 Definition for tERR(nper)

tERR is defined as the cumulative error across n consecutive cycles of n x tCK(avg). tERR is not subject to production test.

### 13.4 Timing Parameters by Speed Grade

**Table 169 — for DDR4-1600 to DDR4-2133**

| Speed   |               | DDR4-1600  |                                  | DDR4-1866                      |                                  | DDR4-2133                      |                                  | Units    | NOTE  |
|---|---------------|--|----------------------------------|--------------------------------|----------------------------------|--------------------------------|----------------------------------|----------|-------|
| Parameter   | Symbol        | MIN  | MAX                              | MIN                            | MAX                              | MIN                            | MAX                              |          |       |
| <b>Clock Timing</b>   |               |  |                                  |                                |                                  |                                |                                  |          |       |
| Minimum Clock Cycle Time (DLL off mode)   | tCK(DLL_OFF)  | 8  | 20                               | 8                              | 20                               | 8                              | 20                               | ns       |       |
| Average Clock Period  | tCK(avg)      | 1.25   | <1.5                             | 1.071                          | <1.25                            | 0.937                          | <1.071                           | ns       | 35,36 |
| Average high pulse width  | tCH(avg)      | 0.48   | 0.52                             | 0.48                           | 0.52                             | 0.48                           | 0.52                             | tCK(avg) |       |
| Average low pulse width   | tCL(avg)      | 0.48   | 0.52                             | 0.48                           | 0.52                             | 0.48                           | 0.52                             | tCK(avg) |       |
| Absolute Clock Period   | tCK(abs)      | tCK(avg)min + tJIT(per)min_tot   | tCK(avg)m ax + tJIT(per)m ax_tot | tCK(avg)min + tJIT(per)min_tot | tCK(avg)m ax + tJIT(per)m ax_tot | tCK(avg)min + tJIT(per)min_tot | tCK(avg)m ax + tJIT(per)m ax_tot | tCK(avg) |       |
| Absolute clock HIGH pulse width   | tCH(abs)      | 0.45   | -                                | 0.45                           | -                                | 0.45                           | -                                | tCK(avg) | 23    |
| Absolute clock LOW pulse width  | tCL(abs)      | 0.45   | -                                | 0.45                           | -                                | 0.45                           | -                                | tCK(avg) | 24    |
| Clock Period Jitter- total  | JIT(per)_tot  | -63  | 63                               | -54                            | 54                               | -47                            | 47                               | ps       | 23    |
| Clock Period Jitter- deterministic  | JIT(per)_dj   | -31  | 31                               | -27                            | 27                               | -23                            | 23                               | ps       | 26    |
| Clock Period Jitter during DLL locking period                                       | tJIT(cc, lck) | -50  | 50                               | -43                            | 43                               | -38                            | 38                               | ps       |       |
| Cycle to Cycle Period Jitter  | tJIT(cc)      | -  | 125                              | -                              | 107                              | -                              | 94                               | ps       |       |
| Cycle to Cycle Period Jitter during DLL locking period                              | tJIT(cc, lck) | -  | 100                              | -                              | 86                               | -                              | 75                               | ps       |       |
| Cumulative error across 2 cycles  | tERR(2per)    | -92  | 92                               | -79                            | 79                               | -69                            | 69                               | ps       |       |
| Cumulative error across 3 cycles  | tERR(3per)    | -109   | 109                              | -94                            | 94                               | -82                            | 82                               | ps       |       |
| Cumulative error across 4 cycles  | tERR(4per)    | -121   | 121                              | -104                           | 104                              | -91                            | 91                               | ps       |       |
| Cumulative error across 5 cycles  | tERR(5per)    | -131   | 131                              | -112                           | 112                              | -98                            | 98                               | ps       |       |
| Cumulative error across 6 cycles  | tERR(6per)    | -139   | 139                              | -119                           | 119                              | -104                           | 104                              | ps       |       |
| Cumulative error across 7 cycles  | tERR(7per)    | -145   | 145                              | -124                           | 124                              | -109                           | 109                              | ps       |       |
| Cumulative error across 8 cycles  | tERR(8per)    | -151   | 151                              | -129                           | 129                              | -113                           | 113                              | ps       |       |
| Cumulative error across 9 cycles  | tERR(9per)    | -156   | 156                              | -134                           | 134                              | -117                           | 117                              | ps       |       |
| Cumulative error across 10 cycles   | tERR(10per)   | -160   | 160                              | -137                           | 137                              | -120                           | 120                              | ps       |       |
| Cumulative error across 11 cycles   | tERR(11per)   | -164   | 164                              | -141                           | 141                              | -123                           | 123                              | ps       |       |
| Cumulative error across 12 cycles   | tERR(12per)   | -168   | 168                              | -144                           | 144                              | -126                           | 126                              | ps       |       |
| Cumulative error across 13 cycles   | tERR(13per)   | -172   | 172                              | -147                           | 147                              | -129                           | 129                              | ps       |       |
| Cumulative error across 14 cycles   | tERR(14per)   | -175   | 175                              | -150                           | 150                              | -131                           | 131                              | ps       |       |
| Cumulative error across 15 cycles   | tERR(15per)   | -178   | 178                              | -152                           | 152                              | -133                           | 133                              | ps       |       |
| Cumulative error across 16 cycles   | tERR(16per)   | -180   | 189                              | -155                           | 155                              | -135                           | 135                              | ps       |       |
| Cumulative error across 17 cycles   | tERR(17per)   | -183   | 183                              | -157                           | 157                              | -137                           | 137                              | ps       |       |
| Cumulative error across 18 cycles   | tERR(18per)   | -185   | 185                              | -159                           | 159                              | -139                           | 139                              | ps       |       |
| Cumulative error across n = 13, 14 ... 49, 50 cycles                                | tERR(nper)    | $tERR(nper)min = ((1 + 0.68\ln(n)) * tJIT(per)_total min)$<br>$tERR(nper)max = ((1 + 0.68\ln(n)) * tJIT(per)_total max)$ |                                  |                                |                                  |                                |                                  | ps       |       |
| Command and Address setup time to CK_t, CK_c referenced to Vih(ac) / Vil(ac) levels | tIS(base)     | 115  | -                                | 100                            | -                                | 80                             | -                                | ps       |       |
| Command and Address setup time to CK_t, CK_c referenced to Vref levels              | tIS(Vref)     | 215  | -                                | 200                            | -                                | 180                            | -                                | ps       |       |
| Command and Address hold time to CK_t, CK_c referenced to Vih(dc) / Vil(dc) levels  | tIH(base)     | 140  | -                                | 125                            | -                                | 105                            | -                                | ps       |       |
| Command and Address hold time to CK_t, CK_c referenced to Vref levels               | tIH(Vref)     | 215  | -                                | 200                            | -                                | 180                            | -                                | ps       |       |
| Control and Address Input pulse width for each input                                | tIPW          | 600  | -                                | 525                            | -                                | 460                            | -                                | ps       |       |
| <b>Command and Address Timing</b>   |               |  |                                  |                                |                                  |                                |                                  |          |       |
| CAS_n to CAS_n command delay for same bank group                                    | tCCD_L        | max(5 nCK, 6.250 ns)   | -                                | max(5 nCK, 5.355 ns)           | -                                | max(5 nCK, 5.355 ns)           | -                                | nCK      | 34    |
| CAS_n to CAS_n command delay for different bank group                               | tCCD_S        | 4  | -                                | 4                              | -                                | 4                              | -                                | nCK      | 34    |

Table 169 — for DDR4-1600 to DDR4-2133 (cont'd)

| Speed   |               | DDR4-1600                                  |      | DDR4-1866               |      | DDR4-2133               |      | Units      | NOTE              |
|---|---------------|--|------|-------------------------|------|-------------------------|------|------------|-------------------|
| Parameter   | Symbol        | MIN  | MAX  | MIN                     | MAX  | MIN                     | MAX  |            |                   |
| <b>Command and Address Timing (cont'd)</b>  |               |  |      |                         |      |                         |      |            |                   |
| ACTIVATE to ACTIVATE Command delay to different bank group for 2KB page size  | tRRD_S(2K)    | Max(4nCK,6ns)                              | -    | Max(4nCK,5.3ns)         | -    | Max(4nCK,5.3ns)         | -    | nCK        | 34                |
| ACTIVATE to ACTIVATE Command delay to different bank group for 2KB page size  | tRRD_S(1K)    | Max(4nCK,5ns)                              | -    | Max(4nCK,4.2ns)         | -    | Max(4nCK,3.7ns)         | -    | nCK        | 34                |
| ACTIVATE to ACTIVATE Command delay to different bank group for 1/2KB page size  | tRRD_S(1/2K)  | Max(4nCK,5ns)                              | -    | Max(4nCK,4.2ns)         | -    | Max(4nCK,3.7ns)         | -    | nCK        | 34                |
| ACTIVATE to ACTIVATE Command delay to same bank group for 2KB page size   | tRRD_L(2K)    | Max(4nCK,7.5ns)                            | -    | Max(4nCK,6.4ns)         | -    | Max(4nCK,6.4ns)         | -    | nCK        | 34                |
| ACTIVATE to ACTIVATE Command delay to same bank group for 1KB page size   | tRRD_L(1K)    | Max(4nCK,6ns)                              | -    | Max(4nCK,5.3ns)         | -    | Max(4nCK,5.3ns)         | -    | nCK        | 34                |
| ACTIVATE to ACTIVATE Command delay to same bank group for 1/2KB page size   | tRRD_L(1/2K)  | Max(4nCK,6ns)                              | -    | Max(4nCK,5.3ns)         | -    | Max(4nCK,5.3ns)         | -    | nCK        | 34                |
| Four activate window for 2KB page size  | tFAW_2K       | Max(28nCK,35ns)                            | -    | Max(28nCK,30ns)         | -    | Max(28nCK,30ns)         | -    | ns         | 34                |
| Four activate window for 1KB page size  | tFAW_1K       | Max(20nCK,25ns)                            | -    | Max(20nCK,23ns)         | -    | Max(20nCK,21ns)         | -    | ns         | 34                |
| Four activate window for 1/2KB page size  | tFAW_1/2K     | Max(16nCK,20ns)                            | -    | Max(16nCK,17ns)         | -    | Max(16nCK,15ns)         | -    | ns         | 34                |
| Delay from start of internal write transaction to internal read command for different bank group                              | tWTR_S        | max(2nCK,2.5ns)                            | -    | max(2nCK,2.5ns)         | -    | max(2nCK,2.5ns)         | -    |            | 1,2,e, 34         |
| Delay from start of internal write transaction to internal read command for same bank group                                   | tWTR_L        | max(4nCK,7.5ns)                            | -    | max(4nCK,7.5ns)         | -    | max(4nCK,7.5ns)         | -    |            | 1,34              |
| Internal READ Command to PRECHARGE Command delay  | tRTP          | max(4nCK,7.5ns)                            | -    | max(4nCK,7.5ns)         | -    | max(4nCK,7.5ns)         | -    |            |                   |
| WRITE recovery time   | tWR           | 15   | -    | 15                      | -    | 15                      | -    | ns         | 1                 |
| Write recovery time when CRC and DM are enabled   | tWR_CRC_DM    | tWR+max(4nCK,3.75ns)                       | -    | tWR+max(5nCK,3.75ns)    | -    | tWR+max(5nCK,3.75ns)    | -    | ns         | 1, 28             |
| delay from start of internal write transaction to internal read command for different bank group with both CRC and DM enabled | tWTR_S_CRC_DM | tWTR_S+max(4nCK,3.75ns)                    | -    | tWTR_S+max(5nCK,3.75ns) | -    | tWTR_S+max(5nCK,3.75ns) | -    | ns         | 2, 29, 34         |
| delay from start of internal write transaction to internal read command for same bank group with both CRC and DM enabled      | tWTR_L_CRC_DM | tWTR_L+max(4nCK,3.75ns)                    | -    | tWTR_L+max(5nCK,3.75ns) | -    | tWTR_L+max(5nCK,3.75ns) | -    | ns         | 3,30, 34          |
| DLL locking time  | tDLLK         | 597  | -    | 597                     | -    | 768                     | -    | nCK        |                   |
| Mode Register Set command cycle time  | tMRD          | 8  | -    | 8                       | -    | 8                       | -    | nCK        |                   |
| Mode Register Set command update delay  | tMOD          | max(24nCK,15ns)                            | -    | max(24nCK,15ns)         | -    | max(24nCK,15ns)         | -    |            | 50                |
| Multi-Purpose Register Recovery Time  | tMPRR         | 1  | -    | 1                       | -    | 1                       | -    | nCK        | 33                |
| Multi Purpose Register Write Recovery Time  | tWR_MPR       | tMOD (min) + AL + PL                       | -    | tMOD (min) + AL + PL    | -    | tMOD (min) + AL + PL    | -    | -          |                   |
| Auto precharge write recovery + precharge time  | tDAL(min)     | Programmed WR + roundup ( tRP / tCK(avg) ) |      |                         |      |                         |      | nCK        | 52                |
| DQ0 or DQL0 driven to 0 set-up time to first DQS rising edge  | tPDA_S        | 0.5  | -    | 0.5                     | -    | 0.5                     | -    | UI         | 45,47             |
| DQ0 or DQL0 driven to 0 hold time from last DQS falling edge  | tPDA_H        | 0.5  | -    | 0.5                     | -    | 0.5                     | -    | UI         | 46,47             |
| <b>CS_n to Command Address Latency</b>  |               |  |      |                         |      |                         |      |            |                   |
| CS_n to Command Address Latency   | tCAL          | max(3 nCK, 3.748 ns)                       | -    | max(3 nCK, 3.748 ns)    | -    | max(3 nCK, 3.748 ns)    | -    | nCK        |                   |
| Mode Register Set command cycle time in CAL mode  | tMRD_tCAL     | tMOD+ tCAL                                 | -    | tMOD+ tCAL              | -    | tMOD+ tCAL              | -    | nCK        |                   |
| Mode Register Set update delay in CAL mode  | tMOD_tCAL     | tMOD+ tCAL                                 | -    | tMOD+ tCAL              | -    | tMOD+ tCAL              | -    | nCK        |                   |
| <b>DRAM Data Timing</b>   |               |  |      |                         |      |                         |      |            |                   |
| DQS_t,DQS_c to DQ skew, per group, per access   | tDQSQ         | -  | 0.16 | -                       | 0.16 | -                       | 0.16 | tCK(avg)/2 | 13,18, 39, 49     |
| DQ output hold time per group, per access from DQS_t,DQS_c  | tQH           | 0.76                                       | -    | 0.76                    | -    | 0.76                    | -    | tCK(avg)/2 | 13,17, 18, 39, 49 |

**Table 169 — for DDR4-1600 to DDR4-2133 (cont'd)**

| Speed   |                 | DDR4-1600               |         | DDR4-1866               |         | DDR4-2133               |         | Units | NOTE             |
|---|-----------------|-------------------------|---------|-------------------------|---------|-------------------------|---------|-------|------------------|
| Parameter   | Symbol          | MIN                     | MAX     | MIN                     | MAX     | MIN                     | MAX     |       |                  |
| <b>DRAM Data Timing (cont'd)</b>  |                 |                         |         |                         |         |                         |         |       |                  |
| Data Valid Window per device per UI : ( tQH - tDQSQ ) of each UI on a given DRAM        | tDVWd           | 0.63                    | -       | 0.63                    | -       | 0.64                    | -       | UI    | 17, 18<br>39, 49 |
| Data Valid Window per pin per UI : ( tQH - tDQSQ ) each UI on a pin of a given DRAM     | tDVWp           | 0.66                    | -       | 0.66                    | -       | 0.69                    | -       | UI    | 17, 18<br>39, 49 |
| DQ low impedance time from CK_t, CK_c   | tLZ(DQ)         | -450                    | 225     | -390                    | 195     | -360                    | 180     | ps    | 39               |
| DQ high impedance time from CK_t, CK_c  | tHZ(DQ)         | -                       | 225     | -                       | 195     | -                       | 180     | ps    | 39               |
| <b>Data Strobe Timing</b>   |                 |                         |         |                         |         |                         |         |       |                  |
| DQS_t, DQS_c differential READ Preamble (1 clock preamble)                              | tRPRE           | 0.9                     | NOTE 44 | 0.9                     | NOTE 44 | 0.9                     | NOTE 44 | tCK   | 40               |
| DQS_t, DQS_c differential READ Preamble (2 clock preamble)                              | tRPRE2          | NA                      | NA      | NA                      | NA      | NA                      | NA      | tCK   | 41               |
| DQS_t, DQS_c differential READ Postamble  | tRPST           | 0.33                    | NOTE 45 | 0.33                    | NOTE 45 | 0.33                    | NOTE 45 | tCK   |                  |
| DQS_t, DQS_c differential output high time  | tQSH            | 0.4                     | -       | 0.4                     | -       | 0.4                     | -       | tCK   | 21               |
| DQS_t, DQS_c differential output low time   | tQSL            | 0.4                     | -       | 0.4                     | -       | 0.4                     | -       | tCK   | 20               |
| DQS_t, DQS_c differential WRITE Preamble (1 clock preamble)                             | tWPRE           | 0.9                     | -       | 0.9                     | -       | 0.9                     | -       | tCK   | 42               |
| DQS_t, DQS_c differential WRITE Preamble (2 clock preamble)                             | tWPRE2          | NA                      | -       | NA                      | -       | NA                      | -       | tCK   | 43               |
| DQS_t, DQS_c differential WRITE Postamble   | tWPST           | 0.33                    | -       | 0.33                    | -       | 0.33                    | -       | tCK   |                  |
| DQS_t and DQS_c low-impedance time (Referenced from RL-1)                               | tLZ(DQS)        | -450                    | 225     | -390                    | 195     | -360                    | 180     | ps    |                  |
| DQS_t and DQS_c high-impedance time (Referenced from RL+BL/2)                           | tHZ(DQS)        | -                       | 225     | -                       | 195     | -                       | 180     | ps    |                  |
| DQS_t, DQS_c differential input low pulse width   | tDQSL           | 0.46                    | 0.54    | 0.46                    | 0.54    | 0.46                    | 0.54    | tCK   |                  |
| DQS_t, DQS_c differential input high pulse width  | tDQSH           | 0.46                    | 0.54    | 0.46                    | 0.54    | 0.46                    | 0.54    | tCK   |                  |
| DQS_t, DQS_c rising edge to CK_t, CK_c rising edge (1 clock preamble)                   | tDQSS           | -0.27                   | 0.27    | -0.27                   | 0.27    | -0.27                   | 0.27    | tCK   | 42               |
| DQS_t, DQS_c rising edge to CK_t, CK_c rising edge (2 clock preamble)                   | tDQSS2          | NA                      | NA      | NA                      | NA      | NA                      | NA      | tCK   | 43               |
| DQS_t, DQS_c falling edge setup time to CK_t, CK_c rising edge                          | tDSS            | 0.18                    | -       | 0.18                    | -       | 0.18                    | -       | tCK   |                  |
| DQS_t, DQS_c falling edge hold time from CK_t, CK_c rising edge                         | tDSH            | 0.18                    | -       | 0.18                    | -       | 0.18                    | -       | tCK   |                  |
| DQS_t, DQS_c rising edge output timing location from rising CK_t, CK_c with DLL On mode | tDQCK (DLL On)  | -225                    | 225     | -195                    | 195     | -180                    | 180     | ps    | 37,38,<br>39     |
| DQS_t, DQS_c rising edge output variance window per DRAM                                | tDQCKI (DLL On) | -                       | 370     | -                       | 330     | -                       | 310     | ps    | 37,38,<br>39     |
| <b>MPSM Timing</b>  |                 |                         |         |                         |         |                         |         |       |                  |
| Command path disable delay upon MPSM entry  | tMPED           | tMOD(min) + tCPDED(min) | -       | tMOD(min) + tCPDED(min) | -       | tMOD(min) + tCPDED(min) | -       |       |                  |
| Valid clock requirement after MPSM entry  | tCKMPE          | tMOD(min) + tCPDED(min) | -       | tMOD(min) + tCPDED(min) | -       | tMOD(min) + tCPDED(min) | -       |       |                  |
| Valid clock requirement before MPSM exit  | tCKMPX          | tCKSRX(min)             |         | tCKSRX(min)             |         | tCKSRX(min)             |         |       |                  |
| Exit MPSM to commands not requiring a locked DLL  | tXMP            | tXS(min)                | -       | tXS(min)                | -       | tXS(min)                | -       |       |                  |
| Exit MPSM to commands requiring a locked DLL  | tXMPDLL         | tXMP(min) + tXSDLL(min) |         | tXMP(min) + tXSDLL(min) |         | tXMP(min) + tXSDLL(min) |         |       |                  |
| CS setup time to CKE  | tMPX_S          | tSmin + tHmin           | -       | tSmin + tHmin           | -       | tSmin + tHmin           | -       |       |                  |
| <b>Calibration Timing</b>   |                 |                         |         |                         |         |                         |         |       |                  |
| Power-up and RESET calibration time   | tZQinit         | 1024                    | -       | 1024                    | -       | 1024                    | -       | nCK   |                  |
| Normal operation Full calibration time  | tZQoper         | 512                     | -       | 512                     | -       | 512                     | -       | nCK   |                  |
| Normal operation Short calibration time   | tZQCS           | 128                     | -       | 128                     | -       | 128                     | -       | nCK   |                  |

**Table 169 — for DDR4-1600 to DDR4-2133 (cont'd)**

| Speed   |                 | DDR4-1600                 |         | DDR4-1866                 |         | DDR4-2133                 |         | Units    | NOTE  |
|---|-----------------|---------------------------|---------|---------------------------|---------|---------------------------|---------|----------|-------|
| Parameter   | Symbol          | MIN                       | MAX     | MIN                       | MAX     | MIN                       | MAX     |          |       |
| <b>Reset/Self Refresh Timing</b>  |                 |                           |         |                           |         |                           |         |          |       |
| Exit Reset from CKE HIGH to a valid command   | tXPR            | max (5nCK,tRFC(min)+10ns) | -       | max (5nCK,tRFC(min)+10ns) | -       | max (5nCK,tRFC(min)+10ns) | -       |          |       |
| Exit Self Refresh to commands not requiring a locked DLL  | tXS             | tRFC(min)+10ns            | -       | tRFC(min)+10ns            | -       | tRFC(min)+10ns            | -       |          |       |
| SRX to commands not requiring a locked DLL in Self Refresh ABORT  | tXS_ABORT (min) | tRFC4(min)+10ns           | -       | tRFC4(min)+10ns           | -       | tRFC4(min)+10ns           | -       |          |       |
| Exit Self Refresh to ZQCL,ZQCS and MRS (CL,CWL,WR,RTP and Gear Down)  | tXS_FAST (min)  | tRFC4(min)+10ns           | -       | tRFC4(min)+10ns           | -       | tRFC4(min)+10ns           | -       |          |       |
| Exit Self Refresh to commands requiring a locked DLL  | tXSDLL          | tDLLK(min)                | -       | tDLLK(min)                | -       | tDLLK(min)                | -       |          |       |
| Minimum CKE low width for Self refresh entry to exit timing   | tCKESR          | tCKE(min)+1nCK            | -       | tCKE(min)+1nCK            | -       | tCKE(min)+1nCK            | -       |          |       |
| Minimum CKE low width for Self refresh entry to exit timing with CA Parity enabled  | tCKESR_PAR      | tCKE(min)+1nCK+PL         | -       | tCKE(min)+1nCK+PL         | -       | tCKE(min)+1nCK+PL         | -       |          |       |
| Valid Clock Requirement after Self Refresh Entry (SRE) or Power-Down Entry (PDE)  | tCKSRE          | max(5nCK,10ns)            | -       | max(5nCK,10ns)            | -       | max(5nCK,10ns)            | -       |          |       |
| Valid Clock Requirement after Self Refresh Entry (SRE) or Power-Down when CA Parity is enabled                                    | tCKSRE_PA_R     | max (5nCK,10ns)+PL        | -       | max (5nCK,10ns)+PL        | -       | max (5nCK,10ns)+PL        | -       |          |       |
| Valid Clock Requirement before Self Refresh Exit (SRX) or Power-Down Exit (PDX) or Reset Exit                                     | tCKSRX          | max(5nCK,10ns)            | -       | max(5nCK,10ns)            | -       | max(5nCK,10ns)            | -       |          |       |
| <b>Power Down Timing</b>  |                 |                           |         |                           |         |                           |         |          |       |
| Exit Power Down with DLL on to any valid command;Exit Precharge Power Down with DLL frozen to commands not requiring a locked DLL | tXP             | max (4nCK,6ns)            | -       | max (4nCK,6ns)            | -       | max (4nCK,6ns)            | -       |          |       |
| CKE minimum pulse width   | tCKE            | max (3nCK,5ns)            | -       | max (3nCK,5ns)            | -       | max (3nCK,5ns)            | -       |          | 31,32 |
| Command pass disable delay  | tCPDED          | 4                         | -       | 4                         | -       | 4                         | -       | nCK      |       |
| Power Down Entry to Exit Timing   | tPD             | tCKE(min)                 | 9*tREFI | tCKE(min)                 | 9*tREFI | tCKE(min)                 | 9*tREFI |          | 6     |
| <b>Power Down Timing</b>  |                 |                           |         |                           |         |                           |         |          |       |
| Timing of ACT command to Power Down entry   | tACTPDEN        | 1                         | -       | 1                         | -       | 2                         | -       | nCK      | 7     |
| Timing of PRE or PREA command to Power Down entry   | tPRPDEN         | 1                         | -       | 1                         | -       | 2                         | -       | nCK      | 7     |
| Timing of RD/RDA command to Power Down entry  | tRDPDEN         | RL+4+1                    | -       | RL+4+1                    | -       | RL+4+1                    | -       | nCK      |       |
| Timing of WR command to Power Down entry (BL8OTF, BL8MRS, BC4OTF)   | tWRPDEN         | WL+4+(tWR/tCK(avg))       | -       | WL+4+(tWR/tCK(avg))       | -       | WL+4+(tWR/tCK(avg))       | -       | nCK      | 4     |
| Timing of WRA command to Power Down entry (BL8OTF, BL8MRS, BC4OTF)  | tWRAPDEN        | WL+4+WR+1                 | -       | WL+4+WR+1                 | -       | WL+4+WR+1                 | -       | nCK      | 5     |
| Timing of WR command to Power Down entry (BC4MRS)   | tWRPBC4DEN      | WL+2+(tWR/tCK(avg))       | -       | WL+2+(tWR/tCK(avg))       | -       | WL+2+(tWR/tCK(avg))       | -       | nCK      | 4     |
| Timing of WRA command to Power Down entry (BC4MRS)  | tWRAPBC4DEN     | WL+2+WR+1                 | -       | WL+2+WR+1                 | -       | WL+2+WR+1                 | -       | nCK      | 5     |
| Timing of REF command to Power Down entry   | tREFPDEN        | 1                         | -       | 1                         | -       | 2                         | -       | nCK      | 7     |
| Timing of MRS command to Power Down entry   | tMRSPDEN        | tMOD(min)                 | -       | tMOD(min)                 | -       | tMOD(min)                 | -       |          |       |
| <b>PDA Timing</b>   |                 |                           |         |                           |         |                           |         |          |       |
| Mode Register Set command cycle time in PDA mode  | tMRD_PDA        | max(16nCK,10ns)           | -       | max(16nCK,10ns)           | -       | max(16nCK,10ns)           | -       | nCK      |       |
| Mode Register Set command update delay in PDA mode  | tMOD_PDA        | tMOD                      |         | tMOD                      |         | tMOD                      |         |          |       |
| <b>ODT Timing</b>   |                 |                           |         |                           |         |                           |         |          |       |
| Asynchronous RTT turn-on delay (Power-Down with DLL frozen)   | tAONAS          | 1.0                       | 9.0     | 1.0                       | 9.0     | 1.0                       | 9.0     | ns       |       |
| Asynchronous RTT turn-off delay (Power-Down with DLL frozen)  | tAOFAS          | 1.0                       | 9.0     | 1.0                       | 9.0     | 1.0                       | 9.0     | ns       |       |
| RTT dynamic change skew   | tADC            | 0.3                       | 0.7     | 0.3                       | 0.7     | 0.3                       | 0.7     | tCK(avg) |       |

**Table 169 — for DDR4-1600 to DDR4-2133 (cont'd)**

| Speed   |                 | DDR4-1600        |        | DDR4-1866        |        | DDR4-2133        |        | Units    | NOTE   |
|---|-----------------|------------------|--------|------------------|--------|------------------|--------|----------|--------|
| Parameter   | Symbol          | MIN              | MAX    | MIN              | MAX    | MIN              | MAX    |          |        |
| <b>Write Leveling Timing</b>  |                 |                  |        |                  |        |                  |        |          |        |
| First DQS_t/DQS_n rising edge after write leveling mode is programmed   | tWLMRD          | 40               | -      | 40               | -      | 40               | -      | nCK      | 12     |
| DQS_t/DQS_n delay after write leveling mode is programmed   | tWLQSEN         | 25               | -      | 25               | -      | 25               | -      | nCK      | 12     |
| Write leveling setup time from rising CK_t, CK_c crossing to rising DQS_t/DQS_n crossing                        | tWLS            | 0.13             | -      | 0.13             | -      | 0.13             | -      | tCK(avg) |        |
| Write leveling hold time from rising DQS_t/DQS_n crossing to rising CK_t, CK_c crossing                         | tWLH            | 0.13             | -      | 0.13             | -      | 0.13             | -      | tCK(avg) |        |
| Write leveling output delay   | tWLO            | 0                | 9.5    | 0                | 9.5    | 0                | 9.5    | ns       |        |
| Write leveling output error   | tWLOE           |                  |        |                  |        |                  |        | ns       |        |
| <b>CA Parity Timing</b>   |                 |                  |        |                  |        |                  |        |          |        |
| Commands not guaranteed to be executed during this time   | tPAR_UNKN OWN   | -                | PL     | -                | PL     | -                | PL     |          |        |
| Delay from errant command to ALERT_n assertion  | tPAR_ALER T_ON  | -                | PL+6ns | -                | PL+6ns | -                | PL+6ns |          |        |
| Pulse width of ALERT_n signal when asserted   | tPAR_ALER T_PW  | 48               | 96     | 56               | 112    | 64               | 128    | nCK      |        |
| Time from when Alert is asserted till controller must start providing DES commands in Persistent CA parity mode | tPAR_ALER T_RSP | -                | 43     | -                | 50     | -                | 57     | nCK      |        |
| Parity Latency  | PL              | 4                |        | 4                |        | 4                |        | nCK      |        |
| <b>CRC Error Reporting</b>  |                 |                  |        |                  |        |                  |        |          |        |
| CRC error to ALERT_n latency  | tCRC_ALER T     | 3                | 13     | 3                | 13     | 3                | 13     | ns       |        |
| CRC ALERT_n pulse width   | CRC_ALER T_PW   | 6                | 10     | 6                | 10     | 6                | 10     | nCK      |        |
| <b>tREFI</b>  |                 |                  |        |                  |        |                  |        |          |        |
| tRFC1 (min)   | 2Gb             | 160              | -      | 160              | -      | 160              | -      | ns       | 34     |
|   | 4Gb             | 260              | -      | 260              | -      | 260              | -      | ns       | 34     |
|   | 8Gb             | 350              | -      | 350              | -      | 350              | -      | ns       | 34     |
|   | 16Gb            | 550 (default)    | -      | 550 (default)    | -      | 550 (default)    | -      | ns       | 34, 51 |
|   |                 | 450 (optional-1) | -      | 450 (optional-1) | -      | 450 (optional-1) | -      |          |        |
|   |                 | 350 (optional-2) | -      | 350 (optional-2) | -      | 350 (optional-2) | -      |          |        |
| tRFC2 (min)   | 2Gb             | 110              | -      | 110              | -      | 110              | -      | ns       | 34     |
|   | 4Gb             | 160              | -      | 160              | -      | 160              | -      | ns       | 34     |
|   | 8Gb             | 260              | -      | 260              | -      | 260              | -      | ns       | 34     |
|   | 16Gb            | 350 (default)    | -      | 350 (default)    | -      | 350 (default)    | -      | ns       | 34, 51 |
|   |                 | 350 (optional-1) | -      | 350 (optional-1) | -      | 350 (optional-1) | -      |          |        |
|   |                 | 260 (optional-2) | -      | 260 (optional-2) | -      | 260 (optional-2) | -      |          |        |
| tRFC4 (min)   | 2Gb             | 90               | -      | 90               | -      | 90               | -      | ns       | 34     |
|   | 4Gb             | 110              | -      | 110              | -      | 110              | -      | ns       | 34     |
|   | 8Gb             | 160              | -      | 160              | -      | 160              | -      | ns       | 34     |
|   | 16Gb            | 260 (default)    | -      | 260 (default)    | -      | 260 (default)    | -      | ns       | 34, 51 |
|   |                 | 260 (optional-1) | -      | 260 (optional-1) | -      | 260 (optional-1) | -      |          |        |
|   |                 | 160 (optional-2) | -      | 160 (optional-2) | -      | 160 (optional-2) | -      |          |        |

## 13.4 Timing Parameters by Speed Grade (cont'd)

Table 170 — for DDR4-2400 to DDR4-3200

| Speed   |                | DDR4-2400  |                                  | DDR4-2666                      |                                  | DDR4-2933                      |                                  | DDR4-3200                      |                                  | Units    | NOTE  |
|---|----------------|--|----------------------------------|--------------------------------|----------------------------------|--------------------------------|----------------------------------|--------------------------------|----------------------------------|----------|-------|
| Parameter   | Symbol         | MIN  | MAX                              | MIN                            | MAX                              | MIN                            | MAX                              | MIN                            | MAX                              |          |       |
| <b>Clock Timing</b>   |                |  |                                  |                                |                                  |                                |                                  |                                |                                  |          |       |
| Minimum Clock Cycle Time (DLL off mode)   | tCK(DLL_OFF)   | 8  | 20                               | 8                              | 20                               | 8                              | 20                               | 8                              | 20                               | ns       |       |
| Average Clock Period  | tCK(avg)       | 0.833  | <0.937                           | 0.750                          | <0.833                           | 0.682                          | <0.750                           | 0.625                          | <0.682                           | ns       | 35,36 |
| Average high pulse width  | tCH(avg)       | 0.48   | 0.52                             | 0.48                           | 0.52                             | 0.48                           | 0.52                             | 0.48                           | 0.52                             | tCK(avg) |       |
| Average low pulse width   | tCL(avg)       | 0.48   | 0.52                             | 0.48                           | 0.52                             | 0.48                           | 0.52                             | 0.48                           | 0.52                             | tCK(avg) |       |
| Absolute Clock Period   | tCK(abs)       | tCK(avg)min + tJIT(per)min_tot   | tCK(avg)m ax + tJIT(per)m ax_tot | tCK(avg)min + tJIT(per)min_tot | tCK(avg)m ax + tJIT(per)m ax_tot | tCK(avg)min + tJIT(per)min_tot | tCK(avg)m ax + tJIT(per)m ax_tot | tCK(avg)min + tJIT(per)min_tot | tCK(avg)m ax + tJIT(per)m ax_tot | tCK(avg) |       |
| Absolute clock HIGH pulse width   | tCH(abs)       | 0.45   | -                                | 0.45                           | -                                | 0.45                           | -                                | 0.45                           | -                                | tCK(avg) | 23    |
| Absolute clock LOW pulse width  | tCL(abs)       | 0.45   | -                                | 0.45                           | -                                | 0.45                           | -                                | 0.45                           | -                                | tCK(avg) | 24    |
| Clock Period Jitter- total  | JIT(per)_tot   | -42  | 42                               | -38                            | 38                               | -34                            | 34                               | -32                            | 32                               | ps       | 25    |
| Clock Period Jitter- deterministic  | JIT(per)_dj    | -21  | 21                               | -19                            | 19                               | -17                            | 17                               | -16                            | 16                               | ps       | 26    |
| Clock Period Jitter during DLL locking period                                       | tJIT(per, lck) | -33  | 33                               | -30                            | 30                               | -27                            | 27                               | -25                            | 25                               | ps       |       |
| Cycle to Cycle Period Jitter  | tJIT(cc)       | -  | 83                               | -                              | 75                               | -                              | 68                               | -                              | 62                               | ps       |       |
| Cycle to Cycle Period Jitter during DLL locking period                              | tJIT(cc, lck)  | -  | 67                               | -                              | 60                               | -                              | 55                               | -                              | 50                               | ps       |       |
| Cumulative error across 2 cycles  | tERR(2per)     | -61  | 61                               | -55                            | 55                               | -50                            | 50                               | -46                            | 46                               | ps       |       |
| Cumulative error across 3 cycles  | tERR(3per)     | -73  | 73                               | -66                            | 66                               | -60                            | 60                               | -55                            | 55                               | ps       |       |
| Cumulative error across 4 cycles  | tERR(4per)     | -81  | 81                               | -73                            | 73                               | -66                            | 66                               | -61                            | 61                               | ps       |       |
| Cumulative error across 5 cycles  | tERR(5per)     | -87  | 87                               | -78                            | 78                               | -71                            | 71                               | -65                            | 65                               | ps       |       |
| Cumulative error across 6 cycles  | tERR(6per)     | -92  | 92                               | -83                            | 83                               | -75                            | 75                               | -69                            | 69                               | ps       |       |
| Cumulative error across 7 cycles  | tERR(7per)     | -97  | 97                               | -87                            | 87                               | -79                            | 79                               | -73                            | 73                               | ps       |       |
| Cumulative error across 8 cycles  | tERR(8per)     | -101   | 101                              | -91                            | 91                               | -83                            | 83                               | -76                            | 76                               | ps       |       |
| Cumulative error across 9 cycles  | tERR(9per)     | -104   | 104                              | -94                            | 94                               | -85                            | 85                               | -78                            | 78                               | ps       |       |
| Cumulative error across 10 cycles   | tERR(10per)    | -107   | 107                              | -96                            | 96                               | -88                            | 88                               | -80                            | 80                               | ps       |       |
| Cumulative error across 11 cycles   | tERR(11per)    | -110   | 110                              | -99                            | 99                               | -90                            | 90                               | -83                            | 83                               | ps       |       |
| Cumulative error across 12 cycles   | tERR(12per)    | -112   | 112                              | -101                           | 101                              | -92                            | 92                               | -84                            | 84                               | ps       |       |
| Cumulative error across 13 cycles   | tERR(13per)    | -114   | 114                              | -103                           | 103                              | -93                            | 93                               | -86                            | 86                               | ps       |       |
| Cumulative error across 14 cycles   | tERR(14per)    | -116   | 116                              | -104                           | 104                              | -95                            | 95                               | -87                            | 87                               | ps       |       |
| Cumulative error across 15 cycles   | tERR(15per)    | -118   | 118                              | -106                           | 106                              | -97                            | 97                               | -89                            | 89                               | ps       |       |
| Cumulative error across 16 cycles   | tERR(16per)    | -120   | 120                              | -108                           | 108                              | -98                            | 98                               | -90                            | 90                               | ps       |       |
| Cumulative error across 17 cycles   | tERR(17per)    | -122   | 122                              | -110                           | 110                              | -100                           | 100                              | -92                            | 92                               | ps       |       |
| Cumulative error across 18 cycles   | tERR(18per)    | -124   | 124                              | -112                           | 112                              | -101                           | 101                              | -93                            | 93                               | ps       |       |
| Cumulative error across n = 13, 14 ... 49, 50 cycles                                | tERR(nper)     | $tERR(nper)\text{min} = ((1 + 0.68\ln(n)) * \text{UIT(per)}_{\text{total min}})$<br>$tERR(nper)\text{max} = ((1 + 0.68\ln(n)) * \text{UIT(per)}_{\text{total max}})$ |                                  |                                |                                  |                                |                                  |                                |                                  | ps       |       |
| Command and Address setup time to CK_t, CK_c referenced to Vih(ac) / Vil(ac) levels | tIS(base)      | 62   | -                                | 55                             | -                                | 48                             | -                                | 40                             | -                                | ps       |       |
| Command and Address setup time to CK_t, CK_c referenced to Vref levels              | tIS(Vref)      | 162  | -                                | 145                            | -                                | 138                            | -                                | 130                            | -                                | ps       |       |
| Command and Address hold time to CK_t, CK_c referenced to Vih(dc) / Vil(dc) levels  | tIH(base)      | 87   | -                                | 80                             | -                                | 73                             | -                                | 65                             | -                                | ps       |       |
| Command and Address hold time to CK_t, CK_c referenced to Vref levels               | tIH(Vref)      | 162  | -                                | 145                            | -                                | 138                            | -                                | 130                            | -                                | ps       |       |
| Control and Address Input pulse width for each input                                | tIPW           | 410  | -                                | 385                            | -                                | 365                            | -                                | 340                            | -                                | ps       |       |

Table 170 — for DDR4-2400 to DDR4-3200 (cont'd)

| Speed  |                | DDR4-2400                                 |     | DDR4-2666                |     | DDR4-2933                |     | DDR4-3200                |     | Units | NOTE      |
|--|----------------|---|-----|--------------------------|-----|--------------------------|-----|--------------------------|-----|-------|-----------|
| Parameter  | Symbol         | MIN                                       | MAX | MIN                      | MAX | MIN                      | MAX | MIN                      | MAX |       |           |
| <b>Command and Address Timing</b>  |                |   |     |                          |     |                          |     |                          |     |       |           |
| CAS_n to CAS_n command delay for same bank group   | tCCD_L         | max(5 nCK, 5 ns)                          | -   | max(5 nCK, 5 ns)         | -   | max(5 nCK, 5 ns)         | -   | max(5 nCK, 5 ns)         | -   | nCK   | 34        |
| CAS_n to CAS_n command delay for different bank group  | tCCD_S         | 4   | -   | 4                        | -   | 4                        | -   | 4                        | -   | nCK   | 34        |
| ACTIVATE to ACTIVATE Command delay to different bank group for 2KB page size   | tRRD_S(2K)     | Max(4nCK, 5.3ns)                          | -   | Max(4nCK, 5.3ns)         | -   | Max(4nCK, 5.3ns)         | -   | Max(4nCK, 5.3ns)         | -   | nCK   | 34        |
| ACTIVATE to ACTIVATE Command delay to different bank group for 2KB page size   | tRRD_S(1K)     | Max(4nCK, 3.3ns)                          | -   | Max(4nCK, 3ns)           | -   | Max(4nCK, 2.7ns)         | -   | Max(4nCK, 2.5ns)         | -   | nCK   | 34        |
| ACTIVATE to ACTIVATE Command delay to different bank group for 1/2KB page size   | tRRD_S(1/2K)   | Max(4nCK, 3.3ns)                          | -   | Max(4nCK, 3ns)           | -   | Max(4nCK, 2.7ns)         | -   | Max(4nCK, 2.5ns)         | -   | nCK   | 34        |
| ACTIVATE to ACTIVATE Command delay to same bank group for 2KB page size  | tRRD_L(2K)     | Max(4nCK, 6.4ns)                          | -   | Max(4nCK, 6.4ns)         | -   | Max(4nCK, 6.4ns)         | -   | Max(4nCK, 6.4ns)         | -   | nCK   | 34        |
| ACTIVATE to ACTIVATE Command delay to same bank group for 1KB page size  | tRRD_L(1K)     | Max(4nCK, 4.9ns)                          | -   | Max(4nCK, 4.9ns)         | -   | Max(4nCK, 4.9ns)         | -   | Max(4nCK, 4.9ns)         | -   | nCK   | 34        |
| ACTIVATE to ACTIVATE Command delay to same bank group for 1/2KB page size  | tRRD_L(1/2K)   | Max(4nCK, 4.9ns)                          | -   | Max(4nCK, 4.9ns)         | -   | Max(4nCK, 4.9ns)         | -   | Max(4nCK, 4.9ns)         | -   | nCK   | 34        |
| Four activate window for 2KB page size   | tFAW_2K        | Max(28nCK, 30ns)                          | -   | Max(28nCK, 30ns)         | -   | Max(28nCK, 30ns)         | -   | Max(28nCK, 30ns)         | -   | ns    | 34        |
| Four activate window for 1KB page size   | tFAW_1K        | Max(20nCK, 21ns)                          | -   | Max(20nCK, 21ns)         | -   | Max(20nCK, 21ns)         | -   | Max(20nCK, 21ns)         | -   | ns    | 34        |
| Four activate window for 1/2KB page size   | tFAW_1/2K      | Max(16nCK, 13ns)                          | -   | Max(16nCK, 12ns)         | -   | Max(16nCK, 10.875ns)     | -   | Max(16nCK, 10ns)         | -   | ns    | 34        |
| Delay from start of internal write transaction to internal read command for different bank group                               | tWTR_S         | max(2nCK, 2.5ns)                          | -   | max(2nCK, 2.5ns)         | -   | max(2nCK, 2.5ns)         | -   | max(2nCK, 2.5ns)         | -   | ns    | 1,2,e, 34 |
| Delay from start of internal write transaction to internal read command for same bank group                                    | tWTR_L         | max(4nCK, 7.5ns)                          | -   | max(4nCK, 7.5ns)         | -   | max(4nCK, 7.5ns)         | -   | max(4nCK, 7.5ns)         | -   |       | 1,34      |
| Internal READ Command to PRECHARGE Command delay   | tRTP           | max(4nCK, 7.5ns)                          | -   | max(4nCK, 7.5ns)         | -   | max(4nCK, 7.5ns)         | -   | max(4nCK, 7.5ns)         | -   |       | 34        |
| WRITE recovery time  | tWR            | 15  | -   | 15                       | -   | 15                       | -   | 15                       | -   | ns    | 1         |
| Write recovery time when CRC and DM are enabled  | tWR_CRC_DM     | tWR+max(5nCK, 3.75ns)                     | -   | tWR+max(5nCK, 3.75ns)    | -   | tWR+max(5nCK, 3.75ns)    | -   | tWR+max(5nCK, 3.75ns)    | -   | ns    | 1, 28     |
| delay from start of internal write transaction to internal read command for different bank groups with both CRC and DM enabled | tWTR_S_CR_C_DM | tWTR_S+max(5nCK, 3.75ns)                  | -   | tWTR_S+max(5nCK, 3.75ns) | -   | tWTR_S+max(5nCK, 3.75ns) | -   | tWTR_S+max(5nCK, 3.75ns) | -   | ns    | 2, 29,34  |
| delay from start of internal write transaction to internal read command for same bank group with both CRC and DM enabled       | tWTR_L_CR_C_DM | tWTR_L+max(5nCK, 3.75ns)                  | -   | tWTR_L+max(5nCK, 3.75ns) | -   | tWTR_L+max(5nCK, 3.75ns) | -   | tWTR_L+max(5nCK, 3.75ns) | -   | ns    | 3, 30,34  |
| DLL locking time   | tDLLK          | 768                                       | -   | 1024                     | -   | 1024                     | -   | 1024                     | -   | nCK   |           |
| Mode Register Set command cycle time   | tMRD           | 8   | -   | 8                        | -   | 8                        | -   | 8                        | -   | nCK   |           |
| Mode Register Set command update delay   | tMOD           | max(24nCK, 15ns)                          | -   | max(24nCK, 15ns)         | -   | max(24nCK, 15ns)         | -   | max(24nCK, 15ns)         | -   | nCK   | 50        |
| Multi-Purpose Register Recovery Time   | tMPRR          | 1   | -   | 1                        | -   | 1                        | -   | 1                        | -   | nCK   | 33        |
| Multi Purpose Register Write Recovery Time   | tWR_MPR        | tMOD(min) + AL + PL                       | -   | tMOD(min) + AL + PL      | -   | tMOD(min) + AL + PL      | -   | tMOD(min) + AL + PL      | -   | nCK   |           |
| Auto precharge write recovery + precharge time   | tDAL(min)      | Programmed WR + roundup ( tRP / tCK(avg)) |     |                          |     |                          |     |                          |     | nCK   | 52        |
| DQ0 or DQL0 driven to 0 set-up time to first DQS rising edge   | tPDA_S         | 0.5                                       | -   | 0.5                      | -   | 0.5                      | -   | 0.5                      | -   | UI    | 45,47     |
| DQ0 or DQL0 driven to 0 hold time from last DQS falling edge   | tPDA_H         | 0.5                                       | -   | 0.5                      | -   | 0.5                      | -   | 0.5                      | -   | UI    | 46,47     |
| <b>CS_n to Command Address Latency</b>   |                |   |     |                          |     |                          |     |                          |     |       |           |
| CS_n to Command Address Latency  | tCAL           | max(3 nCK, 3.748 ns)                      | -   | max(3 nCK, 3.748 ns)     | -   | max(3 nCK, 3.748 ns)     | -   | max(3 nCK, 3.748 ns)     | -   | nCK   |           |
| Mode Register Set command cycle time in CAL mode   | tMRD_tCAL      | tMOD+ tCAL                                | -   | tMOD+ tCAL               | -   | tMOD+ tCAL               | -   | tMOD+ tCAL               | -   | nCK   |           |
| Mode Register Set update delay in CAL mode   | tMOD_tCAL      | tMOD+ tCAL                                | -   | tMOD+ tCAL               | -   | tMOD+ tCAL               | -   | tMOD+ tCAL               | -   | nCK   |           |

Table 170 — for DDR4-2400 to DDR4-3200 (cont'd)

| Speed   |                  | DDR4-2400               |         | DDR4-2666               |         | DDR4-2933               |         | DDR4-3200               |         | Units       | NOTE              |
|---|------------------|-------------------------|---------|-------------------------|---------|-------------------------|---------|-------------------------|---------|-------------|-------------------|
| Parameter   | Symbol           | MIN                     | MAX     | MIN                     | MAX     | MIN                     | MAX     | MIN                     | MAX     |             |                   |
| <b>DRAM Data Timing</b>   |                  |                         |         |                         |         |                         |         |                         |         |             |                   |
| DQS_t,DQS_c to DQ skew, per group, per access   | tDQSQ            | -                       | 0.17    | -                       | 0.18    | -                       | 0.19    | -                       | 0.20    | tCK(avg) /2 | 13,18, 39, 49     |
| DQ output hold time per group, per access from DQS_t,DQS_c                              | tQH              | 0.74                    | -       | 0.74                    | -       | 0.72                    | -       | 0.70                    | -       | tCK(avg) /2 | 13,17, 18, 39, 49 |
| Data Valid Window per device per UI : ( tQH - tDQSQ ) of each UI on a given DRAM        | tDVWd            | 0.64                    | -       | 0.64                    | -       | 0.64                    | -       | 0.64                    | -       | UI          | 17,18, 39, 49     |
| Data Valid Window per pin per UI : ( tQH - tDQSQ ) each UI on a pin of a given DRAM     | tDVWp            | 0.72                    | -       | 0.72                    | -       | 0.72                    | -       | 0.72                    | -       | UI          | 17,18, 39, 49     |
| DQ low impedance time from CK_t, CK_c   | tLZ(DQ)          | -330                    | 175     | -310                    | 170     | -280                    | 165     | -250                    | 160     | ps          | 39                |
| DQ high impedance time from CK_t, CK_c  | tHZ(DQ)          | -                       | 175     | -                       | 170     | -                       | 165     | -                       | 160     | ps          | 39                |
| <b>Data Strobe Timing</b>   |                  |                         |         |                         |         |                         |         |                         |         |             |                   |
| DQS_t, DQS_c differential READ Preamble (1 clock preamble)                              | tRPRE            | 0.9                     | NOTE 44 | tCK         | 39, 40            |
| DQS_t, DQS_c differential READ Preamble (2 clock preamble)                              | tRPRE2           | 1.8                     | NOTE 44 | tCK         | 39, 41            |
| DQS_t, DQS_c differential READ Postamble  | tRPST            | 0.33                    | NOTE 45 | tCK         | 39                |
| DQS_t, DQS_c differential output high time  | tQSH             | 0.4                     | -       | 0.4                     | -       | 0.4                     | -       | 0.4                     | -       | tCK         | 21, 39            |
| DQS_t, DQS_c differential output low time   | tQL              | 0.4                     | -       | 0.4                     | -       | 0.4                     | -       | 0.4                     | -       | tCK         | 20, 39            |
| DQS_t, DQS_c differential WRITE Preamble (1 clock preamble)                             | tWPRE            | 0.9                     | -       | 0.9                     | -       | 0.9                     | -       | 0.9                     | -       | tCK         | 42                |
| DQS_t, DQS_c differential WRITE Preamble (2 clock preamble)                             | tWPRE2           | 1.8                     | -       | 1.8                     | -       | 1.8                     | -       | 1.8                     | -       | tCK         | 43                |
| DQS_t, DQS_c differential WRITE Postamble   | tWPST            | 0.33                    | -       | 0.33                    | -       | 0.33                    | -       | 0.33                    | -       | tCK         |                   |
| DQS_t and DQS_c low-impedance time (Referenced from RL-1)                               | tLZ(DQS)         | -330                    | 175     | -310                    | 170     | -280                    | 165     | -250                    | 160     | ps          | 39                |
| DQS_t and DQS_c high-impedance time (Referenced from RL+BL/2)                           | tHZ(DQS)         | -                       | 175     | -                       | 170     | -                       | 165     | -                       | 160     | ps          | 39                |
| DQS_t, DQS_c differential input low pulse width   | tDQSL            | 0.46                    | 0.54    | 0.46                    | 0.54    | 0.46                    | 0.54    | 0.46                    | 0.54    | tCK         |                   |
| DQS_t, DQS_c differential input high pulse width  | tDQSH            | 0.46                    | 0.54    | 0.46                    | 0.54    | 0.46                    | 0.54    | 0.46                    | 0.54    | tCK         |                   |
| DQS_t, DQS_c rising edge to CK_t, CK_c rising edge (1 clock preamble)                   | tDQSS            | -0.27                   | 0.27    | -0.27                   | 0.27    | -0.27                   | 0.27    | -0.27                   | 0.27    | tCK         | 42                |
| DQS_t, DQS_c rising edge to CK_t, CK_c rising edge (2 clock preamble)                   | tDQSS2           | -0.50                   | 0.50    | -0.50                   | 0.50    | -0.50                   | 0.50    | -0.50                   | 0.50    | tCK         | 43                |
| DQS_t, DQS_c falling edge setup time to CK_t, CK_c rising edge                          | tDSS             | 0.18                    | -       | 0.18                    | -       | 0.18                    | -       | 0.18                    | -       | tCK         |                   |
| DQS_t, DQS_c falling edge hold time from CK_t, CK_c rising edge                         | tDSH             | 0.18                    | -       | 0.18                    | -       | 0.18                    | -       | 0.18                    | -       | tCK         |                   |
| DQS_t, DQS_c rising edge output timing location from rising CK_t, CK_c with DLL On mode | tDQSCK (DLL On)  | -175                    | 175     | -170                    | 170     | -165                    | 165     | -160                    | 160     | ps          | 37,38, 39         |
| DQS_t, DQS_c rising edge output variance window per DRAM                                | tDQSCKI (DLL On) | -                       | 290     | -                       | 270     | -                       | 265     | -                       | 260     | ps          | 37,38, 39         |
| <b>MPSM Timing</b>  |                  |                         |         |                         |         |                         |         |                         |         |             |                   |
| Command path disable delay upon MPSM entry  | tMPED            | tMOD(min) + tCPDED(min) | -       |             |                   |
| Valid clock requirement after MPSM entry  | tCKMPE           | tMOD(min) + tCPDED(min) | -       |             |                   |
| Valid clock requirement before MPSM exit  | tCKMPX           | tCKSRX(min)             | -       | tCKSRX(min)             | -       | tCKSRX(min)             | -       | tCKSRX(min)             | -       |             |                   |
| Exit MPSM to commands not requiring a locked DLL  | tXMP             | tXS(min)                | -       | tXS(min)                | -       | tXS(min)                | -       | tXS(min)                | -       |             |                   |
| Exit MPSM to commands requiring a locked DLL  | tXMPDLL          | tXMP(min) + tXSDL(min)  | -       |             |                   |
| CS setup time to CKE  | tMPX_S           | tISmin + tIHmin         | -       |             |                   |

Table 170 — for DDR4-2400 to DDR4-3200 (cont'd)

| Speed   |                | DDR4-2400                |         | DDR4-2666                |         | DDR4-2933                |         | DDR4-3200                |         | Units    | NOTE  |
|---|----------------|--------------------------|---------|--------------------------|---------|--------------------------|---------|--------------------------|---------|----------|-------|
| Parameter   | Symbol         | MIN                      | MAX     | MIN                      | MAX     | MIN                      | MAX     | MIN                      | MAX     |          |       |
| <b>Calibration Timing</b>   |                |                          |         |                          |         |                          |         |                          |         |          |       |
| Power-up and RESET calibration time   | tZQinit        | 1024                     | -       | 1024                     | -       | 1024                     | -       | 1024                     | -       | nCK      |       |
| Normal operation Full calibration time  | tZOper         | 512                      | -       | 512                      | -       | 512                      | -       | 512                      | -       | nCK      |       |
| Normal operation Short calibration time   | tZQCS          | 128                      | -       | 128                      | -       | 128                      | -       | 128                      | -       | nCK      |       |
| <b>Reset/Self Refresh Timing</b>  |                |                          |         |                          |         |                          |         |                          |         |          |       |
| Exit Reset from CKE HIGH to a valid command   | tXPR           | max(5nCK,tRFC(min)+10ns) | -       | max(5nCK,tRFC(min)+10ns) | -       | max(5nCK,tRFC(min)+10ns) | -       | max(5nCK,tRFC(min)+10ns) | -       | nCK      |       |
| Exit Self Refresh to commands not requiring a locked DLL  | tXS            | tRFC(min)+10ns           | -       | tRFC(min)+10ns           | -       | tRFC(min)+10ns           | -       | tRFC(min)+10ns           | -       | nCK      |       |
| SRX to commands not requiring a locked DLL in Self Refresh ABORT  | tXS_ABORT(min) | tRFC4(min)+10ns          | -       | tRFC4(min)+10ns          | -       | tRFC4(min)+10ns          | -       | tRFC4(min)+10ns          | -       | nCK      |       |
| Exit Self Refresh to ZQCL,ZQCS and MRS (CL,CWL,WR,RTP and Gear Down)  | tXS_FAST(min)  | tRFC4(min)+10ns          | -       | tRFC4(min)+10ns          | -       | tRFC4(min)+10ns          | -       | tRFC4(min)+10ns          | -       | nCK      |       |
| Exit Self Refresh to commands requiring a locked DLL  | tXSDL          | tDLLK(min)               | -       | tDLLK(min)               | -       | tDLLK(min)               | -       | tDLLK(min)               | -       | nCK      |       |
| Minimum CKE low width for Self refresh entry to exit timing   | tCKESR         | tCKE(min)+1nCK           | -       | tCKE(min)+1nCK           | -       | tCKE(min)+1nCK           | -       | tCKE(min)+1nCK           | -       | nCK      |       |
| Minimum CKE low width for Self refresh entry to exit timing with CA Parity enabled  | tCKESR_PAR     | tCKE(min)+1nCK+PL        | -       | tCKE(min)+1nCK+PL        | -       | tCKE(min)+1nCK+PL        | -       | tCKE(min)+1nCK+PL        | -       | nCK      |       |
| Valid Clock Requirement after Self Refresh Entry (SRE) or Power-Down Entry (PDE)  | tCKSRE         | max(5nCK,10ns)           | -       | max(5nCK,10ns)           | -       | max(5nCK,10ns)           | -       | max(5nCK,10ns)           | -       | nCK      |       |
| Valid Clock Requirement after Self Refresh Entry (SRE) or Power-Down when CA Parity is enabled                                    | tCKSRE_PAR     | max(5nCK,10ns)+PL        | -       | max(5nCK,10ns)+PL        | -       | max(5nCK,10ns)+PL        | -       | max(5nCK,10ns)+PL        | -       | nCK      |       |
| Valid Clock Requirement before Self Refresh Exit (SRX) or Power-Down Exit (PDX) or Reset Exit                                     | tCKSRX         | max(5nCK,10ns)           | -       | max(5nCK,10ns)           | -       | max(5nCK,10ns)           | -       | max(5nCK,10ns)           | -       | nCK      |       |
| <b>Power Down Timing</b>  |                |                          |         |                          |         |                          |         |                          |         |          |       |
| Exit Power Down with DLL on to any valid command;Exit Precharge Power Down with DLL frozen to commands not requiring a locked DLL | tXP            | max(4nCK,6ns)            | -       | max(4nCK,6ns)            | -       | max(4nCK,6ns)            | -       | max(4nCK,6ns)            | -       | nCK      |       |
| CKE minimum pulse width   | tCKE           | max(3nCK,5ns)            | -       | max(3nCK,5ns)            | -       | max(3nCK,5ns)            | -       | max(3nCK,5ns)            | -       | nCK      | 31,32 |
| Command pass disable delay  | tCPDED         | 4                        | -       | 4                        | -       | 4                        | -       | 4                        | -       | nCK      |       |
| Power Down Entry to Exit Timing   | tPD            | tCKE(min)                | 9*tREFI | tCKE(min)                | 9*tREFI | tCKE(min)                | 9*tREFI | tCKE(min)                | 9*tREFI | nCK      | 6     |
| Timing of ACT command to Power Down entry   | tACTPDEN       | 2                        | -       | 2                        | -       | 2                        | -       | 2                        | -       | nCK      | 7     |
| Timing of PRE or PREA command to Power Down entry   | tPRPDEN        | 2                        | -       | 2                        | -       | 2                        | -       | 2                        | -       | nCK      | 7     |
| Timing of RD/RDA command to Power Down entry  | tRDPDEN        | RL+4+1                   | -       | RL+4+1                   | -       | RL+4+1                   | -       | RL+4+1                   | -       | nCK      |       |
| Timing of WR command to Power Down entry (BL8OTF, BL8MRS, BC4OTF)   | tWRPDEN        | WL+4+(tWR/tCK(avg))      | -       | WL+4+(tWR/tCK(avg))      | -       | WL+4+(tWR/tCK(avg))      | -       | WL+4+(tWR/tCK(avg))      | -       | nCK      | 4     |
| Timing of WRA command to Power Down entry (BL8OTF, BL8MRS, BC4OTF)  | tWRAPDEN       | WL+4+WR+1                | -       | WL+4+WR+1                | -       | WL+4+WR+1                | -       | WL+4+WR+1                | -       | nCK      | 5     |
| Timing of WR command to Power Down entry (BC4MRS)   | tWRPBC4DEN     | WL+2+(tWR/tCK(avg))      | -       | WL+2+(tWR/tCK(avg))      | -       | WL+2+(tWR/tCK(avg))      | -       | WL+2+(tWR/tCK(avg))      | -       | nCK      | 4     |
| Timing of WRA command to Power Down entry (BC4MRS)  | tWRAPBC4DEN    | WL+2+WR+1                | -       | WL+2+WR+1                | -       | WL+2+WR+1                | -       | WL+2+WR+1                | -       | nCK      | 5     |
| Timing of REF command to Power Down entry   | tREFPDEN       | 2                        | -       | 2                        | -       | 2                        | -       | 2                        | -       | nCK      | 7     |
| Timing of MRS command to Power Down entry   | tMRSPDEN       | tMOD(min)                | -       | tMOD(min)                | -       | tMOD(min)                | -       | tMOD(min)                | -       | nCK      |       |
| <b>PDA Timing</b>   |                |                          |         |                          |         |                          |         |                          |         |          |       |
| Mode Register Set command cycle time in PDA mode  | tMRD_PDA       | max(16nCK,10ns)          | -       | max(16nCK,10ns)          | -       | max(16nCK,10ns)          | -       | max(16nCK,10ns)          | -       | nCK      |       |
| Mode Register Set command update delay in PDA mode  | tMOD_PDA       | tMOD                     |         | tMOD                     |         | tMOD                     |         | tMOD                     |         | nCK      |       |
| <b>ODT Timing</b>   |                |                          |         |                          |         |                          |         |                          |         |          |       |
| Asynchronous RTT turn-on delay (Power-Down with DLL frozen)   | tAONAS         | 1.0                      | 9.0     | 1.0                      | 9.0     | 1.0                      | 9.0     | 1.0                      | 9.0     | ns       |       |
| Asynchronous RTT turn-off delay (Power-Down with DLL frozen)  | tAOFAS         | 1.0                      | 9.0     | 1.0                      | 9.0     | 1.0                      | 9.0     | 1.0                      | 9.0     | ns       |       |
| RTT dynamic change skew   | tADC           | 0.3                      | 0.7     | 0.28                     | 0.72    | 0.26                     | 0.74    | 0.26                     | 0.74    | tCK(avg) |       |

Table 170 — for DDR4-2400 to DDR4-3200 (cont'd)

| Speed   |                 | DDR4-2400        |        | DDR4-2666        |        | DDR4-2933        |        | DDR4-3200        |        | Units    | NOTE  |
|---|-----------------|------------------|--------|------------------|--------|------------------|--------|------------------|--------|----------|-------|
| Parameter   | Symbol          | MIN              | MAX    | MIN              | MAX    | MIN              | MAX    | MIN              | MAX    |          |       |
| <b>Write Leveling Timing</b>  |                 |                  |        |                  |        |                  |        |                  |        |          |       |
| First DQS_t/DQS_n rising edge after write leveling mode is programmed   | tWLMRD          | 40               | -      | 40               | -      | 40               | -      | 40               | -      | nCK      | 12    |
| DQS_t/DQS_n delay after write leveling mode is programmed   | tWLQSEN         | 25               | -      | 25               | -      | 25               | -      | 25               | -      | nCK      | 12    |
| Write leveling setup time from rising CK_t, CK_c crossing to rising DQS_t/DQS_n crossing                        | tWLS            | 0.13             | -      | 0.13             | -      | 0.13             | -      | 0.13             | -      | tCK(avg) |       |
| Write leveling hold time from rising DQS_t/DQS_n crossing to rising CK_t, CK_c crossing                         | tWLH            | 0.13             | -      | 0.13             | -      | 0.13             | -      | 0.13             | -      | tCK(avg) |       |
| Write leveling output delay   | tWLO            | 0                | 9.5    | 0                | 9.5    | 0                | 9.5    | 0                | 9.5    | ns       |       |
| Write leveling output error   | tWLOE           | 0                | 2      | 0                | 2      | 0                | 2      | 0                | 2      | ns       |       |
| <b>CA Parity Timing</b>   |                 |                  |        |                  |        |                  |        |                  |        |          |       |
| Commands not guaranteed to be executed during this time   | tPAR_UNKN OWN   | -                | PL     | -                | PL     | -                | PL     | -                | PL     | nCK      |       |
| Delay from errant command to ALERT_n assertion  | tPAR_ALERT _ON  | -                | PL+6ns | -                | PL+6ns | -                | PL+6ns | -                | PL+6ns | nCK      |       |
| Pulse width of ALERT_n signal when asserted   | tPAR_ALERT _PW  | 72               | 144    | 80               | 160    | 88               | 176    | 96               | 192    | nCK      |       |
| Time from when Alert is asserted till controller must start providing DES commands in Persistent CA parity mode | tPAR_ALERT _RSP | -                | 64     | -                | 71     | -                | 78     | -                | 85     | nCK      |       |
| Parity Latency  | PL              | 5                |        | 5                |        | 6                |        | 6                |        | nCK      |       |
| <b>CRC Error Reporting</b>  |                 |                  |        |                  |        |                  |        |                  |        |          |       |
| CRC error to ALERT_n latency  | tCRC_ALERT      | 3                | 13     | 3                | 13     | 3                | 13     | 3                | 13     | ns       |       |
| CRC ALERT_n pulse width   | CRC_ALERT _PW   | 6                | 10     | 6                | 10     | 6                | 10     | 6                | 10     | nCK      |       |
| Speed   |                 | DDR4-2400        |        | DDR4-2666        |        | DDR4-2933        |        | DDR4-3200        |        | Units    | NOTE  |
| Parameter   | Symbol          | MIN              | MAX    | MIN              | MAX    | MIN              | MAX    | MIN              | MAX    |          |       |
| <b>Gardown timing</b>   |                 |                  |        |                  |        |                  |        |                  |        |          |       |
| Exit RESET from CKE HIGH to a valid MRS gardown (T2/Reset)  | tXPR_GEAR       | -                |        | tXPR             | -      | tXPR             | -      | tXPR             | -      |          |       |
| CKE High Assert to Gear Down Enable time(T2/CKE)  | tXS_GEAR        | -                |        | tXS              | -      | tXS              | -      | tXS              | -      |          |       |
| MRS command to Sync pulse time(T3)  | tSYNC_GEA R     | -                | -      | tMOD+4nCK        | -      | tMOD+4nCK        | -      | tMOD+4nCK        | -      |          | 27    |
| Sync pulse to First valid command(T4)   | tCMD_GEAR       | -                |        | tMOD             | -      | tMOD             | -      | tMOD             | -      |          | 27    |
| Gardown setup time  | tGEAR_setup     | -                | -      | 2                | -      |                  |        | 2                | -      | nCK      |       |
| Gardown hold time   | tGEAR_hold      | -                | -      | 2                | -      |                  |        | 2                | -      | nCK      |       |
| <b>tREFI</b>  |                 |                  |        |                  |        |                  |        |                  |        |          |       |
| tRFC1 (min)   | 2Gb             | 160              | -      | 160              | -      | 160              | -      | 160              | -      | ns       | 34    |
|   | 4Gb             | 260              | -      | 260              | -      | 260              | -      | 260              | -      | ns       | 34    |
|   | 8Gb             | 350              | -      | 350              | -      | 350              | -      | 350              | -      | ns       | 34    |
|   | 16Gb            | 550 (default)    | -      | 550 (default)    | -      | 550 (default)    | -      | 550 (default)    | 34,51  | 34,51    | 34,51 |
|   |                 | 450 (optional-1) | -      | 450 (optional-1) | -      | 450 (optional-1) | -      | 450 (optional-1) |        |          |       |
|   |                 | 350 (optional-2) | -      | 350 (optional-2) | -      | 350 (optional-2) | -      | 350 (optional-2) |        |          |       |
| tRFC2 (min)   | 2Gb             | 110              | -      | 110              | -      | 110              | -      | 110              | -      | ns       | 34    |
|   | 4Gb             | 160              | -      | 160              | -      | 160              | -      | 160              | -      | ns       | 34    |
|   | 8Gb             | 260              | -      | 260              | -      | 260              | -      | 260              | -      | ns       | 34    |
|   | 16Gb            | 350 (default)    | -      | 350 (default)    | -      | 350 (default)    | -      | 350 (default)    | 34,51  | 34,51    | 34,51 |
|   |                 | 350 (optional-1) | -      | 350 (optional-1) | -      | 350 (optional-1) | -      | 350 (optional-1) |        |          |       |
|   |                 | 260 (optional-2) | -      | 260 (optional-2) | -      | 260 (optional-2) | -      | 260 (optional-2) |        |          |       |
| tRFC4 (min)   | 2Gb             | 90               | -      | 90               | -      | 90               | -      | 90               | -      | ns       | 34    |
|   | 4Gb             | 110              | -      | 110              | -      | 110              | -      | 110              | -      | ns       | 34    |
|   | 8Gb             | 160              | -      | 160              | -      | 160              | -      | 160              | -      | ns       | 34    |
|   | 16Gb            | 260 (default)    | -      | 260 (default)    | -      | 260 (default)    | -      | 260 (default)    | 34,51  | 34,51    | 34,51 |
|   |                 | 260 (optional-1) | -      | 260 (optional-1) | -      | 260 (optional-1) | -      | 260 (optional-1) |        |          |       |
|   |                 | 160 (optional-2) | -      | 160 (optional-2) | -      | 160 (optional-2) | -      | 160 (optional-2) |        |          |       |

**Table 170 — for DDR4-2400 to DDR4-3200 (cont'd)**

- 
- NOTE 1 Start of internal write transaction is defined as follows :  
For BL8 (Fixed by MRS and on-the-fly) : Rising clock edge 4 clock cycles after WL.  
For BC4 (on-the-fly) : Rising clock edge 4 clock cycles after WL.  
For BC4 (fixed by MRS) : Rising clock edge 2 clock cycles after WL.
- NOTE 2 A separate timing parameter will cover the delay from write to read when CRC and DM are simultaneously enabled
- NOTE 3 Commands requiring a locked DLL are: READ (and RAP) and synchronous ODT commands.
- NOTE 4 tWR is defined in ns, for calculation of tWRPDEN it is necessary to round up tWR/tCK following rounding algorithm defined in Section 13.5.
- NOTE 5 WR in clock cycles as programmed in MR0.
- NOTE 6 tREFI depends on TOPER.
- NOTE 7 CKE is allowed to be registered low while operations such as row activation, precharge, autoprecharge or refresh are in progress, but power-down IDD spec will not be applied until finishing those operations.
- NOTE 8 For these parameters, the DDR4 SDRAM device supports tnPARAM[nCK]=RU{tPARAM[ns]/tCK(avg)[ns]}, which is in clock cycles assuming all input clock jitter specifications are satisfied
- NOTE 9 When CRC and DM are both enabled, tWR\_CRC\_DM is used in place of tWR.
- NOTE 10 When CRC and DM are both enabled tWTR\_S\_CRC\_DM is used in place of tWTR\_S.
- NOTE 11 When CRC and DM are both enabled tWTR\_L\_CRC\_DM is used in place of tWTR\_L.
- NOTE 12 The max values are system dependent.
- NOTE 13 DQ to DQS total timing per group where the total includes the sum of deterministic and random timing terms for a specified BER. BER spec and measurement method are tbd.
- NOTE 14 The deterministic component of the total timing. Measurement method tbd.
- NOTE 15 DQ to DQ static offset relative to strobe per group. Measurement method tbd.
- NOTE 16 This parameter will be characterized and guaranteed by design.
- NOTE 17 When the device is operated with the input clock jitter, this parameter needs to be derated by the actual tjit(per)\_total of the input clock. (output deratings are relative to the SDRAM input clock). Example tbd.
- NOTE 18 DRAM DBI mode is off.
- NOTE 19 DRAM DBI mode is enabled. Applicable to x8 and x16 DRAM only.
- NOTE 20 tQSL describes the instantaneous differential output low pulse width on DQS\_t - DQS\_c, as measured from on falling edge to the next consecutive rising edge
- NOTE 21 tQSH describes the instantaneous differential output high pulse width on DQS\_t - DQS\_c, as measured from on falling edge to the next consecutive rising edge
- NOTE 22 There is no maximum cycle time limit besides the need to satisfy the refresh interval tREFI
- NOTE 23 tCH(abs) is the absolute instantaneous clock high pulse width, as measured from one rising edge to the following falling edge
- NOTE 24 tCL(abs) is the absolute instantaneous clock low pulse width, as measured from one falling edge to the following rising edge
- NOTE 25 Total jitter includes the sum of deterministic and random jitter terms for a specified BER. BER target and measurement method are tbd.
- NOTE 26 The deterministic jitter component out of the total jitter. This parameter is characterized and guaranteed by design.
- NOTE 27 This parameter has to be even number of clocks
- NOTE 28 When CRC and DM are both enabled, tWR\_CRC\_DM is used in place of tWR.
- NOTE 29 When CRC and DM are both enabled tWTR\_S\_CRC\_DM is used in place of tWTR\_S.
- NOTE 30 When CRC and DM are both enabled tWTR\_L\_CRC\_DM is used in place of tWTR\_L.
- NOTE 31 After CKE is registered LOW, CKE signal level shall be maintained below VIILDC for tCKE specification ( Low pulse width ).
- NOTE 32 After CKE is registered HIGH, CKE signal level shall be maintained above VIHDC for tCKE specification ( HIGH pulse width ).
- NOTE 33 Defined between end of MPR read burst and MRS which reloads MPR or disables MPR function.
- NOTE 34 Parameters apply from tCK(avg)min to tCK(avg)max at all standard JEDEC clock period values as stated in the Speed Bin Tables.
- NOTE 35 This parameter must keep consistency with Speed-Bin Tables shown in section 10.
- NOTE 36 DDR4-1600 AC timing apply if DRAM operates at lower than 1600 MT/s data rate. UI=tCK(avg).min/2
- NOTE 37 applied when DRAM is in DLL ON mode.
- NOTE 38 Assume no jitter on input clock signals to the DRAM
- NOTE 39 Value is only valid for RON<sub>NOM</sub> = 34 ohms
- NOTE 40 1tCK toggle mode with setting MR4:A11 to 0
- NOTE 41 2tCK toggle mode with setting MR4:A11 to 1, which is valid for DDR4-2400/2666/3200 speed grade.
- NOTE 42 1tCK mode with setting MR4:A12 to 0
- NOTE 43 2tCK mode with setting MR4:A12 to 1, which is valid for DDR4-2400/2666/3200 speed grade.
- NOTE 44 The maximum read preamble is bounded by tLZ(DQS)min on the left side and tDQSCK(max) on the right side. See Figure 84 on page 95 --- "Clock to Data Strobe Relationship". Boundary of DQS Low-Z occur one cycle earlier in 2tCK toggle mode which is illustrated in Section 4.20.2 --- "Read Preamble".
- NOTE 45 DQ falling signal middle-point of transferring from High to Low to first rising edge of DQS diff-signal cross-point
- NOTE 46 last falling edge of DQS diff-signal cross-point to DQ rising signal middle-point of transferring from Low to High
- NOTE 47 VrefDQ value must be set to either its midpoint or Vcent\_DQ(midpoint) in order to capture DQ0 or DQL0 low level for entering PDA mode.
- NOTE 48 The maximum read postamble is bound by tDQSCK(min) plus tQSH(min) on the left side and tHZ(DQS)max on the right side. See Figure 84 on page 95
- NOTE 49 Reference level of DQ output signal is specified with a midpoint as a widest part of Output signal eye which should be approximately 0.7 \* VDDQ as a center level of the static single-ended output peak-to-peak swing with a driver impedance of 34 ohms and an effective test load of 50 ohms to VTT = VDDQ
- NOTE 50 For MR7 commands, the minimum delay to a subsequent non-MRS command is 5nCK.
- NOTE 51 Optional' settings allow certain devices in the industry to support this setting, however, it is not a mandatory feature. tRFC2 and tRFC4 needs to be set corresponding to each setting's value (default / optional-1 / optional-2) accordingly. Refer to supplier's data sheet and/or the DIMM SPD information if and how this setting is supported.
- NOTE 52 DALmin is required to refer to the rounding algorithm specified in Section 13.5.
-

## 13.5 Rounding Algorithms

Software algorithms for calculation of timing parameters are subject to rounding errors from many sources. For example, a system may use a memory clock with a nominal frequency of 933.33... MHz, or a clock period of 1.0714... ns. Similarly, a system with a memory clock frequency of 1066.66... MHz yields mathematically a clock period of 0.9375... ns. In most cases, it is impossible to express all digits after the decimal point exactly, and rounding must be done because the DDR4 SDRAM specification establishes a minimum granularity for timing parameters of 1 ps.

Rules for rounding must be defined to allow optimization of device performance without violating device parameters. These algorithms rely on results that are within correction factors on device testing and specification to avoid losing performance due to rounding errors.

These rules are:

- Clock periods such as tCKAVGmin are defined to 1 ps of accuracy; for example, 0.9375... ns is defined as 937 ps and 1.0714... ns is defined as 1071 ps.
- Using real math, parameters like tAAmin, tRCDmin, etc. which are programmed in systems in numbers of clocks (nCK) but expressed in units of time (in ns) are divided by the clock period (in ns) yielding a unitless ratio, a correction factor of 2.5% is subtracted, then the result is set to the next higher integer number of clocks:

$$nCK = \text{ceiling} [ (\text{parameter\_in\_ns} / \text{application\_tCK\_in\_ns}) - 0.025 ]$$

- Alternatively, programmers may prefer to use integer math instead of real math by expressing timing in ps, scaling the desired parameter value by 1000, dividing by the application clock period, adding an inverse correction factor of 97.4%, dividing the result by 1000, then truncating down to the next lower integer value:

$$nCK = \text{truncate} [ \{(\text{parameter\_in\_ps} \times 1000) / (\text{application\_tCK\_in\_ps}) + 974\} / 1000 ]$$

- Either algorithm yields identical results. In case of conflict between results, the preferred algorithm is the integer math algorithm.
- This algorithm applies to all timing parameters documented in a Serial Presence Detect (SPD) when converting from ns to nCK. Other timing parameters may use a simpler algorithm,  
 $nCK = \text{ceiling} (\text{parameter\_in\_ns} \div \text{application\_tCK\_in\_ns}).$

### 13.5 Rounding Algorithms (cont'd)

#### Example 1, using REAL math to convert $t_{AA\min}$ from ns to nCK:

```
// This algorithm subtracts 2.5% correction factor and rounds up to next integer value

real MTB, FTB, TaaMin, Correction, ClockPeriod, TempNck;
int TaainNck;

TaaMin = 15.0;                                     // Calculate tAAmin in ns (FTB is negative offset)
Correction = 0.025;                                // 2.5%, per rounding algorithm
ClockPeriod = ApplicationTck;                      // Frequency (clock period) is application dependent
TempNck = TaaMin / ClockPeriod;                     // Initial calculation of nCK
TempNck = TempNck - Correction;                    // Subtract correction factor from nCK
TaainNck = (int)ceiling(TempNck);                  // Ceiling to next higher integer value//
```

| DDR4-2666W Device Operating at Standard Application Data Rates (Full & Downbinned)<br>Timing Parameter: $t_{AA\min} = 15.0\text{ns}$ |                 |                      |  |                 |                                   |                |
|--|-----------------|----------------------|--|-----------------|-----------------------------------|----------------|
| Application Speed Grade  | Device $t_{AA}$ | Application $t_{CK}$ | Device $t_{AA} \div$<br>Application $t_{CK}$ | 2.5% Correction | $t_{AA} / t_{CK} -$<br>Correction | Ceiling Result |
|  | ns              | ns                   | ratio (real)                                 | (real)          | ratio (real)                      | nCK (integer)  |
| 2666   | 15.000          | 0.750                | 20.0   | 0.025           | 19.975                            | 20             |
| 2400   | 15.000          | 0.833                | 18.0072                                      | 0.025           | 17.9822                           | 18             |
| 2133   | 15.000          | 0.937                | 16.00854                                     | 0.025           | 15.9835                           | 16             |
| 1866   | 15.000          | 1.071                | 14.0056                                      | 0.025           | 13.9806                           | 14             |
| 1600   | 15.000          | 1.250                | 12.0   | 0.025           | 11.975                            | 12             |

NOTE Roundup values for bins 2400, 2133, and 1866 would have lost one clock of performance without the application of the rounding algorithm. For example, a DDR4-2666W device running at DDR4-2400 data rates would have been required to set  $t_{AA}$  to 19 clocks without correction, but with correction  $t_{AA}$  may be safely programmed to 18 clocks.

Note that more detailed SPD rounding algorithm examples are also described in Annex L-4.1.2, in JESD21C.

#### Example 2, using INT math to convert $t_{AA\min}$ from ns to nCK:

```
// This algorithm uses adds 97.4% of a clock and truncates down to the next lower integer value
int MTB, FTB, TaaMin, ClockPeriod, TempNck, TaainNck;

TaaMin = 15000;                                     // Calculate tAAmin in ns (FTB is negative offset)
ClockPeriod = ApplicationTckInPs;                  // Clock period is application specific
TempNck = (TaaMin * 1000) / ApplicationTckInPs;   // Preliminary nCK calculation, scaled by 1000
TempNck = TempNck + 974;                           // Apply inverse of 2.5% correction factor
TaainNck = (int)(TempNck / 1000);                  // Truncate to next lower integer
```

| DDR4-2666W Device Operating at Standard Application Data Rates (Full & Downbinned)<br>Timing Parameter: $t_{AA\min} = 15.0\text{ns}$ (15000ps) |                 |                      |   |                        |                               |
|--|-----------------|----------------------|---|------------------------|-------------------------------|
| Application Speed Grade  | Device $t_{AA}$ | Application $t_{CK}$ | (Device $t_{AA} * 1000$ )<br>Application $t_{CK}$ | Add Inverse Correction | Truncate Corrected nCK / 1000 |
|  | ps              | ps                   | Scaled nCK  | Scaled nCK             | nCK (integer)                 |
| 2666   | 15000           | 750                  | 20000   | 220974                 | 20                            |
| 2400   | 15000           | 833                  | 18007   | 18981                  | 18                            |
| 2133   | 15000           | 937                  | 16008   | 16982                  | 16                            |
| 1866   | 15000           | 1071                 | 14005   | 14979                  | 14                            |
| 1600   | 15000           | 1250                 | 12000   | 12974                  | 12                            |

Note that more detailed SPD rounding algorithm examples are also described in Annex L-4.1.2 of JESD21C.

### 13.6 The DQ input receiver compliance mask for voltage and timing

The DQ input receiver compliance mask for voltage and timing is shown in the figure below. The receiver mask (Rx Mask) defines area the input signal must not encroach in order for the DRAM input receiver to be expected to be able to successfully capture a valid input signal with BER of 1e-16; any input signal encroaching within the Rx Mask is subject to being invalid data. The Rx Mask is the receiver property for each DQ input pin and it is not the valid data-eye.

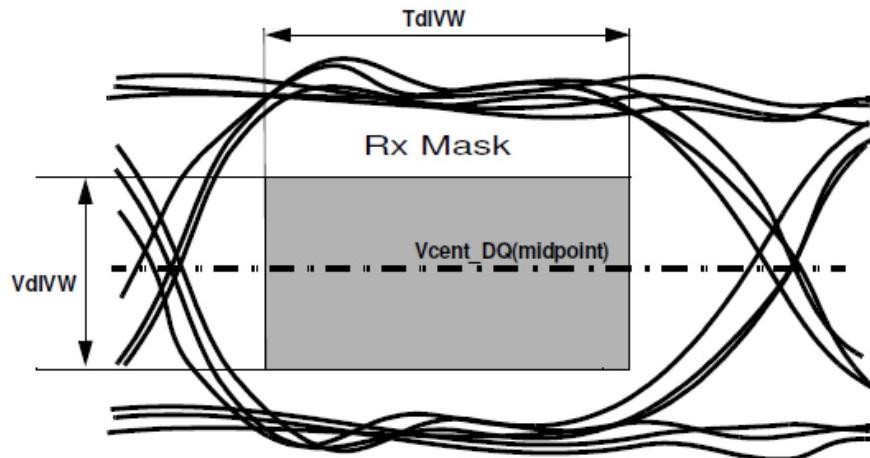


Figure 227 — DQ Receiver(Rx) compliance mask

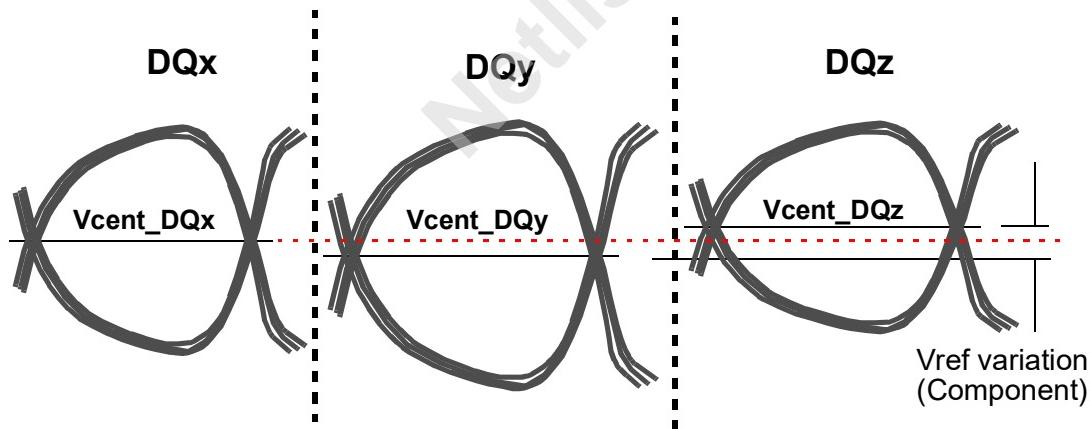
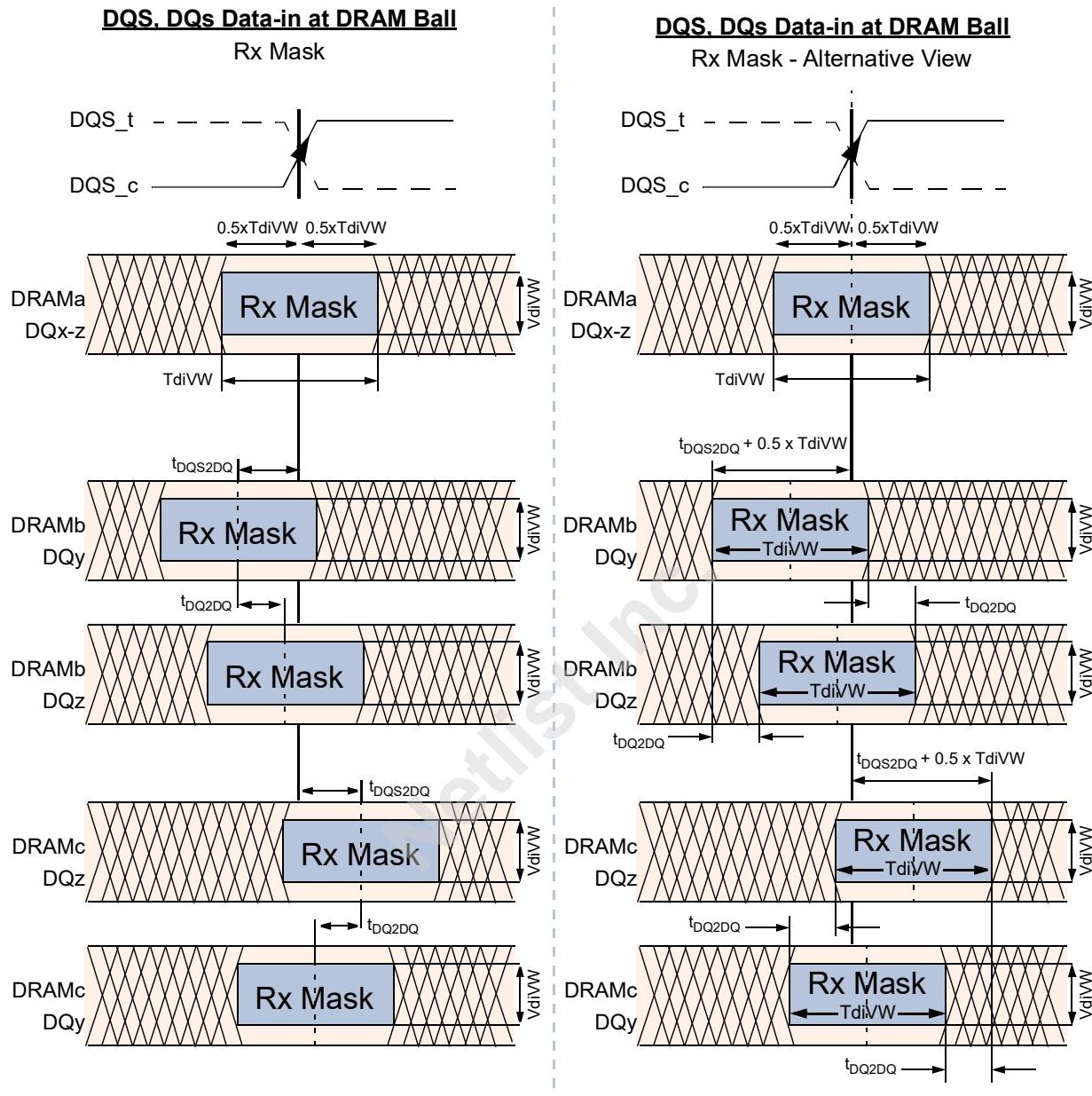


Figure 228 — Vcent\_DQ Variation to Vcent\_DQ(midpoint)

The Vref\_DQ voltage is an internal reference voltage level that shall be set to the properly trained setting, which is generally Vcent\_DQ(midpoint), in order to have valid Rx Mask values.

Vcent\_DQ(midpoint) is defined as the midpoint between the largest Vref\_DQ voltage level and the smallest Vref\_DQ voltage level across all DQ pins for a given DDR4 DRAM component. Each DQ pin Vref level is defined by the center, i.e., widest opening, of the cumulative data input eye as depicted in Figure 228. This clarifies that any DDR4 DRAM component level variation must be accounted for within the DDR4 DRAM Rx mask. The component level Vref will be set by the system to account for Ron and ODT settings.

## 13.6 The DQ input receiver compliance mask for voltage and timing (cont'd)

**Figure 229 — DQS to DQ and DQ to DQ Timings at DRAM Balls**

All of the timing terms in Figure 229 are measured at the  $V_{dIVW}$  voltage levels centered around  $V_{cent\_DQ}$  (midpoint) and are referenced to the  $DQS_t/DQS_c$  center aligned to the DQ per pin.

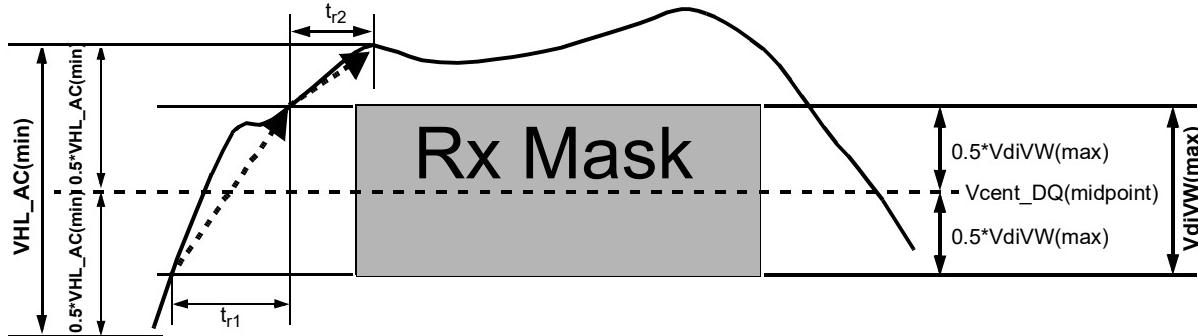
### 13.6 The DQ input receiver compliance mask for voltage and timing (cont'd)

The rising edge slew rates are defined by srr1 and srr2. The slew rate measurement points for a rising edge are shown in Figure 230 below: A low to high transition tr1 is measured from 0.5\*VdiVW(max) below Vcent\_DQ(midpoint) to the last transition through 0.5\*VdiVW(max) above Vcent\_DQ(midpoint) while tr2 is measured from the last transition through 0.5\*VdiVW(max) above Vcent\_DQ(midpoint) to the first transition through the 0.5\*VIHL\_AC(min) above Vcent\_DQ(midpoint).

Rising edge slew rate equations:

$$srr1 = VdiVW(\text{max}) / tr1$$

$$srr2 = (VIHL\_AC(\text{min}) - VdiVW(\text{max})) / (2 * tr2)$$



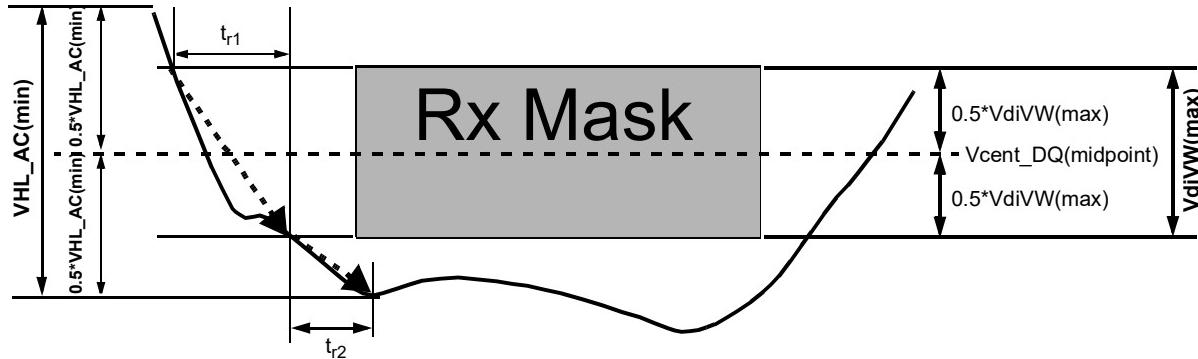
**Figure 230 — Slew Rate Conditions For Rising Transition**

The falling edge slew rates are defined by srf1 and srf2. The slew rate measurement points for a falling edge are shown in Figure 231 below: A high to low transition tf1 is measured from 0.5\*VdiVW(max) above Vcent\_DQ(midpoint) to the last transition through 0.5\*VdiVW(max) below Vcent\_DQ(midpoint) while tf2 is measured from the last transition through 0.5\*VdiVW(max) below Vcent\_DQ(midpoint) to the first transition through the 0.5\*VIHL\_AC(min) below Vcent\_DQ(pin mid).

Falling edge slew rate equations:

$$srf1 = VdiVW(\text{max}) / tf1$$

$$srf2 = (VIHL\_AC(\text{min}) - VdiVW(\text{max})) / (2 * tf2)$$



**Figure 231 — Slew Rate Conditions For Falling Transition**

13.6 The DQ input receiver compliance mask for voltage and timing (cont'd)

**Table 171 — DRAM DQs In Receive Mode; \* UI=tck(avg)min/2**

| Symbol     | Parameter  | 1600,1866,2133 |      | 2400     |      | 2666     |       | 2933     |       | 3200     |       | Unit | NOTE       |
|------------|--|----------------|------|----------|------|----------|-------|----------|-------|----------|-------|------|------------|
|            |  | min            | max  | min      | max  | min      | max   | min      | max   | min      | max   |      |            |
| VdIVW      | Rx Mask voltage - pk-pk                                | -              | 136  | -        | 130  | -        | 120   | -        | 115   | -        | 110   | mV   | 1,2,<br>10 |
| TdIVW      | Rx timing window                                       | -              | 0.2  | -        | 0.2  | -        | 0.22  | -        | 0.23  | -        | 0.23  | UI*  | 1,2,<br>10 |
| VIHL_AC    | DQ AC input swing pk-pk                                | 186            | -    | 160      | -    | 150      | -     | 145      | -     | 140      | -     | mV   | 6,10       |
| TdIPW      | DQ input pulse width                                   | 0.58           | -    | 0.58     | -    | 0.58     | -     | 0.58     | -     | 0.58     | -     | UI*  | 5,10       |
| tDQS2DQ    | Rx Mask DQS to DQ offset                               | -0.17          | 0.17 | -0.17    | 0.17 | -0.19    | 0.19  | -0.22    | 0.22  | -0.22    | 0.22  | UI*  | 6, 10      |
| tDQ2DQ     | Rx Mask DQ to DQ offset                                | -              | tbd  | -        | tbd  | -        | 0.105 | -        | 0.115 | -        | 0.125 | UI*  | 7          |
| srr1, srf1 | Input Slew Rate over VdIVW if tCK >= 0.937ns           | 1.0            | 9    | 1.0      | 9    | 1.0      | 9     | 1.0      | 9     | 1.0      | 9     | V/ns | 8,10       |
|            | Input Slew Rate over VdIVW if 0.937ns > tCK >= 0.625ns | -              | -    | 1.25     | 9    | 1.25     | 9     | 1.25     | 9     | 1.25     | 9     | V/ns | 8,10       |
| srr2       | Rising Input Slew Rate over 1/2 VIHL_AC                | 0.2*srr1       | 9    | 0.2*srr1 | 9    | 0.2*srr1 | 9     | 0.2*srr1 | 9     | 0.2*srr1 | 9     | V/ns | 9,10       |
| srf2       | Falling Input Slew Rate over 1/2 VIHL_AC               | 0.2*srf1       | 9    | 0.2*srf1 | 9    | 0.2*srf1 | 9     | 0.2*srf1 | 9     | 0.2*srf1 | 9     | V/ns | 9,10       |

NOTE 1 Data Rx mask voltage and timing total input valid window where VdIVW is centered around Vcent\_DQ( midpoint) after VrefDQ training is completed. The data Rx mask is applied per bit and should include voltage and temperature drift terms. The input buffer design specification is to achieve at least a BER = e-16 when the RxMask is not violated. The BER will be characterized and extrapolated if necessary using a dual dirac method from a higher BER(tbd).

NOTE 2 Defined over the DQ internal Vref range 1.

NOTE 3 Overshoot and Undershoot Specifications see Figure 124 on page 186 .

NOTE 4 DQ input pulse signal swing into the receiver must meet or exceed VIHL\_AC(min). VIHL\_AC(min) is to be achieved on an UI basis when a rising and falling edge occur in the same UI, i.e., a valid TdIPW.

NOTE 5 DQ minimum input pulse width defined at the Vcent\_DQ( midpoint).

NOTE 6 DQS to DQ offset is skew between DQS and DQs within a nibble (x4) or word (x8, x16) at the DDR4 SDRAM balls over process, voltage, and temperature.

NOTE 7 DQ to DQ offset is skew between DQs within a nibble (x4) or word (x8, x16) at the DDR4 SDRAM balls for a given component over process, voltage, and temperature.

NOTE 8 Input slew rate over VdIVW Mask centered at Vcent\_DQ( midpoint). Slowest DQ slew rate to fastest DQ slew rate per transition edge must be within 1.7 V/ns of each other.

NOTE 9 Input slew rate between VdIVW Mask edge and VIHL\_AC(min) points.

NOTE 10 All Rx Mask specifications must be satisfied for each UI. For example, if the minimum input pulse width is violated when satisfying TdIVW(min), VdIVW(max), and minimum slew rate limits, then either TdIVW(min) or minimum slew rates would have to be increased to the point where the minimum input pulse width would no longer be violated.

## 13.7 Command, Control, and Address Setup, Hold, and Derating

The total tIS (setup time) and tIH (hold time) required is calculated to account for slew rate variation by adding the data sheet tIS (base) values, the VIL(AC)/VIH(AC) points, and tIH (base) values, the VIL(DC)/VIH(DC) points; to the  $\Delta tIS$  and  $\Delta tIH$  derating values, respectively. The base values are derived with single-end signals at 1V/ns and differential clock at 2V/ns. Example: tIS (total setup time) = tIS (base) +  $\Delta tIS$ . For a valid transition, the input signal has to remain above/below VIH(AC)/VIL(AC) for the time defined by tVAC.

Although the total setup time for slow slew rates might be negative (for example, a valid input signal will not have reached VIH(AC)/VIL(AC) at the time of the rising clock transition), a valid input signal is still required to complete the transition and to reach VIH(AC)/VIL(AC). For slew rates that fall between the values listed in derating tables, the derating values may be obtained by linear interpolation.

Setup (tIS) nominal slew rate for a rising signal is defined as the slew rate between the last crossing of VIL(DC)max and the first crossing of VIH(AC)min that does not ring back below VIH(DC)min. Setup (tIS) nominal slew rate for a falling signal is defined as the slew rate between the last crossing of VIH(DC)min and the first crossing of VIL(AC)max that does not ring back above VIL(DC)max.

### 13.7 Command, Control, and Address Setup, Hold, and Derating (cont'd)

Hold (tIH) nominal slew rate for a rising signal is defined as the slew rate between the last crossing of VIL(DC)max and the first crossing of VIH(AC)min that does not ring back below VIH(DC)min. Hold (tIH) nominal slew rate for a falling signal is defined as the slew rate between the last crossing of VIH(DC)min and the first crossing of VIL(AC)min that does not ring back above VIL(DC)max.

**Table 172 — Command, Address, Control Setup and Hold Values**

| DDR4-            | 1600 | 1866 | 2133 | 2400 | 2666 | 2933 | 3200 | Unit | Reference |
|------------------|------|------|------|------|------|------|------|------|-----------|
| tIS(base, AC100) | 115  | 100  | 80   | 62   | -    | -    | -    | ps   | VIH/L(ac) |
| tIH(base, DC75)  | 140  | 125  | 105  | 87   | -    | -    | -    | ps   | VIH/L(dc) |
| tIS(base, AC 90) | -    | -    | -    | -    | 55   | 48   | 40   | ps   | VIH/L(ac) |
| tIH(base, DC 65) | -    | -    | -    | -    | 80   | 73   | 65   | ps   | VIH/L(dc) |
| tIS/tIH @ VREF   | 215  | 200  | 180  | 162  | 145  | 138  | 130  | ps   |           |

NOTE 1 Base ac/dc referenced for 1V/ns slew rate and 2 V/ns clock slew rate.

NOTE 2 Values listed are referenced only; applicable limits are defined elsewhere.

**Table 173 — Command, Address, Control Input Voltage Values**

| DDR4-         | 1600 | 1866 | 2133 | 2400 | 2666 | 2933 | 3200 | Unit | Reference |
|---------------|------|------|------|------|------|------|------|------|-----------|
| VIH.CA(AC)min | 100  | 100  | 100  | 100  | 90   | 90   | 90   | mV   | VIH/L(ac) |
| VIH.CA(DC)min | 75   | 75   | 75   | 75   | 65   | 65   | 65   | mV   | VIH/L(dc) |
| VIL.CA(DC)max | -75  | -75  | -75  | -75  | -65  | -65  | -65  | mV   | VIH/L(ac) |
| VIL.CA(AC)max | -100 | -100 | -100 | -100 | -90  | -90  | -90  | mV   | VIH/L(dc) |

NOTE 1 Command, Address, Control input levels relative to VREFCA.

NOTE 2 Values listed are referenced only; applicable limits are defined elsewhere.

**Table 174 — Derating values DDR4-1600/1866/2133/2400 tIS/tIH - ac/dc based**

| ΔtIS, ΔtIH derating in [ps] AC/DC based <sup>1</sup>   |     |                                   |      |          |      |          |      |          |      |         |      |         |      |          |      |          |      |
|--|-----|-----------------------------------|------|----------|------|----------|------|----------|------|---------|------|---------|------|----------|------|----------|------|
|  |     | CK_t, CK_c Differential Slew Rate |      |          |      |          |      |          |      |         |      |         |      |          |      |          |      |
|  |     | 10.0 V/ns                         |      | 8.0 V/ns |      | 6.0 V/ns |      | 4.0 V/ns |      | 3.0V/ns |      | 2.0V/ns |      | 1.5 V/ns |      | 1.0 V/ns |      |
|  |     | ΔtIS                              | ΔtIH | ΔtIS     | ΔtIH | ΔtIS     | ΔtIH | ΔtIS     | ΔtIH | ΔtIS    | ΔtIH | ΔtIS    | ΔtIH | ΔtIS     | ΔtIH | ΔtIS     | ΔtIH |
| CMD,<br>ADDR,<br>CNTL<br>Input<br>Slew<br>rate<br>V/ns | 7.0 | 76                                | 54   | 76       | 55   | 77       | 56   | 79       | 58   | 82      | 60   | 86      | 64   | 94       | 73   | 111      | 89   |
|  | 6.0 | 73                                | 53   | 74       | 53   | 75       | 54   | 77       | 56   | 79      | 58   | 83      | 63   | 92       | 71   | 108      | 88   |
|  | 5.0 | 70                                | 50   | 71       | 51   | 72       | 52   | 74       | 54   | 76      | 56   | 80      | 60   | 88       | 68   | 105      | 85   |
|  | 4.0 | 65                                | 46   | 66       | 47   | 67       | 48   | 69       | 50   | 71      | 52   | 75      | 56   | 83       | 65   | 100      | 81   |
|  | 3.0 | 57                                | 40   | 57       | 41   | 58       | 42   | 60       | 44   | 63      | 46   | 67      | 50   | 75       | 58   | 92       | 75   |
|  | 2.0 | 40                                | 28   | 41       | 28   | 42       | 29   | 44       | 31   | 46      | 33   | 50      | 38   | 58       | 46   | 75       | 63   |
|  | 1.5 | 23                                | 15   | 24       | 16   | 25       | 17   | 27       | 19   | 29      | 21   | 33      | 25   | 42       | 33   | 58       | 50   |
|  | 1.0 | -10                               | -10  | -9       | -9   | -8       | -8   | -6       | -6   | -4      | -4   | 0       | 0    | 8        | 8    | 25       | 25   |
|  | 0.9 | -17                               | -14  | -16      | -14  | -15      | -13  | -13      | -10  | -11     | -8   | -7      | -4   | 1        | 4    | 18       | 21   |
|  | 0.8 | -26                               | -19  | -25      | -19  | -24      | -18  | -22      | -16  | -20     | -14  | -16     | -9   | -7       | -1   | 9        | 16   |
|  | 0.7 | -37                               | -26  | -36      | -25  | -35      | -24  | -33      | -22  | -31     | -20  | -27     | -16  | -18      | -8   | -2       | 9    |
|  | 0.6 | -52                               | -35  | -51      | -34  | -50      | -33  | -48      | -31  | -46     | -29  | -42     | -25  | -33      | -17  | -17      | -0   |
|  | 0.5 | -73                               | -48  | -72      | -47  | -71      | -46  | -69      | -44  | -67     | -42  | -63     | -38  | -54      | -29  | -38      | -13  |
|  | 0.4 | -104                              | -66  | -103     | -66  | -102     | -65  | -100     | -63  | -98     | -60  | -94     | -56  | -85      | -48  | -69      | -31  |

NOTE 1 VIH/L(ac) = +/-100mV, VIH/L(dc) = +/-75mV; relative to VREFCA

3.7 Command, Control, and Address Setup, Hold, and Derating (cont'd)

**Table 175 — Derating values DDR4-2666/2933/3200 tIS/tIH - ac/dc based**

|  |      | $\Delta tIS, \Delta tIH$ derating in [ps] AC/DC based <sup>1</sup> |      |          |      |          |      |          |      |         |      |         |      |          |      |          |      |
|--|------|--|------|----------|------|----------|------|----------|------|---------|------|---------|------|----------|------|----------|------|
|  |      | CK_t, CK_c Differential Slew Rate                                  |      |          |      |          |      |          |      |         |      |         |      |          |      |          |      |
|  |      | 10.0 V/ns  |      | 8.0 V/ns |      | 6.0 V/ns |      | 4.0 V/ns |      | 3.0V/ns |      | 2.0V/ns |      | 1.5 V/ns |      | 1.0 V/ns |      |
| CMD,<br>ADDR,<br>CNTL<br>Input<br>Slew<br>rate<br>V/ns | ΔtIS | ΔtIH   | ΔtIS | ΔtIH     | ΔtIS | ΔtIH     | ΔtIS | ΔtIH     | ΔtIS | ΔtIH    | ΔtIS | ΔtIH    | ΔtIS | ΔtIH     | ΔtIS | ΔtIH     | ΔtIS |
|  | 7.0  | 68   | 47   | 69       | 47   | 70       | 48   | 72       | 50   | 73      | 52   | 77      | 56   | 85       | 63   | 100      | 78   |
|  | 6.0  | 66   | 45   | 67       | 46   | 68       | 47   | 69       | 49   | 71      | 50   | 75      | 54   | 83       | 62   | 98       | 77   |
|  | 5.0  | 63   | 43   | 64       | 44   | 65       | 45   | 66       | 46   | 68      | 48   | 72      | 52   | 80       | 60   | 95       | 75   |
|  | 4.0  | 59   | 40   | 59       | 40   | 60       | 41   | 62       | 43   | 64      | 45   | 68      | 49   | 75       | 56   | 90       | 71   |
|  | 3.0  | 51   | 34   | 52       | 35   | 53       | 36   | 54       | 38   | 56      | 40   | 60      | 43   | 68       | 51   | 83       | 66   |
|  | 2.0  | 36   | 24   | 37       | 24   | 38       | 25   | 39       | 27   | 41      | 29   | 45      | 33   | 53       | 40   | 68       | 55   |
|  | 1.5  | 21   | 13   | 22       | 13   | 23       | 14   | 24       | 16   | 26      | 18   | 30      | 22   | 38       | 29   | 53       | 44   |
|  | 1.0  | -9   | -9   | -8       | -8   | -8       | -8   | -6       | -6   | -4      | -4   | 0       | 0    | 8        | 8    | 23       | 23   |
|  | 0.9  | -15  | -13  | -15      | -12  | -14      | -11  | -12      | -9   | -10     | -7   | -6      | -4   | 1        | 4    | 16       | 19   |
|  | 0.8  | -23  | -17  | -23      | -17  | -22      | -16  | -20      | -14  | -18     | -12  | -14     | -8   | -7       | -1   | 8        | 14   |
|  | 0.7  | -34  | -23  | -33      | -22  | -32      | -21  | -30      | -20  | -28     | -18  | -25     | -14  | -17      | -6   | -2       | 9    |
|  | 0.6  | -47  | -31  | -47      | -30  | -46      | -29  | -44      | -27  | -42     | -25  | -38     | -22  | -31      | -14  | -16      | 1    |
|  | 0.5  | -67  | -42  | -66      | -41  | -65      | -40  | -63      | -38  | -61     | -36  | -58     | -33  | -50      | -25  | -35      | -10  |
|  | 0.4  | -95  | -58  | -95      | -57  | -94      | -56  | -92      | -54  | -90     | -53  | -86     | -49  | -79      | -41  | -64      | -26  |

NOTE 1 VIH/L(ac) = +/- tbd mV, VIH/L(dc) = +/- tbd mV; relative to VREFCA

### 13.8 DDR4 Function Matrix

DDR4 SDRAM has several features supported by ORG and also by Speed. The following Table is the summary of the features.

**Table 176 — Function Matrix (By ORG. V:Supported, Blank:Not supported)**

| Functions                      | x4 | x8 | x16 | NOTE |
|--------------------------------|----|----|-----|------|
| Write Leveling                 | V  | V  | V   |      |
| Temperature controlled Refresh | V  | V  | V   |      |
| Low Power Auto Self Refresh    | V  | V  | V   |      |
| Fine Granularity Refresh       | V  | V  | V   |      |
| Multi Purpose Register         | V  | V  | V   |      |
| Data Mask                      |    | V  | V   |      |
| Data Bus Inversion             |    | V  | V   |      |
| TDQS                           |    | V  |     |      |
| ZQ calibration —               | V  | V  | V   |      |
| DQ Vref Training               | V  | V  | V   |      |
| Per DRAM Addressability        | V  | V  | V   |      |
| Mode Register Readout          | V  | V  | V   |      |
| CAL                            | V  | V  | V   |      |
| WRITE CRC                      | V  | V  | V   |      |
| CA Parity                      | V  | V  | V   |      |
| Control Gear Down Mode         | V  | V  | V   |      |
| Programmable Preamble          | V  | V  | V   |      |
| Maximum Power Down Mode        | V  | V  |     |      |
| Boundary Scan Mode             |    |    | V   |      |
| Additive Latency               | V  | V  |     |      |
| 3DS                            | V  | V  |     |      |

**Table 177 — Function Matrix (By Speed. V:Supported, Blank:Not supported)**

| Functions                      | DLL Off mode                 | DLL On mode         |          |               | NOTE |
|--------------------------------|------------------------------|---------------------|----------|---------------|------|
|                                | equal or slower than 250Mbps | 1600/1866/2133 Mbps | 2400Mbps | 2666/3200Mbps |      |
| Write Leveling                 | V                            | V                   | V        | V             |      |
| Temperature controlled Refresh | V                            | V                   | V        | V             |      |
| Low Power Auto Self Refresh    | V                            | V                   | V        | V             |      |
| Fine Granularity Refresh       | V                            | V                   | V        | V             |      |
| Multi Purpose Register         | V                            | V                   | V        | V             |      |
| Data Mask                      | V                            | V                   | V        | V             |      |
| Data Bus Inversion             | V                            | V                   | V        | V             |      |
| TDQS                           |                              | V                   | V        | V             |      |
| ZQ calibration                 | V                            | V                   | V        | V             |      |
| DQ Vref Training               | V                            | V                   | V        | V             |      |
| Per DRAM Addressability        |                              | V                   | V        | V             |      |
| Mode Register Readout          | V                            | V                   | V        | V             |      |
| CAL                            |                              | V                   | V        | V             |      |
| WRITE CRC                      |                              | V                   | V        | V             |      |
| CA Parity                      |                              | V                   | V        | V             |      |
| Control Gear Down Mode         |                              |                     |          | V             |      |
| Programmable Preamble (= 2tCK) |                              |                     | V        | V             |      |
| Maximum Power Down Mode        |                              | V                   | V        | V             |      |
| Boundary Scan Mode             | V                            | V                   | V        | V             |      |
| 3DS                            | V                            | V                   | V        | V             |      |

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## A Annex A (Informative) Differences between JESD79-4C and JESD79-4B

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This annex briefly describes most of the changes made to this standard, JESD79-4C, compared to its predecessor, JESD79-4B (June 2017). Some editorial changes are not included

| Ballot   | Subject                                  |
|----------|--|
| RB16-317 | Rounding Algorithm,                      |
| RB16-348 | Industrial Temperature,                  |
| RB18-509 | tRFC update for 16Gb device,             |
| RB19-075 | Speed Bin Table update,                  |
| RB17-123 | CT mode input levels,                    |
| RB18-303 | Overshoot and Undershoot Spec            |
| RB18-304 | duty cycle jitter removal                |
| RB18-305 | Command Address Setup Hold Derating Spec |
| RB18-419 | DDR4 Dram Data Timing.                   |

### A.1 Differences between JESD79-4B and JESD79-4A

Not provided at time of publication.

### A.2 Differences between JESD79-4A and JESD79-4

| Section | Description of Change  |
|---------|--|
| 7.2.1   | Per JCB-12-078, Proposed DDR4 SDRAM AC CK Differential Input Specification Added notes to Fig 171  |
| 7.2.2   | Per JCB-12-078, Proposed DDR4 SDRAM AC CK Differential Input Specification Modified Tables 64 and 65   |
| 7.2.3   | Per JCB-12-078, Proposed DDR4 SDRAM AC CK Differential Input Specification Modified Table 66   |
| 7.2.4   | Per JCB-12-077, Proposed DDR4 SDRAM AC Overshoot and Undershoot<br>Added "Command" to the section heading and to the captions for Table 67 and Figure 173 Modified Table 67 and Figure 173 |
| 7.2.5   | Per JCB-12-077, Proposed DDR4 SDRAM AC Overshoot and Undershoot Modified Table 68 and Figure 174   |
| 7.2.6   | Per JCB-12-077, Proposed DDR4 SDRAM AC Overshoot and Undershoot Modified Table 69 and Figure 175   |
| 7.6     | Per JCB-12-079, Proposed DDR4 Input Level<br>Added Section 7.6, AC & DC Logic input levels for single-ended signals, and Table 74  |
| 8.1     | Per JCB-12-075, Proposed DDR4 SDRAM Output Driver Ron Mismatch Removed Figure 181 and replaced it with Table 75  |
| 8.1.1   | Per JCB-12-076, Proposed DDR4 SDRAM Alert_n Ron Tolerance Modified the unnumbered table in this section  |

Netlist Inc.



## Standard Improvement Form

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1. I recommend changes to the following:

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Test method number      Clause number

The referenced clause number has proven to be:

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